

Service Guide

HP 8560E Spectrum Analyzer



**HEWLETT
PACKARD**

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Regulatory Information

The *HP 8560 E-Series Spectrum Analyzer Calibration Guide* contains regulatory information.

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Product maintenance agreements and other customer assistance agreements are available for Hewlett-Packard products.

For any assistance, contact your nearest Hewlett-Packard Sales and Service Office.

Safety Notes

The following safety notes are used throughout this manual. Familiarize yourself with each of the notes and its meaning before operating this instrument.

Caution	<i>Caution</i> denotes a hazard. It calls attention to a procedure that, if not correctly performed or adhered to, could result in damage to or destruction of the instrument. Do not proceed beyond a <i>caution</i> sign until the indicated conditions are fully understood and met.
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Warning	<i>Warning</i> denotes a hazard. It calls attention to a procedure which, if not correctly performed or adhered to, could result in injury or loss of life. Do not proceed beyond a <i>warning</i> note until the indicated conditions are fully understood and met.
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Instruction Manual	The instruction manual symbol. The product is marked with this symbol when it is necessary for the user to refer to the instructions in the manual.
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General Safety Considerations

Warning	No operator serviceable parts inside. Refer servicing to qualified personnel. To prevent electrical shock, do not remove covers.
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Warning	This is a Safety Class I product (provided with a protective earthing ground incorporated in the power cord). The mains plug shall only be inserted in a socket outlet provided with a protective earth contact. Any interruption of the protective conductor, inside or outside the instrument, is likely to make the instrument dangerous. Intentional interruption is prohibited.
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Caution	Before switching on this instrument, make sure that the line voltage selector switch is set to the voltage of the power supply and the correct fuse is installed.
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How to Use This Guide

Chapter 6, “General Troubleshooting,” can be used to identify the location of a problem to a board or functional area in the spectrum analyzer.

Chapters 7 through 12, which cover the functional areas, can then be used to help you localize the problem further.

Once the faulty area is identified, the adjustments and parts information located in chapters 1 through 5 is available to help you fix the problem.

This guide uses the following conventions:

Front-Panel Key

This represents a key physically located on the instrument.

Softkey

This indicates a “softkey,” a key whose label is determined by the instrument’s firmware.

Screen Text

This indicates text displayed on the spectrum analyzer screen.

Documentation Outline

HP 8560 E-Series Spectrum Analyzer Calibration Guide

- Tells you how to run verification software.
- Tells you what your spectrum analyzer’s specifications are.
- Tells you how to test your spectrum analyzer.

HP 8560 E-Series Spectrum Analyzer User’s Guide

- Tells you how to make measurements with your spectrum analyzer.
- Tells you how to install the spectrum analyzer.
- Tells you how to program your spectrum analyzer.

HP 8560 E-Series Spectrum Analyzer Quick Reference Guide

- Is an abbreviated version of the *HP 8560 E-Series Spectrum Analyzer User’s Guide*.
- Provides you with a listing of all remote programming commands.

HP 8560 E-Series Spectrum Analyzer Component Level Information

- Provides schematics and parts lists for the instrument.

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General Information

This *HP 8560E Spectrum Analyzer Service Guide* contains information required to adjust and service the HP 8560E spectrum analyzer to the assembly level.

For component-level information, refer to the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

Serial Numbers and Repair Information

Hewlett-Packard makes frequent improvements to its products to enhance performance, usability, or reliability. HP service personnel have access to complete records of design changes to each type of equipment, based on the equipment's serial number. Whenever you contact HP about a product, have the complete serial number available to ensure obtaining the most complete and accurate information possible.

The serial number label is usually attached to the rear of the product. The serial number has two parts: the prefix (two letters and the first four numbers), and the suffix (the last four numbers).



92150a

Serial Number Label Example

The two letters identify the country in which the unit was manufactured. The four numbers of the prefix are a code identifying the date of the last major design change incorporated in your Hewlett-Packard product. The four-digit suffix is a sequential number and, coupled with the prefix, provides a unique identification for each unit produced. Whenever you list the serial number or refer to it in obtaining information about your Hewlett-Packard product, be sure to use the complete number, including the full prefix and the suffix.

Units which were produced before the serial number format was changed may also be covered by this documentation. On earlier serial number labels, the prefix consists of the first four numbers and a single letter. The suffix is a five-digit sequential number.



sz156e

Earlier Serial Number Label Example

It is important that you realize that the new serial number format (US00000000) is always considered “above” the earlier format (0000A00000) when you encounter change information such as “... serial prefix 3425A and above” or “... serial number 3425A00564 and above.”

Instrument Variations

There are options available to the HP 8560E spectrum analyzer. The following table lists these options and identifies the assemblies which are unique to them.

Table 1-1. Instrument Variations

Option	Added	Deleted
HP 8560E Option 001 (2nd IF Output)	W19 Cable Assembly Rear-Panel J10	
HP 8560E Option 002 (Tracking Generator)	A10 Tracking Generator Assembly Front Dress Panel (Opt 002) W14 Cable Assembly W16 Cable Assembly W43 Cable Assembly W46 Cable Assembly W47 Cable Assembly W48 Cable Assembly Rear-panel J11 Front-panel J6	Front Dress Panel (Standard) W36 Cable Assembly W42 Cable Assembly Front-panel J3
HP 8560E Option 005 (Add Alternate Sweep Output)	W58 Cable Assembly	
HP 8560E Option 007 (Fast ADC)	A16 Fast ADC Assembly A3 Interface Assembly (Opt 007) W20 Cable Assembly (Opt 007) W59 Cable Assembly	A3 Interface Assembly (Standard) W20 Cable Assembly (Standard)
HP 8560E Option 008 (SIG ID)	A15 RF Assembly (Opt 008)	A15 RF Assembly (Std)
HP 8560E Option 103 (Delete OCXO)	A15 RF Assembly (Opt 103)	W49 Cable Assembly W50 Cable Assembly A15 RF Assembly (Std) A21 OCXO
HP 8560E Option 104 (Delete HP 85620A)		HP 85620A Mass Memory Module

HP 8529B Test and Adjustment Module

When attached to the spectrum analyzer's rear panel, the HP 85629B Test and Adjustment Module (TAM) provides diagnostic functions for the HP 8560E. Because the TAM connects directly to the spectrum analyzer's internal data and address bus, it controls the spectrum analyzer's hardware directly. It would be impossible to control the hardware to the same extent either from the spectrum analyzer's front panel or over the HP-IB.

The TAM measures voltages at key points in the circuitry and flags a failure whenever the voltage falls outside the limits. The TAM locates the failure to a small functional area which can be examined manually.

Service Kit

The HP 8560E Service Kit (HP part number 08562-60021) contains service tools required to repair the instrument. Refer to Table 1-2 for a list of items in the service kit.

Table 1-2. Service Kit Contents

Description	Quantity	HP Part Number
Cable Puller	1	5021-6773
PC Board Prop	1	5021-7459
Line Filter Assembly	1	5061-9032
Line Switch Cable	1	5062-0728
Extender Cable	1	5062-0737
BNC to SMB (snap-on) Cable	2	85680-60093
Connector Extractor Tool Kit	1	8710-1791

Recommended Test Equipment

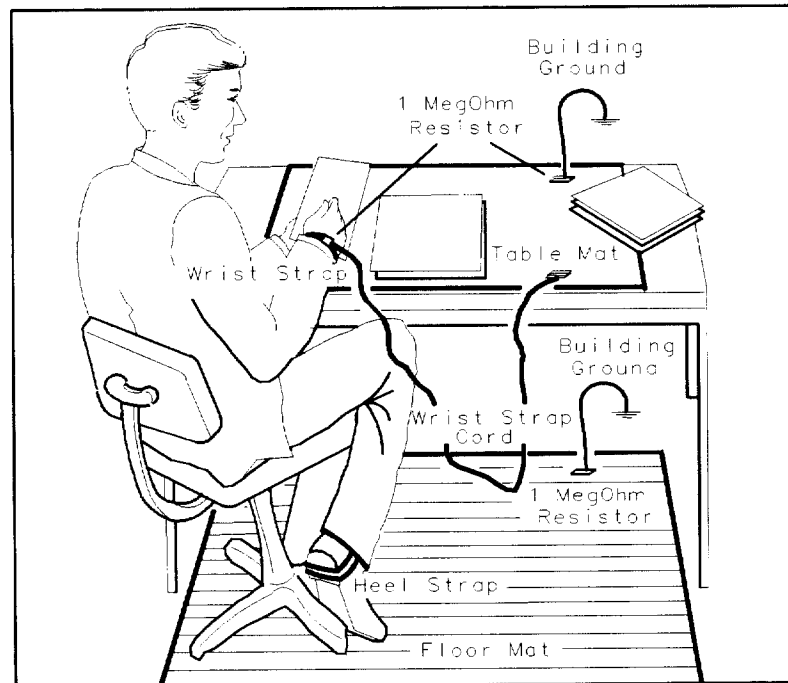
Equipment required for operation verification, performance tests, adjustments, troubleshooting, and the Test and Adjustment Module is listed in Table 1-5. Other equipment may be substituted if it meets or exceeds the critical specifications listed in the table. Refer to the *HP 8560 E-Series Spectrum Analyzer Calibration Guide* for the performance tests.

Electrostatic Discharge

Electrostatic discharge (ESD) can damage or destroy electronic components. Therefore, all work performed on assemblies consisting of electronic components should be done at a static-free workstation. Figure 1-1 is an example of a static-safe workstation using two kinds of ESD protection:

- Conductive table mat and wrist-strap combination.
- Conductive floor mat and heel-strap combination.

These methods may be used together or separately.



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Figure 1-1. Example of a Static-Safe Workstation

Reducing Potential for ESD Damage

The suggestions that follow may help reduce ESD damage that occurs during instrument testing and servicing.

- Before connecting any coaxial cable to a spectrum analyzer connector for the first time each day, momentarily ground the center and outer connectors of the cable.
- Personnel should be grounded with a resistor-isolated wrist strap before touching the center in of any connector and before removing any assembly from the unit.
- Be sure all instruments are properly earth-grounded to prevent build-up of static discharge.

Static-Safe Accessories

Table 1-3. Static-Safe Accessories

HP Part Number	Description
9300-0797	Set includes: 3M static control mat 0.6 m × 1.2 m (2 ft × 4 ft) and 4.6 cm (15 ft) ground wire. (The wrist-strap and wrist-strap cord are not included. They must be ordered separately.)
9300-0980	Wrist-strap cord 1.5 m (5 ft)
9300-1383	Wrist-strap, color black, stainless steel, without cord, has four adjustable links and a 7 mm post-type connection.
9300-1169	ESD heel-strap (reusable 6 to 12 months).

Returning Instruments for Service

Service Tag

If you are returning the instrument to Hewlett-Packard for servicing, fill in and attach a blue service tag. Service tags are supplied in the back of this chapter.

Please be as specific as possible about the nature of the problem. If you have recorded any error messages that appeared on the screen, or have completed a performance test record, or have any other specific data on the performance of the spectrum analyzer, please send a copy of this information with the unit.

Original Packaging

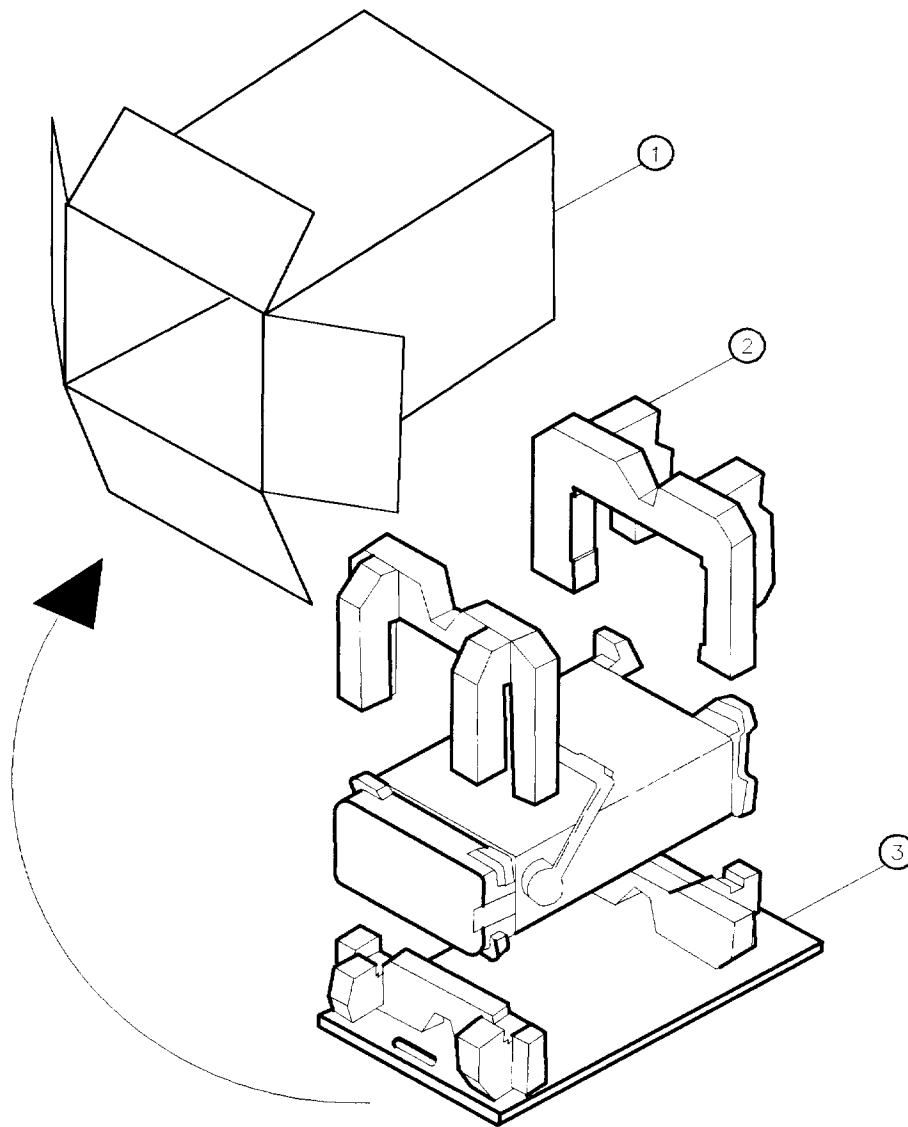
Before shipping, pack the unit in the original factory packaging materials if they are available. If the original materials are unavailable, identical packaging materials may be acquired through any Hewlett-Packard Sales and Service Office. Descriptions of the packaging materials are listed in Figure 1-2.

Other Packaging

Caution	Spectrum analyzer damage can result from using packaging materials other than those specified. Never use styrene pellets in any shape as packaging materials. They do not adequately cushion the equipment or prevent it from shifting in the carton. They cause equipment damage by generating static electricity and by lodging in the spectrum analyzer fan.
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Repackage the spectrum analyzer in the original packaging materials or with commercially available materials described in steps 4 and 5, below.

1. Attach a completed service tag to the instrument.
2. Install the front-panel cover on the instrument.
3. Wrap the instrument in antistatic plastic to reduce the possibility of damage caused by electrostatic discharge.
4. Use the original materials or a strong shipping container that is double-walled, corrugated cardboard carton with 159 kg (350 lb) bursting strength. The carton must be both large enough and strong enough to accommodate the spectrum analyzer and allows at least 3 to 4 inches on all sides of the spectrum analyzer for packing material.
5. Surround the equipment with at least 3 to 4 inches of packing material, or enough to prevent the equipment from moving in the carton. If packing foam is unavailable, the best alternative is SD-240 Air CapTM from Sealed Air Corporation (Commerce, CA 90001). Air Cap looks like a plastic sheet covered with 1-1/4 inch air-filled bubbles. Use the pink-colored Air Cap to reduce static electricity. Wrap the equipment several times in this material to both protect the equipment and prevent it from moving in the carton.
6. Seal the shipping container securely with strong nylon adhesive tape.
7. Mark the shipping container "FRAGILE, HANDLE WITH CARE" to assure careful handling.
8. Retain copies of all shipping papers.



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Figure 1-2. HP 8560E Shipping Container and Cushioning Materials

Item	Description	HP Part Number
1	9211-5636	Outer Carton
2	08590-80013	Pads (2)
3	08590-80014	Bottom Tray

Sales and Service Offices

Hewlett-Packard has sales and service offices around the world providing complete support for Hewlett-Packard products. To obtain servicing information, or to order replacement parts, contact the nearest Hewlett-Packard Sales and Service Office listed in Table 1-4. In any correspondence, be sure to include the pertinent information about model numbers, serial numbers, and assembly part numbers.

Note	Within the USA, a toll-free phone number is available for ordering replacement parts. Refer to the section entitled, "Ordering Information" in Chapter 4, "Replaceable Parts," for the phone number and more information.
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Table 1-4. Hewlett-Packard Sales and Service Offices

US FIELD OPERATIONS		
Headquarters Hewlett-Packard Company 19320 Pruneridge Avenue Cupertino, CA 95014, USA (800) 752-0900	California, Northern Hewlett-Packard Co. 301 E. Evelyn Mountain View, CA 94041 (415) 694-2000	California, Southern Hewlett-Packard Co. 1421 South Manhattan Ave. Fullerton, CA 92631 (714) 999-6700
Colorado Hewlett-Packard Co. 24 Inverness Place, East Englewood, CO 80112 (303) 649-5000	Georgia Hewlett-Packard Co. 2000 South Park Place Atlanta, GA 30339 (404) 955-1500	Illinois Hewlett-Packard Co. 5201 Tollview Drive Rolling Meadows, IL 60008 (708) 255-9800
New Jersey Hewlett-Packard Co. 150 Green Pond Road Rockaway, NJ 07866 (201)627-6400	Texas Hewlett-Packard Co. 930 E. Campbell Rd. Richardson, TX 75081 (214) 231-6101	
EUROPEAN FIELD OPERATIONS		
Headquarters Hewlett-Packard S.A. 150, Route du Nant-d'Avril 1217 Meyrin 2/Geneva Switzerland (41 22) 780.8111	France Hewlett-Packard France 1 Avenue Du Canada Zone D'Activite De Courtaboeuf F-91947 Les Ulis Cedex France (33 1) 69 82 60 60	Germany Hewlett-Packard GmbH Hewlett-Packard Strasse 6380 Bad Homburg v.d.H Germany (49 6172) 16-0
Great Britain Hewlett-Packard Ltd Eskdale Road, Winnersh Triangle Wokingham, Berkshire RF11 5DZ England (44 734) 696622		
INTERCON FIELD OPERATIONS		
Headquarters Hewlett-Packard Company 3495 Deer Creek Rd. Palo Alto, California 94304-1316 (415) 857-5027	Australia Hewlett-Packard Australia Ltd. 31-41 Joseph Street Blackburn, Victoria 3130 (61 3) 895-2895	Canada Hewlett-Packard (Canada) Ltd. 17500 South Service Road Trans-Canada Highway Kirkland, Quebec H9J 2X8 Canada (514) 697-4232
China China Hewlett-Packard Co. 38 Bei San Huan X1 Road Shuang Yu Shu Hai Dian District Beijing, China (86 1) 256-6888	Japan Yokogawa-Hewlett-Packard Ltd. 1-27-15 Yabe, Sagami-hara Kanagawa 229, Japan (81 427) 59-1311	Singapore Hewlett-Packard Singapore (Pte.) Ltd 1150 Depot Road Singapore 0410 (65) 273-7388
Taiwan Hewlett-Packard Taiwan 8th Floor, H-P Building 337 Fu Hsing North Road Taipei, Taiwan (886 2) 712-0404		

Table 1-5. Recommended Test Equipment

Instrument	Critical Specifications for Equipment Substitution	Recommended Model	Use
Sources			
Synthesized sweeper (two required for HP 8560E, HP 8561E and HP 8563E) (one required for HP 8564E and HP 8565E)	Frequency range: HP 8560E, 10 MHz to 12.0 GHz HP 8561E, 10 MHz to 12.0 GHz HP 8563E, 10 MHz to 26.5 GHz Frequency accuracy (CW): 1×10^{-9} /day Leveling modes: Internal & External Modulation modes: AM & Pulse Power level range: -80 to +16 dBm	HP 8340A/B* HP 83630A Opt 001, 008	P,A,T, M,V
Synthesized sweeper (for HP 8564E and HP 8565E)	Frequency range: HP 8564E, 10 MHz to 40.0 GHz HP 8565E, 10 MHz to 50.0 GHz Frequency accuracy (CW): 1×10^{-9} /day Leveling mode: Internal Power level range: -35 to +16 dBm	HP 83650A Opt 001, 008	P,A,T, V
Synthesizer/ level generator	Frequency range: 200 Hz to 80 MHz Frequency accuracy: 1×10^{-7} /month Flatness: ± 0.15 dB Attenuator accuracy: $< \pm 0.09$ dB External 10 MHz reference input Frequency resolution: 1 Hz	HP 3335A*	P,A,T, M,V
Synthesized signal generator	Frequency range: 100 kHz to 2.5 GHz Residual SSB phase noise at 1 GHz: <-73 dBc/Hz at 10 Hz offset <-107 dBc/Hz at 1 kHz offset <-124 dBc/Hz at 10 kHz offset <-124 dBc/Hz at 100 kHz offset	HP 8663A	P,V
Pulse/function generator	Frequency range: 10 kHz to 50 MHz Pulse width: 200 ns; Output amplitude: 5 V peak-to-peak Functions: pulse & triangle Pulse rise time: <100 ns TTL sync output	HP 8116A	P,A
AM/FM signal generator	Frequency range: 1 MHz to 200 MHz Frequency modulation mode Modulation oscillator frequency: 1 kHz FM peak deviation: 5 kHz	HP 8640B HP 8642A	A
* Part of microwave workstation P = performance tests; A = adjustments; M = test & adjustment module; T = troubleshooting; V = operation verification			

Table 1-5. Recommended Test Equipment (continued)

Instrument	Critical Specifications for Equipment Substitution	Recommended Model	Use
Counters			
Frequency standard	Output frequency: 10 MHz Accuracy: $<1 \times 10^{-10}$	HP 5061B	P,A
Microwave frequency counter	Frequency range: 9 MHz to 26.5 GHz Timebase accuracy (aging): $<5 \times 10^{-10}$ /day External frequency reference input	HP 5343A* Option 001	P,A,M,V
Universal counter	Modes: TI A→B, frequency count Time interval measurement range: 100 ns to 120 s Frequency count range: 400 Hz to 11 MHz Frequency resolution: 1 mHz Timebase accuracy (aging): $<3 \times 10^{-7}$ /month External 10 MHz reference input	HP 5334A/B	P
Receivers			
Spectrum analyzer (for HP 8560E Option 002)	Frequency range: 300 kHz to 7 GHz Relative amplitude accuracy: 300 kHz to 2.7 GHz: $<\pm 1.8$ dB 300 kHz to 7 GHz: $<\pm 4.0$ dB Absolute amplitude accuracy: 3.9 GHz to 6.9 GHz: $<\pm 2.7$ dB Frequency accuracy: $<\pm 10$ kHz at 7 GHz	HP 8566B*	P,A,T
Spectrum analyzer	Frequency range: 300 kHz to 7 GHz Amplitude range: -70 dBm to +20 dBm	HP 8566B*	A,T
Measuring receiver	Compatible w/power sensors dB relative mode Resolution: 0.01 dB Reference accuracy: $<\pm 1.2\%$	HP 8902A*	P,A,T, M,V
Sensors			
Power sensor (for HP 8560E or HP 8561E)	Frequency range: 10 MHz to 12 GHz Maximum SWR: 1.40 (10 to 30 MHz) 1.18 (30 to 50 MHz) 1.10 (50 MHz to 2 GHz) 1.18 (2 to 12.4 GHz)	HP 8481A*	P,A,T, M,V
Power sensor	Frequency range: 250 MHz to 350 MHz Power range: 100 nW to 10 μ W Maximum SWR: 1.15 (250 to 350 MHz)	HP 8481D	P,A
* Part of microwave workstation P = performance tests; A = adjustments; M = test & adjustment module; T = troubleshooting; V = operation verification			

Table 1-5. Recommended Test Equipment (continued)

Instrument	Critical Specifications for Equipment Substitution	Recommended Model	Use
Power sensor	Frequency range: 100 kHz to 2.9 GHz Maximum SWR: 1.1 (1 MHz to 2.0 GHz) 1.30 (2.0 GHz to 2.9 GHz)	HP 8482A*	P,A,T, M,V
Power sensor (for HP 8563E)	Frequency range: 50 MHz to 26.5 GHz Maximum SWR: 1.15 (50 to 100 MHz) 1.10 (100 MHz to 2 GHz) 1.15 (2.0 to 12.4 GHz) 1.20 (12.4 to 18 GHz) 1.25 (18 to 26.5 GHz)	HP 8485A*	P,A,T, M,V
Power sensor (for HP 8564E and HP 8565E)	Frequency range: 50 MHz to 50 GHz Maximum SWR: 1.15 (50 to 100 MHz) 1.10 (100 MHz to 2 GHz) 1.15 (2.0 to 12.4 GHz) 1.20 (12.4 to 18 GHz) 1.25 (18 to 26.5 GHz) 1.30 (26.5 to 40 GHz) 1.50 (40 to 50 GHz)	HP 8487A	P,V
Other Equipment Controller	Required to run operation verification software and adjustment/diagnostic software (HP 8564E/ HP 8565E)	HP 9816A, HP 9836A/C, HP 310, 320 HP 332, 360	V
Oscilloscope	Bandwidth (3 dB): dc to 100 MHz Two channels Minimum vertical deflection factor: ≤ 5 mV/div Minimum timebase setting: <100 ns Digitizing display with time cursors Delta-t cursor accuracy in 500 ns/Div: <0.1 μ s	HP 54501A*	P,A,T
Amplifier	Frequency range: HP 8560E, 2.0 to 2.9 GHz HP 8561E, 2.0 to 6.5 GHz HP 8563E, 2.0 to 8.0 GHz HP 8564E, 2.0 to 8.0 GHz HP 8565E, 2.0 to 8.0 GHz	HP 11975	P

* Part of microwave workstation

P = performance tests; A = adjustments; M = test & adjustment module; T = troubleshooting;
V = operation verification

Table 1-5. Recommended Test Equipment (continued)

Instrument	Critical Specifications for Equipment Substitution	Recommended Model	Use
Power supply	Minimum output power (leveled) 2.0 to 8.0 GHz: +16 dBm Output SWR (leveled): <1.7 Output voltage: ≥ 24 Vdc Output voltage accuracy: $< \pm 0.2$ V	HP 6114A	A
Signature multimeter	Clock frequency >10 MHz Time interval function	HP 5005A/B	T
Digital voltmeter	Range: -15 Vdc to +120 Vdc Accuracy: $< \pm 1$ mV on 10 V range Input impedance: ≥ 1 M Ω	HP 3456A*	A,T
Probes			
DVM test leads	≥ 36 inches, alligator clips, probe tips	HP 34118A	A,T
High-frequency probe	No substitute	HP 85024A	T
High-voltage probe	Voltage division ratio: 1000:1	HP 34111A	T
Accessories			
Directional bridge	Frequency range: 1 to 80 MHz Coupling: 6 dB (nominal) Maximum coupling deviation: <1 dB (nominal) Directivity: 40 dB minimum Impedance: 50 Ω (nominal)	HP 8721A	P
Directional coupler (for HP 8561E) (two required)	Frequency range: 2.0 to 6.5 GHz Coupling: 16.0 dB (nominal) Maximum coupling deviation: ± 1 dB (nominal) Directivity: 14 dB minimum Flatness: 0.75 dB maximum VSWR: <1.45 Insertion loss: <1.3 dB	0955-0098	P
Directional coupler (for HP 8563E, HP 8564E, and HP 8565E) (two required)	Frequency range: 2.0 to 8.1 GHz Coupling: 16.0 dB (nominal) Maximum coupling deviation: ± 1 dB (nominal) Directivity: 14 dB minimum Flatness: 0.75 dB maximum VSWR: <1.45 Insertion loss: <1.3 dB	0955-0098	P
10 dB step attenuator	Attenuation range: 30 dB Frequency range: dc to 80 MHz Connectors: BNC(f)	HP 355D	P,V
* Part of microwave workstation P = performance tests; A = adjustments; M = test & adjustment module; T = troubleshooting; V = operation verification			

Table 1-5. Recommended Test Equipment (continued)

Instrument	Critical Specifications for Equipment Substitution	Recommended Model	Use
1 dB step attenuator	Attenuation range: 12 dB Frequency range: dc to 80 MHz Connectors: BNC(f)	HP 355C	P,V
20 dB fixed attenuator	Frequency range: dc to 18 GHz Attenuation accuracy: $<\pm 1$ dB Maximum SWR: 1.2 (dc to 2.9 GHz)	HP 8491B Option 020	P,V
10 dB fixed attenuator	Frequency range: dc to 18 GHz Attenuation accuracy: $<\pm 0.6$ dB Maximum SWR: 1.2 (dc to 2.9 GHz)	HP 8491B Option 010	P,V
Reference attenuator	supplied with HP 8481D	HP 11708A	P,A
Termination (for HP 8560E)	Frequency range: dc to 2.9 GHz Impedance: 50 Ω Maximum SWR: <1.10 Connector: Type N(m)	HP 908A	P,M,V
Termination (for HP 8561E)	Frequency range: dc to 6.5 GHz Impedance: 50 Ω Maximum SWR: <1.10 Connector: Type N(m)	HP 909A Option 011	P,M,V
Termination (for HP 8563E)	Frequency range: dc to 26.5 GHz Impedance: 50 Ω Maximum SWR: <1.22 Connector: APC 3.5	HP 909D Option 012	P,M,V
Termination (for HP 8564E and HP 8565E)	Frequency range: dc to 50 GHz Impedance: 50 Ω Maximum SWR: <1.22 Connector: 2.4 mm (f)	HP 85138B	P,V
Low-pass filter	Cutoff frequency: 50 MHz Rejection at 65 MHz: >40 dB Rejection at 75 MHz: >60 dB	0955-0306	P,M,V
Low-pass filter (for HP 8563E, HP 8564E and HP 8565E) (two required)	Cutoff frequency: 1.8 GHz Rejection at >3 GHz: >45 dB 0.1 dB ripple	0955-0491	P
Low-pass filter (for HP 8561E HP 8563E, HP 8564E and HP 8565E) (two required)	Cutoff frequency: 4.4 GHz Rejection at 5.5 GHz: >40 dB	HP 11689A	P
P = performance tests; A = adjustments; M = test & adjustment module; T = troubleshooting; V = operation verification			

Table 1-5. Recommended Test Equipment (continued)

Instrument	Critical Specifications for Equipment Substitution	Recommended Model	Use
Power splitter (for HP 8560E or HP 8561E)	Frequency range: 1 kHz to 12 GHz Insertion loss: 6 dB (nominal) Output tracking: <0.25 dB Equivalent output SWR: <1.22	HP 11667A	P,A,M,V
Power splitter (for HP 8563E)	Frequency range: 1 kHz to 26.5 GHz Insertion loss: 6 dB (nominal) Output tracking: <0.25 dB, <18 GHz Equivalent output SWR: <1.22	HP 11667B	P,A,M,V
Power splitter (for HP 8564E and HP 8565E)	Frequency range: 30 Hz to 50 GHz Insertion loss: 6 dB (nominal) Output tracking: <0.35 dB, <26.5 GHz <0.40 dB, <50 GHz Equivalent output SWR: 1.29, <26.5 GHz 1.50, <40 GHz 1.65, <50 GHz	HP 11667C	P,A,V,T
Service accessory kit	No substitute	08562-60021	A,T
Tuning tool	No substitute	8710-1010	A
Cables			
Test cable	Connectors: BNC (m)-to-SMB (f) Length: ≥ 61 cm (24 in.)	85680-60093	A,M
Cable, RG-214/U	Connectors: Type N (m) Length: ≥ 91 cm (36 in.)	HP 11500A	P,V
Cable	Connectors: SMA (m) Length: 24 to 36 inches	8120-1578	P
Cable, 50 Ω coaxial (five required)	Connectors: BNC (m) Length: ≥ 122 cm (48 in.)	HP 10503A	P,A,V
Cable (two required)	Frequency range: 30 Hz to 26.5 GHz Maximum SWR: <1.4 at 26.5 GHz Maximum insertion loss: 3 dB Connectors: APC 3.5 (m), both ends Length: ≥ 61 cm (24 in.)	8120-4921	P,A,M,V
Cable (for HP 8564E and HP 8565E)	Frequency range: 30 Hz to 50 GHz Maximum SWR: <1.55 at 50 GHz Maximum insertion loss: 5.75 dB Connectors: 2.4 mm (f) to 2.4 mm (m) Length: ≥ 1 m (39 in.)	8120-6164	P,A,V,T
P = performance tests; A = adjustments; M = test & adjustment module; T = troubleshooting; V = operation verification			

Table 1-5. Recommended Test Equipment (continued)

Instrument	Critical Specifications for Equipment Substitution	Recommended Model	Use
Cable, HP-IB (eight required)	Required w/operation verification software Required w/HP 85629B test & adjustment module Length: 2 m (6.6 ft.)	HP 10833B	P,A,M
Adapters			
Adapter	Type N(f)-to-BNC(m)	1250-1477	P,A
Adapter (three required)	Type N(m)-to-BNC(f)	1250-1476	P,A,V
Adapter	Type N(f)-to-BNC(f)	1250-1474	P,V
Adapter	Type N(m)-to-N(m)	1250-1475	P
Adapter	Type N(f)-to-APC 3.5(m)	1250-1750	A
Adapter (two required)	Type N(m)-to-APC 3.5(m)	1250-1743	P,M,V
Adapter	Type N(m)-to-APC 3.5(f)	1250-1744	P,V
Adapter	Type N(m)-to-BNC(m)	1250-1473	P
Adapter	Type N(m)-to-N(f)	1250-1472	P
Adapter (two required)	Type N(f)-to-APC 3.5(f)	1250-1745	P,V
Adapter (two required)	Type N(m)-to-SMA(f)	1250-1250	P,V
Adapter	Type N(f)-to-SMA(f)	1250-1772	P
Adapter	BNC(f)-to-BNC(f)	1250-0059	A
Adapter	BNC tee(f)(m)(f)	1250-0781	P,A,M,V
Adapter	BNC(f)-to-SMA(m)	1250-1200	P,A,V
Adapter	BNC(f)-to-dual banana plug	1251-2816	A,T
Adapter (two required)	APC 3.5(f)-to-APC 3.5(f)	5061-5311	P,M,V
Adapter (two required)	APC 3.5(m)-to-APC 3.5(m)	1250-1748	P,V
Adapter	2.4 mm(f)-to-2.4 mm(f)	HP 11900B	P,A,T,V
Adapter	APC 3.5(f)-to-2.4 mm(f)	HP 11901B	P
Adapter	APC 3.5(m)-to-2.4 mm(f)	HP 11901D	P
Adapter	Type N(f)-to-2.4 mm(f)	HP 11903B	P,A,T,V
Adapter	Type N(f)-to-2.4 mm(m)	HP 11903C	P
P = performance tests; A = adjustments; M = test & adjustment module; T = troubleshooting; V = operation verification			

Adjustment Procedures

Introduction

This chapter contains information on automated and manual adjustment procedures for the HP 8560E spectrum analyzer. Perform the automated procedures using the HP 85629B Tests and Adjustment Module (TAM). Never perform adjustments as routine maintenance. Adjustments should be performed after a repair or performance test failure.

Introduction

- Safety Considerations

- Which Adjustments Should Be Performed?

- Test Equipment

- Adjustable and Factory-Selected Components

- Adjustment Tools

- Instrument Service Position

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- Test Equipment

- Adjustment Indicator

1. High-Voltage Power Supply Adjustment
2. Display Adjustment
3. IF Bandpass Adjustment
4. IF Amplitude Adjustments
5. DC Log Amplifier Adjustments
6. Sampling Oscillator Adjustment
7. YTO Adjustment
8. First LO Distribution Amplifier Adjustment
9. Tracking Generator Power Level Adjustments (Option 002)
10. Frequency Response Adjustment
11. Calibrator Amplitude Adjustment
12. 10 MHz Reference Adjustment-TCXO (Option 103)
13. Demodulator Adjustment
14. External Mixer Bias Adjustment
15. External Mixer Amplitude Adjustment
16. Signal ID Oscillator Adjustment (Option 008)
17. 10 MHz Reference Adjustment-OCXO
18. Tracking Oscillator Adjustment (Option 002)
19. 16 MHz PLL Adjustment

Note

Before performing any adjustments, allow the instrument to warm up for 5 minutes.

Safety Considerations

Although this instrument has been designed in accordance with international safety standards, this manual contains information, cautions, and warnings which must be followed to ensure safe operation and to prevent damage to the instrument. Service and adjustments should be performed only by qualified service personnel.

Warning	Adjustments in this section are performed with power supplied to the instrument and protective covers removed. There are voltages at many points in the instrument which can, if contacted, cause personal injury. Be extremely careful. Adjustments should be performed only by trained service personnel.
----------------	--

Warning	Power is still applied to this instrument with the LINE switch in the off position. Before removing or installing any assembly or printed circuit board, remove the line-power cord.
----------------	---

Warning	Capacitors inside the instrument may still be charged, even if the instrument has been disconnected from its source of supply.
----------------	---

Warning	Use a nonmetallic adjustment tool whenever possible.
----------------	---

Which Adjustments Should Be Performed?

Table 2-1 lists the manual adjustments that should be performed when an assembly is repaired or changed. It is important to perform the adjustments in the order indicated to ensure that the instrument meets its specifications.

Test Equipment

The equipment required for the manual adjustment procedures is listed in Table 1-5, "Recommended Test Equipment." Any equipment that satisfies the critical specifications given in the table may be substituted for the preferred test equipment.

Adjustable and Factory-Selected Components

Table 2-2 lists the adjustable components by reference designation and name. For each component, the table provides a description and lists the adjustment number.

Refer to Table 2-3 for a complete list of factory-selected components used in the instrument along with their functions. Factory-selected components are identified with an asterisk on the schematic diagrams.

Adjustment Tools

For adjustments requiring a nonmetallic tuning tool, use fiber tuning tool, HP part number 8170-0033. For adjustments to the IF Bandpass, use tuning tool, HP part number 8710-1010. Never try to force an adjustment control. This is especially critical when tuning variable capacitors or slug-tuned inductors.

Required service accessories, with part numbers, are listed under "Service Kit" in Chapter 1.

Instrument Service Position

Refer to Chapter 3 for information on removing the spectrum analyzer cover assembly and accessing all internal assemblies.

Table 2-1. Related Adjustments

Assembly Changed or Repaired	Perform the Following Related Adjustments in the Order Listed	Adjustment Number
A1A1 Keyboard	No related adjustment	
A1A2 RPG	No related adjustment	
A2 Controller	16 MHz PLL Adjustment	19
	Display Adjustment	2
	If the old EEROM cannot be used in a new A2 or if an EEROM must be replaced, the following adjustments must be performed:	
	First LO Distribution Amplifier Adjustment	8
	External Mixer Amplitude Adjustment	15
	Frequency Response Adjustment	10
A3 Interface	Display Adjustment (fast zero span)	2
	Frequency Response Adjustment	10
A4 Log Amp/Cal Osc	Display Adjustment (fast zero span)	2
	Demodulator Adjustment	13
	IF Amplitude Adjustment	4
	DC Log Amplifier Adjustment	5
A5 IF	IF Bandpass Adjustment	3
	IF Amplitude Adjustment	4
A6 Power Supply	High Voltage Power Supply Adjustment	1
	Display Adjustment	2
A6A1 HV Module	High Voltage Power Supply Adjustment	1
	Display Adjustment	2
A7 1ST LO	First LO Distribution Amplifier Adjustment	8
Distribution Amplifier	Frequency Response Adjustment (or perform the Frequency Response performance test in the <i>HP 8560 E-Series Spectrum Analyzer Calibration Guide</i> . The adjustment must be performed if the performance test fails.)	10
A8 Low Band Mixer	Frequency Response Adjustment	10
A9 Input Attenuator	Frequency Response Adjustment (or perform the Frequency Response performance test in the <i>HP 8560 E-Series Spectrum Analyzer Calibration Guide</i> . The adjustment must be performed if the performance test fails.)	10
A10 Tracking Generator	Tracking Generator Power Level Adjustment	9
	Frequency Response Adjustment	10
A11 YTO	YTO Adjustment	7
	Frequency Response Adjustment (or perform the Frequency Response performance test in the <i>HP 8560 E-Series Spectrum Analyzer Calibration Guide</i> . The adjustment must be performed if the performance test fails.)	10

Table 2-1. Related Adjustments (continued)

Assembly Changed or Repaired	Perform the Following Related Adjustments in the Order Listed	Adjustment Number
A13 2nd Converter	Frequency Response Adjustment	10
A14 Frequency Control	Display Adjustment (fast zero span)	2
	YTO Adjustment	7
	First LO Distribution Amplifier Adjustment	8
	Frequency Response Adjustment	10
A15 RF	10 MHz Reference Adjustment (Option 103)	12
	Calibrator Amplitude Adjustment	11
	External Mixer Bias Adjustment	14
	Sampling Oscillator Adjustment	6
	Signal ID Oscillator Adjustment	16
	External Mixer Amplitude Adjustment	15
	Frequency Response Adjustment	10
A15U100 Sampler	Sampling Oscillator Adjustment	6
A17 CRT Driver	Display Adjustment	2
A18V1 CRT	Display Adjustment	2
A19 HP-IB	No related adjustment	
A21 OCXO	10 MHz Reference Adjustment (OCXO)	17

Table 2-2. Adjustable Components

Reference Designator	Adjustment Name	Adjustment Number	Description
A2R152	16 MHz PLL ADJ	19	Adjusts the free-running frequency of the 16 MHz CPU clock.
A2R206	DGTL X GAIN	2	Adjusts the horizontal gain in the X line generator.
A2R209	SWEEP OFFSET	2	Adjusts the beginning of the trace to the leftmost vertical graticule line in fast-analog, zero-span mode.
A2R215	DGTL Y GAIN	2	Adjusts the vertical gain in the Y line generator.
A2R218	VIDEO OFFSET	2	Adjusts the vertical position in fast-analog, zero-span to match the digital zero-span input.
A2R262	STOP BLANK	2	Adjusts the blanking at the end of a vector on the display.
A2R263	START BLANK	2	Adjusts the blanking at the start of a vector on the display.
A2R268	VIDEO GAIN	2	Adjusts the vertical gain in fast-analog, zero-span to match with the digital zero-span input.
A2R271	SWEEP GAIN	2	Adjusts the end of the trace to the rightmost vertical-graticule line in fast-analog, zero-span mode.
A4C707	FM DEMOD	13	Adjusts the FM demodulation for a peak response.
A4R445	LIMITER PHASE	5	Adjusts Limiter Phase for peak response
A4R531	LOG AMP TOS	5	Minimizes Log error near Top of Screen
A4R544	LIN FIDELITY BOW	5	Minimizes Linearity Fidelity error.
A4R826	CAL OSC AMPTD	4	Sets calibration oscillator output power (nominally -35 dBm). This power is injected into the IF during the AUTO IF ADJUST routines.
A5L300	LC CTR 1	3	Adjusts center frequency of first stage of LC bandwidth filter to 10.7 MHz.
A5L301	LC CTR 2	3	Adjusts center frequency of second stage of LC bandwidth filter to 10.7 MHz.
A5L700	LC CTR 3	3	Adjusts center frequency of third stage of LC bandwidth filter to 10.7 MHz.
A5L702	LC CTR 4	3	Adjusts center frequency of fourth stage of LC bandwidth filter to 10.7 MHz.
A5R343	15 DB ATT	4	Adjusts the attenuation of the Reference 15 dB attenuator for 15 dB between minimum and maximum attenuation.
A5T200	XTAL CTR 1	3	Adjusts center frequency of first stage of crystal bandwidth filter to 10.7 MHz.
A5T202	XTAL CTR 2	3	Adjusts center frequency of second stage of crystal bandwidth filter to 10.7 MHz.

Table 2-2. Adjustable Components (continued)

Reference Designator	Adjustment Name	Adjustment Number	Description
A5T500	XTAL CTR 3	3	Adjusts center frequency of third stage of crystal bandwidth filter to 10.7 MHz.
A5T502	XTAL CTR 4	3	Adjusts center frequency of fourth stage of crystal bandwidth filter to 10.7 MHz.
A6R410	HV ADJ	1	Adjusts the voltage between A6TP405 and A6TP401 to the voltage marked on the A6A1 High Voltage Module.
A10R13	-10 dB ADJ	9	Offsets power level range of A10 Tracking Generator.
A10R18	0 dB ADJ	9	Adjusts gain of power level range of A10 Tracking Generator.
A10C3	TRK OSC CTR	20	Centers range of A10 Tracking Generator's tracking oscillator.
A14R42	6.01 GHz	7	Adjusts the main coil tune driver current at a YTO frequency of 6.01 GHz (near the upper YTO frequency limit).
A14R76	FM SPAN	7	Adjusts the FM span accuracy by affecting the sensitivity of the FM coil driver.
A14R93	3.2 GHz	7	Adjusts the main coil fixed driver current at a YTO frequency of 3.2 GHz (near the lower YTO frequency limit).
A15C100	SMPL MATCH 1	6	Transforms the sampler input impedance to 50 ohms over the 280 to 298 MHz range.
A15C210	VCO RANGE	6	Adjusts the VCO tank capacitance so that 21 V on the VCO tune line equals 298 MHz VCO frequency.
A15C629	298 MHz ADJ	17	Fine adjusts the 298 MHz SIG ID Oscillator (Option 008) frequency to optimize its performance.
A15U302	10 MHz ADJ	12	Adjusts frequency of the temperature compensated crystal oscillator (TCXO) to 10 MHz.
A15R561	CAL AMPTD	11	Adjusts amplitude of the 300 MHz calibrator signal to -10.0 dBm.
A15R926	EXT BIAS ZERO	14	Adjusts zero bias point of external mixer bias.

Table 2-2. Adjustable Components (continued)

Reference Designator	Adjustment Name	Adjustment Number	Description
A17R4	Z GAIN	2	Adjusts maximum intensity.
A17R11	CUTOFF	2	Adjusts intensity to turn off blanked lines.
A17R21	Z FOCUS	2	Adjusts focus for lines of different brightness.
A17R26	X FOCUS	2	Adjusts focus at the left and right corners of the display.
A17R34	COARSE FOCUS	2	Adjusts focus at the center of the display.
A17R55	X GAIN	2	Adjusts the horizontal-deflection amplifier gain.
A17R57	X POSN	2	Adjusts the CRT horizontal position.
A17R75	Y GAIN	2	Adjusts the vertical-deflection amplifier gain.
A17R77	Y POSN	2	Adjusts the CRT vertical position.
A17R90	TRACE ALIGN	2	Adjusts the display axis rotation.
A17R92	DDD	2	Adjusts focus of the center of the display.
A17R93	ASTIG	2	Adjusts for the spot roundness on the CRT display.

Table 2-3. Factory Selected Components

Reference Designator	Adjustment Number	Basis of Selection
A5C204	3	Selected to optimize center frequency of LC tank that loads the crystal.
A5C216	3	Selected to optimize center frequency of LC tank that loads the crystal.
A5C326	3	Selected to optimize LC pole center frequency.
A5C327	3	Selected to optimize LC pole center frequency.
A5C505	3	Selected to optimize center frequency of LC tank that loads the crystal.
A5C516	3	Selected to optimize center frequency of LC tank that loads the crystal.
A5C717	3	Selected to optimize LC pole center frequency.
A5C718	3	Selected to optimize LC pole center frequency.
A15U802	16	Selected to set the gain of the second IF to 12 dB.

Using the TAM

The HP 85629B TAM can be used to perform approximately half of the HP 8560E adjustment procedures. Table 2-4 lists the TAM adjustments and their corresponding manual adjustments.

The TAM adjustments do not include procedures for choosing factory-selected components. If an adjustment cannot be made and a factory-selected component must be changed, refer to the corresponding manual adjustment.

To select an adjustment, press **MODULE** to display the TAM main menu, then press **ADJUST**. Position the pointer next to the desired adjustment using either the knob or step keys. Press **EXECUTE**, then follow the instructions displayed on the screen.

Test Equipment

During the TAM adjustments, instructions for setting test equipment controls are displayed, with the exclusion of the test listed below. Test equipment for this adjustment is controlled automatically.

Test 8. Low Band Flatness

Table 2-5 lists the test equipment needed to perform each TAM adjustment. Required models must be used. Substitutions may be made for recommended models. Substitute sources must operate over the frequency ranges indicated. Recommended substitutes are listed in the Configuration Menu. If you must substitute the source with a user-defined model, the adjustments run faster using a synthesized source rather than an unsynthesized source.

Note

When connecting signals from the HP 8340A/B (or any microwave source) to the adjustment setup, use a high-frequency test cable with minimum attenuation to 2.9 GHz. HP part number 8120-4921 is recommended for its ruggedness, repeatability, and low insertion loss.

Adjustment Indicator

To aid in making adjustments, the TAM displays an "Analog Voltmeter Display Box" along the left-hand side of the display. A horizontal line moves inside the box to represent the needle of an analog voltmeter. A digital readout appears below the box. Tick marks are often displayed on the inside edges of the box indicating the desired needle position. (The tick marks and needle are intensified when the needle is within this acceptable region.) During some adjustments, an arrow appears along the right edge of the box. This arrow always indicates the highest position the needle has reached. The arrow is useful when a component must be adjusted for a peak response; if the peak is overshoot, the arrow indicates where the peak was. The component can be readjusted until the needle is at the same position as the arrow.

Table 2-4. TAM Adjustments

TAM Adjustment	Corresponding Manual Adjustment	Adjustment Number
1. IF Bandpass, LC Poles	IF Bandpass Adjustment	3
2. IF Bandpass, Crystal Poles	IF Bandpass Adjustment	3
3. IF Amplitude	IF Amplitude Adjustment	4
4. Limiter Phase	DC Log Amplifier Adjustments, A4 Limiter Phase	5
5. Linear Fidelity	DC Log Amplifier Adjustments, A4 Linear Fidelity	5
6. Log Fidelity	DC Log Amplifier Adjustments, A4 Log Fidelity	5
7. Sampling Oscillator	Sampling Oscillator Adjustment	6
8. YTO	YTO Adjustment	7
9. LO Distribution Amp	First LO Distribution Amplifier Adjustment	8
10. Low Band Flatness	Frequency Response Adjustment	10
11. Calibrator Amplitude	Calibrator Amplitude Adjustment	11
12. 10 MHz Reference Oscillator	10 MHz Reference Adjustment – TCXO (Option 103)	12
13. External Mixer Bias *	External Mixer Bias Adjustment	14
14. External Mixer Amplitude *	External Mixer Amplitude Adjustment	15
* Adjustment excluded if the HP 8560E is an Option 002.		

Table 2-5. Required Test Equipment for TAM

Adjustment	Equipment Used	Required Model	Recommended Model
1. IF Bandpass, LC Poles	None		
2. IF Bandpass, Crystal Poles	None		
3. IF Amplitude	Synthesizer/Level Generator Test Cable (SMB to BNC) Manual Probe Cable	HP 3335A	85680-60093
4. Limiter Phase	Synthesizer/Level Generator Test Cable BNC	HP 3335A	HP 10503A
5. Linear Fidelity	Synthesizer/Level Generator Test Cable BNC	HP 3335A	HP 10503A
6. Log Fidelity	Synthesizer/Level Generator Test Cable BNC	HP 3335A	HP 10503A
7. Sampling Oscillator	Manual Probe Cable		
8. YTO	Frequency Counter (3 to 6.8 GHz)		HP 5342A, HP 5343A
9. LO Distribution Amplifier	Power Meter Power Sensor (3 to 6.8 GHz, 10 to 20 dBm)		HP 8902A, HP 436A, HP 438A HP 8485A
10. Low Band Flatness	Source (10 MHz to 2.9 GHz) Power Meter Power Sensor (10 MHz to 2.9 GHz) Power Splitter (10 MHz to 2.9 GHz)		HP 8340A/B HP 8902A, HP 436A, HP 438A HP 8482A, HP 8481A HP 11667B
11. Calibrator Amplitude	Power Meter Power Sensor	HP 8482A, HP 8481A	HP 8902A, HP 436A, HP 438A
12. 10 MHz Reference Oscillator	Frequency Counter (9 to 11 MHz)		HP 5342A, HP 5343A
13. External Mixer Bias	Manual Probe Cable		
14. External Mixer Amplitude	Power Meter Power Sensor (310.7 MHz, -25 to -35 dBm) Source (310.7 MHz, -30 dBm)		HP 8902A, HP 436A, HP 438A HP 8481D, HP 8484A HP 8340A/B

1. High-Voltage Power Supply Adjustment

Assembly Adjusted

A6 power supply

Related Performance Test

There is no related performance test for this adjustment.

Description

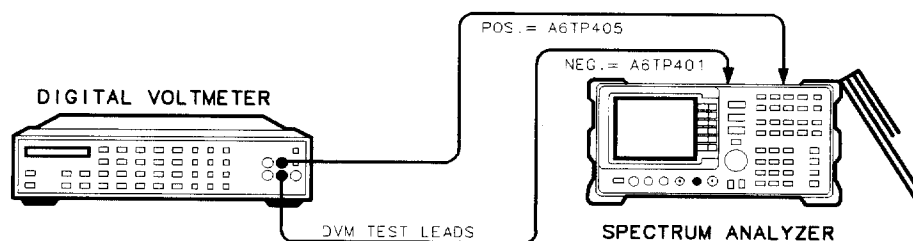
The high-voltage power supply is adjusted to the voltage marked on the A6A1 HV module. The A6A1 HV module is characterized in the factory to ensure that the display filament voltage is set to 6.0 V rms when the +110 Vdc (nominal) supply is set to the voltage marked on the HV module.

Warning	To minimize shock hazard, use a nonmetallic adjustment tool when adjusting the A6 power supply.
----------------	--

Warning	The following procedure probes voltages that, if contacted, could cause personal injury or death.
----------------	--

Note	Adjustment of the high-voltage power supply should not be a routine maintenance procedure. Any adjustments should be done only if the A6 power supply, A6A1 HV module, or A18 CRT (display) is repaired or replaced.
-------------	--

Note	You must perform the display adjustments after this adjustment if either the display or HV module has been replaced.
-------------	--



SK 11

Figure 2-1. High-Voltage Power Supply Adjustment Setup

1. High-Voltage Power Supply Adjustment

Equipment

Digital multimeter	HP 3456A
DVM test leads	HP 34118A

Procedure

Warning **After disconnecting the ac power cord, allow capacitors in the high-voltage supply to discharge for at least 30 seconds before removing the protective cover from the A6 power supply.**

1. Press **LINE** to turn the spectrum analyzer off, disconnect the power cord, and remove the spectrum analyzer cover. Fold down the A2 controller, A3 interface, A4 log amplifier, and A5 IF assemblies. Remove the A6 power supply cover.
2. Position the HP 8560E as shown in Figure 2-1. Connect the positive DVM lead to A6TP405 and the negative DVM lead to A6TP401.
3. Set the HP 3456A controls as follows:

Function DC VOLTS
Range 1000 VOLTS

4. Reconnect the power cord to the spectrum analyzer and press **LINE** to turn the spectrum analyzer on.
5. Record the voltage marked on the A6A1 HV module.

Voltage marked on A6A1 HV Module = _____ Vdc

6. Adjust A6R410 HV ADJ for a voltage equal to the voltage recorded in step 5.
7. Press **LINE** to turn the spectrum analyzer off and disconnect the power cord. Wait at least 30 seconds for the high-voltage power supply capacitors to discharge.
8. Disconnect the DVM test leads from A6TP401 and A6TP405. Reinstall the power supply cover.

2. Display Adjustment

Assembly Adjusted

A2 controller
A17 CRT driver

Related Performance Test

Sweep Time Accuracy (sweep times <30 ms)

Description

Coarse adjustment of the deflection amplifiers, Z-axis amplifiers, and line generators is done using the CRT adjust pattern. Fine adjustments use the graticule. The fast zero-span amplitude adjustments correct for differences between analog and digital display modes. The displayed sweep time accuracy is adjusted in the fast zero-span sweep adjustments for non-Option 007 spectrum analyzers.

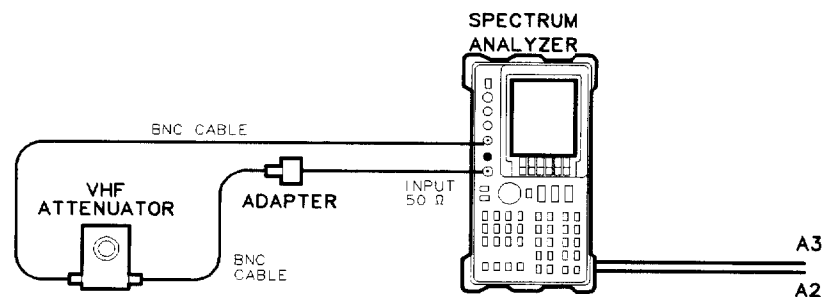


Figure 2-2. Display Adjustment Setup

Equipment

10 dB VHF step attenuator HP 355D
Photometer/radiometer TEK J16-TV

Adapters

Type N (m) to BNC (f) 1250-1476

Cables

BNC, 122 cm (2 required) HP 10503A

Procedure

1. Press **LINE** to turn the spectrum analyzer off. Remove the spectrum analyzer's cover and fold out the A2 Controller and A3 Interface assemblies as illustrated in Figure 2-2. Connect the CAL OUTPUT to the INPUT. Adjustment locations are shown on the CRT neck for A17 adjustments and in Figure 2-4 for the A2 adjustments.

Preliminary Adjustments

2. Set A17R55 X GAIN, A17R75 Y GAIN, A17R92 DDD, A17R93 ASTIG, A2R206 DGTL X GAIN, A2R215 DGTL Y GAIN, A2R262 STOP BLANK, and A2R263 START BLANK to midrange. Also set the rear-panel X POSN, Y POSN, and TRACE ALIGN to midrange.
3. Set A17R21 Z FOCUS, A17R26 X FOCUS, and A17R11 CUTOFF fully counterclockwise.
4. Set A17R4 Z GAIN fully clockwise.
5. Turn the spectrum analyzer on and allow it to warm up for at least 3 minutes. Adjust A17R11 CUTOFF until the display is visible and A17R34 COARSE FOCUS for best possible focus.

Cutoff Adjustment

6. Press **PRESET**, **DISPLAY**, **INTENSITY**, 255, **ENTER**, **STORE INTENSITY**, **MORE 1 of 2**, **FOCUS**, 127, **ENTER**, **STORE FOCUS**, then **GRAT OFF**. Adjust A17R11 CUTOFF until the line between the bottom of trace A and the annunciators at the bottom of the display just disappears.

Deflection Adjustments

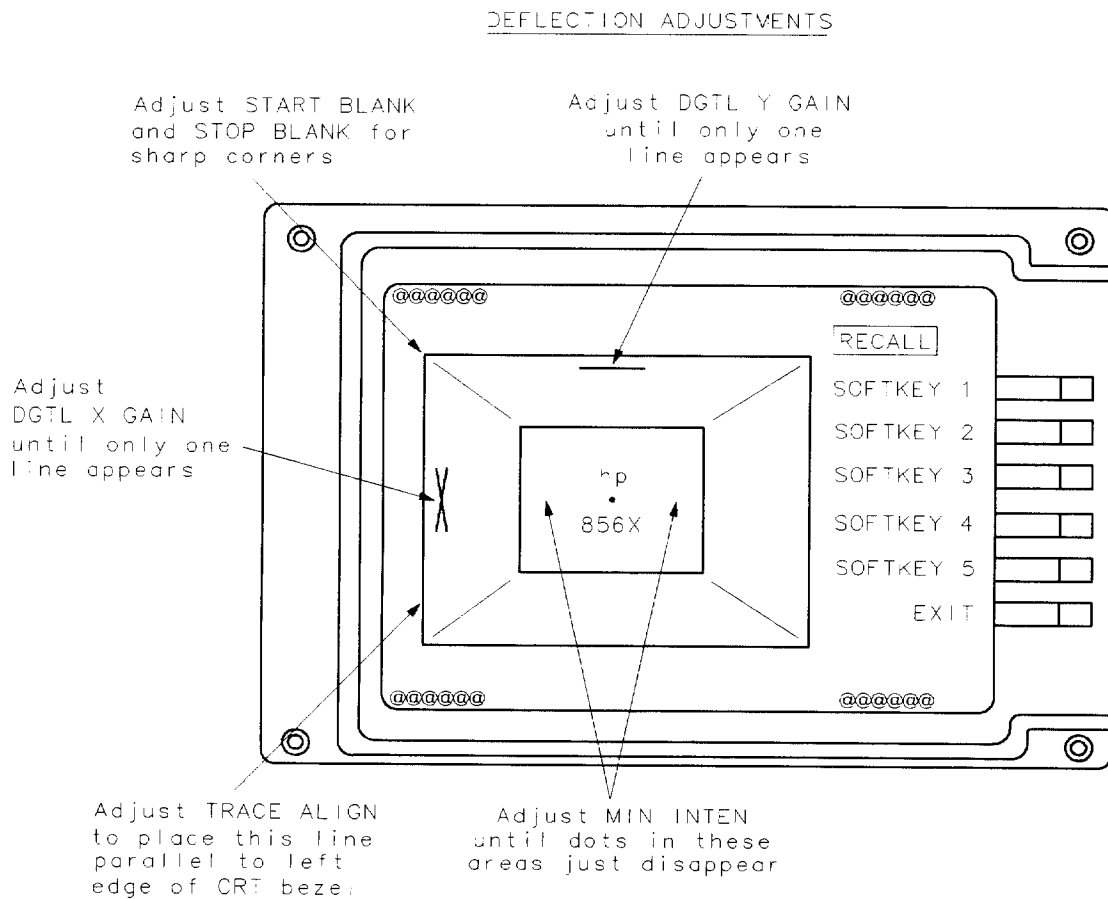
7. Press **GRAT ON**, **MORE 2 of 2**, **INTENSITY**, 80 **ENTER**, **STORE INTENSITY**, **CAL**, **MORE 1 of 2**, and **CRT ADJ PATTERN**. Fold up the A3 Interface assembly.
8. Refer to Figure 2-3 for locating the lines used for adjusting DGTL X GAIN and DGTL Y GAIN. Each of these lines is actually two lines adjusted for coincidence. The two lines will form an "X" if they are not adjusted properly.
9. Adjust A2R206 DGTL X GAIN until the two vertical lines near the left edge of the display appear to be one single line.
10. Adjust A2R215 DGTL Y GAIN until the two horizontal lines near the top edge of the display appear to be one single line.
11. Adjust A2R262 STOP BLANK and A2R263 START BLANK for the sharpest corners of the outer box in the test pattern. The intensity of the corners should be the same as the middle of the lines between the corners.
12. Adjust the rear-panel TRACE ALIGN until the leftmost line of the test pattern is parallel with the CRT bezel. See Figure 2-3.
13. Adjust the rear-panel X POSN and A17R55 X GAIN until the leftmost "@" characters and the softkey labels appear just inside the left and right edges of the CRT bezel.

2. Display Adjustment

14. Adjust the rear-panel Y POSN and A17R75 Y GAIN until the softkey labels align with their appropriate softkeys.
15. Press **PRESET**. If necessary, readjust STOP BLANK and START BLANK for the best-looking intersection of the graticule lines. This will be most noticeable along the center vertical and horizontal graticule lines.

Intensity Adjustments

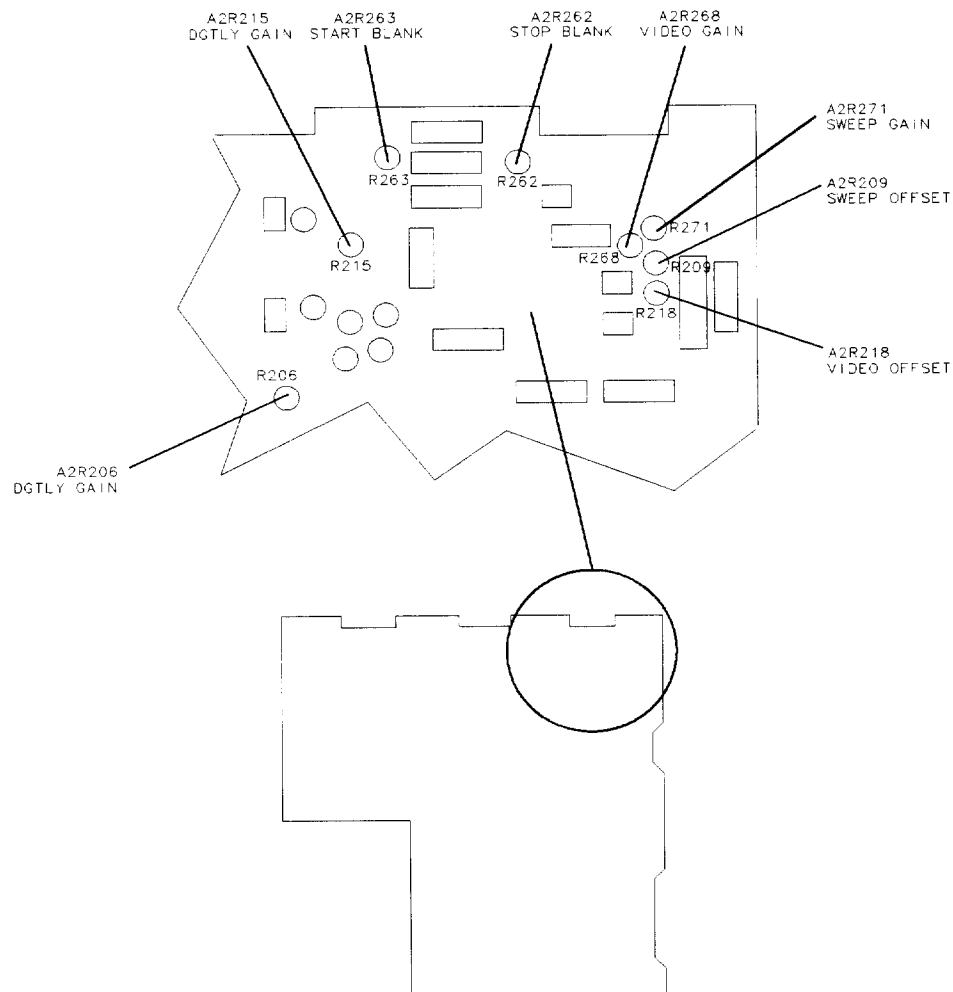
16. Press **AMPLITUDE** then set the **REF LVL** to -70 dB and the **LOG dB/DIV** to 1. This should almost completely fill the screen with the noise floor. Press **SGL SWP**. Adjust A17R4 Z GAIN until the intensity at the center of the screen is 15 NITs, as indicated by the TEK J16-TV Photometer/Radiometer.
17. Press **CAL**, **MORE 1 of 2**, and **CRT ADJ PATTERN**. Locate the dot just below the HP logo. Adjust A17R93 ASTIG for the smallest round dot possible.



SK13

Figure 2-3. CRT Adjust Pattern

2. Display Adjustment



SK14

Figure 2-4. A2 Display Adjustment Locations

18. Adjust A17R34 COARSE FOCUS and A17R92 DDD for the best focus of the characters at the center of the screen.
19. Adjust A17R21 Z FOCUS for the best focus of the test pattern's outside box.
20. Adjust A17R26 X FOCUS for best focus of the "@" characters at the corners of the test pattern.
21. Repeat steps 17 through 20 to obtain the best overall focus quality.

2. Display Adjustment

Fast Zero Span Adjustments

Note The following adjustments apply only to analyzers not equipped with Option 007, fast digitized time domain sweeps.

22. Set A2R209 SWEEP OFFSET, A2R218 VIDEO OFFSET, A2R268 VIDEO GAIN and A2R271 SWEEP GAIN to midrange. Adjustment locations are shown in Figure 2-4 for these A2 adjustments.
23. Set the HP 355D attenuator to provide 30 dB attenuation.
24. Press **[PRESET]** on the spectrum analyzer, and connect the equipment as shown in Figure 2-2. Set the HP 8560E controls as follows:

Center frequency		300 MHz
Span		0 Hz
Reference level		-40 dBm
Resolution BW		1 kHz
Video BW		300 Hz
Sweep time		50 ms
25. Press **[MKR]**, **[MKR->]**, and **MARKER-> REF LVL**. If the marker is not at the top graticule, press **MARKER-> REF LVL** again.
26. Press **[SAVE]**, **SAVE STATE**, and **STATE 0**.
27. Set the sweep time to 10 ms.
28. Press **[SAVE]**, **SAVE STATE**, and **STATE 1**.
29. Adjust A2R209 SWEEP OFFSET to place the beginning of the trace at the leftmost vertical graticule line.
30. Adjust A2R271 SWEEP GAIN to place the end of the trace at the tenth vertical graticule line (one division from the right edge of the graticule).
31. Press **[AMPLITUDE]** and press the $\uparrow$ key 7 times.
32. Press **[SAVE]**, **SAVE STATE**, and **STATE 2**.
33. Set the sweep time to 50 ms. Press **[SAVE]**, **SAVE STATE**, and **STATE 3**.
34. Press **[RECALL]**, **RECALL STATE**, and **STATE 1**.
35. Switch between **STATE 1** and **STATE 2**. Adjusting A2R268 and A2R218 so that in STATE 1 the trace is lined up with the top graticule and in STATE 2 the trace is lined up with the eighth graticule (from the top line). Repeat until they align to within ± 0.2 divisions.
36. Adjust A2R209 and A2R271 until the start of sweep is aligned to the leftmost vertical graticule line and the stop sweep is aligned with the right most vertical graticule line.
37. Press **STATE 2** and **STATE 3**. The two traces should be aligned within ± 0.1 divisions.
38. Press **STATE 0** and **STATE 1**. The two traces should be aligned within ± 0.1 divisions.

3. IF Bandpass Adjustment

Assembly Adjusted

A5 IF assembly

Related Performance Test

Resolution Bandwidth Accuracy and Selectivity

Description

The center frequency of each IF bandpass filter pole is adjusted by DAC-controlled varactor diodes and an inductor (for the LC poles) or a transformer (for the crystal poles). The inductors and transformers are for coarse tuning and the varactors are for fine tuning by the microprocessor. The inductors and transformers are adjusted such that the varactor diodes are biased near the middle of their capacitance range. The varactor diode bias is measured with the DVM.

Note This procedure is not a routine adjustment. It should be performed only if repairs to the A5 IF assembly are made. If the entire A5 IF assembly is replaced, the assembly arrives pre-adjusted from the factory and requires no further adjustment.

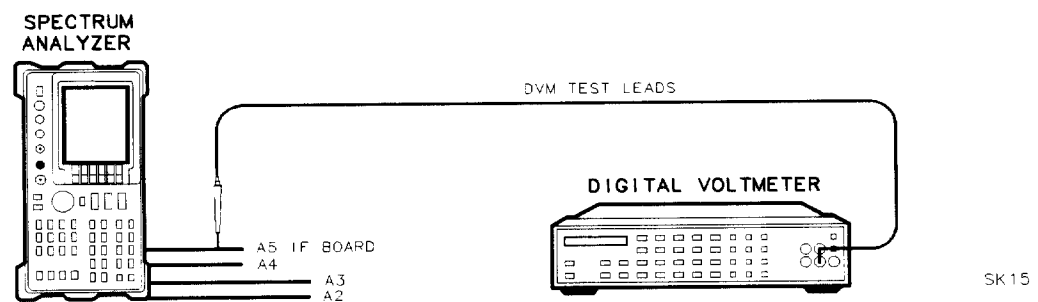


Figure 2-5. IF Bandpass Adjustment Setup

Equipment

Digital voltmeter	HP 3456A
DVM test leads	HP 34118A
Special tuning tool	8710-1010

3. IF Bandpass Adjustment

Procedure

1. Press **LINE** to turn the spectrum analyzer off and disconnect the power cord. Remove the spectrum analyzer cover and fold down the A2 controller, A3 interface, A4 log amp, and A5 IF assemblies. Reconnect the power cord and press **LINE** to turn the spectrum analyzer on. Allow the spectrum analyzer to warm up for at least 30 minutes.
2. Connect the negative DVM lead to pin 6 of A5J6. See Figure 2-5. Set the HP 3456A controls as follows:

Function DC VOLTS
Range 10 V

3. On the HP 8560E press **PRESET**, **SPAN**, 2, **MHz**, **CAL**, and **IF ADJ OFF**.

LC Bandpass Adjustments

4. On the HP 8560E, press **ADJ CURR IF STATE**. Wait for the IF ADJUST STATUS message to disappear before continuing with the next step.
5. Read the voltage on A5TP5 (this is an empty-hole type of test point). If the voltage is less than +6.06 Vdc, turn A5L300 LC CTR 1 clockwise. If the voltage is greater than +6.26 Vdc, turn LC CTR 1 counterclockwise.
6. Repeat steps 4 and 5 until the voltage reads +6.16 Vdc $\pm$ 100 mV.

Note

If the range for the LC CTR adjustment is insufficient, replace the appropriate factory-selected capacitor as listed in Table 2-6. To determine the correct replacement value, center the LC CTR adjustment and press **ADJ CURR IF STATE**. After the IF ADJUST STATUS message disappears, read the DVM display. Choose a capacitor value from Table 2-7, based on the DVM reading and the presently loaded capacitor value. Table 2-10 lists a few capacitor part numbers.

Caution

Press **LINE** to turn the spectrum analyzer off before removing or replacing any shield.

7. Move the positive DVM lead to A5TP6.
8. Adjust A5L301 LC CTR 2 by repeating steps 4 through 6.
9. Move the positive DVM test lead to A5TP2 (this is a resistor-lead type of test point).
10. Adjust A5L700 LC CTR 3 by repeating steps 4 through 6.
11. Move the positive DVM test lead to A5TP1 (this is a resistor-lead type of test point).
12. Adjust A5L702 LC CTR 4 using the procedure in steps 4 through 6.

3. IF Bandpass Adjustment

Table 2-6. Factory-Selected LC Filter Capacitors

LC CTR Adjustment	Fixed Factory Select Capacitor
A5L300 LC CTR 1	A5C326
A5L301 LC CTR 2	A5C327
A5L700 LC CTR 3	A5C717
A5L702 LC CTR 4	A5C718

Table 2-7. LC Factory-Selected Capacitor Selection

DVM Reading (V)	Currently Loaded Capacitor Value (pF)						
	Replace 6.8 with:	Replace 8.2 with:	Replace 10 with:	Replace 12 with:	Replace 15 with:	Replace 18 with:	Replace 20 with:
0 to 1.5	*	*	*	*	*	*	*
1.5 to 2.5	18	18	*	*	*	*	*
2.5 to 3.5	15	15	18	18	*	*	*
3.5 to 4.5	10	12	15	15	18	*	*
4.5 to 5.5	8.2	10	12	15	18	*	*
5.5 to 6.5	no change	no change	no change	no change	no change	no change	no change
6.5 to 7.5	no change	no change	no change	no change	no change	no change	no change
7.5 to 8.5	*	6.8	8.2	10	12	15	18
8.5 to 9.5	*	*	6.8	8.2	12	15	18
9.5 to 10	*	*	6.8	8.2	10	12	15

* Indicates a condition that should not exist; suspect broken hardware.

XTAL Bandpass Adjustments

13. On the HP 8560E, press **SPAN**, 1, **MHz**, and **CAL**.
14. Move the positive DVM test lead to A5TP7.
15. On the HP 8560E, press **ADJ CURR IF STATE**. Wait for the IF ADJUST STATUS message to disappear before continuing to the next step.
16. Read the voltage displayed on the DVM. If the voltage is less than +6.06 Vdc, turn A5T200 XTAL CTR 1 clockwise. If the voltage is greater than +6.26 Vdc, turn XTAL CTR 1 counterclockwise.
17. Repeat steps 15 and 16 until the voltage reads +6.16 Vdc $\pm$ 100 mV.

3. IF Bandpass Adjustment

Note

If the range for the XTAL CTR adjustment is insufficient, replace the appropriate factory-selected capacitor as listed in Table 2-8. To determine the correct replacement value, center the XTAL CTR adjustment, and press **ADJ CURR IF STATE**. After the IF ADJUST STATUS message disappears, read the DVM display. Choose a capacitor value from Table 2-9, based on the DVM reading and the presently loaded capacitor value. Table 2-10 lists a few capacitor part numbers.

Caution

Press **LINE** to turn the spectrum analyzer off before removing or replacing any shield.

18. Move the positive DVM test lead to A5TP8.
19. Adjust A5T202 XTAL CTR 2 using the procedure in steps 15 through 17.
20. Move the positive DVM test lead to A5TP3.
21. Adjust A5T500 XTAL CTR 3 using the procedure in steps 15 through 17.
22. Move the positive DVM test lead to A5TP4.
23. Adjust A5T502 XTAL CTR 4 using the procedure in steps 15 through 17.

Table 2-8. Factory-Selected XTAL Filter Capacitors

XTAL CTR Adjustment	Fixed Factory Select Capacitor
A5T200 XTAL CTR 1	A5C204
A5T202 XTAL CTR 2	A5C216
A5T500 XTAL CTR 3	A5C505
A5T502 XTAL CTR 4	A5C516

Table 2-9. XTAL Factory-Selected Capacitor Selection

DVM Reading (V)	Currently Loaded Capacitor Value (pF)					
	Replace 15 with:	Replace 18 with:	Replace 20 with:	Replace 22 with:	Replace 24 with:	Replace 27 with:
0 to 1.5	*	*	*	*	*	*
1.5 to 2.5	27	*	*	*	*	*
2.5 to 3.5	22	27	27	*	*	*
3.5 to 4.5	18	22	24	27	27	*
4.5 to 5.5	18	20	22	24	27	*
5.5 to 6.5	no change	no change	no change	no change	no change	no change
6.5 to 7.5	no change	no change	no change	no change	no change	no change
7.5 to 8.5	*	15	18	18	22	24
8.5 to 9.5	*	15	15	18	20	24
9.5 to 10	*	*	15	18	20	24

* Indicates a condition that should not exist; suspect broken hardware.

3. IF Bandpass Adjustment

Table 2-10. Capacitor Part Numbers

Capacitor Value (pF)	HP Part Number
6.8	0160-4793
8.2	0160-4792
10	0160-4791
12	0160-4790
15	0160-4789
18	0160-4788
20	0160-5699
22	0160-4787
24	0160-5903
27	0160-4786

4. IF Amplitude Adjustments

The IF Amplitude Adjustments consist of the Cal Oscillator Amplitude adjustment and the Reference 15 dB Attenuator adjustment.

Assembly Adjusted

A4 log amp/cal oscillator
A5 IF assembly

Related Performance Tests

IF Gain Uncertainty
Scale Fidelity

Equipment

Frequency synthesizer HP 3335A

Adapters

Type N (m) to BNC (f) 1250-1476

Cables

BNC, 122 cm (48 in)	HP 10503A
Test cable	85680-60093

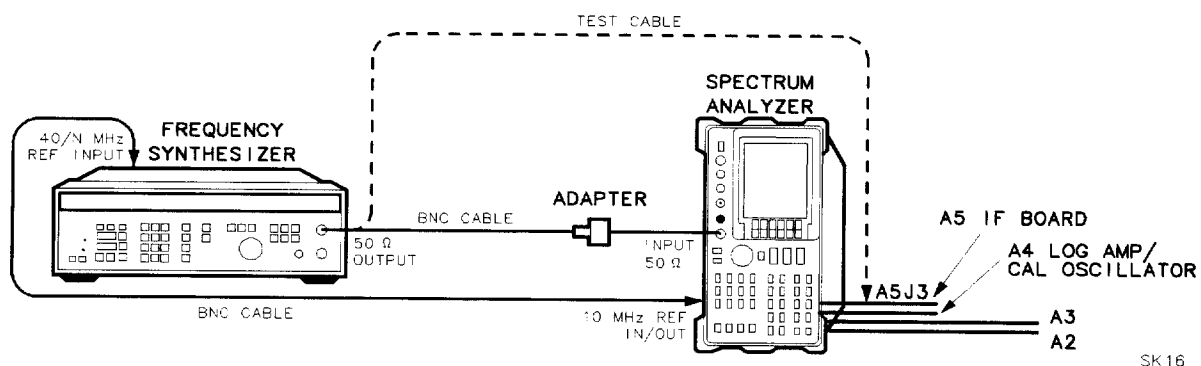


Figure 2-6. IF Amplitude Adjustment Setup

4. IF Amplitude Adjustments

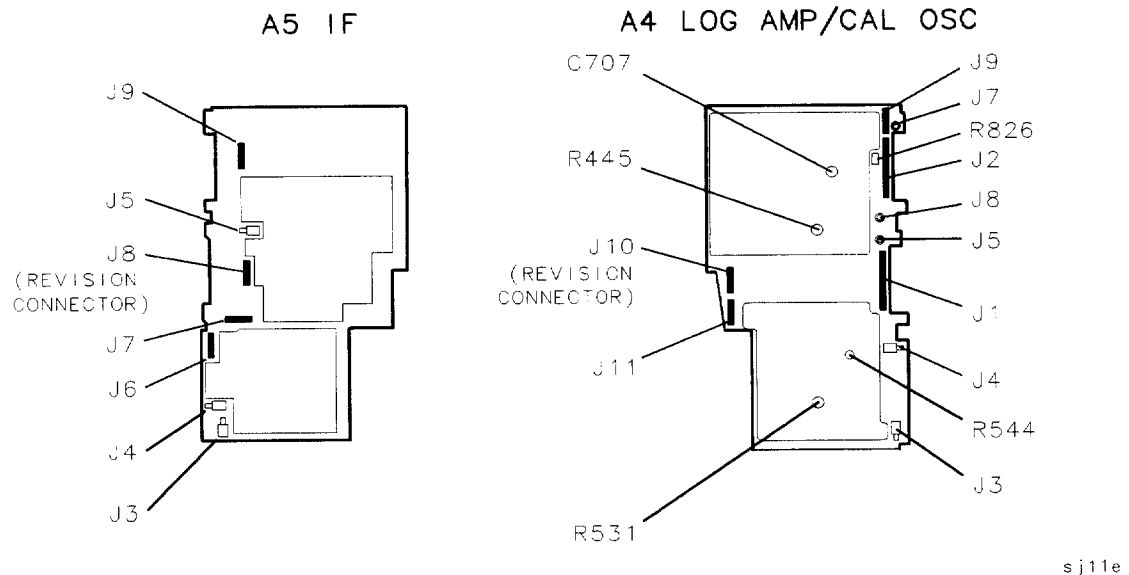


Figure 2-7. IF Amplitude Adjustment Locations

A4 Log Amp/Cal Oscillator Amplitude Adjustment

This adjustment sets the output amplitude of the cal oscillator on the A4 assembly, and the absolute amplitude of the reference 15 dB attenuator.

The output of the cal oscillator is adjusted so that a -55 dBm signal applied to the 10.7 MHz IF input on the A5 IF assembly (A5J3) causes a displayed signal of -60 dBm. The effect of this adjustment is visible only after the **ADJ CURR IF STATE** sequence is complete.

ADJ CURR IF STATE causes the IF gain adjustment to use the “new” output amplitude from the cal oscillator. When the adjustment sequence is complete, the result of the adjustment should cause the -35 dBm signal at A5J5 to be displayed at -60 dBm.

This procedure also sets the attenuator of the reference 15 dB attenuator so that a source amplitude change of 50 dB combined with a spectrum analyzer reference level change of 50 dB displays an amplitude difference of 50 dB.

Note

The 15 dB reference attenuator adjustment is preset at the factory and need not be done if the entire A5 IF assembly is replaced.

4. IF Amplitude Adjustments

Procedure

1. Press **LINE** to turn the spectrum analyzer off. Remove the spectrum analyzer cover and place the spectrum analyzer in the service position as illustrated in Figure 2-6. See Figure 2-7 for adjustment location.
2. Disconnect W29, violet coax cable, from A5J3. Connect the test cable between A5J3 and the 50 Ω output of the HP 3335A. Press **LINE** to turn the spectrum analyzer on.
3. Set the HP 8560E controls as follows:

Center frequency	10.7 MHz
Span	200 kHz
Reference level	-60 dBm
Attenuator	0 dB
Log/division	1 Log/division
Resolution BW	300 kHz
Video BW	100 Hz

4. On the HP 8560E, press **MKR**, **CAL**, and **IF ADJ OFF**.

5. Set the HP 3335A controls as follows:

Frequency	10.7 MHz
Amplitude	-55 dBm

6. Note the marker value. Ideally it should read $-60 \text{ dBm} \pm 0.1 \text{ dB}$.
7. If the marker reads below -60.1 dBm , rotate A4R826 CAL OSC AMPTD one-third turn counter-clockwise for every 0.1 dB below -60 dBm . See Figure 2-7 for the location of A4R826.
8. If the marker reads above -59.9 dBm , rotate A4R826 CAL OSC AMPTD one-third turn clockwise for every 0.1 dB above -60 dBm . A change in the displayed amplitude will not be seen at this point.

Note	If A4R826 has inadequate range, refer to "Inadequate CAL OSC AMPTD Range" in Chapter 9.
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9. Press **ADJ CURR IF STATE**. After allowing the spectrum analyzer time to complete the adjustments, the displayed amplitude and marker reading should change.
10. Repeat steps 7 and 8 until the marker reads $-60 \text{ dBm} \pm 0.1 \text{ dB}$.
11. Disconnect the test cable from A5J3 and reconnect W29 to A5J3.

A5 Reference Attenuator Adjustment

12. Set the HP 3335A **AMPLITUDE** to -60 dBm.
13. Connect a BNC cable between the $50\ \Omega$ output of the HP 3335A and the HP 8560E INPUT $50\ \Omega$.
14. On the HP 8560E, press **CAL** and **REF LEVEL ADJUST**. Use the front-panel knob or step keys to place the peak of the displayed signal 3 dB to 5 dB below the reference level.
15. On the HP 8560E press **PEAK SEARCH** and **MARKER DELTA**. Set the spectrum analyzer reference level to -10 dBm.
16. Change the HP 3335A **AMPLITUDE** to -10 dBm.
17. On the HP 8560E press **CAL**.
18. Note the Δ MKR amplitude. Ideally, it should read $50.00\text{ dB} \pm 0.1\text{ dB}$.
19. If the Δ MKR amplitude is less than 49.9 dB, rotate A5R343 (15 dB ATTEN) one-half turn counterclockwise for each 0.1 dB below 50.00 dB. If the Δ MKR amplitude is greater than 50.1 dB, rotate A5R343 one-half turn clockwise for each 0.1 dB above 50.00 dB. Do not adjust A5R343 more than five turns before continuing with the next step.
20. On the HP 8560E press **ADJ CURR IF STATE**. Note the Δ MKR amplitude reading.
21. Set the HP 8560E reference level to -60 dBm and press **MKR** and **MARKERS OFF**.
22. Repeat steps 12 through 21 until the Δ MKR amplitude reading is $50.00\text{ dB} \pm 0.1\text{ dB}$.

A5 Adjustment Verification

23. On the HP 8560E, disconnect W29 from A5J3. Connect the test cable between A5J3 and the $50\ \Omega$ output of the HP 3335A.
24. Set the HP 8560E reference level to -10 dBm.
25. Set the HP 3335A **AMPLITUDE** to -5 dBm.
26. On the HP 8560E press **MKR** and **MARKER NORMAL**.
27. The MARKER amplitude should read $-10\text{ dBm} \pm 0.13\text{ dB}$. If the reading is outside of this range, repeat steps 3 through 21.
28. On the HP 8560E, reconnect W29 to A5J3. Press **PRESET** and set the controls as follows:

Center frequency	300 MHz
Span	 0 Hz
Reference level	 -10 dBm
Resolution BW	 300 kHz
29. Connect a BNC cable between the HP 8560E CAL OUTPUT and INPUT $50\ \Omega$.
30. On the HP 8560E, press **MKR**, **CAL**, and **REF LVL ADJ**.
31. Use the knob or step keys to adjust the REF LEVEL CAL setting until the MKR reads $-10.00\text{ dBm} \pm 0.1\text{ dB}$.
32. On the HP 8560E, press **STORE REF LVL**.

4. IF Amplitude Adjustments

5. DC Log Amplifier Adjustments

There are three DC Log adjustments; Limiter Phase, Linear Fidelity, and Log Fidelity.

These adjustment need only be done under the following conditions:

Limiter Phase	Only if a repair is made to blocks F, G, H, I, or J.
Linear Fidelity	Only if a repair is made to blocks C, D, F, G, H, I, J, K, O, IF Gain Accuracy, RBW switching, or Log Fidelity.
Log Fidelity	Only if a repair is made to blocks D, F, H, K, IF Gain Accuracy, RBW switching, or Log Fidelity.

If multiple adjustments are required they should be done in the following order:

1. Limiter Phase
2. Linear Fidelity
3. Log Fidelity

All adjustments should be made with all of the shields on and only after allowing at least a 20-minute warmup.

Assembly Adjusted

A4 log amplifier

Related Performance Tests

IF Gain Uncertainty
Scale Fidelity

Equipment

Frequency synthesizer HP 3335A

Adapters

Type N (m) to BNC (f) 1250-1476

Cables

BNC, 122 cm (48 in) HP 10503A

Test cable 85680-60093

A4 Limiter Phase Adjustment

This adjustment consists of adjusting A4R445 for maximum on screen amplitude under the following conditions.

Procedure

1. Press **LINE** to turn the spectrum analyzer off. Remove the spectrum analyzer cover and place the spectrum analyzer in the service position as illustrated in Figure 2-6. See Figure 2-7 for adjustment location.
2. Connect the HP 3335A 50 Ω output to the HP 8560E 50 Ω input. Press **LINE** to turn the spectrum analyzer on.
3. Set the HP 8560E controls as follows

Center frequency	 15 MHz
Span	 0
Reference level	 -10 dBm
Log/division	 1 Log/division
Resolution BW	 300 kHz
IF Adjust	 off
4. Set up an HP 3335A as follows:

Frequency	 15 MHz
Amplitude	 -18 dBm
5. Press **CAL** and **ADJ CURR IF STATE**, wait for the spectrum analyzer to complete adjustments, then press **MKR**.
6. Adjust A4R445 for maximum on-screen amplitude. Refer to Figure 2-7 for the location of A4R445.

A4 Linear Fidelity Adjustment

This adjustment consists of adjusting A4R544 until the delta marker reads -40 dB under the following conditions.

Procedure

1. Press **LINE** to turn the spectrum analyzer off. Remove the spectrum analyzer cover and place the spectrum analyzer in the service position as illustrated in Figure 2-6. See Figure 2-7 for adjustment location.
2. Connect the HP 3335A 50 Ω output to the HP 8560E 50 Ω input. Press **LINE** to turn the spectrum analyzer on.
3. Press **PRESET**, **AMPLITUDE**, **LINEAR**, **MORE 1 of 3**, **AMPD UNITS**, **dBm**, **CAL**, and **IF ADJ OFF**.
4. Set the HP 8560E controls as follows:

Center frequency	 15 MHz
Span	 5 MHz
Resolution BW	 300 kHz
Reference level	 -10 dBm
5. Set up an HP 3335A as follows:

Frequency	 15 MHz
Amplitude	 -18 dBm

5. DC Log Amplifier Adjustments

6. Press **PEAK SEARCH** and **MARKER DELTA**.
7. Reduce the input power by 40 dB, to -58 dBm (use an attenuator or a source with a good relative amplitude accuracy).
8. If the signal is lower on the screen than expected (delta marker reads a change of greater than 40 dB, such as -41dB) then adjust A4R544 (see Figure 2-7) for an even lower level and press **CAL** and **ADJ CURR IF STATE**. Allow sufficient time for the spectrum analyzer to complete the adjustment.
9. If the signal is higher on the screen than expected (delta marker reads a change of less than 40 dB, such as reads -39 dB) then adjust A4R544 for an even higher level signal and press **CAL** and **ADJ CURR IF STATE**. Allow sufficient time for the spectrum analyzer to complete the adjustment.
10. Repeat the adjustment and adjust current state until the delta marker reads -40 dB $\pm$ 2 dB.

A4 Log Fidelity Adjustment

This adjustment consists of adjusting A4R531 until the error is adjusted to zero.

Procedure

1. Press **LINE** to turn the spectrum analyzer off. Remove the spectrum analyzer cover and place the spectrum analyzer in the service position as illustrated in Figure 2-6. See Figure 2-7 for adjustment location.
2. Connect the HP 3335A 50 Ω output to the HP 8560E 50 Ω input. Press **LINE** to turn the spectrum analyzer on.
3. Press **PRESET**, **CAL**, **IF ADJ OFF** and **ADJ CURR IF STATE**.
4. Set the HP 8560E controls as follows:
Center frequency 15 MHz
Span 0
Resolution BW 300 kHz
Reference level -10 dBm
5. Set up an HP 3335A as follows:
Frequency 15 MHz
Amplitude -10 dBm
6. Press **MKR**, **MARKER DELTA** and decrease the source power to -26 dBm.
7. Calculate the error. The error = Delta Marker reading + 16 (in dB).
8. Set the source power to -10 dBm.
9. Adjust A4R531 (see Figure 2-7) to read 2 times the error, press **CAL** and **ADJ CURR IF STATE**.
10. Repeat to check. Readjust as necessary to get error adjusted to zero.

6. Sampling Oscillator Adjustment

Assembly Adjusted

A15 RF assembly

Related Performance Test

There is no related performance test for this adjustment procedure.

Description

The sampling oscillator tank circuit is adjusted for a tuning voltage of 5.05 Vdc when the sampling oscillator is set to 297.222 MHz. The voltage monitored is actually the tuning voltage divided by 4.05. The setting is then checked at other frequencies for the full tuning range of the sampling oscillator.

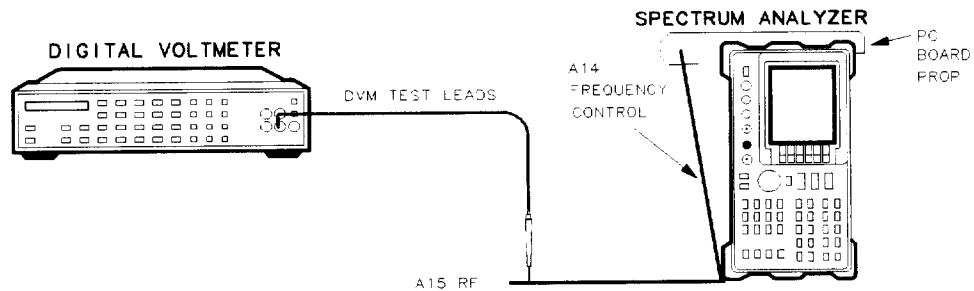


Figure 2-8. Sampler Adjustment Setup

Equipment

Digital voltmeter	HP 3456A
DVM test leads	HP 34118A

Procedure

1. Press **LINE** to turn the spectrum analyzer off and disconnect the line power cord. Remove the spectrum analyzer cover and fold down the A15 RF and A14 frequency control assemblies. Prop up the A14 frequency control assembly. Reconnect the line power cord and press **LINE** to turn the spectrum analyzer on. Connect the equipment as illustrated in Figure 2-8.

6. Sampling Oscillator Adjustment

2. Press **PRESET** on the HP 8560E and set the controls as follows:

Center frequency 2126 MHz
Span 0 Hz

3. Set the HP 3456A controls as follows:

Function DC VOLTS
Range 10 V, MANUAL

Sampling Oscillator Adjustment

4. Connect the negative DVM test lead to A15J200 pin 6. Connect the positive DVM lead to A15J200 pin 13.
5. Adjust A15C210 VCO RANGE for a DVM reading of $5.05 \text{ V} \pm 0.05 \text{ V}$.



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Figure 2-9. TAM Connector Pin Locations

Sampler Match Adjustment

6. Connect the negative DVM test lead to A15J400 pin 6, and the positive DVM test lead to A15J400 pin 1.
7. Press **FREQUENCY** and set the HP 8560E center frequency to 2302.3 MHz. This sets the sampling oscillator to 291.667 MHz.
8. Adjust A15C100 SMPL MATCH to peak the voltage displayed on the DVM.
9. Record the displayed voltage in Table 2-11 as the displayed voltage for the sampling oscillator frequency of 291.667 MHz.
10. Press **FREQUENCY** on the HP 8560E. Use the keypad to set the spectrum analyzer center frequency to the frequencies listed in Table 2-11. At each listed frequency, record the displayed voltage in the table.
11. If the difference between the maximum and minimum voltages is less than 0.50 V, and all voltage readings are between +0.5 and +2.5 Vdc, proceed to step 15.
12. Locate the center frequency at which the voltage is lowest. Use the keypad to set the HP 8560E to this frequency.
13. Readjust SMPL MATCH to set the displayed voltage to $0.8 \pm 0.1 \text{ Vdc}$.
14. Set the HP 8560E center frequency to 2302.3 MHz and repeat steps 9 through 13.
15. Move the positive DVM test lead to A15J400 pin 3. Check that the measured voltage is the negative of the voltage at pin 1, within $\pm 0.1 \text{ Vdc}$.
16. Disconnect the DVM probes from A15J400.

6. Sampling Oscillator Adjustment

Table 2-11. Sampling Adjustments

Center Frequency (MHz)	Sampling Oscillator (MHz)	Displayed Voltage (Vdc)				
		1st Trial	2nd Trial	3rd Trial	4th Trial	5th Trial
2156.3	285.000					
2176.3	286.364					
2230.3	288.462					
2263.3	290.000					
2302.3	291.667					
2158.3	293.478					
2196.3	295.000					
2378.3	296.471					
2422.3	297.222					

7. YTO Adjustment

Assembly Adjusted

A14 frequency control assembly

Related Performance Tests

Frequency Span Accuracy

Frequency Readout Accuracy and Frequency Count Marker Accuracy

Description

The YTO main coil adjustments are made with the phase-lock loops disabled. The YTO endpoints are adjusted to bring these points within the capture range of the main loop. The YTO FM coil is adjusted to place the 300 MHz CAL OUTPUT signal at the center vertical graticule in a 20 MHz span.

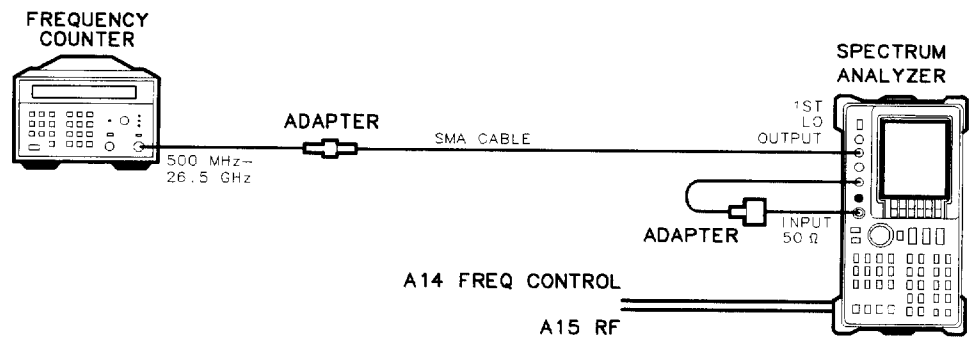


Figure 2-10. YTO Adjustment Setup

SK19

Equipment

Microwave frequency counter HP 5343A Option 001

Adapters

Type N (m) to BNC (f) 1250-1476

Type N (f) to APC 3.5 (f) (*Option 026 only*) 1250-1745

APC 3.5 (f) to APC 3.5 (f) 5061-5311

Cables

BNC, 122 cm (48 in) HP 10503A

SMA, 61 cm (24 in) 8120-1578

Procedure

Note This adjustment cannot be performed if the spectrum analyzer preselected external mixer mode is selected.

YTO Main Coil Adjustments

1. Press **LINE** to turn the spectrum analyzer off. Remove the spectrum analyzer cover and fold down the A15 RF and A14 frequency control assemblies.
2. Disconnect the 50 Ω termination from the 1ST LO OUTPUT. Connect the equipment as shown in Figure 2-10. Press **LINE** to turn the spectrum analyzer on.
3. Move the jumper on A14J23 from the NORM position (pins 1 and 2 jumpered) to the TEST position (pins 2 and 3 jumpered).
4. If the HP 8560E spectrum analyzer does not have Option 002, press the following keys:

CONFIG **EXT MXR PRE UNPR** (UNPR)
AUX CTRL **EXTERNAL MIXER LOCK HARMONIC** 6 Hz
SPAN **ZERO SPAN**
FREQUENCY **CENTER FREQ** 18.8893 GHz **SGL SWP**
SAVE **SAVE STATE STATE 0**
FREQUENCY 35.7493 GHz
SAVE **SAVE STATE STATE 1**
RECALL **RECALL STATE STATE 0.**

5. If the HP 8560E spectrum analyzer has Option 002, press the following keys:

SPAN **ZERO SPAN**
FREQUENCY **CENTER FREQ** 300 KHz
SAVE **SAVE STATE STATE 0**
FREQUENCY 2.0993 GHz
SAVE **SAVE STATE STATE 1**
RECALL **RECALL STATE STATE 0.**

6. On the HP 5343A, press **SHIFT** 7 and set the controls as follows:

SAMPLE RATE Fully Counterclockwise
 10 Hz—500 MHz/500 MHz—26.5 GHz SWITCH 500 MHz—26.5 GHz

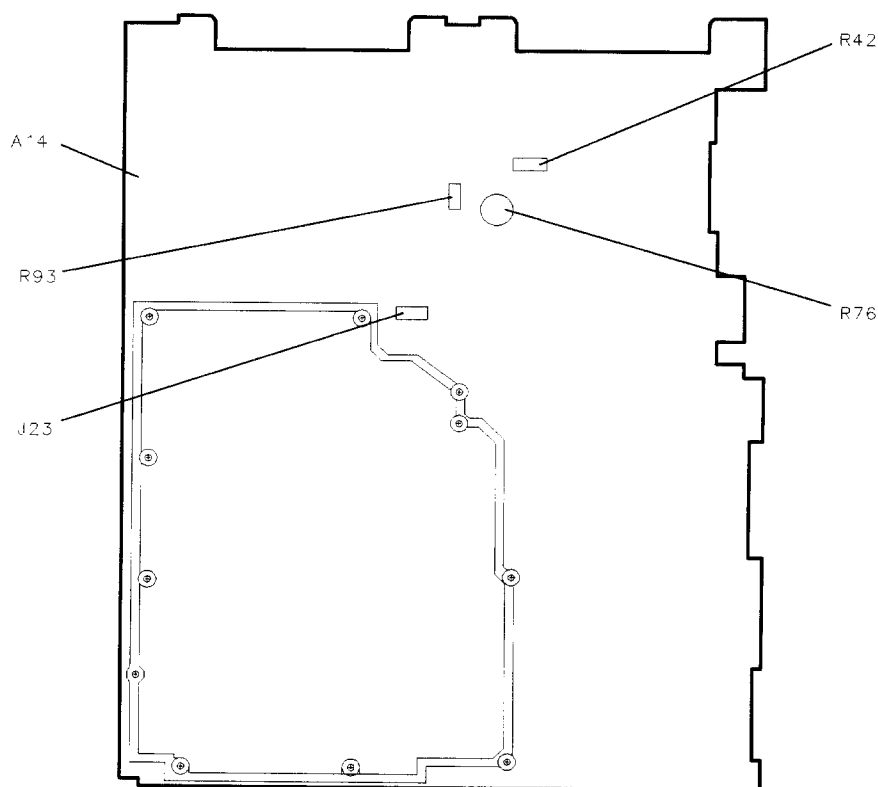
7. Adjust A14R93 3.2 GHz for the appropriate frequency counter reading:

3.200 GHz $\pm$ 1 MHz
 3.911 GHz $\pm$ 1 MHz if Option 002

8. On the HP 8560E, press **STATE 1**.
9. Adjust A14R42 6.01 GHz for a frequency counter reading of 6.010 GHz $\pm$ 1 MHz.
10. On the HP 8560E, press **STATE 0**.

7. YTO Adjustment

11. Repeat steps 6 through 9 until both of these interacting adjustments meet their tolerances.
12. Place the jumper on A14J23 in the NORM position (pins 1 and 2 jumpered).
13. Disconnect the SMA cable from the 1ST LO OUTPUT jack and reconnect the 50 Ω termination on the 1ST LO OUTPUT.



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Figure 2-11. YTO Adjustment Locations

YTO FM Coil Adjustments

14. On the HP 8560E, press **PRESET** and set the controls as follows:

Center frequency		300 MHz
Span		20 MHz
15. Adjust A14R76 FM SPAN until the 300 MHz CAL OUTPUT SIGNAL is aligned with the center vertical graticule line.

8. First LO Distribution Amplifier Adjustment

Assembly Adjusted

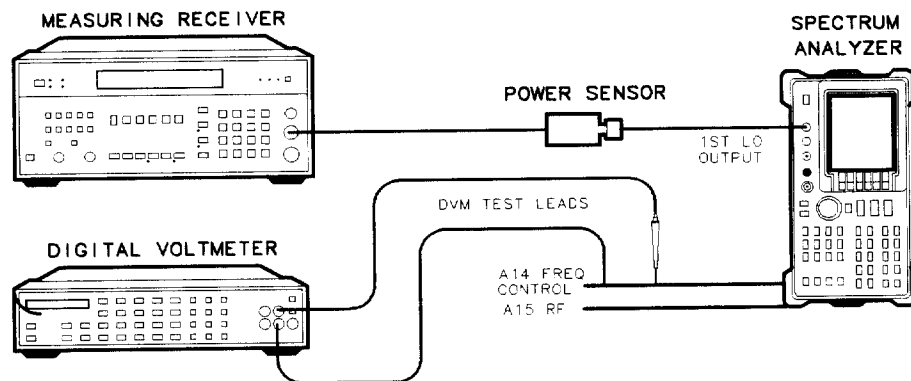
A14 frequency control assembly

Related Performance Test

First LO OUTPUT Amplitude

Description

The gate bias and SENSE voltages for the A7 switched LO distribution amplifier is adjusted to the value specified on the label of A7.



SK 110

Figure 2-12. First LO Distribution Amplifier Adjustment Setup

Equipment

Measuring receiver	HP 8902A
DVM	HP 3456A
Power sensor	HP 8485A
DVM test leads	HP 34118A

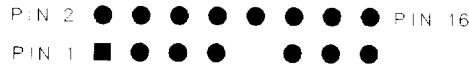
Procedure

1. Press **LINE** to turn the spectrum analyzer off and disconnect the line cord. Remove the cover and fold down the A15 RF and A14 Frequency Control assemblies.
2. Move the jumper on A2J12 from the WR PROT to the WR ENA position. The jumper is on the edge of the A2 board assembly and can be moved without folding the board down.
3. Reconnect the line cord and turn on the spectrum analyzer.
4. Set the HP 8560E controls as follows:

Center frequency	1.45 GHz
Span	0 Hz
5. On the HP 8560E, press **CAL**, **MORE 1 OF 2**, **SERVICE CAL DATA**, **LO LEVELS**, and **INT LO LEVEL**.

8. First LO Distribution Amplifier Adjustment

6. Use the knob or key pad to enter the value 32. This sets the LO power to a low level.
7. To set the gate bias, connect the positive lead of the DVM to A14J18 pin 15 and the negative lead to A14J18 pin 6. See Figure 2-13 for a pin location drawing.



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Figure 2-13. TAM Connector Pin Locations

8. On the HP 8560E press **LO GATE LEVEL**.
9. Note the Gate Bias voltage printed on the A7 LO distribution amp label. Use the knob or keypad to change the displayed DAC value so the DVM reading is equal to the label voltage, ± 10 mV.
10. To set the low band sense voltage, connect the positive lead of the DVM to A14J18 pin 13 and the negative lead to A14J18 pin 6.
11. On the HP 8560E press **INT LO LEVEL**. The message **DRIVE FOR BAND# 0** will be displayed.
12. Note the Sense voltage printed on the A7 LO distribution amp label. Use the knob or keypad, and press enter, to change the displayed DAC value so the DVM reading is equal to the label voltage, ± 5 mV.
13. Record the DAC value:

DAC value for 1.45 GHz = _____

14. Set the "Sense EXT" value by pressing **EXT LO LEVEL**.
15. Use the knob or keypad to enter the DAC value for 1.45 GHz from the band 0 sense voltage adjustment above.
16. Save the adjustment values by pressing **PREV MENU**, **STORE DATA**, and **YES**.
17. Move the jumper on A2J12 from WR ENA back to the WR PROT position.

9. Tracking Generator Power Level Adjustments (Option 002)

Assembly Adjusted

A10 tracking generator assembly

Related Performance Test

Absolute Amplitude and Vernier Accuracy

Description

The A10 tracking generator has two adjustments for setting the output power. A10R13 -10 dB ADJ sets the power level when the TRK GEN RF POWER is set to -10 dBm and A10R18 0 dB ADJ sets the power level when the TRK GEN RF POWER is set to 0 dBm. The -10 dB ADJ acts as an offset adjustment while 0 dB ADJ acts as a gain adjustment.

These adjustments are set in the factory for a 10 dB difference in output power between the -10 dBm and 0 dBm TRK GEN RF POWER settings. When installing a replacement tracking generator, it should only be necessary to adjust -10 dB ADJ (the offset adjustment) to account for variations in cable loss from the tracking generator to the RF OUT 50 Ω connector. This adjustment is done at a 0 dBm TRK GEN RF POWER setting. This ensures that the absolute power level with a 0 dBm TRK GEN RF POWER setting is 0 dBm with little effect, if any, on the vernier accuracy.

In some cases, the power level at the -10 dBm TRK GEN RF POWER setting might be out of tolerance. In such cases, the -10 dB ADJ is set at a TRK GEN RF POWER of -10 dBm and the 0 dB ADJ is set at a TRK GEN RF POWER of 0 dBm. These two adjustments must be iterated until the power level at the two settings are within the given tolerance.

Equipment

Measuring receiver	HP 8902A
Power sensor	HP 8482A

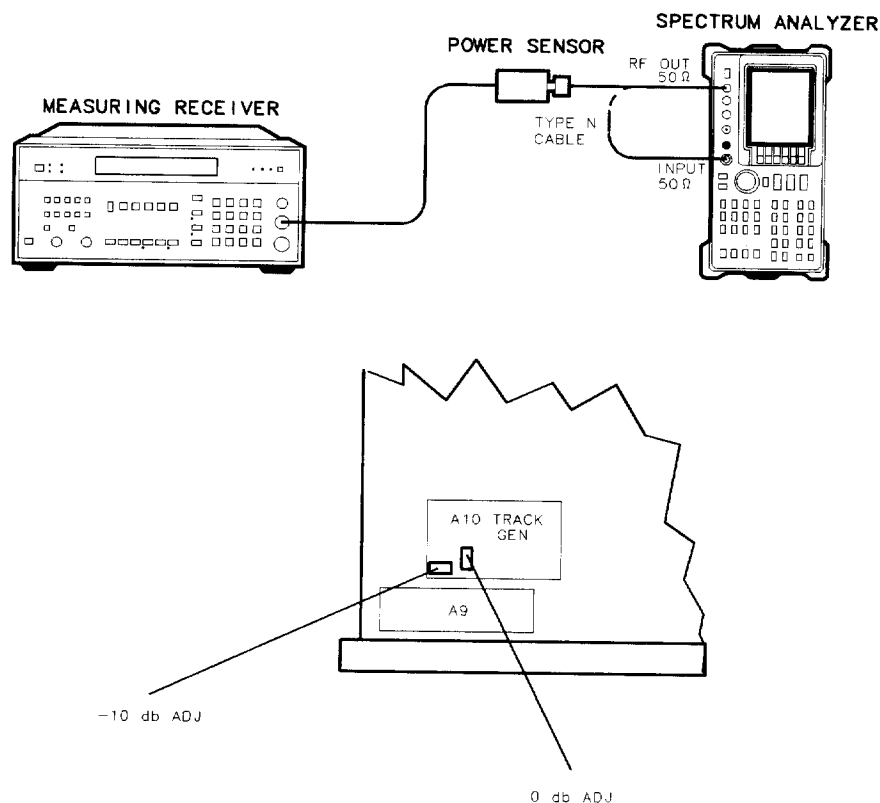
Cable

Type N, 62 cm (24 in)	HP 11500B/C
-----------------------------	-------------

Procedure

1. Press **LINE** to turn the spectrum analyzer off. Remove the spectrum analyzer cover and place the spectrum analyzer in the service position as illustrated in Figure 2-14.

9. Tracking Generator Power Level Adjustments (Option 002)



SJ11

Figure 2-14. Tracking Generator Power Level Adjustments Setup and Adjustment Locations

2. Connect the Type N cable between the RF OUT 50Ω and RF INPUT 50Ω connectors on the HP 8560E.
3. Press **PRESET** on the HP 8560E and set the controls as follows:

Center frequency		300 MHz
Span		0 Hz
4. On the HP 8560E, press **MKR**, **AUX CTRL**, **TRACKING GENRATOR**, **SRC PWR ON**, 0, and **dBm**.
5. On the HP 8560E, press **MORE 1 OF 3**, **TRACKING PEAK**. Wait for the **PEAKING** message to disappear.
6. Zero and calibrate the measuring receiver/power sensor combination in log mode (power levels readout in dBm). Enter the power sensor's 300 MHz Cal Factor into the measuring receiver.
7. Disconnect the Type N cable from the RF OUT 50Ω and connect the power sensor to the RF OUT 50Ω.
8. On the HP 8560E, press 0, **dBm**, and **SGL SWP**.
9. Adjust A10R13 -10 dB ADJ for a 0 dBm ±0.05 dB reading on the measuring receiver.

9. Tracking Generator Power Level Adjustments (Option 002)

10. Set the TRK GEN RF POWER to -10 dBm. Note the power displayed on the measuring receiver.

Power at -10 dBm Setting _____ dBm

11. Proceed with steps 12 through 14 only if the power level noted in the previous step was outside the range of -10 dBm ± 0.23 dB.
12. With the TRK GEN RF POWER set to -10 dBm, adjust A10R13 -10 dB ADJ for a -10 dBm ± 0.1 dB reading on the measuring receiver. Refer to Figure 2-14 for adjustment location.
13. Set the TRK GEN RF POWER to 0 dBm. Adjust A10R18 0 dB ADJ for a 0 dBm ± 0.2 dB reading on the measuring receiver. Refer to Figure 2-14 for adjustment location.
14. Repeat steps 12 and 13 until the output power level is within the tolerances indicated at both the -10 dBm and 0 dBm TRK GEN RF POWER settings. Adjust -10 dB ADJ only with the TRK GEN RF POWER set to -10 dBm and adjust 0 dB ADJ only with the TRK GEN RF POWER set to 0 dBm.

10. Frequency Response Adjustment

Assembly Adjusted

A15 RF assembly

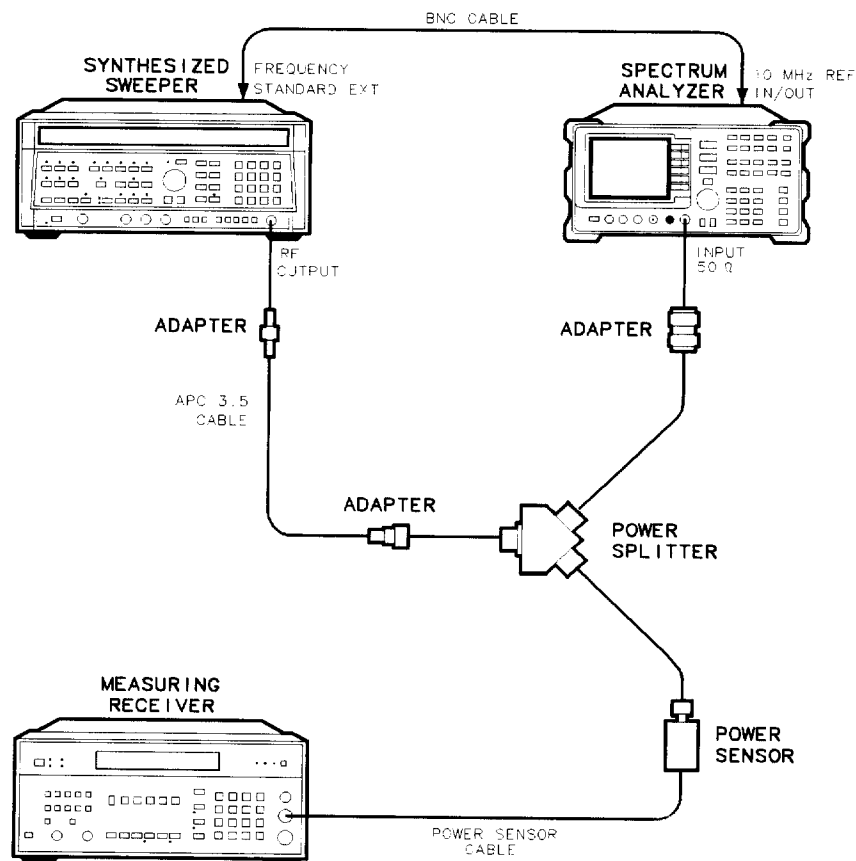
Related Performance Tests

Displayed Average Noise Level

Frequency Response

Description

A signal of the same known amplitude is applied to the spectrum analyzer at several different frequencies. At each frequency, the DAC controlling the flatness compensation amplifiers is adjusted to place the peak of the displayed signal at the same place on the screen. With firmware revisions greater than 920528, there are correction points at 2 MHz and 6 MHz. These points are outside the synthesized sweeper's frequency range. The DAC values for these two points are set to a fixed offset from the DAC value at 10 MHz. The DAC values are stored in EEROM.



sj142e

Figure 2-15. Frequency Response Adjustment Setup

Equipment

Synthesized sweeper	HP 8340A/B
Measuring receiver	HP 8902A
Power sensor	HP 8482A
Power splitter	HP 11667A

Adapters

Type N (m) to Type N (m)	1250-1475
Type N (m) to APC 3.5 (f)	1250-1744
Type APC 3.5 (f) to APC 3.5 (f)	5061-5311

Cables

BNC, 122 cm (48 in)	HP 10503A
APC 3.5, 91 cm (36 in)	8120-4921

Procedure

1. Connect the equipment as shown in Figure 2-15. Do not connect the HP 8482A Power Sensor to the HP 11667B Power Splitter.
2. Zero and calibrate the HP 8902A/HP 8482A combination in log mode (power levels read out in dBm) and connect the power sensor through an adapter to the power splitter.
3. Place the WR PROT/WR ENA jumper on the A2 Controller assembly in the WR ENA position.
4. Press **PRESET** on the HP 8560E and set the controls as follows:

Center frequency	10 MHz
Span	0 Hz
Resolution BW	300 kHz
Log/division	2 dB
5. Press **INSTR PRESET** on the HP 8340A/B and set the controls as follows:

CW	10 MHz
Power level	-4 dBm
6. Set ref level cal DAC to zero. Press **CAL**, **REF LVL ADJ** and use the knob to set the value to 0. Press **STORE REF LVL**.
7. On the HP 8560E, press **MKR**, **CAL**, **MORE 1 OF 2**, **SERVICE CAL DATA**, then **FLATNESS**. The current value of the RF Gain DAC should be displayed in the active function area. If the frequency displayed in the active function area is not 10 MHz, press **↑** or **↓** until 10 MHz is displayed.
8. Enter the appropriate Power Sensor Calibration factor into the HP 8902A.
9. Set the HP 8340A/B **CW** output to the frequency indicated in the active function area of the HP 8560E display. Adjust the HP 8340A/B POWER LEVEL for a -10 dBm reading on the HP 8902A.
10. On the HP 8560E spectrum analyzer, adjust the RF Gain DAC value using the front-panel knob or keypad until the marker reads -10 dBm ± 0.10 dB. Each DAC count yields an approximate 0.01 dB change.

10. Frequency Response Adjustment

11. On the spectrum analyzer, press **↑** to proceed to the next frequency.
12. Repeat steps 7 through 10 for all low-band frequencies ≥ 10 MHz.
13. If the firmware revision is later than 920528, perform steps 13 through 17. Otherwise, skip to step 18.
14. Press **↑** until 10 MHz is displayed in the active function block. Record the RF gain DAC value at 10 MHz.

10 MHz RF gain DAC value _____

15. Add 67 to the 10 MHz RF gain DAC value and record as the 2 MHz RF gain DAC value.

2 MHz RF gain DAC value _____

16. Add 62 to the 10 MHz RF gain DAC value and record as the 6 MHz RF gain DAC value.

6 MHz RF gain DAC value _____

17. Press **↓** until 2 MHz is displayed in the active function block. Use the DATA keys to enter the 2 MHz RF gain DAC value recorded in step 14.
18. Press **↑** until 6 MHz is displayed in the active function block. Use the DATA keys to enter the 6 MHz RF gain DAC value recorded in step 15.
19. Press **PREV MENU STORE DATA**, then **YES** on the HP 8560E.
20. Place the WR PROT/WR ENA jumper on the A2 Controller assembly in the WR PROT position.

11. Calibrator Amplitude Adjustment

Assembly Adjusted

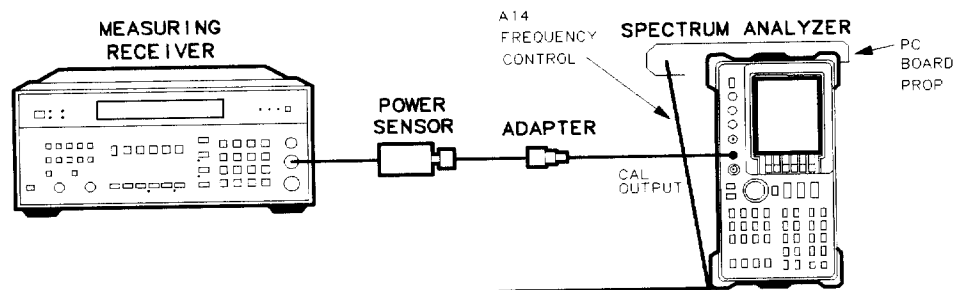
A15 RF assembly

Related Performance Test

Calibrator Amplitude and Frequency Accuracy

Description

The CAL OUTPUT amplitude is adjusted for -10.00 dBm measured directly at the front panel CAL OUTPUT connector.



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Figure 2-16. Calibrator Amplitude Adjustment Setup

Equipment

Measuring receiver	HP 8902A
Power sensor	HP 8482A

Adapters

Type N (f) to BNC (m)	1250-1477
-----------------------------	-----------

Procedure

Note The HP 8560E should be allowed to warm up for at least 30 minutes before performing this adjustment.

1. Place the HP 8560E in the service position shown in Figure 2-16. Prop the A14 Frequency Control Board assembly in the service position.
2. Zero and calibrate the HP 8902A/HP 8482A combination in log display mode. Enter the power sensor 300 MHz Cal Factor into the HP 8902A.
3. Connect the HP 8482A through an adapter directly to the HP 8560E CAL OUTPUT connector.
4. Adjust A15R561 CAL AMPTD for a -10.00 dBm reading on the HP 8902A display.

12. 10 MHz Reference Adjustment-TCXO (Option 103)

Assembly Adjusted

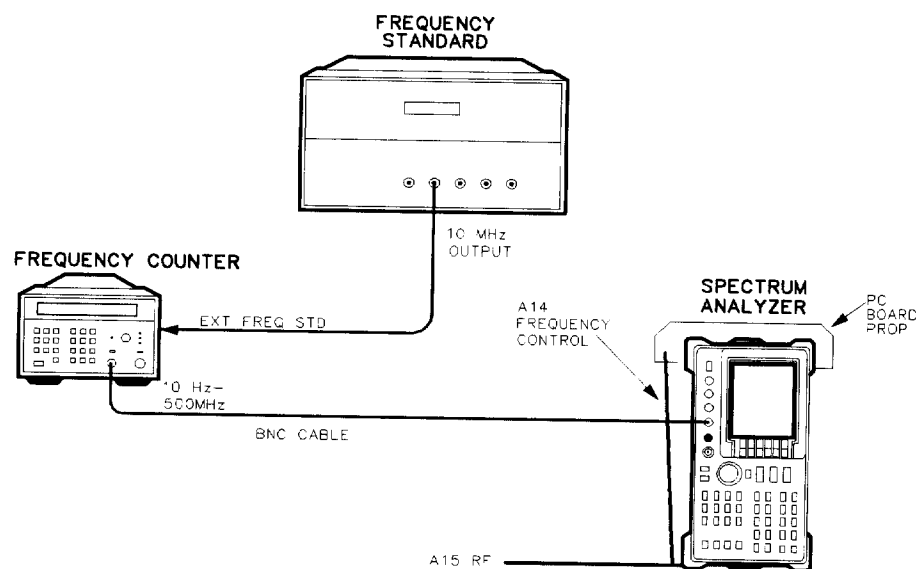
A15 RF assembly

Related Performance Test

10 MHz Reference Output Accuracy

Description

The frequency counter is connected to the CAL OUTPUT, which is locked to the 10 MHz reference. This yields better effective resolution. The temperature-compensated crystal oscillator (TCXO) is adjusted for a frequency of 300 MHz as read by the frequency counter.



SP11E

Figure 2-17. 10 MHz Frequency Reference Adjustment Setup

Equipment

Microwave frequency counter HP 5343A Option 001
Frequency standard HP 5061B Cesium Beam Standard
(or any 10 MHz frequency standard with accuracy $< \pm 1 \times 10^{-10}$)

Cables

BNC, 122 cm (2 required) HP 10503A

12. 10 MHz Reference Adjustment-TCXO (Option 103)

Procedure

Note Allow the HP 8560E spectrum analyzer to warm up for at least 30 minutes before performing this adjustment.

1. Connect the equipment as shown in Figure 2-17. Prop up the A14 Frequency Control Assembly.
2. Set the HP 5343A controls as follows:

SAMPLE RATE Midrange
50 Ω —1 M Ω SWITCH 50 Ω
10 Hz—500 MHz/500 MHz—26.5 GHz SWITCH 10 Hz—500 MHz

3. Press **AUX CTRL**, **REAR PANEL**, and ensure that the 10 MHz reference is set to **10 MHz INT**.

Note When the 10 MHz reference is set to **10 MHz EXT**, the TCXO is not operating and warmed up. If the reference is set to **10 MHz EXT**, set the reference to **10 MHz INT** and allow 30 minutes for the TCXO to warm up.

4. Remove dust cap from A15U302, TCXO. The dust cap is toward the rear of the spectrum analyzer.
5. Adjust 10 MHz ADJ on A15U302 for a frequency counter reading of 300.000000 MHz $\pm$ 30 Hz.
6. Replace the dustcap on A15U302.

13. Demodulator Adjustment

Assembly Adjusted

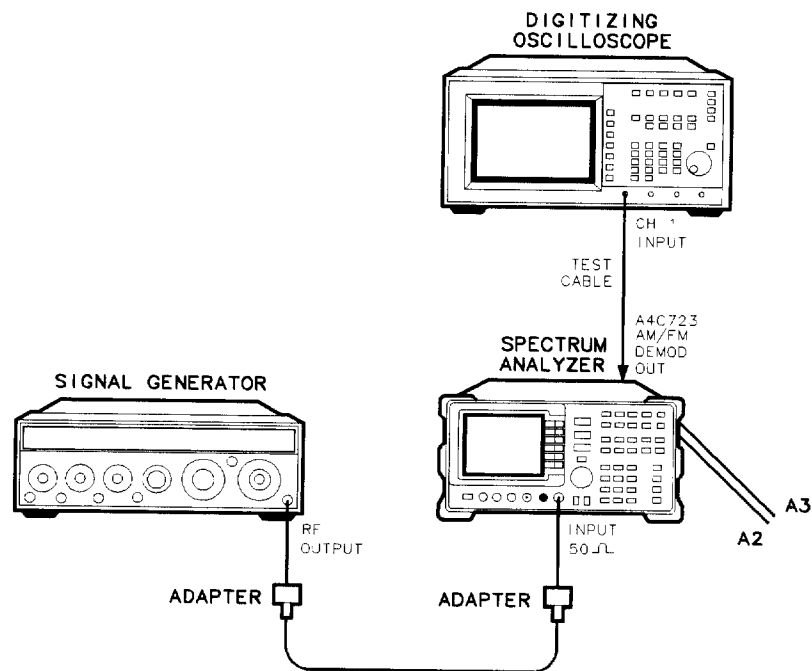
A4 log amplifier assembly

Related Performance Test

There is no related performance test for this adjustment procedure.

Description

A 5 kHz peak-deviation FM signal is applied to the INPUT 50Ω. The detected audio is monitored by an oscilloscope. FM DEMOD is adjusted to peak the response displayed on the oscilloscope.



s j150e

Figure 2-18. Demodulator Adjustment Setup

Equipment

AM/FM signal generator HP 8640B
Oscilloscope HP 1980A/B

Adapters

Type N (m) to BNC (f) (2 required) 1250-1476

13. Demodulator Adjustment

Cables

BNC, 122 cm (48 in)	HP 10503A
Oscilloscope probe	HP 10432A

Procedure

1. Press **LINE** to turn the spectrum analyzer off. Place the spectrum analyzer in the service position as illustrated in Figure 2-18.
2. Connect the oscilloscope probe from the oscilloscope channel 1 input to probe A4C723 (the end closest to A4U707) as in Figure 2-19. Press **LINE** to turn the spectrum analyzer on. Connect the HP 8640B RF OUTPUT to the HP 8560E INPUT 50 Ω .

3. Set the HP 8640B controls as follows:

Range MHz	61 to 128
Frequency	100.000 MHz
Output level	-10 dBm
RF	ON
AM	OFF
FM	INT
Modulation frequency	1000 Hz
Peak deviation	5 kHz
Scale FM	(k/MHz)

4. Adjust the HP 8640B FM deviation vernier for a full-scale reading on the meter. Set the FM to off.

5. Set the oscilloscope controls as follows:

Channel 1	on
Channel 2	off
Channel 1	50 mV/div
Channel 1	ac
Channel 1	BW lim
Time base	1.0 ms/div
Trigger	auto
Trigger source	1
Trigger level	0.0 V

6. On the HP 8560E, press **PRESET** and set the controls as follows:

Center frequency	100 MHz
Span	5 MHz
Ref level	-10 dBm
Resolution BW	100 kHz

7. On the HP 8560E press: **PEAK SEARCH**, **MARKER** $\rightarrow$ **CF**

SPAN, **ZERO SPAN**

AUX CTRL, **AM/FM DEMOD**, **FM DEMOD ON OFF** (ON)

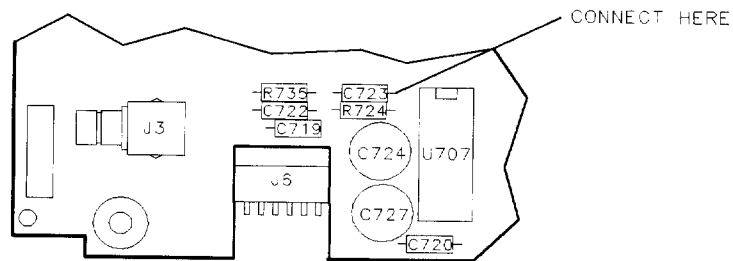
CAL, **IF ADJ ON OFF** (OFF)

TRIG, and **SWEEP CONT SGL** (SGL).

Set the volume control to midrange.

13. Demodulator Adjustment

8. Set the HP 8640B FM to INT.
9. A 1 kHz sine wave should be observed on the oscilloscope. Rotate the volume knob on the front panel of the spectrum analyzer until the amplitude of the 1 kHz signal is at about 150 mV (3 divisions on the oscilloscope.)
10. Adjust A4C707 FM DEMOD for a maximum peak-to-peak response on the oscilloscope.
11. Press **LINE** to turn the spectrum analyzer off. Disconnect the test cable from A4C723.



SF115E

Figure 2-19. Demodulator Adjustment Locations

14. External Mixer Bias Adjustment

Assembly Adjusted

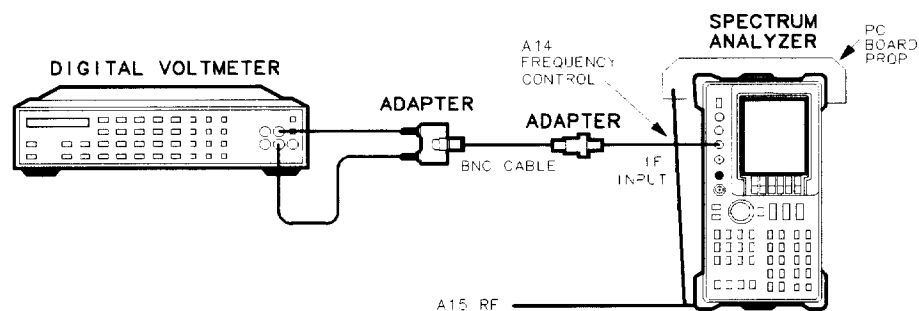
A15 RF assembly

Related Performance Test

There is no related performance test for this adjustment procedure.

Description

A voltmeter is connected to the HP 8560E IF INPUT with the external mixer bias set to off. The bias is adjusted for a 0 Vdc output.



SK116

Figure 2-20. External Mixer Bias Adjustment Setup

Equipment

DVM HP 3456A

Adapters

Type BNC (f) to SMA (m) 1250-1200

Type BNC (f) to dual banana plug 1251-2816

Cables

BNC, 122 cm (48 in) HP 10503A

14. External Mixer Bias Adjustment

Procedure

- 1. Press **LINE** to turn the spectrum analyzer off and disconnect the ac power cord. Remove the spectrum analyzer cover and connect the equipment as illustrated in Figure 2-20. Reconnect the power cord and press **LINE** to turn the spectrum analyzer on.
- 2. Set the HP 3456A controls as follows:
Function DC VOLTS
Range 0.1 V
Resolution 100 mV
- 3. On the HP 8560E press **AUX CTRL**, **EXTERNAL MIXER**, **BIAS**, then **BIAS OFF**.
- 4. Adjust A15R926 EXT BIAS ZERO for a DVM reading of 0.000 Vdc $\pm$ 12.5 mV.

15. External Mixer Amplitude Adjustment

Assembly Adjusted

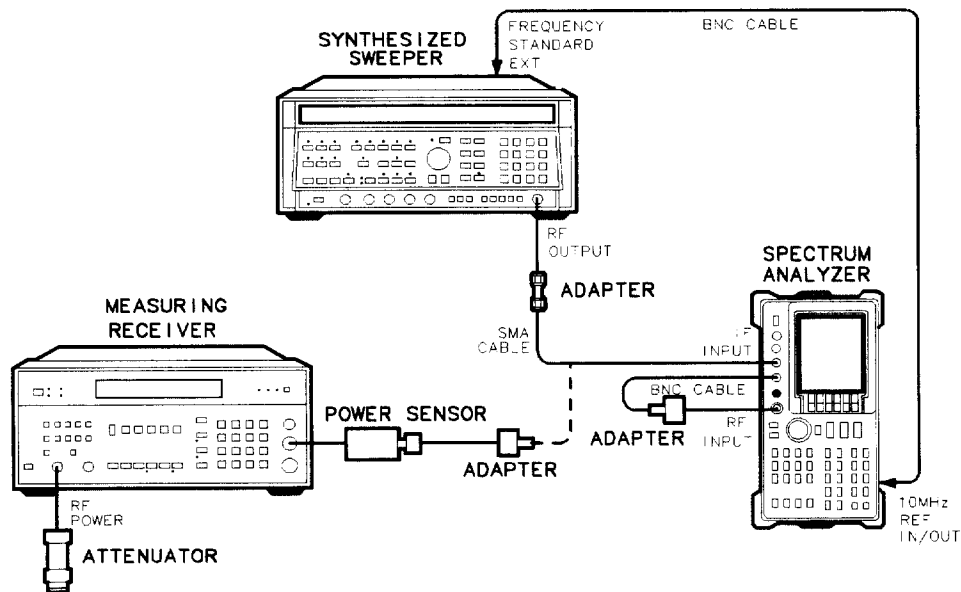
A15 RF assembly

Related Performance Test

IF Input Amplitude Accuracy

Description

The slope of the flatness compensation amplifiers is determined. The user-loaded conversion losses for K-band are recorded and reset to 30 dB. A 310.7 MHz signal is applied to the power sensor and the power level of the source is adjusted for a -30 dBm reading. The signal is then applied to the IF INPUT. The flatness compensation amplifiers are then adjusted (via DACs) to place the displayed signal at the reference level. Only the determination of the Flatness Compensation Amplifier slope is performed if the HP 8560E has Option 002.



SK 17

Figure 2-21. External Mixer Amplitude Adjustment Setup

Equipment

Synthesized sweeper	HP 8340A/B
Measuring receiver	HP 8902A
Power sensor	HP 8484A, 8481D
50 MHz reference attenuator	HP 11708A
<i>(supplied with HP 8481D)</i>	

15. External Mixer Amplitude Adjustment

Adapters

Type N (f) to SMA (f)	1250-1772
Type N (m) to BNC (f)	1250-1476
Type APC 3.5 (f) to APC 3.5 (f)	5061-5311

Cables

BNC, 122 cm (48 in)	HP 10503A
SMA, 61 cm (24 in)	8120-1578

Procedure

1. Press **LINE** to turn the spectrum analyzer off and disconnect the power cord. Remove the spectrum analyzer cover and reconnect the power cord.
2. Set up the equipment as illustrated in Figure 2-21. Do not connect the SMA cable to the HP 8560E.
3. Move the WR PROT/WR ENA jumper on the A2 Controller assembly to the WR ENA position. (The jumper is on the edge of the A2 controller assembly and can be moved without folding the board down.) Press **LINE** to turn the spectrum analyzer on.
4. On the HP 8560E, press **AUX CTRL**, **EXTERNAL MIXER AMPTD CORRECT**, then **CNV LOSS VS FREQ**.
5. On the HP 8560E, press **CAL**, **MORE 1 OF 2**, **SERVICE CAL DATA**, **3RD IF AMP**, and **CAL 3RD AMP GAIN**. Wait until the message **ADJUSTMENT-DONE** appears in the active function block.

Note Perform steps 6 through 13 only if the HP 8560E does not have Option 002.

6. Press **↑** or **↓** to display the conversion loss value for each frequency listed in Table 2-12. Record any conversion loss reading *not equal* to 30 dB in Table 2-12 at the appropriate frequency.
7. If all conversion loss values equal 30 dB, skip to step 8, otherwise continue to step a.
 - a. Refer to Table 2-12 and press **↑** or **↓** to select a frequency at which the conversion loss value does not equal 30 dB.
 - b. Use the spectrum analyzer front-panel keys to set the conversion loss value to 30 dB.
 - c. Repeat steps a and b for all frequencies having a conversion loss value other than 30 dB.
8. Press **INSTR PRESET** on the HP 8340A/B and set the controls as follows:

CW frequency	310.7 MHz
Power level	-30 dBm

15. External Mixer Amplitude Adjustment

Table 2-12. Conversion Loss Data

Frequency (GHz)	Conversion Loss (dB) ($\neq 30$ dB)
18	
20	
22	
24	
26	
27	

9. Connect the power sensor to the HP 11708A attenuator already connected to the HP 8902A RF power connector. Zero and calibrate the HP 8902A/power sensor combination in log mode. Enter the power sensor 50 MHz Cal Factor into the HP 8902A. Connect the power sensor, through an adapter, to the SMA cable.
10. Adjust the HP 8340A **POWER LEVEL** until the power displayed on the HP 8902A reads $-30 \text{ dBm} \pm 0.05 \text{ dB}$.
11. Disconnect the SMA cable from the power-sensor/adapter and connect the cable to the HP 8560E IF INPUT.
12. On the HP 8560E, press **CAL** **MORE 1 OF 2 SERVICE CAL DATA 3RD IF AMP**, then **EXT MXR REF CAL**.
13. Use the HP 8560E front-panel knob, step keys, or keypad to change the amplitude of the displayed signal until the marker reads $0 \text{ dBm} \pm 0.17 \text{ dB}$.
14. Press **PREV MENU STORE DATA** and **YES** on the HP 8560E.
15. Place the WR PROT/ WR ENA jumper on the A2 Controller assembly in the WR PROT position.

Note The following steps should only be performed if you need to replace the 30 dB conversion loss values with those recorded in Table 2-12.

16. Press **AUX CTRL**, **EXTERNAL MIXER**, **AMPTD CORRECT**, then **CNV LOSS VS FREQ** on the HP 8560E.
17. Press **▲** or **▼** to select frequencies where the conversion loss value was recorded in Table 2-12.
18. Use the spectrum analyzer front panel keys to enter the conversion loss values recorded for the frequency.

16. Signal ID Oscillator Adjustment

Assembly Adjusted

A15 RF assembly

Related Performance Test

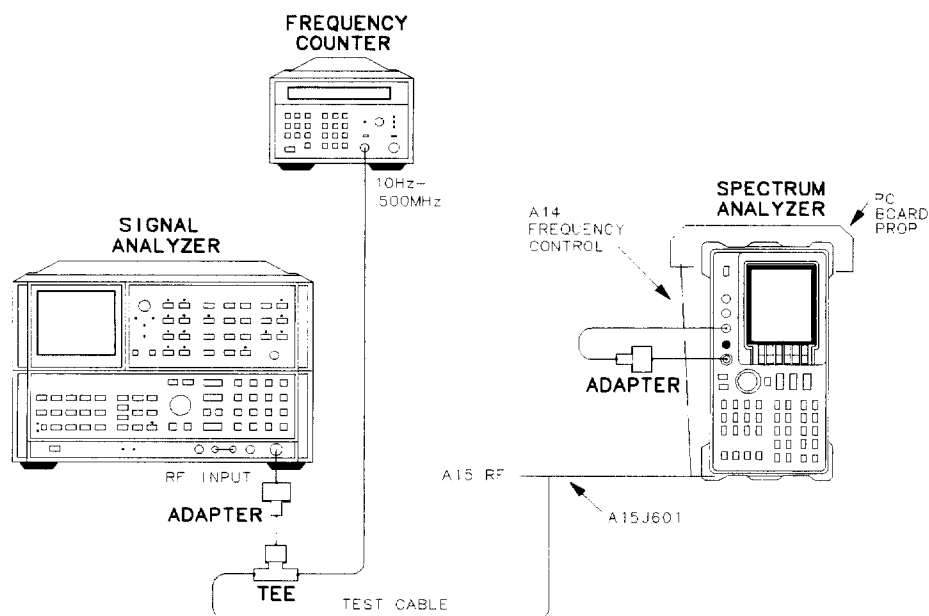
There is no related performance test for this adjustment.

Description

The frequency range of the 298 MHz signal ID oscillator is determined by counting the 10.7 MHz IF as A15C629 is rotated through its range of adjustment. The SIG ID oscillator is then set to the frequency determined by the following equation:

$$\text{Oscillator frequency} = 12.7 \text{ MHz} + \left(\frac{\text{Oscillator frequency range}}{4} \right)$$

This adjustment applies only to spectrum analyzers with a serial number prefix less than 3310A or spectrum analyzers with both a serial number prefix greater than or equal to 3310A and Option 008 installed.



SK119

Figure 2-22. Signal ID Oscillator Adjustment Setup

Equipment

Microwave frequency counter HP 5343A
Spectrum analyzer HP 8566A/B

Adapters

Type N (m) to BNC (f) (2 required) 1250-1476
BNC tee (f, m, f) 1250-0781

Cables

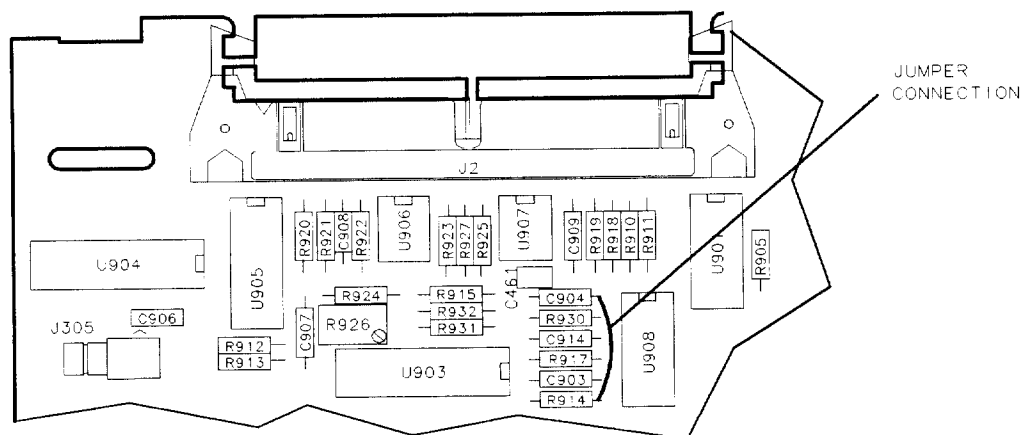
BNC, 122 cm (48 in) (2 required) HP 10503A
Test cable, BNC (m) to SMB (f) 85680-60093

Procedure

1. Press **LINE** to turn the spectrum analyzer off, disconnect the power cord, and remove the spectrum analyzer cover. Fold down the A15 RF and A14 frequency control assemblies. Prop up the A14 frequency control assembly.
2. Connect the HP 8560E CAL OUTPUT to the INPUT 50 Ω using an adapter. Disconnect the W29 cable from A15J601 (10.7 MHz IF out) and connect the SMB end of the test cable to A15J601. Connect the rest of the equipment as shown in Figure 2-22.
3. Remove the four screws holding the brace on the A15 RF assembly (near J2.)
4. Connect a jumper between the leads of A15R914 and A15C904 (the ends near U908.) See Figure 2-23 for the location of the components.
5. Reconnect the power cord and press **LINE** to turn the spectrum analyzer on. After the power-on sequence is complete, set the HP 8560E controls as follows:

Center frequency 300 MHz
Span 0 Hz

6. Press **CAL**, **IF ADJ ON OFF** (OFF), and **SGL SWP**.



sp117e

Figure 2-23. Signal ID Oscillator Adjustment Jumper Location

16. Signal ID Oscillator Adjustment

7. Press **INSTR PRESET** on the HP 8566A/B and set the controls as follows:

Center frequency 12.7 MHz
Span 500 kHz

8. Set the HP 5343A controls as follows:

Sample rate Fully counterclockwise
50 Ω —1 M Ω SWITCH 50 Ω
10 Hz—500 MHz/500 MHz—26.5 GHz switch 10 Hz—500 MHz

9. If no signal is displayed on the HP 8566A/B, adjust A15C629 SIG ID until a signal is displayed.

Note If the 298 MHz SIG ID oscillator is severely mistuned, it might be necessary to widen the span on the HP 8566A/B to see the IF signal.

10. Rotate A15C629 SIG ID slightly while observing the HP 8566A/B display.

Note The nominal counted frequency should be 12.7 MHz, not 10.7 MHz.

11. While observing the HP 8566A/B display, adjust A15C629 SIG ID for the highest obtainable frequency, with less than 3 dB decrease in amplitude from maximum. Read this frequency from the frequency counter and record as $F_{3 \text{ dB HIGH}}$.

$F_{3 \text{ dB HIGH}} = \text{_____MHz}$

12. Observe the HP 8566A/B display as you adjust A15C629 SIG ID for the lowest obtainable frequency, with less than 3 dB decrease in amplitude from maximum. Record the frequency counter reading as $F_{3 \text{ dB LOW}}$.

$F_{3 \text{ dB LOW}} = \text{_____MHz}$

13. Calculate the difference between $F_{3 \text{ dB HIGH}}$ and $F_{3 \text{ dB LOW}}$, then divide results by four. Enter the result as F_{OFFSET} .

$F_{\text{OFFSET}} = \text{_____kHz}$

14. Add F_{OFFSET} to $F_{3 \text{ dB LOW}}$ recorded in step 10 and record the result as F_{SIGID} .

$F_{\text{SIGID}} = \text{_____MHz}$

15. Adjust A15C629 for a frequency counter reading equaling F_{SIGID} . The final adjusted frequency must equal 12.7 MHz $\pm$ 50 kHz.

17. 10 MHz Reference Adjustment-OCXO

Assembly Adjusted

A21 OCXO assembly

Note	Replacement oscillators are factory adjusted after a complete warmup and after the specified aging rate has been achieved. Thus, readjustment should typically not be necessary after oscillator replacement and is generally not recommended.
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Related Performance Test

10 MHz Reference Accuracy

Description

The frequency of the internal 10 MHz frequency reference is compared to a known frequency standard and adjusted for minimum frequency error. This procedure does not adjust the short-term stability or long-term stability of the A21 10 MHz ovenized crystal oscillator (OCXO). Stability is determined by the characteristics of the particular oscillator and the environmental and warmup conditions to which it has been recently exposed. The spectrum analyzer must be on continuously for at least 24 hours immediately prior to oscillator adjustment to allow both the temperature and frequency of the oscillator to stabilize.

17. 10 MHz Reference Adjustment-OCXO

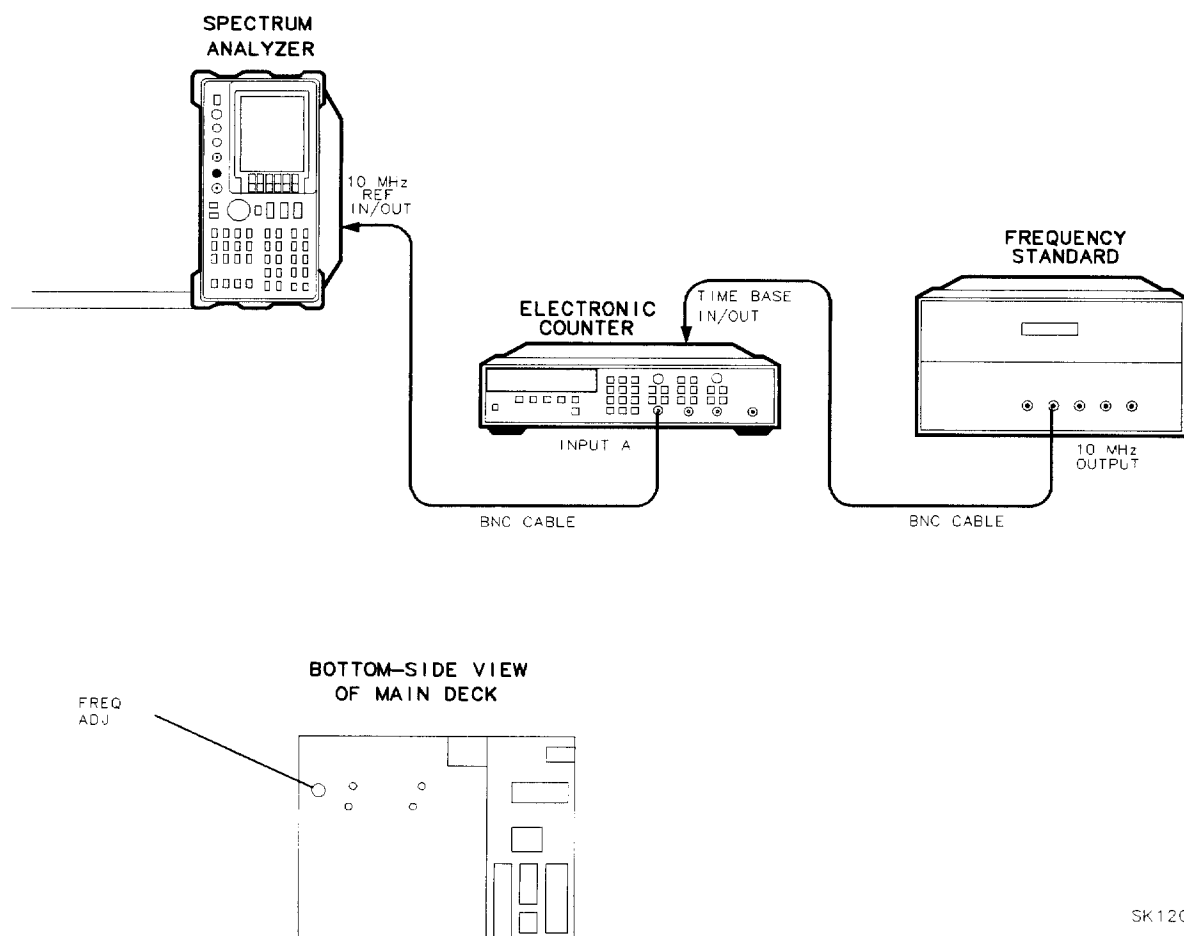


Figure 2-24. 10 MHz Reference Adjustment Setup and Adjustment Location

Equipment

Frequency counter HP 5334A/B
 Frequency standard HP 5061B Cesium Beam Standard
 (or any 10 MHz frequency standard with accuracy $< \pm 1 \times 10^{-10}$)

Cable

BNC, 122 cm (2 required) HP 10503A

Procedure

Note Failure to allow a 24 hour minimum warmup time for OCXO frequency and temperature stabilization may result in oscillator misadjustment.

1. Connect equipment as shown in Figure 2-24. Perform the following steps:
 - a. Press **LINE** to turn the spectrum analyzer on. After the automatic power-on adjustment sequence is complete, press **PRESET** to ensure that the frequency reference is set to internal.

17. 10 MHz Reference Adjustment-OCXO

- b. Allow the spectrum analyzer to remain powered on continuously for at least 24 hours to ensure that the A21 OCXO temperature and frequency stabilize.

Note If the reference is set to **10 MHz EXT**, press **10 MHz INT**. Allow the 24-hour warmup for the OCXO before continuing. When the 10 MHz reference is set to **10 MHz EXT**, the OCXO is not operating or warmed up.

- c. Connect the frequency standard to the frequency counter rear panel TIMEBASE IN/OUT connector.
 - d. Connect a BNC cable between the spectrum analyzer rear panel 10 MHz REF IN/OUT connector and INPUT A on the frequency counter.
2. Set the frequency counter controls as follows:

Function/data	freq A
Input	A:
×10 Attenuator	OFF
AC	OFF (DC coupled)
50ΩZ	OFF (1 MΩ input impedance)
Auto trigger	ON
100 kHz filter A	OFF
INT/EXT switch (rear panel)	EXT
 3. Select a 1 second gate time on the HP 5334A/B frequency counter by pressing **GATE TIME**, 1, and **GATE TIME**.
 4. To offset the displayed frequency by -10.0 MHz, press MATH **SELECT/ENTER**, **CHX/EE**, 10, **CHS/EE**, 6, **SELECT/ENTER**, **SELECT/ENTER**. The frequency counter should now display the difference between the frequency of the INPUT A signal and 10.0 MHz with a displayed resolution of 0.010 Hz (10 MHz).
 5. Locate the FREQ ADJ control on the HP 8560E. This control is accessible through the center deck of the spectrum analyzer. See Figure 2-24.
 6. Remove the dust-cap screw.
 7. Use a nonconductive adjustment tool to adjust the FREQ ADJ control on the A21 OCXO for a frequency counter reading of 0.00 Hz.
 8. On the HP 5334A/B frequency counter, select a 10-second gate time by pressing **GATE TIME**, 10, **GATE TIME**. The frequency counter should now display the difference between the frequency of the INPUT A signal and 10.0 MHz with a resolution of 0.001 Hz (1 MHz).
 9. Wait at least two gate periods for the frequency counter to stabilize, then adjust the FREQ ADJ control on A21 OCXO for a stable frequency counter reading of 0.000 Hz ±0.010 Hz.
 10. Replace the dust-cap screw to A21 OCXO.

18. Tracking Oscillator Adjustment (Option 002)

Note This is *not* a routine adjustment. This adjustment should only be performed if there is insufficient tracking adjustment range.

Assembly Adjusted

A10 tracking generator assembly

Related Performance Test

Tracking Adjustment Range

Description

The centering of the tracking oscillator range is adjusted in the factory to ensure that the tracking adjustment functions properly. Over a period of 5 years, however, the center frequency of the tracking oscillator range may drift outside of acceptable limits. This adjustment should only be performed if there is insufficient tracking adjustment range.

This adjustment recenters the tracking oscillator range. The A10 tracking generator is partially removed from the spectrum analyzer to perform this adjustment. A synthesized sweeper is used as the first local oscillator signal. A frequency counter is used to measure the output frequency.

Equipment

Synthesized sweeper	HP 8340A/B
Microwave frequency counter	HP 5343A
50 Ω termination	1810-0118
Alignment tool, non-metallic	8710-0033

Cables

SMA, 91 cm (36 in)	5061-5458
BNC, 122 cm (48 in) (3 required)	HP 10503A

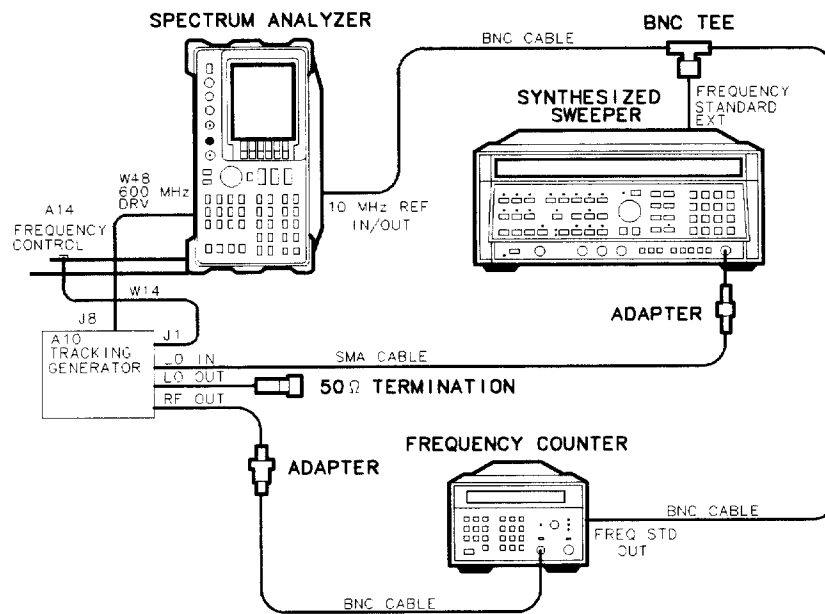
Adapters

APC 3.5 (f) to APC 3.5 (f)	5061-5311
SMA (m) to BNC (f)	1250-1200
BNC tee	1250-0781

18. Tracking Oscillator Adjustment (Option 002)

Procedure

1. Remove the A10 tracking generator assembly as described in Chapter 3. With the A10 tracking generator positioned next to the the HP 8560E, reconnect W14 (10-wire ribbon cable) to A10J1. Reconnect W48 to A10J8. Connect the 50 Ω termination to A10J3.
2. Connect the equipment as shown in Figure 2-25. The frequency counter provides the frequency reference for the synthesized sweeper and the HP 8560E.



SJ14

Figure 2-25. Tracking Oscillator Adjustment Setup

3. Press **LINE** to turn the spectrum analyzer on. Press **AUX CTRL**, **TRACKING GENRATOR**, **SRC PWR ON**, **AUX CTRL**, **REAR PANEL**, and **10 MHz EXT**. Allow the HP 8560E to warm up for at least 5 minutes. Set the controls as follows:

Center frequency 300 MHz
Span 0 Hz

4. Press **INSTR PRESET** on the synthesized sweeper and set the controls as follows:

CW 4.2107 GHz
Power level +12 dBm
Frequency standard switch (rear panel) EXT

5. Set the frequency counter controls as follows:

SAMPLE RATE Fully CCW
10 Hz—500 MHz / 500 MHz—26.5 GHz Switch 10 Hz—500 MHz
50 Ω —1 M Ω Switch 50 Ω

6. Remove the dust cap screw used to seal the tracking oscillator adjustment.
7. On the HP 8560E, press **AUX CTRL**, **TRACKING GENRATOR**, **MORE 1 OF 3**, **MAN TRK ADJ**, **0**, and **Hz**. Rotate the knob counterclockwise until FINE TRACK ADJ is set to 0.

18. Tracking Oscillator Adjustment (Option 002)

8. Record the frequency counter reading in Table 2-13 as F1.
9. On the HP 8560E, press **MAN TRK ADJ**, 255, and **[Hz]**. Rotate the knob clockwise until the FINE TRACK ADJ is set to 255.
10. Record the frequency counter reading in Table 2-13 as F2.
11. Calculate F_{center} as shown below and record in Table 2-13.

$$F_{\text{center}} = (F1 + F2) / 2$$

12. Set COARSE TRACK ADJ to 25. This sets the tracking oscillator near the center of its frequency range (the relationship between the COARSE TRACK ADJ dac number and the output frequency is nonlinear). Adjust COARSE TRACK ADJ and FINE TRACK ADJ until the frequency counter reads $F_{\text{center}} \pm 100$ Hz.
13. Record the values of COARSE TRACK ADJ and FINE TRACK ADJ in Table 2-13.
14. Adjust A10C3 TRK OSC CTR until the frequency counter reads 300 MHz ± 500 Hz.
15. Repeat steps 7 through 14 at least once more until no further adjustment of A10C3 TRK OSC CTR is necessary.
16. Press **[LINE]** to turn the spectrum analyzer off. Replace the dust cap screw on A10. Disconnect all cables from A10.
17. Reinstall A10 in the HP 8560E.

Table 2-13. Tracking Oscillator Range Centering

N	F1 (MHz)	F2 (MHz)	F _{center} (MHz)	TRACK ADJ DAC Settings	
				COARSE	FINE
1					
2					
3					
4					
5					

19. 16 MHz PLL Adjustment

Note This adjustment applies only to spectrum analyzers with A2 controller assemblies other than 08563-60017.

Assembly Adjusted

A2 controller assembly

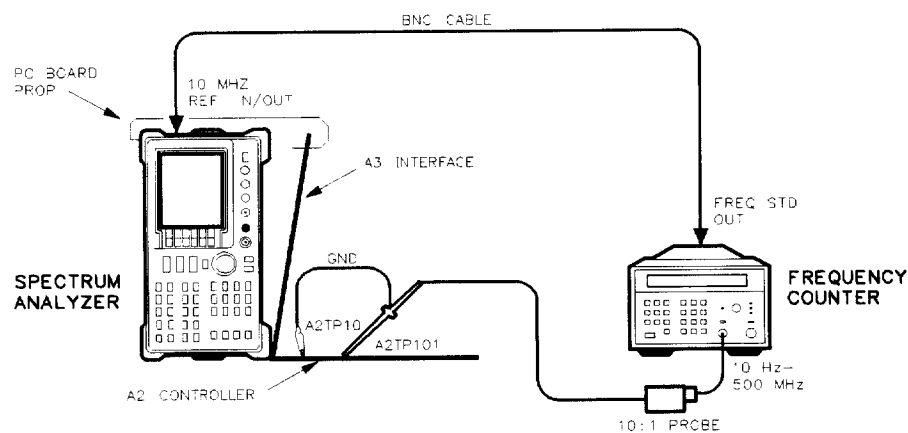
Related Performance Tests

Sweep Time Accuracy
Gate Delay Accuracy and Gate Length Accuracy
Delayed Sweep Accuracy
Fast Sweep Time Accuracy (Option 007)

Description

In spectrum analyzers with serial prefix numbers greater than or equal to 3310A, the 16MHz CPU clock is phase locked to the 10 MHz reference. The output of the 16 MHz PLL's loop integrator is adjusted for a clock frequency of approximately 14.4 MHz with the loop unlocked. This ensures that the CPU will still function and the display annotation will be distorted but readable, even if the 10 MHz reference to A2 is absent.

Note If necessary, perform the display adjustments after performing the following adjustment.



sj140e

Figure 2-26. 16 MHz PLL Adjustment Setup

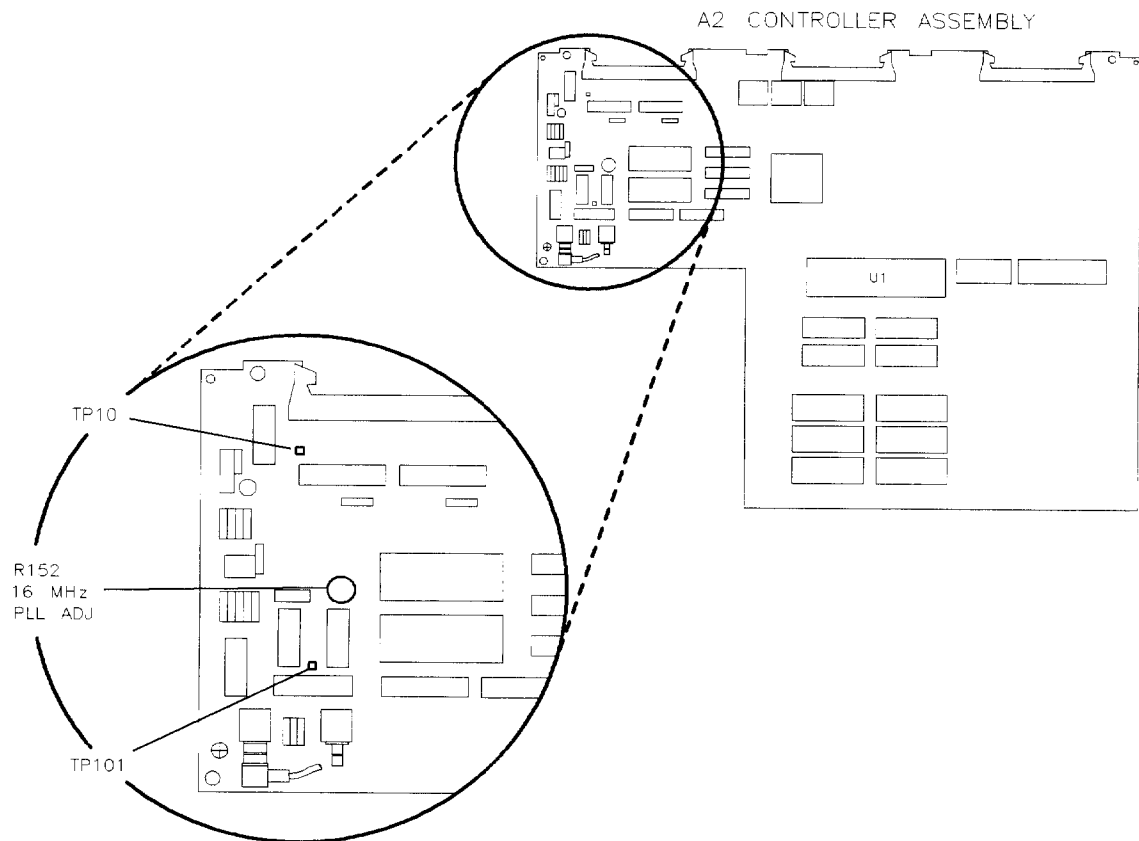
19. 16 MHz PLL Adjustment

Equipment

Microwave frequency counter HP 5343A
10:1 probe HP 10432A

Procedure

1. Press **LINE** to turn the spectrum analyzer off. Remove the spectrum analyzer's cover and fold out the A2 controller and A3 interface assemblies. Use a pc board prop to hold up the A3 interface assembly, as shown in Figure 2-26.
2. Connect the equipment as shown in Figure 2-26. The 10:1 probe's ground lead connects to A2TP10 and the probe's tip connects to A2TP101.
3. The 16 MHz PLL adjustment location is shown in Figure 2-27.



sj141e

Figure 2-27. 16 MHz PLL Adjustment Location

19. 16 MHz PLL Adjustment

4. Press **LINE** to turn the spectrum analyzer on. Wait until the spectrum analyzer's power-on adjustments have completed.
5. Set the microwave frequency counter as follows:

Sample rate	Fully counterclockwise
10 Hz—500 MHz/500 MHz—26.5 GHz Switch	10 Hz—500 MHz
50 Ω /1 M Ω Switch	1 M Ω
6. On the HP 8560E spectrum analyzer, press **AUX CTRL**, **REAR PANEL**, and **10 MHz EXT**.
7. Disconnect W22 (10 MHz frequency counter) from A2J8. The display will probably appear distorted and error messages may appear. Ignore the error messages.
8. Adjust A2R152 (16 MHz PLL ADJ) until the microwave frequency counter reads 14.4 MHz $\pm$ 200 KHz.
9. Reconnect W22 to A2J8. The microwave frequency counter should read 16 MHz. If the counter reads 16 MHz and the display is still distorted, perform the display adjustments in "Display Adjustment," in this chapter.
10. On the spectrum analyzer, press **CAL** and **REALIGN LO and IF** to clear any error messages.

Assembly Replacement

This chapter describes the removal and replacement of all major assemblies. The following replacement procedures are provided:

- Access to Internal Assemblies
- Cable Color Code
- Procedure 1. Spectrum Analyzer Cover
- Procedure 2. A1 Front Frame/A18 CRT
- Procedure 3. A1A1 Keyboard/Front Panel Keys
- Procedure 4. A1A2 RPG
- Procedure 5. A2, A3, A4, and A5 Assemblies
- Procedure 6. A6 Power Supply Assembly
- Procedure 7. A6A1 High Voltage Assembly
- Procedure 8. A7 through A13 Assemblies
 - A7 1st LO Distribution Amplifier
 - A8 Low Band Mixer
 - A9 Input Attenuator
 - A10 Tracking Generator (Option 002)
 - A11 YTO
 - A13 Second Converter
- Procedure 9. A14 and A15 Assemblies
- Procedure 10. A16 FADC/A17 CRT Driver
- Procedure 11. B1 Fan
- Procedure 12. BT1 Battery
- Procedure 13. Rear Frame/Rear Dress Panel
- Procedure 14. W3 Line Switch Cable
- Procedure 15. EEROM (A2U501)
- Procedure 16. A21 OCXO

Tools required to perform the procedures are listed in Table 3-1.

The words *right* and *left* are used throughout the replacement procedures to indicate the side of the spectrum analyzer as viewed from the front panel.

Numbers in parentheses are used throughout the replacement procedures to indicate numerical callouts on the figures.

Caution	The spectrum analyzer contains static-sensitive components. Read the section entitled, "Electrostatic Discharge" in Chapter 1.
----------------	--

Access to Internal Assemblies

Servicing the HP 8560E requires the removal of the spectrum analyzer cover assembly and the folding down of six board assemblies. Four of these assemblies lay flat along the top of the spectrum analyzer and two lay flat along the bottom of the spectrum analyzer. All six assemblies are attached to the spectrum analyzer right side frame using hinges and fold out of the spectrum analyzer allowing access to all major assemblies. See Figure 3-1.

- To remove the spectrum analyzer cover assembly, refer to procedure 1.
- To access the A2, A3, A4, and A5 assemblies, refer to procedure 5.
- To access the A14 and A15 assemblies, refer to procedure 9.
- To remove A16 or A17, refer to procedure 10.

Cable Color Code

Coaxial cables and wires will be identified in the procedures by reference designation, or name, followed by a color code. The code is identical to the resistor color code. The first number indicates the base color with second and third numbers indicating any colored stripes. For example, W23, coax 93, indicates a white cable with an orange stripe.

Table 3-1. Required Tools

Description	HP Part Number
5/16-inch open-end wrench	8720-0015
3 mm hex (Allen) wrench	8710-1366
4 mm hex (Allen) wrench	8710-1164
No. 6 hex (Allen) wrench	5020-0289
7 mm nut driver	8710-1217
3/8-inch nut driver	8720-0005
7/16-inch nut driver	8720-0006
9/16-inch nut driver (drilled out, end covered with heatshrink tubing)	8720-0008
Small No.1 pozidrive screwdriver	8710-0899
Large No.2 pozidrive screwdriver	8710-0900
T-8 TORX screwdriver	8710-1614
T-10 TORX screwdriver	8710-1623
T-15 TORX screwdriver	8710-1622
Long-nose pliers	8710-0030
Wire cutters	8710-0012

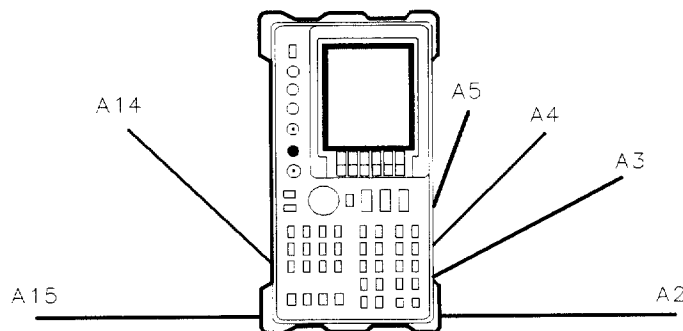
Procedure 1. Spectrum Analyzer Cover

Removal/Replacement

1. Disconnect the line-power cord, remove any adapters from the front-panel connectors, and place the spectrum analyzer on its front panel.
2. If an HP 85620A Mass Memory Module or HP 85629B Test and Adjustment Module is mounted on the rear panel, remove it. Loosen (but do not remove) the four rear-bumper screws, using a 4 mm hex wrench. Pull the cover assembly off towards the rear of the instrument.

Caution When replacing the spectrum analyzer cover, use caution to avoid damaging any cables.

3. When installing the cover assembly, be sure to locate the cover's air vent holes on the bottom side of the spectrum analyzer. Attach with the four screws loosened in step 2, and tighten the four screws gradually to ensure that the cover is seated in the front-frame gasket groove.
4. Torque each screw to 40 to 50 inch-pounds to ensure proper EMI gasket compression.



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Figure 3-1. Hinged Assemblies

Procedure 2. A1 Front Frame/A18 CRT

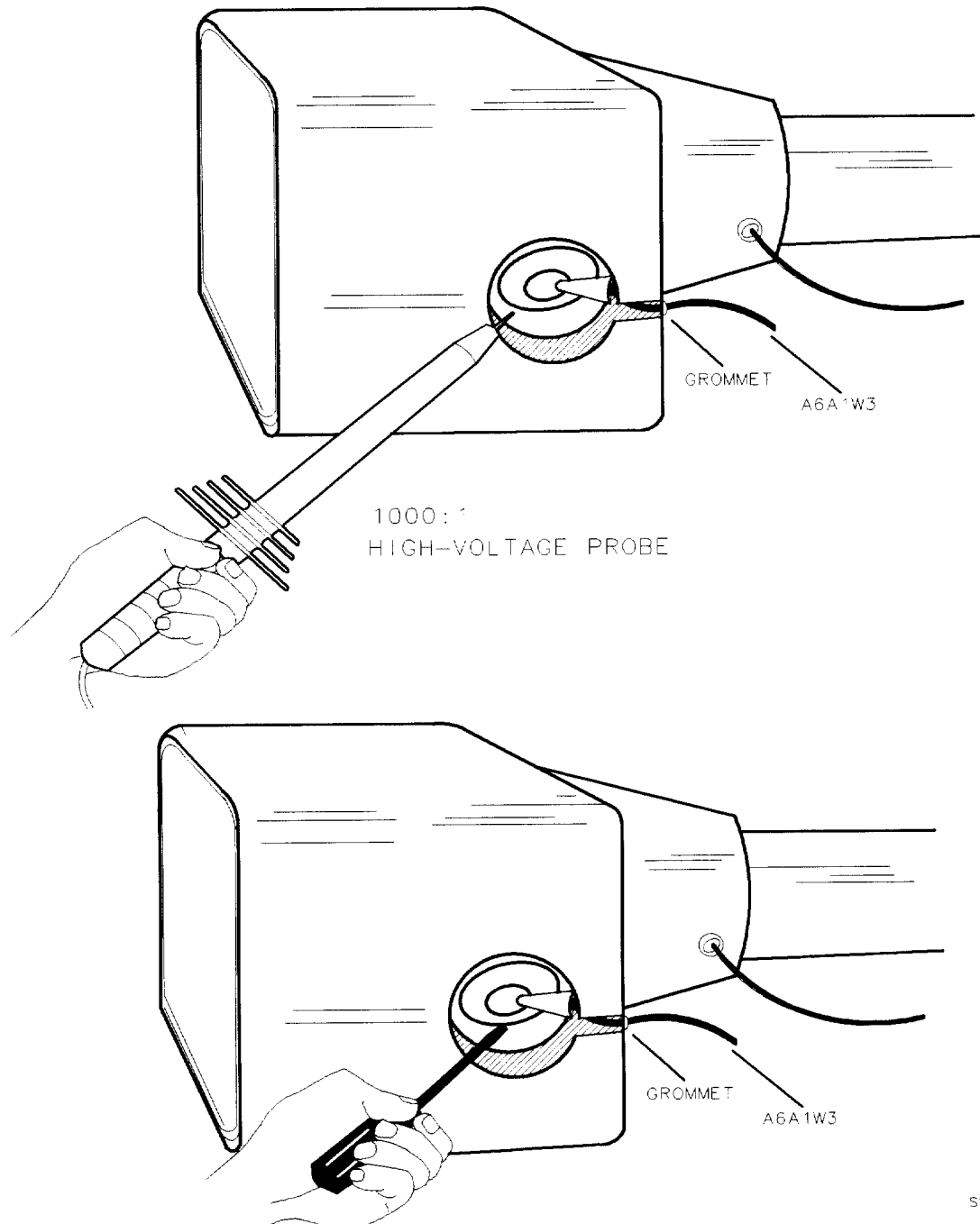
Removal

Warning	The voltage potential at A6A1W3 is +9 kV. Disconnect at the CRT with caution! Failure to properly discharge A6A1W3 may result in <i>severe electrical shock</i> to personnel and damage to the instrument.
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1. Remove the spectrum analyzer cover assembly as described in "Procedure 1. Spectrum Analyzer Cover."
2. Fold out the A2, A3, A4, and A5 assemblies as described in steps 2 through 6 under "Procedure 5. A2, A3, A4, and A5 Assemblies Removal."
3. Disconnect A1A1W1 from A3J602.
4. Place the spectrum analyzer top-side-up on the work bench.
5. Connect the spectrum analyzer line-power cord to provide proper grounding while discharging the A6A1W3 post-accelerator cable. Make sure that the spectrum analyzer line-power switch is in the off position.
6. Connect a high-voltage probe (1000:1), such as the HP 34111A to a voltmeter with a 10 megohm input.
7. Connect the clip lead of the probe (ground) to the chassis of the spectrum analyzer.
8. Slip the tip of the high-voltage probe under the A6A1W3 post-accelerator cable's rubber shroud to obtain a reading on the voltmeter. See Figure 3-2.
9. Keep the high-voltage probe on the post-accelerator connector until the voltage has dropped to a voltmeter reading of less than 5 mV (less than 5 V at the connector). This normally takes about 30 seconds.
10. Disconnect the line-power cord from the spectrum analyzer.
11. Using a small screwdriver with the shank in contact with the CRT shield assembly, slip the tip of the screwdriver under the A6A1W3 post-accelerator cable's rubber shroud and short the cable to ground on the CRT shield assembly. See Figure 3-2.
12. Pry out the black grommet protecting post-accelerator cable A6A1W3 from the CRT shield assembly.
13. Carefully unsnap the A6A1W3 post-accelerator cable from the CRT and discharge it by shorting the cable to chassis ground on the CRT shield assembly.
14. Place the spectrum analyzer on its right side frame with the front-frame assembly hanging over the front edge of the work bench.
15. Fold out the A14 and A15 assemblies as described in steps 3 and 4 under "Procedure 9. A14 and A15 Assemblies Removal."

Warning

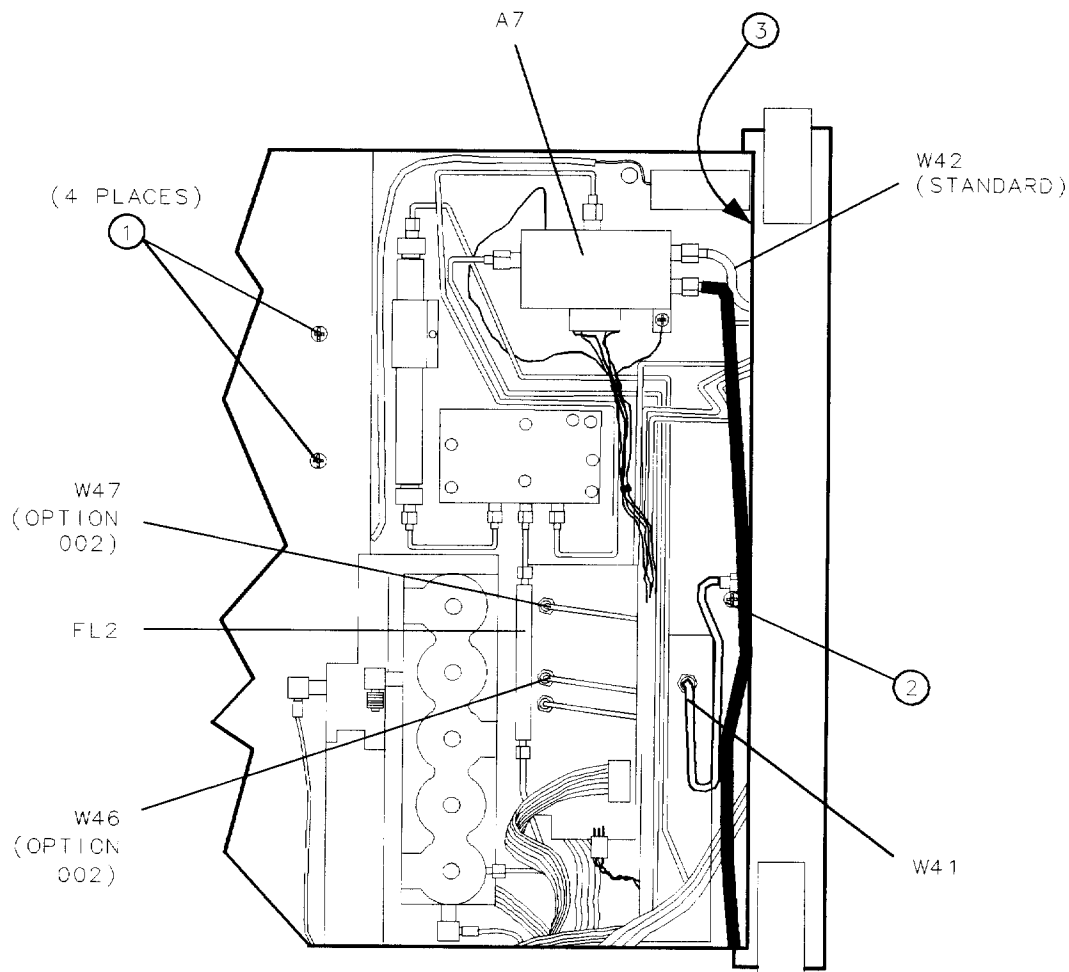
The voltage potential at A6A1W3 is +9 kV. Failure to discharge A6A1W3 correctly may result in *severe electrical shock* to personnel and damage to the instrument.



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Figure 3-2. Discharging the Post-Accelerator Cable

Procedure 2. A1 Front Frame/A18 CRT



sj133e

Figure 3-3. A9, A18, and Line-Switch Assembly Mounting Screws

16. Remove screw (2) securing the A9 input attenuator assembly to the center support on the front frame. See Figure 3-3.
17. Use a 5/16-inch open-end wrench to disconnect W41 from the front-panel INPUT 50 Ω connector. Loosen the opposite end of W41.
18. *For Option 002 spectrum analyzers:* use a 5/16-inch open-end wrench to disconnect W47 from the front-panel RF OUT 50 Ω connector.
19. Disconnect W42 from A7J3 and the front-panel 1ST LO OUTPUT connector. *For Option 002 spectrum analyzers:* disconnect W46 from the front-panel 1ST LO OUTPUT connector.
20. Disconnect W36, coax 86, from the front-panel IF INPUT connector.
21. Remove the VOLUME knob and potentiometer from the front panel. If necessary, drill out the nut driver used to remove the VOLUME potentiometer and cover the tip with heatshrink tubing or tape to avoid scratching the enameled front panel.

3-6 Assembly Replacement

Procedure 2. A1 Front Frame/A18 CRT

22. Use a 9/16-inch nut driver to remove the dress nut holding the front-panel CAL OUTPUT connector to the front panel. If necessary, drill out the nut driver to fit over the BNC connectors and cover the tip with heatshrink tubing or tape to avoid scratching the enameled front panel.
23. Remove screw (3) securing the line-switch assembly to the front frame. See Figure 3-3.
24. Gently remove the line-switch assembly, using caution to avoid damaging A1W1 and power indicator LED A1W1DS1.
25. Remove A1W1 and A1W1DS1 from the line-power switch assembly.
26. Remove the three screws (1) securing the front-frame assembly to the spectrum analyzer right side frame. See Figure 3-4.

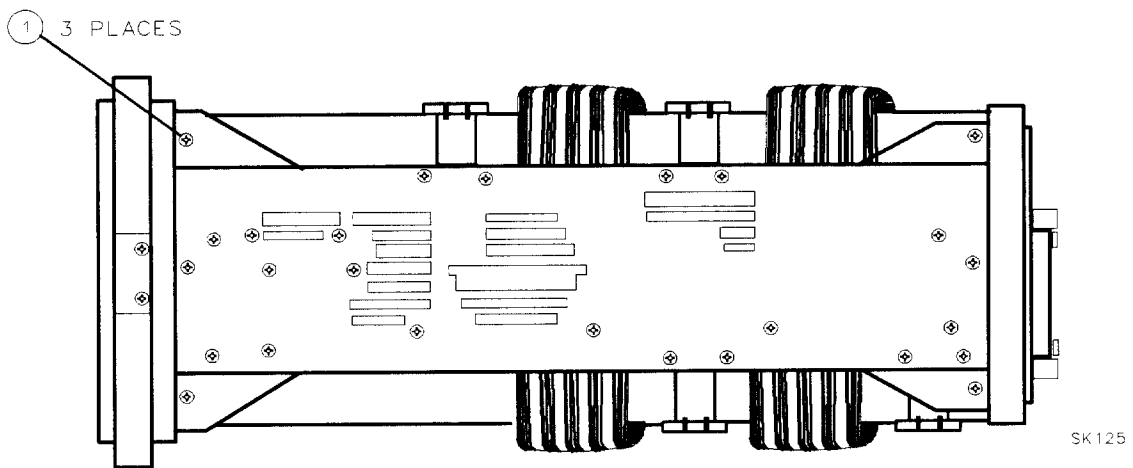
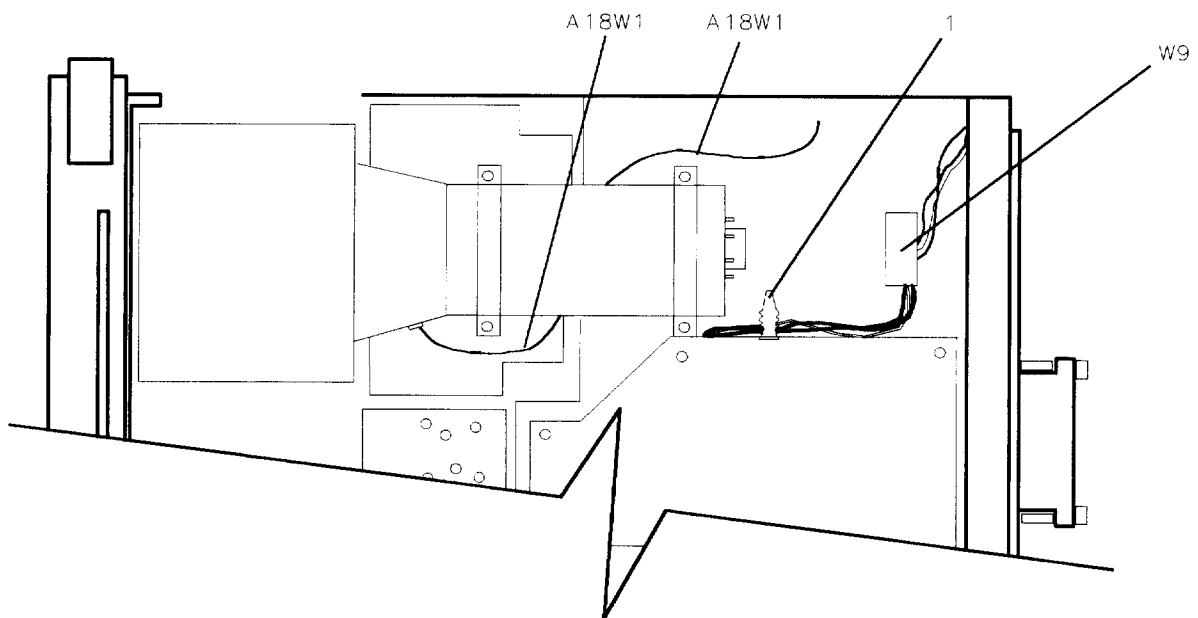


Figure 3-4. Front-Frame Mounting Screws

27. Remove the three screws securing the front-frame assembly to the spectrum analyzer left side frame.
28. Remove the four screws (1) (Figure 3-3) securing the CRT clamps to the deck.
29. Pull the cable tie (1) to free W9. See Figure 3-5. Gently pry W9, the CRT cable, from the end of the CRT assembly.
30. Support the A18 CRT assembly while gently pulling the front frame and CRT out of the spectrum analyzer 1 or 2 inches.
31. Disconnect A18W1, the trace align wires, from A17J5. Remove the front-frame and CRT assemblies.
32. Gently pull the CRT assembly off of the front-frame assembly.

Procedure 2. A1 Front Frame/A18 CRT



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Figure 3-5. Installing the CRT and Front-Frame Assemblies

Replacement

Note

Use care when handling the glass CRT EMI shield. The glass may be cleaned using thin-film cleaner (HP part number 8500-2163) and a lint-free cloth. When installing the glass shield, face the side of the glass with the silver coated edge towards the inside of the spectrum analyzer.

1. Place the spectrum analyzer on its right side frame with the front end extending slightly over the front of the work bench.
2. Gently place the A18 CRT assembly into the A1 front-frame assembly as illustrated in Figure 3-6.
3. Place the front-frame and CRT assemblies into the spectrum analyzer, using caution to avoid pinching any cables.
4. Dress the A18W1 trace-align wires between the CRT assembly mounts and the A6 power supply top shield.

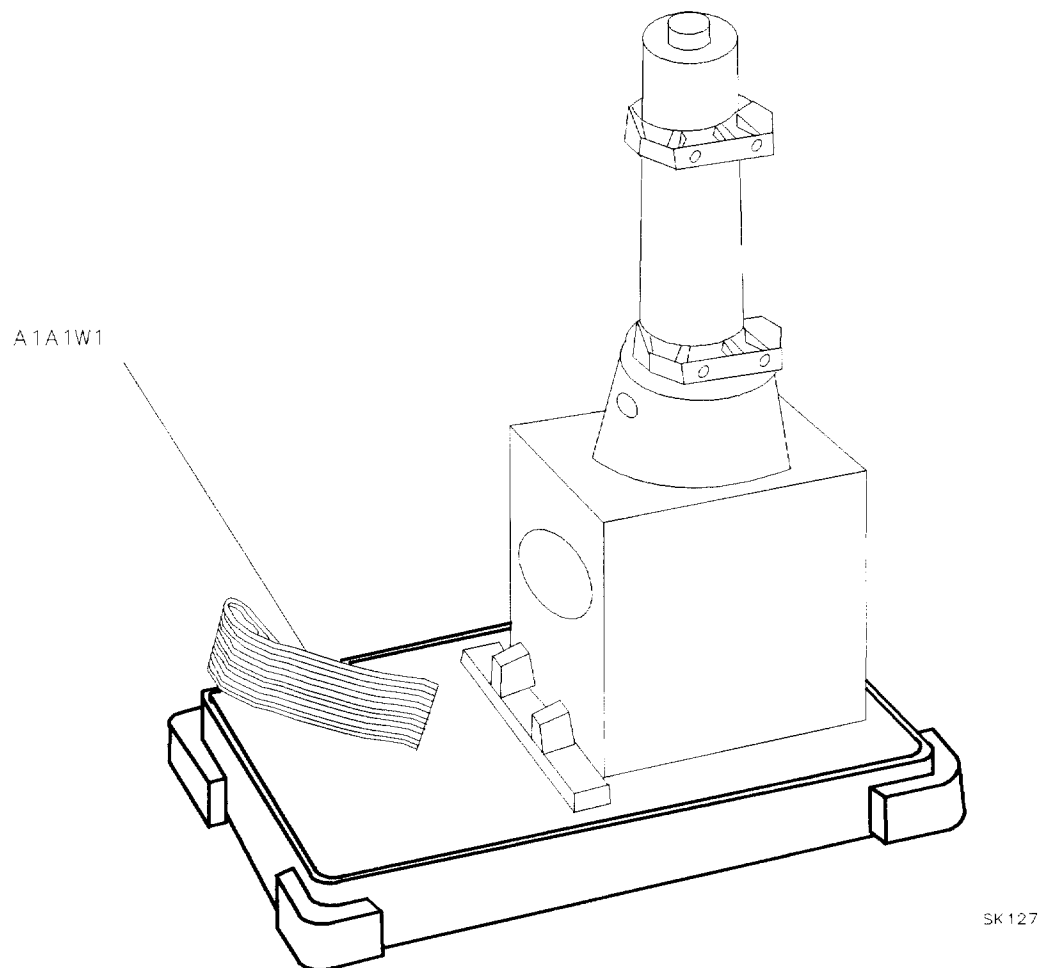


Figure 3-6. Placing the CRT into the Front Frame

5. Connect A18W1 to A17J5.
6. Snap CRT cable W9 onto the end of the CRT assembly.
7. Fully seat the front frame and CRT assemblies into the spectrum analyzer.
8. Secure the front frame to the spectrum analyzer side frames, using three flathead screws per side. See Figure 3-4.
9. Retighten the four screws securing the CRT clamps to the deck.
10. Place W9 between the CRT assembly and the A6 power supply assembly top shield so that the W9 wires are below the surface of the top shield.
11. Connect W42 to A7J3 and the front-panel 1ST LO OUTPUT connector. *For Option 002 spectrum analyzers:* connect W46 to the front-panel 1ST LO OUTPUT connector.
12. Use a 9/16-inch nut driver to reconnect CAL OUTPUT connector to the front panel.
13. Connect the VOLUME potentiometer and knob to the front panel.
14. *For Option 002 spectrum analyzers:* use a 5/16-inch open-end wrench to connect W47 to the front-panel RF OUT connector.

Procedure 2. A1 Front Frame/A18 CRT

15. Connect W36, coax 86, to the front-panel IF INPUT connector.
16. Use a 5/16-inch wrench to connect W41 from the A9 input attenuator to the front-panel INPUT 50 Ω connector. Make sure that W40, W36, and A1W1 are routed between W41 and the attenuator bracket. Secure the A9 input attenuator bracket to the center support on the front frame using one panhead screw. See Figure 3-3 (2).
17. Place led A1W1DS1 into the line-power switch assembly.
18. Attach the line switch assembly into the front-frame using one panhead screw. Be sure to connect the line-power switch ground lug with the screw. The screw is captive.
19. Fold up the A14 and A15 assemblies as described in steps 3 through 5 under "Procedure 9. A14 and A15 Assemblies Replacement."
20. Place the spectrum analyzer top-side-up on the work bench and connect A1A1W1 to A3J602.
21. Snap post-accelerator cable A6A1W3 to the A18 CRT assembly.
22. Snap the black grommet protecting the A6A1W3 into the CRT shield.
23. Fold up assemblies A2, A3, A4, and A5 as described in steps 6 through 12 under "Procedure 5. A2, A3, A4, and A5 Assemblies Replacement."
24. Replace the spectrum analyzer cover assembly.
25. Connect the line-power cord and switch the spectrum analyzer power on. If the display does not operate properly, turn off spectrum analyzer power, disconnect the line cord, and recheck the spectrum analyzer.

Procedure 3. A1A1 Keyboard/Front Panel Keys

Removal

1. Remove the front frame from the spectrum analyzer as described in "Procedure 2. A1 Front Frame/A18 CRT."
2. Place the front frame face-down on the bench and remove the front-frame center support.
3. Disconnect A1W1 from A1A1J3 and the RPG cable from A1A1J2.
4. Remove the nine screws holding the A1A1 keyboard assembly to the front frame and remove the assembly.
5. Remove the rubber keypad.

Note

The front-panel softkey actuators are part of the CRT bezel assembly and are not replaceable. Should the softkeys become damaged, replace the bezel assembly.

Replacement

1. Install the rubber keypad, ensuring that the screw holes are visible through the pad.
2. Place the A1A1 keyboard assembly over the rubber keypad. Secure with nine panhead screws.
3. Connect the RPG cable to A1A1J2, and A1W1 to A1A1J3.
4. Secure the center support to the front frame using two panhead screws. The arrow stamped on the center support should point to the top of the frame.
5. Install the front-frame assembly as described in "Procedure 2. A1 Front Frame/A18 CRT."

Procedure 4. A1A2 RPG

Removal

1. Remove the A9 input attenuator as described in “Procedure 8. A7 through A13 Assemblies.”
2. Disconnect the RPG cable from the A1A1 keyboard assembly.
3. Remove the front-panel RPG knob using a number 6 hex (Allen) wrench. Use a 7/16-inch nut driver to remove the nut holding the RPG shaft to the front panel.
4. Remove the RPG.

Replacement

1. Place the RPG into the front frame with the cable facing the bottom of the spectrum analyzer. Place a lock washer and nut on the RPG shaft to hold it in the frame.
2. Use a 7/16-inch nut driver to secure the RPG assembly to the front frame.
3. Connect the RPG cable to A1A1J2.
4. Attach the RPG knob using a number 6 hex (Allen) wrench.
5. Replace the A9 input attenuator as described in “Procedure 8. A7 through A13 Assemblies.”

Procedure 5. A2, A3, A4, and A5 Assemblies

Removal

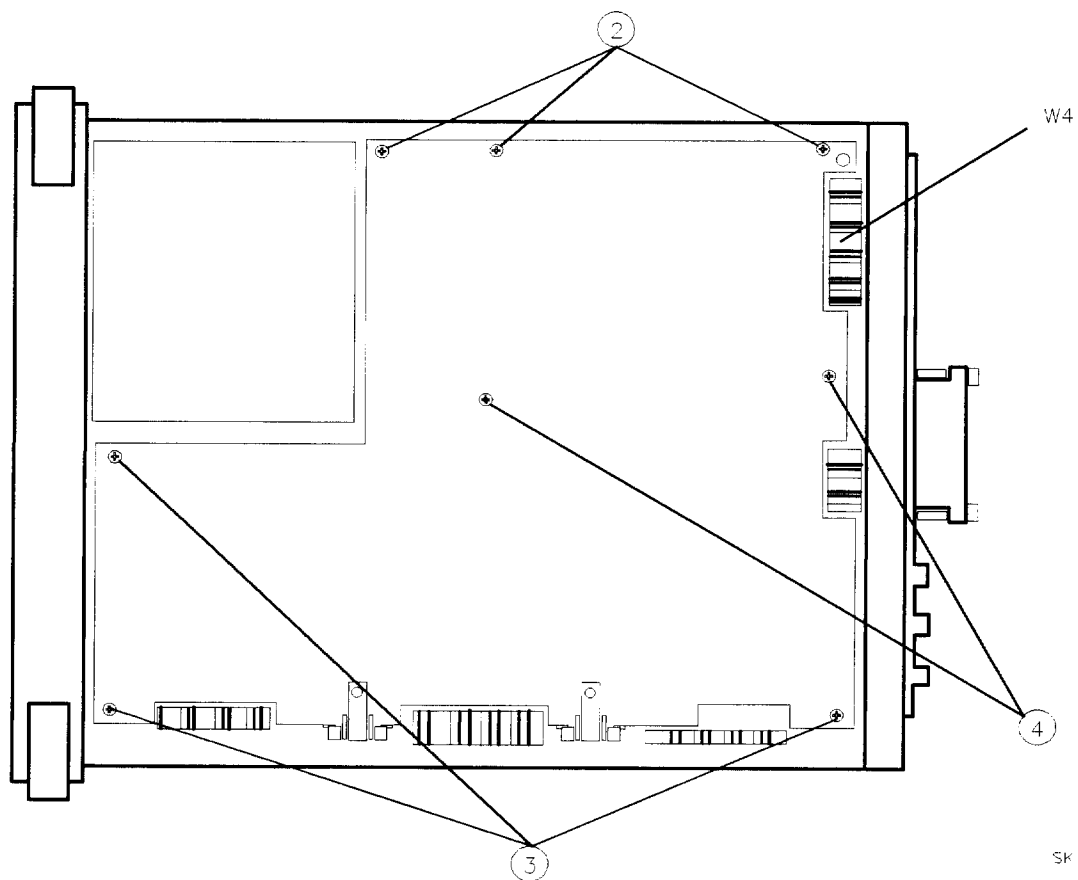
1. Remove the spectrum analyzer cover.
2. Place the spectrum analyzer on its right side frame.
3. Remove the eight screws holding the A2, A3, A4, and A5 assemblies to the top of the spectrum analyzer. These screws are labeled (2), (3), and (4) in Figure 3-7. They are also labeled on the back of the A2 board assembly.
4. Remove ribbon cable W4 from A2J6. See Figure 3-7.

Caution	Do not fold the board assemblies out of the spectrum analyzer one at a time. Always fold the A2 and A3 assemblies as a unit and the A4 and A5 assemblies as a unit. Folding out one assembly at a time binds the hinges attaching the assemblies and may damage an assembly and hinge.
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5. The board assemblies are attached to the spectrum analyzer right side frame with two hinges. Fold both the A2 and A3 assemblies out of the spectrum analyzer as a unit.
6. Fold both the A4 and A5 assemblies out of the spectrum analyzer as a unit.
7. Remove the cables from the assembly being removed, as illustrated in Figure 3-8.
8. Remove the two screws that attach the assembly being removed to its two mounting hinges.

Caution	Do not torque shield torx screws to more than 8 inch-pounds. Applying excessive torque will cause the screws to stretch.
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Procedure 5. A2, A3, A4, and A5 Assemblies



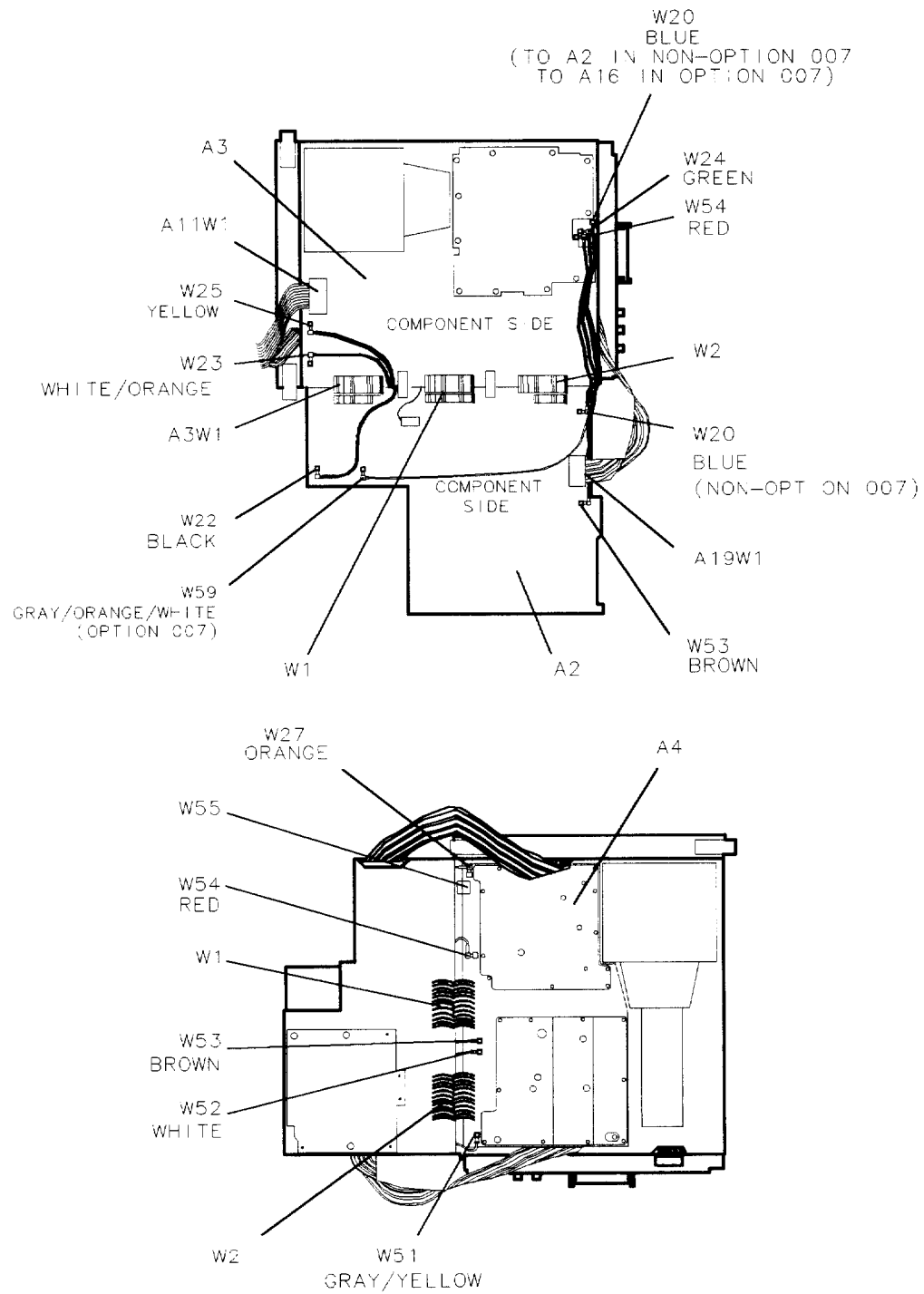
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Figure 3-7. A2, A3, A4, and A5 Assembly Removal

Replacement

1. Place the spectrum analyzer top-side-up on the work bench.
2. Attach the assembly being installed to the two chassis hinges with two panhead screws.
3. Leave the assembly in the folded-out position and attach ribbon cables W1 and W2.
4. Attach all coaxial cables to the assembly, as illustrated in Figure 3-8.
5. Locate the cable clip on the inside of the right side frame. Make sure that the coaxial cables are routed properly on the clip as illustrated in Figure 3-9.
6. Lay the A2, A3, A4, and A5 assemblies flat against each other in the folded-out position. Make sure that no cables become pinched between any two assemblies.

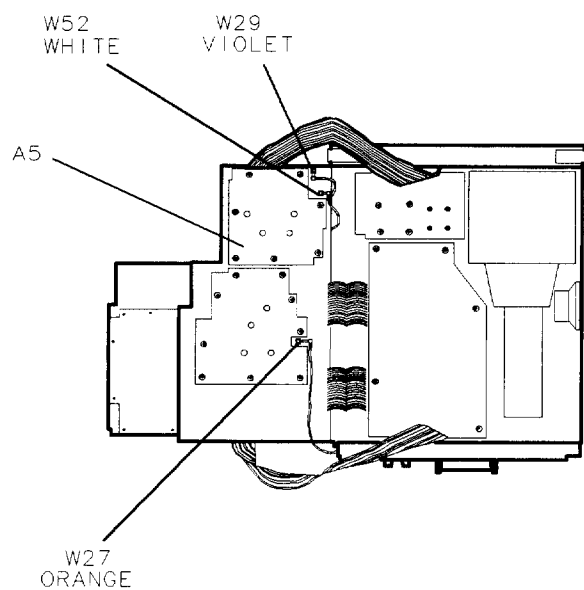
Procedure 5. A2, A3, A4, and A5 Assemblies



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Figure 3-8. Assembly Cables

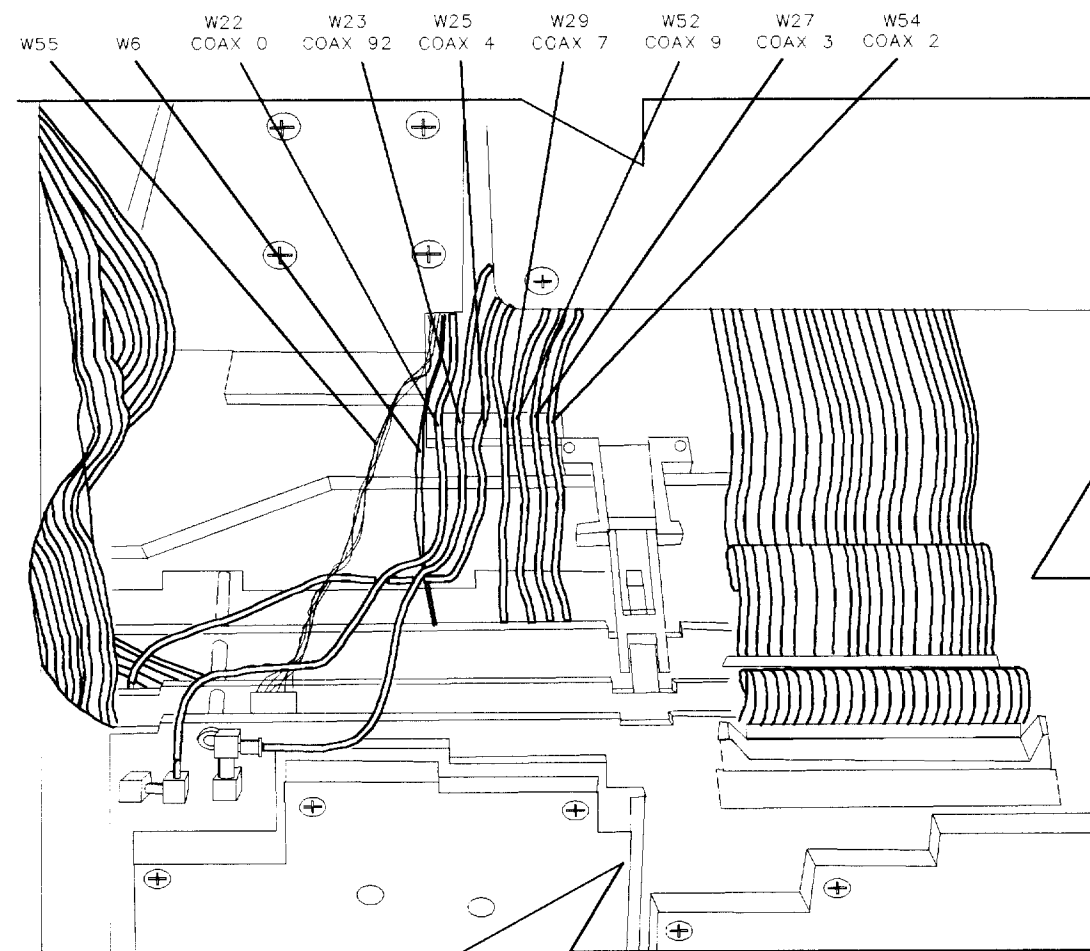
Procedure 5. A2, A3, A4, and A5 Assemblies



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Figure 3-8. Assembly Cables (2 of 2)

Procedure 5. A2, A3, A4, and A5 Assemblies



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Figure 3-9. Coaxial Cable Clip

7. Check to ensure that no cables will become pinched under the hinges when folding up the A4 and A5 assemblies.
8. Fold the A4 and A5 assemblies together as a unit into the spectrum analyzer. Use caution to avoid damaging any cable assemblies. The standoffs on the A5 assembly must fit into the cups on the A6 power supply top shield.
9. Fold the A2 and A3 assemblies together as a unit into the spectrum analyzer. Be sure to fold HP-IB cable A19W1 between the A3 and A4 assemblies, using the two sets of hook and loop (Velcro) fasteners.
10. Fold ribbon cable A1A1W1 between A3 and A4 assemblies. Take care to dress the protective tubing as close to A3J602 connector as possible, so that the tubing does not fold with the cable. See Figure 3-10.
11. Attach ribbon cable W4 to A2J6 while folding up the assemblies.
12. Secure the assemblies using the eight screws removed in step 3 under "Removal." See Figure 3-7.

Procedure 5. A2, A3, A4, and A5 Assemblies

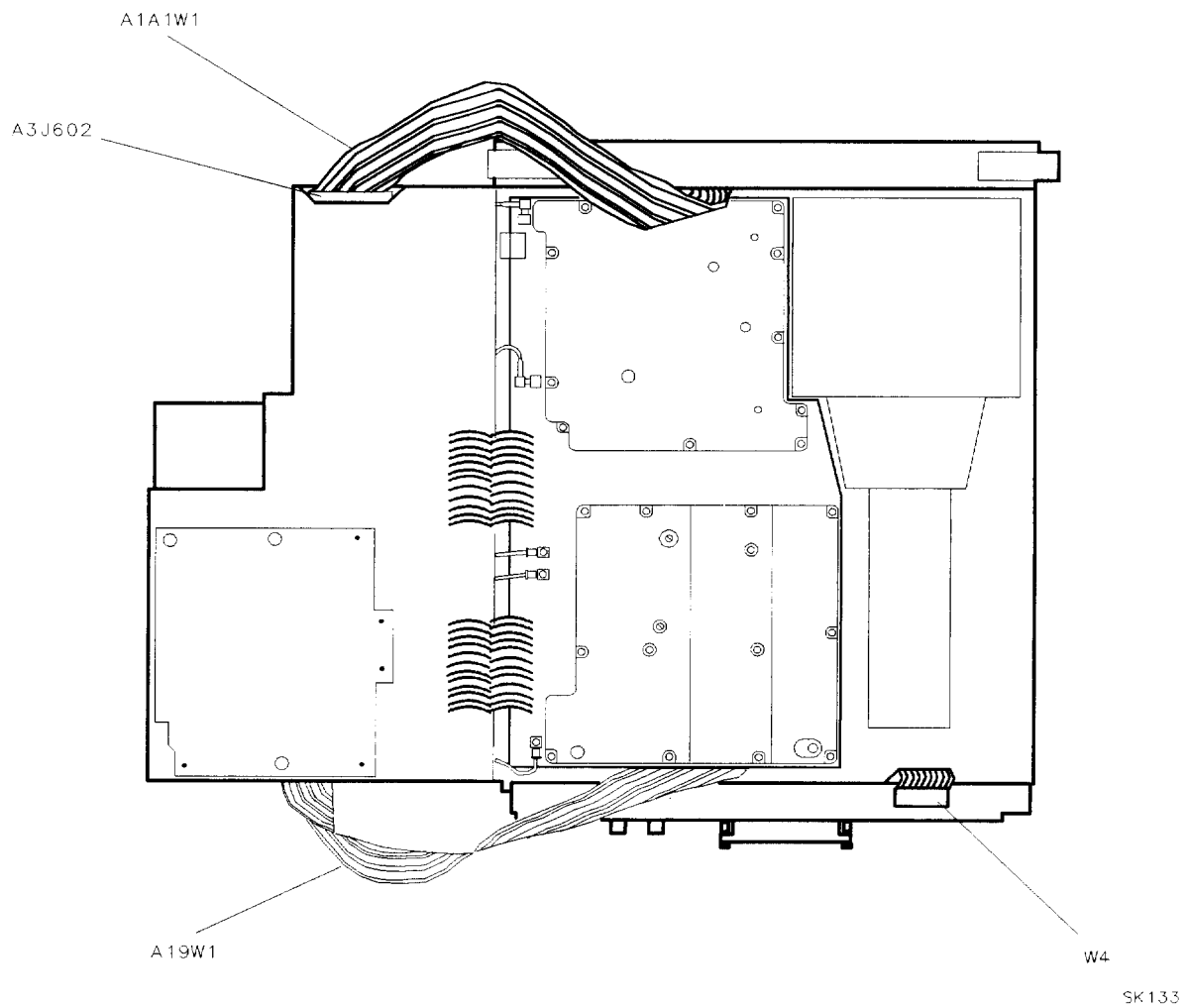


Figure 3-10. HP-IB and A1A1 W1 Cable Placement

Procedure 6. A6 Power Supply Assembly

Removal

Warning	The A6 Power Supply and A6A1 High Voltage assemblies contain lethal voltages with lethal currents in all areas. Use extreme care when servicing these assemblies. Always disconnect the power cord from the instrument before beginning this replacement procedure. Failure to follow this precaution will represent a shock hazard which may result in personal injury.
----------------	---

1. Disconnect the power cord from the spectrum analyzer.
2. Remove the spectrum analyzer cover assembly. Refer to "Procedure 1. Spectrum Analyzer Cover."
3. Fold out the A2, A3, A4, and A5 assemblies as described in steps 2 through 6 under "Procedure 5. A2, A3, A4, and A5 Assemblies Removal."
4. Place the spectrum analyzer top-side-up on the work bench with A2, A3, A4, and A5 folded out to the right.

Warning	The voltage potential at A6A1W3 is +9 kV. Disconnect at the CRT with caution! Failure to properly discharge A6A1W3 may result in <i>severe electrical shock</i> to personnel and damage to the instrument.
----------------	---

5. Connect the spectrum analyzer line-power cord to provide proper grounding while discharging the A6A1W3 post-accelerator cable. Make sure that the spectrum analyzer line-power switch is in the off position.
6. Connect a high-voltage probe (1000:1), such as the HP 34111A to a voltmeter with a 10 megohm input.
7. Connect the clip lead of the probe (ground) to the chassis of the spectrum analyzer.
8. Slip the tip of the high-voltage probe under the A6A1W3 post-accelerator cable's rubber shroud to obtain a reading on the voltmeter. See Figure 3-2.
9. Keep the high-voltage probe on the post-accelerator connector until the voltage has dropped to a voltmeter reading of less than 5 mV (less than 5 V at the connector). This normally takes about 30 seconds.
10. Disconnect the line-power cord from the spectrum analyzer.
11. Using a small screwdriver with the shank in contact with the CRT shield assembly, slip the tip of the screwdriver under the A6A1W3 post-accelerator cable's rubber shroud and short the cable to ground on the CRT shield assembly. See Figure 3-2.
12. Remove the three screws securing the power supply shield to the power supply and remove the shield.
13. Remove the three screws securing the A6A1 high voltage assembly to the A6 power supply assembly.
14. Disconnect ribbon cable A6A1W1 from A6J5 and lift the A6A1 assembly out of the way. See Figure 3-11.

Procedure 6. A6 Power Supply Assembly

15. Disconnect all cables from the A6 power supply assembly. See Figure 3-11.
16. Use a TORX screwdriver to remove the hardware from the shield wall, the heatsink, and the A6 power supply assembly.
17. Remove the A6 power supply assembly by lifting from the regulator heatsink toward front of spectrum analyzer.

Replacement

1. Ensure that the bottom shield wall is in place before replacing the A6 power supply assembly.
2. Attach the A6 power supply assembly to the spectrum analyzer chassis and top shield wall using the four screws.
3. Connect W1 to A6J1, W3 to A6J2, fan power wires to A6J3, W8 to A6J4, and the line-power jack to A6J101. See Figure 3-11.
4. Secure the A6A1 high voltage assembly to the A6 power supply assembly, using three panhead screws. Connect ribbon cable A6A1W1 to A6J5.
5. Snap post-accelerator cable A6A1W3 to the CRT assembly.

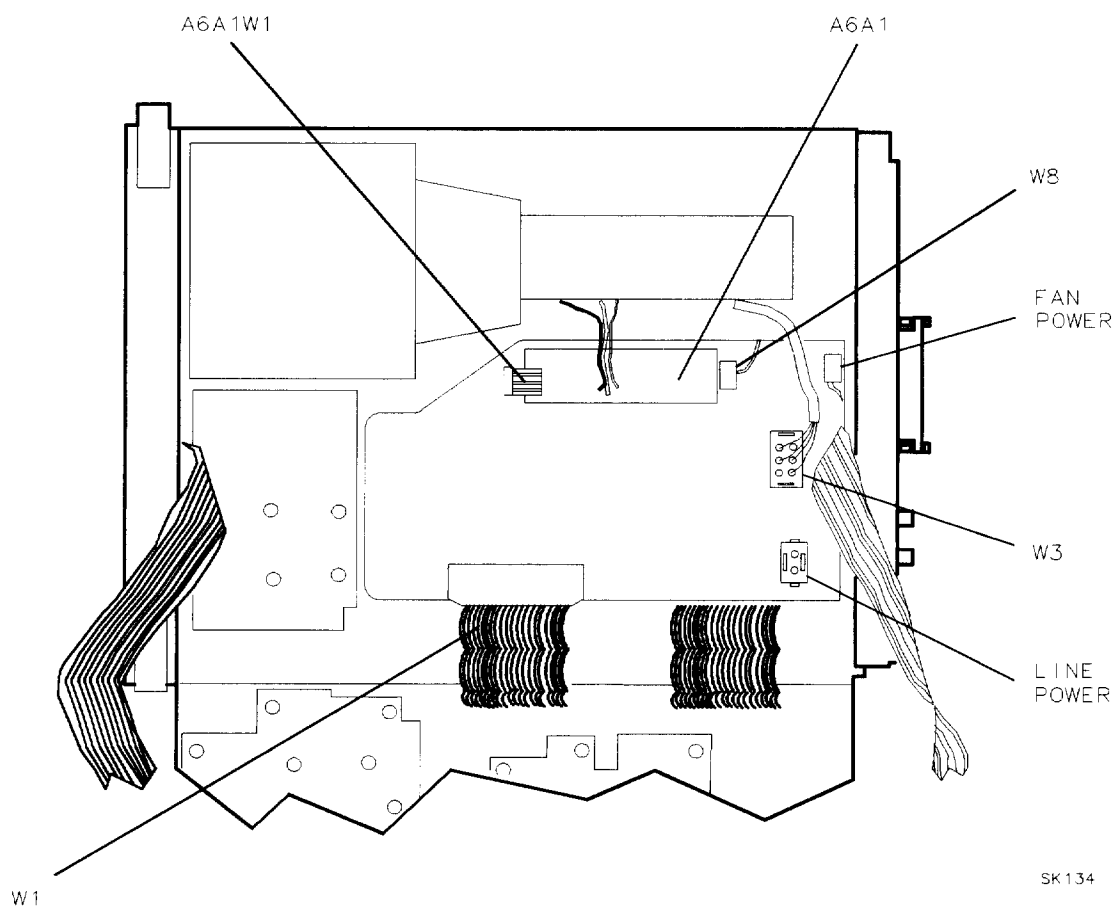
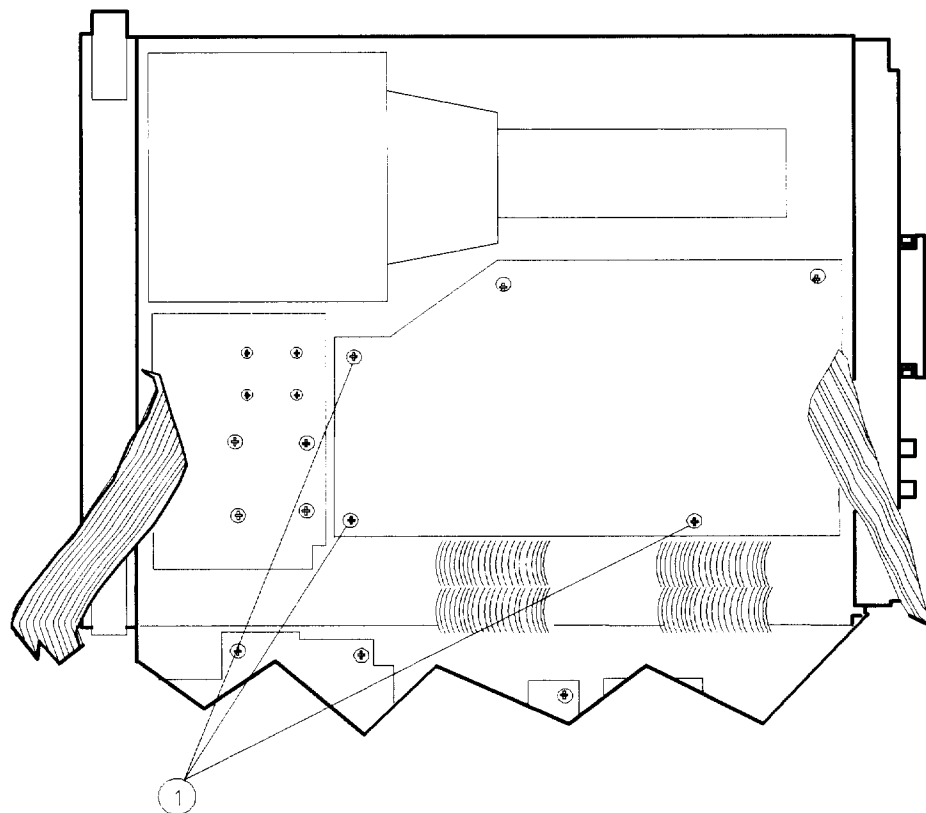


Figure 3-11. A6 Power Supply Connections

Procedure 6. A6 Power Supply Assembly

6. Ensure that all cables are safely routed and will not be damaged when securing the A6 cover.
7. Secure the power supply cover shield to the power supply using three flathead screws (1). See Figure 3-12. One end of the cover fits into a slot provided in the rear frame assembly. Ensure that the extended portion of the cover shield is seated in the shield wall groove.
8. Fold the A2, A3, A4, and A5 assemblies into the spectrum analyzer as described in steps 6 through 12 under "Procedure 5. A2, A3, A4, and A5 Assemblies Replacement."



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Figure 3-12. Power Supply Cover

Procedure 7. A6A1 High Voltage Assembly

Removal

Warning	The A6 power supply and A6A1 high voltage assemblies contain lethal voltages with lethal currents in all areas. Use extreme care when servicing these assemblies. Always disconnect the power cord from the instrument before beginning this replacement procedure. Failure to follow this precaution can represent a shock hazard which may result in personal injury.
----------------	--

1. Disconnect the power cord from the spectrum analyzer.
2. Remove the spectrum analyzer cover assembly as described in "Procedure 1. Spectrum Analyzer Cover."
3. Fold out the A2, A3, A4, and A5 assemblies as described in "Procedure 5. A2, A3, A4, and A5 Assemblies."
4. Place the spectrum analyzer top-side-up on the work bench.

Warning	The voltage potential at A6A1W3 is +9 kV. Disconnect at the CRT with caution! Failure to properly discharge A6A1W3 may result in <i>severe electrical shock</i> to personnel and damage to the instrument.
----------------	---

5. Connect the spectrum analyzer line-power cord to provide proper grounding while discharging the A6A1W3 post-accelerator cable. Make sure that the spectrum analyzer line-power switch is in the off position.
6. Connect a high-voltage probe (1000:1), such as the HP 34111A to a voltmeter with a 10 megohm input.
7. Connect the clip lead of the probe (ground) to the chassis of the spectrum analyzer.
8. Slip the tip of the high-voltage probe under the A6A1W3 post-accelerator cable's rubber shroud to obtain a reading on the voltmeter. See Figure 3-2.
9. Keep the high-voltage probe on the post-accelerator connector until the voltage has dropped to a voltmeter reading of less than 5 mV (less than 5 V at the connector). This normally takes about 30 seconds.
10. Disconnect the line-power cord from the spectrum analyzer.
11. Using a small screwdriver with the shank in contact with the CRT shield assembly, slip the tip of the screwdriver under the A6A1W3 post-accelerator cable's rubber shroud and short the cable to ground on the CRT shield assembly. See Figure 3-2.
12. Pry out the black grommet protecting post-accelerator cable A6A1W3 from the CRT shield assembly.
13. Carefully unsnap the A6A1W3 post-accelerator cable from the CRT and discharge it by shorting the cable to chassis ground on the CRT shield assembly.
14. Remove the three screws securing the power supply shield to the power supply and remove the shield.

Procedure 7. A6A1 High Voltage Assembly

15. Remove the three screws securing the A6A1 high voltage assembly to the A6 power supply assembly.
16. Disconnect ribbon cable A6A1W1 from A6J5. See Figure 3-11.
17. *For Option 007 spectrum analyzers:* Remove the two screws (1) securing two board-mounting posts to the left side frame and remove the posts. See Figure 3-13.
18. Remove the two left side frame screws (2) securing the A17 assembly (and A16 assembly in Option 007). *For Option 007 spectrum analyzers:* Lift up the A16 FADC assembly and swing it out of the spectrum analyzer. Do not remove any cables.
19. Lift up the A17 CRT driver assembly and disconnect A6A1W2 from A17J6. Do not remove any other cables from the A17 assembly.
20. Disconnect the tie wraps from the A6A1 assembly cables and remove the A6A1 high voltage assembly from the spectrum analyzer.

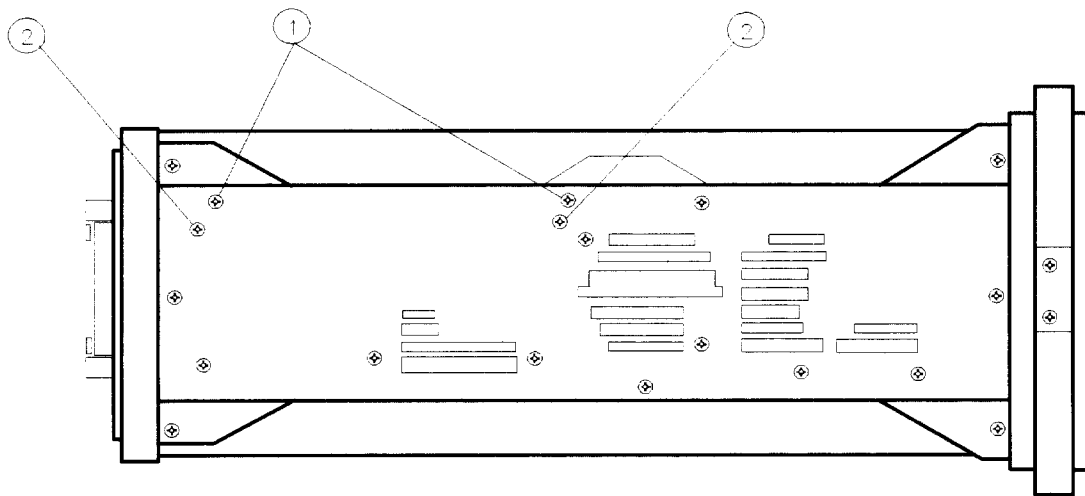


Figure 3-13. A17 CRT Driver Mounting Screws

Replacement

1. Secure the A6A1 high voltage assembly to the A6 power supply using three panhead screws. Connect ribbon cable A6A1W1 to A6J5.
2. Snap post-accelerator cable A6A1W3 to the CRT assembly.
3. Place the black grommet protecting the post-accelerator cable into the CRT shield.
4. Ensure that all cables are safely routed and will not be damaged when securing the A6 cover.
5. Secure the power supply cover shield to the power supply using three flathead screws (1). See Figure 3-12. One end of the cover fits into a slot provided in the rear frame assembly. Ensure that the extended portion of the cover shield is seated in the shield wall groove.
6. Connect A6A1W2 to A17J6.

Procedure 7. A6A1 High Voltage Assembly

7. Place the A17 CRT Driver assembly into the center-deck mounting slot nearest the CRT. Use caution when routing cables to avoid damage.
8. *For Option 007 spectrum analyzers:* Place the A16 FADC assembly into the center-deck mounting slot nearest the left side frame. Ensure that the A16 FADC assembly is properly seated in the right end of the slot.
9. Secure the A17 assembly (and A16 assembly in Option 007) with the two flathead screws removed in step 18 under "Removal." See Figure 3-13 (2).
10. *For Option 007 spectrum analyzers:* Connect the two mounting posts to the left side frame using the two screws removed in step 17 under "Removal." See Figure 3-13 (1).
11. Fold the A2, A3, A4, and A5 assemblies into the spectrum analyzer and secure the spectrum analyzer cover assembly as described in "Procedure 5. A2, A3, A4, and A5 Assemblies."

Procedure 8. A7 through A13 Assemblies

A separate replacement procedure is supplied for each assembly listed below. Before beginning a procedure, do the following:

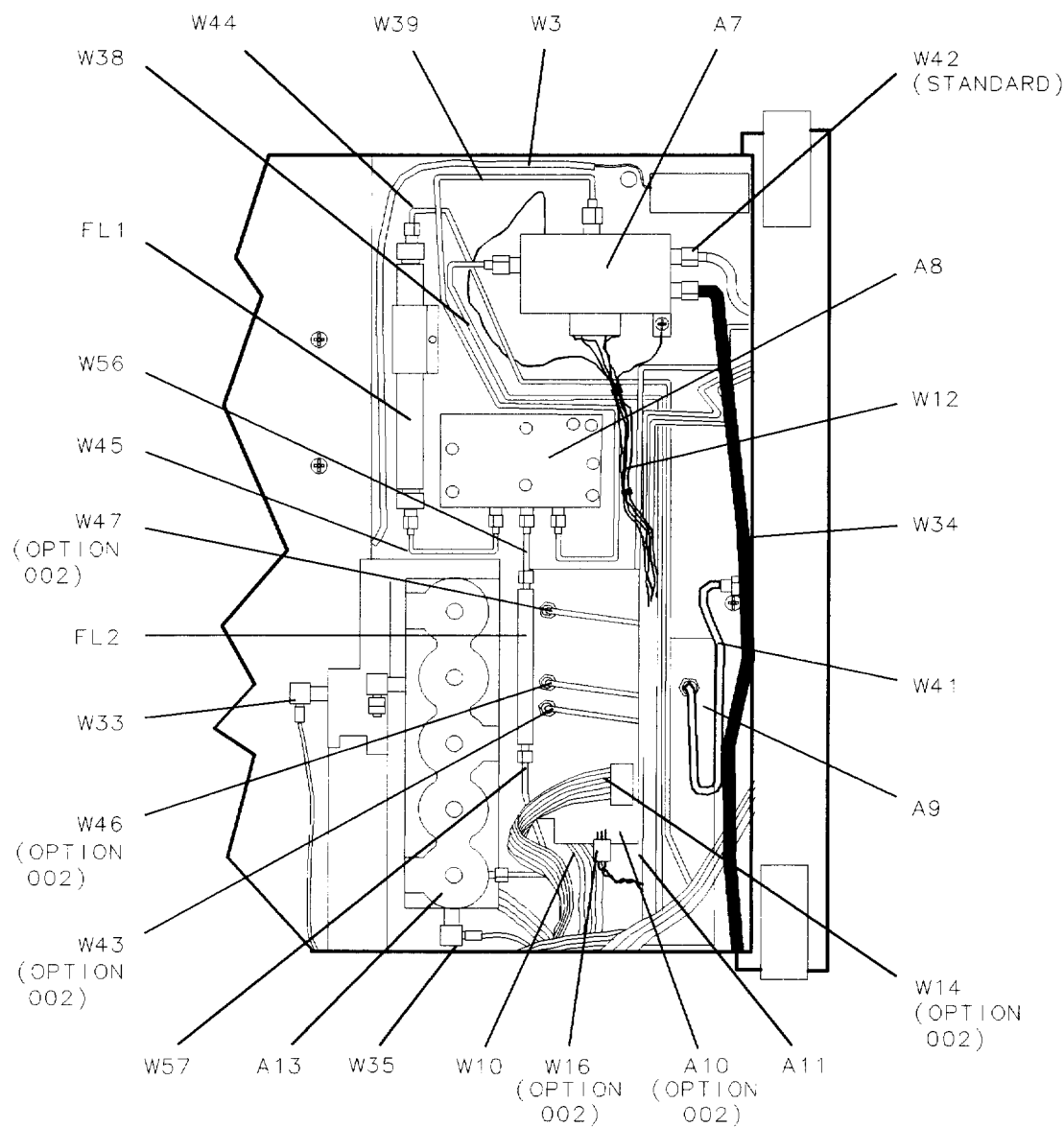
Caution	Turn off the spectrum analyzer power when replacing any of the following assemblies. Failure to turn off the power may result in damage to the assembly being removed.
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- Fold out the A14 and A15 assemblies as described in “Procedure 9. A14 and A15 assemblies.”
- If the A11 YTO or A10 tracking generator (Option 002) assembly is being removed, also fold down the A2, A3, A4, and A5 assemblies as described in “Procedure 5. A2, A3, A4, and A5 assemblies.”

A7 First LO Distribution Amplifier
A8 Low Band Mixer
A9 Input Attenuator
A10 Tracking Generator (Option 002)
A11 YTO
A13 Second Converter

Figure 3-14 illustrates the location of the assemblies and Figure 3-15 provides the colors and locations of the assembly bias wires.

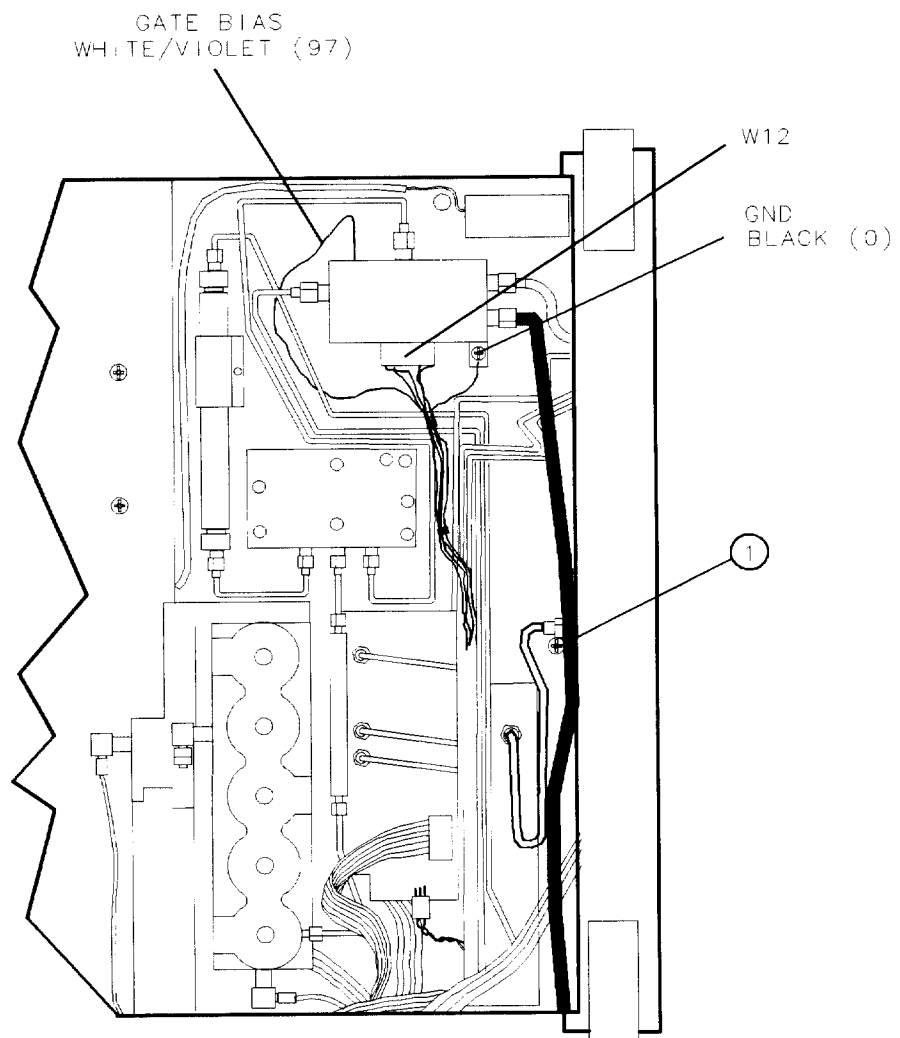
Procedure 8. A7 through A13 Assemblies



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Figure 3-14. Assembly Locations

Procedure 8. A7 through A13 Assemblies



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Figure 3-15. RF Section Bias Connections

Procedure 8. A7 through A13 Assemblies

A7 1st LO Distribution Amplifier

Removal

1. Remove the two screws securing the assembly to the spectrum analyzer center deck.
2. Use a 5/16-inch wrench to disconnect W38 and W39 at A7J1 and J2.
3. Disconnect W42 (W43 on Option 002) at the front-panel 1ST LO OUTPUT connector. Loosen W42 (W43 on Option 002) at A7J3.
4. Remove the gate bias wire, color code 97, and W12 from the A7 assembly.
5. Remove the assembly and disconnect W34.

Replacement

1. Use a 5/16-inch wrench to attach W34 to A7J4 and W42 (W43 on Option 002) to A7J3.
2. Connect gate bias wire, color code 97, to the A7 gate bias connection next to A7J2.
3. Connect cable W12 to the A7 assembly.
4. Place gate bias wire, color code 97, beneath W38 and connect W38 to A7J1. Connect W42 (W43 on Option 002) to the front-panel 1ST LO OUTPUT connector. Connect W39 to A7J2.
5. Use two panhead screws to secure A7 to the center deck. Be sure to attach the ground lug on the screw next to A7J4.
6. Tighten all RF cable connections.

A8 Low Band Mixer

Removal

1. Use a 5/16-inch wrench to remove W45 from FL1 and A8J1.
2. Loosen the semirigid coax cable connections at A8J2 and A8J3.
3. Remove the two screws securing A8 to the center deck.
4. Remove all semirigid coax cables from the A8 assembly.

Replacement

1. Place A8 on the center deck and attach all semirigid cables, starting with A8J3. Use caution to avoid damaging any of the cables' center conductor pins.
2. Use two panhead screws to secure A8 to the center deck. Reconnect W45 to FL1 and A8.
3. Tighten all semirigid coax connections on A8. Ensure that all cable connections are tight.

A9 Input Attenuator

Removal

1. Place the spectrum analyzer upside-down on the work bench.
2. Remove W41 and disconnect W44 from the attenuator.
3. Remove screw (1) securing the attenuator to the front-frame center support.
See Figure 3-15.
4. Remove screw (1) securing the A9 input attenuator to the right side frame.
See Figure 3-16.
5. Remove the attenuator and disconnect the attenuator ribbon cable.

Replacement

1. Connect the attenuator-control ribbon cable to the A9 input attenuator.
2. Place the A9 input attenuator into the spectrum analyzer with the A9 mounting brackets resting against the front-frame center support and the right side frame. Use caution to avoid damaging any cables.
3. Attach the attenuator to the center support with one panhead screw (1). See Figure 3-15.
4. Attach the attenuator to the right side frame, using one flathead screw (1).
See Figure 3-16.
5. Connect semirigid cables W41 and W44 to the attenuator assembly. Connect opposite end of W41 to the front frame.

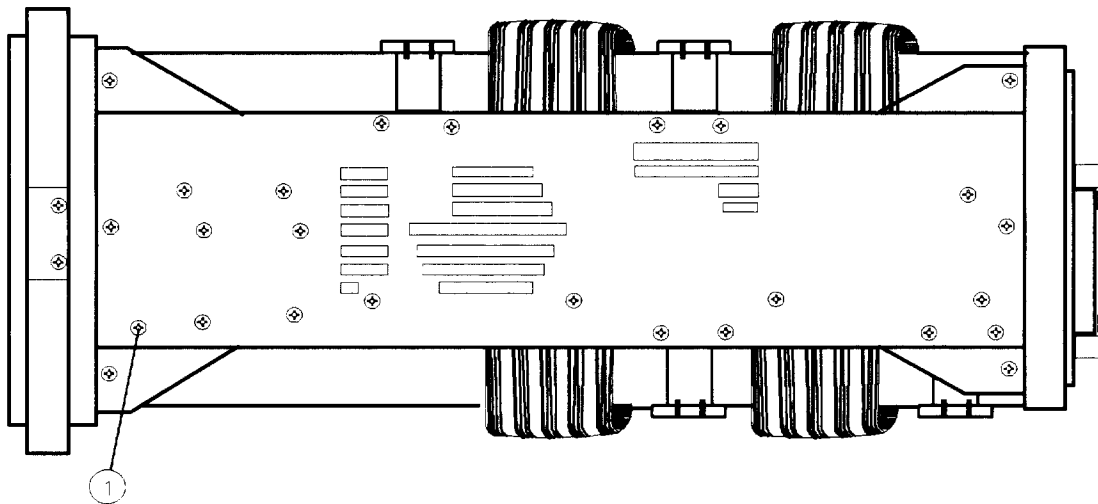


Figure 3-16. A9 Mounting Screws at Right Frame

Procedure 8. A7 through A13 Assemblies

A10 Tracking Generator (Option 002)

Removal

1. Use a 5/16-inch wrench to remove the A10 tracking generator's RF OUT, LO OUT, and LO IN semi-rigid cables.
2. Disconnect W14 and W16 from the A10 tracking generator.
3. Remove the three screws (1) securing the A10 tracking generator to the center deck. These screws are located on the top side of the center deck as illustrated in Figure 3-17.
4. Remove the A10 tracking generator and disconnect W48, coax 80.

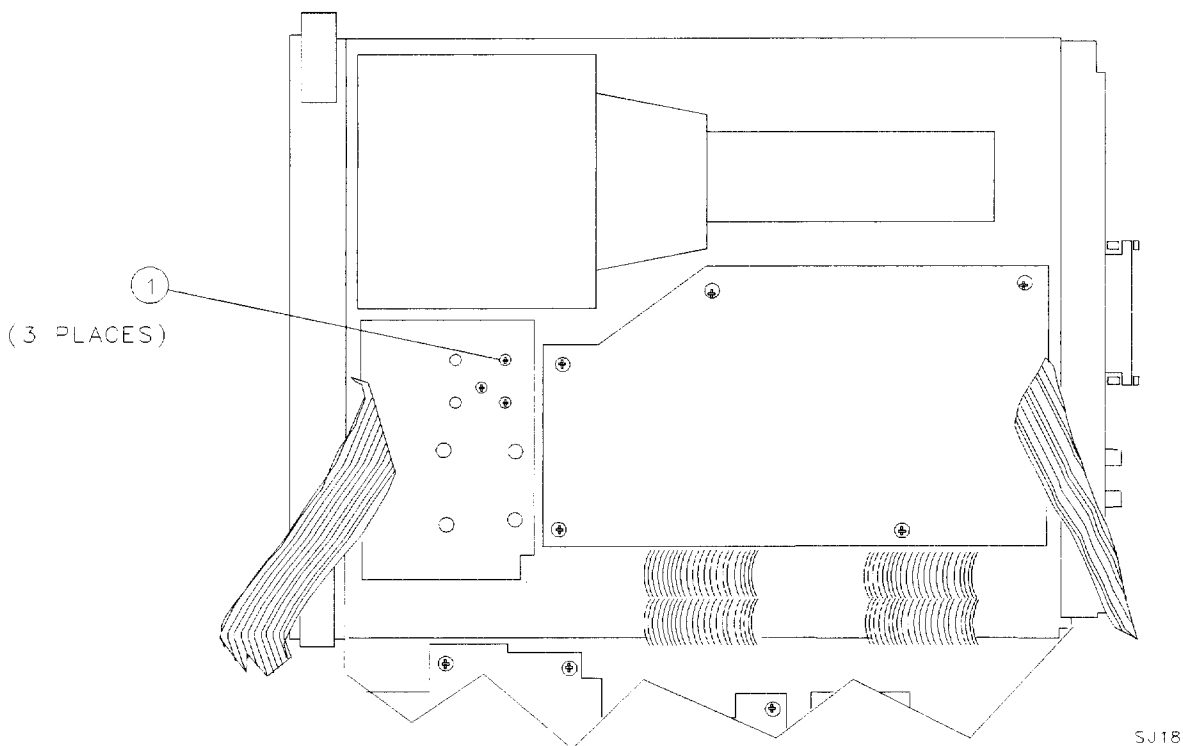


Figure 3-17. A10 Tracking Generator Mounting Screws

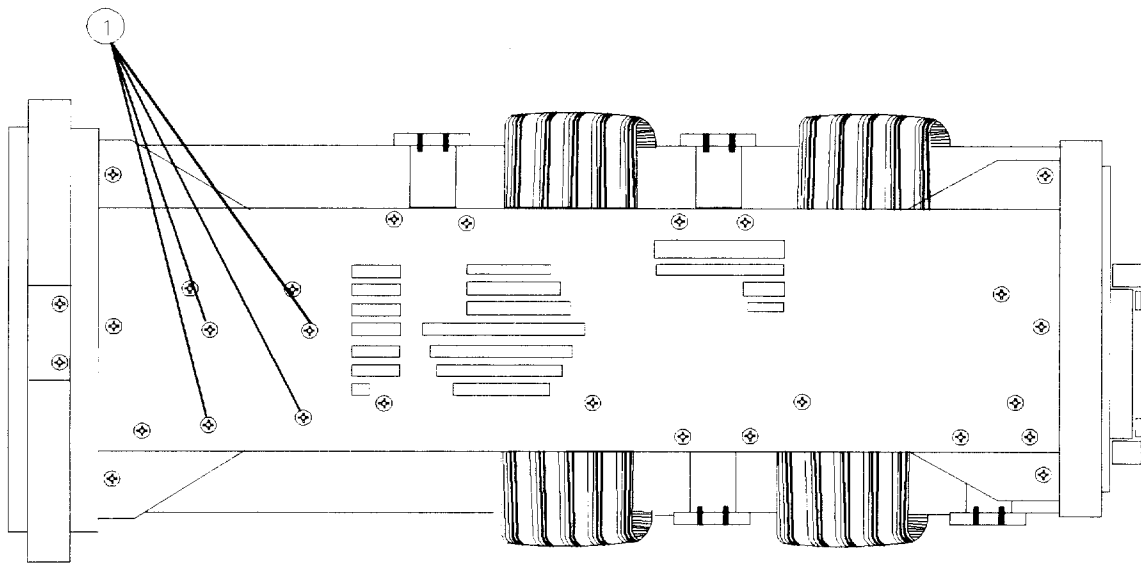
Replacement

1. Connect W48, coax 80, to the A10 tracking generator's INPUT connector.
2. Orient the tracking generator so that its LO IN, LO OUT, and RF OUT connectors are closest to the A13 Second Converter.
3. Loosely connect the LO IN, LO OUT, and RF OUT semi-rigid cables.
4. Secure the A10 tracking generator to the spectrum analyzer center deck using the three screws removed in step 3 under "Removal."
5. Tighten the semi-rigid cables.
6. Connect W14 and W16 to the A10 tracking generator.

A11 YTO

Removal

1. If the spectrum analyzer is an Option 002, remove the A10 tracking generator before proceeding.
2. Place the spectrum analyzer top-side-down on the work bench.
3. Use a 5/16-inch wrench to remove W56/FL2/W57 (as a unit).
4. Disconnect W38 at the A11 assembly.
5. Remove the A11 mounting screws (1) shown in Figure 3-18.
6. Disconnect W10 from A11.



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Figure 3-18. A11 Mounting Screws

Replacement

1. Reconnect W10 to A11.
2. Place the A11 assembly in the spectrum analyzer.
3. Secure the A11 assembly to the right side frame using the four screws (1) removed in step 5 under "Removal."
4. Connect W38 to A11.
5. Install W56/FL2/W57. Ensure that all of the connections are tight.
6. If the spectrum analyzer is an Option 002, install the A10 tracking generator.

Procedure 8. A7 through A13 Assemblies

A13 Second Converter

Caution	Turn off the spectrum analyzer power when replacing the A13 second converter assembly. Failure to turn off the power may result in damage to the assembly.
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Removal

1. Place the spectrum analyzer upside-down on the work bench.
2. Disconnect W33, coax 81, and W35, coax 92, from the A13 assembly.
3. *For Option 002 instruments:* Disconnect W48, coax 8, from A13J3.
4. Disconnect W57 from A13J1.
5. Remove the four screws securing A13 to the main deck and remove the assembly.
6. Disconnect ribbon cable W13 from the A13 assembly.

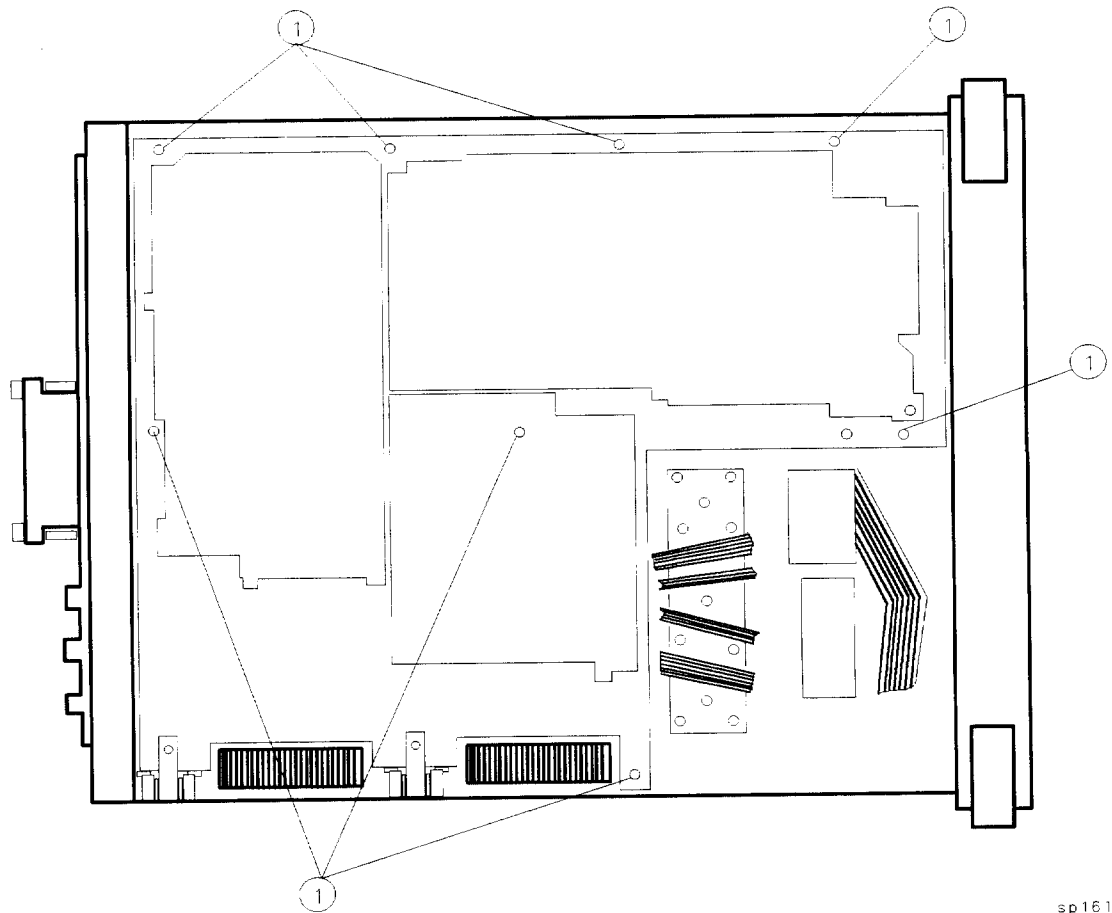
Replacement

1. Connect ribbon cable W13 to the A13 assembly.
2. Secure A13 to the spectrum analyzer main deck, using four panhead screws.
3. Connect W33, coax 81, to A13J4 600 MHz IN jack.
4. Connect W35, coax 92, to A13J2 310.7 MHz OUT jack.
5. *For Option 002 instruments:* Connect W48, coax 8, to A13J3. Route W48 under W35, coax 92.
6. Connect W57 to A13J1. Ensure that all of the cable connections are tight.

Procedure 9. A14 and A15 Assemblies

Removal

1. Remove the spectrum analyzer cover as described in "Procedure 1. Spectrum Analyzer Cover."
2. Place the spectrum analyzer on its right side frame.
3. Remove the eight screws (1) holding the A14 and A15 assemblies to the bottom of the spectrum analyzer. See Figure 3-19.



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Figure 3-19. A14 and A15 Assembly Removal

Procedure 9. A14 and A15 Assemblies

Caution	DO NOT fold the board assemblies out of the spectrum analyzer one at a time. Always fold the A14 and A15 assemblies as a unit. Folding out one assembly at a time binds the hinges attaching the assemblies and may damage an assembly and hinge.
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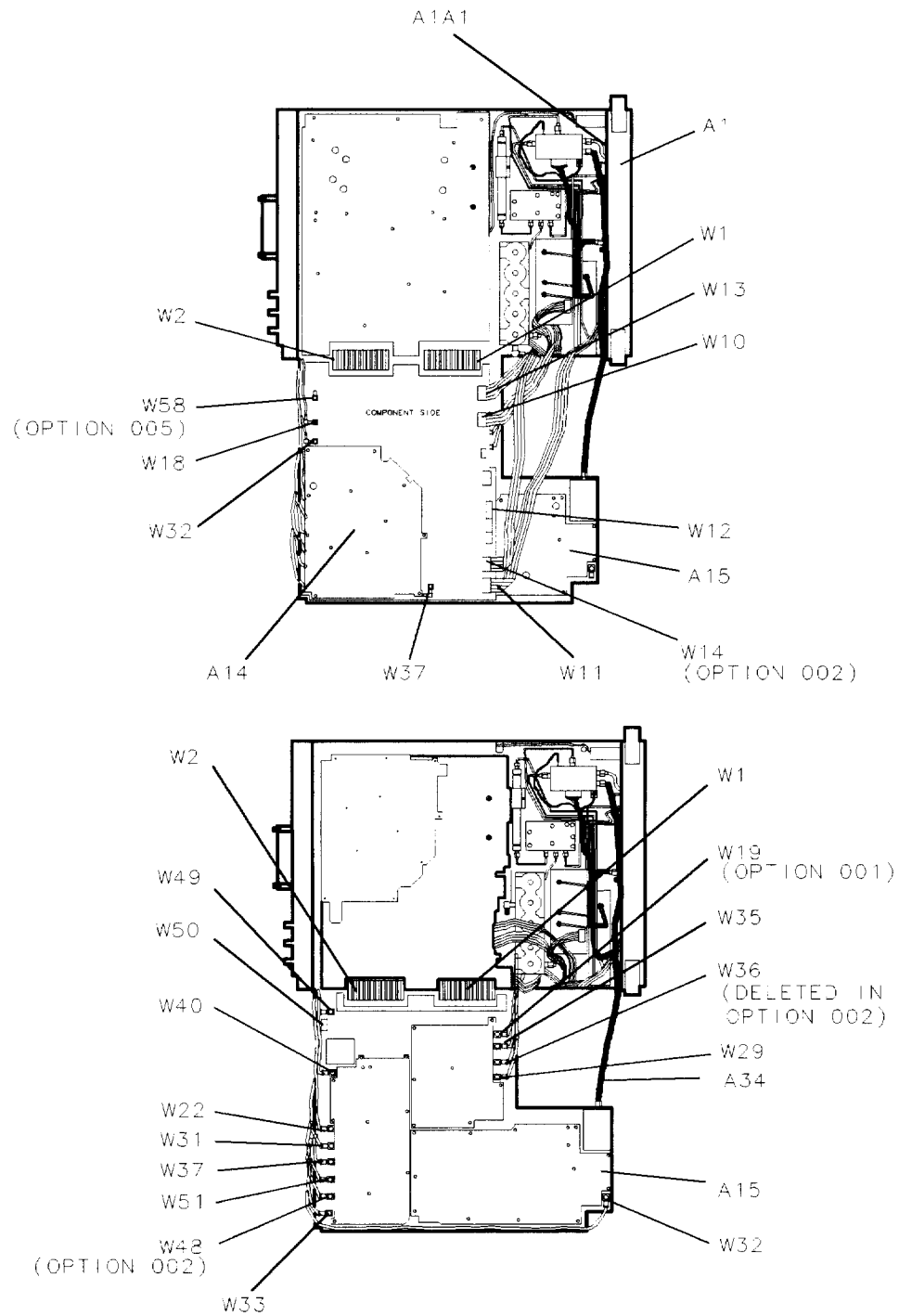
4. The board assemblies are attached to the spectrum analyzer right side frame with two hinges. Fold both the A14 and A15 assemblies out of the spectrum analyzer as a unit.
5. Remove all cables from the assembly being removed.
6. Remove the two screws that attach the assembly being removed to its two mounting hinges.

Caution	DO NOT torque shield screws to more than 8 inch-pounds. Applying excessive torque will cause the screws to stretch.
----------------	---

Replacement

1. Attach the removed assembly to the two chassis hinges with two panhead screws.
2. Attach all cables to the assembly as illustrated in Figure 3-20.
3. Lay the A14 and A15 assemblies flat against each other in the folded out position. Make sure that no cables become pinched between the two assemblies. Ensure that all coaxial cables are clear of hinges and standoffs before continuing onto the next step.
4. Fold both board assemblies into the spectrum analyzer as a unit. Use caution to avoid damaging any cable assemblies.
5. Secure the assemblies using the eight screws removed in step 3 under "Removal." See Figure 3-19.
6. Secure the spectrum analyzer cover assembly as described in "Procedure 1. Spectrum Analyzer Cover."

Procedure 9. A14 and A15 Assemblies



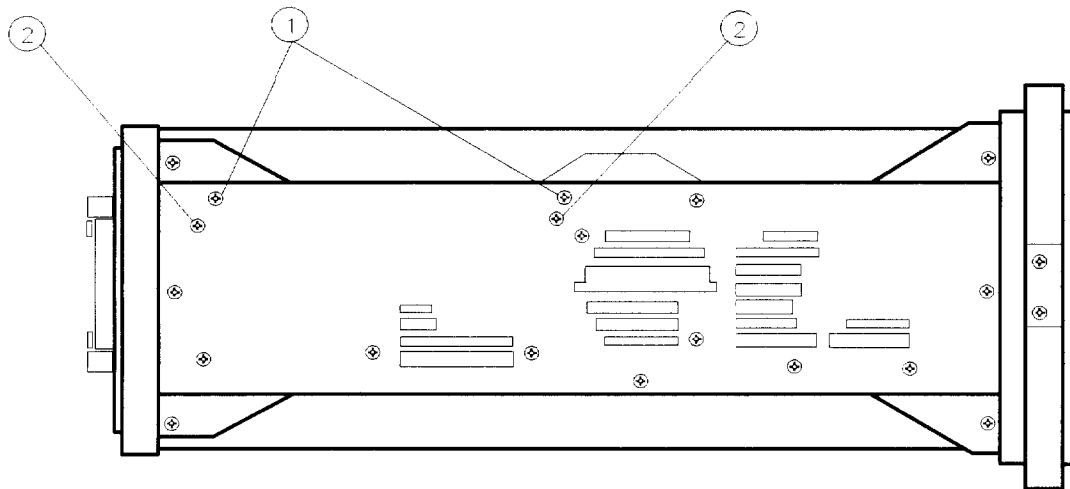
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Figure 3-20. A14 and A15 Assembly Cables

Procedure 10. A16 FADC/A17 CRT Driver

Removal

1. Remove the spectrum analyzer cover assembly and fold out the A2, A3, A4, and A5 assemblies as described in steps 3 through 6 under "Procedure 5. A2, A3, A4, and A5 Assemblies Removal."
2. Place the spectrum analyzer top-side-up on the work bench with A2, A3, A4, and A5 folded out to the right.
3. *For Option 007 spectrum analyzers:* Remove two screws (1) securing the two board-mounting posts to the left side frame, and remove the posts. See Figure 3-21.
4. Remove two screws (2) securing the A17 assembly (and A16 assembly in Option 007) to the left side frame. Remove the two spacers (non-Option 007).
5. Pull the A17 assembly out of the spectrum analyzer.
6. *For Option 007 spectrum analyzers:* Pull the A16 assembly out of the spectrum analyzer.
7. Disconnect W7, W8, W9, A6A1W2, and A18W1 from the A17 CRT driver assembly.
8. *For Option 007 spectrum analyzers:* Disconnect all cables from the A16 FADC assembly.



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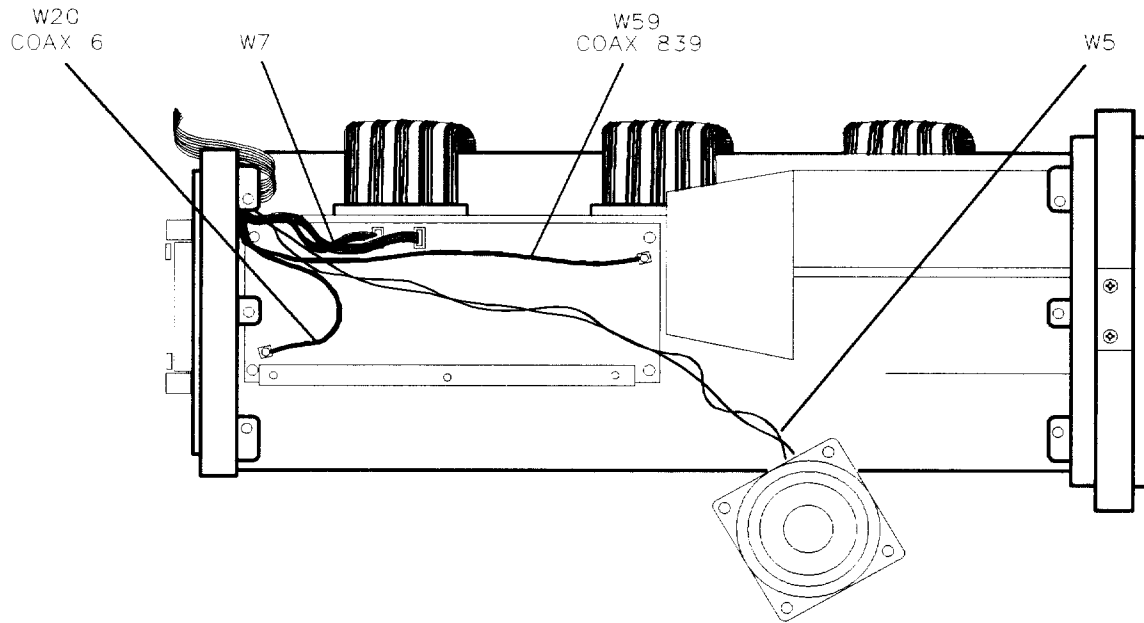
Figure 3-21. A16 and A17 Mounting Screws

Replacement

1. Connect W7, W8, W9, A6A1W2, and A18W1 to the A17 CRT driver assembly. Place the assembly into the center-deck mounting slot next to the CRT assembly.
2. *For Option 007 spectrum analyzers:* Connect all A16 assembly cables as illustrated in Figure 3-22 which shows the left side frame removed so that proper A16 assembly cable routing may be viewed. Place the A16 assembly into the center-deck mounting slot nearest the left side frame.

Procedure 10. A16 FADC/A17 CRT Driver

3. Secure the A17 assembly (and A16 assembly in Option 007) to the left side frame using two flathead screws (and two spacers in non-Option 007). *For Option 007:* Attach the board mounts to the left side frame using two flathead screws (1). See Figure 3-21.
4. Place the spectrum analyzer on its right side frame.
5. Fold the A2, A3, A4, and A5 assemblies into the spectrum analyzer as described in "Procedure 5. A2, A3, A4, and A5 Assemblies." Secure the spectrum analyzer cover assembly.



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Figure 3-22. A16 Cable Routing

Procedure 11. B1 Fan

Removal/Replacement

Warning	Always disconnect the power cord from the instrument before beginning this replacement procedure. Failure to follow this precaution can present a shock hazard which may result in personal injury.
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1. Remove the four screws securing the fan assembly to the rear frame.
2. Remove the fan and disconnect the fan wire from the A6 Power Supply assembly.
3. To reinstall the fan, connect the fan wire to A6J3 and place the wire into the channel provided on the left side of the rear-frame opening. Secure the fan to the rear frame using four panhead screws.

Note	The fan must be installed so that the air enters through the front and sides of the instrument and exits out the rear of the instrument.
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Procedure 12. BT1 Battery

Warning	Battery BT1 contains lithium polycarbon monofluoride. Do not incinerate or puncture this battery. Dispose of discharged battery in a safe manner.
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Caution	To avoid loss of the calibration constants stored on the A2 Controller assembly, connect the spectrum analyzer to the main power source and turn on before removing the battery.
----------------	--

The battery used in this instrument is designed to last several years. An output voltage of +3.0 V is maintained for most of its useful life. Once this voltage drops to +2.6 V, its life and use are limited and the output voltage will deteriorate quickly. When the instrument is turned off, stored states and traces will only be retained for a short time and may be lost. Refer to "State- and Trace-Storage Problems" in Chapter 9, "Controller Section," in this manual. The battery should be replaced if its voltage is +2.6 V or less.

Removal/Replacement

1. Remove any option module attached to the rear panel.
2. Locate the battery assembly cover on the spectrum analyzer rear panel. Use a screwdriver to remove the two flathead screws securing the cover to the spectrum analyzer.
3. Remove the old battery and replace it with the new one, ensuring proper polarity.
4. Measure the voltage across the new battery. Nominal new battery voltage is approximately +3.0 V. If this is not the case, check the battery cable and A2 Controller assembly.
5. Secure the battery assembly into the spectrum analyzer.

Procedure 13. Rear Frame/Rear Dress Panel

Removal

Warning	The A6 power supply and A6A1 high voltage assemblies contain lethal voltages with lethal currents in all areas. Use extreme care when servicing these assemblies. Always disconnect the power cord from the instrument before beginning this replacement procedure. Failure to follow this precaution can present a shock hazard which may result in personal injury.
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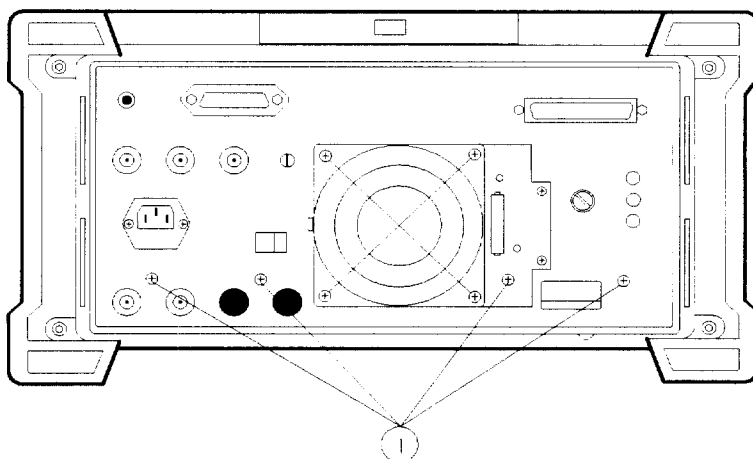
1. Disconnect the line-power cord from the spectrum analyzer.
2. Remove the spectrum analyzer cover as described in procedure 1 and place the spectrum analyzer on its right side frame.
3. Fold out the A2, A3, A4, and A5 assemblies as described in steps 3 through 5 under "Procedure 5. A2, A3, A4, and A5 Assemblies Removal."
4. Disconnect the HP-IB cable at A2J5.
5. Place the spectrum analyzer top-side-up on the work bench with A2 through A5 folded out to the right.

Warning	The voltage potential at A6A1W3 is +9 kV. Disconnect at the CRT with caution! Failure to properly discharge A6A1W3 may result in <i>severe electrical shock</i> to personnel and damage to the instrument.
----------------	---

6. Connect the spectrum analyzer line-power cord to provide proper grounding while discharging the A6A1W3 post-accelerator cable. Make sure that the spectrum analyzer line-power switch is in the off position.
7. Connect a high-voltage probe (1000:1), such as the HP 34111A to a voltmeter with a 10 megohm input.
8. Connect the clip lead of the probe (ground) to the chassis of the spectrum analyzer.
9. Slip the tip of the high-voltage probe under the A6A1W3 post-accelerator cable's rubber shroud to obtain a reading on the voltmeter. See Figure 3-2.
10. Keep the high-voltage probe on the post-accelerator connector until the voltage has dropped to a voltmeter reading of less than 5 mV (less than 5 V at the connector). This normally takes about 30 seconds.
11. Disconnect the line-power cord from the spectrum analyzer.
12. Using a small screwdriver with the shank in contact with the CRT shield assembly, slip the tip of the screwdriver under the A6A1W3 post-accelerator cable's rubber shroud and short the cable to ground on the CRT shield assembly. See Figure 3-2.
13. Remove the three screws securing the power-supply shield to the power supply, and remove the shield. See Figure 3-24.
14. Disconnect the fan and line-power cables from A6J3 and A6J101 on the A6 power supply assembly.

Procedure 13. Rear Frame/Rear Dress Panel

15. Remove the two flathead screws securing the rear-panel battery assembly, and remove the assembly. Remove the battery and unsolder the two wires attached to the battery assembly.
16. Use a 9/16-inch nut driver to remove the dress nuts holding the BNC connectors to the rear frame. If necessary, drill out the nut driver to fit over the BNC connectors, and cover it with heatshrink tubing or tape to avoid scratching the dress panel.
17. *For Option 001 spectrum analyzers:* Use a 5/16-inch wrench to disconnect W19, coax 83, from rear-panel connector J10.
18. *For Option 002 spectrum analyzers:* Unsolder the wire from the center conductor of J11 BNC connector. Use a 9/16-inch wrench to remove J11 from the rear panel.
19. Remove the four screws (1) securing the rear frame to the main deck. See Figure 3-23.
20. Remove the six screws securing the rear frame to the left and right side frames.
21. Remove the knurled nut securing the earphone jack. Carefully remove the jack using caution to avoid losing the nut. Replace the nut onto the jack for safekeeping.
22. Remove the rear-frame assembly.
23. To remove the rear dress panel, remove the two nuts located on the inside of the rear frame near the display adjustment holes.



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Figure 3-23. Main Deck Screws

Replacement

1. If the rear dress panel is removed, secure it to the rear frame using two nuts. Ensure that the dress panel is aligned with the frame.
2. Place the spectrum analyzer on its front panel allowing easy access to the rear-frame area.
3. Place the rear frame on the spectrum analyzer and secure the knurled nut on the earphone jack.

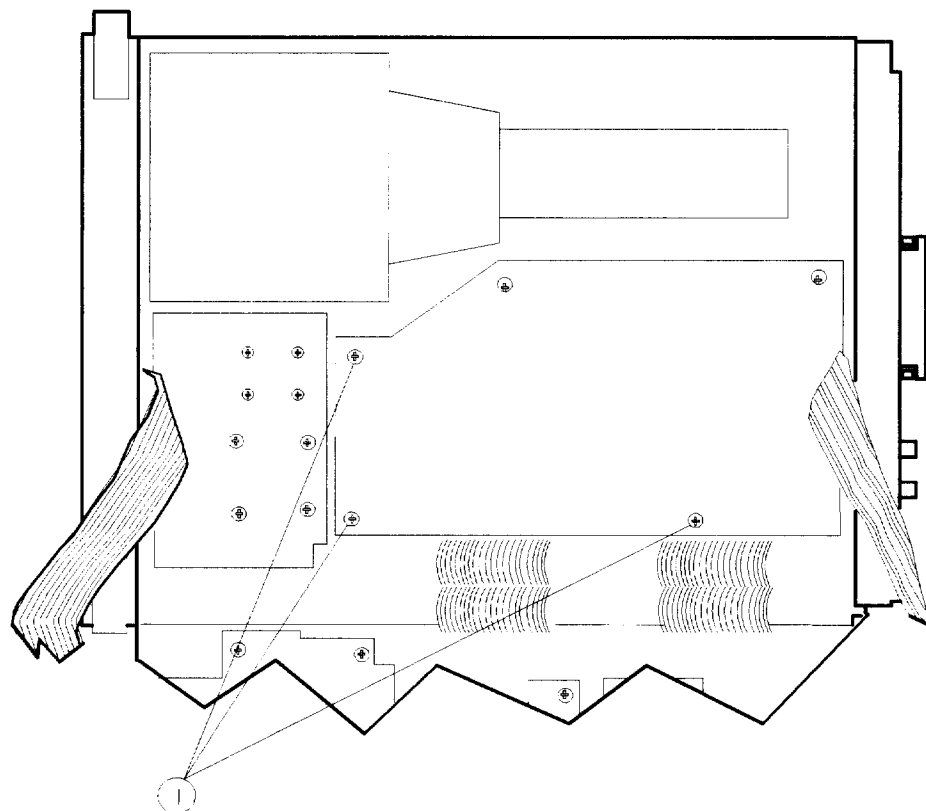
Procedure 13. Rear Frame/Rear Dress Panel

4. Place the coax cable's BNC connectors into the appropriate rear-frame holes as described below. Use a 9/16-inch nut driver to attach the dress nuts holding the BNC connectors to the rear frame.

Rear Panel Jack	RF Cable
J4	W24, coax 5
J5	W23, coax 93
J6	W25, coax 4
J8	W18, coax 97
J9	W31, coax 8
J11	W58, coax 8 (Option 005)

5. *For Option 001 spectrum analyzers:* Use a 5/16-inch wrench to connect W19, coax 83, to rear-panel connector J10.
6. *For Option 002 spectrum analyzers:* Use a 9/16-inch wrench to install J11 on the rear panel. Be sure to place the ground lug of W16 over the threaded body of J11 before installing the nut. Solder the loose wire (P/O W16) to the center conductor of J11.
7. Secure the rear frame to the spectrum analyzer main deck, using four panhead screws (1). See Figure 3-23.
8. Secure the rear frame to the spectrum analyzer side frames using three flathead screws per side. Use caution to avoid damaging any coaxial cables.
9. Place the spectrum analyzer top-side-up on the work bench.
10. Pull the red and black battery wires through the rear-frame's battery-assembly hole. Solder the red wire to the battery-assembly's positive lug and the black wire to the negative lug. Replace the battery.
11. Secure the battery assembly to the rear frame, using two flathead screws.
12. Connect the fan and line-power cables to A6J3 and A6J101 on the A6 Power Supply.
13. Snap the A6A1W3 post-accelerator cable to the CRT assembly.
14. Snap the black grommet protecting A6A1W3 into the CRT shield.
15. Ensure that all cables are safely routed and will not be damaged when securing the A6 cover.
16. Secure the power-supply cover shield to the power supply, using three flathead screws (1). One end of the cover fits into a slot provided in the rear-frame assembly. Ensure that the extended portion of the cover shield is seated in the shield wall groove. See Figure 3-24.
17. Connect the HP-IB cable to A2J5.
18. Fold the A2, A3, A4, and A5 assemblies into the spectrum analyzer as described in procedure 5.

Procedure 13. Rear Frame/Rear Dress Panel



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Figure 3-24. A6 Power Supply Cover

Procedure 14. W3 Line Switch Cable

Removal

Warning **Due to possible contact with high voltages, disconnect the spectrum analyzer line-power cord before performing this procedure.**

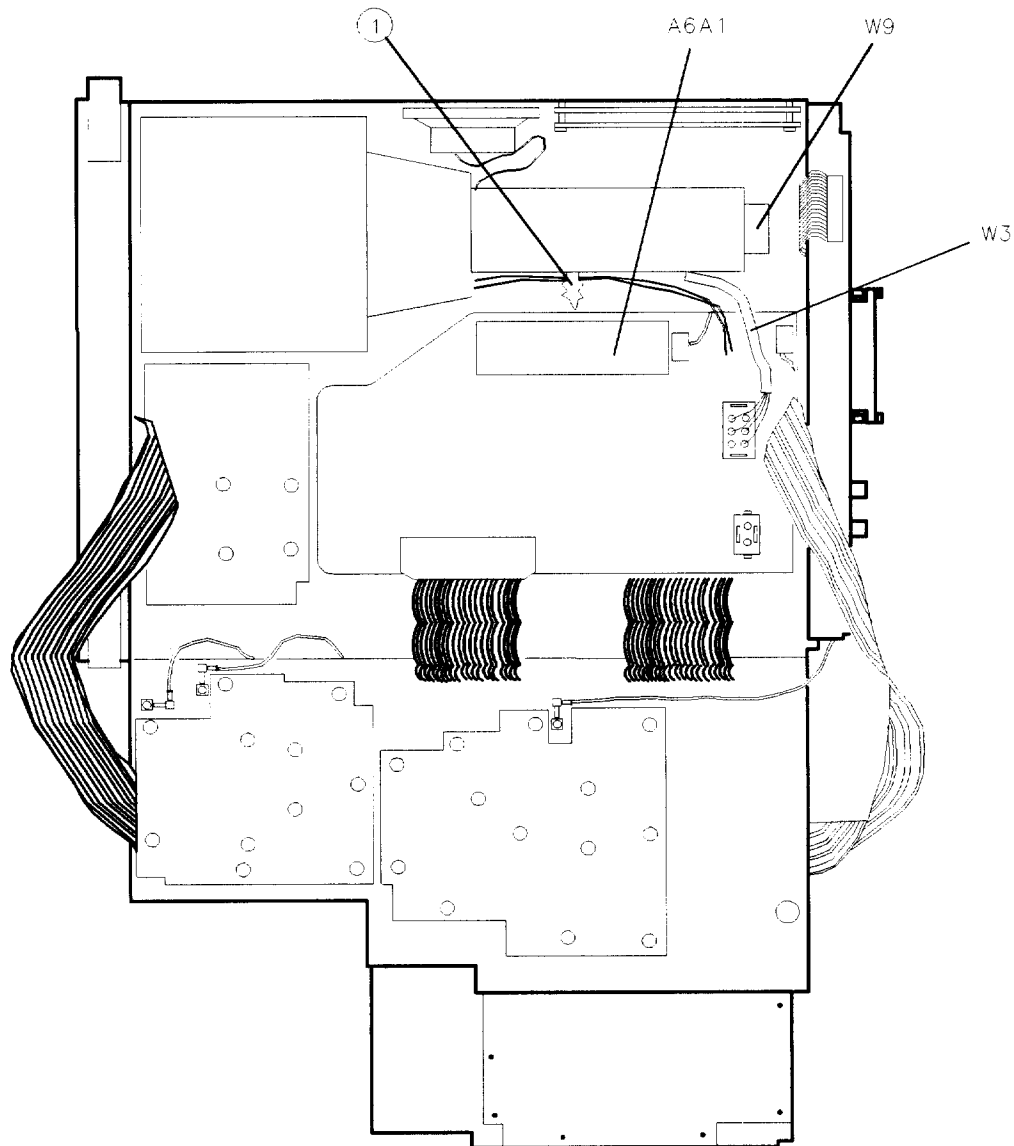
1. Remove the spectrum analyzer cover assembly as described in "Procedure 1. Spectrum Analyzer Cover."
2. Fold out the A2, A3, A4, and A5 assemblies as described in steps 3 through 5 under "Procedure 5. A2, A3, A4, and A5 Assemblies Removal."
3. Disconnect A1A1W1 from A3J602.
4. Place the spectrum analyzer top-side-up on the work bench with A2 through A5 folded out to the right.

Warning **The voltage potential at A6A1W3 is +9 kV. Disconnect at the CRT with caution! Failure to properly discharge A6A1W3 may result in *severe electrical shock* to personnel and damage to the instrument.**

5. Connect the spectrum analyzer line-power cord to provide proper grounding while discharging the A6A1W3 post-accelerator cable. Make sure that the spectrum analyzer line-power switch is in the off position.
6. Connect a high-voltage probe (1000:1), such as the HP 34111A to a voltmeter with a 10 megohm input.
7. Connect the clip lead of the probe (ground) to the chassis of the spectrum analyzer.
8. Slip the tip of the high-voltage probe under the A6A1W3 post-accelerator cable's rubber shroud to obtain a reading on the voltmeter. See Figure 3-2.
9. Keep the high-voltage probe on the post-accelerator connector until the voltage has dropped to a voltmeter reading of less than 5 mV (less than 5 V at the connector). This normally takes about 30 seconds.
10. Disconnect the line-power cord from the spectrum analyzer.
11. Using a small screwdriver with the shank in contact with the CRT shield assembly, slip the tip of the screwdriver under the A6A1W3 post-accelerator cable's rubber shroud and short the cable to ground on the CRT shield assembly. See Figure 3-2.
12. Remove the three screws securing the power supply shield to the power supply, and remove the shield.
13. Pull the cable tie (1), Figure 3-25, to free W9 and the post-accelerator cables.
14. Disconnect W3 from A6J2.
15. Pull W3 up from between the power supply and the CRT assembly to release it from the cable clamp.
16. Place the spectrum analyzer on its right side frame.

Procedure 14. W3 Line Switch Cable

17. Fold out the A14 and A15 assemblies as described in steps 3 and 4 under "Procedure 9. A14 and A15 Assemblies Removal."
18. Loosen the screw (1) securing W3, the line switch assembly, to the front frame. The screw is captive. See Figure 3-26.



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Figure 3-25. W3 Dress and Connection to A6 Power Supply

19. Remove A1W1 and A1W1DS1 from the line-switch assembly. Let each hang freely.

Note

If contact removal tool, HP part number 8710-1791, is available, complete assembly removal by performing "Removal" steps 20 and 21. If not, skip to step 23 under "Removal."

Procedure 14. W3 Line Switch Cable

20. With wire cutters, clip the tie wrap holding the cable to the contact housing. From the top side of the spectrum analyzer, use contact removal tool, HP part number 8710-1791, to remove the four wires from the W3 connector. See Figure 3-27.
21. Completely remove the cable from the instrument.
22. Remove the A1 front-frame assembly and A18 CRT assembly as described in steps 16 through 29 under "Procedure 2. A1 Front Frame/A18 CRT Removal."
23. Remove the left side frame from the spectrum analyzer. See Figure 3-28. (The side frame will still be attached by the speaker wires. Do not let it hang freely.)
24. Remove the line-switch cable assembly.

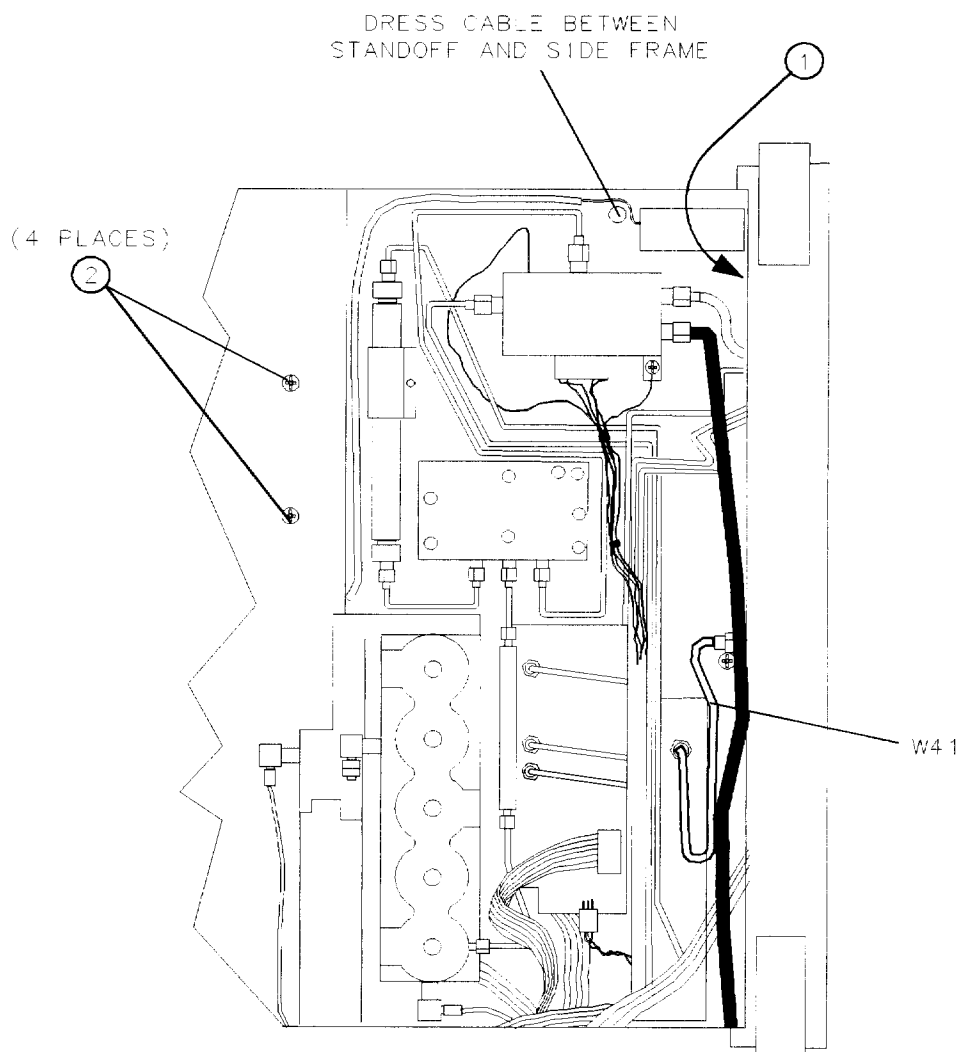
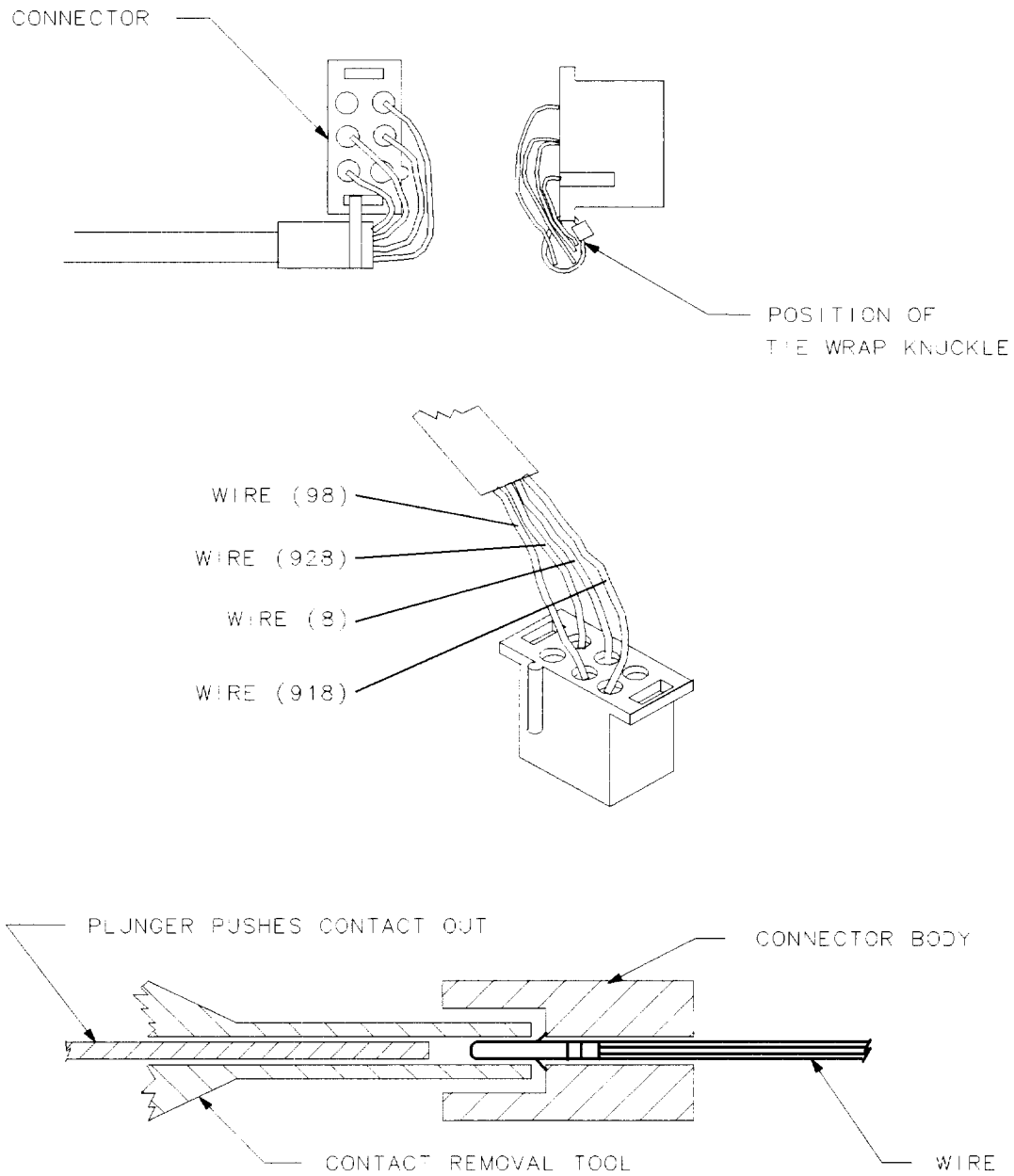


Figure 3-26. Line Switch Mounting Screw and Cable Dress

Procedure 14. W3 Line Switch Cable



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Figure 3-27. W3 Cable Connector

Procedure 14. W3 Line Switch Cable

Replacement (Using Contact Removal Tool, HP Part Number 8710-1791)

1. Ensure that the action of the switch is working properly. With a pair of wire cutters, clip the tie wrap holding the cable to the contact housing of the replacement W3 assembly.
2. Using the contact removal tool, remove the four wires from the replacement cable assembly's connector.
3. From the bottom side of the spectrum analyzer, insert the contact end of W3 through the slotted opening in the main deck. W3 should come through to the top side of the spectrum analyzer between the A18 CRT assembly and the post-accelerator cable.
4. Place LED A1W1DS1 into the line-switch assembly.
5. Attach the line-switch assembly into the front frame, using the captive panhead screw. Ensure the connection of the line-switch grounding lug to the screw.
6. Dress W3 between the main deck standoff and the side frame. See Figure 3-26.
7. On the top side of the spectrum analyzer, redress W3.
8. Insert the four contacts into the W3 connector.
9. Attach the cable to the connector housing using the supplied tie wrap.
10. Connect W3 to A6J2. Dress W3 into the slotted opening in the deck.
11. Connect A1A1W1 to A3J602.
12. Secure the power-supply cover shield to the power supply, using three flathead screws. One end of the cover fits into a slot provided in the rear-frame assembly. Ensure that the extended portion of the cover shield is seated in the shield wall groove.
13. Redress W3 and the other cable assemblies down between the CRT assembly and the power supply cover such that the W9 wires are below the surface of the power-supply cover.
14. Fold up the A2, A3, A4, and A5 assemblies into the spectrum analyzer as described in steps 5 through 10 under "Procedure 5. A2, A3, A4, and A5 Assemblies Replacement."
15. Fold up A14 and A15 assemblies as described in steps 9 through 11 under "Procedure 9. A14 and A15 Assemblies Replacement."

Replacement (without Contact Removal Tool)

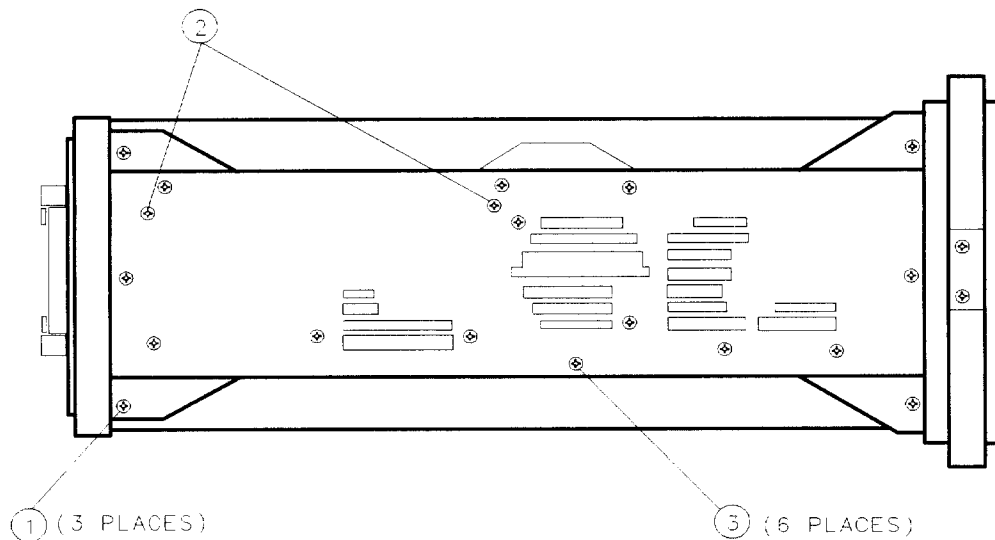
1. Lay the replacement line-switch cable assembly between the side frame and main deck. Ensure that the action of the switch is working properly.
2. Attach the left side frame to the deck and rear frame. See Figure 3-28.

Screw	Quantity
(1) SCREW-MACH M4 X 0.7 8 mm-LG FLAT HD	3
(2) SCREW-MACH M3 X 0.5 35 mm-LG FLAT HD	2
(3) SCREW-MACH M3 X 0.5 6 mm-LG FLAT HD	6

3. Dress W3 between the main deck standoff and the side frame. See Figure 3-26.
4. Attach the A1 Front Frame assembly and the A18 CRT assembly as described in steps 1 through 16 under "Procedure 2. A1 Front Frame/A18 CRT Replacement."
5. Place LED A1W1DS1 into the line-switch assembly.

Procedure 14. W3 Line Switch Cable

6. Attach the line-switch assembly into the front frame using the captive panhead screw. Ensure the connection of the line-switch grounding lug to the screw.



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Figure 3-28. Side Frame Mounting Screws

7. On the top side of the spectrum analyzer, redress W3.
8. Connect W3 to A6J2. Dress W3 into the slotted opening in the deck.
9. Connect A1A1W1 to A3J602.
10. Secure the power-supply cover shield to the power supply using three flathead screws. One end of the cover fits into a slot provided in the rear-frame assembly. Ensure that the extended portion of the cover shield is seated in the shield wall groove. See Figure 3-24.
11. Place W3 and the other cable assemblies between the CRT assembly and the power supply cover so the W9 wires are below the surface of the power-supply cover.
12. Fold up the A2, A3, A4, and A5 assemblies into the spectrum analyzer as described in steps 5 through 10 under "Procedure 5. A2, A3, A4, and A5 Assemblies Replacement."
13. Fold up A14 and A15 assemblies as described in steps 3 through 5 under "Procedure 9. A14 and A15 Assemblies Replacement."
14. Replace the spectrum analyzer cover assembly.
15. Connect the line-power cord and switch the spectrum analyzer power on. If the spectrum analyzer does not operate properly, turn off the spectrum analyzer power, disconnect the line cord, and recheck the spectrum analyzer.

Procedure 15. EEROM (A2U501)

Removal/Replacement

Caution The EEROM is replaced with the power on. Use a nonmetallic tool to remove the defective EEROM and install the new EEROM.

1. Turn the HP 8560E **LINE** switch off. Remove the spectrum analyzer cover assembly and fold out the A2, A3, A4, and A5 assemblies as described in steps 3 through 5 under "Procedure 5. A2, A3, A4, and A5 Assemblies Removal."
2. Turn the HP 8560E **LINE** switch on.
3. Set the WR PROT/WR ENA jumper on the A2 Controller Assembly to the WR ENA position.
4. Press **CAL**, **MORE 1 OF 2**, **SERVICE CAL DATA**, **COPY EEROM**, and **COPY TO EEROM**. The spectrum analyzer will store the contents of the EEROM into the program RAM.
5. Using a nonmetallic tool, carefully remove the defective EEROM.
6. Carefully install a new EEROM.
7. Press **COPY TO EEROM**. The spectrum analyzer will store the contents of the program RAM into the new EEROM.
8. Turn the HP 8560E **LINE** switch off, then on, cycling the spectrum analyzer power. Allow the power-on sequence to finish.
9. If error message 701, 702, or 703 is displayed, press **RECALL**, **MORE**, and **RECALL ERRORS**. Use the STEP keys to view any other errors.
10. If error message 701 or 703 is displayed, perform Adjustment 9, "Frequency Response Adjustment" in Chapter 2. (If a TAM is available, perform the module's "Low Band Flatness" adjustment. Press **MODULE**, **ADJUST** to enter the adjust menu of the TAM.)
11. If there are no errors after cycling the spectrum analyzer power, the EEROM is working properly, but the frequency-response correction data might be invalid. Check the spectrum analyzer frequency response.
12. Place the WR PROT/WR ENA jumper in the WR PROT position.
13. Fold the A2 and A3 assemblies into the spectrum analyzer as described in "Procedure 5. A2, A3, A4, and A5 Assemblies." Secure the spectrum analyzer cover assembly.

Procedure 16. A21 OCXO

Removal

1. Remove the rear-frame assembly as described in steps 1 through 22 under "Procedure 13. Rear Frame/Rear Dress Panel Removal," steps 1 through 22.
2. Place the spectrum analyzer on its right side frame.
3. Fold out the A14 and A15 assemblies as described in steps 3 and 4 under "Procedure 9. A14 and A15 Assemblies Removal."
4. Remove the three screws (1) and three shoulder washers securing the OCXO to the main deck. See Figure 3-29.
5. Disconnect W49, coax 82, from the OCXO and disconnect W50 (orange cable) from the A15 RF assembly. Clip the tie wraps that hold W49 and W50 together and remove the OCXO and insulator from the spectrum analyzer (leaving the orange cable connected).

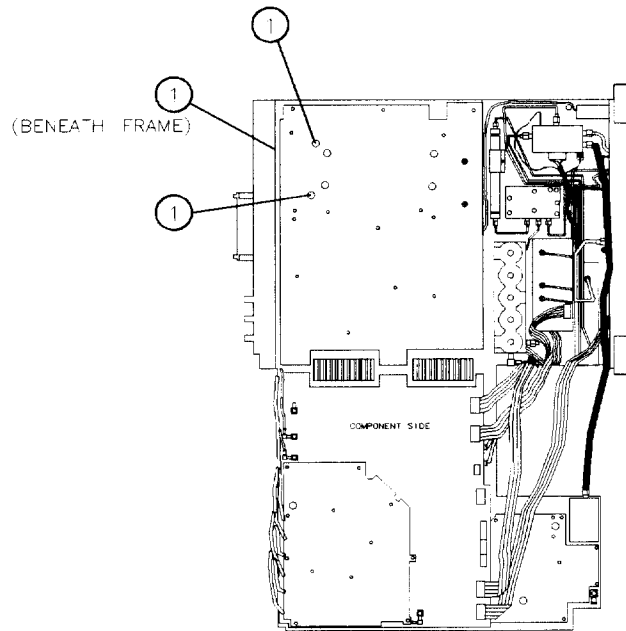


Figure 3-29. A21 OCXO Mounting Screws

Replacement

1. Connect W49, coax 82, to the OCXO and position the OCXO and insulator in the spectrum analyzer. Dress W50 (orange cable) next to W49 through the opening in the deck.
2. Secure the OCXO to the spectrum analyzer main deck using three screws (1) and three shoulder washers. See Figure 3-29.
3. Fold the A14 and A15 assemblies into the spectrum analyzer as described in procedure 9.
4. Perform the rear-frame assembly replacement procedure described in procedure 13.

Replaceable Parts

This chapter contains information on ordering all replaceable parts and assemblies. Locate the instrument parts in the following figures and tables:

Table 4-1. Reference Designations, Abbreviations and Multipliers

Table 4-2. Manufacturers Code List

Table 4-3. Replaceable Parts

Figure 4-1. Parts Identification, Assembly Mounting

Figure 4-2. Parts Identification, Cover Assembly

Figure 4-3. Parts Identification, Main Chassis

Figure 4-4. Parts Identification, RF Section

Figure 4-5. Parts Identification, Front Frame

Figure 4-6. Parts Identification, Rear Frame

Ordering Information

To order a part or assembly, quote the Hewlett-Packard part number (with check digit), indicate the quantity required, and address the order to the nearest HP Sales and Service office. The check digit will ensure accurate and timely processing of your order.

To order a part that is not listed in the replaceable parts table, include the instrument model number, the description and function of the part, and the number of parts required. Address the order to the nearest HP Sales and Service office.

Direct Mail-Order System

Within the USA, Hewlett-Packard can supply parts through a direct mail-order system. Advantages of using the system are as follows:

- Direct ordering and shipment from the HP Support Materials Organization in Roseville, California.
- No maximum or minimum on any mail order. (There is a minimum order amount for parts ordered through a local HP Sales and Service office when the orders require billing and invoicing.)
- Prepaid transportation. (There is a small handling charge for each order.)
- No invoices.

To provide these advantages, a check or money order must accompany each order. Mail-order forms and specific ordering information is available through your local Hewlett-Packard Sales and Service office.

Direct Phone-Order System

Within the USA, a phone order system is available for regular and hotline replacement parts service. A toll-free phone number is available, and Mastercard and Visa are accepted.

Regular Orders: The toll-free phone number, (800) 227-8164, is available 6 am to 5 pm, Pacific standard time, Monday through Friday. Regular orders have a four-day delivery time.

Hotline Orders: Hotline service for ordering emergency parts is available 24 hours a day, 365 days a year. There is an additional hotline charge to cover the cost of freight and special handling.

The toll-free phone number is (800) 227-8164, is available 6 am to 5 pm, Pacific standard time, Monday through Friday and (916) 785-8HOT for after hours, weekends, and holidays. Hotline orders are normally delivered the following business day.

Parts List Format

The following information is listed for each part:

1. The Hewlett-Packard part number.
2. The part number check digit (CD).
3. The total quantity (Qty) in the assembly. This quantity is given only once, at the first appearance of the part in the list.
4. The description of the part.
5. A five-digit code indicating a typical manufacturer of the part.
6. The manufacturer part number.

Firmware-Dependent Part Numbers

Refer to the following firmware note, part number 5961-6734:

HP 8560 Series, HP 85620A, and HP 85629B Firmware Note.

Table 4-1. Reference Designations, Abbreviations and Multipliers

REFERENCE DESIGNATIONS					
A	Assembly	F	Fuse	RT	Thermistor
AT	Attenuator, Isolator, Limiter, Termination	FL	Filter	S	Switch
B	Fan, Motor	HY	Circulator	T	Transformer
BT	Battery	J	Electrical Connector (Stationary Portion), Jack	TB	Terminal Board
C	Capacitor	K	Relay	TC	Thermocouple
CP	Coupler	L	Coil, Inductor	TP	Test Point
CR	Diode, Diode Thyristor, Step Recovery Diode, Varactor	M	Meter	U	Integrated Circuit, Microcircuit
DC	Directional Coupler	MP	Miscellaneous Mechanical Part	V	Electron Tube
DL	Delay Line	P	Electrical Connector (Movable Portion), Plug	VR	Breakdown Diode (Zener), Voltage Regulator
DS	Annunciator, Lamp, Light Emitting Diode (LED), Signaling Device (Visible)	Q	Silicon Controlled Rectifier (SCR), Transistor, Triode Thyristor	W	Cable, Wire, Jumper
E	Miscellaneous Electrical Part	R	Resistor	X	Socket
				Y	Crystal Unit (Piezoelectric, Quartz)
				Z	Tuned Cavity, Tuned Circuit
ABBREVIATIONS					
A		BSC	Basic	CNDCT	Conducting, Conductive, Conductivity, Conductor
A	Across Flats, Acrylic, Air (Dry Method), Ampere	BTN	Button	CONT	Contact, Continuous, Control, Controller
ADJ	Adjust, Adjustment	C		CONV	Converter
ANSI	American National Standards Institute (formerly USASI-ASA)	C	Capacitance, Capacitor, Center Tapped, Cermet, Cold, Compression	CPRSN	Compression
ASSY	Assembly	CCP	Carbon Composition Plastic	CUP-PT	Cup Point
AWG	American Wire Gage	CD	Cadmium, Card, Cord	CW	Clockwise, Continuous Wave
B		CER	Ceramic	D	
BCD	Binary Coded Decimal	CHAM	Chamfer	D	Deep, Depletion, Depth, Diameter, Direct Current
BD	Board, Bundle	CHAR	Character, Characteristic, Charcoal	DA	Darlington
BE-CU	Beryllium Copper	CMOS	Complementary Metal Oxide Semiconductor		

Reference Designations, Abbreviations, and Multipliers (2 of 4)

ABBREVIATIONS					
DAP-GL	Diallyl Phthalate Glass	FT	Current Gain Bandwidth Product (Transition Frequency), Feet, Foot	JFET	Junction Field Effect Transistor
DBL	Double				K
DCDR	Decoder				
DEG	Degree				
D-HOLE	D-Shaped Hole	FXD	Fixed	K	Kelvin, Key, Kilo, Potassium
DIA	Diameter		G	KNRLD	Knurled
DIP	Dual In-Line Package			KVDC	Kilovolts Direct Current
DIP-SLDR	Dip Solder	GEN	General, Generator		
D-MODE	Depletion Mode	GND	Ground		
DO	Package Type Designation	GP	General Purpose, Group		L
DP	Deep, Depth, Dia- metric Pitch, Dip			LED	Light Emitting Diode
DP3T	Double Pole Three Throw		H	LG	Length, Long
DPDT	Double Pole Double Throw	H	Henry, High	LIN	Linear, Linearity
DWL	Dowell	HDW	Hardware	LK	Link, Lock
	E	HEX	Hexadecimal, Hexagon, Hexagonal	LKG	Leakage, Locking
		HLCL	Helical	LUM	Luminous
E-R	E-Ring	HP	Hewlett-Packard Company, High Pass		M
EXT	Extended, Extension, External, Extinguish			M	Male, Maximum, Mega, Mil, Milli, Mode
	F		I	MA	Milliampere
F	Fahrenheit, Farad, Female, Film (Resistor), Fixed, Flange, Frequency	IC	Collector Current, Integrated Circuit	MACH	Machined
		ID	Identification, Inside Diameter	MAX	Maximum
FC	Carbon Film/ Composition, Edge of Cutoff Frequency, Face	IF	Forward Current, Intermediate Frequency	MC	Molded Carbon Composition
		IN	Inch	MET	Metal, Metallized
FDTHRU	Feedthrough	INCL	Including	MHZ	Megahertz
FEM	Female	INT	Integral, Intensity, Internal	MINTR	Miniature
FIL-HD	Fillister Head			MIT	Miter
FL	Flash, Flat, Fluid		J	MLD	Mold, Molded
FLAT-PT	Flat Point			MM	Magnetized Material, Millimeter
FR	Front	J-FET	Junction Field Effect Transistor	MOM	Momentary
FREQ	Frequency			MTG	Mounting
				MTLC	Metallic
				MW	Milliwatt

Reference Designations, Abbreviations, and Multipliers (3 of 4)

ABBREVIATIONS					
N		PLSTC	Plastic	SMA	Subminiature,
		PNL	Panel		A Type (Threaded
N	Nano, None	PNP	Positive Negative		Connector)
N-CHAN	N-Channel		Positive (Transistor)	SMB	Subminiature,
NH	Nanohenry	POLYC	Polycarbonate		B Type (Slip-on
NM	Nanometer,	POLYE	Polyester		Connector)
	Nonmetallic	POT	Potentiometer	SMC	Subminiature,
NO	Normally Open,	POZI	Pozidriv Recess		C-Type (Threaded
	Number	PREC	Precision		Connector)
NOM	Nominal	PRP	Purple, Purpose	SPCG	Spacing
NPN	Negative Positive	PSTN	Piston	SPDT	Single Pole
	Negative (Transistor)	PT	Part, Point,		Double Throw
NS	Nanosecond,		Pulse Time	SPST	Single Pole
	Non-Shorting, Nose	PW	Pulse Width		Single Throw
NUM	Numeric			SQ	Square
NYL	Nylon (Polyamide)			SST	Stainless Steel
O		Q		STL	Steel
		Q	Figure of Merit	SUBMIN	Subminiature
OA	Over-All			SZ	Size
OD	Outside Diameter	R			
OP AMP	Operational			T	
	Amplifier	R	Range, Red,		
OPT	Optical, Option,		Resistance, Resistor,	T	Teeth,
	Optional		Right, Ring		Temperature,
		REF	Reference		Thickness, Time,
	P	RES	Resistance, Resistor		Timed, Tooth,
PA	Picoampere, Power	RF	Radio Frequency		Typical
	Amplifier	RGD	Rigid	TA	Ambient
PAN-HD	Pan Head	RND	Round		Temperature,
PAR	Parallel, Parity	RR	Rear		Tantalum
PB	Lead (Metal),	RVT	Rivet, Riveted		Temperature
	Pushbutton			TC	Coefficient
PC	Printed Circuit	S			
PCB	Printed Circuit			THD	Thread, Threaded
	Board	SAWR	Surface Acoustic	THK	Thick
P-CHAN	P-Channel		Wave Resonator	TO	Package Type
PD	Pad, Power	SEG	Segment		Designation
	Dissipation	SGL	Single	TPG	Tapping
PF	Picofarad, Power	SI	Silicon,	TR-HD	Truss Head
	Factor		Square Inch	TRMR	Trimmer
PKG	Package	SL	Slide, Slow	TRN	Turn, Turns
		SLT	Slot, Slotted	TRSN	Torsion

Reference Designations, Abbreviations, and Multipliers (4 of 4)

ABBREVIATIONS					
U		VAR	Variable	Y	
		VDC	Volts—Direct Current		
UCD	Microcandela			YIG	Yttrium-Iron-Garnet
UF	Microfarad				
UH	Microhenry	W			
UL	Microliter,				
	Underwriters'	W	Watt, Wattage,	Z	
	Laboratories, Inc.		White, Wide, Width		
UNHDND	Unhardened	W/SW	With Switch	ZNR	Zener
		WW	Wire Wound		
V		X			
V	Variable, Violet,				
	Volt, Voltage	X	By (Used with		
VAC	Vacuum, Volts—		Dimensions),		
	Alternating Current		Reactance		

MULTIPLIERS					
Abbreviation	Prefix	Multiple	Abbreviation	Prefix	Multiple
T	tera	10^{12}	m	milli	10^{-3}
G	giga	10^9	μ	micro	10^{-6}
M	mega	10^6	n	nano	10^{-9}
k	kilo	10^3	p	pico	10^{-12}
da	deka	10	f	femto	10^{-15}
d	deci	10^{-1}	a	atto	10^{-18}
c	centi	10^{-2}			

Table 4-2. Manufacturers Code List

Mfr. Code	Manufacturer Name	Address	
C0633	RIFA AB	STOCKHOLM	SW
C1433	AB ELEKTRONICK GMBH	SALZBURG	AU
D8350	GROSS A	STUTTGART	GM
D8351	MARQUARDT GMBH	RIETHEIM	GM
D8439	ROEDERSTEIN/RESISTA GMBH	LANDSHUT	GM
K7253	STC/STANTEL	DEVON	EG
K8479	HOLSWORTHY ELECTRONICS LTD	HOLSWORTHY	EG
S0545	NEC ELECTRONICS INC	MTN VIEW	CA
S0562	TOSHIBA CORP	TOKYO	JP
00000	ANY SATISFACTORY SUPPLIER		
00471	DOW-KEY CO INC	BROOMFIELD	WY
00494	ADDRESSOGRAPH FARRINGTON	TREVOSE	PA
00779	AMP INC	HARRISBURG	PA US
00853	SANGAMO WESTON INC	NORCROSS	GA US
01121	ALLEN-BRADLEY CO INC	EL PASO	TX US
01295	TEXAS INSTRUMENTS INC	DALLAS	TX US
01686	RCL ELECTRONICS INC	NORTHBROOK	IL US
01766	INTL CRYSTAL MFG CO INC	OKLAHOMA CITY	OK
01961	PULSE ENGINEERING INC	SAN DIEGO	CA
02113	COILCRAFT INC	CARY	IL
02114	FERROXCUBE CORP	SAUGERTIES	NY US
02768	ITW FASTEX	DES PLAINES	IL
04222	AVX CORP	GREAT NECK	NY US
04713	MOTOROLA INC	ROSELLE	IL US
05791	LYN-TRON INC	BURBANK	CA
05972	LOCTITE CORP	NEWINGTON	CT
06001	MEPCO/ELECTRA INC	MORRISTOWN	NJ US
06132	COMPUTER TERMINAL CORP	SAN ANTONIO	TX
06156	BAUM W A CO INC	COPIAGUE	NY
06341	PRODUCTS/TECHNIQUES INC	LOS ANGELES	CA
06383	PANDUIT CORP	TINLEY PARK	IL US
06394	HOOVER UNIVERSAL INC BALL & RLR DIV	SALINE	MI
06424	SPERRY U-WAVE ELEK DIV SPERRY RAND	CLEARWATER	FL
06560	JEFFERS ELECTRONICS INC	NOGALES	AZ US
06665	PRECISION MONOLITHICS INC	SANTA CLARA	CA US
07047	MILTON ROSS CO	SOUTHAMPTON	PA
07263	FAIRCHILD SEMICONDUCTOR CORP	CUPERTINO	CA US
07933	RAYTHEON CO SEMICONDUCTOR DIV HQ	MOUNTAIN VIEW	CA
09023	CORNELL-DUBILIER/SANGAMO	WAYNE	NJ
09795	DIXON INDUSTRIES CORPORATION	BRISTOL	RI
09922	BURNDY CORP	NORWALK	CT
11236	CTS CORP	ELKHART	IN
11502	IRC INC	BOONE	NC US

Table 4-2. Manufacturers Code List (continued)

Mfr. Code	Manufacturer Name	Address
15542	MINI-CIRCUITS LAB	BROOKLYN NY US
15801	FENWAL ELECTRONICS INC	SADDLE BROOK NJ
15818	TELEDYNE SEMICONDUCTOR	MOUNTAIN VIEW CA
16179	M/A-COM INC	BURLINGTON MA US
16299	CORNING ELECTRONICS	RALEIGH NC US
16428	COOPER INDUSTRIES INC	HOUSTON TX
17856	SILICONIX INC	SANTA CLARA CA US
18324	SIGNETICS CORP	SUNNYVALE CA US
18612	VISHAY INTERTECHNOLOGY INC	MALVERN PA
18873	DUPONT E I DE NEMOURS & CO	WILMINGTON DE US
19701	MEPCO/CENTRALAB INC	WEST PALM BEACH FL US
2M627	ROHM CORP	IRVINE CA US
24022	TELEDYNE INC	LOS ANGELES CA US
24226	GOWANDA ELECTRONICS CORP	GOWANDA NY US
24355	ANALOG DEVICE INC	NORWOOD MA US
25403	NV PHILIPS ELCOMA	EINDHOVEN NE
27014	NATIONAL SEMICONDUCTOR CORP	SANTA CLARA CA US
28480	HP DIV 01 SAN JOSE COMPONENTS	SAN JOSE CA
29005	STORM PRODUCTS CO	LOS ANGELES CA
30043	SOLID STATE DEVICES INC	LA MIRADA CA
3L585	RCA CORP	NEW YORK NY US
30161	AAVID ENGINEERING INC	LACONIA NH US
32159	WEST-CAP ARIZONA	SAN FERNANDO CA US
32293	INTERSIL INC	CUPERTINO CA US
32997	BOURNS INC	RIVERSIDE CA US
33096	COLORADO CRYSTAL CORP	LOVELAND CO
33399	TELE-TECH CORP	BOZEMAN MT US
34335	ADVANCED MICRO DEVICES INC	SUNNYVALE CA US
34371	HARRIS CORP	MELBOURNE FL US
34649	INTEL CORP	SANTA CLARA CA US
34899	FAIR RITE PRODUCTS CORP	WALLKILL NY
4G819	OVERLAND PRODUCTS CORP	PHOENIX AZ
50157	MIDWEST COMPONENTS	MUSKEGON MI
52063	EXAR INTEGRATED SYSTEMS INC	SUNNYVALE CA
52763	STETTNER & CO	LAUF GM
55719	SNAP-ON TOOLS CORP	KENOSHA WI US
55210	GETTIG ENGRG & MFG CO INC	SPRING MILLS PA
55285	BERGWUIST CO	MINNEAPOLIS MN
55322	SAMTEC	NEW ALBANY IN
55680	NICHICON (AMERICA) CORP	SCHAUMBERG IL US
56289	SPRAGUE ELECTRIC CO	LEXINGTON MA US

Table 4-2. Manufacturers Code List (continued)

Mfr. Code	Manufacturer Name	Address	
6E259	AMETEK INC	PAOLI	PA US
70276	ALLEN MFG CO	HARTFORD	CT
71744	GENERAL INSTRUMENT CORP	CLIFTON	NJ
71984	DOW CORNING CORP	MIDLAND	MI
72228	CONTINENTAL SCREW CO DIV OF AMCA	BEDFORD	MA
73138	BECKMAN INDUSTRIAL CORP	FULLERTON	CA US
76381	3M CO	ST PAUL	MN US
78553	EATON CORP	CLEVELAND	OH
83701	ELECTRONIC DEVICES INC	YONKERS	NY
84411	AMERICAN SHIZUKI CORP	CONOGA PARK	CA US
9M011	INTL RECTIFIER CORP	LOS ANGELES	CA US
9N171	UNITRODE CORP	LEXINGTON	MA US
91506	AUGAT INC	MANSFIELD	MA
91637	DALE ELECTRONICS INC	COLUMBUS	NE US
92194	ALPHA WIRE CORP	ELIZABETH	NJ
92895	AMERICAN OIL & SUPPLY CO	NEWARK	NJ
96900	HARDMAN INC	BELLEVILLE	NJ
98978	INTL ELECTRONIC RESEARCH CORP	BURBANK	CA
98291	SEAELECTRO CORP	TRUMBULL	CT US
99800	AMER PRCN IND INC DELEVAN DIV	AURORA	NY
01561	CHASSIS TRAK DIV GENERAL DEVICES CO	INDIANAPOLIS	IN
10183	GRAHAM MAGNETICS INC	FT WORTH	TX US
11591	STUART RADIATOR CO	SAN FRANCISCO	CA
16179	M/A-COM INC	BURLINGTON	MA US
16428	COOPER INDUSTRIES INC	HOUSTON	TX US
24022	TELEDYNE INC	LOS ANGELES	CA US
24931	SPECIALTY CONNECTOR CO	FRANKLIN	IN US

Table 4-3. Replaceable Parts

Reference Designation	HP Part Number	C	D	Qty	Description	Mfr Code	Mfr Part Number
					ACCESSORIES SUPPLIED		
	1810-0118	1	1		TERMINATION-COAXIAL SMA; 0.5W; 50Ω	16179	2003-6113-02
	1250-0780	5	1		ADAPTER-COAX F-BNC M-N	24931	29JP104-2
	HP 10502A	9	1		50Ω COAX CABLE WITH BNC MALE	28480	HP 10502A
	8710-1755	9	3		WRENCH-HEX KEY	55719	AWML4
					OPTION 908		
	5062-0800	5	1		RACK KIT WITH FLANGES (Includes Parts Listed Below)		
	5001-8739	7	2		PANEL-DRESS	28480	5001-8739
	5001-8740	0	2		PANEL-SUB	28480	5001-8740
	5001-8742	2	2		SUPPORT-REAR	28480	5001-8742
	5021-5807	6	2		FRAME-FRONT	28480	5021-5807
	5021-5808	7	2		FRAME-REAR	28480	5021-5808
	5021-5836	1	5		CORNER-STRUT	28480	5021-5836
	0510-1148	2	10		RETAINER-PUSH-ON KB-TO-SHFT EXT	11591	669
	0515-0886	3	16		SCREW-MACH M3 × 0.5 6MM-LG PAN-HD	28480	0515-0886
	0515-0887	4	8		SCREW-MACH M3.5 × 0.6 6MM-LG PAN-HD	28480	0515-0887
	0515-0889	6	12		SCREW-MACH M3.5 × 0.6 6MM-LG	28480	0515-0889
	0515-1241	6	8		SCREW-MACH M5 × 0.8 12 MM-LG PAN-HD	28480	0515-1241
	0515-1331	5	22		SCREW-METRIC SPECIALTY M4 × 0.7 THD; 7MM	28480	0515-1331
	5061-9679	2	2		MOUNT FLANGE	28480	5061-9679
	0515-1114	2	6		SCREW-MACH M4 × 0.7 10MM-LG PAN-HD	28480	0515-1114
	8710-1755	9			WRENCH-HEX KEY	55719	AWML4
	5958-6573	0	2		ASSEMBLY INSTRUCTIONS	28480	5958-6573
					OPTION 909		
	5062-1900	8	1		RACK KIT WITH FLANGES AND HANDLES (Includes Parts Listed Below)		
	5001-8739	7			PANEL-DRESS	28480	5001-8739
	5001-8740	0			PANEL-SUB	28480	5001-8740
	5001-8742	2			SUPPORT-REAR	28480	5001-8742
	5021-5807	6			FRAME-FRONT	28480	5021-5807
	5021-5808	7			FRAME-REAR	28480	5021-5808
	5021-5836	1			CORNER-STRUT	28480	5021-5836
	0510-1148	2			RETAINER-PUSH-ON KB-TO-SHFT EXT	11591	669
	0515-0886	3			SCREW-MACH M3 × 0.5 6MM-LG PAN-HD	28480	0515-0886
	0515-0887	4			SCREW-MACH M3.5 × 0.6 6MM-LG PAN-HD	28480	0515-0887
	0515-0889	6			SCREW-MACH M3.5 × 0.6 6MM-LG	28480	0515-0889

Table 4-3. Replaceable Parts (continued)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A1	0515-1241	6		SCREW-MACH M5 × 0.8 12MM-LG PAN-HD	28480	0515-1241
	0515-1331	5		SCREW-METRIC SPECIALTY M4 × 0.7 THD; 7MM	28480	0515-1331
	5061-9501	9	2	FRONT HANDLE ASS'Y	28480	5061-9501
	5061-9685	0	2	MOUNT FLANGE	28480	5061-9685
	0515-1106	2	6	SCREW-MACH M4 × 0.7 16MM-LG PAN-HD	28480	0515-1106
	8710-1755	9		WRENCH-HEX KEY	55719	AWML4
	5958-6573	0		ASSEMBLY INSTRUCTIONS	28480	5958-6573
				RACK SLIDE KIT		
	1494-0060	0	1	SLIDE-CHAS 25-IN-LG 21.84-IN-TRVL	01561	C858-2
				(Includes Parts Listed Below. Slides cannot be ordered separately.)		
	0515-0949	9	4	SCREW-MACH M5 × 0.8 14MM-LG PAN-HD	28480	0515-0949
	0515-1013	0	9	SCREW-MACH M4 × 0.7 12MM-LG	28480	0515-1013
	0515-0909	1	4	SCREW-MACH M4 × 0.7 12MM-LG PAN-HD	28480	0515-0909
	0535-0080	1	8	NUT-CHANNEL M4 × 0.7 3.5MM-THK 10.3MM-WD	28480	0535-0080
				MAJOR ASSEMBLIES		
				FRONT FRAME ASSEMBLY		
				(not available as a field replacement)		
				(The A1 assembly includes the front frame, front faceplate, front-panel keys, and other hardware. Refer to Figure 4-5 for individual part numbers.)		

Table 4-3. Replaceable Parts (continued)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A1A1	08562-60140	6	1	BD AY-KEYBOARD	28480	08562-60140
A1A2	0960-0745	6	1	RPG ASSEMBLY (Includes Cable)	28480	0960-0745
A2	08563-60032	6	1	CONTROLLER ASSEMBLY*	28480	08563-60032
A3	08563-60021	3	1	INTERFACE ASSEMBLY	28480	08563-60021
A3	08563-60033	7	1	INTERFACE ASSEMBLY (Option 007)	28480	08563-60033
A4	08563-60050	7	1	LOG AMPLIFIER/CAL OSC. ASSY.	28480	08563-60050
A5	08563-60023	5	1	IF FILTER ASSEMBLY	28480	08563-60023
A6	08563-60020	2	1	POWER SUPPLY ASSEMBLY* (Does not include A6A1)	28480	08563-60020
A6A1	5062-7089	6	1	HIGH VOLTAGE ASSEMBLY	28480	5062-7089
A7	5086-7744	0	1	FIRST LO DISTRIBUTION AMPL	28480	5086-7744
A8	5086-7748	4	1	LOW BAND MIXER	28480	5086-7748
	5086-6748	2	1	REBUILT LOW BAND MXR	28480	5086-6748
A9	5086-7822	5	1	PORT ATTEN, 22 GHz	28480	5086-7822
	5086-6822	3	1	REBUILT A9, EXCHANGE REQUIRED	28480	5086-6822
A10	5086-7879	9	1	BUILT-IN TRACKING GENERATOR	28480	5086-7879
	5086-6879			REBUILT A10, EXCHANGE REQUIRED	28480	5086-6879
A11	5086-7906	6	1	PORTABLE LVLD YTO	28480	5086-7906

* These board assemblies are part of the rebuilt board exchange program. To order a rebuilt board, use the same number as that of the new board with the exception of the 7th digit which should be a 9. Example: New board number is 08562-60094. Therefore, the rebuilt board number will be 08562-69094.

Table 4-3. Replaceable Parts (continued)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
A13	5086-7812	3	1	SECOND CONVERTER	28480	5086-7812
A14	08560-60059	9	1	FREQUENCY CONTROL ASSEMBLY	28480	08560-60059
A15	08563-60043		1	Option 103, without SIG ID	28480	08563-60043
A15	08563-60044		1	Non-Option 103, without SIG ID	28480	08563-60044
A15	08563-60045		1	Option 103, with SIG ID	28480	08563-60045
A15	08563-60046		1	Non-Option 103, without SIG ID	28480	08563-60046
A15U100	5086-7806	5	1	SAMPLER	28480	5086-7806
A16	08563-60030	4	1	FAST ADC ASSEMBLY (Option 007)	28480	08563-60030
A17	08562-60166	6	1	CRT DRIVER ASSEMBLY	28480	08562-60166
A18				CRT ASSEMBLY (Order by Individual Parts)		
A18MP1	5062-7095	4	1	CRT WIRING ASSEM. (Includes Shield A18L1, and A18W1)	28480	5062-7095
A18MP2	5041-3987	1	1	SPACER, CRT	28480	5041-3987
A18V1	2090-0225	4	1	TUBE, CRT 6.7 IN	28480	2090-0225
A18W1				CABLE ASSEMBLY, TWO WIRE, TRACE ALIGN (P/O A18MP1, A17J5 to A18L1)		
A19	08562-60042	7	1	HP-IB ASSEMBLY	28480	08562-60042
A19W1	5061-9031	0	1	CABLE ASSEMBLY, RIBBON, HP-IB (A2J5 to Rear Panel J2)	28480	5061-9031
A20	5062-7755	3	1	BATTERY ASSY (Includes W6)	28480	5062-7755
A21	5063-0245	4	1	OCXO CABLE ASSEMBLY, 10.0 MHz	28480	5063-0245

Table 4-3. Replaceable Parts (continued)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
B1	5061-9036	5	1	FAN ASSEMBLY (Includes Wire)	28480	5083-9036
BT1	1420-0341	5	1	BATTERY 3.0 V 1.2 A-HR LITHIUM POLYCARBON MONOFLORIDE	08709	BR 213 A 55P
F1	2110-0709	3	1	THIONYL FUSE 5A 250V NTD FE IEC (230 VAC Operation)	16428	GDA-5
F1	2110-0756	0	1	FUSE 5A 125V NTD UL (115 VAC Operation)	28480	2110-0756
FL1	0955-0703	5	1	LOW PASS FILTER, 2.9 GHz	28480	0955-0703
FL2	0955-0519	1	1	LOW PASS FILTER, 4.4 GHz	28480	0955-0519
FL3				NOT ASSIGNED		
LS1	9160-0282	9	1	LOUDSPEAKER 2.5 IN SQ (Part of W5)	28480	9160-0282
CHASSIS MECHANICAL PARTS (See Figures 4-1 through 4-6 for a complete listing of mechanical chassis parts.)						
ASSEMBLY SHIELDS						
A3 Assembly	5021-6723	7	1	PEAK DETECTOR (TOP)	28480	5021-6723
	5021-6724	8	1	PEAK DETECTOR (BOTTOM)	28480	5021-6724
	0515-2080	8	2	SCREW M2.5 14L	28480	0515-2080
	0515-1486	9	10	SCREW M2.5 9.5L	28480	0515-1486
	0905-0375	2	12	O-RING .070ID	28480	0905-0375
	2190-0583	9	12	WSHR LK M2.5ID	28480	2190-0583

Table 4-3. Replaceable Parts (continued)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
ASSEMBLY SHIELDS (continued)						
A4 Assembly	5063-0222	5	1	AMP 1 (BOTTOM)	28480	5063-0222
	5063-0221	6	1	AMP 1 (TOP)	28480	5063-0221
	5063-0219	2	1	AMP 2 (TOP)	28480	5063-0219
	5063-0220	7	1	AMP 2 (BOTTOM)	28480	5063-0220
	0515-1486	1	4	SCREW SMM 2.5 10 PNTROX	28480	0515- 1486
	0515-2080	8	23	SCREW M2.5 14L	28480	0515-2080
	2190-0583	9	23	WSHR LK M2.5ID	28480	2190-0583
	0905-0375	2	23	O-RING .070ID	28480	0905-0375
A5 Assembly	5021-6729	3	1	IF 1 (TOP)	28480	5021-6729
	5021-6730	6	1	IF 1 (BOTTOM)	28480	5021-6730
	5021-6731	7	1	IF 2 (TOP)	28480	5021-6731
	5021-6732	8	1	IF 2 (BOTTOM)	28480	5021-6732
	0515-2081	3	16	SCREW 5MM 2.5 16 PNPDS	28480	0515-2081
	0905-0375	2	16	O-RING .070ID	28480	0905-0375
	2190-0583	9	16	WSHR LK M2.5ID	28480	2190-0583
A14 Assembly	5063-0209	0	1	FC (TOP)	28480	5063-0209
	5063-0210	3	1	FC (BOTTOM)	28480	5063-0210
	0515-0951	3	13	SCREW 5MM 2.5 16 PNPDS	28480	0515-0951
	0905-0375	2	13	O-RING .070ID	28480	0905-0375
	2190-0583	9	13	WSHR LK M2.5ID	28480	2190-0583
A15 Assembly	5021-6735	1	1	REF (TOP)	28480	5021-6735
	5021-6736	2	1	REF (BOTTOM)	28480	5021-6736
	5022-0047	8	1	SYNTHZR (TOP)	28480	5022-0047
	5022-0046	7	1	SYNTHZR (BOTTOM)	28480	5022-0046
	5021-6739	5	1	SIGPATH (TOP)	28480	5021-6739
	5021-6740	8	1	SIGPATH (BOTTOM)	28480	5021-6740
	5002-0631	4	1	BRACE. RF BD	28480	5002-0631
	0515-2081	3	36	SCREW 5MM 2.5 16 PNPDS	28480	0515-2081
	0905-0375	2	36	O-RING .070ID	28480	0905-0375
	2190-0583	9	36	WSHR LK M2.5 ID	28480	2190-0583
	0515-0367	5	2	SCREW 2.5M X 8MM LG TORX	28480	0515- 0367

Table 4-3. Replaceable Parts (continued)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
CABLE ASSEMBLIES						
W1	8120-5682	8	1	POWER CABLE, RIBBON	28480	8120-5682
W2	5061-9025	2	1	CONTROL CABLE, RIBBON	28480	5061-9025
W3	5062-0728	6	1	CABLE ASSEMBLY LINE SWITCH	28480	5062-0728
W4	5061-9033	2	1	CABLE ASSEMBLY, RIBBON, OPTION MODULE (A2J6 to Rear Panel J3)	28480	5061-9033
W5	5062-6471	8	1	VOLUME CONTROL ASSEMBLY (Includes W55)	28480	5062-6471
W6	5062-0767	3	1	CABLE ASSEMBLY, BATTERY (A2J9 to Rear Panel Battery Holder)	28480	5062-0767
W7	8120-6172	3	1	CABLE ASSEMBLY, RIBBON (Option 007) (A2J3 to A16J1/J2)	28480	8120-6172
W8	5061-9030	9	1	CABLE ASSEMBLY, DISPLAY POWER (A6J4 to A17J2)	28480	5061-9030
W9	5062-6482	1	1	CABLE ASSEMBLY, CRT, YOKE (A17J3 and J7 to A18V1)	28480	5062-6482
W10	5062-0742	4	1	CABLE ASSEMBLY, RIBBON, A11 YTO DRIVE (A14J3 to A11J1)	28480	5062-0742
W11	08562-60064	3	1	CABLE ASSEMBLY, RIBBON, A9 ATTEN. DRIVE (A14J6 to A9)	28480	08562-60064
W13	5062-0743	5	1	CABLE ASSEMBLY, RIBBON, A13 2ND CONV DRIVE (A14J12 to A13) (Part of Cable Assembly-Microcircuit, 08562-60045)	28480	5062-0743
W14	08560-60002	7	1	CABLE ASSEMBLY, RIBBON, A10 CONTROL SIGNAL (A14J13 to A10J1)	28480	08560-60002
W15				NOT ASSIGNED		

Table 4-3. Replaceable Parts (continued)

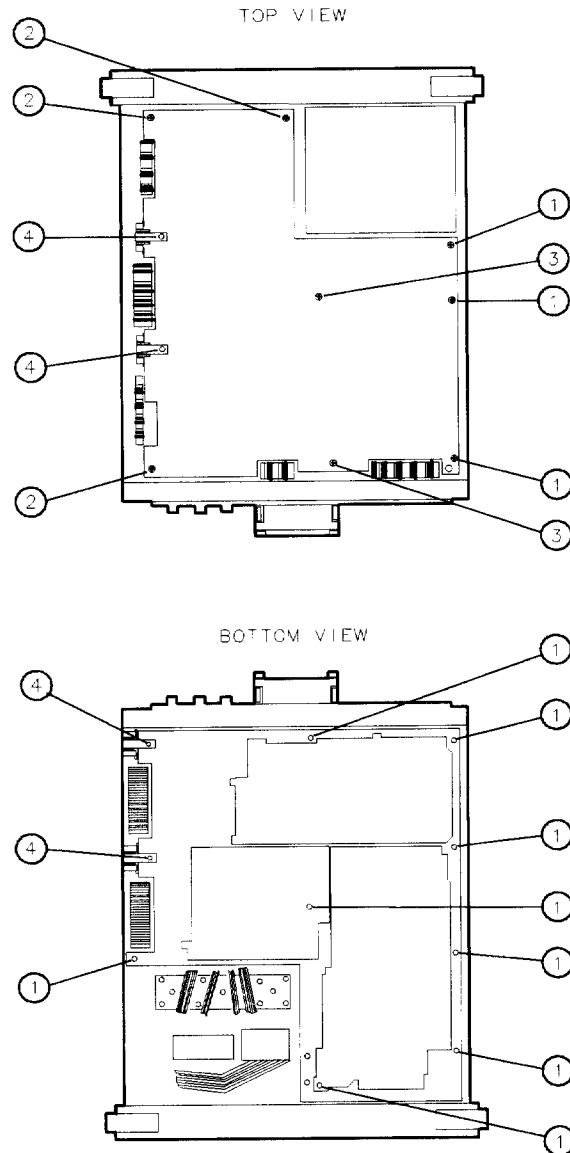
Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
W16	08560-60001	6	1	CABLE ASSEMBLIES (continued) CABLE ASSEMBLY, A10 ALC EXT (Option 002) (Rear Panel J11 to A10)	28480	08560-60001
W18	5062-0721	8	1	CABLE ASSEMBLY, COAX 97, LO SWEEP 0.5 V/GHz (A14J7 to Rear Panel J8)	28480	5062-0721
W19	5062-0723	1	1	CABLE ASSEMBLY, COAX 83, OPT 001 2ND IF OUT (A15J803 to Rear Panel J10)	28480	5062-0723
W20	5062-0717	3	1	CABLE ASSEMBLY, COAX 6, 0 SPAN VIDEO (A3J103 to A2J4) (Non-Option 007)	28480	5062-0717
W20	5063-0281	8	1	CABLE ASSEMBLY, COAX 6, 0 SPAN VIDEO (A3J103 to A16J4) Option 007	28480	5063-0281
W22	5062-0709	3	1	CABLE ASSEMBLY, COAX 0, 10 MHz FREQ. COUNT (A15J302 to A2J8)	28480	5062-0709
W23	5062-0719	5	1	CABLE ASSEMBLY, COAX 93, EXT TRIG IN (Rear Panel J5 to A3J600)	28480	5062-0719
W24	5062-0720	8	1	CABLE ASSEMBLY, COAX, 5 VIDEO OUT (A3J102 to Rear Panel J4)	28480	5062-0720
W25	5062-0718	4	1	CABLE ASSEMBLY, COAX 4, BLANKING OUT (A3J601 to Rear Panel J6)	28480	5062-0718
W27	5062-0714	0	1	CABLE ASSEMBLY, FILTER 10.7 MHz (A5J5 to A4J3)	28480	5062-0714
W29	5062-0711	7	1	CABLE ASSEMBLY, COAX 7, 10.7 IF (A15J601 to A5J3)	28480	5062-0711
W31	5062-0722	0	1	CABLE ASSEMBLY, COAX 8, REF IN/OUT (A15J301 to Rear Panel J9)	28480	5062-0722
W32	5062-0705	9	1	CABLE ASSEMBLY, COAX 87, SAMPLER IF (A15J101 to A14J501)	28480	5062-0705
W33	5062-0706	0	1	CABLE ASSEMBLY, COAX 81, 2ND LO DRIVE (A15J701 to A13J4)	28480	5062-0706
W34	8120-5446	7	1	CABLE ASSEMBLY, COAX 0, 1ST LO SAMP. (A7J4 to A15A2J1)	28480	8120-5446

Table 4-3. Replaceable Parts (continued)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
				CABLE ASSEMBLIES (continued)		
W35	5062-0710	6	1	CABLE ASSEMBLY, COAX 92, INT 2ND IF (A13J2 to A15J801)	28480	5062-0710
W36	5062-0725	3	1	CABLE ASSEMBLY, COAX 86, EXT 2ND IF (Front Panel J3 to A15J802)	28480	5062-0725
W37	5062-0707	1	1	CABLE ASSEMBLY, COAX 85, 10 MHz REF 1 (A15J303 to A14J301)	28480	5062-0707
W38	08560-20005	3	1	CABLE ASSEMBLY, SEMI-RIGID, 1ST LO IN (A11J2 to A7J1)	28480	08560-20005
W39	08560-20006	8	1	CABLE ASSEMBLY, SEMI-RIGID, 1ST MIXER OUT (A7J2 to A8J3)	28480	08560-20006
W40	5062-0724	2	1	CABLE ASSEMBLY, COAX 89, CAL OUT (A15J501 to Front Panel J5)	28480	5062-0724
W41	5021-8635	5	1	CABLE ASSEMBLY, SEMI-RIGID, RF INPUT (Front panel J1 to A9J1)	28480	5021-8635
W42	5021-6705	9	1	CABLE ASSEMBLY, SEMI-RIGID, 1ST LO OUT (A7J3 to Front Panel J4)	28480	5021-6705
W43	08560-20001	6	1	CABLE ASSEMBLY, SEMI-RIGID, A10 LO IN (A10 to A7J3)	28480	08560-20001
W44	5022-1125	5	1	CABLE ASSEMBLY, SEMI-RIGID (A9 to FL1J1)	28480	5022-1125
W45	5022-1123	3	1	CABLE ASSEMBLY, SEMI-RIGID (FL1J2 to A8J1)	28480	5022-1123
W46	08560-20002	7	1	CABLE ASSEMBLY, SEMI-RIGID, A10 LO OUT (A10 to Front Panel J4) (Option 002)	28480	08560-20002
W47	08560-20003	4	1	CABLE ASSEMBLY, SEMI-RIGID, A10 RF OUT (A10 to Front Panel J6) (Option 002)	28480	08560-20003
W48	08560-60003	8	1	CABLE ASSEMBLY, COAX 80, A10 600 MHz (A15J702 to A10) Option 002	28480	08560-60003
W49	5062-4892	3	1	CABLE ASSEMBLY, COAX 82, A21 OCXO (A21 to A15J305)	28480	5062-4892
W50	5063-0245	4	1	CABLE ASSEMBLY, OCXO (A21 to A15J306)	28480	5063-0245

Table 4-3. Replaceable Parts (continued)

Reference Designation	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
				CABLE ASSEMBLIES (continued)		
W51	5062-6478	5	1	CABLE ASSEMBLY, COAX 84, 10 MHz REF2 (A15J304 to A4J7)	28480	5062-6478
W52	5062-6477	4	1	CABLE ASSEMBLY, COAX 9, 10.7 MHz CAL SIG (A5J4 to A4J8)	28480	5062-6477
W53	5062-6476	3	1	CABLE ASSEMBLY, COAX 1, FREQ COUNTER (A2J7 to A4J5)	28480	5062-6476
W54	5062-6475	3	1	CABLE ASSEMBLY, COAX 2, VIDEO (A3J101 to A4J4)	28480	5062-6475
W55	5062-6471	8	1	CABLE ASSEMBLY, AUDIO (A4J6 to LSI J1 and Rear Panel J1)	28480	5062-6471
W56	5022-0049	5	1	CABLE ASSEMBLY, SEMI-RIGID (A8J2 to FL2J1)	28480	5022-0049
W57	5022-0050	4	1	CABLE ASSEMBLY, SEMI-RIGID (FL2J2 to A13J1)	28480	5022-0050
W58	5062-0722	0	1	CABLE ASSEMBLY, COAX 8, ALT SWEEP OUT (A14J20 to Rear Panel J11) (Option 005)	28480	5062-0722
W59	5063-0282	9	1	CABLE ASSEMBLY, COAX 839, FAST ADC CLOCK (A2J15 to A16J3) (Option 007)	28480	5063-0282



sp 126e

Figure 4-1. Parts Identification, Assembly Mounting

Item	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
1	0515-1349	5	11	SCREW-MACH M3 X 30MM-LG PAN-HD TORX	28480	0515-1349
2	0515-2310	2	3	SCREW-MACH M3 X 60MM-LG PAN-HD TORX	28480	0515-2310
3	0515-2308	8	2	SCREW-MACH M3 X 100MM-LG PAN-HD TORX	28480	0515-2308
4	0515-2332	8	10	SCREW-MACH M3 X 6MM-LG PAN-HD TORX	28480	0515-2332
4	0515-0664	5	2	SCREW-MACH M3 X 12MM-LG PAN-HD TORX	28480	0515-0664

Parts List, Cover Assembly (See Figure 4-2)

Item	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
1	5041-8911	1	1	BAIL HANDLE	28480	5041-8911
2	5041-8912	2	2	TRIM CAP	28480	5041-8912
3	0515-1114	2	4	SCREW MACH M4 X 10MM-LG PAN-HD	28480	0515-1114
4	1460-2164	0	2	SPRING-CPRSN .845 IN-OD 1.25-IN-OA-LG	28480	1460-2164
5	5021-6343	7	2	RING GEAR	28480	5021-6343
6	5021-6344	8	2	SOCKET GEAR	28480	5021-6344
7	5021-8667	2	2	HANDLE PLATE	28480	5021-8667
8	5001-8728	4	2	BACKUP PLATE	28480	5001-8728
9	0515-1367	0	6	SCREW MACH M4 X 8MM-LG 90DEG-FLH-HD	28480	0515-1367
10	0515-1133	5	2	SCREW-MACH M5 X 16MM-LG	28480	0515-1133
11	5001-8800	3	1	COVER	28480	5001-8800
12	5041-7238	3	1	MOISTURE DEFLECTOR-LF	28480	5041-7238
13	5041-3989	3	1	MOISTURE DEFLECTOR-RT	28480	5041-3989
14	5041-8913	3	2	SIDE TRIM	28480	5041-8913
15	0515-1114	2	2	SCREW-MACH M4 X 10MM-LG PAN-HD	28480	0515-1114
16	5041-8907	5	2	REAR FOOT	28480	5041-8907
17	0900-0024	8	4	O-RING .145-1N-XSECT-DIA SIL	51633	A5568-007
18	2190-0587	3	4	WASHER-LK HLCL 5.0 MM 5.1-MM-ID	28480	2190-0587
19	0515-1218	7	4	SCREW-SKT-HD-CAP M5 X 40MM-LG	28480	0515-1218
20	08562-80028	1	1	INSULATOR 292 X 355 MM .51 THK	28480	08562-80028

Parts List, Main Chassis (See Figure 4-3)

Item	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
1	0515-2145	1	4	SCREW-MACH M3 X 8MM-LG PAN-HD TORX	28480	0515-2145
3	0515-1715	9	3	SCREW-MACH M3 X 35MM-LG PAN-HD TORX	28480	0515-1715
4	0380-2052	2	2	SPACER .937LG .166ID	28480	0380-2052
5	5002-1010	5	1	COVER, A6 POWER SUPPLY	28480	5002-1010
	5181-8215	4	1	WARNING LABEL (not shown)	28480	5181-8215
	08562-80029	2	1	INSULATOR 100 X 140 (not shown)	28480	08562-80029
6	0515-2309	8	3	SCREW-MACH M3 X 0.5 45MM-LG TORX	28480	0515-2309
7	5041-7246	3	1	BOARD CLIP	28480	5041-7246
8	0515-0372	2	2	SCREW-MACH M3 X 8MM-LG PAN-HD TORX	28480	0515-0372
9	5041-8961	1	1	TOP COVER, A17	28480	5041-8961
	5041-7248	5	1	BOTTOM COVER, A17	28480	5041-7248
10	5021-5486	7	2	CRT MOUNT	28480	5021-5486
11	5001-5870	1	2	CRT MOUNT STRAP	28480	5001-5870
13	0515-0372	2	4	SCREW-MACH M3 X 8MM-LG PAN-HD TORX	28480	0515-0372
14	5002-1008	1	1	MAIN DECK	28480	5002-1008
	5002-1009	2	1	EMI SHIELD (not shown)	28480	5002-1009
15	5001-8755	5	1	FRONT END DECK	28480	5001-8755
16	0515-1101	7	4	SCREW-MACH M4 X 8MM-LG FLH-HD TORX	28480	0515-1101
17	0515-1227	8	2	SCREW MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
18	5021-7464	5	2	SIDE FRAME	28480	5021-7464
19	0515-1101	7	12	SCREW-MACH M4 X 8MM-LG FLH-HD TORX	28480	0515-1101
20	0515-1227	8	12	SCREW MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
21	0515-1227	8	8	SCREW MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
22	0515-1227	8	5	SCREW MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
23	5021-5484	5	5	MOUNTING POST	28480	5021-5484
24	5062-0750	4	2	HINGE, 2 BOARD	28480	5062-0750
25	5062-0751	5	2	HINGE, 4 BOARD	28480	5062-0751
26	5041-7250	9	1	CABLE CLAMP	28480	5041-7250
27	0515-2164	4	2	SCREW-MACH M3 X 35MM-LG TORX	28480	0515-2164
28	0515-1227	8	2	SCREW-MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
29	5181-8214	3	1	LABEL, ASSEMBLY LOCATIONS	28480	5181-8214
30	5063-0269	2	1	SHIELD WALL, TOP	28480	5063-0269
31	5063-0268	1	1	SHIELD WALL, BOTTOM	28480	5063-0268
A18MP1	5062-7095	4	1	CRT WIRING ASSY (INCLUDES A18L1, A18W1)	28480	5062-7095
A18MP2	5041-3987	1	1	SPACER, CRT	28480	5041-3987
A18V1	2090-0225	4	1	TUBE, CRT	28480	2090-0225
A18W1				P/O A18MP1		
	5181-5046	3	1	LABEL, CRT ADJUSTMENT	28480	5181-5046

Parts List, RF Section (See Figure 4-4)

Item	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
1	0515-2332	8	2	SCREW-MACH M3 X 6MM-LG PAN-HD TORX	28480	0515-2332
2	0515-1032	3	2	SCREW-MACH M3 X 14MM-LG FLH-HD TORX	28480	0515-1032
3	0515-2332	8	2	SCREW-MACH M3 X 6MM-LG PAN-HD TORX	28480	0515-2332
4	5021-7467	8	1	FILTER CLAMP	28480	5021-7467
6	0515-2332	8	2	SCREW-MACH M3 X 6MM-LG PAN-HD TORX	28480	0515-2332
7	5002-1008	1	1	MAIN DECK	28480	5002-1008
8	0515-1227	8	2	SCREW-MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
9	5001-8755	5	1	FRONT END DECK	28480	5001-8755
11	0515-1227	8	3	SCREW-MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
12	2360-0461	3	4	SCREW-MACH 6-32 .375-IN-LG FLH-HD TORX	28480	2360-0461
13	0515-0372	2	1	SCREW-MACH M3 X 8MM-LG PAN-HD TORX	28480	0515-0372
14	0515-1250	7	2	SCREW-MACH M3 X 6MM-LG PAN-HD TORX	28480	0515-1250
15	5001-8731	9	1	ATTENUATOR BRACKET	28480	5001-8731
18	08560-00002	1	1	ATTENUATOR BRACKET	28480	08560-00002
19	0515-1250	7	2	SCREW-MACH M3 X 6MM-LG PAN-HD TORX	28480	0515-1250
20	0515-1227	8	1	SCREW-MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
22	0515-1227	8	4	SCREW-MACH M3 X 6MM-LG FLH-HD TORX	28480	0515-1227
23	0515-1410	1	2	SCREW-MACH M3 X 20MM-LG PAN-HD TORX	28480	0515-1410

Parts List, Front Frame (See Figure 4-5)

Item	HP Part Number	C	Qty	Description	Mfr Code	Mfr Part Number
1	0515-1622	7	4	SCREW-SKT-HD-CAP M4 X 0.7 8MM-LG	28480	0515-1622
2	5041-8906	4	1	CRT BEZEL	28480	5041-8906
3	1000-0897	4	1	RFI CRT FACEPLATE	28480	1000-0897
4	0370-3069	2	1	KNOB BASE 1-1/8 JGK .252-IN-IO (INCLUDES ITEM 5)	28480	0370-3069
5	3030-0022	4	2	SCREW-SET 6-32 .125-IN-LG SMALL CUP-PT	00000	DESCRIBE
6	2950-0043	8	1	NUT-HEX-DBL-CHAM 3/8-32-THD .094-IN-THK	00000	DESCRIBE
7	2190-0016	3	1	WASHER-LK INTL T 3/8 IN .377-IN-ID	28480	2190-0016
8	08560-00011	7	1	FRONT PANEL-DRESS	28480	08560-00011
8	08560-00010	0	1	FRONT PANEL-DRESS (Option 002)	28480	08560-00010
9	5060-0467	6	1	PROBE POWER JACK	28480	5060-0467
10	0590-1251	6	1	NUT-SPCLY 15/32-32-THD .1-IN-THK .562-WD	00000	DESCRIBE
11	1250-1666	8	2	ADAPTOR COAX STR F-SMA F-SMA	28480	1250-1666
12	0515-2145	1	12	SCREW-MACH M3 X 0.5 8MM-LG PAN-HD TX	28480	0515-2145
13	5062-4806	9	1	BUMPER KIT (Includes 4 bumpers)	28480	5062-4806
14	0905-1018	2	4	O-RING .126TD	28480	0905-1018
15	5021-5483	4	2	CATCH LATCH	28480	5021-5483
16	0515-0366	3	4	SCREW-MACH M2.5 X 0.45 6MM-LG PAN-HD TX	28480	0515-0366
17	5022-0199	8	1	FRONT FRAME	28480	5022-0199
18	8160-0520	7	1	RFI ROUND STRIP STL MSH/SIL RBR CU/SN	28480	8160-0520
19	0535-0082	3	2	NVTM W LKWR M4	28480	0535-0082
20	2190-0016	3	1	WASHER-LK INTL T 3/8 IN .377-IN-ID	28480	2190-0016
21	2950-0043	8	1	NUT-HEX-DBL-CHAM 3/8-32-THD .094-IN-THK	00000	DESCRIBE
22	1250-2191	2	1	RF INPUT ASSEMBLY	28480	1250-2191
23	0515-0430	1	2	SCREW-MACH M3 X 0.5 8MM-LG PAN-HD TX	28480	0515-0430
24	5041-8985	9	1	RUBBER KEYPAD (INCLUDES KEYCAPS)	28480	5041-8985
25	1990-1131	0	1	LED-LAMP LUM-INT=560UCD IF=20MA-MAX	2M627	LD-101MG
26	5062-0728	6	1	LINE SWITCH CABLE ASSEMBLY	28480	5062-0728
27	0900-0010	2	1	O-RING .101-IN-ID .07-IN-XSECT-DIA NTRL	51633	AS568-005
28	0515-0664	5	1	SCREW-MACHINE ASSEMBLY M3 X 0.5 12MM-LG	28480	0515-0664
29	5021-5482	3	1	SUPPORT CENTER	28480	5021-5482
30	0515-1143	7	2	SCREW-MACH M4 X 0.7 16MM-LG PAN-HD TX	28480	0515-1143
31	0515-1934	4	9	SCREW-MACH M2.5 X 0.45 6MM-LG PAN-HD TX (P/O A1W1)	28480	0515-1934
32	2100-4232	4	1	R-VC 20K 20% LOG	28480	2100-4232
33	3050-0014	6	2	WASHER-FL .250ID12	28480	3050-0014
34	2190-0067	4	1	WASHER-LK INTL .256-IN-ID	28480	2190-0067
35	2950-0072	3	1	NUT-HEX 1/4-32 THD	28480	2950-0072
36	0370-3079	4	1	KNOB RND .125 JG	28480	0370-3079

Parts List, Rear Frame (See Figure 4-6)

Item	HP Part Number	C D	Qty	Description	Mfr Code	Mfr Part Number
1	0515-1946	8	2	SCREW-MACH M3 6MM-LG FLH-HD TORX	28480	0515-1946
2	5062-7755	3	1	BATTERY HOLDER (INCLUDES WIRES)	28480	5062-7755
3	0515-2216	7	4	SCREW-MACH M4 40MM-LG PAN-HD TORX	28480	0515-2216
4	3160-0309	5	1	FAN GRILL	28480	3160-0309
5	0380-0012	0	4	SPACER-RND .875-IN-ID	28480	0380-0012
6				NOT ASSIGNED		
7	6960-0149	4	1	PLUG-HOLE TR-HD FOR 0.5-D-HOLE STL	05093	6960-0149
8	6960-0023	9	1	PLUG-HOLE DOME-HD FOR 0.312-D-HOLE STL	04213	D-2730-LC2
9	1250-1753	4	1	ADAPTOR-COAX STR F-SMA OPT 001 (INCLUDES WASHER AND NUT)	28480	1250-1753
10	0515-1946	8	4	SCREW-MACH M3 6MM-LG FLH-HD TORX	28480	0515-1946
11	0515-0684	9	1	SCREW-MACH M3 6MM-LG PAN-HD TORX	28480	0515-0684
12	2950-0035	8	5	NUT HEX 15/32THD	28480	2950-0035
13	5062-4838	6	1	CONNECTOR-TEL 2-CKT .141-SHK-DIA (INCLUDES NUT AND JACK) PART OF W5	28480	5062-4838
14	5002-1012	7	1	REAR PANEL-DRESS	28480	5002-1012
15	0515-2145	1	4	SCREW-MACH M3 6MMLG PAN-HD TORX	28480	0515-2145
16	8160-0520	7	1	RFI ROUND STRIP STL SPIRA .150	28480	8160-0520
17	5021-5479	8	1	REAR FRAME	28480	5021-5479
18	5021-6391	5	2	SCREW-CONNECTOR HP-IB	28480	5021-6391
19	2200-0225	9	2	SCREW-MACH 4-40 .25-IN-LG TORX	28480	2200-0225
20	0535-0082	3	2	NUT M4.0 W/LOCKWR	28480	0535-0082
21	0515-0433	6	1	SCREW-MACH M4 8MM-LG PAN-HD TORX	28480	0515-0433
22	0535-0023	2	2	NUT-HEX DBL-CHAM M4 X 0.7 3.2MM-THK	28480	0535-0023
B1	5061-9036	5	1	FAN ASSEMBLY (INCLUDES WIRE)	28480	5061-9036
BT1	1420-0341	5	1	BATTERY 3.0V 1.2A-HR LITHIUM POLYCARBON MONOFLOURIDE	08709	BR 2/3A SSP

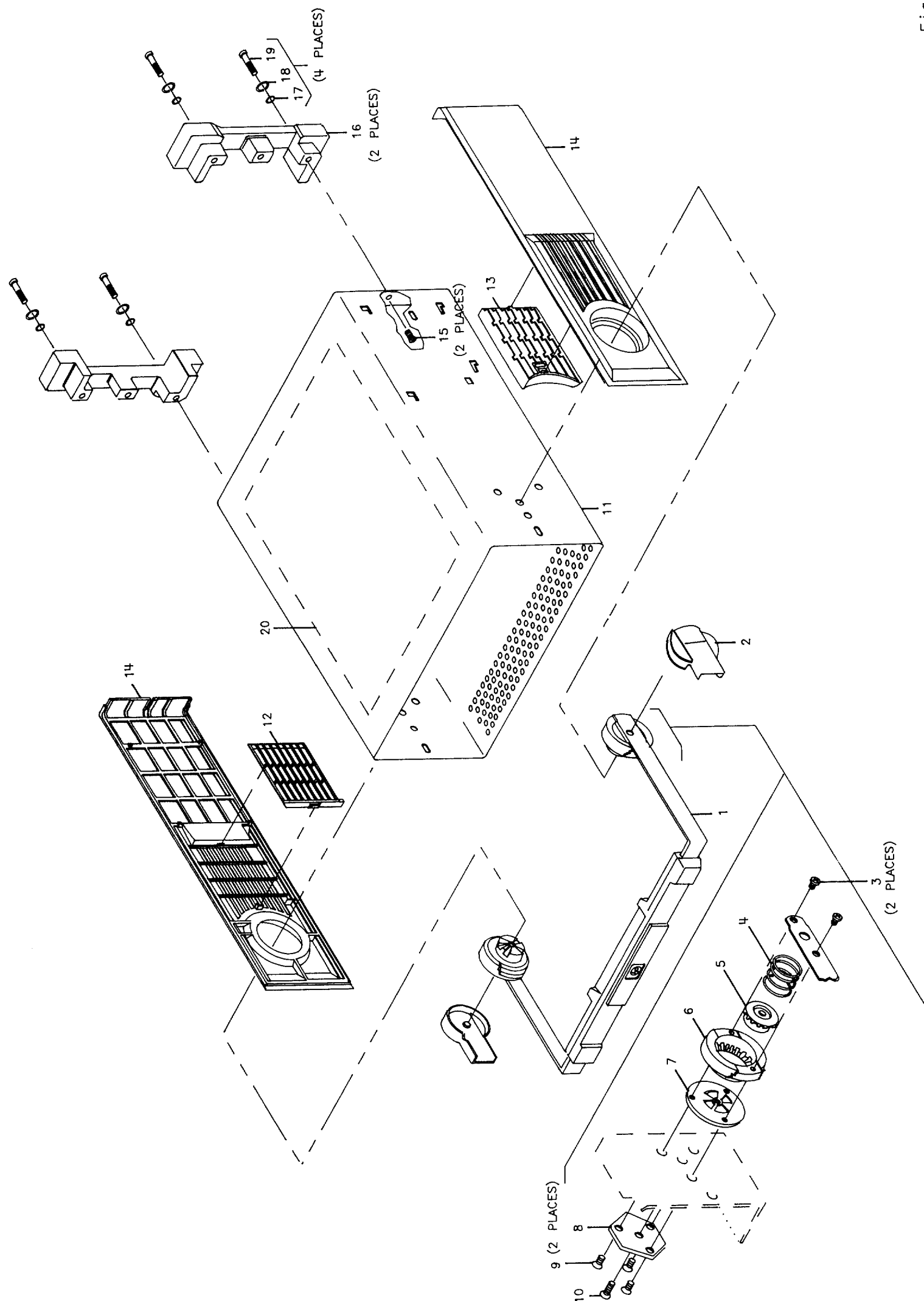
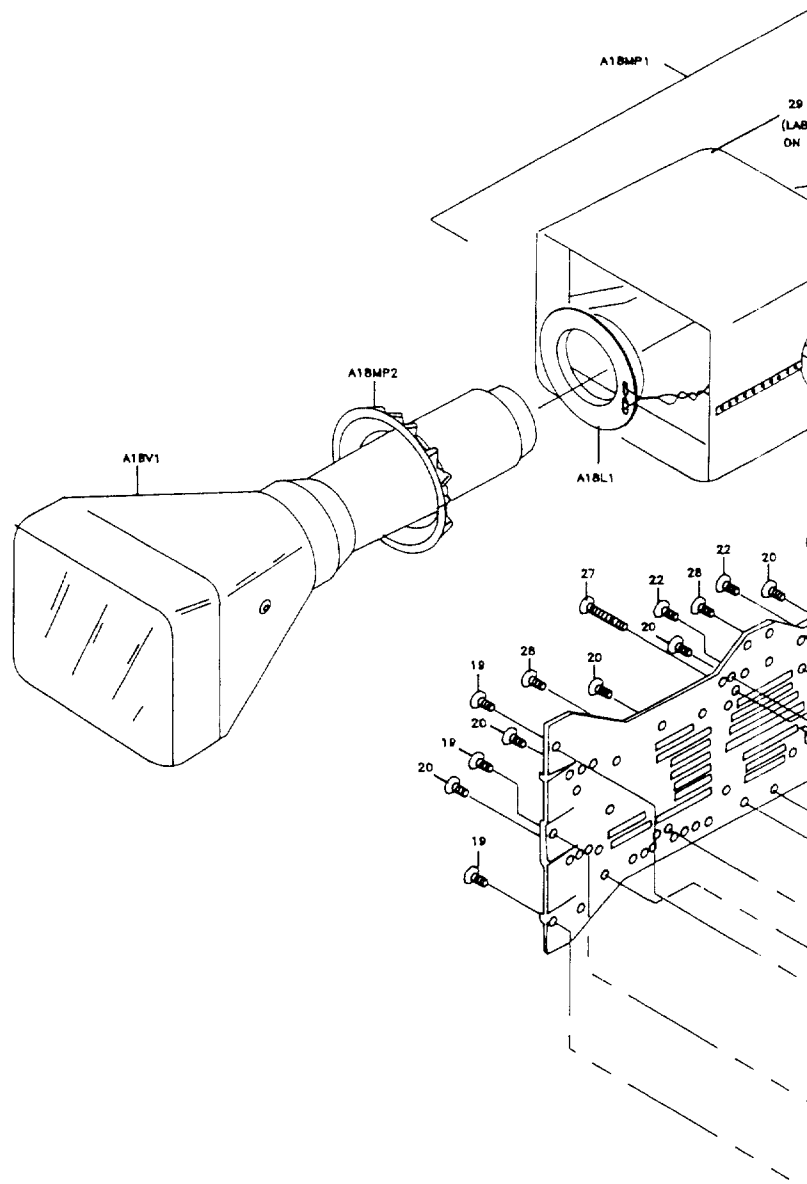
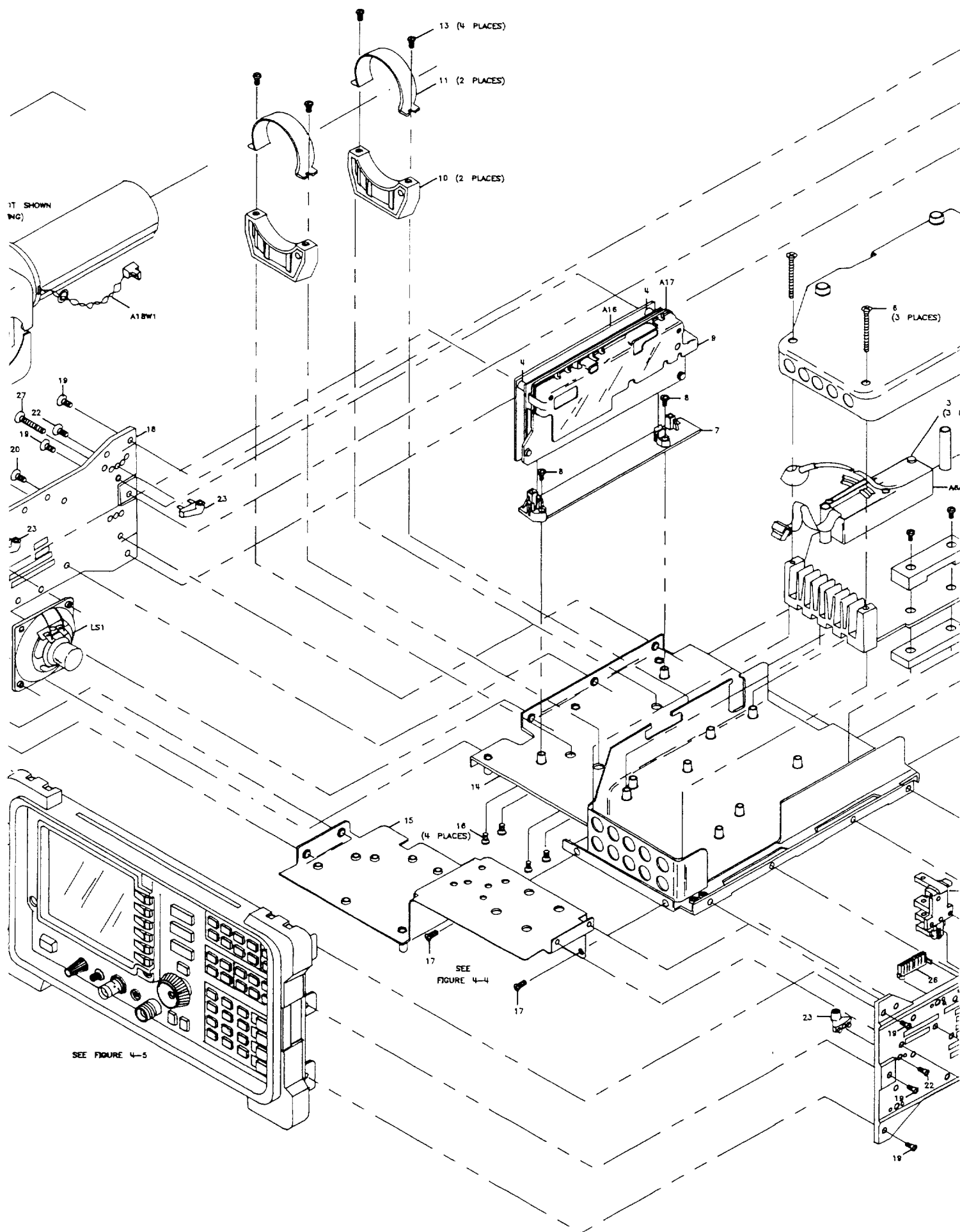


Figure 4-2. Parts Identification, Cover Assembly





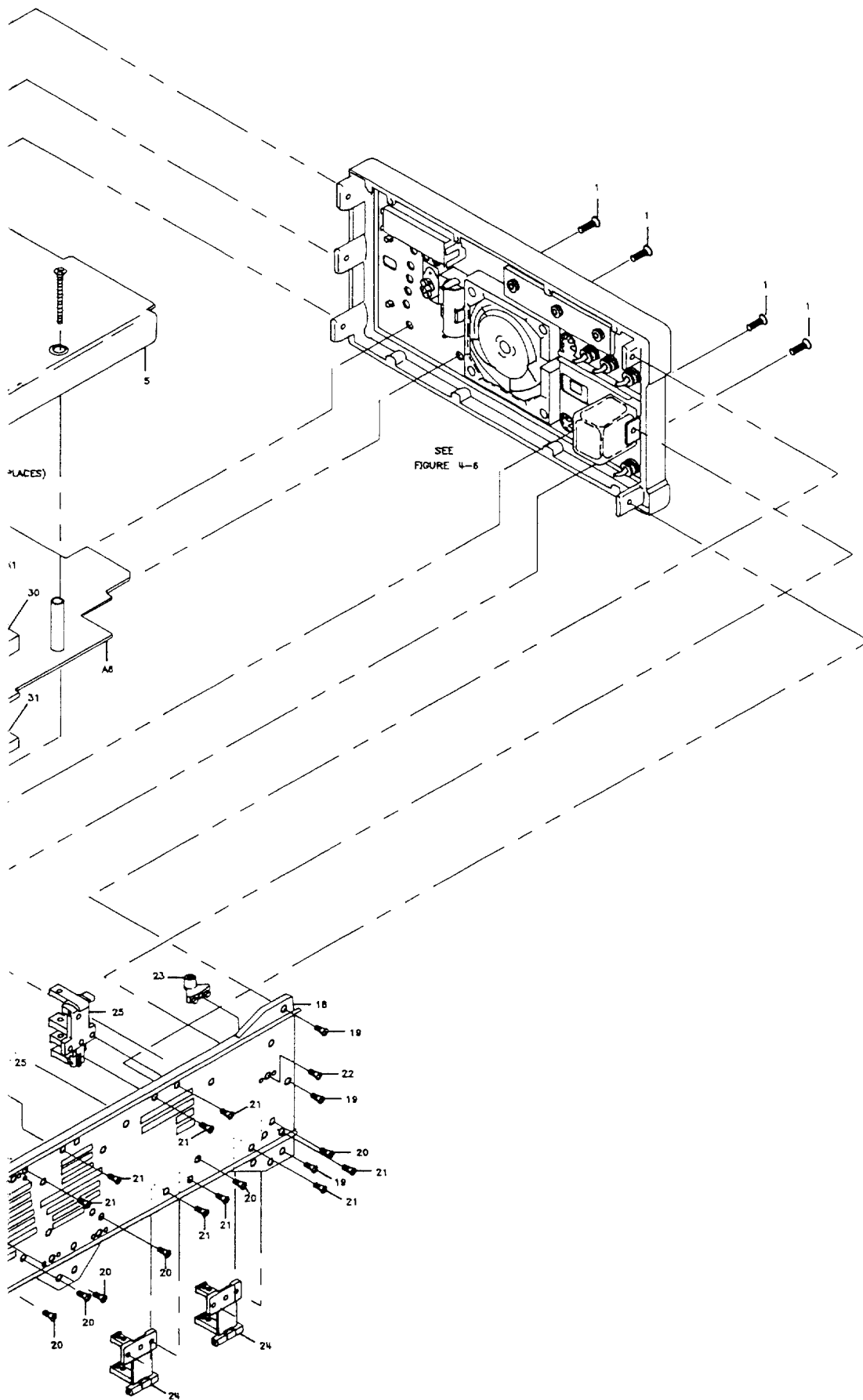
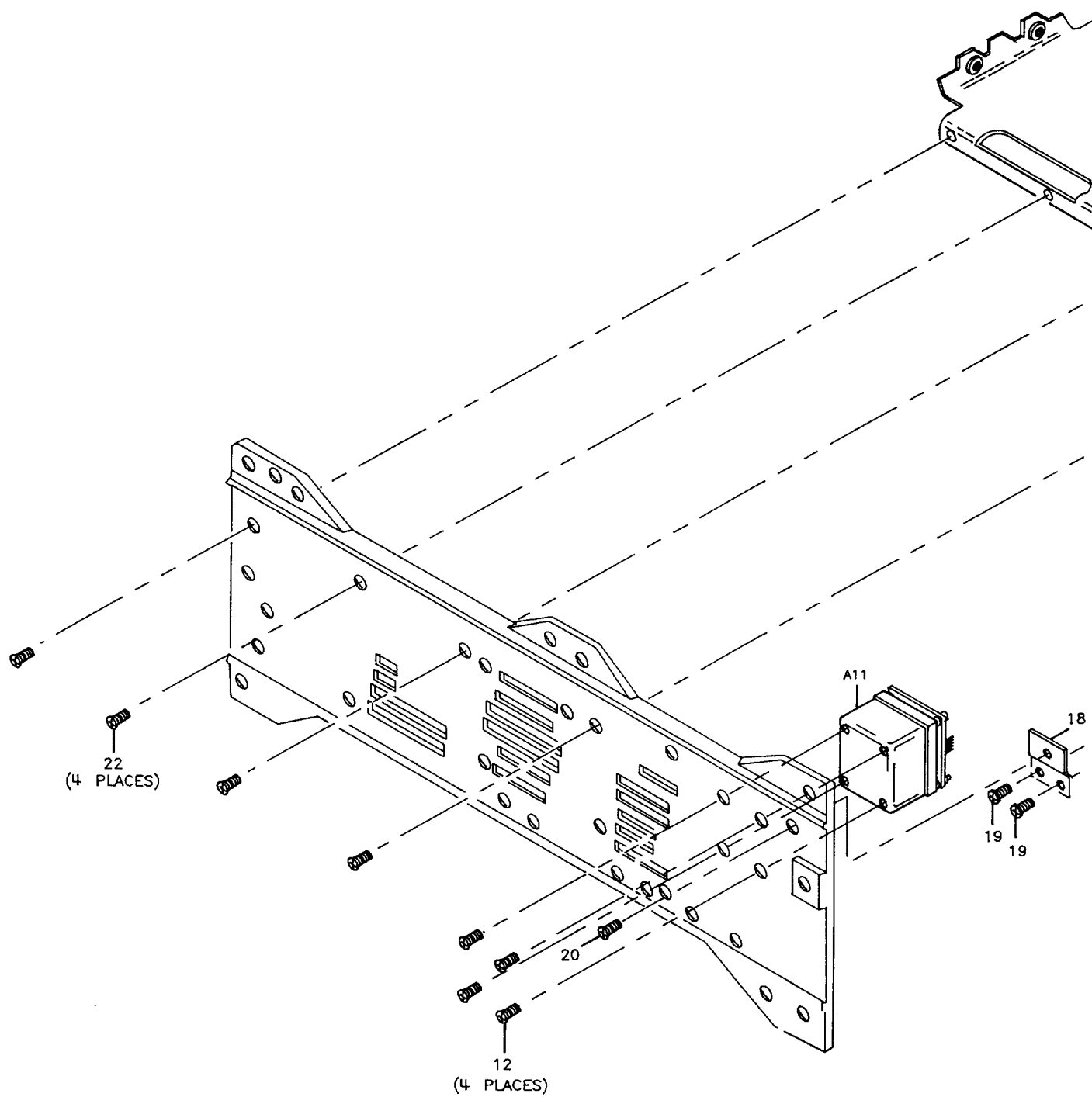


FIGURE 4-3. PARTS IDENTIFICATION, MAIN CHASSIS



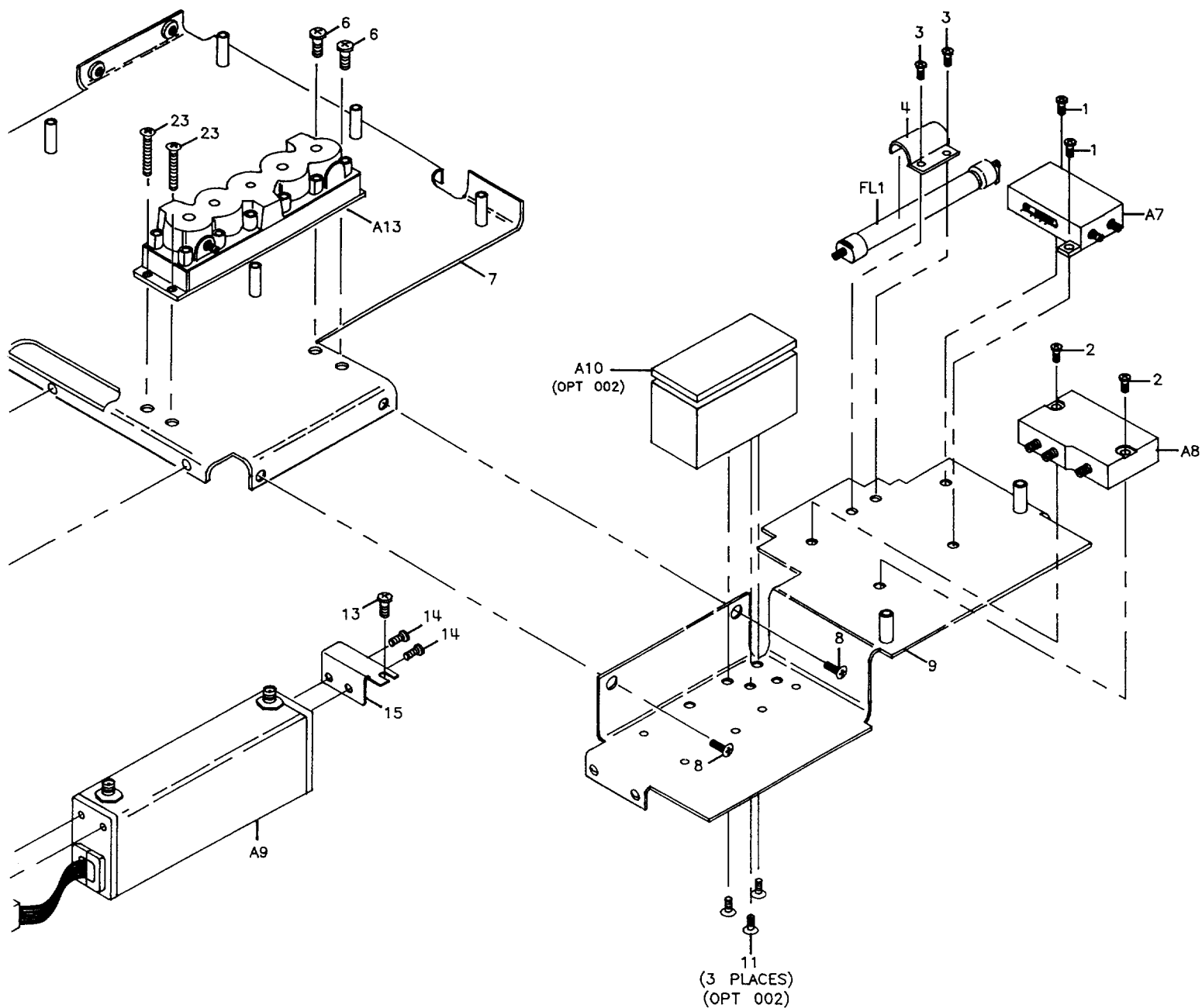
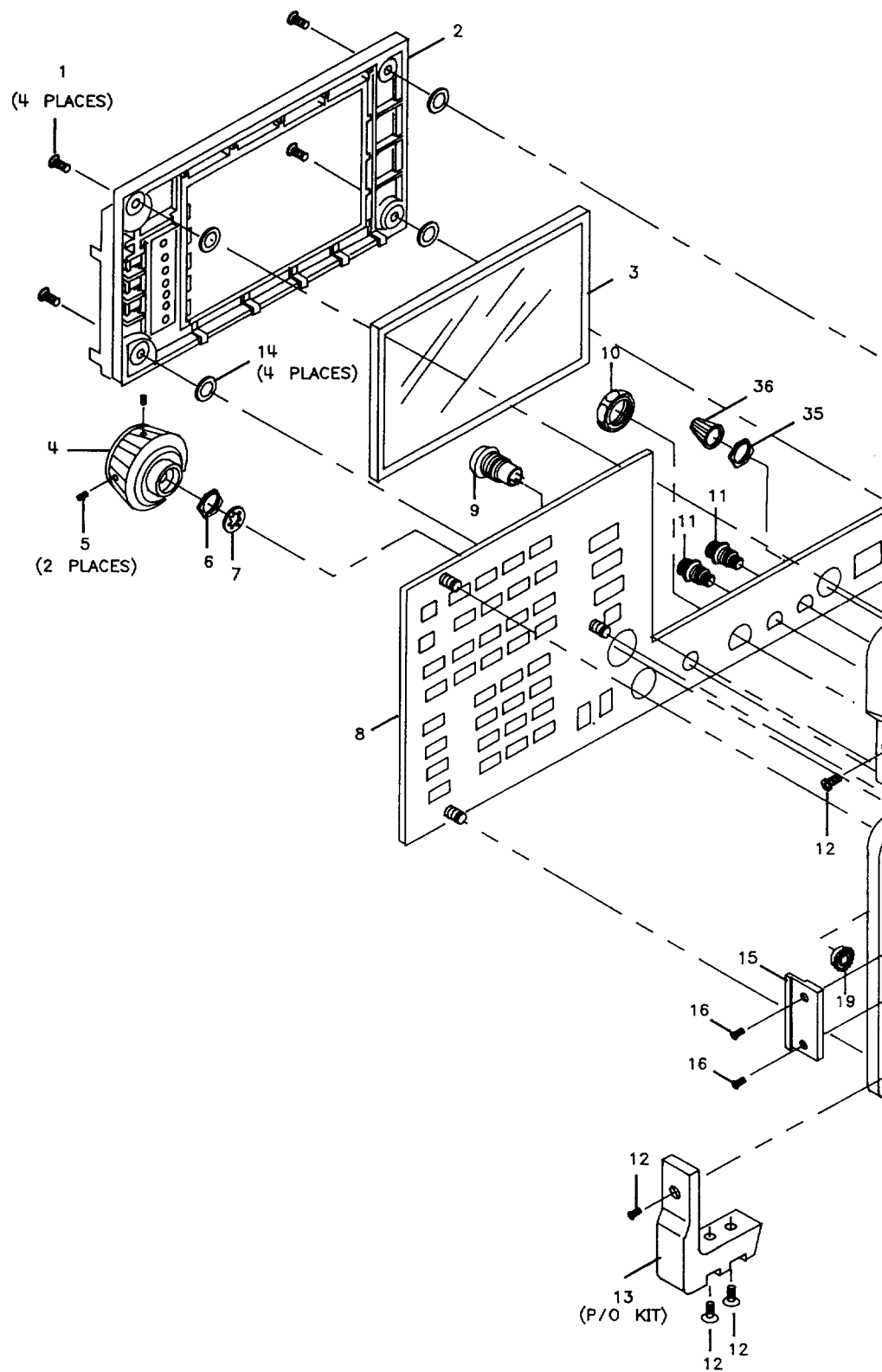


Figure 4-4. Parts Identification, RF Section



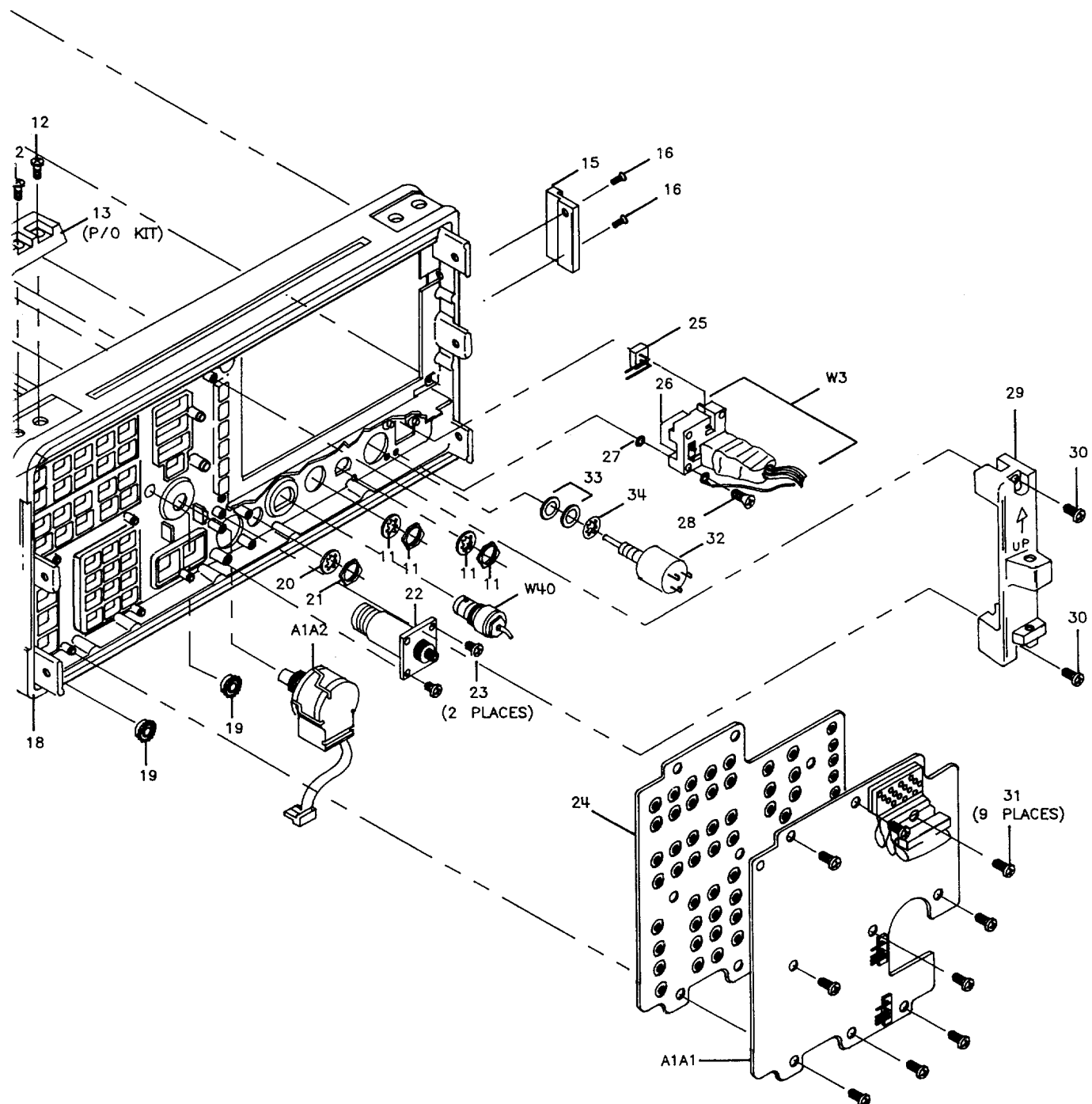
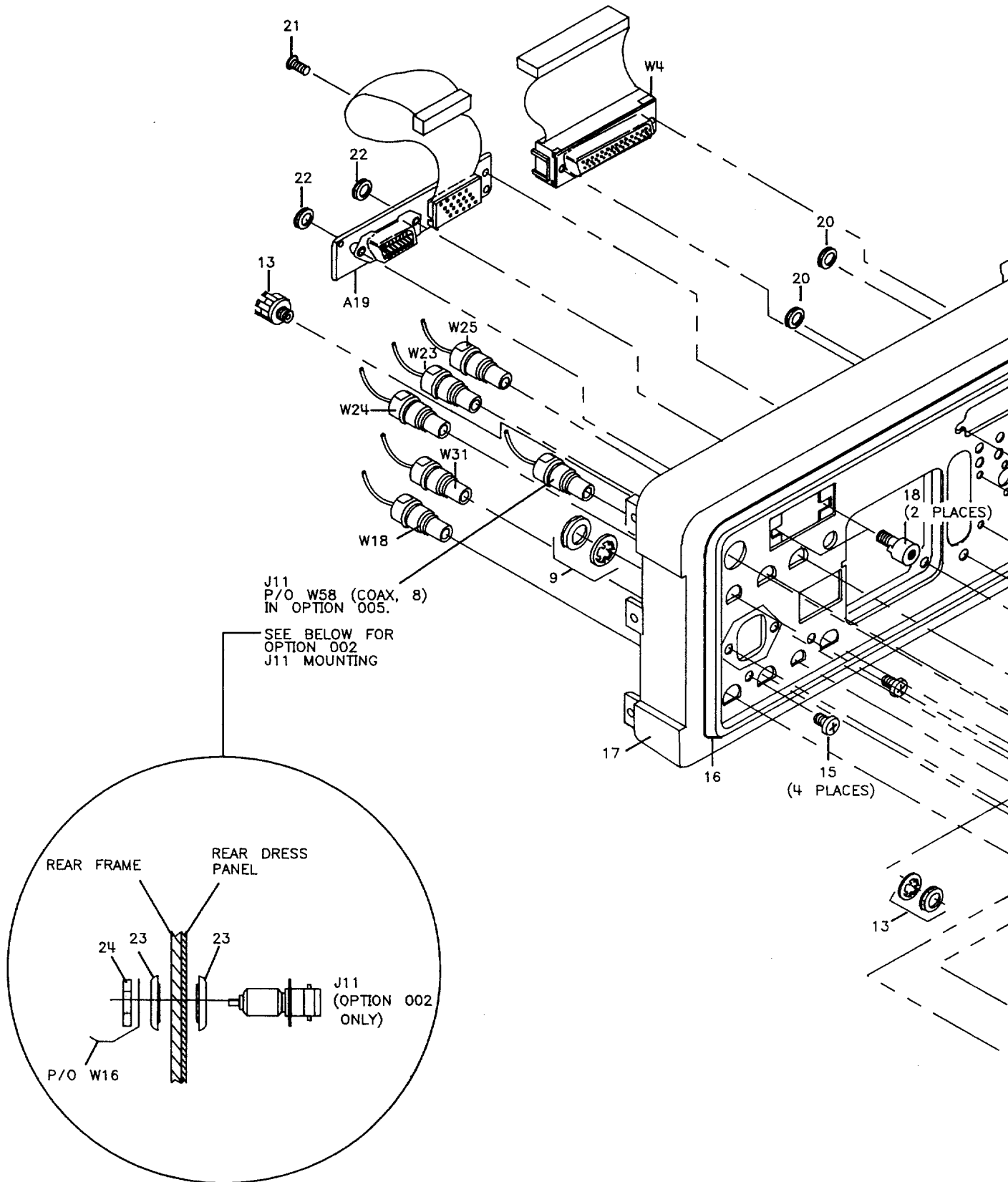


Figure 4-5. Parts Identification, Front Frame



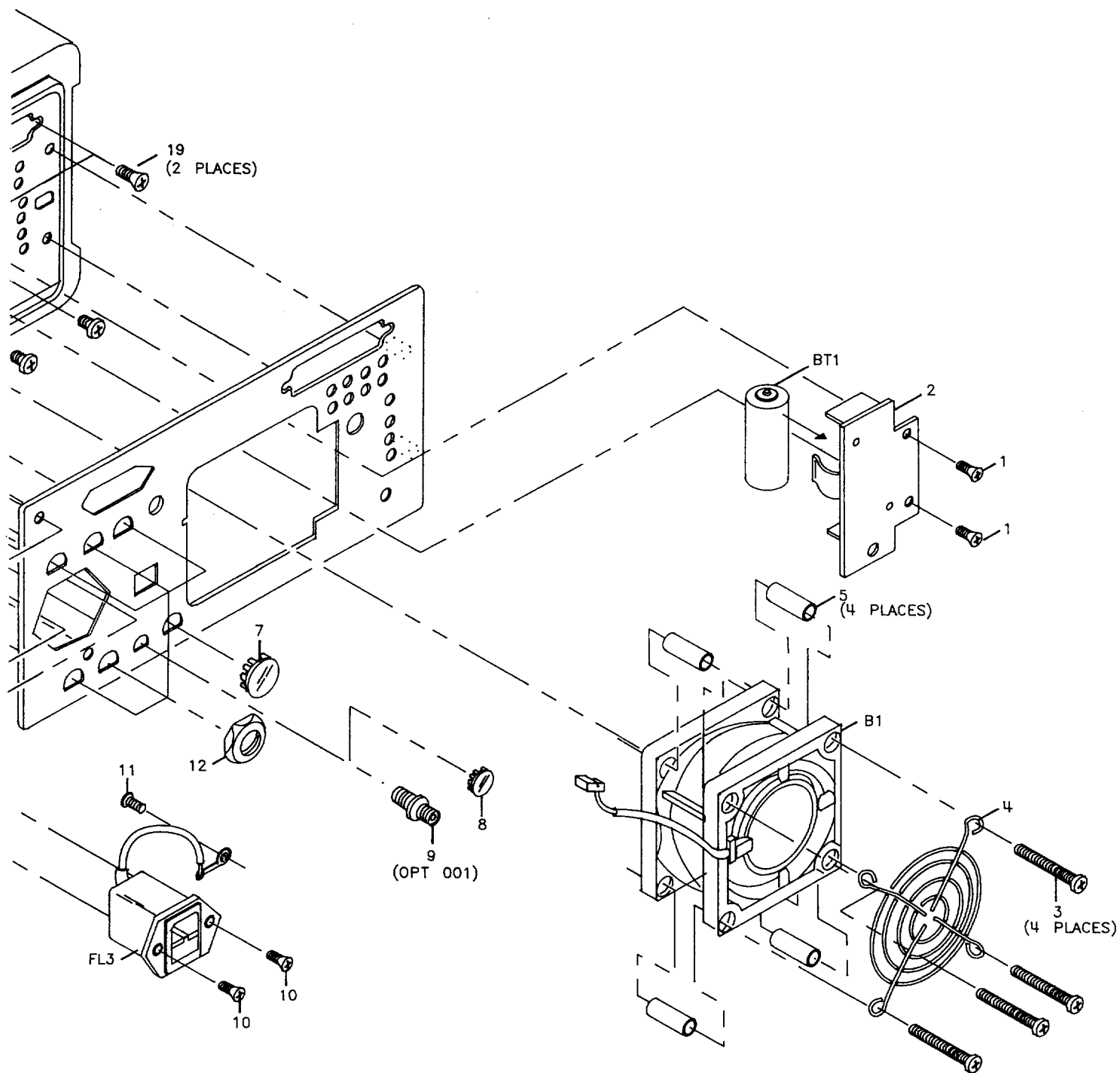


Figure 4-6. Parts Identification, Rear Frame

Major Assembly and Cable Locations

Introduction

This chapter identifies the instrument's assemblies and cables and contains the following figures:

- Figure 5-1. Hinged Assemblies
- Figure 5-2. Top View (A2 Unfolded)
- Figure 5-3. Top View (A2 and A3 Unfolded)
- Figure 5-4. Top View (A2, A3, A4, and A5 Unfolded)
- Figure 5-5. Bottom View (A15 Unfolded)
- Figure 5-6. Bottom View (A15 and A14 Unfolded)
- Figure 5-7. Front End
- Figure 5-8. Rear View

Use the list below to determine the figure(s) illustrating the desired assembly or cable.

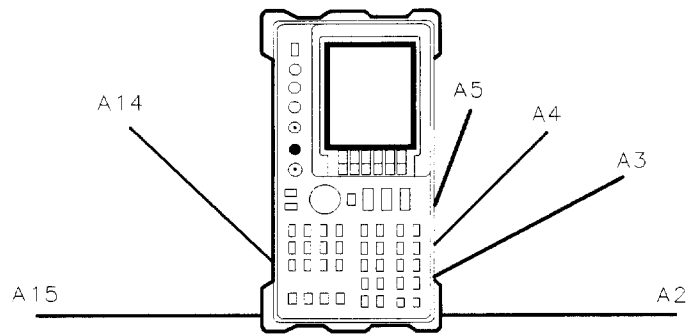
Assemblies	Figure
A1 Front Frame	5-6
A1A1 Keyboard	5-6
A2 Controller	5-1, 5-2
A3 Interface	5-1, 5-2
A4 Log Amplifier/Cal Oscillator	5-1, 5-3
A5 IF Filter	5-1, 5-4
A6 Power Supply	5-4
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A7 LO Distribution Amplifier	5-7
A8 Low Band Mixer	5-7
A9 RF Attenuator	5-7
A10 Tracking Generator (Option 002)	5-7
A11 YTO	5-7
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A13 Second Converter	5-7
A14 Frequency Control	5-1, 5-6
A15 RF	5-1, 5-5, 5-6
A16 Fast ADC (Option 007)	5-2, 5-4
A17 CRT Driver	5-4
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Assemblies	Figure
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B1 Fan	5-8
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FL1 Low Pass Filter	5-7
FL2 Low Pass Filter	5-7
FL3 Line Filter	5-8
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Cables	Figure
A1A1W1 Keyboard Cable	5-2, 5-4
A3W1 Interface Cable	5-2
A19W1 HP-IB Cable	5-2, 5-4
W1 Power Cable	5-2, 5-3, 5-4, 5-5
W2 Control Cable	5-2, 5-3, 5-4, 5-5
W3 Line Switch Cable	5-4, 5-7
W4 Option Module Cable	5-4
W5 (NOT ASSIGNED)	
W6 Battery Cable	5-2
W7 Display/FADC Cable	5-2
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W9 CRT Yoke Cable	5-4
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W27 Filter 10.7 MHz	5-3, 5-4
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W29 10.7 IF (coax 7)	5-4, 5-5
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W31 Ref. In/Out (coax 8)	5-5
W32 Sampler IF (coax 87)	5-5, 5-6
W33 Second LO Drive (coax 81)	5-5, 5-7

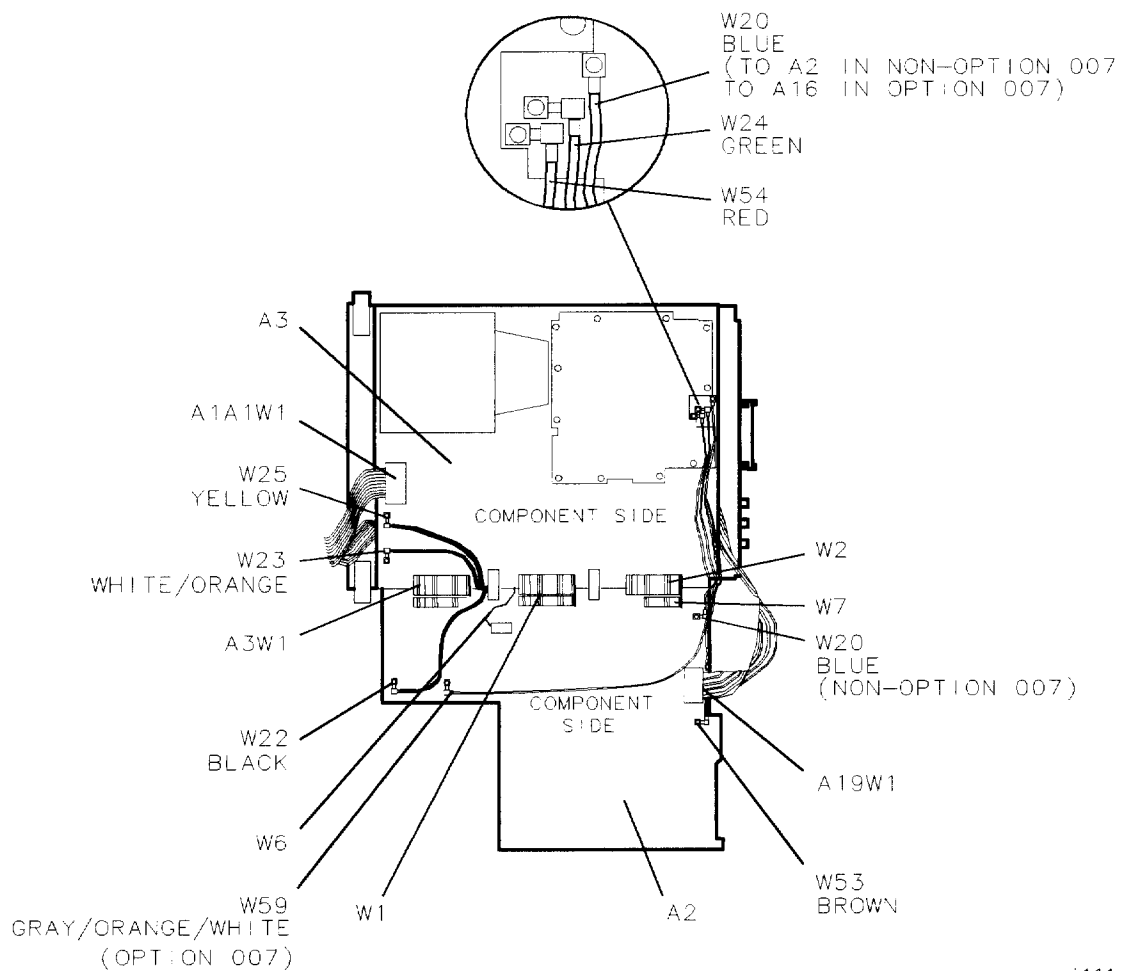
5-2 Major Assembly and Cable Locations

Cables	Figure
W34 First LO Samp. (coax 0)	5-5, 5-6, 5-7
W35 Int Second IF (coax 92)	5-5, 5-7
W36 Ext Second IF (coax 86) (Deleted in Opt. 002)	5-5
W37 10 MHz Ref 1 (coax 85)	5-5, 5-6
W38 Semirigid coax, A11J2 to A7J1	5-7
W39 Semirigid coax, A7J2 to A8J3	5-7
W40 Cal. Out (coax 89)	5-5
W41 Semirigid coax, front-panel J1 to A9J1	5-7
W42 Semirigid coax, A7J3 to front-panel J4 (Standard)	5-7
W43 Semirigid coax, A7J3 to A10J4 (Option 002)	5-7
W44 Semirigid coax, A9J2 to FL1J1	5-7
W45 Semirigid coax, FL1J2 to A8J1	5-7
W46 Semirigid coax, A10J3 to front-panel J4 (Option 002)	5-7
W47 Semirigid coax, A10J2 to front-panel J6 (Option 002)	5-7
W48 A10 600 MHz (coax 80) (Option 002)	5-5
W49 OCXO 10 MHz output (coax 82)	5-5
W50 OCXO power (part of A21 OCXO assembly)	5-5
W51 10 MHz IN (coax 84)	5-3, 5-5
W52 CAL Oscillator Out (coax 9)	5-4
W53 Frequency Counter (coax 1)	5-2, 5-3
W54 Video (coax 2)	5-2, 5-3
W55 Audio Out	5-3, 5-4
W56 Semirigid coax, A8J2 to FL2J1	5-7
W57 Semirigid coax, FL2J2 to A13J1	5-7
W58 ALT SWEEP OUT (coax 8)	5-6
W59 FADC klok (coax 839) (Option 007)	5-2



SK155

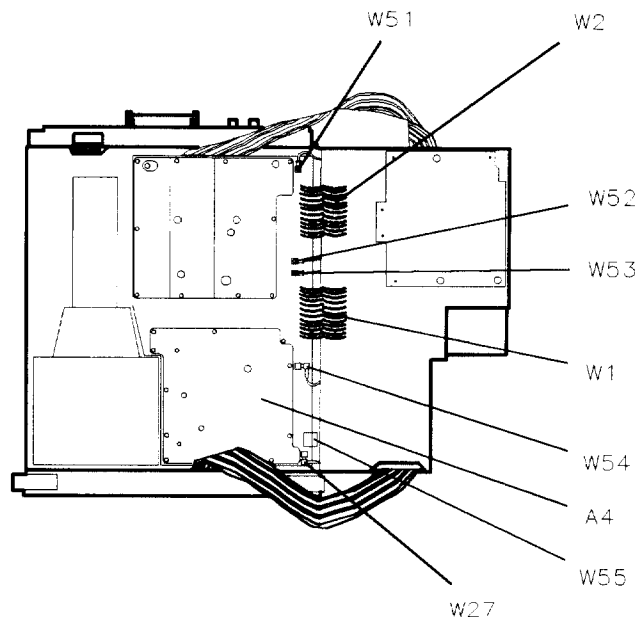
Figure 5-1. Hinged Assemblies



sj111e

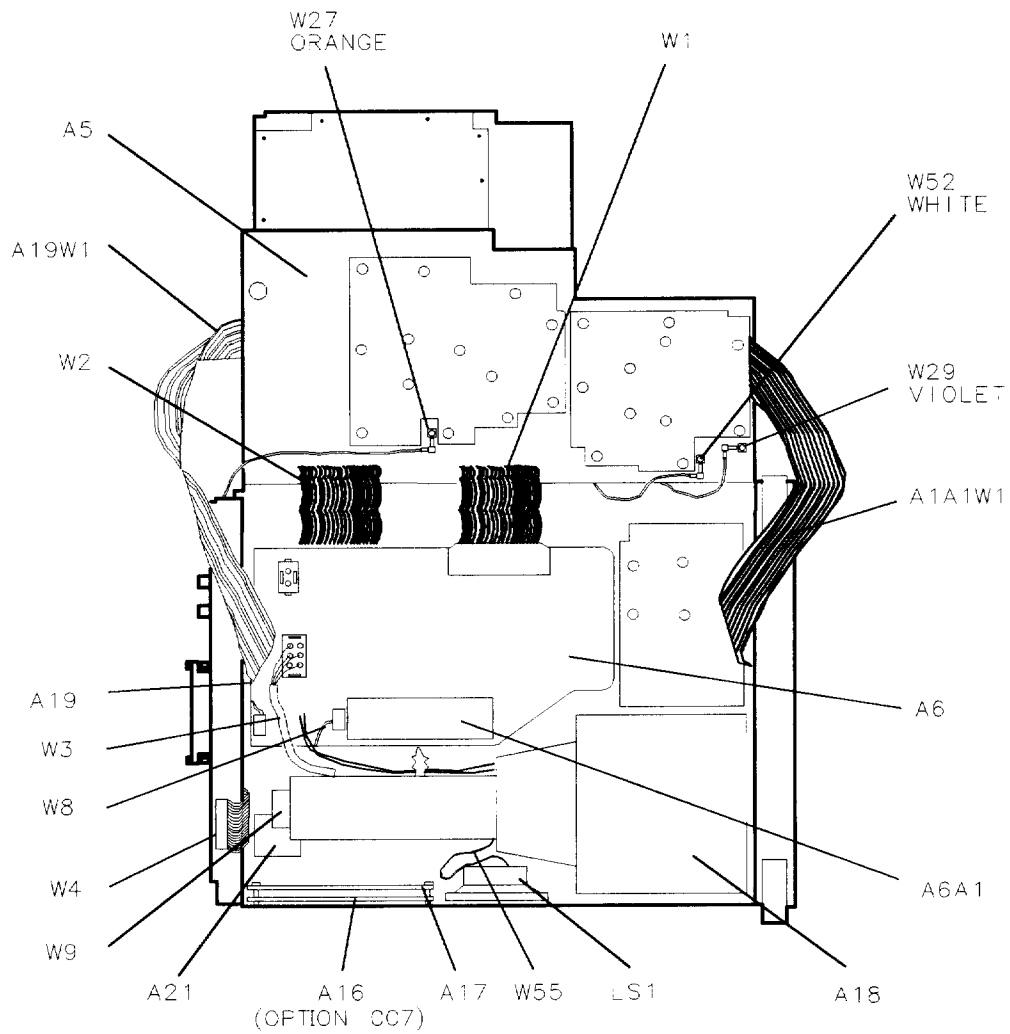
Figure 5-2. Top View (A2 Unfolded)

5-4 Major Assembly and Cable Locations



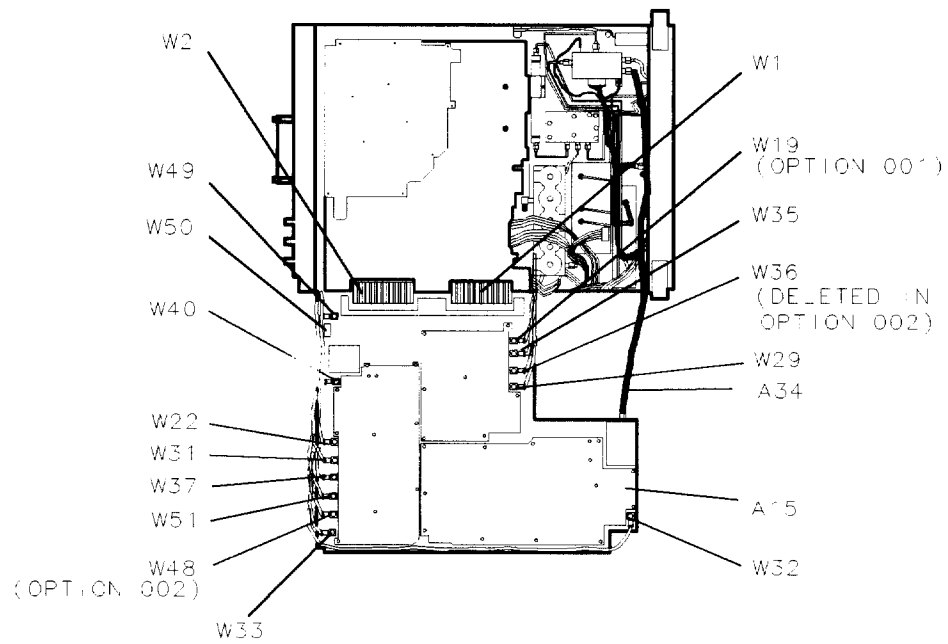
SK 157

Figure 5-3. Top View (A2 and A3 Unfolded)



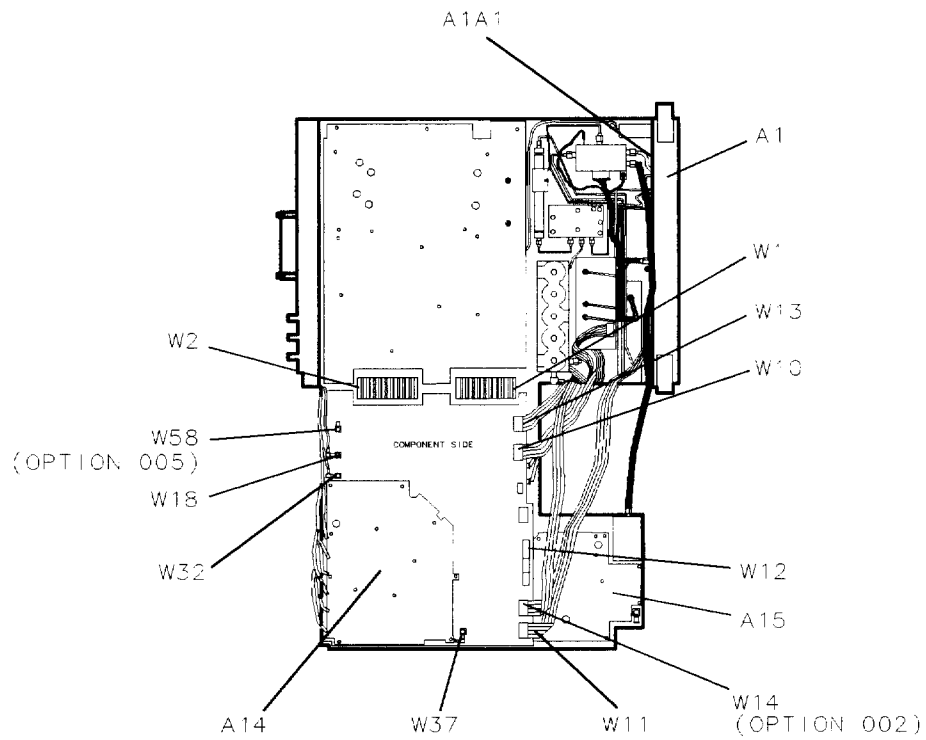
SP110E

Figure 5-4. Top View (A2, A3, A4, and A5 Unfolded)



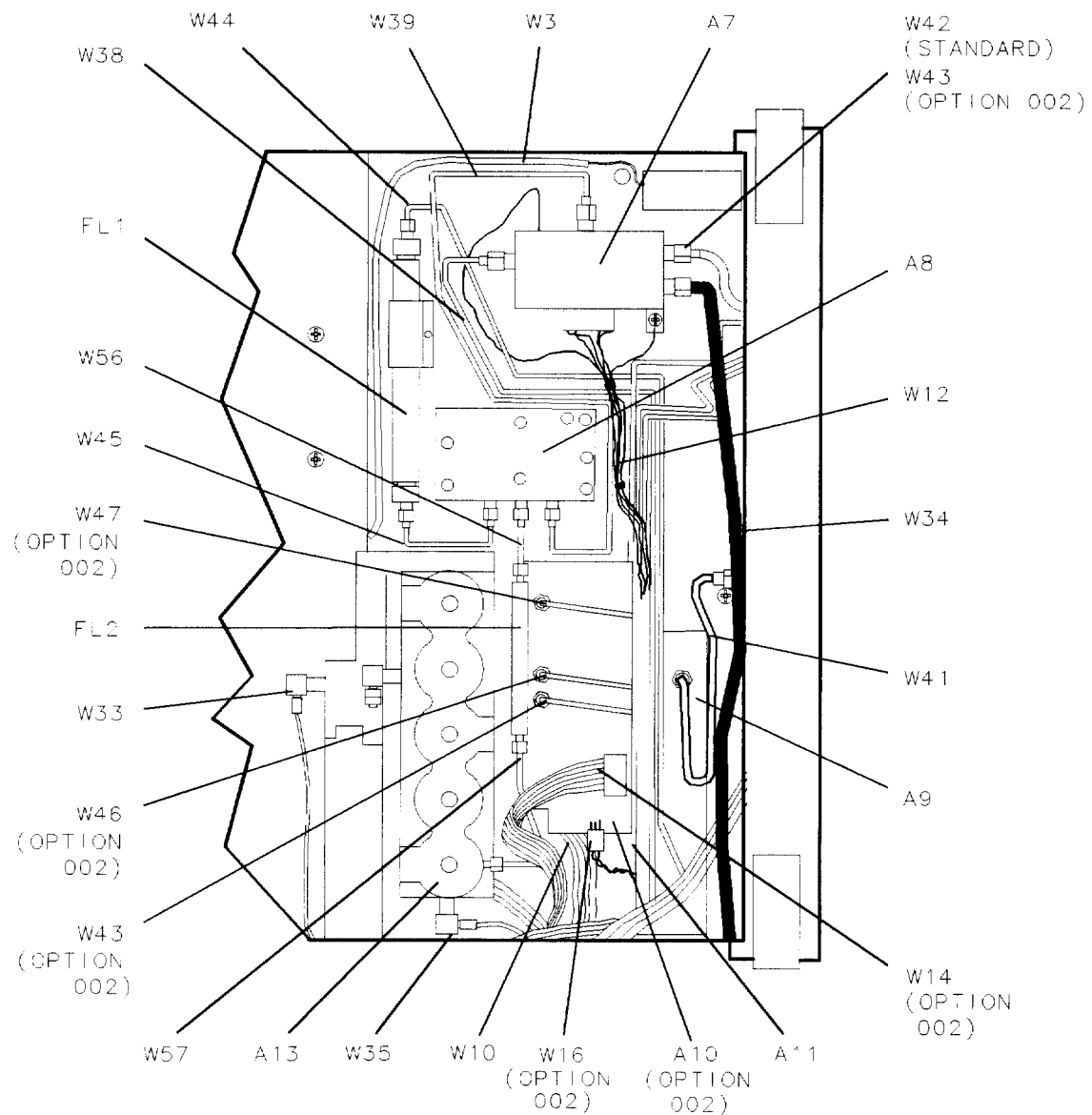
sj112e

Figure 5-5. Bottom View (A15 Unfolded)



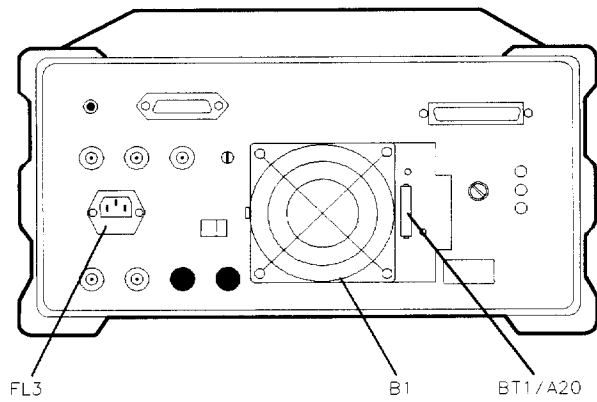
sj113e

Figure 5-6. Bottom View (A15 and A14 Unfolded)



sj137e

Figure 5-7. Front End



sj 14e

Figure 5-8. Rear View

General Troubleshooting

Introduction

This chapter provides information needed to troubleshoot the instrument to one of the six major functional sections. Chapters 7 through 12 cover troubleshooting for each of these sections. Before troubleshooting, read the rest of this introduction. To begin troubleshooting, refer to “Troubleshooting to a Functional Section” in this chapter.

Troubleshooting to a Functional Section
Using the TAM
Error Messages
System Analyzer Programming Errors (100 to 150)
Block Diagram Description

Note	When a part or assembly is replaced, adjustment of the affected circuitry is usually required. Refer to Chapter 2, “Adjustment Procedures.”
-------------	---

Warning	Troubleshooting and repair of this instrument without the cover exposes high voltage points that may, if contacted, cause personal injury. Maintenance and repair of this instrument should, therefore, be performed only by a skilled person who knows the hazards involved. Where maintenance can be performed without power applied, the power should be removed. When any repair is completed, be sure that all safety features are intact and functioning and that all necessary parts are connected to their grounds.
----------------	--

Assembly Level Text

To locate troubleshooting information for an individual assembly, refer to Table 6-1.

Block Diagrams

Instrument-level block diagrams are located at the end of this chapter. Power levels and voltages shown on block diagrams are provided as a troubleshooting aid only. They should not be used for making instrument adjustments.

Assembly Test Points

The spectrum analyzer's board assemblies contain four types of test points: post, pad, extended component lead, and test jack. Figure 6-1 illustrates each type of test point as seen on both block diagrams and circuit boards. The name of the test point will be etched into the circuit board next to the test point (for example, TP2). In some instances, the test point will be identified on the board by its number only.

Pad

Each pad test point uses a square pad and a round pad etched into the board assembly. The square pad is the point being measured. The round pad supplies a grounding point for the test probe.

Test Jack

The test jack is a collection of test points located on a 16-pin jack. There are over 26 test jacks used throughout the spectrum analyzer. The HP 85629B Test and Adjustment Module uses the spectrum analyzer's test jacks during diagnostic and adjustment procedures. The pins on the test jack may be manually probed, provided caution is used to prevent accidental shorting between adjacent pins.

Figure 6-1 illustrates the pin configuration for the test jack. Line names are the same for all test jacks. The following mnemonics are used: MS "measured signal," TA "test and adjustment Module address line," and OS "output signal." Test jack test points are identified on block diagrams by both the jack/pin number and line name.

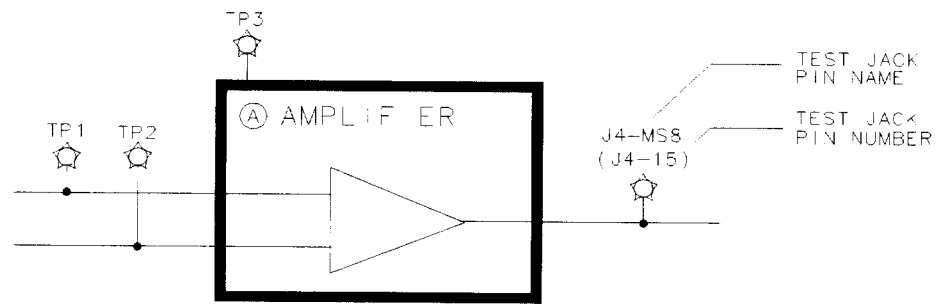
Ribbon Cables

Ribbon cables are used extensively in the spectrum analyzer. The following five cables use different pin numbering methods on the jacks (signal names remain the same but the pin numbers vary):

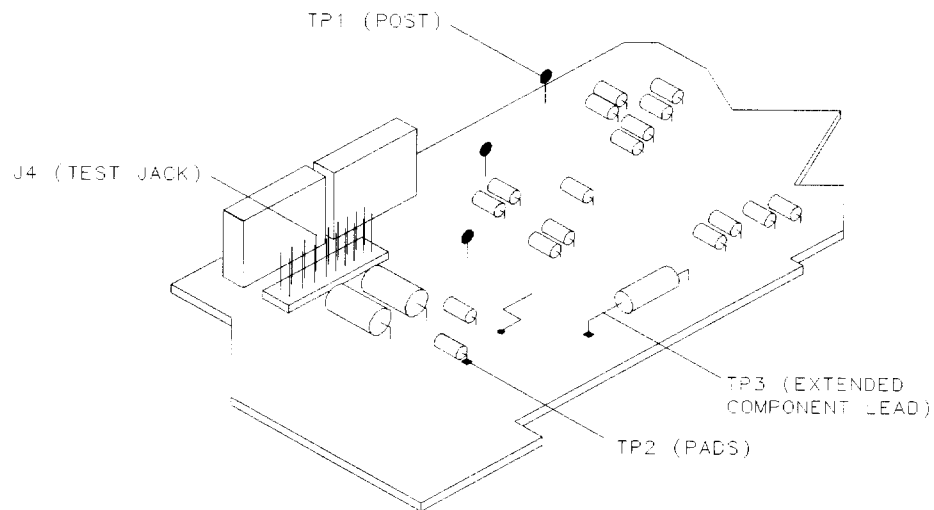
- W1, Power Cable
- W2, Control Cable
- W4, Option Cable
- A3W1, Interface Cable
- A19W1, HP-IB Cable

Figure 6-2 illustrates the pin configurations of these five cables. Cables W1 and W2 use two pin numbering methods on their many jacks. These methods are identified in the interconnect and block diagrams by the letters "A" and "B" next to the jack designator (for example, J1(A)). Board assembly jacks connected to W1 will always be labeled J1. Board assembly jacks connected to W2 will always be labeled J2.

TEST POINTS ON BLOCK DIAGRAM

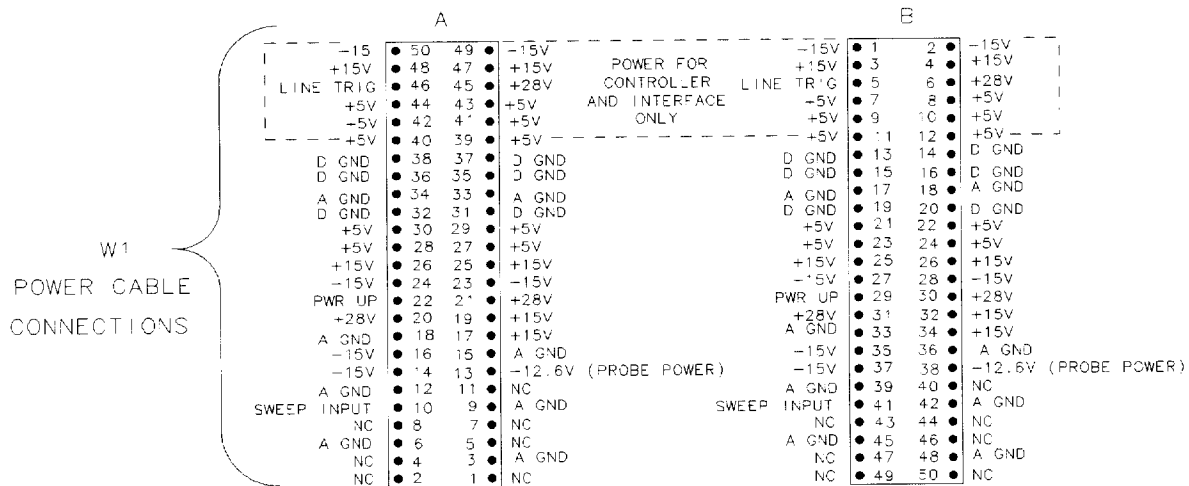


TEST POINTS ON CIRCUIT BOARD ASSEMBLY

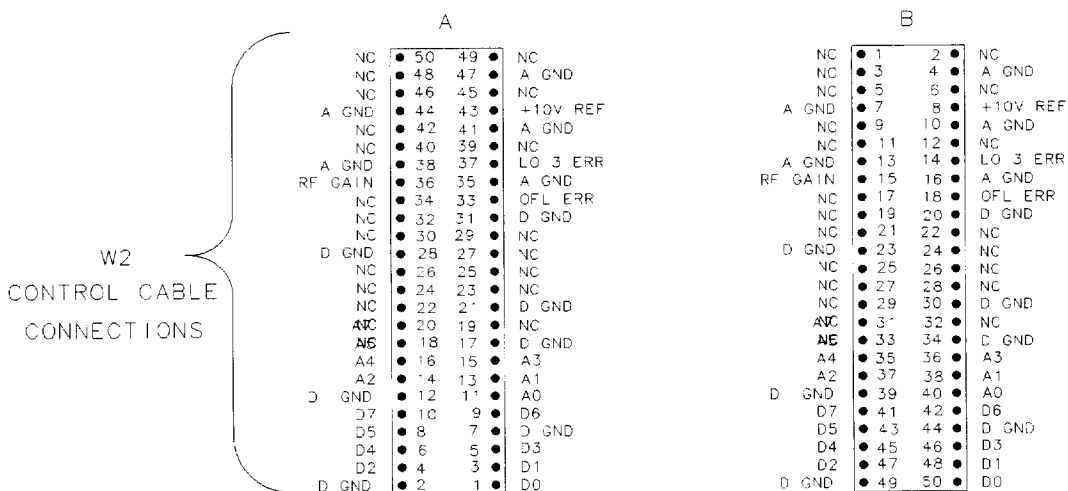


SK163

Figure 6-1. Assembly Test Points

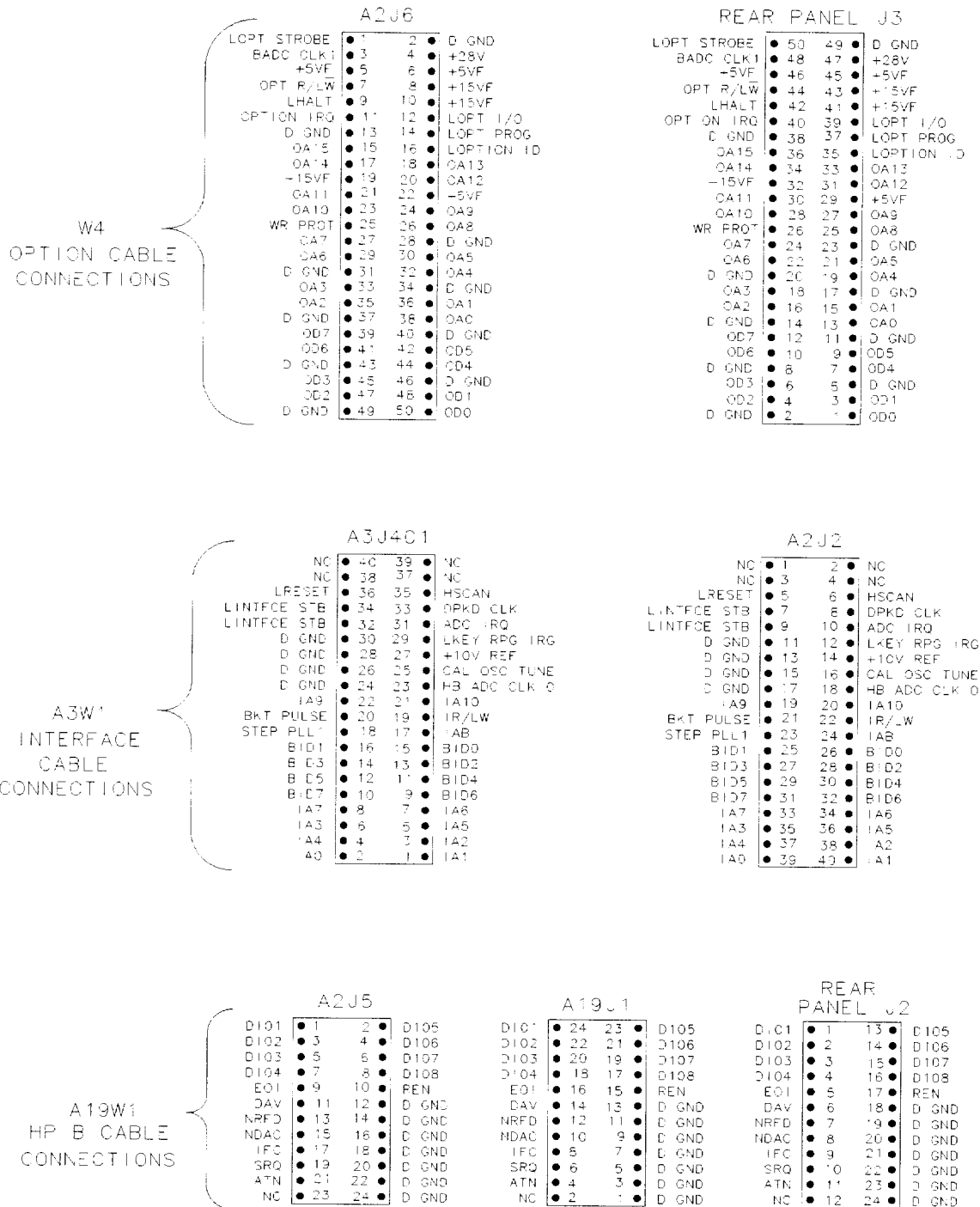


*NOTE: Sweep Input for the Controller or Interface boards only.



sp149e

Figure 6-2. Ribbon Cable Connections



sp150e

Figure 6-2. Ribbon Cable Connections (2 of 2)

Service Cal Data Softkey Menus

The jumper on jack A2J12 is shipped from the factory in the WR PROT (write protect) position (jumper on pins 2 and 3). When the jumper is set to the WR ENA (write enable) position (jumper on pins 1 and 2), an additional service cal data menu is displayed under **CAL**. Figure 6-3 illustrates those areas of the service cal data menu that are available.

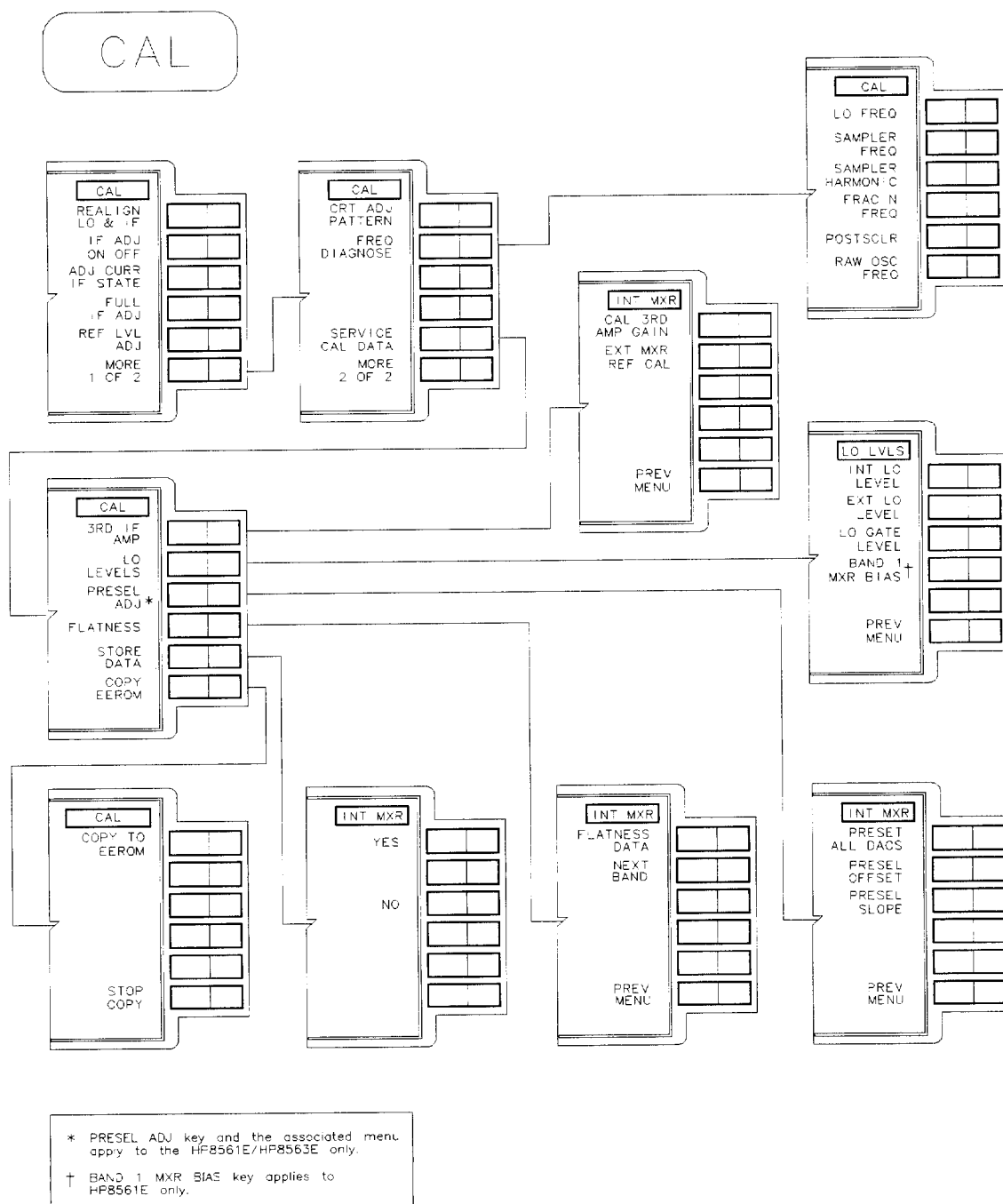


Figure 6-3. Service Cal Data Menu

Troubleshooting to a Functional Section

1. Refer to Table 6-1 for the location of troubleshooting information.
2. If the HP 85629B Test and Adjustment Module (TAM) is available, refer to "Using the TAM" in this chapter.
3. If error messages are displayed, refer to "Error Messages" in this chapter. You will find both error descriptions and troubleshooting information.
4. If a signal cannot be seen, and no errors messages are displayed, the fault is probably in the RF section. Refer to Chapter 11, "RF Section."
5. Blank displays result from problems caused by either the controller or display/power-supply sections. Because error messages 700 to 755 caused by the controller section cannot be seen on a blank display, use the following BASIC program to read these errors over HP-IB. If the program returns an error code of 0, there are no errors.

```
10 DIM Err$(128)
20 OUTPUT 718;"ERR?;"
30 ENTER 718; Err$
40 PRINT Err$
50 END
```

- a. If there is no response over HP-IB, set an oscilloscope to the following settings:
Sweep time 2 ms/div
Amplitude scale 1 V/div
 - b. The signals at A2J202 pin 3 and pin 14 should measure about 4 Vp-p. If the levels are incorrect, refer to Chapter 9 and troubleshoot the A2 controller assembly.
 - c. Set the oscilloscope to the following settings:
Sweep time 1 ms/div
Amplitude scale 2 V/div
 - d. The signal at A2J202 pin 15 should consist of TTL pulses. If the signal is at a constant level (high or low), troubleshoot the A2 controller assembly.
6. Display problems such as intensity or distortion are caused by either the controller or display/power-supply sections. Refer to Chapter 9 or Chapter 12.

Table 6-1. Location of Assembly Troubleshooting Text

Instrument Assembly	Location of Troubleshooting Text
A1A1 keyboard	Chapter 7. ADC/Interface Section
A1A2 RPG	Chapter 7. ADC/Interface Section
A2 controller	Chapter 9. Controller Section
A3 interface	Chapter 7. ADC/Interface Section
	Chapter 8. IF Section
A4 log amplifier/cal oscillator	Chapter 8. IF Section
A5 IF	Chapter 8. IF Section
A6 power supply	Chapter 12. Display/Power Supply Section
A6A1 HV module	Chapter 12. Display/Power Supply Section
A7 1ST LO dist. ampl.	Chapter 10. Synthesizer Section
A8 low band mixer	Chapter 11. RF Section
A9 input attenuator	Chapter 11. RF Section
A10 tracking generator	Chapter 11. RF Section
A11 YTO	Chapter 10. Synthesizer Section
A13 2nd converter	Chapter 11. RF Section
A14 frequency control	Chapter 10. Synthesizer Section
	Chapter 11. RF Section
A15 RF assembly	Chapter 10. Synthesizer Section
	Chapter 11. RF Section
A17 CRT driver	Chapter 12. Display/Power Supply Section
A18 CRT	Chapter 12. Display/Power Supply Section
A19 HP-IB	Chapter 9. Controller Section
FL1,2	Chapter 11. RF Section

Using the TAM

When attached to the spectrum analyzer's rear panel, the HP 85629B test and adjustment module (TAM) provides diagnostic functions for supporting the HP 8560E. Because the TAM is connected directly to the spectrum analyzer's internal data and address bus, it controls the spectrum analyzer's hardware directly through firmware control. It would be impossible to control the hardware to the same extent either from the spectrum analyzer's front panel or over the HP-IB.

- Revision C (date code 890704), or later, of the HP 85629B TAM firmware supports the HP 8560E spectrum analyzer.

The TAM measures voltages at key points in the circuitry and flags a failure whenever the voltage falls outside the limits. The TAM locates the failure to a small functional area which can be examined manually. Remember the following when using the TAM:

- Be sure the spectrum analyzer's power is turned off when installing or removing the TAM.
- Use the **HELP** softkey (found in all menus) for useful information.
- Pressing **MODULE** will return you to the TAM's main menu.
- The TAM acts as the active controller on the HP-IB bus. No other active controller should be connected to the bus.

Diagnostic Functions

The TAM provides the three diagnostic functions listed below. (Additional menu selections support the TAM itself.) Refer to the following for a description of each function.

Diagnostic

1. Automatic Fault Isolation
2. Manual Probe Troubleshooting (*requires cover removal*)
3. Cal Oscillator Troubleshooting Mode (*requires cover removal*)

Note	The HP 85629B test and adjustment modules with firmware revision A or B will not properly execute automatic fault isolation on the HP 8560E spectrum analyzer.
-------------	--

TAM Requirements

For the TAM to function properly, certain parts of the spectrum analyzer must be operating properly. These include the CPU, parts of the program ROM and program RAM, the keyboard and keyboard interface, and the display.

Even though the TAM communicates to the operator via the display, some display problems can be troubleshoot using the TAM. This is possible by using the **Print Page** softkey. Even if the display is dead, **Print Page** is still active. Refer to Chapter 12 for instructions on using the TAM when the display is not functioning.

Test Connectors

The TAM uses a built-in dc voltmeter and DAC to measure voltages on any one of the “test connectors” located throughout the HP 8560E.

Note	HP 85629B test and adjustment modules with firmware revisions A or B cannot make valid measurements on test connector A14J16 on standard HP 8560E spectrum analyzers, nor test connector A14J17 on HP 8560E Option 002 spectrum analyzers.
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Revision Connectors

One test connector on each assembly is reserved as a “revision connector.” The TAM uses the revision connector to identify the assembly’s design revision. A “revision voltage” (placed onto one measured signal line, MSL, pin) indicates design changes.

The TAM must be plugged into the revision connector first to determine which tests to use for the assembly. If the revision connector has not been probed, a message will appear instructing you to connect the probe to the revision connector and press **TEST**. You can then probe the rest of the assembly’s connectors.

Note	If the revision of the PC board is newer than the TAM, a message will be displayed stating that the revision code for this board is not known by this module. The choices presented are to use the test for the latest known revision board, measure only voltages, or exit. In general, most points will not change from one board revision to another, so using the most current tests is still very useful. However, any failure should be verified using the manual troubleshooting procedures before doing a repair.
-------------	---

Inconsistent Results

Many of the signals measured by the TAM are digitally controlled. If inconsistent results are obtained, or if failures appear in unrelated areas, the digital control may be at fault. Refer to the manual troubleshooting procedures for those assemblies to isolate those failures.

Erroneous Results

If the TAM manual probe troubleshooting seems to be giving erroneous results, its performance can be checked by placing the probe on the TAM test connector (A2J11) located on the A2 controller assembly and executing the manual probe diagnostics. If either of the tests fail, the TAM is malfunctioning and should be serviced.

Blank Display

It is possible to use the TAM's manual probe troubleshooting without a display if an HP-IB printer is available. Refer to Chapter 12 for more information.

Automatic Fault Isolation

Automatic fault isolation (AFI) is designed to isolate most faults to one or two assemblies. AFI can be run with the spectrum analyzer's cover in place and requires only the CAL OUTPUT signal as a stimulus. The entire procedure takes less than 2 minutes to complete if no failures are found.

AFI performs checks of five functional areas in a pre-defined sequence. The sequence minimizes the chance of making false assumptions. The TAM checks the spectrum analyzer "from the inside out." For example, the ADC is checked before the IF is checked. This ensures that if no signal is detected through the IF, the fault is in the IF section and not a faulty ADC. (The ADC measures the video signal from the IF section.)

The sequence of checks is as follows:

1. Controller check
2. ADC/interface check
3. IF/LOG check
4. LO control check
5. RF low band check

Display/Power Supply

AFI cannot check the display/power-supply section because this section powers the TAM and provides the display of AFI results.

Controller Check

The TAM performs a checksum of all ROMs, RAMs, and the EEROM. The CPU is also checked, since parts of the CPU could be nonfunctional while the TAM still operates. These checks are very similar to those done by the spectrum analyzer at power-on.

ADC/Interface Check

The keyboard interface and strobe-select circuitry must be functioning correctly, since these are required to operate the TAM. The TAM checks the ADC by attempting to measure three signals from three different locations. This ensures that an open or short in one cable will not hide the fact that the ADC is operating satisfactorily.

The analog bus (W2 control cable) is checked by sending data out on the data lines and reading the data back. If this check fails, disconnect one board at a time and rerun AFI to determine if an assembly causes the problem. If the fault remains with all assemblies disconnected from W2, troubleshoot W2 or the A3 interface assembly.

IF/LOG Check

The TAM uses the cal oscillator on the A4 assembly as the stimulus for checking the IF section. If the signal is undetected, the TAM repeats the test with a signal originating from the RF section. Presence of this signal through the IF indicates a faulty cal oscillator.

LO Control Check

The LO control check verifies test that all phase-lock loops (PLLs) in the synthesizer section lock. (Some oscillators are checked to ensure that they will lock outside their normal operating frequency range.) The TAM also performs an operational check on several DACs in the synthesizer section.

RF Check

The TAM tests the operation of A8 low band mixer, A9 input attenuator, second IF distribution, and most of the A13 second converter.

AFI also checks the flatness compensation amplifiers (part of the A15 RF assembly), ensuring that their gain can be adjusted over a certain range.

If no signal is detected through the RF section, AFI will substitute the 298 MHz SIG ID oscillator (Option 008 only) for the 3rd LO while simultaneously decreasing the 1st LO frequency by 2 MHz. If a signal can now be detected, troubleshoot the 3rd LO driver amplifier on the A15 RF assembly.

Manual Probe Troubleshooting

Manual probe troubleshooting probes the instrument's test connectors to perform the following types of measurements:

- Amplifier and oscillator dc current draw by monitoring the voltage across a resistor of known value.
- Oscillator tune voltages ensuring proper operation of phase/frequency detectors and loop integrators.
- Static bias voltages.

If probing a connector for a check yields a "FAIL" indication, select the desired check using either the knob or step keys and press **More Info**. A description of the function checked (with measured and expected voltages/currents) is displayed with a list of additional areas to check. These areas can sometimes be checked by looking at another TAM connector, but usually require manual troubleshooting techniques to isolate the problem further. If an HP-IB printer is connected, press **Print Page** to provide a hard copy of the currently displayed screen (the softkey labels will not be printed).

Each test connector has fifteen pins (one pin is missing to act as a key). The pins contain eight measured signal lines (measured signal lines denoted as MS1 through MS8), one input signal line (OS1), one ground, and five pins encoding a five-bit connector address.

The TAM needs to probe each assembly's revision connector once; subsequent readings are not necessary. It is possible, for example, to probe the A5 IF assembly, then the A4 log amplifier assembly, and then return to A5 without having to re-probe A5's revision connector. However, the revision connector must be re-probed if the spectrum analyzer is returned to normal operation and then back to TAM control. (This is also true if the spectrum analyzer is turned off.)

Cal Oscillator Troubleshooting Mode

The cal oscillator troubleshooting mode enables front-panel control of the cal oscillator on the A4 assembly. The cal oscillator can be fixed-tuned to three different frequencies. The cal oscillator may also be set to one of five sweep widths, centered at 10.7 MHz.

Fixed-tuned settings:

- 11.5 MHz
- 10.7 MHz
- 9.9 MHz

Sweep-width settings:

- 20 kHz
- 10 kHz
- 4 kHz
- 2 kHz

The cal oscillator troubleshooting mode sends the cal oscillator output (-35 dBm) to the A5 IF assembly. On the A5 IF assembly all crystal filter poles are shorted, all LC poles enabled, and the 15 dB attenuator disabled. Signals from the RF section are attenuated as much as possible.

Error Messages

The spectrum analyzer displays error messages in the lower right-hand corner of the display. A number, or error code, is associated with each error message. These error messages alert the user to errors in spectrum analyzer function or use.

Multiple error messages may exist simultaneously. Refer to “Viewing Multiple Messages” below.

The following information can be found in this section:

- Viewing Multiple Messages
- Error Message Elimination
- System Analyzer Programming Errors (100 to 150)
- ADC Errors (200 to 299)
- LO and RF Hardware/Firmware Failures (300 to 399)
 - YTO Loop Errors (300 to 301)
 - Roller PLL Errors (302 to 316)
 - YTO Loop Errors (317 to 318)
 - Roller Oscillator Errors (321 to 329)
 - YTO Loop Error (331)
 - 600 MHz Reference Loop (333)
 - YTO Leveling Loop (334)
 - Sampling Oscillator (335)
 - 10 MHz Reference (336)
 - Fractional N PLL (337)
 - YTO Loop Settling Errors (351 to 354)
 - Sampling Oscillator (355)
- Automatic IF Errors (400 to 599)
- System Errors (600 to 651)
- Digital and Checksum Errors (700 to 799)
 - EEROM Checksum Errors (700 to 704)
 - Program ROM Checksum Errors (705 to 710)
 - RAM Check Errors (711 to 716)
 - Microprocessor Error (717)
- Battery Problem (718)
- Model Number Error (719)
- System Errors (750 to 759)
- Fast ADC Error (760)
- Option Module Errors (800 to 899)
- User Generated Errors (900 to 999)

Viewing Multiple Messages

Although multiple errors may exist, the spectrum analyzer displays only one error message at a time. To view any additional messages, do the following:

1. Press **RECALL** and **MORE 1 OF 2**.
2. Press **RECALL ERRORS**. An error message is displayed in the active function block.
3. Use the up and down step keys to scroll through any other error messages which might exist, making note of each error code.

Error Message Elimination

When an error message is displayed, always perform the following procedure.

1. Press **SAVE** and **SAVE STATE**.
2. Store the current state in a convenient STATE register. (It may be necessary to set **SAVELOCK** to OFF.)
3. Press **CAL** and **REALIGN LO & IF**. Wait for the sequence to finish.
4. Press **RECALL** and **RECALL STATE**.
5. Recall the previously stored STATE.
6. If an error message is still displayed, refer to the list of error messages below for an explanation of the error messages.

System Analyzer Programming Errors (100 to 150)

Refer to the *HP 8560 E-Series Spectrum Analyzer User's Guide* for information on programming the spectrum analyzer.

100 NO PWRON	Power-on state is invalid; default state is loaded. Press SAVE , PWR ON STATE to clear error message.
101 NO STATE	State to be RECALLED not valid or not SAVED.
106 ABORTED!	Current operation is aborted; HP-IB parser reset.
107 HELLO ??	No HP-IB listener is present.
108 TIME OUT	Analyzer timed out when acting as controller.
109 CtrlFail	Analyzer unable to take control of the bus.
110 NOT CTRL	Analyzer is not system controller.
111 # ARGMTS	Command does not have enough arguments.
112 ??CMD??	Unrecognized command.
113 FREQ NO!	Command cannot have frequency units.
114 TIME NO!	Command cannot have time units.
115 AMPL NO!	Command cannot have amplitude units.
116 ?UNITS??	Unrecognizable units.
117 NOP NUM	Command cannot have numeric units.
118 NOP EP	Enable parameter cannot be used.
119 NOP UPDN	UP/DN are not valid arguments for this command.
120 NOP ONOF	ON/OFF are not valid arguments for this command.
121 NOP ARG	AUTO/MAN are not valid arguments for this command.
122 NOP TRC	Trace registers are not valid for this command.

123 NOP ABLK	A-block format not valid here.
124 NOP IBLK	I-block format not valid here.
125 NOP STRNG	Strings are not valid for this command.
126 NO ?	This command cannot be queried.
127 BAD DTMD	Not a valid peak detector mode.
128 PK WHAT?	Not a valid peak search parameter.
129 PRE TERM	Premature A-block termination.
130 BAD TDF	Arguments are only for TDF command.
131 ?? AM/FM	AM/FM are not valid arguments for this command.
132 !FAV/RMP	FAV/RAMP are not valid arguments for this command.
133 !INT/EXT	INT/EXT are not valid arguments for this command.
134 ??? ZERO	ZERO is not a valid argument for this command.
135 ??? CURR	CURR is not a valid argument for this command.
136 ??? FULL	FULL is not a valid argument for this command.
137 ??? LAST	LAST is not a valid argument for this command.
138 !GRT/DSP	GRT/DSP are not valid arguments for this command.
139 PLOTONLY	Argument can only be used with PLOT command.
140 ?? PWRON	PWRON is not a valid argument for this command.
141 BAD ARG	Argument can only be used with FDIAG command.
142 BAD ARG	Query expected for FDIAG command.
143 NO PRESL	No preselector hardware to use command with.
144 COUPL??	Invalid COUPLING argument, expected AC or DC.

ADC Errors (200 to 299)

These errors are directly related to the ADC/interface section. Suspect a faulty A2 controller, A3 interface assembly, or A16 fast ADC (FADC) assembly. (Option 007).

Errors 202 through 207 apply only to spectrum analyzers with fast ADC (Option 007).

200 SYSTEM	ADC driver/ADC hardware/firmware interaction; check for other errors.
201 SYSTEM	ADC Controller/ADC Hardware/firmware interaction; check for other errors.
202 FADC CAL	Binary search failed during FADC linear offset calibration. This error applies only to spectrum analyzers with fast ADC (Option 007).

203 FADC CAL	Binary search failed during FADC log offset calibration. This error applies only to spectrum analyzers with fast ADC (Option 007).
204 FADC CAL	Binary search failed during FADC log expand offset calibration. This error applies only to spectrum analyzers with fast ADC (Option 007).
205 FADC CAL	Slope derivation failed during FADC linear offset calibration. This error applies only to spectrum analyzers with fast ADC (Option 007).
206 FADC CAL	Slope derivation failed during FADC log offset calibration. This error applies only to spectrum analyzers with fast ADC (Option 007).
207 FADC CAL	Slope derivation failed during FADC log expand offset calibration. This error applies only to spectrum analyzers with fast ADC (Option 007).
250 OUTOF RG	ADC input is outside of ADC range.
251 NO IRQ	Microprocessor not receiving interrupt from ADC.

LO and RF Hardware/Firmware Failures (300 to 399)

YTO Loop Errors (300 to 301)

These errors often require troubleshooting the A14 frequency control assembly (synthesizer section) or the ADC circuits.

300 YTO UNLK	YTO (first LO) phase locked loop is unlocked. The ADC measures YTO_ERR voltage under phase-lock condition.
301 YTO UNLK	YTO (first LO) phase locked loop is unlocked. Same as ERR 300 except ERR 301 is set if the voltage is outside certain limits.

Roller PLL Errors (302 to 316)

These errors indicate a faulty roller oscillator on the A14 frequency control assembly. Refer to Chapter 10. The A3 interface ADC circuits may also be faulty. If error codes 333 and 499 are present, suspect the 10 MHz reference, the A21 OCXO, or on the A15 assembly (Option 103). These errors do not apply to the hardware in an HP 8560 E-Series spectrum analyzer. If they occur in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

302 OFF UNLK

Offset roller oscillator PLL is unlocked. May indicate loss of 10 MHz reference. The 10 MHz reference should measure greater than -7 dBm at A15J303. The ADC measures OFFSENSE at the beginning of each sweep and, if the voltage is outside certain limits, the offset oscillator pretuned DAC is adjusted to bring OFFSENSE within the proper range. ERR 302 is set if this cannot be accomplished. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

303 XFR UNLK

Transfer roller oscillator PLL is unlocked. May indicate loss of 10 MHz reference. The 10 MHz reference should measure greater than -7 dBm at A15J303. The ADC measures XFRSENSE at the beginning of each sweep and, if the voltage is outside certain limits, the transfer oscillator pretuned DAC is adjusted to bring XFRSENSE within the proper range. ERR 303 is set if this cannot be accomplished. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

304 ROL UNLK

Main roller oscillator PLL is unlocked. May indicate loss of 10 MHz reference. The 10 MHz reference should measure greater than -7 dBm at A15J303. The ADC measures MAINSENSE at the beginning of each sweep and, if the voltage is outside certain limits, the main roller pretune DAC is adjusted to bring OFFSENSE within the proper range. ERR 304 is set if this cannot be accomplished. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

305 FREQ ACC

Unable to adjust MAINSENSE close to 0 volts using the coarse adjust DAC. The coarse adjust and fine adjust DAC are used together to set MAINSENSE to 0 volts with the loop opened. ERR 305 is set if the coarse adjust DAC cannot bring MAINSENSE close enough to 0 volts for the fine adjust DAC to bring MAINSENSE to exactly 0 volts. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

306 FREQ ACC

Unable to adjust MAINSENSE to 0 volts using the fine adjust DAC. The coarse adjust and fine adjust DAC are used together to set MAINSENSE to 0 volts with the loop opened. ERR 306 is set if the fine adjust DAC cannot bring MAINSENSE to 0 volts. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

307 FREQ ACC	Transfer oscillator pretuned DAC out of range. The transfer oscillator pretune procedure attempts to find pretuned DAC values by programming the PLL to 25 different frequencies and incrementing the transfer oscillator pretune DAC until XFRSENSE changes polarity. ERR 307 is set if the DAC is set to 255 (maximum) before XFRSENSE changes polarity. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
308 FREQ ACC	Offset oscillator pretune DAC not within prescribed limits at low frequency. The offset oscillator pretune DAC is set to provide a frequency less than 189 MHz while the PLL is programmed for 189 MHz. ERR 308 is set if XFRSENSE is greater than +5 V (it should be at the negative rail). This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
309 FREQ ACC	Offset oscillator pretune DAC not within prescribed limits at high frequency. The offset oscillator pretune DAC is set to provide a frequency less than 204 MHz while the PLL is programmed for 204 MHz. ERR 309 is set if XFRSENSE is greater than +5 V (it should be at the negative rail). This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
310 FREQ ACC	Main roller pretune DAC set to 255. The main roller pretune DAC is set to 5, causing MAINSENSE to go to the positive rail. The DAC is incremented until MAINSENSE changes polarity. ERR 310 is set if the DAC is set to 255 before MAINSENSE changes to a negative polarity. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
311 FREQ ACC	Main roller pretune DAC set to 255. The main roller pretune DAC is set to 5, causing MAINSENSE to go to the positive rail. The DAC is incremented until MAINSENSE changes polarity. ERR 311 is set if the DAC is set to 255 before MAINSENSE changes to a negative polarity. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
312 FREQ ACC	Unable to adjust MAINSENSE to 0 volts using the fine adjust DAC. The coarse adjust and fine adjust DAC are used together to set MAINSENSE to 0 volts with the loop opened. ERR 312 is set if the fine adjust DAC cannot bring MAINSENSE to 0 volts. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

- 313 FREQ ACC** Error in LO synthesis algorithm. ERR 313 is set if a combination of sampler oscillator and roller oscillator frequencies could not be found to correspond to the required YTO start frequency. Contact the factory. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 314 FREQ ACC** Indicates problems in the span calibration. Troubleshoot any unlocks before attempting to troubleshoot span calibration problems, because the loops must all lock in order to perform the calibration. If LO spans greater than 1 MHz are correct, check A14U114B , A14U115A, A14U116, or A14Q101. This error message appears when the main roller oscillator sweep sensitivity is 0. A sweep ramp is injected into the locked main roller loop which should generate a negative-going ramp on MAINSENSE. ERR 314 is set if the slope of this ramp is 0. This is an indication of an unlocked main roller loop or lack of a sweep ramp. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 315 FREQ ACC** Indicates problems in the span calibration. Troubleshoot any unlocks before attempting to troubleshoot span calibration problems, because the loops must all lock in order to perform the calibration. If LO spans greater than 1 MHz are correct, check A14U114B , A14U115A, A14U116, or A14Q101. This error message appears when the roller span attenuator DAC is out of range. This DAC value is recalculated each time there are changes to the span or start frequency. ERR 315 is set if this value is less than 10 or greater than 245. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 316 FREQ ACC** Sensitivity of main roller pretune DAC is 0. Once the main roller is locked, the MAINSENSE voltage is measured and the pretune DAC value is incremented by two. ERR 316 is set if the difference between the new MAINSENSE voltage and the previous MAINSENSE voltage is 0. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

YTO Loop Errors (317 to 318)

These messages indicate that the YTO main coil coarse DAC (ERR 317) or fine DAC (ERR 318) is at its limit. If error codes 300 or 301 are not present, a hardware problem exists in the YTO loop but the loop can still acquire lock. Refer to Chapter 10 to troubleshoot the YTO PLL. The ADC circuit on the A3 interface assembly may also cause this error.

- 317 FREQ ACC Main coil coarse DAC at limit. The main coil coarse DAC is set to bring YTO ERR close enough to 0 volts for the main coil fine DAC to bring YTO ERR to exactly 0 volts. ERR 317 is set if the main coil coarse DAC is set to one of its limits before bringing YTO ERR close enough to 0 volts.
- 318 FREQ ACC Main coil fine DAC at limit. The main coil fine DAC is set to bring YTO ERR to 0 volts after the main coil coarse DAC has brought YTO ERR close to 0 volts. ERR 318 is set if the main coil fine DAC is set to one of its limits before bringing YTO ERR to 0 volts.

Roller Oscillator Errors (321 to 329)

These errors indicate a faulty roller oscillator on the A14 frequency control assembly. Refer to Chapter 10. The A3 interface ADC circuits may also be faulty. If error codes 333 and 499 are also present, suspect the 10 MHz reference, the A21 OCXO, or the A15 assembly (Option 103). These errors do not apply to the hardware in an HP 8560 E-Series spectrum analyzer. If they occur in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

- 321 FREQ ACC Main roller tuning sensitivity is not greater than 0. The MAINSENSE voltage is noted in a locked condition and the main roller is programmed to a frequency 400 kHz higher. ERR 321 is set if the new MAINSENSE voltage is not greater than the previous MAINSENSE voltage. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 322 FREQ ACC Main roller pretune DAC value set greater than 255. During the LO adjust sequence, the main roller is locked and then programmed to a frequency 1.6 MHz higher. A new pretune DAC value is calculated based upon the main roller tuning sensitivity. ERR 322 is set if this calculated value is greater than 255. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 324 FREQ ACC Unable to adjust MAINSENSE close to 0 volts using the coarse adjust DAC. The coarse adjust and fine adjust DAC are used together to set MAINSENSE to 0 volts with the loop opened. ERR 324 is set if the coarse adjust DAC cannot bring MAINSENSE close enough to 0 volts for the fine adjust DACs to bring MAINSENSE to exactly 0 volts. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

- 325 FREQ ACC** Unable to adjust MAINSENSE to 0 volts using the fine adjust DAC. The coarse adjust and fine adjust DAC are used together to set MAINSENSE to 0 volts with the loop opened. ERR 325 is set if the fine adjust DAC cannot bring MAINSENSE to 0 volts. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 326 FREQ ACC** Fine adjust DAC near end of range. The fine adjust DAC is set to bring MAINSENSE to 0 volts. ERR 326 is set if the fine adjust DAC value is set to less than 5 or greater than 250. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 327 OFF UNLK** Offset roller oscillator PLL is unlocked. May indicate loss of 10 MHz reference. The 10 MHz reference should measure greater than -7 dBm at A15J303. The ADC measures OFFSENSE at the beginning of each sweep and, if the voltage is outside certain limits, the offset oscillator pretune DAC is adjusted to bring OFFSENSE within the proper range. ERR 327 is set if this cannot be accomplished. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 328 FREQ ACC** Roller fine adjust DAC sensitivity less than or equal to 0. During the LO adjust routine, the fine adjust DAC is set to two different values and the MAINSENSE voltage is measured at each setting. ERR 328 is set if the difference between these voltages is 0 or negative. This is typically the result of the main roller loop's being unlocked. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.
- 329 FREQ ACC** Roller coarse adjust DAC sensitivity less than or equal to 0. During the LO adjust routine, the coarse adjust DAC is set to two different values and the MAINSENSE voltage is measured at each setting. ERR 329 is set if the difference between these voltages is 0 or negative. This is typically the result of the main roller loop's being unlocked. This error is not applicable to HP 8560 E-Series spectrum analyzers. If it occurs in an HP 8560 E-Series spectrum analyzer, suspect a problem with the model number identification in the spectrum analyzer firmware.

YTO Loop Error (331)

This error rarely occurs but is usually indicative of a digital hardware failure.

- 331 FREQ ACC** Invalid YTO frequency. Firmware attempted to set the YTO to a frequency outside the range of the YTO (2.95 to 6.8107 GHz). Suspect a digital hardware problem, such as a bad RAM on the A2 controller assembly. Contact the factory.

600 MHz Reference Loop (333)

This error requires troubleshooting the A14 frequency control assembly (synthesizer section) or the ADC circuits.

333 600 UNLK

The 600 MHz reference oscillator PLL is unlocked. If error codes 302, 303, 304, 327 or 499 are also present, suspect the 10 MHz reference, the A21 OCXO, or the TCXO on Option 103, or the A15 RF assembly. ERR 333 is set if LO3ERR is outside of its prescribed limits.

YTO Leveling Loop (334)

This error often requires troubleshooting the A14 frequency control assembly or A7 LODA (synthesizer section) or the ADC circuits.

334 LO AMPL

1ST LO distribution amplifier is unlevelled. Error 334 may be displayed if the front-panel LO OUTPUT is not terminated into 50 ohms. This error is usually accompanied by error codes 300 or 301. ERR 301 YTO UNLK is cleared once ERR 334 has been cleared. Check the output of the A11 YTO with the jumper on A14J23 in the TEST position. The YTO power output should be between +9 and +13 dBm. If the YTO is working properly, refer to "A7 LODA Drive" in Chapter 10. The LODA AGC voltage is monitored by the ADC. ERR 334 is set if LODA AGC is outside of its prescribed limits. Refer to "A7 LODA Drive" in Chapter 11.

Sampling Oscillator (335)

This error indicates an unlocked sampling oscillator (also known as the offset lock loop).

335 SMP UNLK

Sampling oscillator PLL is unlocked. ERR 335 is set if OFL_ERR is outside its prescribed limits.

10 MHz Reference (336)

This message occurs during the internal IF calibration routines. The routine locks the cal oscillator to the internal 10 MHz reference, regardless of the setting of INT/EXT REF.

336 10 MHz Ref

Calibration oscillator failed to lock when going to internal 10 MHz reference.

Fractional N PLL (337)

This error indicates an unlocked fractional N phase locked loop. This error only applies to the hardware in an HP 8560 E-Series spectrum analyzer.

337 FN UNLK

Fractional N circuitry is unable to lock.

YTO Loop Settling Errors (351 to 354)

These errors are generated when the YTO loop error voltage will not stabilize at an acceptable value during the YTO loop locking routines. These errors only apply to the hardware in an HP 8560 E-Series spectrum analyzer.

351 SETL FLD	YTO error voltage is not settling.
352 TWID FLD	Unable to bring YTO error voltage DAC's to quiescent point.
353 SRCH FLD	No acceptable YTO DAC value found.
354 LK ITERS	Cannot lock. Lock iteration routine terminated.

Sampling Oscillator (355)

This error indicates an unlocked sampling oscillator during the local oscillator (LO) alignment routine. This error only applies to the hardware in an HP 8560 E-Series spectrum analyzer.

355 SMP CAL	Sampler unlock condition during calibration routine. This error remains until a successful recalibration is performed.
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Automatic IF Errors (400 to 599)

These error codes are generated when the automatic IF adjustment routine detects a fault. This routine first adjusts amplitude parameters, then resolution bandwidths in this sequence: 300 kHz, 1 MHz, 2 MHz, 100 kHz, 30 kHz, 10 kHz, 3 kHz, 1 kHz, 300 Hz, 100 Hz, 30 Hz, 10 Hz, 3 Hz, and 1 Hz. The routine restarts from the beginning if a fault is detected. Parameters adjusted after the routine begins but before the fault is detected are correct; parameters adjusted later in the sequence are suspect. Refer to "Automatic IF Adjustment" in Chapter 8.

The IF Section relies on the ADC and video circuitry to perform its continuous IF adjustments. IF-related errors occur if the ADC, video circuitry, or A4 assembly linear path is faulty.

400 AMPL <300	Unable to adjust amplitude of resolution bandwidths less than 300 Hz.
401 AMPL 300	Unable to adjust amplitude of 300 Hz resolution bandwidth.
402 AMPL 1K	Unable to adjust amplitude of 1 kHz resolution bandwidth.
403 AMPL 3K	Unable to adjust amplitude of 3 kHz resolution bandwidth.
404 AMPL 10K	Unable to adjust amplitude of 10 kHz resolution bandwidth.

Errors 405 to 416: When these 10K resolution bandwidth (RBW) error messages appear, use the following steps to check for errors 581 or 582.

1. Press **LINE** to turn the spectrum analyzer off.
2. Press **LINE** to turn the spectrum analyzer on and observe the lower right-hand corner of the display for 10 seconds.
3. If ERR 581 or ERR 582 appears, the fault is most likely caused by the cal oscillator. Refer to errors 581 and 582.
4. If ERR 581 or ERR 582 does not appear, troubleshoot the A5 IF assembly.

Multiple IF Errors During IF adjust: If a **FULL IF ADJ** sequence (pressing **CAL** and **FULL IF ADJ**) results in IF errors while displaying **IF ADJUST STATUS: AMPLITUDE**, the cal oscillator on A4 might not be providing the correct output signal. Perform the following steps:

1. Disconnect W30 (white) from A5J4.
2. Connect W30 to the input of a second spectrum analyzer and set its controls as follows:
 Center Frequency 10.7 MHz
 Reference Level -30 dBm
3. Observe the spectrum analyzer display while pressing **FULL IF ADJ** on the spectrum analyzer. If a -35 dBm signal does not appear, troubleshoot the cal oscillator on A4.
4. If a -35 dBm signal does appear, troubleshoot the A5 IF assembly.

405 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in first crystal pole.
406 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in second crystal pole.
407 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in third crystal pole.
408 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in fourth crystal pole.
409 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in first crystal pole.
410 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in second crystal pole.
411 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in third crystal pole.
412 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in fourth crystal pole.
413 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in first crystal pole.
414 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in second crystal pole.
415 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in third crystal pole.
416 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in fourth crystal pole.
417 RBW 3K	Unable to adjust 3 kHz resolution bandwidth in first crystal pole.
418 RBW 3K	Unable to adjust 3 kHz resolution bandwidth in second crystal pole.
419 RBW 3K	Unable to adjust 3 kHz resolution bandwidth in third crystal pole.

420 RBW 3K	Unable to adjust 3 kHz resolution bandwidth in fourth crystal pole.
421 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in first crystal pole.
422 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in second crystal pole.
423 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in third crystal pole.
424 RBW 10K	Unable to adjust 10 kHz resolution bandwidth in fourth crystal pole.
425 RBW 3K	Unable to adjust 3 kHz resolution bandwidth in first crystal pole.
426 RBW 3K	Unable to adjust 3 kHz resolution bandwidth in second crystal pole.
427 RBW 3K	Unable to adjust 3 kHz resolution bandwidth in third crystal pole.
428 RBW 3K	Unable to adjust 3 kHz resolution bandwidth in fourth crystal pole.
429 RBW 100	Unable to adjust resolution bandwidths less than 300Hz. ADC handshake.
430 RBW 300	Unable to adjust 300 Hz resolution bandwidth. ADC handshake.
431 RBW 1K	Unable to adjust 1 kHz resolution bandwidth. ADC handshake.
432 RBW 3K	Unable to adjust 3 kHz resolution bandwidth. ADC handshake.
433 RBW 10K	Unable to adjust 10 kHz resolution bandwidth. ADC handshake.
434 RBW 300	300 Hz resolution bandwidth amplitude low in first crystal pole.
435 RBW 300	300 Hz resolution bandwidth amplitude low in second crystal pole.
436 RBW 300	300 Hz resolution bandwidth amplitude low in third crystal pole.
437 RBW 300	300 Hz resolution bandwidth amplitude low in fourth crystal pole.
438 RBW 1K	1 kHz resolution bandwidth amplitude low in first crystal pole.
439 RBW 1K	1 kHz resolution bandwidth amplitude low in second crystal pole.
440 RBW 1K	1 kHz resolution bandwidth amplitude low in third crystal pole.
441 RBW 1K	1 kHz resolution bandwidth amplitude low in fourth crystal pole.
442 RBW 3K	3 kHz resolution bandwidth amplitude low in first crystal pole.
443 RBW 3K	3 kHz resolution bandwidth amplitude low in second crystal pole.
444 RBW 3K	3 kHz resolution bandwidth amplitude low in third crystal pole.
445 RBW 3K	3 kHz resolution bandwidth amplitude low in fourth crystal pole.
446 RBW 10K	10 kHz resolution bandwidth amplitude low in first crystal pole.
447 RBW 10K	10 kHz resolution bandwidth amplitude low in second crystal pole.
448 RBW 10K	10 kHz resolution bandwidth amplitude low in third crystal pole.
449 RBW 10K	10 kHz resolution bandwidth amplitude low in fourth crystal pole.
450 IF SYSTM	IF hardware failure. Check other error messages.
451 IF SYSTM	IF hardware failure. Check other error messages.
452 IF SYSTM	IF hardware failure. Check other error messages.
454 AMPL	Unable to adjust step gain amplifiers. Check other errors.

455 AMPL	Unable to adjust fine attenuator of the step gain amplifiers.
456 AMPL	Unable to adjust fine attenuator of the step gain amplifiers.
457 AMPL	Unable to adjust fine attenuator of the step gain amplifiers.
458 AMPL	Unable to adjust first step gain stage.
459 AMPL	Unable to adjust first step gain stage.
460 AMPL	Unable to adjust first step gain stage.
461 AMPL	Unable to adjust second step gain stage.
462 AMPL	Unable to adjust second step gain stage.
463 AMPL	Unable to adjust third step gain stage.
464 AMPL	Unable to adjust third step gain stage.
465 AMPL	Unable to adjust third step gain stage.
466 LIN AMPL	Unable to adjust linear amplifier scale.
467 AMPL	Unable to adjust step gain amplifiers.
468 AMPL	Unable to adjust third step gain stage.
469 AMPL	Unable to adjust step gain amplifiers.
470 AMPL	Unable to adjust third step gain stage.
471 RBW 30K	Unable to adjust 30 kHz resolution bandwidth in first LC pole.
472 RBW 100K	Unable to adjust 100 kHz resolution bandwidth in first LC pole.
473 RBW 300K	Unable to adjust 300 kHz resolution bandwidth in first LC pole.
474 RBW 1M	Unable to adjust 1 MHz resolution bandwidth in first LC pole.
475 RBW 30K	Unable to adjust 30 kHz resolution bandwidth in second LC pole.
476 RBW 100K	Unable to adjust 100 kHz resolution bandwidth in second LC pole.
477 RBW 300K	Unable to adjust 300 kHz resolution bandwidth in second LC pole.
478 RBW 1M	Unable to adjust 1 MHz resolution bandwidth in second LC pole.
483 RBW 10K	Unable to adjust 10 kHz resolution bandwidth.
484 RBW 3K	Unable to adjust 3 kHz resolution bandwidth.
485 RBW 1K	Unable to adjust 1 kHz resolution bandwidth.
486 RBW 300	Unable to adjust 300 Hz resolution bandwidth.
487 RBW 100	Unable to adjust 100 Hz resolution bandwidth.
488 RBW 10	Unable to adjust 100 Hz resolution bandwidth.
489 RBW 100	Unable to adjust 100 Hz resolution bandwidth.
490 RBW 100	Unable to adjust 100 Hz resolution bandwidth.
491 RBW <300	Unable to adjust resolution bandwidths less than 300 Hz. Crystal sweep gain problem.

492 RBW 300	Unable to adjust 300 Hz resolution bandwidth. Crystal sweep gain problem.
493 RBW 1K	Unable to adjust 1 kHz resolution bandwidth. Crystal sweep gain problem.
494 RBW 3K	Unable to adjust 3 kHz resolution bandwidth. Crystal sweep gain problem.
495 RBW 10K	Unable to adjust 10 kHz resolution bandwidth. Crystal sweep gain problem.
496 RBW 100	Unable to adjust 100 Hz resolution bandwidth. Inadequate Q.
497 RBW 100	Unable to adjust 100 Hz resolution bandwidth. Alignment problem.
498 RBW 100	Unable to adjust 100 Hz resolution bandwidth. Gain problem.
499 CAL UNLK	Cal oscillator is unlocked. Verify the unlocked conditions as follows: 1. Place A4 in its service position and disconnect W51 (gray-yellow) from A4J7. 2. Connect W51 to the input of another spectrum analyzer. This is the 10 MHz reference for the cal oscillator. 3. If a 10 MHz signal (approximately 0 dBm) is not present, suspect the A15 RF assembly, the A21 OCXO, or the A15 assembly TCXO (Option 103). If the 10 MHz reference is present, continue with step 4. 4. Reconnect W17 to A4J7 and monitor the tune voltage at A4J9 pin 3 with an oscilloscope. 5. Press PRESET on the spectrum analyzer under test. 6. If the voltage is either +15 Vdc or -15 Vdc, the cal oscillator is probably at fault. Normally, the voltage should be near +15 V during a sweep, and between -9 V and +9 V during retrace. An <i>intermittent</i> error 499 indicates the cal oscillator phase-locked-loop probably can lock at 10.7 MHz, but cannot lock at the 9.9 and 11.5 MHz extremes. This may prevent the cal oscillator from adjusting the 1 MHz or 30 kHz through 300 kHz bandwidths. This symptom implies a failure in the oscillator, function block X. (See the A4 log amp/cal oscillator schematic sheet 4 of 4.) The oscillator is unable to tune the required frequency range with the -9 V to +9 V control voltage. Troubleshoot A4CR802 (most probable cause), L801, C808, C809, and U807.
500 AMPL 30K	Unable to adjust amplitude of 30 kHz resolution bandwidth.
501 AMPL .1M	Unable to adjust amplitude of 100 kHz resolution bandwidth.
502 AMPL .3M	Unable to adjust amplitude of 300 kHz resolution bandwidth.
503 AMPL 1M	Unable to adjust amplitude of 1 MHz resolution bandwidth.
504 AMPL 30K	Unable to adjust amplitude of 30 kHz resolution bandwidth.
505 AMPL .1M	Unable to adjust amplitude of 100 kHz resolution bandwidth.

506 AMPL .3M	Unable to adjust amplitude of 300 kHz resolution bandwidth.
507 AMPL 1M	Unable to adjust amplitude of 1 MHz resolution bandwidth.
508 AMPL 30K	Unable to adjust amplitude of 30 kHz resolution bandwidth. Insufficient gain during LC bandwidth calibration.
509 AMPL .1M	Unable to adjust amplitude of 100 kHz resolution bandwidth. Insufficient gain during LC bandwidth calibration.
510 AMPL .3M	Unable to adjust amplitude of 300 kHz resolution bandwidth. Insufficient gain during LC bandwidth calibration.
511 AMPL 1M	Unable to adjust amplitude of 1 MHz resolution bandwidth. Insufficient gain during LC bandwidth calibration.
512 RBW 100	Unable to adjust 100 Hz resolution bandwidth. Insufficient gain during crystal bandwidth calibration.
513 RBW 300	Unable to adjust 300 Hz resolution bandwidth. Insufficient gain during crystal bandwidth calibration.
514 RBW 1K	Unable to adjust 1 kHz resolution bandwidth. Insufficient gain during crystal bandwidth calibration.
515 RBW 3K	Unable to adjust 3 kHz resolution bandwidth. Insufficient gain during crystal bandwidth calibration.
516 RBW 10K	Unable to adjust 10 kHz resolution bandwidth. Insufficient gain during crystal bandwidth calibration.
517 RBW 100	Unable to adjust 100 Hz resolution bandwidth. Crystal sweep problem.
518 RBW 300	Unable to adjust 300 Hz resolution bandwidth. Crystal sweep problem.
519 RBW 1K	Unable to adjust 1 kHz resolution bandwidth. Crystal sweep problem.
520 RBW 3K	Unable to adjust 3 kHz resolution bandwidth. Crystal sweep problem.
521 RBW 10K	Unable to adjust 10 kHz resolution bandwidth. Crystal sweep problem.
522 RBW 10K	Unable to adjust symmetry of 10 kHz resolution bandwidth in first crystal pole.
523 RBW 10K	Unable to adjust symmetry of 10 kHz resolution bandwidth in second crystal pole.
524 RBW 10K	Unable to adjust symmetry of 10 kHz resolution bandwidth in third crystal pole.
525 RBW 10K	Unable to adjust symmetry of 10 kHz resolution bandwidth in fourth crystal pole.
526 RBW <300	ADC timeout during IF ADJUST of <300 Hz resolution bandwidth.
527 RBW <300	Step gain correction failed for <300 Hz resolution bandwidth. Check narrow BW SGO attenuator.

528 RBW <300	Calibration of dc level at ADC failed for <300 Hz resolution bandwidth.
529 RBW <300	Invalid demodulated data for <300 Hz resolution bandwidth flatness and IF down-converter. Demod data for calibration may be bad.
530 RBW <300	Adjustment of VCXO down-converter failed. Narrow bandwidth VCXO calibration failed.
531 RBW <300	Flatness correction data for resolution bandwidths <300 Hz not acceptable.
532 RBW <300	Absolute gain data for resolution bandwidths <300 Hz not acceptable.
533 RBW <300	ADC timeout adjusting resolution bandwidths less than 300 Hz. Timeout during data sampling narrow bandwidth chunk.
534 RBW <300	Unable to do frequency count of CAL OSC using IF down-converter when adjusting resolution bandwidths less than 300 Hz.
535 RBW <300	Unable to obtain adequate FM demod range to measure 500 Hz IF filter with resolution bandwidths less than 300 Hz.
536 RBW <300	Unable to auto-range chirp signal while setting VCXO or doing flatness calibration with resolution bandwidths less than 300 Hz.
537 RBW <300	Unable to auto-range CW CAL OSC signal to count VCXO signal with resolution bandwidths less than 300 Hz.
538 RBW <300	Shape of 500 Hz IF filter appears too noisy to adjust VCXO down-converter for resolution bandwidths less than 300 Hz.
539 RBW <300	Unable to auto-range the CW CAL OSC signal to pretune the VCXO for resolution bandwidths less than 300 Hz.
540 RBW <300	Unable to find CW CAL OSC signal during VCXO pretune at power-up with resolution bandwidths less than 300 Hz.
550 IDCALOSC	CAL Oscillator ID. Indicates incompatible hardware. Cal oscillator on A16 Cal Osc not expected.
551 LOG AMPL	LOG Board ID. Indicates incompatible hardware. Cal oscillator on A4 assembly not expected.
552 LOG AMPL	Unable to adjust amplitude of log scale.
553 LOG AMPL	Unable to adjust amplitude of log scale.
554 LOG AMPL	Unable to adjust amplitude of log scale.
555 LOG AMPL	Unable to adjust amplitude of log scale.
556 LOG AMPL	Unable to adjust amplitude of log scale.
557 LOG AMPL	Unable to adjust amplitude of log scale.
558 LOG AMPL	Unable to adjust amplitude of log scale.
559 LOG AMPL	Unable to adjust amplitude of log scale.
560 LOG AMPL	Unable to adjust amplitude of log scale.

561 LOG AMPL	Unable to adjust amplitude of log scale. Possible problem in second step gain.
562 LOG AMPL	Unable to adjust amplitude of log scale. Possible problem in second step gain.
563 LOG AMPL	Unable to adjust amplitude of log scale. Possible problem in third step gain range.
564 LOG AMPL	Unable to adjust amplitude of log scale.
565 LOG AMPL	Unable to adjust amplitude of log scale.
566 LOG AMPL	Unable to adjust amplitude of log scale.
567 LOG AMPL	Unable to adjust amplitude of log scale. Possible problem in Log offset/Log Expand stage.
568 LOG AMPL	Unable to adjust amplitude of log scale. Possible problem in Log offset/Log Expand stage.
569 LOG AMPL	Unable to adjust amplitude of log scale. Possible problem in Log offset/Log Expand stage.
570 LOG AMPL	Unable to adjust amplitude of log scale. Possible problem in Log offset/Log Expand stage.
571 AMPL	Unable to adjust step gain amplifiers.
572 AMPL 1M	Unable to adjust amplitude of 1 MHz resolution bandwidth.
573 LOG AMPL	Unable to adjust amplitude of log scale. Check video offset circuitry.
574 LOG AMPL	Unable to adjust amplitude of log scale. Check video offset circuitry.
575 LOG AMPL	Unable to adjust amplitude of log scale. Check video offset circuitry.
576 LOG AMPL	Unable to adjust amplitude of log scale. Check video offset circuitry.
577 LOG AMPL	Unable to adjust amplitude of log scale. Check video offset circuitry.
578 LOG AMPL	Limiter calibration error from DC logger calibration.
579 LOG AMPL	Attenuator CAL level error from DC logger calibration.
580 LOG AMPL	calibration level error from DC logger calibration.
581 AMPL	Unable to adjust 100 kHz resolution bandwidth and resolution bandwidths less than or equal to 10 kHz. ADC/CALOSC handshake calibration problem in crystal sweep. Refer to Error 582.

Unable to adjust 100 kHz resolution bandwidth and resolution bandwidths less than or equal to 10 kHz. Bad CALOSC calibration in sweep rate. Test the 100 kHz resolution bandwidth filter 3 dB bandwidth as follows:

1. Connect the CAL OUTPUT signal (A4J8) to the INPUT 50 Ω .
2. Press **PRESET** and set the controls as follows:

CENTER FREQ	300 MHz
SPAN	500 kHz
Resolution Bandwidth	100 kHz
LOG dB/DIV	1 dB
REF LEVEL	adjust to place signal peak at top of the screen
3. Press **PEAK SEARCH** and **MARKER DELTA** and turn the knob clockwise to position the marker until the delta MKR reads $-3 \text{ dB} \pm 0.1 \text{ dB}$.
4. Press **MARKER DELTA** and move the marker to the other side of the peak until the delta MKR reads $0 \text{ dB} \pm 0.1 \text{ dB}$.
5. If the delta MKR frequency is between 90 kHz and 110 kHz, the 100 kHz resolution bandwidth is working properly. If the frequency is outside these limits, read the following information on the A4 cal oscillator sweep generator.

If the 100 kHz resolution bandwidth works properly, the cal oscillator sweep generator is failing to sweep its oscillator frequency at the correct rate. The error is detected in sweeping on the skirts of the 100 kHz resolution bandwidth.

A properly operating sweep generator generates a series of negative-going parabolas. These parabolas generate the sweeps used to adjust resolution bandwidths of 10 kHz and below. Check the sweep generator with the following steps. Refer also to "300 Hz to 3 kHz resolution bandwidth out of specification" in the A4 cal oscillator troubleshooting text in Chapter 8.

1. Remove the shields.
2. Connect an oscilloscope probe to A4U804C pin 8.
3. On the spectrum analyzer, press **CAL** and **FULL IF ADJ**.
4. Approximately 8 seconds after starting the **FULL IF ADJ**, check for negative-going parabolas (similar to half-sine waves) 5 ms wide and approximately -4 V at their peak. Refer to Chapter 8, "IF Section," for more information on the A4 log amp/cal oscillator assembly.

583 RBW 30K	Unable to adjust 30 kHz resolution bandwidth.
584 RBW 100K	Unable to adjust 100 kHz resolution bandwidth.
585 RBW 300K	Unable to adjust 300 kHz resolution bandwidth.
586 RBW 1M	Unable to adjust 1 MHz resolution bandwidth.
587 RBW 30K	Unable to adjust 30 kHz resolution bandwidth.
588 RBW 100K	Unable to adjust 100 kHz resolution bandwidth.
589 RBW 300K	Unable to adjust 300 kHz resolution bandwidth.
590 RBW 1M	Unable to adjust 1 MHz resolution bandwidth.
591 LOG AMPL	Unable to adjust amplitude of log scale.
592 LOG AMPL	Unable to adjust amplitude of log scale.
593 LOG TUNE	Limiter calibration tune error from DC logger calibration.
594 LOG OFST	Attenuator calibration offset error from DC logger calibration.
595 LOG ATTN	Attenuator calibration absolute error from DC logger calibration.
596 LOG FID	Fidelity error from DC logger calibration.
597 LOG OFST	Fidelity offset error from DC logger calibration.
598 LOG OFST	Fidelity offset unstable from DC logger calibration.
599 LOG GAIN	Fidelity gain error from DC logger calibration.

System Errors (600 to 651)

ADC timeout errors occur if the A2 controller assembly frequency counter is faulty. Refer to Chapter 7, "ADC/Interface Section."

600 SYSTEM	Hardware/firmware interaction; check other errors.
601 SYSTEM	Hardware/firmware interaction; check other errors.
650 OUTOF RG	ADC input is outside of the ADC range.
651 NO IRQ	Microprocessor is not receiving interrupt from ADC.

Digital and Checksum Errors (700 to 799)

EEROM Checksum Errors (700 to 704)

Faults on the A2 controller assembly can cause these errors. Refer to Chapter 9, "Controller Section." Although some of these errors might result in a blanked display, it is possible to read these errors over HP-IB. Refer to "Troubleshooting to a Functional Section" in this chapter.

The EEROM on A2 is used to store data for frequency response correction, elapsed time, focus, and intensity levels. Error codes from 700 to 703 indicate that some part of the data in EEROM is invalid. An EEROM error could result from either a defective EEROM or an improper sequence of storing data in EEROM. Check the EEROM with the following steps:

1. Place the WR PROT/WR ENA jumper on the A2 controller assembly in the WR ENA position.
2. On the spectrum analyzer, press **CAL**, **MORE 1 OF 2**, **SERVICE CAL DATA**, **FLATNESS**, and **FLATNESS DATA**. Enter a value of 130. Press **PREV MENU**, **STORE DATA**, **YES**, and **DISPLAY**.
3. Press **INTEN**, enter an intensity value of 90, and press **STORE INTEN**.
4. Press **MORE 1 OF 2 FOCUS**, enter a focus value of 128, and press **STORE FOCUS**. Press **LINE** to turn the spectrum analyzer off, then on, cycling the power.
5. If errors are still present, the EEROM A2U501 is defective. Refer to the EEROM replacement procedure in Chapter 3.

700 EEROM

Checksum error of EEROM A2U501.

701 AMPL CAL

Checksum error of frequency response correction data.

702 ELAP TIM

Checksum error of elapsed time data.

703 AMPL CAL

Checksum error of frequency response correction data. Default values being used.

704 PRESELECT

Checksum error of customer preselector peak data. External preselector data recalled in internal mode, or internal preselector data recalled in external mode. To clear the error, press **RECALL**, **MORE 1 OF 2**, **FACTORY PRSEL PK**, **SAVE**, and **SAVE PRSEL PK**.

Program ROM Checksum Errors (705 to 710)

The instrument power-on diagnostics perform a checksum on each programmed ROM (A2 controller assembly). If an invalid checksum is found for a particular ROM, an error code is generated. If a defective programmed ROM is found, replace it with another ROM with the same HP part number. Refer to Chapter 4, "Replaceable Parts."

Although some of these errors might result in a blanked display, it is possible to read these errors over HP-IB. Refer to "Troubleshooting to a Functional Section" in this chapter.

705 ROM U306	Checksum error of program ROM A2U306.
706 ROM U307	Checksum error of program ROM A2U307.
707 ROM U308	Checksum error of program ROM A2U308.
708 ROM U309	Checksum error of program ROM A2U309.
709 ROM U310	Checksum error of program ROM A2U310.
710 ROM U311	Checksum error of program ROM A2U311.

RAM Check Errors (711 to 716)

The instrument power-on diagnostics check the program RAM. This includes the two RAMs used for STATE storage. If any STATE information is found to be invalid, all data in that RAM is destroyed. A separate error code is generated for each defective program RAM. All RAM is battery-backed. See "STATE and TRACE Storage Problems" in Chapter 9.

711 RAM U303	Checksum error of system RAM A2U303.
712 RAM U302	Checksum error of system RAM A2U302.
713 RAM U301	Checksum error of system RAM A2U301.
714 RAM U300	Checksum error of system RAM A2U300.
715 RAM U305	Checksum error of system RAM A2U305.
716 RAM U304	Checksum error of system RAM A2U304.

Microprocessor Error (717)

717 BAD uP!!	Microprocessor not fully operational. Refer to Chapter 9, "Controller Section."
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Battery Problem (718)

If STATE or TRACE data is found to be corrupt, the processor tests the display RAMs and the program RAMs containing the STATE information. If the RAMs are working properly, this error message is generated. To check the BT1 battery and the battery backup circuitry, refer to "STATE and TRACE Storage Problems" in Chapter 9.

718 BATTERY? Nonvolatile RAM not working; check battery BT1. This error can also be generated if the battery has been disconnected then reconnected. If this is the cause, cycling power clears the error.

Model Number Error (719)

If this error occurs, return the instrument to a service center for repair.

719 MODEL #? Could not read ID string from EEROM A2U501.

System Errors (750 to 759)

These errors often require troubleshooting the A2 controller and A3 interface assemblies.

750 SYSTEM Hardware/firmware interaction, zero divide. Check for other errors.

751 SYSTEM Hardware/firmware interaction, floating point overflow. Check for other errors.

752 SYSTEM Hardware/firmware interaction, floating point underflow. Check for other errors.

753 SYSTEM Hardware/firmware interaction, log error. Check for other errors.

754 SYSTEM Hardware/firmware interaction, integer overflow. Check for other errors.

755 SYSTEM Hardware/firmware interaction, square root error. Check for other errors.

756 SYSTEM Hardware/firmware interaction, triple overflow. Check for other errors.

757 SYSTEM Hardware/firmware interaction, BCD overflow. Check for other errors.

758 SYSTEM Unknown system error.

759 SYSTEM Hardware/firmware interaction. Code invoked for wrong instrument.

Fast ADC Error (760)

This error applies only to spectrum analyzers with fast ADC (Option 007).

760 NO FADC

The FADC board did not respond properly to initialization commands.

Option Module Errors (800 to 899)

These error codes are reserved for option modules, such as the HP 85629 test and adjustment module and the HP 85620A mass memory module. Refer to the option module manual for a listing of error messages.

User-Generated Errors (900 to 999)

These error codes indicate user-generated errors.

900 TG UNLVL

Tracking generator output is unleveled.

901 TGFrqLmt

Tracking generator output unleveled because START FREQ is set below tracking generator frequency limit (300 kHz).

902 BAD NORM

The state of the stored trace does not match the current state of the spectrum analyzer.

903 A > DLMT

Unnormalized trace A is off-screen with trace math or normalization on.

904 B > DLMT

Calibration trace (trace B) is off-screen with trace math or normalization on.

905 EXT REF

Unable to lock cal oscillator when set to external frequency reference. Check that the external 10 MHz reference is within tolerance.

906 OVENCOLD

The oven-controlled crystal oscillator (OCXO) oven is cold.

907 DO IF CAL

Unit is still performing IF calibrations, or is in need of IF calibrations which were not yet done due to an OVENCOLD condition.

908 BW>>SPCG

Channel bandwidth is too wide, compared to the channel spacing, for a meaningful adjacent channel power computation.

909 SPAN<ACP

The frequency span is too small to obtain a valid adjacent channel power (ACP) measurement.

910 SPAN>ACP

The frequency span is too wide, compared to the channel bandwidth, to obtain a valid adjacent channel power (ACP) measurement.

Block Diagram Description

The spectrum analyzer is comprised of the six main sections listed below. See Figure 6-4. The following descriptions apply to the Simplified Block Diagram and Overall Block Diagram located at the end of this chapter. Assembly level block diagrams are located in Chapters 7 through 12.

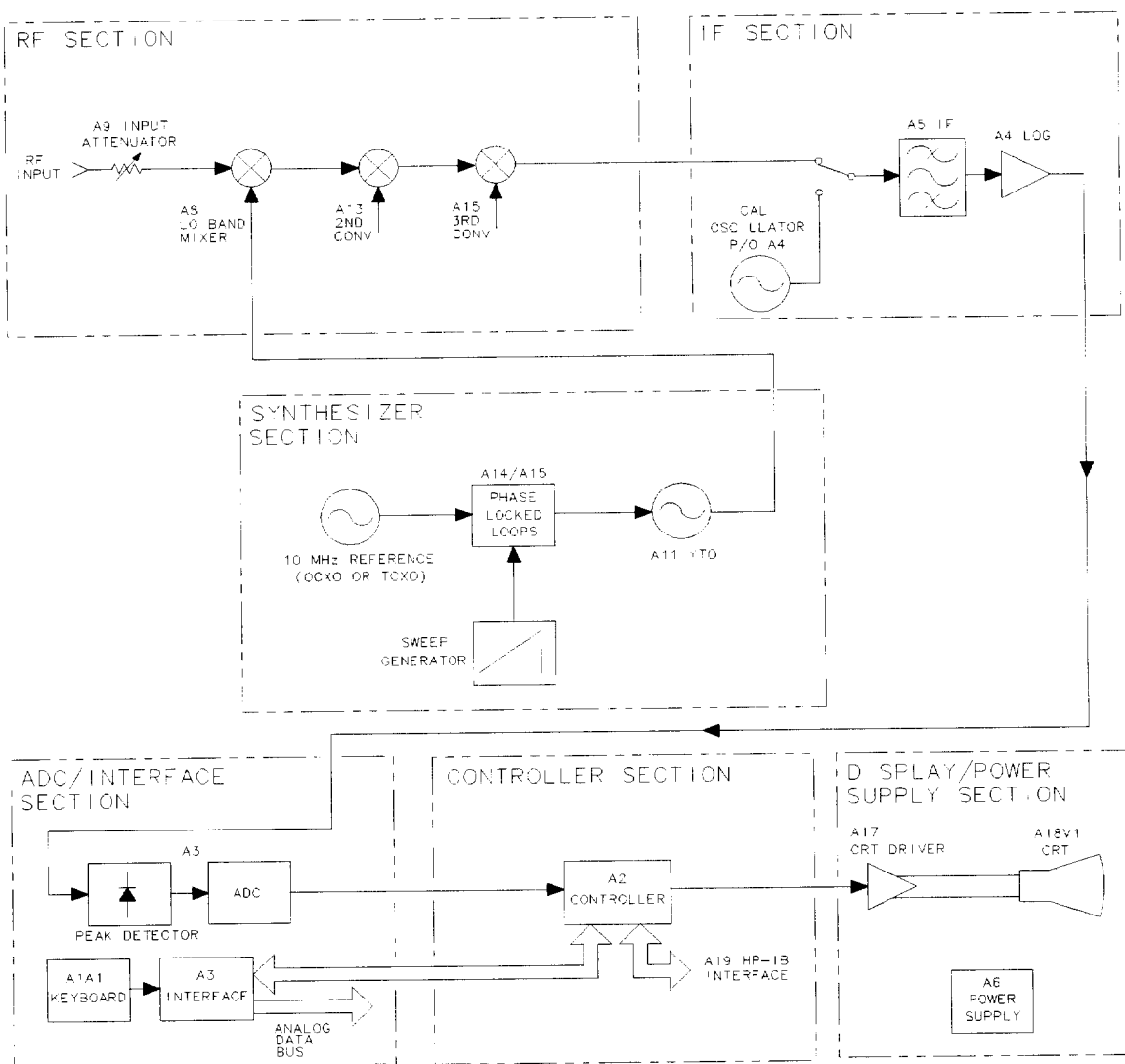


Figure 6-4. Functional Sections

RF Section

The RF Section includes the following assemblies:

- A7 LODA (LO distribution amplifier)
- A8 low band mixer
- A9 input attenuator
- A10 tracking generator (Option 002)
- A11 YTO (YIG-tuned oscillator)
- A13 second converter
- A14 frequency control assembly (also in synthesizer section)
- A15 RF assembly (also in synthesizer section)
- FL1, FL2 low-pass filters

The RF section converts all input signals to a fixed IF of 10.7 MHz. The RF section's microcircuits are controlled by signals from the A14 frequency control and A15 RF assemblies.

The HP 8560E spectrum analyzer uses triple conversion to produce the 10.7 MHz IF and a fourth conversion used only in resolution bandwidths ≤ 100 Hz. A8 low band mixer up-converts the RF input to a first IF of 3.9107 GHz. A13 second converter down-converts the 3.9107 GHz IF to an IF of 310.7 MHz. A third conversion on the A15 RF assembly down-converts the second IF to the 10.7 MHz third IF. A fourth conversion on the A4 log amplifier assembly down-converts the third IF to the 4.8 kHz fourth IF used only in resolution bandwidths ≤ 100 Hz.

A7 LODA

The A7 LODA (LO distribution amplifier) levels the output of the A11 YTO and distributes the power to the front-panel 1ST LO OUTPUT, A8 Low Band Mixer, Option 002 Tracking Generator, and A15U100 Sampler. The leveling circuitry is on the A14 Frequency Control Assembly.

A8 Low Band Mixer

A8 low band mixer is dc-coupled and contains a limiter.

A9 Input Attenuator

The attenuator is a 50 Ω precision, coaxial step attenuator. Attenuation in 10 dB steps from 0 dB to 70 dB is accomplished by switching the signal path through one or more of the three resistive pads. The attenuator automatically sets to 70 dB and DC block when the spectrum analyzer turns off, providing ESD protection. (Note that the input attenuator is not field-repairable.)

A11 YTO

A11 is a YTO (YIG-tuned oscillator). YIG (yttrium-iron-garnet) is a ferro-magnetic material which is polished into a small sphere and precisely oriented in a magnetic field. Changes in this magnetic field alter the frequency generated by the YTO. Current control of the magnetic field surrounding the YIG sphere tunes the oscillator to the desired frequency.

A13 Second Converter

The A13 second converter down-converts the 3.9107 GHz 1st IF to a 310.7 MHz 2nd IF. The converter generates a 3.6 GHz second LO by multiplying a 600 MHz reference. Bandpass filters remove unwanted harmonics of the 600 MHz driving signal. First IF and 2nd LO signals are filtered by cavity filters.

Second IF Distribution Amplifier (part of A15)

The second IF distribution amplifier (SIFA) amplifies and filters the second IF. (Option 001 instruments provide the pre-filtered signal at the rear-panel's 2ND IF OUTPUT.)

The external mixing input from the front-panel's IF INPUT connector is also directed through the SIFA. A dc bias is placed onto the IF INPUT line for biasing external mixers.

Third Converter (part of A15)

The third converter down-converts the 310.7 MHz IF to 10.7 MHz. A PIN-diode switch selects the LO signal used. For normal operation, a 300 MHz LO signal is used. The signal is derived from the 600 MHz reference PLL. During signal identification (SIG ID ON) for option 008, the 298 MHz SIG ID oscillator is fed to the double balanced mixer on alternate sweeps.

Flatness Compensation Amplifiers (part of A15)

The flatness compensation amplifiers amplify the output of the double-balanced mixer. The amplifier's variable gain (8 to 32 dB) compensates for flatness variations within a band. Band conversion loss is compensated by step gain amplifiers in the IF section.

Control for the amplifiers originates from two DACs on the A3 interface assembly. (DAC values are interpolated approximately every 17 MHz based on data obtained during the frequency response adjustment.) A15's flatness-compensation control circuitry converts the RF GAIN voltage, from A3, into two currents: RF GAIN1 and RF GAIN2. These currents drive PIN diodes in the flatness compensation amplifiers.

Synthesizer Section

The first LO is phase-locked to the instrument's internal 10 MHz standard by four PLLs. See Figure 6-5.

The Reference PLL supplies reference frequencies for the instrument. The three remaining PLLs tune and phase-lock the LO through its frequency range. To tune the LO to a particular frequency, the instrument's microprocessor must set the programmable feedback dividers (N) and reference dividers (R) contained in each PLL.

Sweeping the First LO

The spectrum analyzer uses a method called lock and roll to sweep the first LO (A11 YTO) for LO spans >2 MHz. This involves phase-locking the spectrum analyzer at the start frequency during the retrace of the sweep, then sweeping through the desired frequency range in an unlocked condition. The sweep ramp, which sweeps the LO during the roll part of the lock and roll process, is generated on the A14 frequency control assembly. It is applied to either A11 YTO's main coil or the A11 YTO's FM coil. For LO spans ≤ 2.0 MHz, the YTO PLL remains locked and the fractional N PLL sweeps while remaining phase locked. The frequency/span relationships are as follows:

A11 YTO Spanwidth	Sweep Applied To
20.1 MHz to 3.8107 GHz	A11 YTO's main coil
2.01 MHz to 20.0 MHz	A11 YTO's FM coil
100 Hz to 2 MHz	Fractional N phase locked loop

When the sweep ramp is applied to the YTO, the spectrum analyzer must prevent this loop from trying to compensate for changes in the output frequency. To accomplish this, the spectrum analyzer breaks the PLL by disconnecting the YTO PLL's phase detector output.

Reference PLL (part of A15)

The 600 MHz reference PLL provides 600 MHz for the second LO and the A10 tracking generator (option 002), 300 MHz for the third LO, and the sampling oscillator reference and 10 MHz to the fractional N PLL. The reference PLL is locked to a 10 MHz OCXO (oven-compensated crystal oscillator) or an Option 103 TCXO (temperature-compensated crystal oscillator). The PLL can also be locked to an external frequency reference.

The 10 MHz reference also supplies the reference for the frequency counter on the A2 controller assembly, and the cal oscillator on the A4 log amplifier assembly.

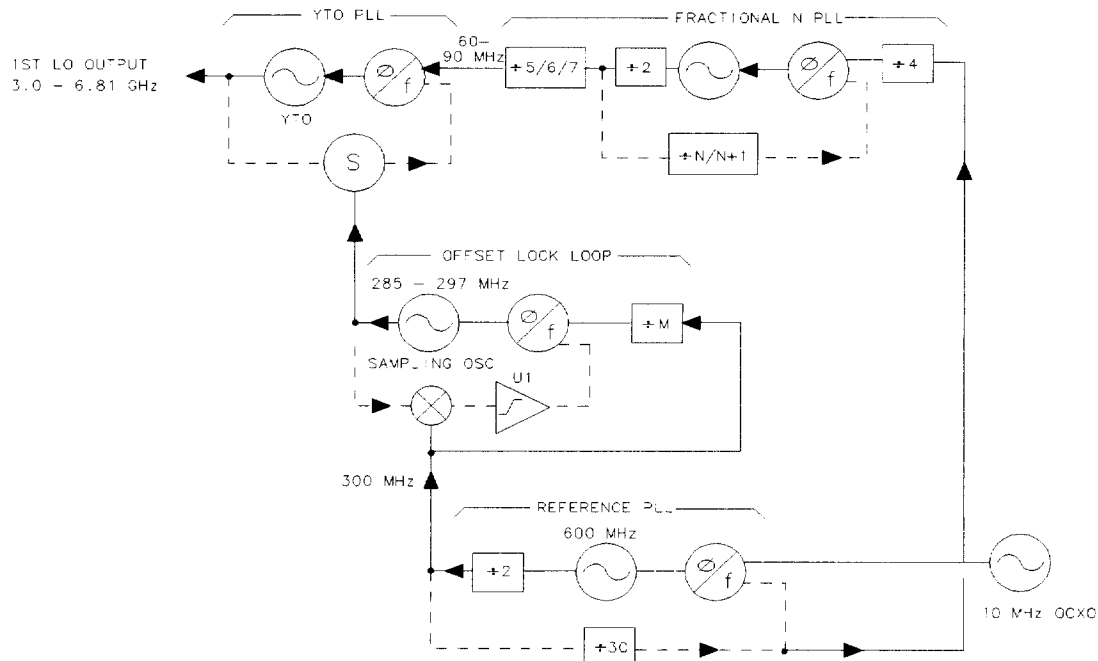
YTO PLL (A7, A11, part of A14, part of A15)

The YTO PLL produces the instrument's first LO (3.0 to 6.81 GHz). The YTO's output is mixed with a harmonic of the sampling oscillator in the sampler (A15U100), and the resulting frequency is phase-locked to the output of the fractional N PLL.

The A15U100 sampler mixes the LO signal from the A7 LODA with a harmonic of the sampling oscillator. The mixing product, the sampler IF, is between 60 and 96 MHz (same frequency range as the fractional N PLL).

Offset Lock Loop (part of A15)

The 285 MHz to 297.2 MHz sampling oscillator is used to sample the YTO. By changing the offset lock loop's programmable dividers, the YTO frequency can be changed.



sj116e

Figure 6-5. Phase Lock Loops

Fractional N PLL (part of A14)

The fractional N PLL produces an output of 60 MHz to 96 MHz. This PLL's output serves as the reference frequency for the YTO PLL. A one-to-one relationship in frequency tracking exists between the fractional N PLL and the YTO. A change of 1 MHz in the fractional N PLL will produce a 1 MHz change in the YTO frequency.

IF Section

The IF section processes the 10.7 MHz output of the RF section and sends the detected video to the ADC/interface section. The following major assemblies are included in this section:

- A3 interface assembly
- A4 log amplifier/cal oscillator assembly
- A5 IF assembly

The HP 8560E uses trace-data manipulation to generate the 5 dB/DIV scale from the 10 dB/DIV scale. The A3 interface assembly amplifies and offsets the 10 dB/DIV video to generate the 2 dB/DIV scale. The 1 dB/DIV scale is generated from the 2 dB/DIV scale through trace data manipulation.

The first 50 dB of IF gain (log and linear mode) is achieved using the A5 assembly's linear step-gain amplifiers. The A4 assembly's video-offset circuit provides the remaining 60 dB of log mode IF gain. The A4 assembly's linear amplifiers provide 40 dB of linear mode gain. IF gain steps of less than 10 dB (regardless of the reference level) are accomplished on the A5 assembly.

A4 Log Amplifier/Cal Oscillator Assembly

The A4 log amplifier has separate log and linear amplifier paths. After amplification, the signal path consists of a linear detector, video log amp, buffer amplifier, video offset, and video buffer amplifier. Other auxiliary functions include the frequency counter prescaler/conditioner, the AM/FM demodulator, and down-conversion to 4.8 kHz for digital resolution bandwidths of 1 Hz through 100 Hz.

The cal oscillator, which is part of A4, supplies the stimulus signal for automatic IF adjustments. Normally, the oscillator operates only during retrace (for a few milliseconds) to adjust part of the IF. (All IF parameters will be re-adjusted approximately every five minutes.) With continuous IF adjust on, a group of IF parameters are adjusted during each retrace period (non-disruptive). If continuous IF adjust is off, the most recent IF calibration data will be used.

The IF parameters adjusted include step gains, log amplifier gain and offset, bandwidth centering, 3 dB bandwidth, bandwidth amplitude, crystal-filter symmetry, and oscillator frequency used in 1 Hz through 100 Hz resolution bandwidths.

The cal oscillator's output has three forms (all -35 dBm):

- 10.7 MHz
- 9.9 to 11.5 MHz in 100 kHz steps
- Frequency sweeps from 20 kHz to 2 kHz centered at 10.7 MHz (lasting 5 to 60 ms respectively)

The purpose of these signals is:

- adjust gains, log amps, and video slopes and offsets
- adjust 3 dB bandwidth and center frequencies of LC resolution BW filters (30 kHz through 1 MHz)
- adjust 3 dB bandwidth, symmetry, and gain of the crystal resolution BW filters (300 Hz through 10 kHz)
- adjust gain and gain-vs-frequency for digital resolution bandwidths (1 Hz through 100 Hz)

A5 IF Assembly

The A5 IF assembly has four crystal filter poles, four LC filter poles, and step gain amplifiers. The crystal filters provide resolution bandwidths of 300 Hz to 10 kHz. The LC filters provide resolution bandwidths of 30 kHz to 2 MHz. All filter stages are in series. PIN diode switches bypass unwanted stages.

An automatic IF adjustment, in spectrum analyzer firmware, sets center frequency and 3 dB bandwidth of all filter poles through varactor and PIN diodes. The firmware also controls crystal-pole symmetry and the step gain amplification.

ADC/Interface Section

The ADC/interface section is the link between the controller section and the rest of the spectrum analyzer. It controls the RF, synthesizer, and IF sections through address and data lines on the W2 control cable (analog bus). Analog signals from these sections are monitored by the ADC/interface section's ADC (analog to digital converter) circuit.

The ADC/interface section includes the A3 interface assembly, A1A1 keyboard, and A1A2 RPG (front-panel knob). The A3 assembly includes log expand, video filter, peak detector, track-and-hold, real-time DACs, RF gain DACs, +10 V reference, and ADC circuitry. The assembly's digital section includes ADC ASM, sweep trigger, keyboard interface, RPG interface, and analog bus interface circuitry.

ADC

The HP 8560E spectrum analyzer can digitize signals with either the main ADC on the A3 interface assembly or the optional A16 fast ADC (option 007). The main ADC is used for digitizing video signals when the sweep time is ≥ 30 ms and various other signals, such as PLL error voltages. The fast ADC is used only to digitize video signals for sweep times < 30 ms.

Main ADC (part of A3)

For sweep times ≥ 30 ms, the spectrum analyzer uses a successive approximation type of ADC. The main ADC has 10-bit resolution but it is realized with 12-bit hardware. The ADC algorithmic state machine (ADC ASM) controls the interface between the start/stop control and the ADC, switching between positive and negative peak detectors when the NORMAL detector mode is selected, and switching the ramp counter into the ADC for comparison to the analog sweep ramp.

A16 Fast ADC

When option 007 is installed, and sweep times < 30 ms are selected, the spectrum analyzer digitizes video signals with the A16 fast ADC. The fast ADC uses an 8-bit flash ADC that is sampled at a 12 MHz rate. Only POS PEAK, NEG PEAK, and SAMPLE detector modes are available with the fast ADC; NORMAL detector mode is not available. Pre-triggering is possible with the fast ADC.

Log Expand/Video Functions

The A3 interface assembly performs log expand and offset functions. The log expand/log offset amplifier provides a 2 dB/div log scale. When the main ADC is used, the 5 dB/div scale is derived by multiplying the digitized 10 dB/div trace data by two in the CPU. When the fast ADC is used, the 5 dB/div scale is derived by amplifying the video signal by two. The 1 dB/div scale is derived by either multiplying the 2 dB/div trace data by two (main ADC) or amplifying the video signal by two (fast ADC).

The spectrum analyzer uses two types of video filters. An RC low-pass circuit provides 300 Hz to 3 MHz video bandwidths. Video bandwidths of 1 Hz to 100 Hz are generated using digital filtering. When a digital filter is selected, a D appears along the left edge of the CRT, indicating that something other than the normal detector mode is being used. Digitally filtered bandwidths use a sample detector.

After filtering, the video is sent to the positive and negative peak detectors. These detectors are designed for optimum pulse response. The positive peak detector resets at the end of each horizontal "bucket" (there are 601 such buckets across the screen). The negative peak detector resets at the end of every other bucket. When reset, the output of the peak detector equals its input.

Triggering

The HP 8560E has five trigger modes: free run, single, external, video, and line. The free run and single trigger signal comes from the 1 MHz ADC clock. The line trigger signal comes from the A6 power supply. Video triggering originates from A3's video filter buffer circuit. External triggering requires either a high or low TTL logic level as determined by the setting of the trigger polarity function. The external trigger signal is received from a rear-panel BNC connector. A DAC in the trigger circuit sets the video trigger level. The trigger circuit is responsible for setting HSCAN high.

Controller Section

The controller section includes the A2 controller assembly and A19 HP-IB assembly. The A2 assembly controls the A17 CRT driver through W7. The battery on the rear panel provides battery-backup for state and trace storage.

The A2 contains the CPU, RAM, ROM, the display ASM and line generators, CRT blanking, focus, intensity control, HP-IB interface, frequency counter, display RAM, option module interface, and EEROM. The A19 HP-IB is a mechanical interface between the standard HP-IB connector and the ribbon cable connector on the A2 controller assembly.

All six RAM IC's (there are only four RAM IC's on newer A2 controller assemblies) are battery-backed. The battery-backed RAM stores trace information (two display memory RAMs) and spectrum analyzer state information (two program RAMs). A total of eight traces and ten states may be stored. Typical battery life is five years with the lithium battery. Trace and state information may be retained for up to 30 minutes with a dead battery and power turned off. This is due to the RAM's very low data retention current.

EEROM

The EEROM stores important amplitude-related correction data. This includes data for LODA DACs and RF Gain DACs (flatness correction). The spectrum analyzer serial number, model number, and installed options are also stored in EEROM.

Firmware

The spectrum analyzer firmware reads the model number and installed options from the EEROM to determine how to respond to certain keystrokes.

Display ASM

Much of the miscellaneous digital control is performed by A2U100. U100 functions as the display ASM (algorithmic state machine) and character ROM. It also converts the 16-bit CPU data bus to an 8-bit data bus for the rest of the spectrum analyzer.

Display/Power Supply Section

A6 Power Supply

The A6 power supply is a switching supply operating at 40 kHz for the low voltages and 30 kHz for the CRT supplies (cathode, filament, +110 Vdc, and post accelerator). A6A1 high voltage module contains the high-voltage transformer and post-accelerator multiplier. Power is distributed through W8 to A17 and through W1 to the rest of the assemblies. A6A1W2 supplies CRT cathode and filament voltages to the A17 assembly.

The speed of the spectrum analyzer's fan is variable. A thermistor on A6 senses the temperature and adjusts the fan speed accordingly. This allows the spectrum analyzer to run quietly in most room-temperature environments and faster (louder) only when necessary.

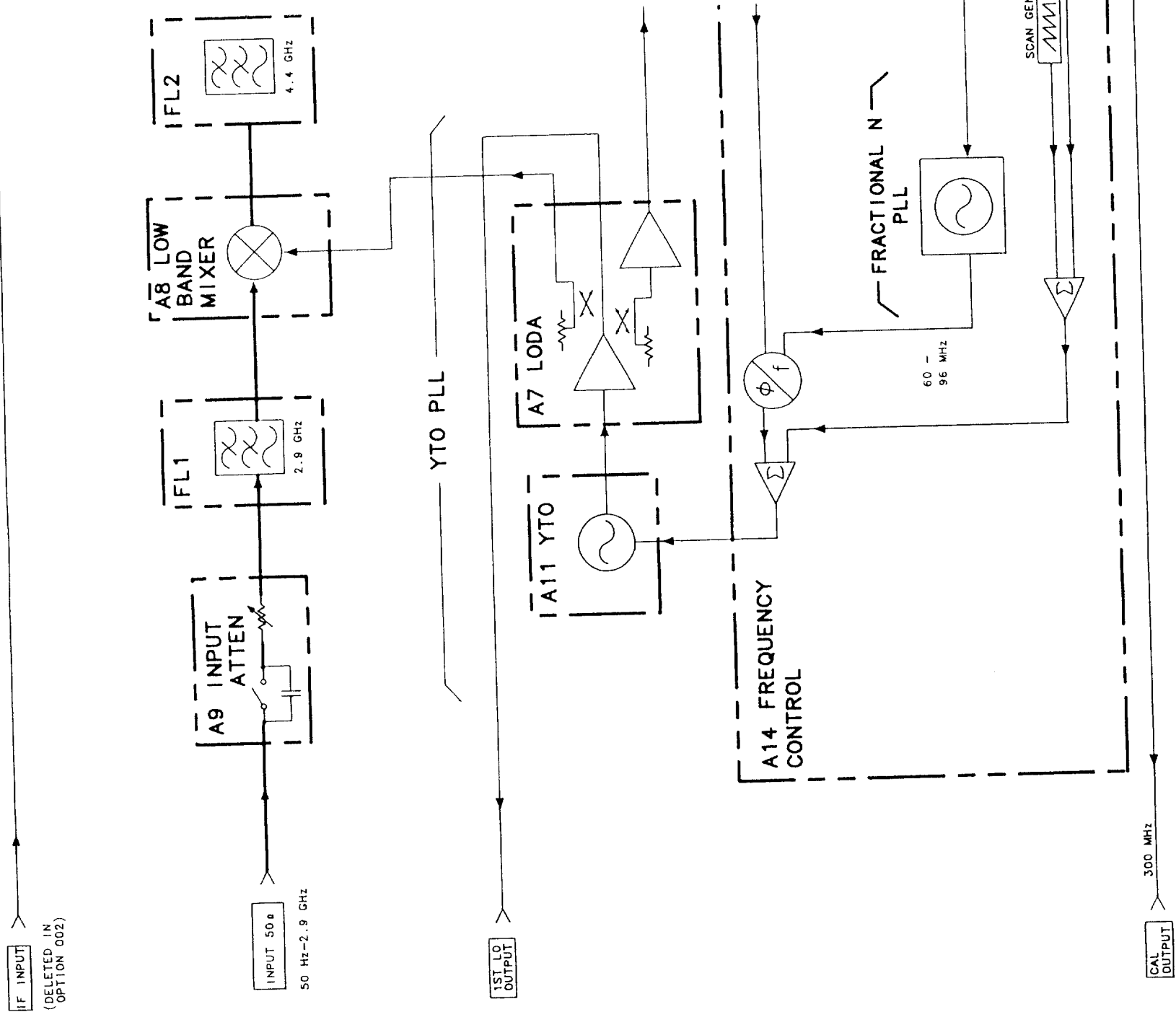
A17 CRT Display Driver

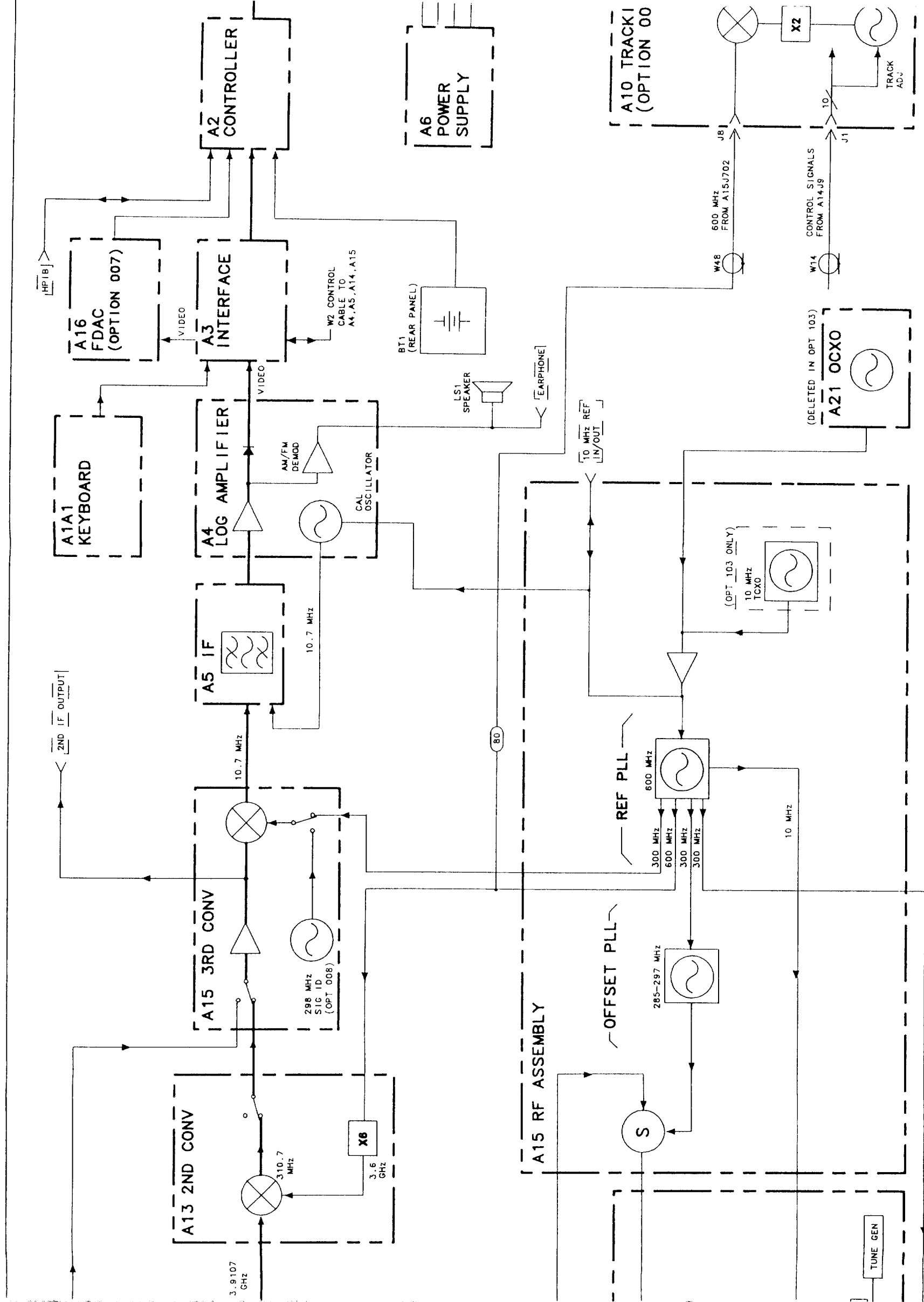
The line generators on the A2 assembly drive the A17 CRT driver. The A17 assembly contains X and Y deflection amplifiers, focus and intensity grid amplifiers, and miscellaneous CRT bias circuitry. The high voltage is supplied by the A6A1 high voltage module.

For non-option 007, in fast-analog zero-span mode (sweep times ≤ 30 ms), the 0-SPAN VIDEO signal from A3 and the sweep ramp from A14 goes to the A17 CRT driver. The graticule and annotation is still digitally drawn.

For fast ADC (Option 007), in fast-analog zero-span mode (sweep times ≤ 30 ms), the 0-SPAN VIDEO signal from A3 goes to the A16 fast ADC assembly.

8560E SIMPLIFIED BLOCK DIAGRAM





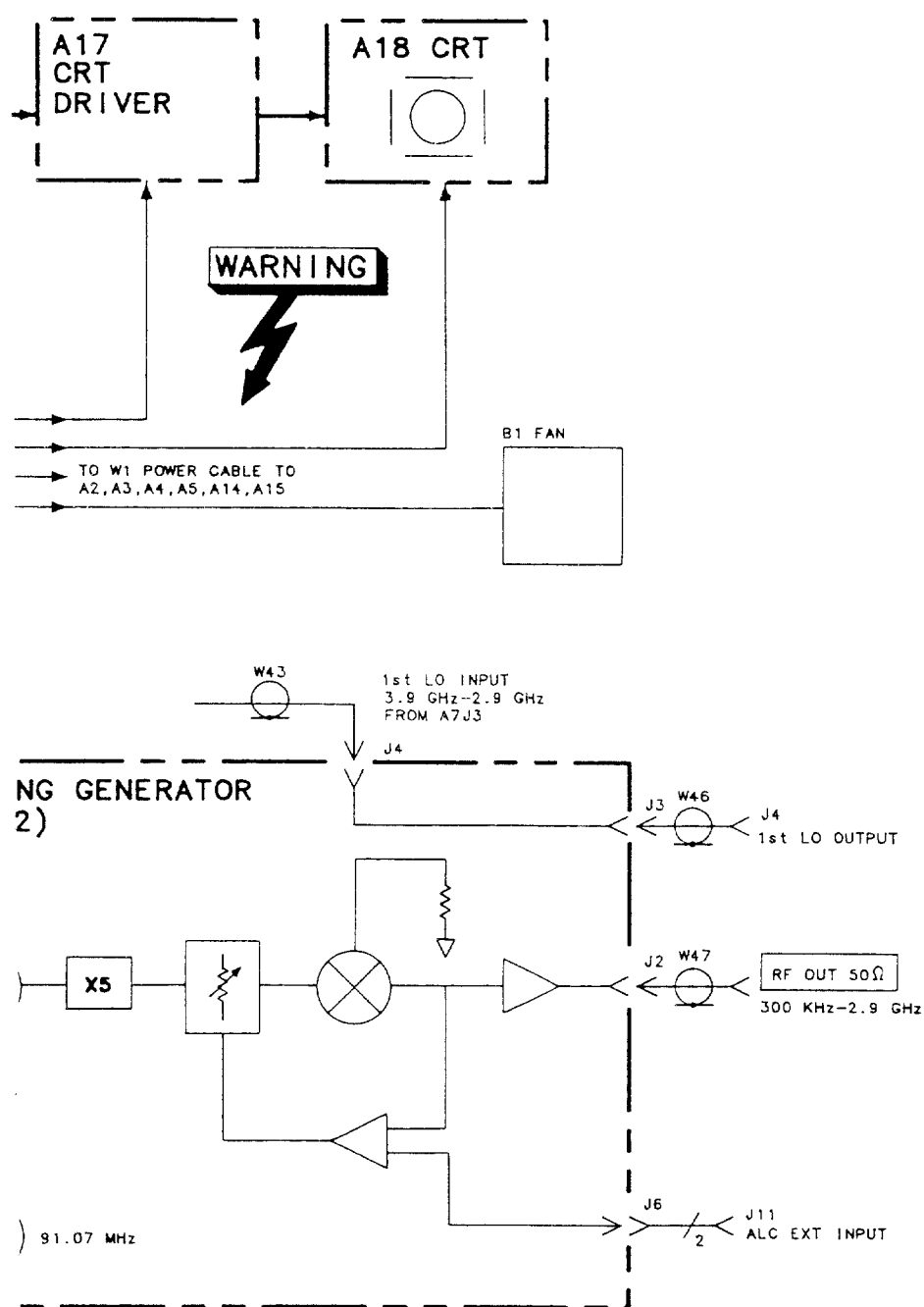
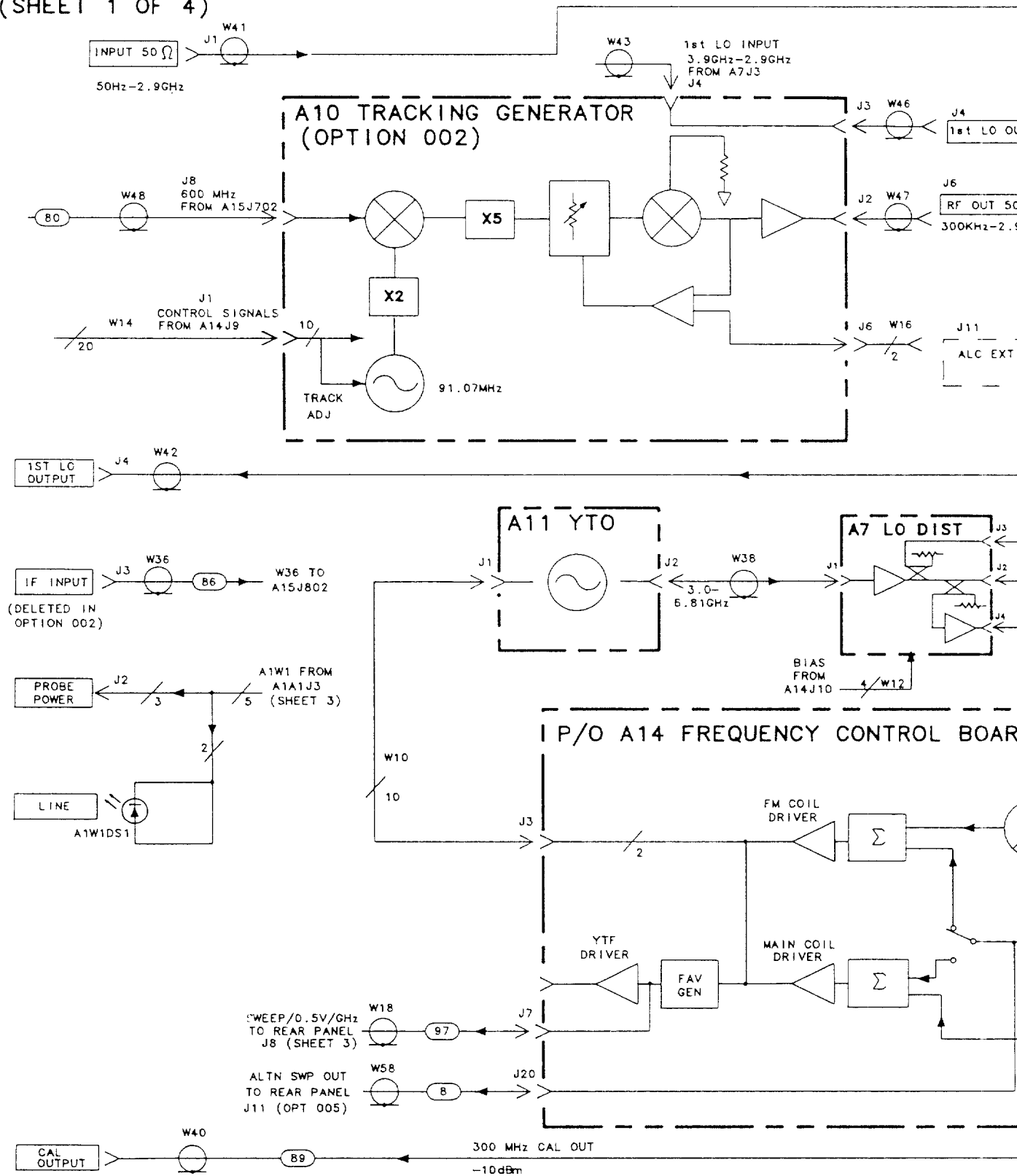
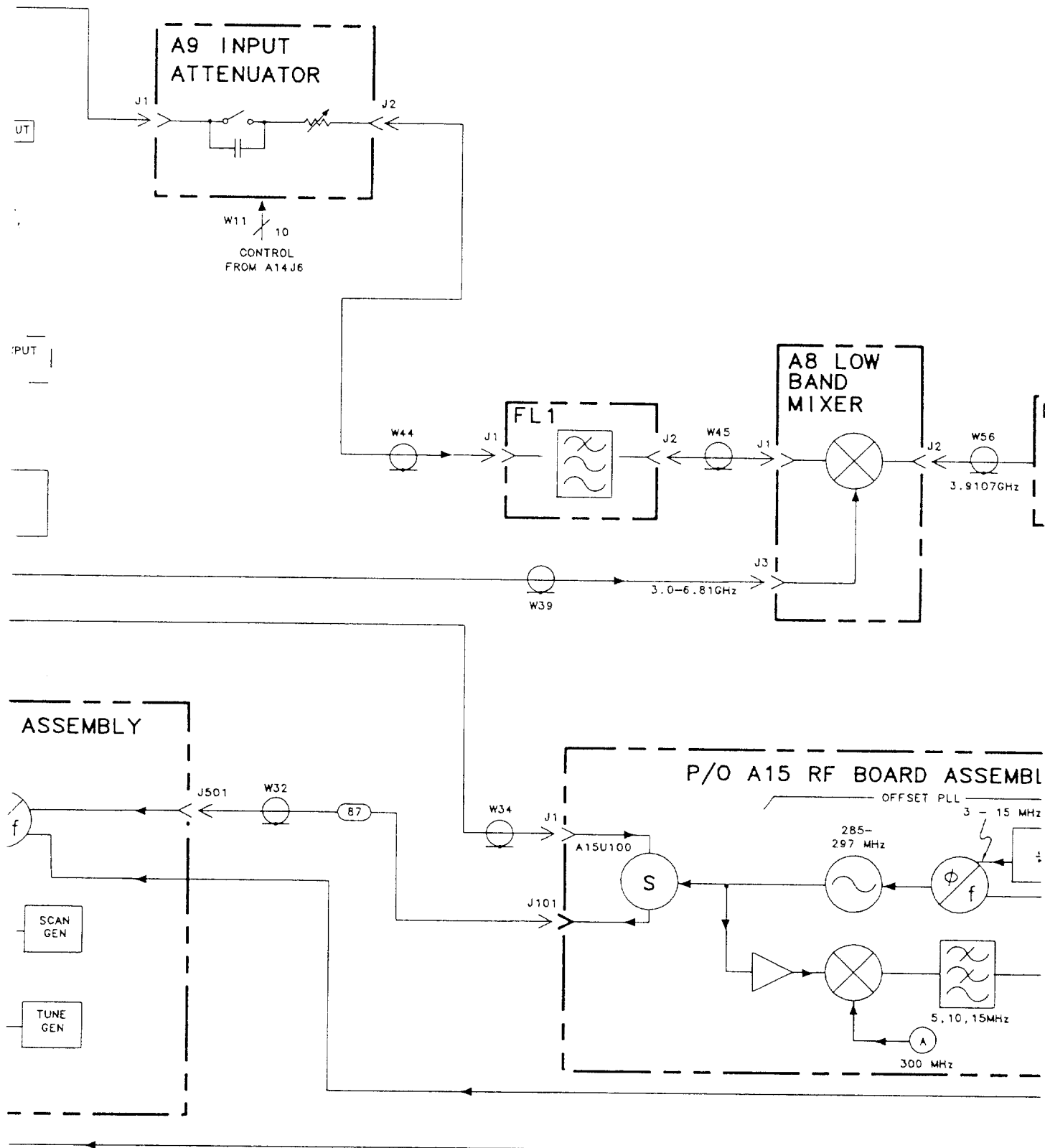
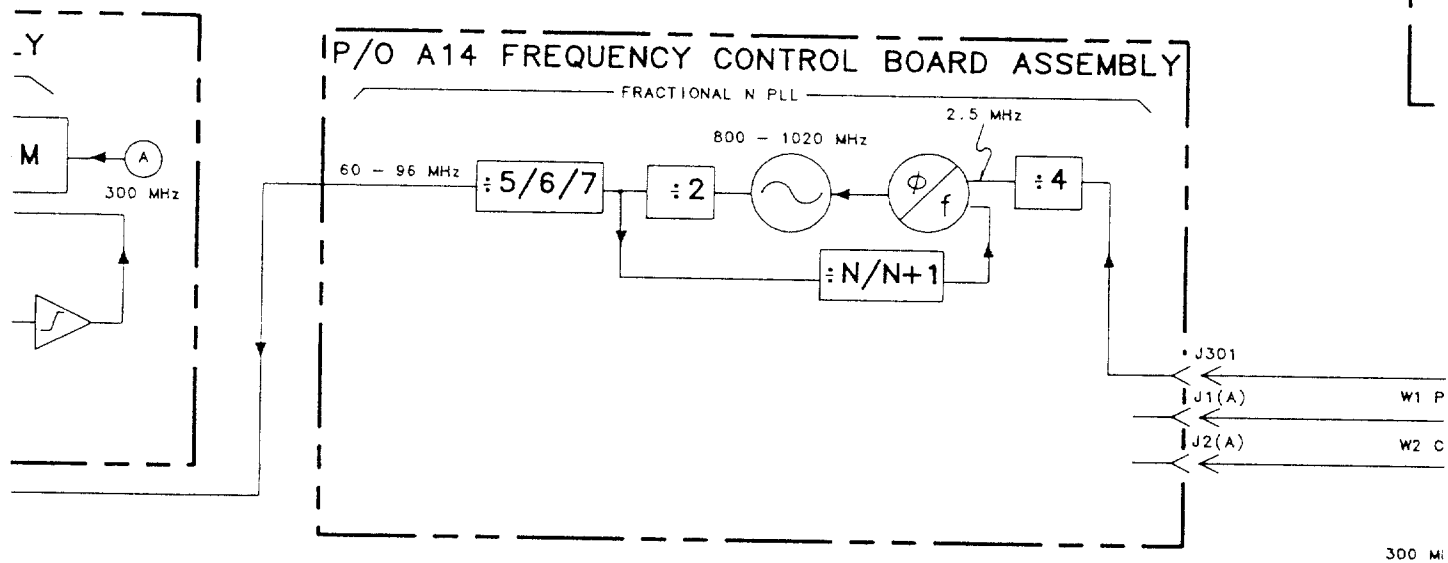
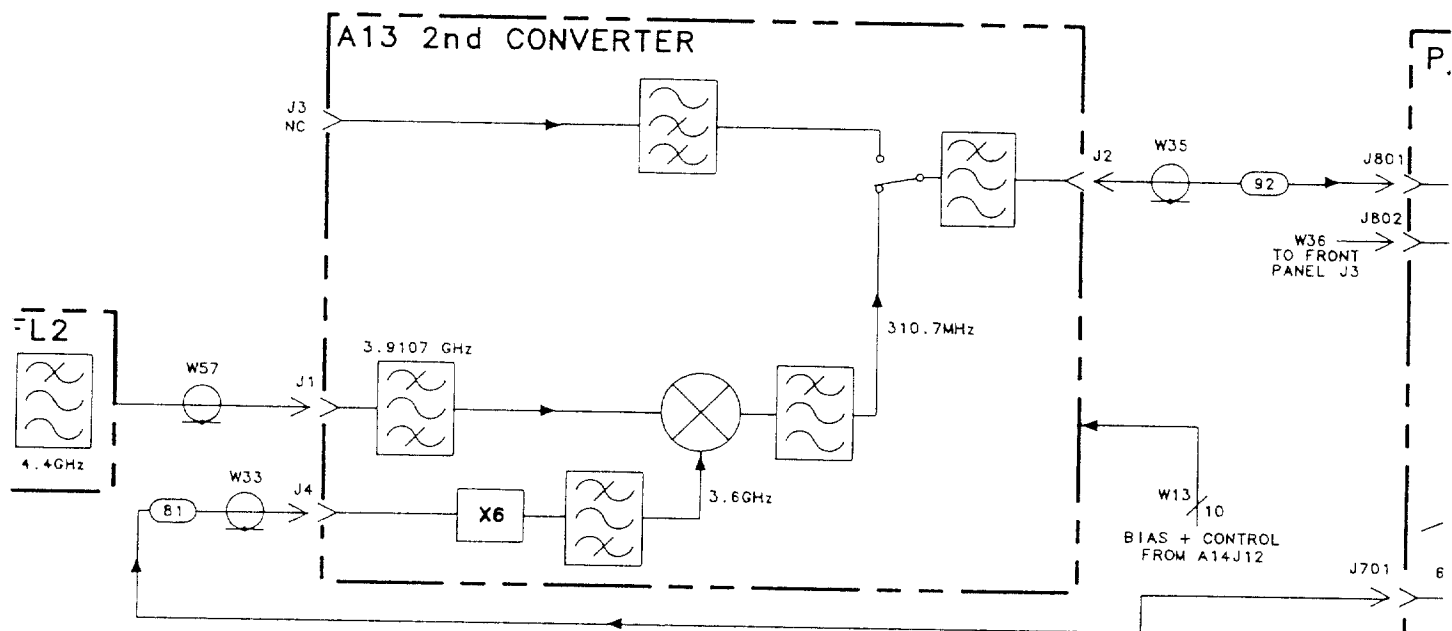


FIGURE 6-6. SIMPLIFIED BLOCK DIAGRAM

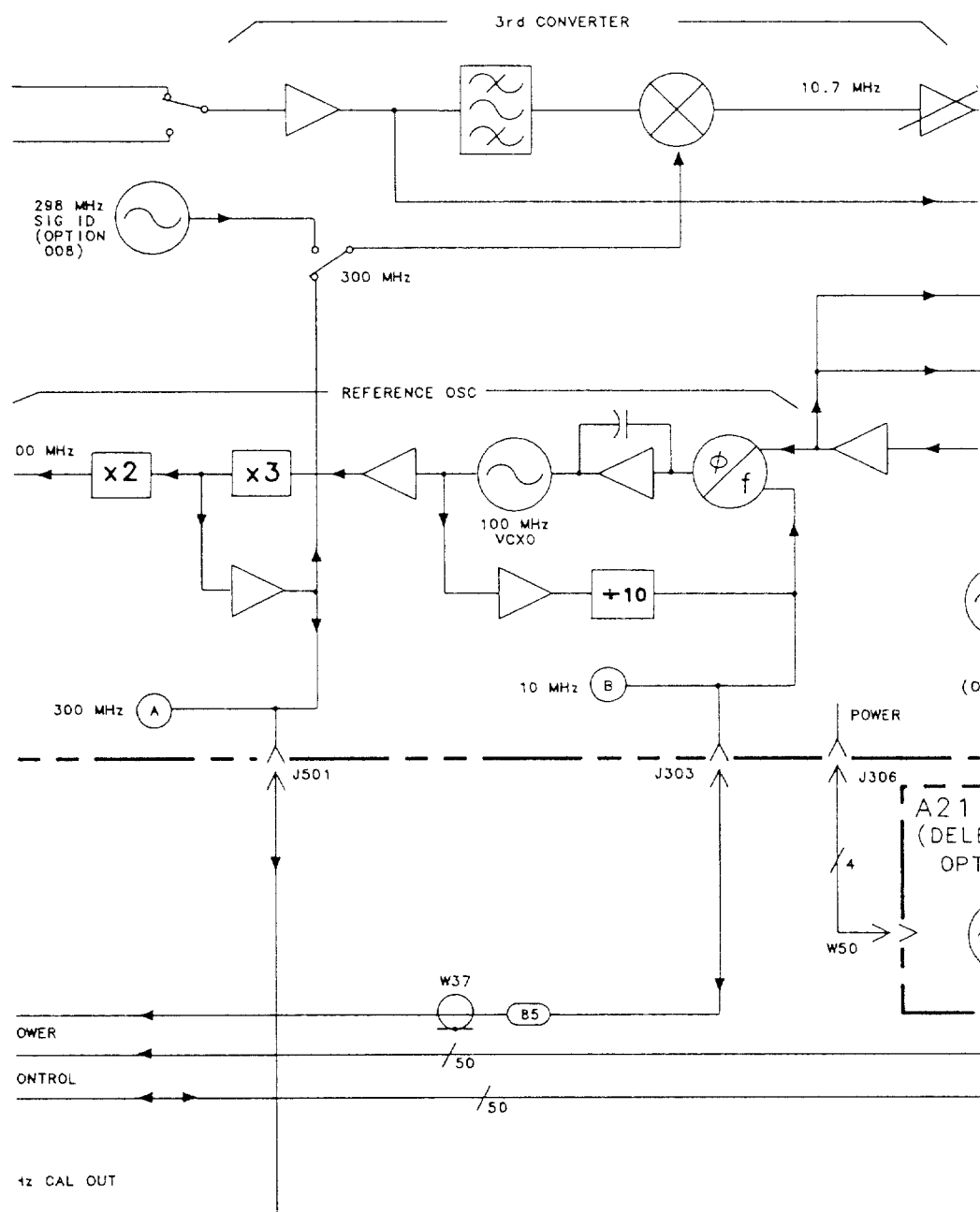
8560E OVERALL BLOCK DIAGRAM (SHEET 1 OF 4)







/0 A15 RF BOARD ASSEMBLY



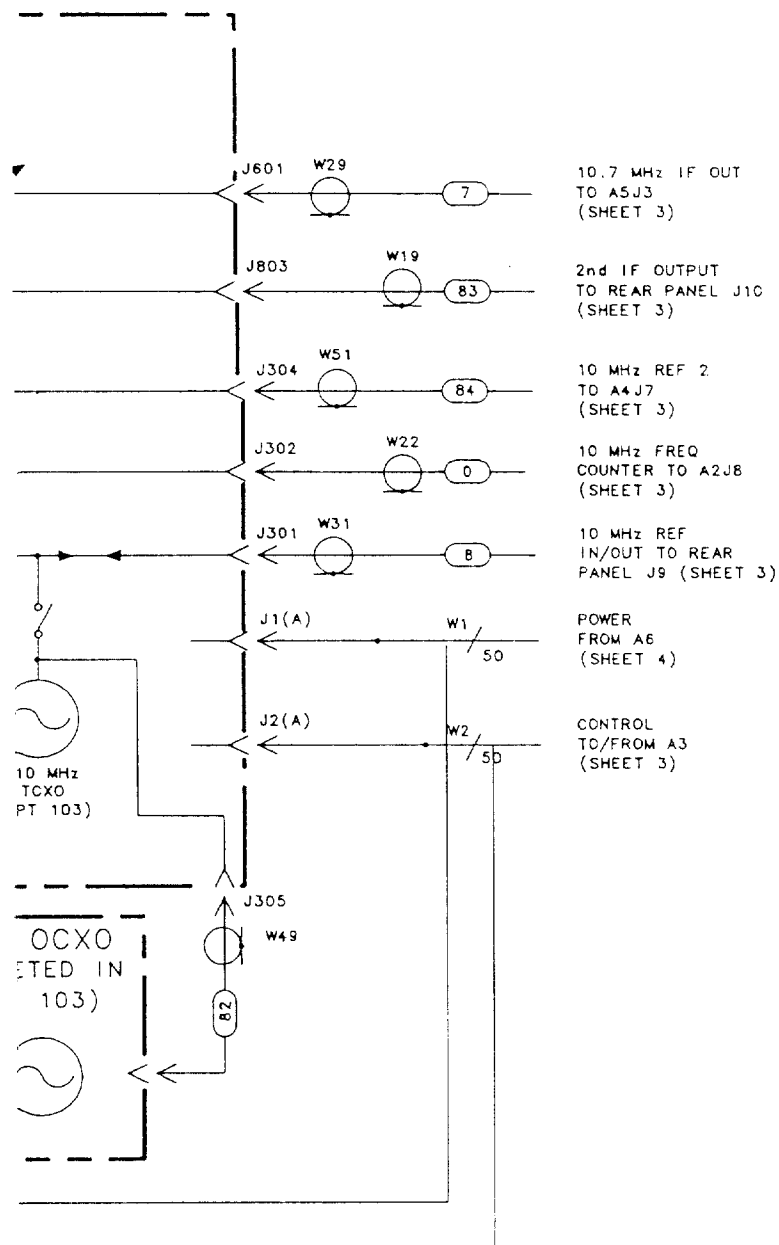
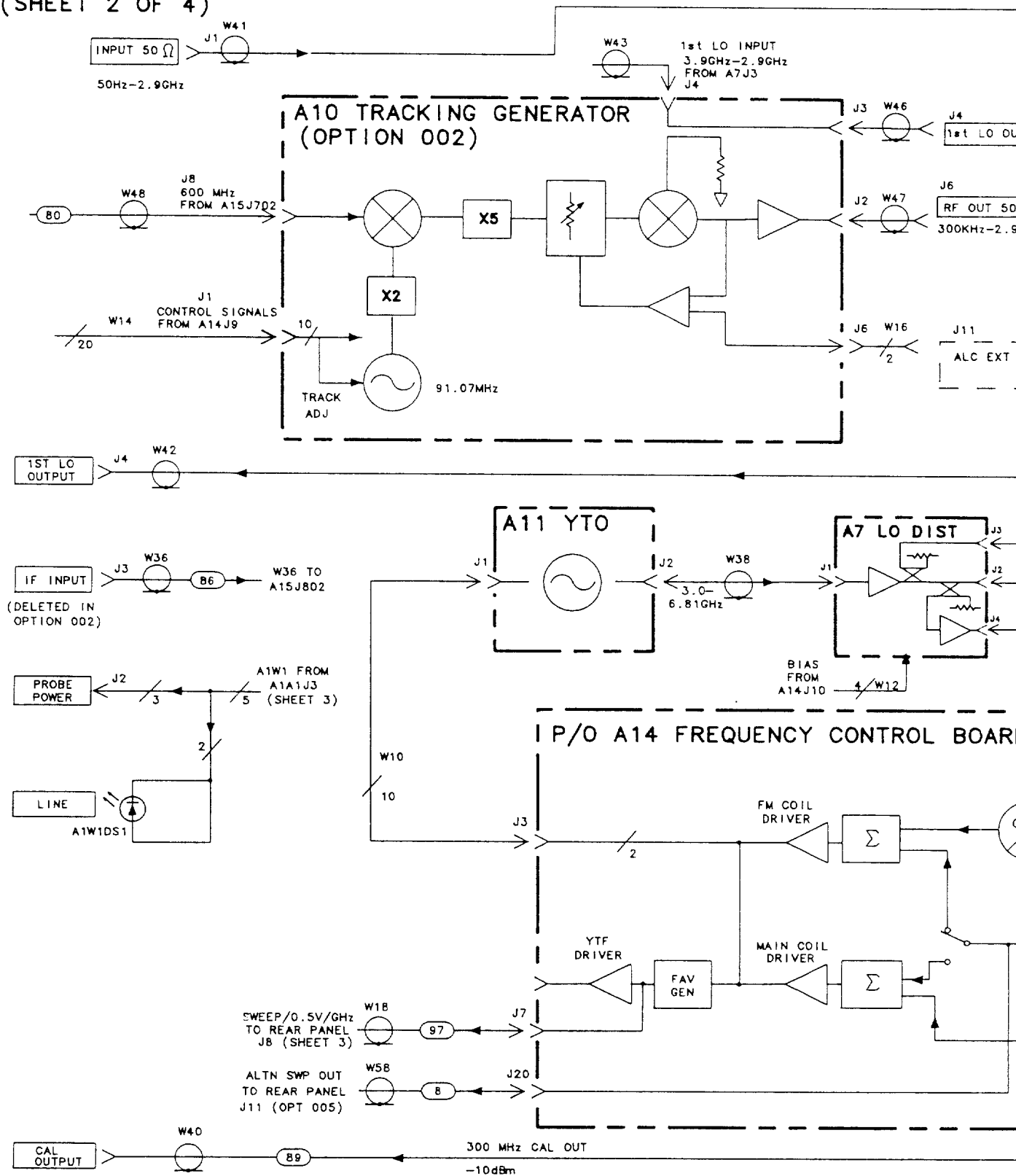
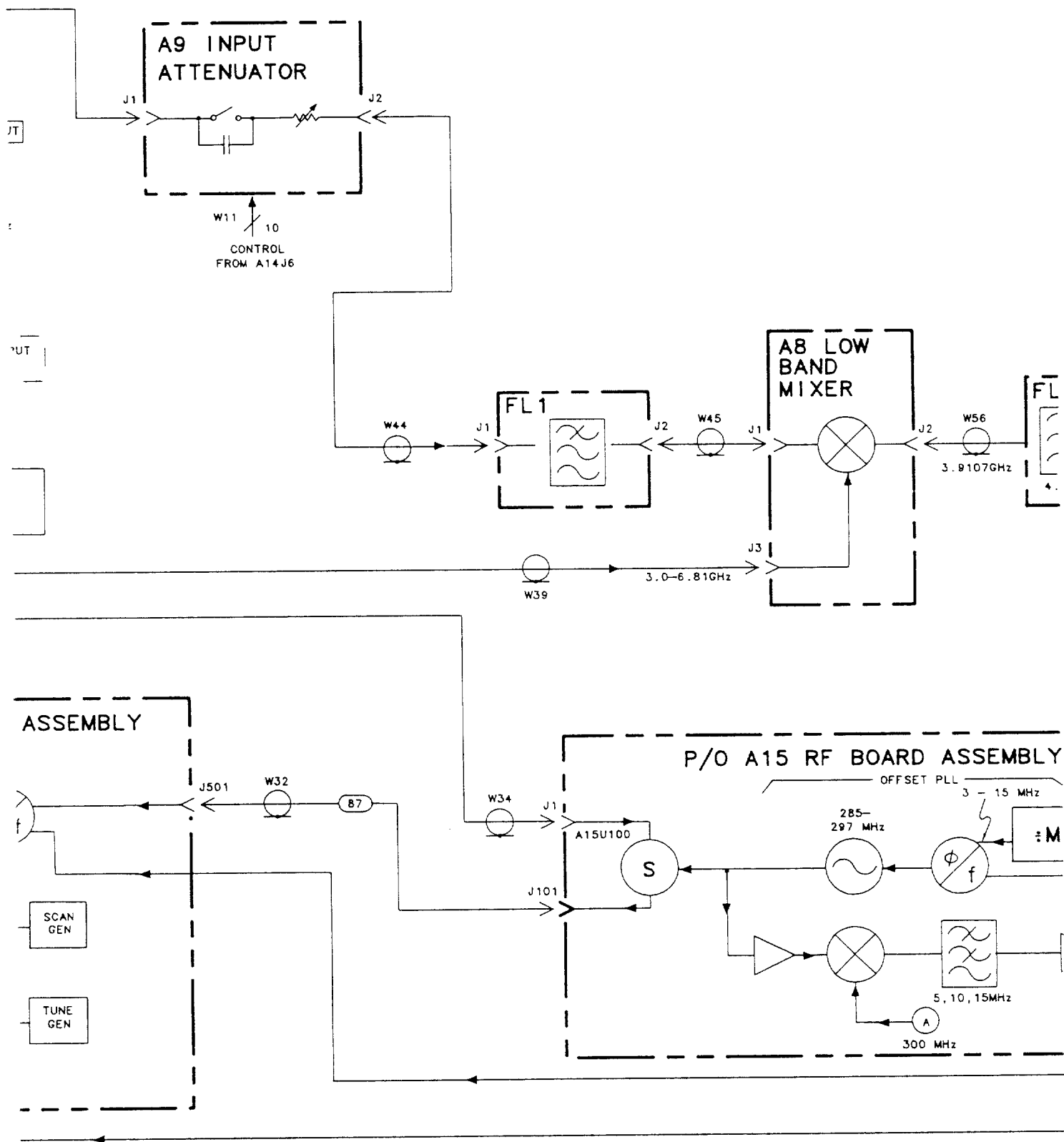
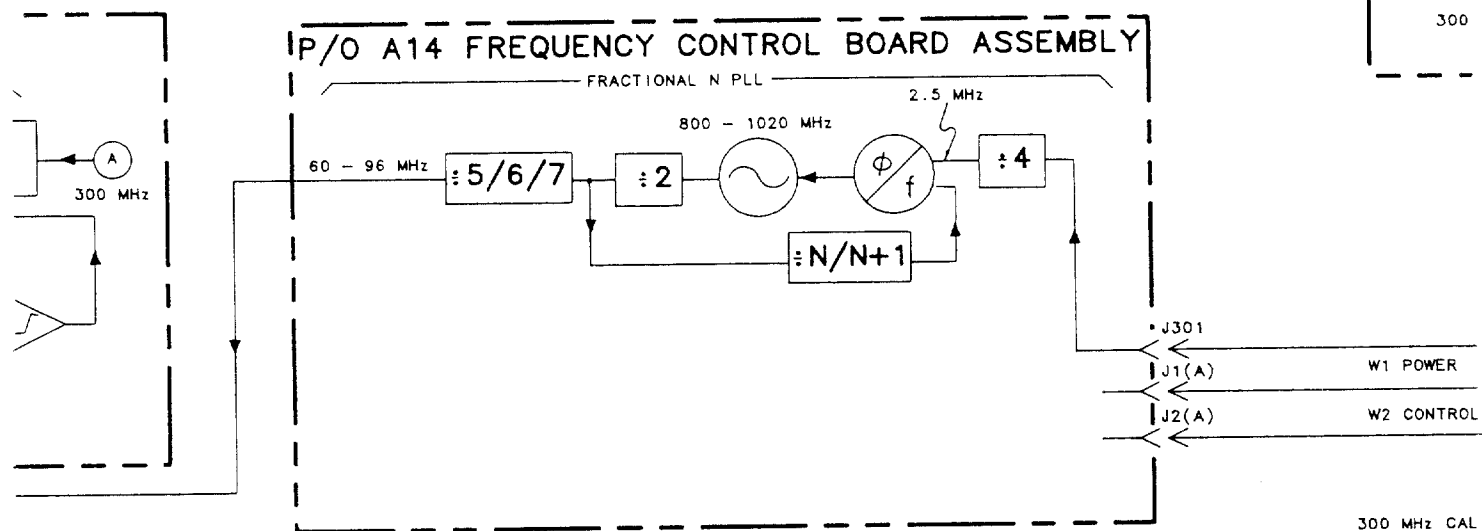
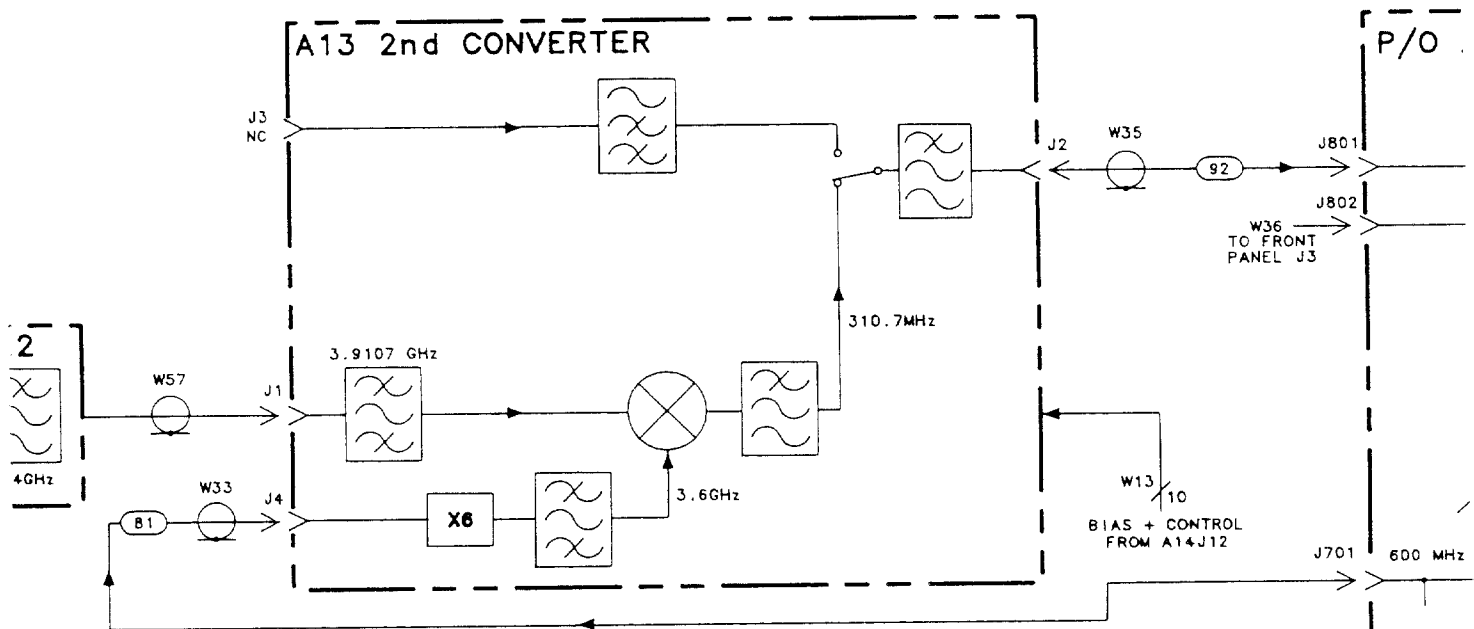


FIGURE 6-7. HP MODEL 8560E OVERALL BLOCK DIAGRAM
OF 4 FOR A15 08563-60054, 08563-60055, OR 08563-60056)

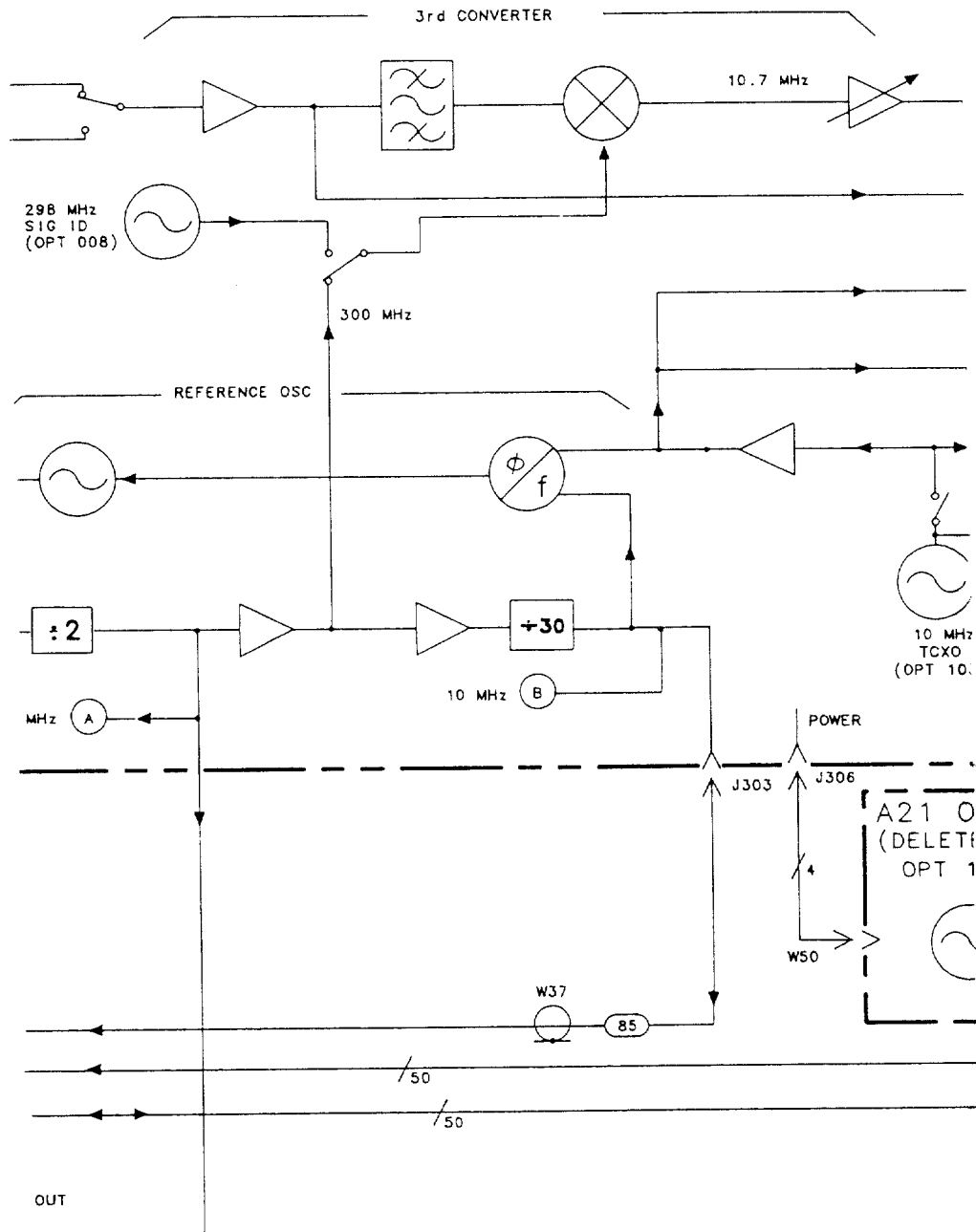
8560E OVERALL BLOCK DIAGRAM (SHEET 2 OF 4)







A15 RF BOARD ASSEMBLY



GENERAL TROUBLESHOOTING

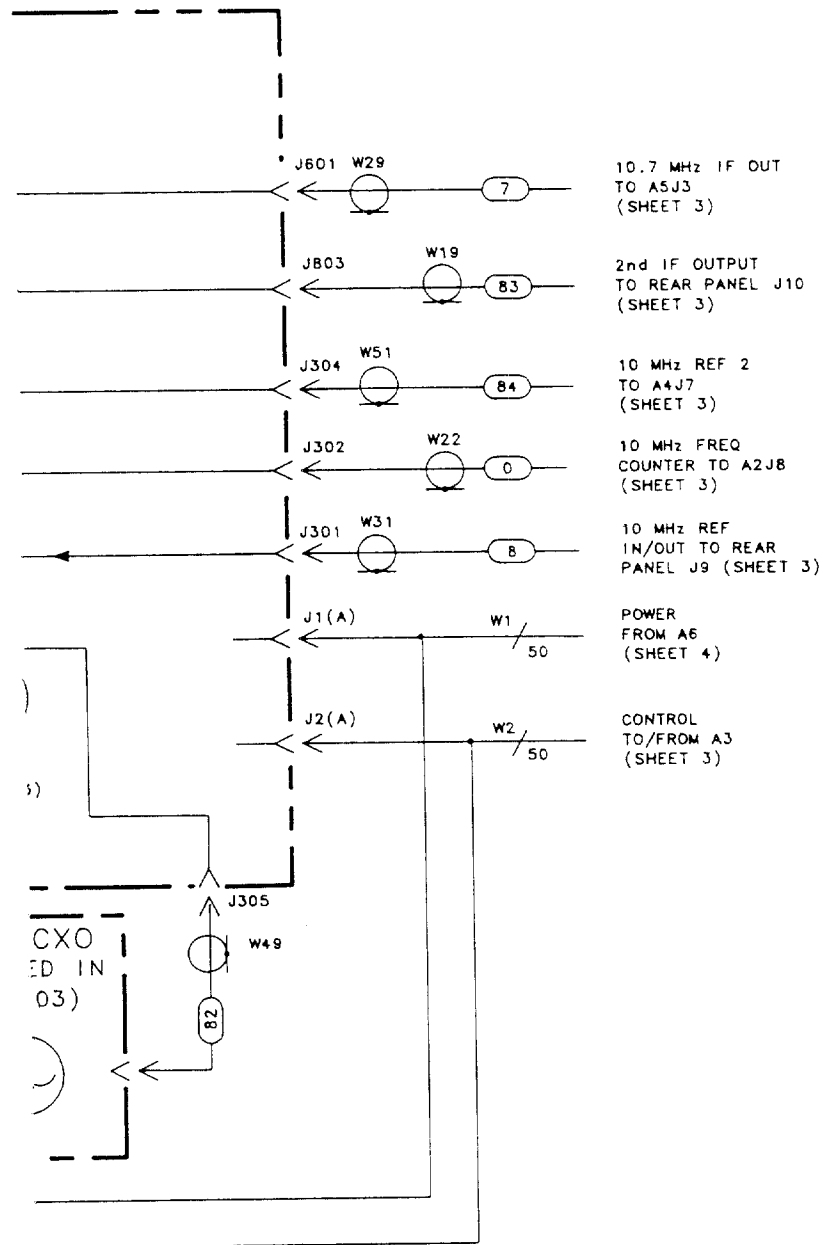
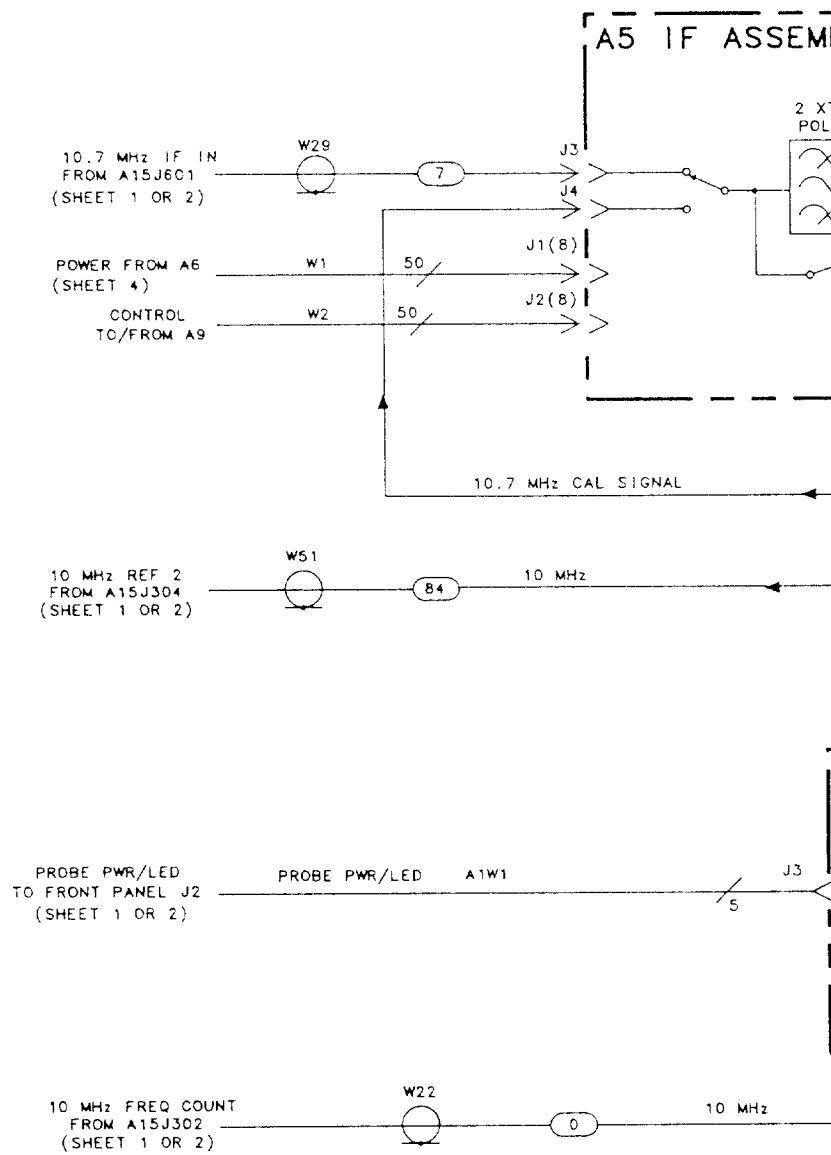
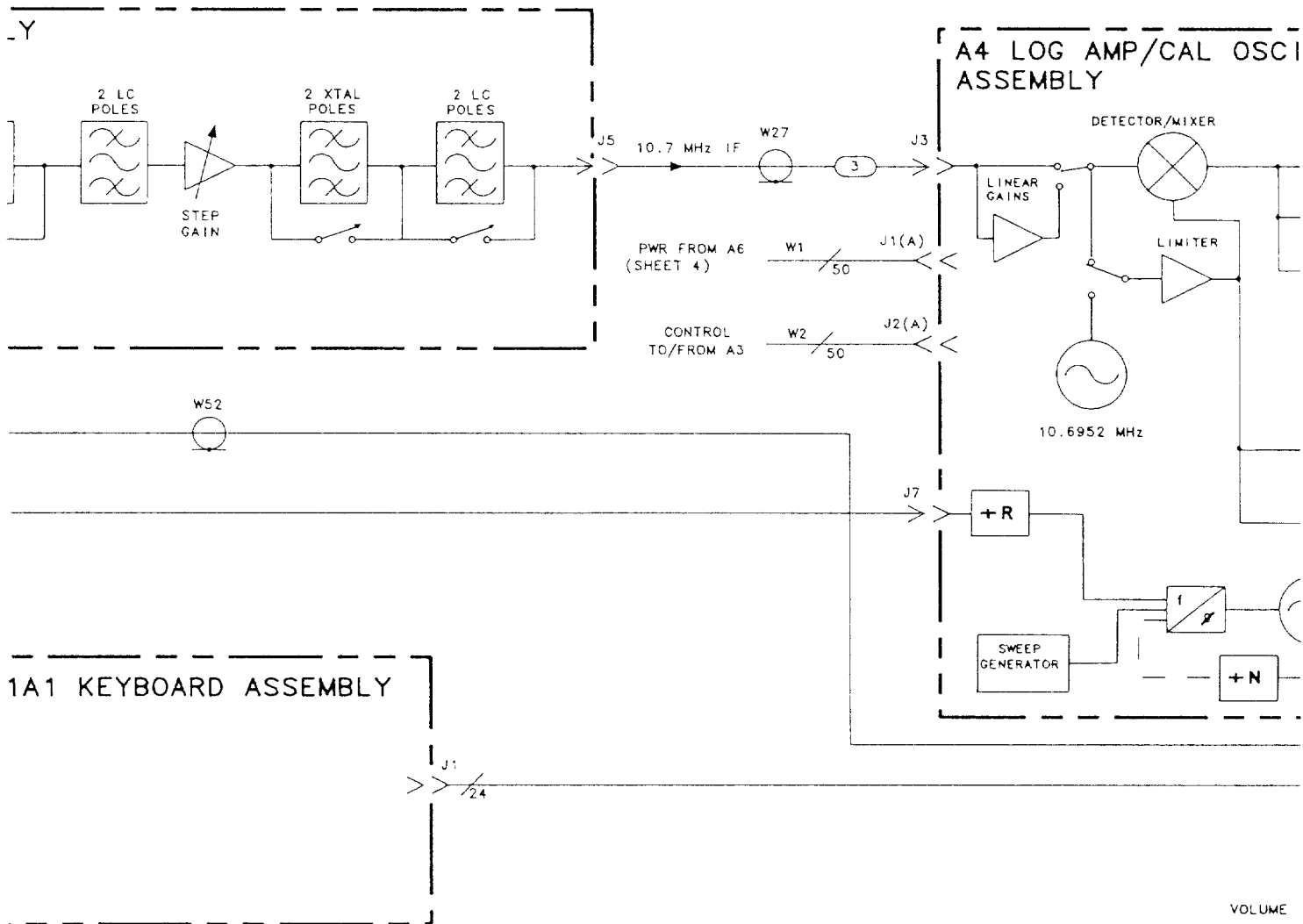
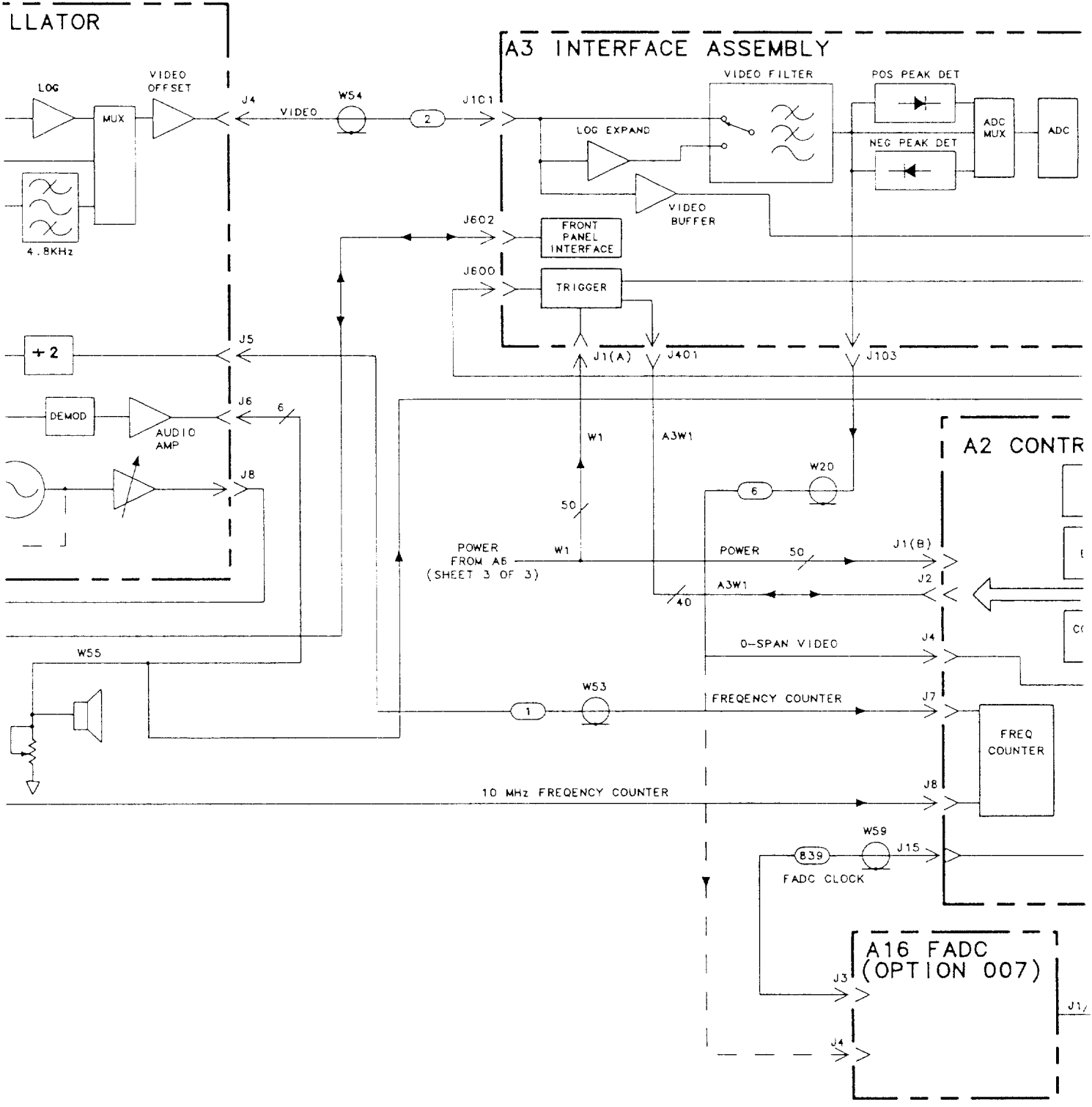


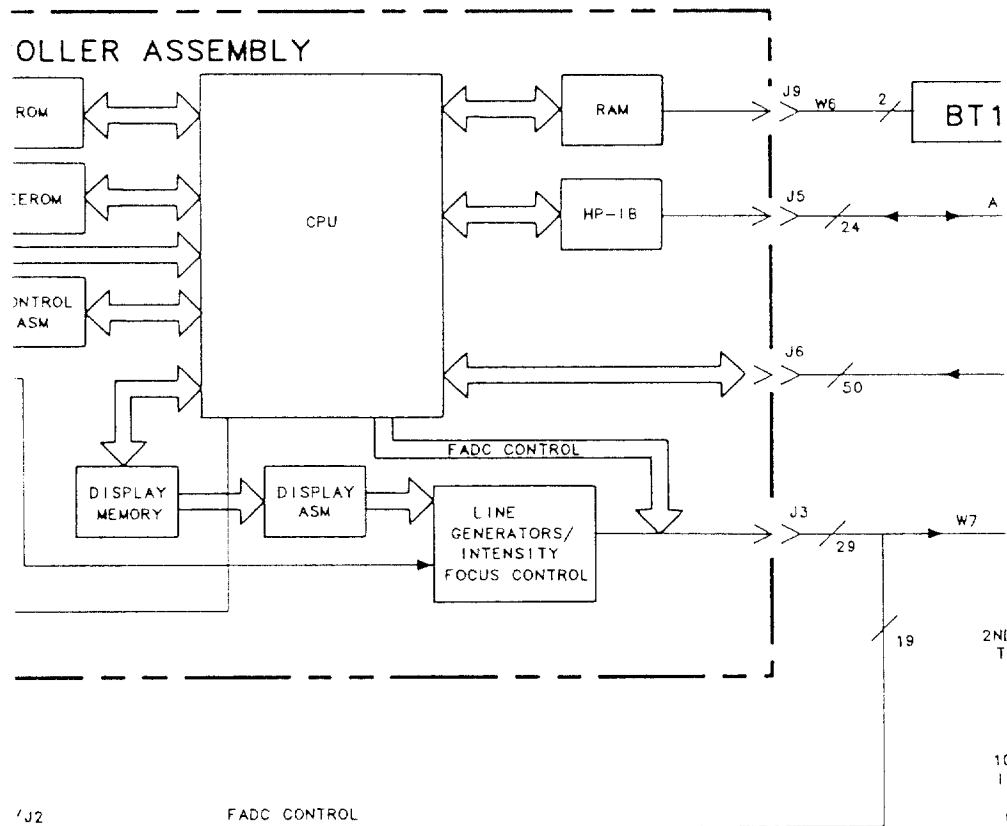
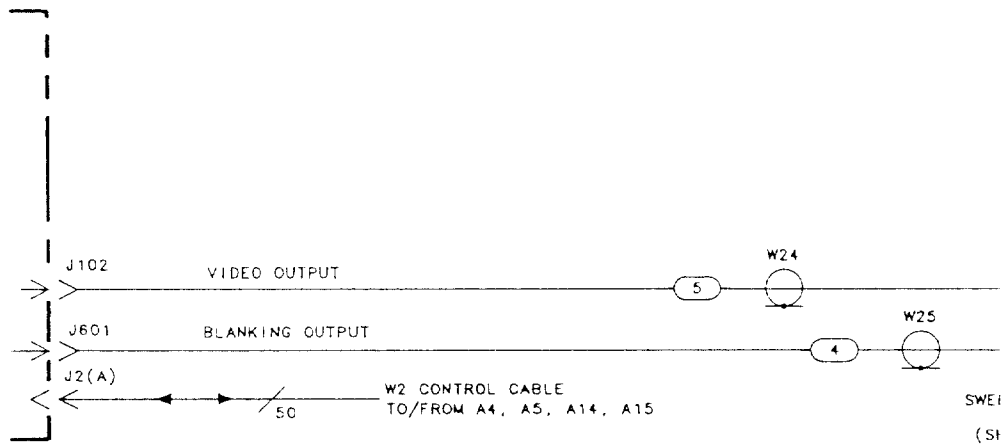
FIGURE 6-7. HP MODEL 8560E OVERALL BLOCK DIAGRAM
 EARLIER THAN 08563-60054, 08563-60055, OR 08563-60056).

8560E OVERALL BLOCK DIAGRAM (SHEET 3 OF 4)









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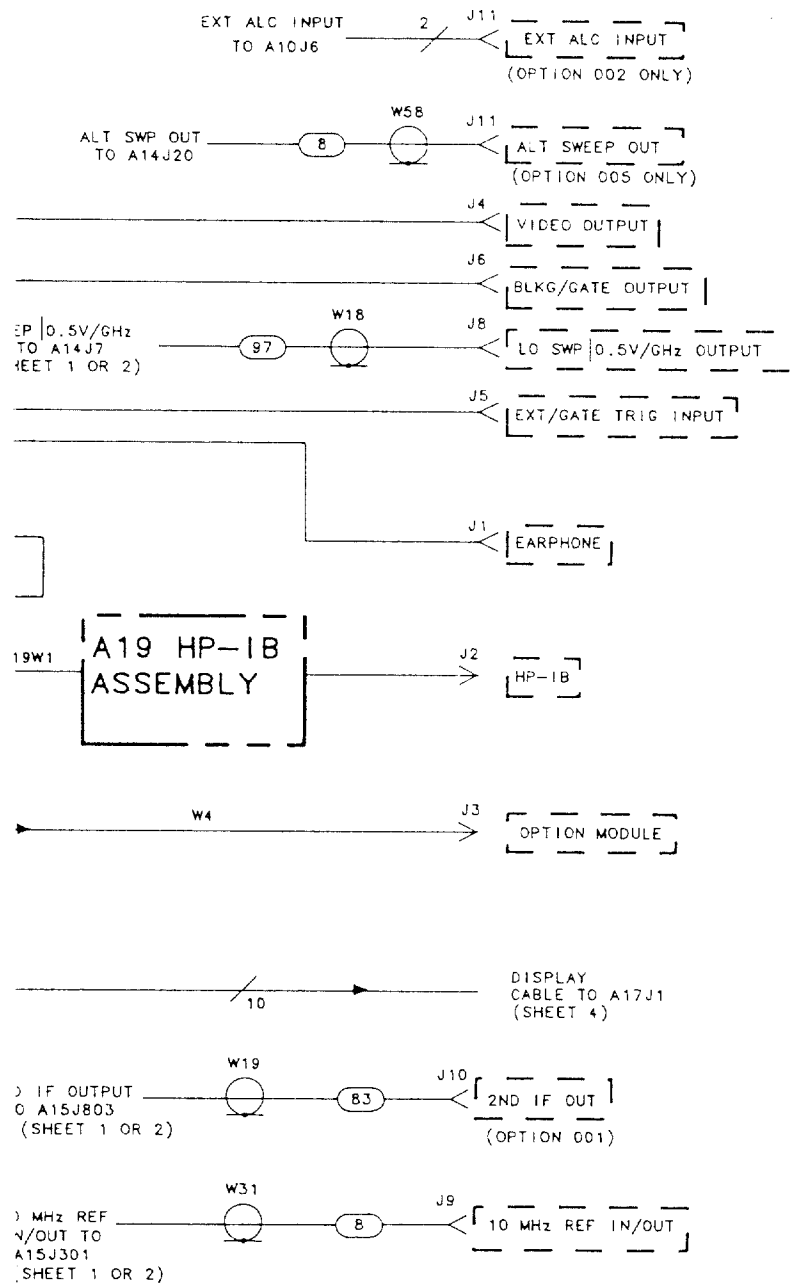
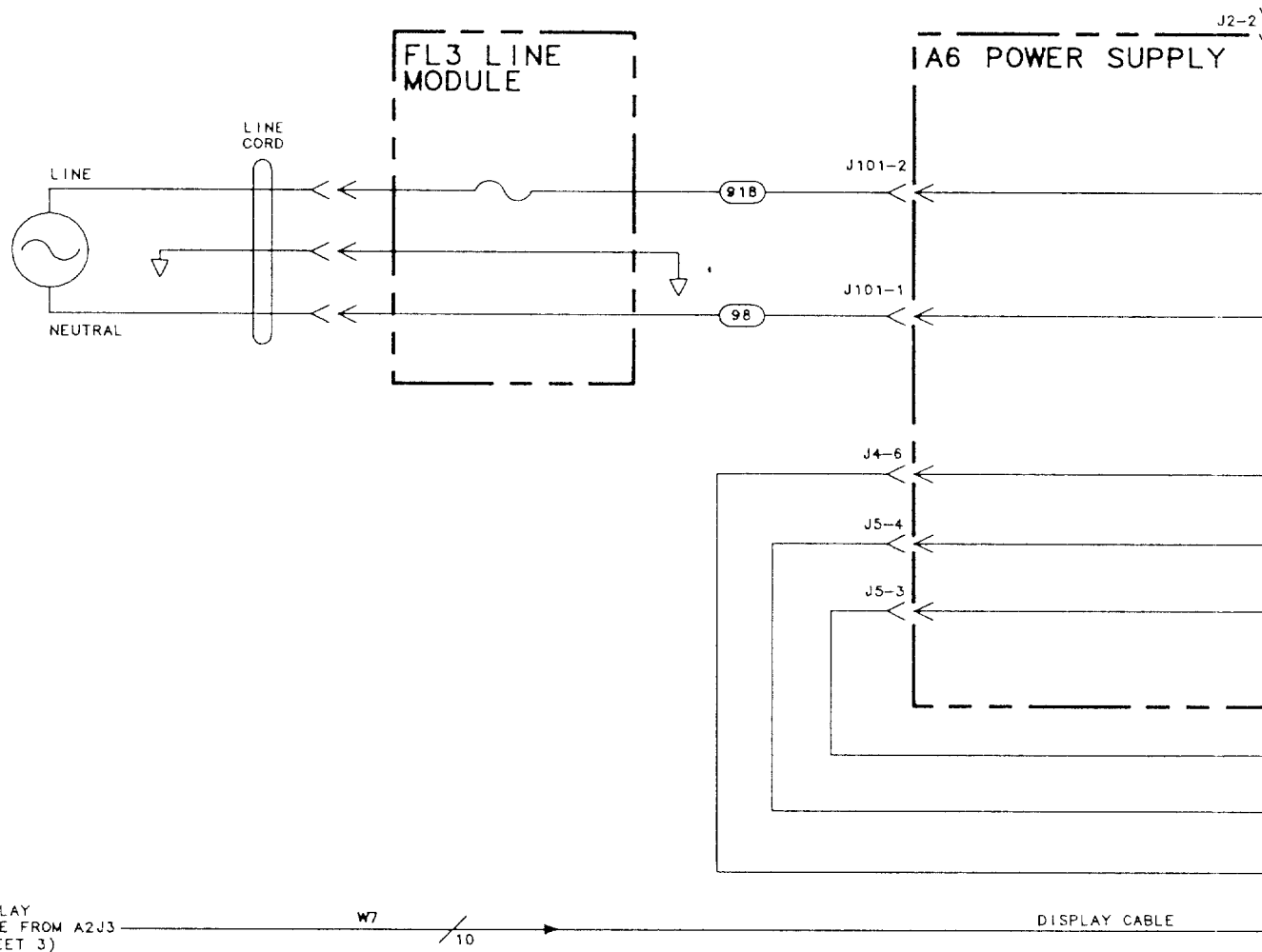
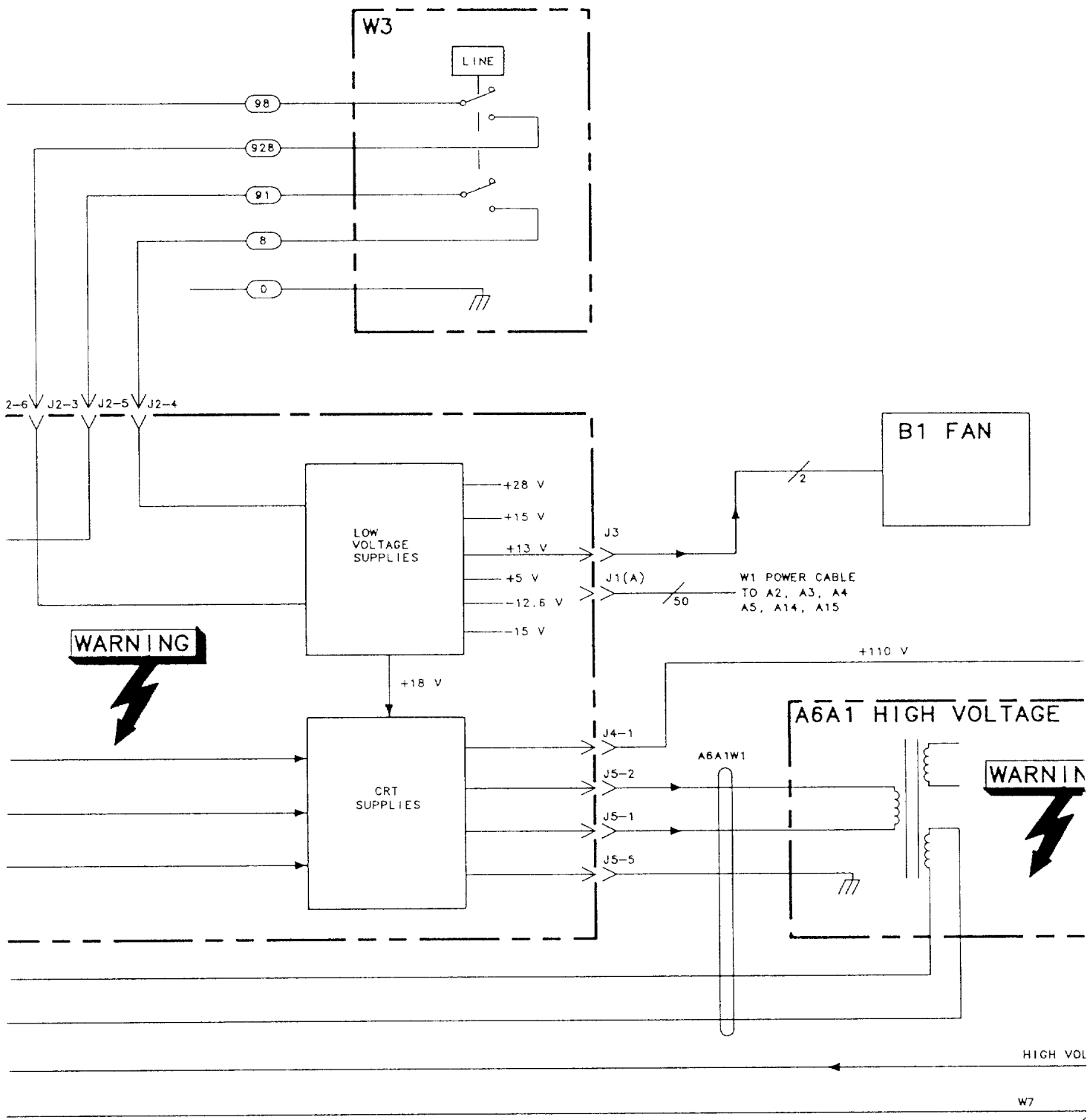
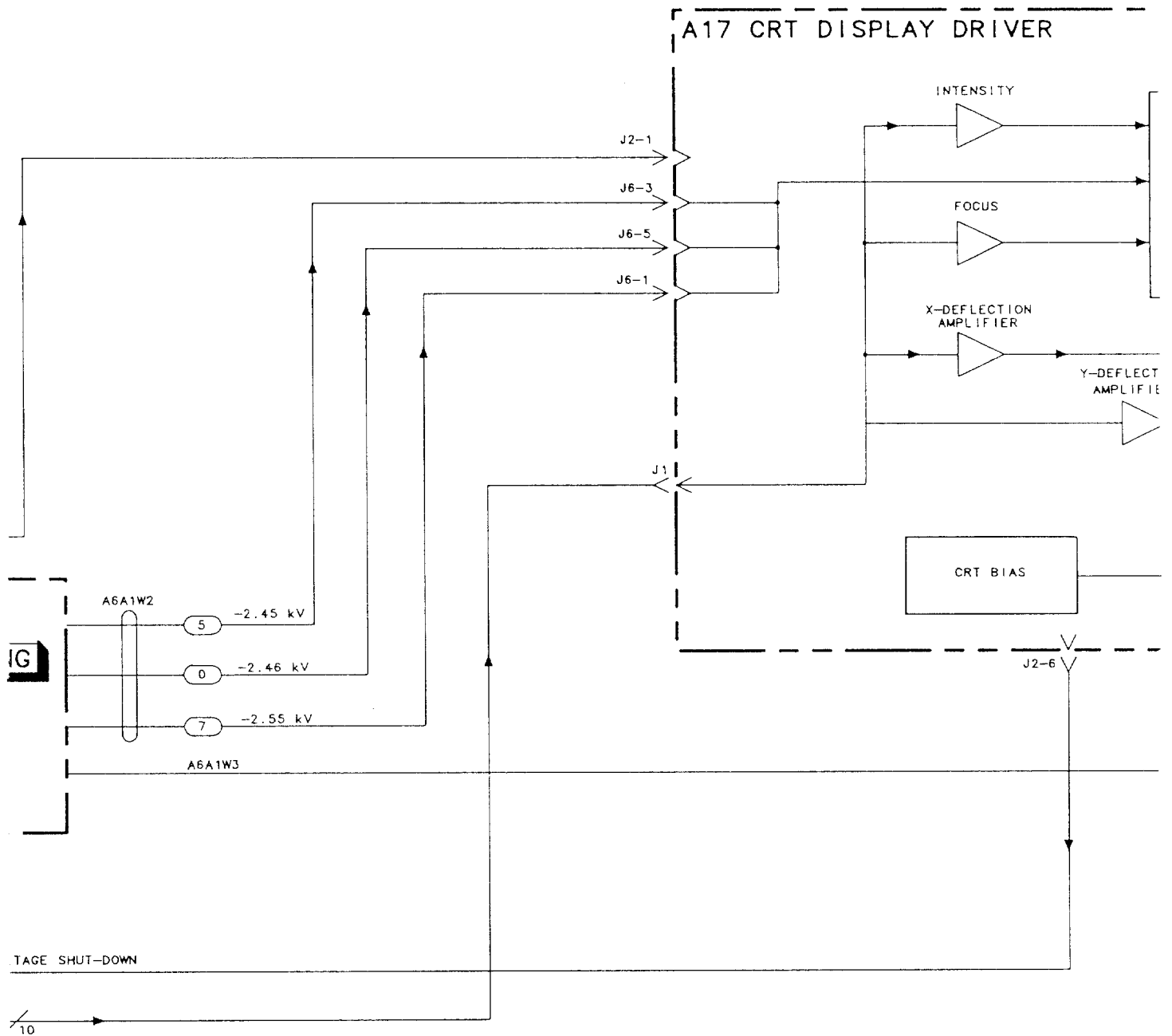


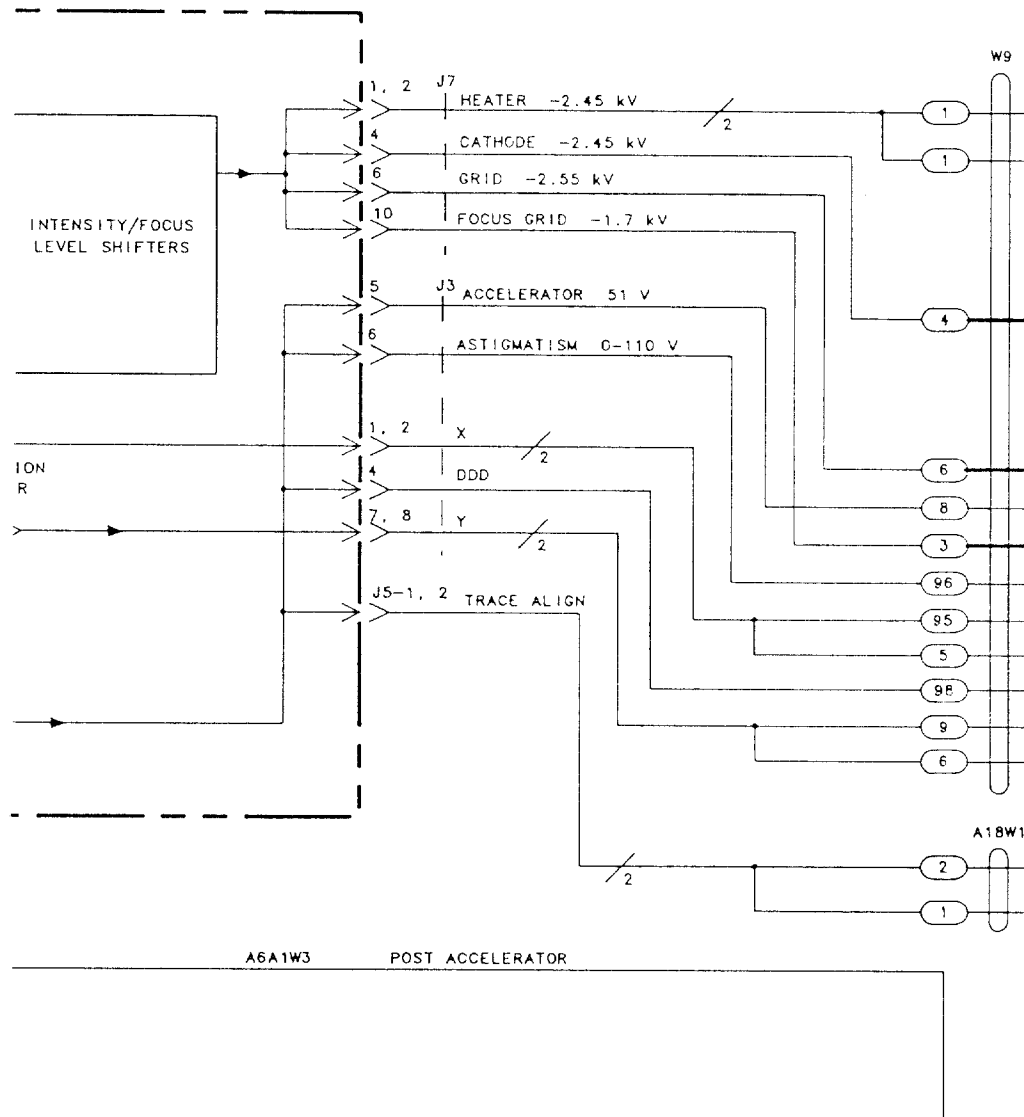
FIGURE 6-7. HP 8560E OVERALL BLOCK DIAGRAM (SHEET 3 OF 4)

8560E OVERALL BLOCK DIAGRAM
(SHEET 4 OF 4)



A17 CRT DISPLAY DRIVER





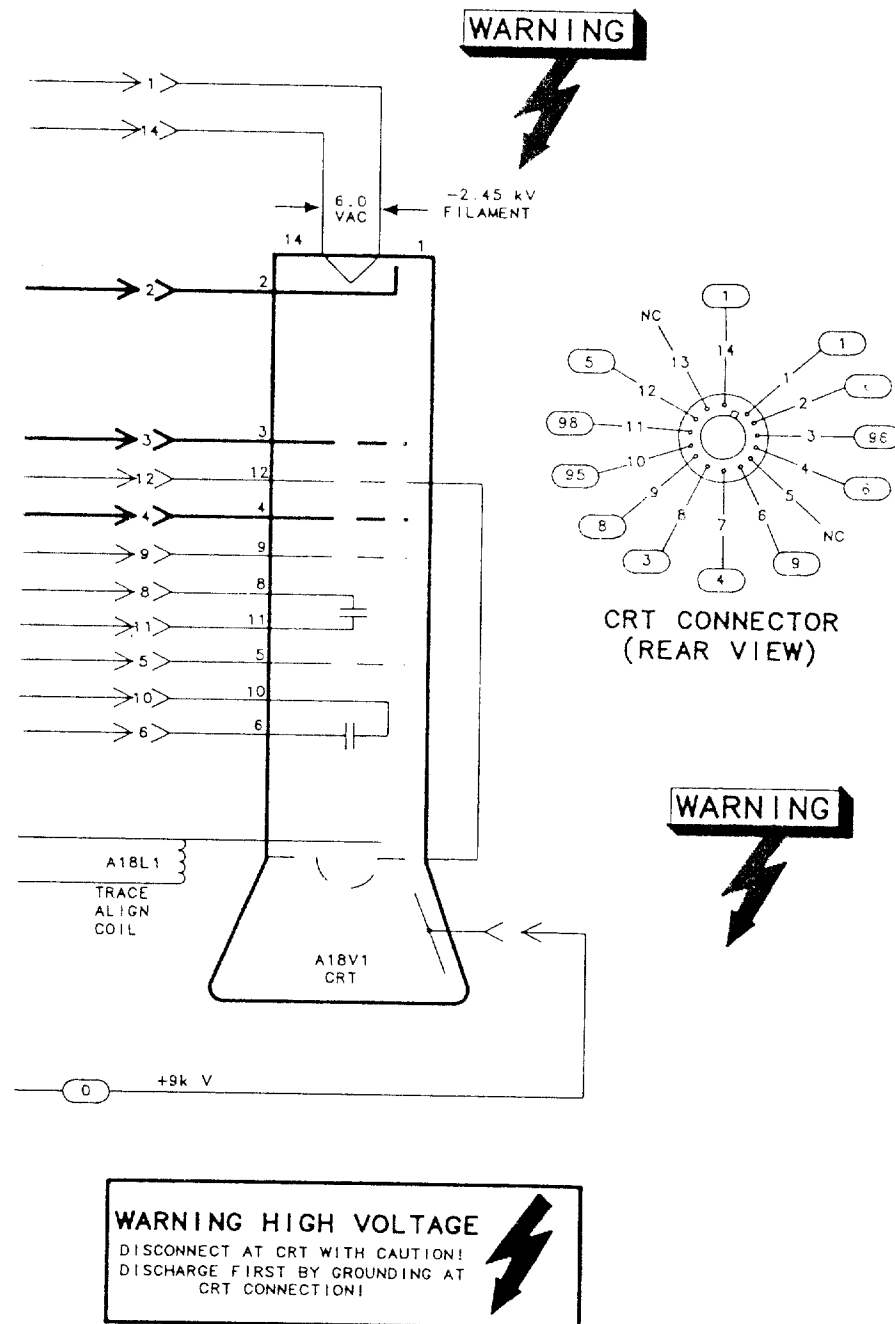


FIGURE 6-7. HP 8560E OVERALL BLOCK DIAGRAM (SHEET 4 OF 4)

ADC/Interface Section

The ADC/Interface section includes the A1A1 keyboard, A1A2 RPG (rotary pulse generator), A3 interface, and A16 fast ADC (Option 007) assemblies. Table 7-1 lists signal versus pin numbers for control cable W2.

- Troubleshooting Using the TAM
 - Automatic Fault Isolation
- Keyboard/RPG Problems
 - Keyboard Interface
 - RPG Interface
- Triggering or Video Gating Problems
- Preselector Peaking Control (Real Time DAC)
- Flatness Control (RF Gain DACs)
- A3 Assembly's Video Circuits
 - Log Offset/Log Expand
 - Video MUX
 - Video Filter
 - Video Filter Buffer Amplifier
 - Positive/Negative Peak Detectors
 - Peak Detector Reset
 - Rosenfell Detector
 - ADC MUX
 - Variable Gain Amplifier (VGA)
 - Track and Hold
- A3 Assembly's ADC Circuits
 - ADC Control Signals
 - ADC Start/Stop Control
 - ADC ASM
 - ADC
 - Ramp Counter
- A3 Assembly's Control Circuits
 - Analog Bus Drivers
 - Analog Bus Timing
 - Interface Strobe Select
- A16 Assembly's Fast ADC Circuits (Option 007)
 - Video Input Scaling Amplifiers and Limiter
 - 8-Bit Flash ADC
 - Peak/Pit Detection
 - 32 K-Byte Static RAM
- A16 Assembly's Fast ADC Control Circuits (Option 007)
 - CPU Interface and Control Registers
 - Reference Clock
 - Clock and Sample Rate Generator

Trigger
 16-Bit Post-Trigger Counter
 15-Bit (32 K) Circular Address Counter
 Video Trigger Comparator

Table 7-1. W2 Control Cable Connections

Signal	A3J2 (pins)	A4J2 (pins)	A5J2 (pins)	A14J2 (pins)	A15J2 (pins)
D0	1*	1	50	1	1
D GND	2*	2	49	2	2
D1	3*	3	48	3	3
D2	4*	4	47	4	4
D3	5*	5	46	5	5
D4	6*	6	45	6	6
D GND	7*	7	44	7	7
D5	8*	8	43	8	8
D6	9*	9	42	9	9
D7	10*	10	41	10	10
A0	11*	11	40	11	11
D GND	12*	12	39	12	12
A1	13*	—	38	13	13
A2	14*	—	37	14	14
A3	15*	15	36	15	15
A4	16*	—	35	16	16
D GND	17*	17	34	17	17
A5	18*	—	33	18	—
A6	19*	—	32	—	—
A7	20*	—	31	20	—
D GND	21*	21	30	21	21
LRF_STB	22*	—	—	—	22
LFC_STB	23*	—	—	23	—
LIF_STB	24*	—	27	—	—
CAL OSC TUNE	25	25*	—	—	—
LLOG_STB	26*	26	—	—	—
VCMON	—	—	—	27	—
D GND	28*	28	23	28	28
RT PULSE	29*	—	—	—	—
HSCAN	30*	—	—	30	—
D GND	31*	31	20	31	31
RESERVED	—	—	—	—	—
OFL ERR	33	—	—	—	33*
R/T DAC3	34*	—	—	—	—

* Indicates signal source.

Table 7-1. W2 Control Cable Connections (continued)

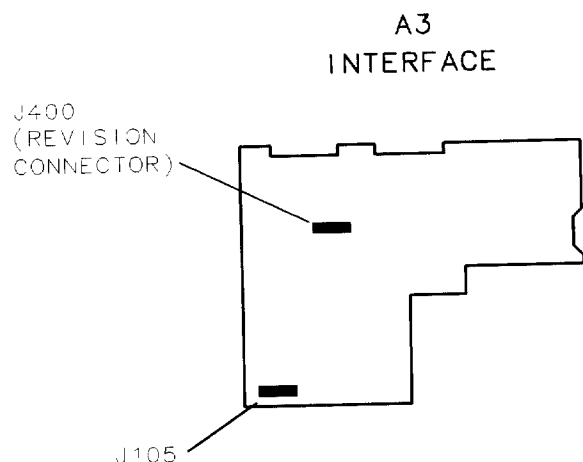
Signal	A3J2 (pins)	A4J2 (pins)	A5J2 (pins)	A14J2 (pins)	A15J2 (pins)
A GND	35*	35	16	35	35
RF GAIN	36*	—	—	—	36
LO3 ERR	—	—	—	37	37*
A GND	38*	38	13	38	38
LVFC_ENABLE	39*	—	—	39	—
FC ERR	40	—	—	40*	—
A GND	41*	41	10	41	41
YTO ERR	42	—	—	42*	—
+10V REF	43*	43	—	—	43
A GND	44*	44	7	44	44
SCAN RAMP	45	—	—	45*	—
VIDEO TRIGGER	46*	—	—	—	—
A GND	47*	47	4	47	47
NC	—	—	—	—	—
R/T DAC2	49*	—	—	—	—
R/T DAC1	50*	—	—	50	—

* Indicates signal source.

Troubleshooting Using the TAM

When using Automatic Fault Isolation, the TAM indicates suspected circuits that need to be manually checked. Use Table 7-2 to locate the manual procedure.

Table 7-3 lists assembly test connectors associated with each Manual Probe Troubleshooting test. Figure 7-1 illustrates the location of A3's test connectors.



SK 169

Figure 7-1. A3 Test Connectors

Automatic Fault Isolation

Analog data bus errors that occur during Automatic Fault Isolation result from either a shorted W2 control cable or faulty A3 assembly. Perform the following steps to determine the cause of the error.

1. Disconnect W2 from A3J2 and repeat the Automatic Fault Isolation procedure.
2. If the analog data bus error is still present, troubleshoot the A3 Interface assembly. If the error disappears, look for a short on W2 or another assembly connecting to it.
3. To isolate a short on W2, reconnect W2 to A3J2 and disconnect W2 from all other assemblies.
4. Repeat the Automatic Fault Isolation routine.
5. If the analog data bus error is still present, W2 is shorted. If the error disappears, reconnect the other assemblies one at a time and repeat the procedure. Once the faulty assembly is reconnected to W2, the error should reappear.

Table 7-2. Automatic Fault Isolation References

Suspected Circuit Indicated by Automatic Fault Isolation	Manual Procedure to Perform
Check ADC ASM	ADC ASM
Check ADC MUX	ADC MUX
Check ADC Start/Stop Control	ADC Start/Stop Control
Check Analog Bus Drivers	Automatic Fault Isolation (<i>in this chapter</i>) Analog Bus Drivers
Check Analog Bus Timing	Automatic Fault Isolation (<i>in this chapter</i>) Analog Bus Timing
Check Interface Strobe Select	Interface Strobe Select
Check Keyboard Interface	Keyboard/RPG Problems
Check Negative Peak Detector	Positive/Negative Peak Detectors (<i>steps 3 through 10</i>)
Check Peak Detector Reset	Peak Detector Reset
Check Positive Peak Detector	Positive/Negative Peak Detectors (<i>steps 3 through 10</i>)
Check Real Time DAC	Preselector Peaking Control (Real Time DAC)
Check Ramp Counter	Ramp Counter
Check RF Gain DACs	Band Flatness Control (RF Gain DACs)
Check Rosenfell Detector	Rosenfell Detector
Check RPG Interface	Keyboard/RPG Problems
Check Track and Hold	Track and Hold
Check Trigger	Triggering Problems
Check Variable Gain Amplifier (VGA)	Variable Gain Amplifier (VGA)
Check Video Filter	Video Filter
Check Video Filter Buffer Amplifier	Video Filter Buffer Amplifier
Check Video MUX	Video MUX

Table 7-3. TAM Tests versus A3 Test Connectors

Connector	Manual Probe Troubleshooting Test	Measured Signal Lines
A3J105	Video Input to Interface Video to Rear Panel Video MUX LOG Offset/LOG Expand Video Filter Buffer Amp. Video Peak Detectors ADC MUX Variable Gain Amplifier Track and Hold	MS1 MS1, MS2 MS1, MS3 MS1, MS3 MS3, MS5, OS1 MS5, MS6 MS6 MS6, MS7 MS7, MS8
A3J400	Revision Trigger ADC Start/Stop Control Video Trigger DAC Real Time DAC #1 RF Gain DACs	MS2 MS8 MS7 MS1 MS3 MS6

Keyboard/RPG Problems

Keyboard Interface

Refer to function block G of A3 Interface Assembly Schematic Diagram (sheet 3 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

A pressed key results in a low on a keyboard sense line (LKSNS0 through LKSNS7). This sets the output of NAND gate U607 high, generating KBD/RPG_IRQ. The CPU determines the key pressed by setting only one keyboard scan line (LKSCN0 through LKSCN5) low through U602 and reading the keyboard sense lines.

1. If none of the keys or RPG responds, check ribbon cable, A1A1W1. (This cable connects the A1A1 keyboard to the A3 interface assembly.) The keys are arranged in a row/column matrix, as shown in Table 7-4.
2. If an entire row or column of keys does not respond, and the RPG does respond, there might be an open or shorted wire in A1A1W1.

Table 7-4. Keyboard Matrix

	LKSNS0	LKSNS1	LKSNS2	LKSNS3	LKSNS4	LKSNS5	LKSNS6	LKSNS7
LKSCN0	CONFIG	SAVE	RECALL	GHz	MHz	kHz	Hz	PRESET
LKSCN1	MODULE	TRIG	DISP	9	6	3	BK SP	↑
LKSCN2	PEAK SEARCH	BW	TRACE	8	5	2	•	↓
LKSCN3	FREQ COUNT	AUTO COUPLE	MKR →	7	4	1	0	HOLD
LKSCN4	SWEEP	SK1	SK2	SK3	SK4	SK5	SK6	MKR
LKSCN5	AUX CTRL	MEAS/USER	CAL	SGL SWP	COPY	FRE- QUENCY	SPAN	AMPLI- TUDE

3. Check that all inputs to NAND gate A3U607 (LKSNS lines) are high when no key is pressed. If any input is low, continue with the following:
 - a. Disconnect A1A1W1 from A3J602 and again check all inputs to U607.
 - b. If any input is low with A1A1W1 disconnected, suspect A3U604, A3U607, or A3U602.
 - c. Reconnect A1A1W1 to A3J602.
4. Monitor A3U607 pin 8 with a logic probe. A TTL high should be present when any key is held down. Monitor this point while pressing each key in succession.
5. Check that the LKSCN lines (outputs of A3J602 pins 1 through 6) read a TTL low with no key pressed. (Any TTL high indicates a faulty A3 Interface assembly.)
6. Check that a pulse is present at each LKSCN output of U602 when a key is pressed.
7. Check that only one input to U607 (LKSNS lines) goes low when a key is pressed.
8. Check that U602 pin 9 (LKBD_RESET) pulses low when a key is pressed.

9. If LKBD_RESET is incorrect and a pulse is not present at each of the LKSCN outputs of U602 when a key is pressed, check for LWRCLK and LSCAN_KBD.

RPG Interface

Refer to function block J of A3 Interface Assembly Schematic Diagram (sheet 3 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

U608B latches the RPG direction from the two RPG outputs, RPG_COUNT and RPG_COUNT1. Counterclockwise RPG rotation produces low-going pulses which result in a high output on U608B. Clockwise RPG rotation results in a low output from U608B. U612A provides the edge to trigger one-shot U423B, which generates a 90 ms pulse. This pulse gates U610A for counting of RPG pulses by U606. Gates U610D and U614D prevent retriggering of U423B until its 90 ms pulse has timed out.

Note Elsewhere, RPG_COUNT1 is referred to as RPG_01 and RPG_COUNT is referred to as RPG_02.

1. Monitor A3U401 pin 2 with a logic probe or oscilloscope. Pulses should be present as the RPG is rotated.
2. Monitor A3U608 pin 12 as the RPG is rotated. Pulses should be present.
3. If pulses are missing at both points, check for power and ground signals to A1A1W1 and A1A2W1. If both power and ground are there, the A1A2 RPG is probably defective.
4. If pulses are missing at only one point, check for an open or short on A1A1W1 and A1A2W1. If these cables are working properly, A1A2 RPG is probably defective.
5. Press **LINE** to turn spectrum analyzer off and disconnect A1A1W1 from A3J602. Jumper A3U608 pin 12 (RPG_COUNT) to U608 pin 14 (+5 Vdc). Jumper U401 pin 2 (RPG_COUNT1) to U511 pin 11 (HDPKD_CLK). This provides a 7.8 kHz square wave to the RPG_COUNT1 input of the RPG Interface.
6. Press **LINE** to turn spectrum analyzer on.
7. Check A3U608 pin 9 for narrow, low-going pulses approximately every 90 ms.
8. Check A3U608 pin 13 (LRPG_RESET) for narrow, low-going pulses approximately every 90 ms.
9. Check A3U612 pin 5 for narrow, low-going pulses approximately every 90 ms.
10. Check U608 pin 5 (HRPG_IRQ) for narrow, high-going pulses approximately every 90 ms.
11. If HRPG_IRQ is correct but LRPG_RESET is incorrect, check U505 pin 13 (LKBD/RPG_IRQ) for narrow, low-going pulses approximately every 90 ms.
12. If HRPG_IRQ and LKBD/RPG_IRQ are correct but LRPG_RESET is incorrect, suspect a failure on the A2 controller assembly.
13. Check U610 pin 3 for a 7.8 kHz square wave. Check U606 pin 2 (HRPG_RESET) for narrow, high-going pulses approximately every 90 ms. Refer to Table 7-5 and check the frequencies at divide-by-16 counter A3U606.
14. If all the checks above are correct but the spectrum analyzer does not respond to the RPG, suspect a problem in either the A1A2 RPG or the A1A1 Keyboard.

15. Press **LINE** to turn spectrum analyzer off.
16. Reconnect A1A1W1 to A3J602 and remove all jumpers.

Table 7-5. Counter Frequencies

A3U606 pin #	Nominal Frequency (Hz)
3	3900
4	1950
5	975
6	488
11	244
10	122
9	61

Triggering or Video Gating Problems

Refer to function block H of A3 Interface Assembly Schematic Diagram (sheet 3 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The 1 MHz ADC clock provides synchronization in FREE RUN and SINGLE triggering. LINE triggering synchronization originates on the A6 power supply. Trigger MUX A3U613 selects between FREE RUN, VIDEO, LINE, and EXTERNAL trigger sources. The trigger signal sets the output of the HSCAN latch high. HBADC_CLK0 provides the trigger signal for FREE RUN. The VIDEO TRIG signal must be at least 25 mV (0.25 divisions) peak-to-peak to trigger in video trigger mode.

The trigger for Gated Video has two modes of operation, level mode and edge mode. In the edge mode, positive-edge or negative-edge triggering can be selected. Output 0 from pin 10 of A3U617 generates the gate delay and output 1 from pin 13 of A3U617 generates the gate length. The duration of these two time intervals is set using front-panel softkeys under the **SWEEP** key. The trigger input for Gated Video is the rear-panel EXT/GATE TRIG INPUT (TTL > 10 k Ω).

1. Check that the trigger MUX is receiving the proper trigger source information by selecting each of the following trigger modes and checking the TRIG_SOURCE0 and TRIG_SOURCE1 lines as indicated in Table 7-6.
2. If a trigger mode does not work, check that a trigger signal is present at the appropriate trigger MUX input, as indicated in Table 7-6.

Table 7-6. Trigger MUX Truth Table

Trigger Mode	TRIG_SOURCE0 U613 pin 14	TRIG_SOURCE1 U613 pin 2	MUX Input Pin Number U613
FREE RUN	L	L	6
VIDEO	H	L	5
LINE	H	H	3
EXTERNAL	L	H	4

3. Check that the appropriate trigger MUX input signal is present at the trigger MUX output (A3U613 pin 7).
4. To check the video trigger level DAC, connect a DVM's positive lead to A3J400 pin 1 and the negative DVM lead to A3TP4.
5. Press **TRIG** and **VIDEO**.
6. Press the STEP **▼** key several times while noting the DVM reading and position of the video trigger level on the screen.
7. Check that the voltage displayed on the DVM changes by 1 V for each step of the VIDEO TRIG LEVEL.
8. If the voltage changes incorrectly, proceed as follows:
 - a. Check the -10 Vdc reference (A3U409 pin 4).
 - b. While using the front-panel knob to adjust the video trigger level, check for the presence of pulses on A3U409 pin 15 (LDAC2).
 - c. While using the front-panel knob to adjust the video trigger level, check for the presence of pulses on A3U409 pin 16 (LWRCLK).
 - d. Check that pulses are present on U409 pin 6 (IA0).
9. If the LWRCLK and LDAC2 signals are not correct, refer to "Interface Strobe Select" in this chapter.
10. If correct trigger pulses are present at the trigger MUX output (A3U613 pin 7), but the instrument does not appear to be sweeping, proceed as follows:
 - a. Press **PRESET**, **SWEEP**, and **DLY SWP ON OFF** until ON is underlined, then **DLY SWP []** 30 milliseconds.
 - b. Using an oscilloscope, check for activity at pins 1 and 3 of A3U615A.
 - c. If there is activity at pin 1 but not at pin 3 of A3U615A, suspect A3U616 or A3U617.
 - d. If there is activity at pin 1 and pin 3 of A3U615A, suspect A3U615. (Check pin 5 for activity.)
11. If there is a problem with Video Gating, proceed as follows:
 - a. Press **PRESET** and set the HP 8560E as follows:

Center frequency	300 MHz
Span	0 Hz
Sweep time	150 ms
 - b. Press **TRIG**, **EXTERNAL**, then **SWEEP** and **GATE ON OFF** until ON is underlined.
 - c. Press **GATE DLY []** 10 milliseconds, then press **GATE LEN []** 30 milliseconds.
 - d. Connect a pulse/function generator (such as an HP 8116A) to provide a 5 V peak-to-peak square wave (TTL level) to the HP 8560E rear-panel EXT/GATE TRIG INPUT and also (using a BNC tee) to the channel 4 input of the oscilloscope (HP 54501A).
 - e. Set the pulse/function generator to NORMAL mode with a duty cycle of 50% and a frequency of 10 Hz.

f. Press the following keys on the oscilloscope:

CLEAR DISPLAY

off frame axes grid highlight **grid**

connect dots off on highlight **on**

TRIG

source 1 2 3 4 highlight **4**

level 2 V

TIMEBASE

TIMEBASE 50 ms/div

CHAN

CHANNEL 1 2 3 4 off on

highlight CHANNEL 1 on

set V/div to 0.2 V and offset to 0.6 V (10:1 probe used)

highlight CHANNEL 4 on

set V/div to 2 V and offset to 0 V

DISPLAY

DISPLAY norm avg env highlight **norm**

- g. Using a 10:1 probe connected to channel 1 of the oscilloscope, check for activity at pins 10 and 13 of A3U617.
- h. If either pin (or both) show no activity, check for activity at pin 21 (LTIMER) of A3U617.
- i. If LTIMER is not active, troubleshoot the Interface Strobe Select circuitry (block K)
- j. If there was activity at pins 10 and 13 of A3U617, suspect A3U616.

Preselector Peaking Control (Real Time DAC)

Refer to function block L of A3 Interface Assembly Schematic Diagram (sheet 4 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The HP 8560E uses a real-time DAC (R/T DAC1) to peak the preselector.

1. Press **PRESET** on the HP 8560E and set the span to 0 Hz.
2. Connect a positive DVM lead to A3J400 pin 3 and the negative DVM lead to A3TP4.
3. Press **MKR**, **AUX CTRL**, **INTERNAL MIXER**, and **PRESEL MAN ADJ**.
4. Monitor the DVM reading while changing the PRESELECTOR TUNE value from 0 to 255. The PRESELECTOR TUNE value is R/T DAC1's setting.
5. Check that the DVM reading increases from 0 to approximately +10 Vdc as R/T DAC1 is set from 0 to 255.
6. If the voltage does not change as described, set the spectrum analyzer to single trigger mode and check the following:
 - a. Check that A3U409B pin 18 is at -10 Vdc.

- b. Check for the presence of pulses at U409 pin 6 (IA0).
 - c. Check that pulses are present at U409 pin 15 (LDAC2).
 - d. Check that pulses are present at U409 pin 16 (LWRCLK).
7. If the LDAC2 or LWRCLK signals are incorrect, refer to “Interface Strobe Select” in this chapter.

Flatness Control (RF Gain DACs)

Refer to function block M of A3 Interface Assembly Schematic Diagram (sheet 4 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

RF Gain DACs control the A15 assembly's flatness compensation amplifiers. The RF Gain DACs are arranged so that the output of one DAC is the voltage reference for the other DAC. This results in an RF GAIN voltage which is exponentially proportional to the DAC settings. Each DAC is set to the same value. The A15 RF assembly converts the RF GAIN signal to a current for driving the PIN diode attenuators in the Flatness Compensation Amplifiers. The exponentially-varying voltage compensates for the nonlinear resistance-versus-current characteristic of the PIN diodes.

1. Place the WR PROT/WR ENA jumper on the A2 controller assembly in the WR ENA position.
2. Press **CAL**, **MORE 1 OF 2**, **SERVICE CAL DATA**, **FLATNESS**, and **FLATNESS DATA**. Press **NEXT BAND** until “FLATNESS BAND # 0” is displayed.
3. Press the **▲** key until “DATA @ 300 MHz” is displayed. Note the number directly below “DATA @ 300 MHz”; this is the RF Gain DAC value.
4. Connect a positive DVM lead to A3J400 pin 13 and the negative DVM lead to A3TP4.
5. Check that the DVM reading increases from near 0 Vdc to between -1.3 and -1.9 Vdc as the RF Gain DAC setting is increased from 0 to 4095.
6. If the DVM readings are incorrect, press **PRESET**, **SGL SWP**, **CAL**, **MORE 1 OF 2**, **SERVICE CAL DATA**, **FLATNESS**, and **FLATNESS DATA**. Press **NEXT BAND** until “FLATNESS BAND # 0” is displayed. Press the **▲** key until “DATA @ 300 MHz” is displayed. Proceed as follows:
 - a. Check the +10 V reference.
 - b. Check for narrow, low-going pulses at A3U417 pin 13 (LWRCLK).
 - c. While rotating the front-panel knob, check for narrow, low-going pulses at A3U417 pin 1 (LDAC1) and pin 14 (LDACU1).
 - d. While rotating the front-panel knob, check for narrow, low-going pulses at U417 pin 16 (L-IA0) and pin 15 (IA4).
7. If the LWRCLK, LDAC1, or LDACU1 is incorrect, refer to the Interface Strobe Select block in this chapter.
8. Place the WR PROT/WR ENA jumper on the A2 controller assembly in the WR PROT position. Press **PRESET**.

A3 Assembly's Video Circuits

Voltages from A3J101 to A3's Variable Gain Amplifier correspond (approximately) to on-screen signal levels. (One volt corresponds to the top of the screen and zero volts corresponds to the bottom of the screen.) This is true for both log and linear settings except when the spectrum analyzer is in 1 dB/div or 2 dB/div. In these cases the log expand amplifier is selected, and 1 V corresponds to top-screen and 0.8 or 0.9 V corresponds to bottom-screen. The spectrum analyzer can be set to zero span at the peak of a signal to generate a constant dc voltage in the video circuits during sweeps.

1. Disconnect W26 from A3J101 and W20 from A2J4.
2. Connect W26 to A2J4.
3. Set the HP 8560E to the following settings:

Span	0 Hz
Sweep time	20 ms
Resolution bandwidth	1 MHz
Log/division	10 dB/div
4. If a trace is displayed, troubleshoot the A3 assembly. If a trace is absent, connect an oscilloscope to the rear-panel BLKG/GATE OUTPUT.
5. The presence of a TTL signal (TTL low during 20 ms sweep) indicates a good A3 Interface Assembly. Troubleshoot the IF section.
6. If the BLKG/GATE OUTPUT is always at a TTL high or low, troubleshoot the A3's trigger/video gating circuits.
7. Reconnect W26 to A3J101 and W20 to A2J4.
8. Remove the A3 assembly's shield.
9. If the video filters appear to be faulty, refer to "Video Filter" in this chapter.
10. If there appears to be a peak detector problem, refer to "Positive/Negative Peak Detectors" in this chapter.
11. Connect the HP 8560E's CAL OUTPUT to the INPUT 50 Ω and set the controls as follows:

Center frequency	300 MHz
Span	0 Hz
Reference level	-10 dBm
12. If the spectrum analyzer works correctly in 5 dB/div and 10 dB/div but not in 1 dB/div or 2 dB/div, refer to "Log Offset/Log Expand" in this chapter. Continue with step 13 if the problem involves on-screen amplitude errors which appear to originate in the video chain.
13. Press **CAL** and **IF ADJ ON OFF** until OFF is underlined. Monitor A3TP9 with an oscilloscope. If the voltage is not approximately +1 Vdc, troubleshoot the Log Amplifier on A4. (Refer to the IF troubleshooting procedure in Chapter 8.)
14. To confirm proper video input to the video circuit, set the HP 8560E to Log 10 dB per division and change the reference level in 10 dB steps from -10 dBm to +30 dBm. At each 10 dB step, the input voltage should change 100 mV. The input level should be +0.6 Vdc for a +30 dBm reference level.

Note

The on-screen amplitude level will probably not change as expected, since the video circuitry is assumed to be faulty.

15. Monitor A3TP14 while stepping the reference level from -10 dBm to $+30$ dBm. If the voltage does not step approximately 100 mV per 10 dB step, refer to "Video MUX" in this chapter.
16. If the Video MUX is working properly, monitor A3TP15 with the oscilloscope and step the reference level from -10 dBm to $+30$ dBm. If the voltage does not change 100 mV per 10 dB step, refer to "Video Filter" in this chapter.
17. If the voltage at A3TP15 is correct, move the oscilloscope probe to A3TP17 and step the reference level between -10 dBm and $+30$ dBm. If the voltage does not change 100 mV per 10 dB step, refer to "Video Filter Buffer Amplifier" in this chapter.
18. If the voltage at A3TP17 is correct, move the oscilloscope probe to A3TP6. Set the following controls to keep the ADC MUX set to the MOD_VIDEO input during the sweep.
SWEEP TIME 50 s
DETECTOR MODE SAMPLE
19. Step the reference level from -10 dBm to $+30$ dBm while monitoring the voltage change on the oscilloscope. If the voltage does not change 100 mV per 10 dB step, refer to "ADC MUX" in this chapter.
20. If the voltage at A3TP6 is correct, move the oscilloscope probe to A3TP8 and step the reference level between -10 dBm and $+30$ dBm. If the voltage at A3TP8 is not the same as that at A3TP6, replace A3U110.
21. If the voltage at A3TP8 and A3TP6 are equal, move the oscilloscope probe to A3TP7.
22. Change the reference level from -10 dBm to 0 dBm. The voltage change on A3TP7 should be between 630 mV and 770 mV. If the voltage change is outside of these limits, refer to "Variable Gain Amplifier (VGA)" in this chapter. The gain of the VGA should be $7 \pm 10\%$.

Log Offset/Log Expand

Refer to function block X of A3 Interface Assembly Schematic Diagram (sheet 5 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The log scales are modified using a combination of amplification and digital trace manipulation. The video input to the A3 assembly is either 10 dB/div or linear. To obtain the 5 dB/div scale, the CPU manipulates the trace data from the 10 dB/div scale. To obtain the 2 dB/div scale, the video signal is amplified and offset so that top-screen in 10 dB/div corresponds to top-screen in 2 dB/div. To obtain the 1 dB/div scale, the CPU manipulates trace data from the 2 dB/div scale.

In 2 dB/div, Log Offset/Log Expand amplifies the top 20 dB of the display. This is done by offsetting the video signal by -0.8 V and providing a gain of 5 to the top 0.2 V of the video signal. The -0.8 V offset is accomplished by sinking 2 mA through R114 by current source U105/Q101.

1. On the HP 8560E, press **PRESET**, **SPAN**, **ZERO SPAN**, **CAL**, and **IF ADJ OFF**.

2. Disconnect W26 (coax 2) from A3J101 and connect the output of a function generator to A3J101.

3. Set the function generator to the following settings:

Output Sine wave
Amplitude 1 V pk-to-pk
DC Offset +500 mV
Frequency 50 Hz

4. Set the HP 8560E sweep time to 50 ms.

5. Adjust the function generator amplitude and offset until the sine wave fills the entire graticule area.

6. Measure and note the function generator's peak-to-peak voltage using an oscilloscope.

$$V_{(10 \text{ dB/div})} = \text{_____ V}$$

7. Set the HP 8560E to 2 dB/div.

8. Readjust the function generator amplitude and offset until the sine wave again fills the entire graticule area.

9. Measure the function generator's peak-to-peak voltage and dc offset.

$$V_{(2 \text{ dB/div})} = \text{_____ V}$$

10. The ratio of voltage recorded in step 6 to the voltage recorded in step 9 should be $5 \pm 3\%$. If the ratio is not 5, troubleshoot the A3 Interface assembly.

11. Reconnect W26 to A3J101.

Video MUX

Refer to function block U of A3 Interface Assembly Schematic Diagram (sheet 5 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

1. Press **PRESET** and set the HP 8560E controls as follows:

Center frequency 300 MHz
Span 0 Hz

2. Press **SGL SWP**, **CAL**, and **IF ADJ OFF**. Connect the CAL OUTPUT to the INPUT 50Ω connector.

3. Check for a TTL high on A3U104 pin 2 and a TTL low on U104 pin 10. Set the spectrum analyzer to 2 dB/div and check for a TTL high on A3U104 pin 10 and a TTL low on A3U104 pin 2.

4. If the logic levels on A3U104 are incorrect, check the LLOG_STB signal as follows:

a. Monitor A3U104 pin 9 with an oscilloscope or logic probe. Check that a 1 microsecond, low-going pulse is present when switching between 10 dB/div and 2 dB/div.

b. Check the inputs to A3U104 (pins 3 and 11) while switching between 10 dB/div and 2 dB/div.

- c. If the logic signals are incorrect, refer to "Analog Bus Timing" and "Analog Bus Drivers" in this chapter.
5. Check comparators A3U109A/C for proper outputs. The outputs should be high when the noninverting input is greater than the threshold voltage of +1.3 Vdc.
6. If A3U104 and A3U109 are working properly, set the **AMPLITUDE** and **REF LVL** to 0 dBm.
7. Monitor the voltage at A3TP14 while switching the spectrum analyzer between 10 dB/div and 2 dB/div. The voltage should switch between 0.8 and 0.4 Vdc.
8. If the voltage at A3TP14 is incorrect, suspect either A3Q220 or A3Q221.
9. The Video MUX will appear faulty if A3CR109 is shorted or leaky. Diode A3CR109 clamps the voltage at A3TP14 to -0.4 V when in log expand with less than 0.8 V at J101. To confirm this failure, lift diode A3CR109's cathode and perform steps 1 through 7 again.
10. To return the HP 8560E to automatic sweep, press **SWEEP**, **SWEEP CONT SGL** or press **PRESET**.

Video Filter

Refer to function block V of A3 Interface Assembly Schematic Diagram (sheet 5 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The HP 8560E uses digital filtering for 1 Hz to 100 Hz video bandwidths. An RC low-pass filter is used for 300 Hz to 3 MHz video bandwidths. Various series resistances and shunt capacitances switch into the video filter to change its cutoff frequency.

When Gated Video is selected, the video signal is "gated" (turned on periodically for a set duration of time). This function is shown in

block V of the block diagram as a series switch that allows the video signal to pass only when it is closed. The actual switch, U109B/CR118, shunts the video to ground (video signal is passed only when the switch is open). The control circuitry for this switch is described under "Triggering or Video Gating Problems" in this chapter. The rear-panel EXT/GATE TRIG INPUT provides the connection for triggering in the Gated Video mode. The gate output signal is available at the rear-panel BLKG/GATE OUTPUT connector. Positive or negative edge mode, or level mode can be selected from the front panel.

1. Press **PRESET** and set the HP 8560E controls to the following settings:

Center frequency	225 MHz
Span	550 MHz
Sweep time	Uncoupled (MAN)

2. Press **CAL** and **IF ADJ OFF**.
3. Step the Video BW from 3 MHz to 10 kHz. At each step, the peak-to-peak deviation of the noise should decrease.
4. Step the Video BW down to 1 Hz. At each step, the amplitude of the LO feedthrough should decrease.
5. Refer to Table 7-7 and check for correct latched levels for the selected video bandwidth setting.

6. If latch A3U102's output is not correct, trigger an oscilloscope on LLOG_STB (U102 pin 9) and monitor U102 pin 1 and other latch inputs while changing the video bandwidth.
7. If the inputs are incorrect, troubleshoot the analog bus. Correct inputs with bad outputs indicate a faulty U102.
8. Check that the outputs of A3U111A, A3U111B, and A3U107A/B/C/D are correct for their inputs. The outputs should be high with noninverting inputs higher than the +1.4 V threshold voltage. If a voltage drop is noticed across these components, suspect A3CR109 or A3Q317B. Since no dc current flows through any of the series resistances or FETS (drain to source), no voltage drops should occur.
9. To return the HP 8560E to automatic sweep, press **SWEEP**, **SWEEP CONT SGL** or **PRESET**.

Table 7-7. A3U102 Latch Outputs

Video BW	Pin 2	Pin 5	Pin 7	Pin 10	Pin 12	Pin 15
300 Hz	H	L	L	L	L	L
1 kHz	L	L	L	L	L	H
3 kHz	L	H	L	L	L	L
10 kHz	L	L	L	L	H	L
30 kHz	H	L	H	L	L	L
100 kHz	L	L	H	L	L	H
300 kHz	L	H	H	L	L	L
1 MHz	L	L	H	L	H	L
3 MHz	L	L	L	H	L	L

Video Filter Buffer Amplifier

Refer to function block W of A3 Interface Assembly Schematic Diagram (sheet 5 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The video filter buffer amplifier provides outputs for video trigger, positive and negative peak detectors, and the analog zero-span (sweeps <30 ms). The zero-span video output is terminated in 500 ohms on the A2 Controller assembly. The amplifier is a high-input-impedance buffer amplifier with a gain of one when properly terminated.

Current source U307C provides twice the current of Q316. Resistor R145 and current source U307D shift the dc level. Resistor R260 terminates the peak detector inputs in 500 ohms. The unterminated gain is 1.1. Diode CR114 prevents latchup during positive overdrive conditions while CR113 protects Q318 during overdrive. Diode CR117 is a 12.7 V zener that limits the peak detector's output to +1.5 V. Typically, limiting occurs at +1.1 V.

Positive/Negative Peak Detectors

Refer to function blocks Y and Z of A3 Interface Assembly Schematic Diagram (sheet 5 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The following information pertains to the positive peak detector and is applicable to troubleshooting the negative peak detector.

The positive peak detector consists of an input amplifier (A3U204 and A3Q210) followed by detector diodes (A3CR203 and A3CR204) and hold capacitor A3C217. Output amplifier A3Q206, Q211, and Q212 buffers the hold capacitor. Both the input and output amplifiers have a gain of one. Each amplifier has local feedback. On the output amplifier the emitter of Q212 connects to Q206's gate. On the input amplifier the feedback goes through Q209 and Q208 back to the base of U204D. Global feedback occurs from the output amplifier through R223 back to the input amplifier U204D. The peak detector resets through Q207.

1. Press **PRESET** and set the HP 8560E controls as follows:

Center frequency	300 MHz
Span	500 MHz
Resolution bandwidth	AUTO
Video bandwidth	AUTO
Log dB/division	10 dB/div

2. If the HP 8560E does not meet the conditions in steps a through e below, the positive and negative peak detectors are probably faulty. Continue with step 3 to check the detectors.
 - a. The peak-to-peak deviation of the noise in NORMAL detector mode should be approximately two divisions. Press **TRACE**, **TRACE B**, **CLEAR WRITE B**, **VIEW B**, **TRACE A**, **MORE 1 of 3**, and **DETECTOR MODES**.
 - b. Select **DETECTOR POS PEAK** mode.
 - c. Confirm that the noise is about one-third division peak-to-peak. The noise should also be no higher than the top of the noise level in NORMAL detector mode.
 - d. Select **DETECTOR NEG PEAK** mode. The noise should be about one-third of a division peak-to-peak. The noise should also be no lower than the bottom of the noise in NORMAL mode.
 - e. Select **DETECTOR SAMPLE** mode. Check that the noise appears between the top and bottom of the noise in NORMAL mode.
3. On the HP 8560E, connect the front-panel CAL OUTPUT to the INPUT 50 Ω and set the controls to the following settings:

Center frequency	300 MHz
Span	0 Hz
Sweep time	5 s
Detector mode	POS PEAK
4. Monitor A3TP17 and A3TP16 simultaneously with an oscilloscope.
5. Change the reference level from -10 dBm to +30 dBm and verify a voltage change at both A3TP17 and A3TP16 of 0.9 V to 0.5 V in 100 mV steps.
6. Check the entire range of the detector by substituting a dc source at J101 and varying its output from 0 V to 1 V.

7. If the peak detector appears latched up, check LPOS_RST (U422 pin 4) for a negative TTL level reset pulses. The reset pulses should occur every 130 μ s and should be approximately 250 ns wide.
8. If the reset pulses are absent, troubleshoot the Peak Detector Reset circuitry.
9. If the reset pulses are present, check the gate of Q207. The pulses should be positive-going from -12.7 V to -1.35 V.
10. The peak detector can be made into a unity gain amplifier by shorting the cathode of CR203 to the anode of CR204. If the peak detector functions normally as a unity gain amplifier, suspect Q208 or CR203 or CR204.

Peak Detector Reset

Refer to function block R of A3 Interface Assembly Schematic Diagram (sheet 4 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

1. Press **PRESET** on the HP 8560E and set the controls as follows:

Center frequency	300 MHz
Span	 0 Hz
Sweep time	 5 s
Detector mode	 POS PEAK
2. Check that HHOLD (A3U526 pin 11) has 18 μ s wide pulses every 128 μ s.
3. Check that HODD (U408 pin 5) is a square wave with a period of 16.7 ms (2 $\times$ sweep time/600).
4. Check LPOS_RST (U422 pin 4) for 200 ns low-going pulses every 128 μ s.
5. Check LNEG_RST (A3U422 pin 12) for 200 ns low-going pulses every 128 μ s.
6. Set the detector mode to NORMAL and check that LNEG_RST (A3U422 pin 12) has two pulses spaced 40 μ s apart and then a single pulse approximately 88 μ s from the second pulse.
7. Check HMUX_SEL0 (A3U408 pin 3) and HMUX_SEL1 (A3U408 pin 9) according to Table 7-8.

Table 7-8. HMUX_SELO/1 versus Detector Mode

Detector Mode	HMUX_SEL0 (U408 pin 3)	HMUX_SEL1 (U408 pin 9)
NORMAL	15 μ s pulse every 128 μ s	40 μ s pulse every 128 μ s
SAMPLE	H	H
POS PEAK	H	L
NEG PEAK	L	H

Rosenfell Detector

Refer to function block S of A3 Interface Assembly Schematic Diagram (sheet 4 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

If both HPOS_HLDNG and HNEG_HLDNG are high during the same bucket, HROSENFELL will also be set high. This indicates that the video signal probably consists of noise, since it rose and fell during the same period. The HROSENFELL signal is valid only when the NORMAL (rosenfell) detector mode is selected.

1. Remove anything connected to the HP 8560E front-panel INPUT 50 Ω connector. Press

PRESET on the HP 8560E and set the controls as follows:

Center frequency	300 MHz
Span	 0 Hz
Sweep time	 5 s
Detector mode	 NORMAL

2. Check LPOS_RST and LNEG_RST as described in "Peak Detector Reset."
3. Check A3U423 pin 4 for two low-going 3.3 μ s pulses 40 μ s apart occurring every 130 μ s.
4. Check that HROSENFELL (A3U610 pin 6) has two pulses spaced approximately 40 μ s apart and then a third pulse 60 μ s from the second pulse. Each pulse should be approximately 10 μ s wide and low-going.
5. Monitor HROSENFELL with an oscilloscope while reducing the video bandwidth from 1 MHz to 1 kHz.
6. As the video bandwidth is decreased to 1 kHz, the HROSENFELL line should increasingly show a low logic level. With a video bandwidth of 1 kHz, a nearly flat line should be displayed on the CRT.
7. Set the sweep time to 50 ms. Externally trigger the oscilloscope using the HP 8560E rear-panel BLKG/GATE OUTPUT.
8. Check that HPOS_HLDNG (A3U416 pin 4) is mostly high with a 1 MHz video bandwidth and mostly low with a 1 kHz video bandwidth.
9. Check that HNEG_HLDNG (U416 pin 9) is mostly high with a 1 MHz video bandwidth and mostly low with a 1 kHz video bandwidth.

ADC MUX

Refer to function block AA of A3 Interface Assembly Schematic Diagram (sheet 6 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The ADC MUX switches various inputs into the video path for conversion by the ADC. The SCAN RAMP input is used during sweeps having a width of equal to or greater than 2.01 MHz times N, to control the timing of the ADC operations. Some combination of MOD_VIDEO, NEG_PEAK, and POS_PEAK is used for the video signal to be converted by the ADC. The YTO ERR, FCMUX, CAL OSC TUNE, and OFL ERR inputs are used only during diagnostic and auto adjust routines and during retrace.

1. Set the HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz
Reference level -10 dBm
Sweep time 50 s
DETECTOR MODE SAMPLE

2. Refer to Table 7-9 and check for correct logic levels at A3U108 pins 1, 15, and 16. Check for proper output signals at TP6. If the select lines are not changing, suspect the ADC ASM or the VGA/ADC MUX Control. If the select lines are changing, but the proper video inputs are not being switched to the output, replace U108. In SAMPLE mode, the input is MOD_VIDEO (pin 7); in POS PEAK mode, the input is POS_PEAK (pin 5); and in NEG PEAK mode, the input is NEG_PEAK (pin 6).
3. Check for the presence of the YTO ERR signal at A3J2 pin 42 with an oscilloscope probe.
4. If ERR 300 YTO UNLK or 301 YTO UNLK occurs and the voltage is near zero during a sweep and positive during retrace (YTO is being locked), the fault is on the A3 assembly. If a constant dc voltage is present, refer to the Synthesizer section troubleshooting procedure in Chapter 10.

Table 7-9. Logic Levels at A3U108

Detector Mode	U108 pin 1	U108 pin 15	U108 pin 16
SAMPLE	H	L	H
POS PEAK	H	L	L
NEG PEAK	L	L	H

5. Set the HP 8560E to the following settings:
Span 5 MHz
Sweep time 50 ms
6. Check for the presence of the SCAN RAMP signal by connecting an oscilloscope probe to A3J2 pin 45 (component side of A3J2). Connect the negative-probe lead to A3TP4.
7. A 0 to 10 V ramp should be present in both LINE and FREE RUN trigger modes. If the waveform is present only in LINE trigger, ADC control signal HBADC_CLK0 may be faulty. Refer to "ADC Control Signals" in this chapter.
8. If the scan ramp is present, but is not being switched to the output of U108, replace U108. If the scan ramp is absent in either mode, do the following:
 - a. Connect the oscilloscope probe to A3J400 pin 15 (HSCAN).
 - b. A TTL signal (high during 50 ms sweep time and low during retrace) should be present, indicating A3 is working properly. Refer to the Synthesizer section troubleshooting procedure in Chapter 10. A faulty TTL signal indicates a bad A3 Interface assembly.
9. Set the HP 8560E to the following settings:
Sweep time 100 ms
Span 100 MHz

10. Press **CAL** and **IF ADJ ON** and check for the presence of the CAL OSC TUNE signal by monitoring A3J401 pin 25 with an oscilloscope. If ERR 499 CAL UNLK is displayed and a signal within the range of -10 V to $+10\text{ V}$ is present during part of the retrace period, the fault is on the A3 assembly.
11. If a constant dc voltage is present during the sweep and all of the retrace period, refer to the IF Section troubleshooting procedure in Chapter 8.

Variable Gain Amplifier (VGA)

Refer to function block AB of A3 Interface Assembly Schematic Diagram (sheet 6 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The VGA provides adjustable gain in the video path. Its nominal gain of 7 can be adjusted $\pm 10\%$. U112 removes dc offset to keep U113 in its monotonic range. (Both U112 and U113 are set to the same value.) The DAC settings cannot be changed from the front panel.

Track and Hold

Refer to function block AC of A3 Interface Assembly Schematic Diagram (sheet 6 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

1. Press **PRESET** on the HP 8560E and set the controls as follows:

Center frequency		300 MHz
Span		0 Hz
Detector mode		Sample
Reference level		-70 dBm
Log dB/division		2 dB/div
Sweep time		50 ms

2. Disconnect any signal from the spectrum analyzer input. A full scale display of sampled noise should be present.
3. Trigger an oscilloscope on the positive going edge of HHOLD (A3U506 pin 16).
4. The waveform at A3TP10 should be random noise with an average level of approximately 4 V. The noise should have a flat spot in its response while HHOLD is high, indicating proper operation of U114.

A3 Assembly's ADC Circuits

The ADC consists of a 12-bit DAC, 12-bit successive approximation register (SAR), data multiplexers, and data latches. The ADC ASM (algorithmic state machine) controls the ADC. Eight inputs are controlled by the ADC MUX. These include a positive peak detector, negative peak detector, sampled video, scan ramp, YTO error voltage, FC MUX voltages, Cal Oscillator tune voltage, and offset lock error voltage. A MUX on the A14 frequency control assembly selects which voltage is sent to the ADC MUX on the FC MUX signal line.

During NORMAL detector mode sweeps, when noise is detected by the rosenfell detector, the ADC ASM automatically switches between POS PEAK and NEG PEAK.

ADC Control Signals

Refer to function blocks B and F of A3 Interface Assembly Schematic Diagram (sheet 2 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The ADC requires two signals from the A2 controller assembly: HBADC_CLK0 and HBBKT_PULSE. HBBKT_PULSE is used only in zero span. Use the following steps to verify the signals.

1. Disconnect W22 from A2J8.
2. If a 10 MHz TTL signal is absent on W22, refer to the 10 MHz Reference (on the A15 RF assembly) troubleshooting procedure in Chapter 11.
3. Set the HP 8560E's **SPAN** to zero.
4. Reconnect W22.
5. With an oscilloscope probe, monitor A3J401 pin 20.
6. If TTL pulses are absent, the A2 controller assembly is faulty. Refer to Chapter 9. The presence of TTL pulses indicates a faulty A3 assembly.
7. Monitor A3J401 pin 23 (HBADC_CLK0). If a 1 MHz TTL clock signal is present, HBADC_CLK0 is working properly.
8. If HBKT_PULSE or HBADC_CLK0 is missing, disconnect A3W1 from A2J2.
9. Monitor A2U5 pin 3 for HBKT_PULSE and A2U5 pin 7 for HBADC_CLK0.
10. If HBADC_CLK0 is absent, troubleshoot the A2 controller assembly.
11. HBKT_PULSE is absent, refer to the information on troubleshooting the frequency counter in Chapter 9.
12. Reconnect A3W1 to A2J2.

ADC Start/Stop Control

Refer to function block B of A3 Interface Assembly Schematic Diagram (sheet 2 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The ADC Start/Stop Control determines the start time of all ADC conversions. Multiplexer A3U509 chooses the source of the start signal. Both HSTART_SRC and HBUCKET tell the ASM to start a conversion.

1. Press **PRESET** on the HP 8560E and set the following controls:

Span 0 Hz
Sweep time 60 s
Detector mode SAMPLE

2. Check for a TTL high at A3U509 pin 2 and a TTL low at A3U509 pin 14.

3. Set the detector mode to NORMAL.

4. Check that A3U509 pins 2 and 14 are both TTL low.

5. Set the HP 8560E to the following settings:

Span 1 MHz
Detector mode SAMPLE

6. Check for a TTL high at A3U509 pin 2 and a TTL low at A3U509 pin 14.

7. Press **CAL** and **REALIGN LO & IF**. During the realignment, A3U509 pin 2 should be TTL low and pin 14 should be TTL high until the 10 kHz and narrower resolution bandwidths are adjusted. If correct, the Start/Stop Control circuitry is being selected properly by the processor and U508 in the ADC Register block is working properly.

8. Press **PRESET** on the HP 8560E and set the controls as follows:

Span 0 Hz
Detector mode SAMPLE
Sweep time 400 ms

9. Check that A3U509 pin 7 has positive 15 μ s pulses with a 667 μ s period (sweep time/600). Check that A3U509 pin 9 has positive 15 μ s pulses with a 667 μ s period (sweep time/600). The pulses should be present during the sweep but absent during retrace.

10. Set the detector mode to NORMAL.

11. Check that A3U509 pin 9 has pulses every 130 μ s and U509 pin 7 has pulses every 667 μ s (although pulse widths may be changing).

ADC ASM

Refer to function block F of A3 Interface Assembly Schematic Diagram (Sheet 2 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

1. Press **PRESET** on the HP 8560E and set the controls as follows:
Span 0 Hz
Sweep time 60 s
Detector mode SAMPLE
2. Check that HSTART_SRC (U504 pin 4) goes TTL high, causing HHOLD (U506 pin 16) to go high 15 μ s later.
3. Check that HSTART_ADC (U506 pin 15) goes TTL high 19 μ s after HSTART_SRC goes high.
4. HHOLD should stay TTL high for approximately 18 μ s, and HSTART_ADC should stay high for approximately 31 μ s.
5. Check that LCMPLT (U504 pin 15) goes TTL low 12 μ s after HSTART_ADC goes high (12 bits at 1 μ s per bit). LCMPLT indicates that the successive approximation state machine (SASM) has completed the ADC conversion.
6. Check that LDONE (U506 pin 19) goes TTL low approximately 2 μ s after LCMPLT goes low.

ADC

Refer to function block A of A3 Interface Assembly Schematic Diagram (sheet 2 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The successive approximation state machine (SASM) consists of A3U527 and A3U528. Upon the occurrence of HSTART_ADC, the SASM successively toggles bits from high to low starting with the most significant bit. The digital result is then converted to an analog current in DAC U518 and compared with the SAMPLED VIDEO. If the DAC current is too high, the output of U512 will be low, telling the SASM that the “guess” was high and that the bit just toggled should remain low. It then moves on to the next most significant bit until all 12 bits have been “guessed” at. Each “guess” takes 1 μ s (one cycle of HBADC_CLK0), or 12 μ s to complete a conversion. When the conversion is completed, the SASM sets LCMPLT low. The bits are written to the data bus by buffers U514 and U516.

1. Set the HP 8560E controls as follows:

Center frequency	300 MHz
Span	0 Hz
Sweep time	60 s
Detector mode	SAMPLE

2. Trigger an oscilloscope on HSTART_ADC (U506 pin 15) and monitor the outputs of the SASM (U527 pins 18 and 19; U528 pins 14 thru 23). Each bit should start high and be switched low. It will either stay low or return to a high state 1 μ s later, depending on the comparison at U512.
3. If the outputs do not exhibit this bit pattern, and the ADC ASM checks are working properly, suspect A3U527, U528, or one of the latches (U514/516). If the output of comparator U512 does not toggle back and forth during a conversion, suspect either U512 or one of the clipping diodes (CR500/CR501).

Note

Because currents are being summed at U512 pins 2 and 3, voltage levels at these points are difficult to interpret.

Ramp Counter

Refer to function block D of A3 Interface Assembly Schematic Diagram (sheet 2 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The ramp counter is used for sweeps with widths greater than 2.0 MHz times N. The analog sweep ramp is compared to the digital ramp counter. When the analog sweep ramp exceeds the DAC output generated for that ramp counter setting, HRAMP_COMP toggles high, indicating the end of a bucket. The ramp counter counts horizontal buckets. There are 601 buckets per sweep, so the ramp (bucket) counter counts from 0 to 600. The ramp counter is incremented by HRST_PK_ENA.

1. Press **PRESET** on the HP 8560E and set the controls as follows:

Span	5 MHz
Detector mode	SAMPLE

2. For spans greater than 2.0 MHz times N0, HODD (A3U525 pin 3) is a square wave with a period defined by $(2 \times \text{sweep time}/600)$. For example, for a 6 s sweep time, HODD has a period of 20 ms. The ramp (bucket) counter will be odd every other bucket.

A3 Assembly's Control Circuits

A digital control problem will cause the following three steps to fail.

1. On the HP 8560E, press **AMPLITUDE**, **ATTEN MAN**, 7, 0, and **dB**.
2. A click should be heard after pressing dB in step 1, unless ATTEN was previously set to 70 dB.
3. Press 1, 0, and **dB**. Another click should be heard. If no clicks were heard, but the ATTEN value displayed on the CRT changed, the digital control signals are not operating properly.

Analog Bus Drivers

Refer to function block N of A3 Interface Assembly Schematic Diagram (sheet 4 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

1. Press **PRESET** on the HP 8560E, and set the controls as follows:
Span 0 Hz
Trigger Single
2. Monitor A3U401 pin 3 (LRF_STB) with an oscilloscope or logic probe. This is the strobe for the A15 RF Assembly.
3. Press **AUX CTRL** and **REAR PANEL** and check that pulses occur when toggling between **10 MHz INT** and **10 MHz EXT**.
4. Monitor U401 pin 5 (LFC_STB) with an oscilloscope or logic probe. This is the strobe for the A14 frequency control assembly.
5. Press **AMPLITUDE** and check that pulses occur when toggling between **ATTEN** settings of 10 and 20 dB.
6. Monitor U401 pin 7 (LIF_STB) with an oscilloscope or logic probe. This is the strobe for the A5 IF assembly.
7. Press **AMPLITUDE** and check that pulses occur when toggling between **REF LVL** settings of -10 dBm and -20 dBm.
8. Monitor U401 pin 9 (LLOG_STB) with an oscilloscope or logic probe. This is the strobe for the log amplifier on the A4 assembly.
9. Press **AMPLITUDE** and check that pulses occur when toggling between **LINEAR** and **LOG dB/DIV**.
10. To check the Address and Data Lines, place a jumper from A3TP1 and A3TP2 to A3U406 pin 20 (+5 V).
11. Check that address lines A0 through A7 and data lines D0 through D7 are all TTL high.
12. If any address or data line is low, press **LINE** to turn spectrum analyzer off and disconnect the W2 control cable from A3J2. Press **LINE** to turn spectrum analyzer on. Ignore any error messages.

13. Check that address lines A0 through A7 and data lines D0 through D7 are all high. If all address and data lines are high, suspect a fault either in W2 or one of the other four assemblies which connect to W2.
14. If any address or data line is low, check the appropriate input of either U405 (data lines) or U406 (address lines).
15. If a data line input is stuck low, check the data bus buffer. If an address line input is stuck low, check A3W1 and the A2 controller assembly.
16. If the appropriate input is high or toggling between high and low, suspect a failure in either U405 (data lines) or U406 (address lines).
17. Remove jumpers.

Analog Bus Timing

Refer to function block P of A3 Interface Assembly Schematic Diagram (sheet 4 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

Analog bus timing (ABT) generates the strobes for the A4, A5, A14, and A15 assemblies. The A14 frequency control assembly also requires a qualifier for its strobe, LVFC_ENABLE. A3U400 and A3U414 provide a 2 μ s delay between the time HANA_BUS goes high and the enable line to demultiplexer A3U407 goes low.

1. Press **PRESET** on the HP 8560E and set the controls as follows:

Center frequency	 300 MHz
Span	 100 MHz
2. Check that A3U407 pin 1 goes low approximately 2 μ s after HANA_BUS (A3U400 pin 3) goes high.
3. If HANA_BUS is absent, check for pulses on ABT A3U505 pin 2 and IA10 (A3U505 pin 5).
4. If A3U407 pin 1 is not delayed 2 μ s from HANA_BUS, check for the presence of the 1 MHz HBADC_CLK0.
5. If A3U407 pin 1 is not delayed 2 μ s from HANA_BUS and HBADC_CLK0 is correct, suspect a fault in either A3U414 or A3U400.
6. Press **PRESET** and set the controls as follows:

Span	 0 Hz
Trigger	 SINGLE
7. Monitor A3U401 pin 3 (LR_STB) with an oscilloscope or logic probe. This is the strobe for the A15 RF assembly.
8. Press **AUX CTRL** and **REAR PANEL** and check that pulses occur when toggling between **10 MHz INT** and **10 MHz EXT**.
9. Monitor A3U401 pin 5 (LF_STB) with an oscilloscope or logic probe. This is the strobe for the A14 frequency control assembly.
10. Press **AMPLITUDE** and check that pulses occur when toggling between **ATTEN** settings of 10 and 20 dB.

11. Monitor A3U401 pin 7 (LI_STB) with an oscilloscope or logic probe. This is the strobe for the A5 IF assembly.
12. Press **AMPLITUDE** and check that pulses occur when toggling between **REF LVL** settings of -10 dBm and -20 dBm.
13. Monitor A3U401 pin 9 (LV_STB) with an oscilloscope or logic probe. This is the strobe for the A4 log amplifier/cal oscillator assembly.
14. Press **AMPLITUDE** and check that pulses occur when toggling between **LINEAR** and **LOG DB/DIV**.

Interface Strobe Select

Refer to function block K of A3 Interface Assembly Schematic Diagram (sheet 3 of 6) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

Interface strobe select generates the various strobes used by circuits on the A3 Interface Assembly. Table 7-10 and Table 7-11 are the truth tables for demultiplexers A3U410 and A3U500.

Table 7-10. Demultiplexer A3U410 Truth Table

Selected Output Line	IA1	IA2	IA3
Pin 15, LSCAN_KBD	L	L	L
Pin 14, LDACU1	H	L	L
Pin 13, LDAC1	L	H	L
Pin 12, LDAC2	H	H	L
Pin 11, LDAC3	L	L	H
Pin 10	H	L	H
Pin 9, LTIMER	L	H	H
Pin 7, LADC_REG1	H	H	H

Table 7-11. Demultiplexer A3U500 Truth Table

Selected Output Line	IA0	IA1	IA2
Pin 15, LSENSE_KBD	L	L	L
Pin 14, LINT_PRIOR	H	L	L
Pin 13, LADC_DATA1	L	H	L
Pin 12, LDAC_DATA0	H	H	L
Pin 11, HCNTR_LD0	L	L	H
Pin 10, HCNTR_LD1	H	L	H
Pin 9, LRPGRD	L	H	H
Pin 7, LADC_REG0	H	H	H

A16 Assembly's Fast ADC Circuits (Option 007)

The fast ADC consists of video signal scaling and limiting amplifiers, an 8-bit flash ADC, peak/pit detection of the digitized video signal, a 32 K-byte RAM, and the fast ADC control circuitry.

Video Input Scaling Amplifiers and Limiter

Refer to function block L of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The video input scaling amplifiers help provide scaling (10 dB/div, 5 dB/div, 2 dB/div, or 1 dB/div) and buffer the flash video output. When the GAINX2 control line is low, switch U44D is open and switch

U44C is closed. Thus, the scaled video at TP26 virtually follows the video input (0 - 1 V). When the GAINX2 control line is high, switch U44C is open and switch U44D is closed. Amplifier U43 then provides a gain of $2(V_{in}) - 1$ V. Voltage clamp CR4 prevents the scaled video input to amplifier U45 from going more negative than -0.35 V or more positive than +1.25 V.

Note

When measuring voltages or waveforms on the A16 fast ADC assembly, connect the ground (or common) lead to the ground-plane trace on the A16 assembly. This digital ground plane is totally isolated from the chassis.

1. Press **PRESET** on the HP 8560E Option 007 and set the controls as follows:

Center frequency	 300 MHz
Span	 0 Hz
Reference level	 -10 dBm
Log/division	 10 dB/div
Sweep time	 20 ms
2. Connect the CAL OUTPUT to the INPUT 50 Ω connector.
3. Adjust the HP 8560E Option 007 reference level to place the signal at the top graticule line on the CRT display.
4. Measure the dc level at TP25. If the voltage measured is not $+1.0 \pm 0.15$ V, troubleshoot the A3 interface assembly.
5. Measure the dc level at TP26. The level should be approximately the same as the level measured at TP25. If not, suspect switch U44.
6. Set the HP 8560E Option 007 scale to 5dB per division.
7. Adjust the HP 8560E Option 007 reference level to place the signal at the top graticule line on the CRT display.
8. Measure the dc level at TP25 and TP26. The level should be $+1.0 \pm 0.25$ V. If the level measured at TP26 differs from the level measured at TP25 by more than 0.25 volts, troubleshoot U43 and associated circuitry.
9. Disconnect the CAL OUTPUT signal from the INPUT 50 Ω connector.

10. The level at TP26 should drop to -0.35 Vdc. If the level is less (more negative) than -0.35 Vdc, replace voltage clamp CR4.
11. Measure the dc level of the flash video at TP27. The level should be near 0 Vdc with the signal at the bottom graticule line (no input to the spectrum analyzer).
12. Connect the CAL OUTPUT to the INPUT 50Ω connector.
13. Measure the dc level of the flash video at TP27. The level should be near $+1.7$ Vdc.

8-Bit Flash ADC

Refer to function block I of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The flash ADC (U35) converts the analog video signal into 8-bit digital values at a fixed rate of 12 megasamples per second.

Note When measuring voltages or waveforms on the A16 fast ADC assembly, connect the ground (or common) lead to the ground-plane trace on the A16 assembly. This digital ground plane is totally isolated from the chassis.

1. Press **PRESET** on the HP 8560E Option 007 and set the controls as follows:

Center frequency	300 MHz
Span	0 Hz
Reference level	-20 dBm
Log/division	5 dB/div
Sweep time	20 ms
2. Connect the CAL OUTPUT to the INPUT 50Ω connector.
3. Pins 4 through 10 (ADC7-ADC1) and pin 21 (ADC0) of U35 should all be high (logic 1), corresponding to an ADC digital count of 255 for the analog input of $+2$ volts or greater.
4. Disconnect the CAL OUTPUT signal from the INPUT 50Ω connector.
5. Pins 4 through 10 (ADC7-ADC1) and pin 21 (ADC0) of U35 should all be low (logic 0), corresponding to an ADC digital count of zero for the analog input of 0 volts or less.

Peak/Pit Detection

Refer to function block J of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

Peak detection or pit (negative peak) detection can be enabled whenever the sample rate is less than 12 MHz (sweep times greater than $50\ \mu\text{s}$). Peak detection uses the maximum value of all the samples taken within each bucket (between adjacent display points). Pit detection uses the minimum value of all the samples taken within each bucket. And sample detection uses the last sample of all the samples taken within each bucket.

The different detection modes are implemented by selectively clocking latch U30, depending on the state of LP/Q which is generated in PAL U1 (block A). When LP/Q is low, U30 is clocked by WCLK. When LP/Q is high, U30 is not clocked. LP/Q is a function of the 12M_SEL, SCLK-1, LAMPLE, LPEAK, P_LO, and P_HI signals. See Table 7-12.

If the sample rate is 12 MHz, 12M_SEL is high, which forces LP/Q low so that every sample is clocked into latch U30 and latched into RAM U32 (block K). If the sample rate is less than 12 MHz and the detection mode is peak or pit, the SCLK-1, LPEAK, P_LO, and P_HI signals control the LP/Q signal. In these detection modes, latch U30 stores the peak or pit value of the samples taken for each bucket. The 8-bit digital magnitude comparator, U31, compares the input byte (P) with the output byte (Q) from latch U30. When P is greater than Q, P_LO is low (0) and P_HI is high (1). When P is less than Q, P_LO is high (1) and P_HI is low (0). When P is equal to Q, P_LO and P_HI are both low (0). See Table 7-12.

Table 7-12. LP/Q Truth Table

Mode	LP/Q	12M_SEL	SCLK-1	LSAMPLE	LPEAK	P_LO	P_HI
12MHz	L	H	X	X	X	X	X
SAMPLE	L	X	X	L	X	X	X
POS PEAK	L	L	L	H	L	L	H
	H	L	L	H	L	H	L
	H	L	L	H	L	L	L
NEG PEAK (Pit)	H	L	L	H	H	L	H
	L	L	L	X	H	H	L
	H	L	L	H	H	L	L
Clocking Peak/Pit Sample	L	L	H	H	X	X	X

32 K-Byte Static RAM

Refer to function block K of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The static RAM stores the flash ADC samples that are taken when the fast ADC circuitry is in the “write” mode. When not in the “write” mode, the static RAM is read by the CPU on the A2 controller assembly to retrieve the fast ADC data.

The 8-bit Q bus connects the outputs of latch U30 to the data port of static RAM U32.

A16 Assembly's Fast ADC Control Circuits (Option 007)

The fast ADC control circuits consist of the CPU interface and control registers, the reference clock, a clock and sample rate generator, a trigger circuit, a 16-bit post-trigger counter, a 15-bit circular address counter, a video trigger comparator, and the reference and power supply circuits.

CPU Interface and Control Registers

Refer to function block A of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The A16 assembly's digital interface to the A2 controller assembly consists of an 8-bit bi-directional data bus, one address line, a most-significant byte strobe, and a least-significant byte strobe.

The A16 fast ADC assembly can be accessed by firmware (on the A2 controller assembly) at two logical addresses. When the address line (ADDR3) is low, the primary address is selected. When the ADDR3 is high, the secondary address is selected. The data transfers between the A16 fast ADC assembly and the A2 controller assembly are clocked by the two strobe lines, MSB_STRB and LSB_STRB. 16-bit word transfers occur as two sequential byte transfers; the most-significant byte first, followed by the least-significant byte.

The primary address (ADDR3 low) contains the 16-bit control word written by the firmware on the A2 controller assembly. The secondary address (ADDR3 high) supports both 8-bit byte and 16-bit word reads and writes. There is no read/write line on the A16 fast ADC assembly to control the direction of data transfer. The fast ADC is preconfigured to read or write by setting the appropriate bits in the 16-bit control word. Refer to Table 7-13. If the control word is not correct, it may result in a bus conflict.

Table 7-13. Control Word at Primary Address (U3 and U4)

Bit	Mnemonic	State	Description
Bit 0	WRITE		Allows samples to be written to FADC memory.
		1	All on-board clocks running and samples being written to FADC memory. (FADC memory cannot be read by A2 controller in this mode.)
		0	All on-board clocks turned off and no samples being written to FADC memory. (FADC memory can be read by A2 controller.)
Bit 1	ARM		Arms the FADC assembly for a trigger.
		1	FADC assembly armed to accept trigger from HSWP line or video trigger.
		0	FADC assembly cannot be triggered.

Table 7-13. Control Word at Primary Address (U3 and U4) (continued)

Bit	Mnemonic	State	Description
Bit 2	GAINX2		Turns on X2 log expand amplifier.
		1	A16U43 turned on. (5 dB/div or 1 dB/div scale)
		0	A16U43 turned off. (10 dB/div, 2 dB/div, or linear scale)
Bit 3	VTRIG_POL		Controls digital video trigger polarity.
		1	Negative-edge video trigger
		0	Positive-edge video trigger
Bit 4	LSAMPLE		Enables sample detection mode.
		1	Sample detection mode disabled.
		0	Sample detection mode enabled.
Bit 5	LADCEN		Enables FADC memory for "writes". (Toggled in conjunction with bit 0.)
		1	Disables FADC memory for "writes".
		0	Enables FADC memory for "writes".
Bit 6	LLOADADDR		Enables load address counter.
		1	"Writes" to the address counter disabled.
		0	"Writes" to the address counter enabled.
Bit 7	LLOADPOST		Enables load post-trigger counter.
		1	"Writes" to the post-trigger counter disabled.
		0	"Writes" to the post-trigger counter enabled.
Bit 8	LVTRIG_EN		Enables digital video trigger on A16.
		1	Digital video trigger disabled.
		0	Digital video trigger enabled.
Bit 9	LREADCLK		Clocks counters during "read" mode. Used to load post-trigger counter or address counter. Also used to post-increment address counter following memory "reads".
		1	Read clock disabled.
		0	Read clock enabled.

Table 7-13. Control Word at Primary Address (U3 and U4) (continued)

Bit	Mnemonic	State	Description
Bit 10	LREADMEM		Enables read FADC memory.
		1	Read FADC memory disabled.
		0	Read FADC memory enabled.
Bit 11	LREADADDR		Enables read trigger address latch.
		1	“Reads” from trigger address latch disabled.
		0	“Reads” from trigger address latch enabled.
Bit 12	LRATELATCH		Enables load sample rate latch.
		1	“Writes” to the sample rate latch are disabled.
		0	“Writes” to the sample rate latch are enabled.
Bit 13	LRLSHSWP		Releases HSWP strobe.
		1	Release HSWP strobe disabled.
		0	Release HSWP strobe enabled.
Bit 14	LLOADTRIG		Enables load video trigger level.
		1	Load digital video trigger level disabled.
		0	Load digital video trigger level enabled.
Bit 15	LPEAK		Peak/pit detection mode control.
		1	Enables pit (negative-peak) detection mode if LSAMPLE (Bit 4) is also high.
		0	Enables peak detection mode if LSAMPLE (Bit 4) is high.

Reference Clock

Refer to function block B of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The reference clock circuitry takes the 8 MHz CMOS square wave clock from the A2 controller assembly (via W59, coax 839) and triples the frequency to 24 MHz. Inverters U5A and U5B provide the proper match for the 8 MHz clock input, and also the desired drive level into the 24 MHz bandpass filter. The 24 MHz bandpass filter consists of R5, C8, L1, C9, C10, L2, C11, L3, C12, L4, C13, C14, and R6. Inverters U6A and U6B provide amplification of the 24 MHz clock to produce CMOS levels, and also buffer the 24 MHz clock output.

Clock and Sample Rate Generator

Refer to function block C of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The clock and sample rate generator takes the 24 MHz reference clock signal and generates all of the various clock signals used on the A16 fast ADC assembly. The sample rate generator consists of CMOS latch U15, CMOS counters U14 and U16, and CMOS flip-flops U7B and U9A. The sample rate generator only controls the rate at which the static RAM address counter (15-bit circular address counter) and the 16-bit post-trigger counter are clocked (ACLK and PCLK respectively). The sample rate generator also controls the number of flash ADC samples taken per bucket. The range of the sample rate is 1 sample per bucket (12 MHz rate) to 256 samples per bucket (less than 12 MHz rate). SCLK-1 is an input to PAL U1 (block A) and affects the LP/Q signal to ensure that the first sample of a bucket is always clocked into latch U30 (block J) and written into static RAM U32 (block K) when the detection mode is peak or pit and the sample rate is less than 12 MHz. Refer to Table 7-12, LP/Q Truth Table in this chapter.

Trigger

Refer to function block D of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

When the A16 fast ADC is triggered, the current static RAM address is latched into trigger address latches U27 and U28 (block G), and the

post-trigger counter (U19, U20, U21, U22, and U47) begins counting.

Samples continue to be written to consecutive addresses in RAM U32 until the post-trigger counter reaches its terminal count. The CPU on the A2 controller assembly monitors the HSWP line and starts a software timer when HSWP goes high after being triggered. The software timer is set to slightly longer than the post-trigger counter will be counting, so at the end of the "time-out", the post-trigger counter has already reached its terminal count. At the end of this "time-out", the CPU on the A2 controller assembly takes the fast ADC out of "write" mode and reads latches U27 and U28 to determine the static RAM address of the sample that was taken when the trigger occurred. The CPU then writes the trigger address (read at U27/U28) to the fast ADC static RAM address counter (15-bit circular address counter). If pre-trigger or post-trigger (delay) is being used, the CPU adds or subtracts appropriately and writes the "adjusted" trigger address to the static RAM counter. The CPU then begins reading the fast ADC data, starting from the trigger (or offset trigger) address.

The trigger circuitry is enabled by the ARM signal (bit 1 of the fast ADC control word). Once a trigger occurs, the fast ADC cannot be triggered again until the ARM line goes low (disarmed), then high again (armed).

The fast ADC is triggered by the HSWP line in **FREE RUN**, **LINE**, and **EXTERNAL** trigger modes. When **VIDEO** trigger is being used, a synchronous digital video trigger signal, VCLK, is generated by PAL U1 (block A) and U17A (block D).

16-Bit Post-Trigger Counter

Refer to function block E of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The 16-bit post-trigger counter controls the number of static RAM memory locations that will be written after the trigger occurs. This counter consists of U19, U20, U21, U22, and U47. The counter is loaded from the CPU on the A2 controller assembly when the A16 fast ADC assembly is in “read” mode. The CPU loads the counter by first setting the LLOADPOST (bit 7 of the fast ADC control word) and the LREADCLK (bit 9 of the fast ADC control word) to their low state. The CPU then writes the 16-bit word to the fast ADC secondary address. The rising edge of PCLK then latches the 16-bit data into the post-trigger counter.

The post-trigger counter begins counting upward in “write” mode on the first rising edge of PCLK after the LCOUNT signal from the trigger circuit goes low. The frequency of PCLK is the programmed sample rate. When the post-trigger counter reaches its terminal count, the LSTOP signal goes low and disables the static RAM address counter from further counting. LSTOP also forces LCOUNT high in NAND gate U11D, which disables the post-trigger counter.

15-Bit (32 K) Circular Address Counter

Refer to function block G of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

This 15-bit programmable circular counter provides the address lines of the static RAM (U32). The counter consists of U23, U24, U25, and U26. It counts upward from 0 to 32767 and then back to 0 in a circular fashion. When a trigger occurs, latches U27 and U28 latch the current static RAM address so that the CPU on the A2 controller assembly can later read the latches and determine the static RAM address of the sample that was taken when the trigger occurred.

The CPU loads the address counter during “read” mode by first setting LLOADADDR (bit 6 of the fast ADC control word) and LREADCLK (bit 9 of the fast ADC control word) to their low state. The CPU then writes the 16-bit load value to the CPU secondary address. The rising edge of ACLK then latches the 16-bit data into the address counter.

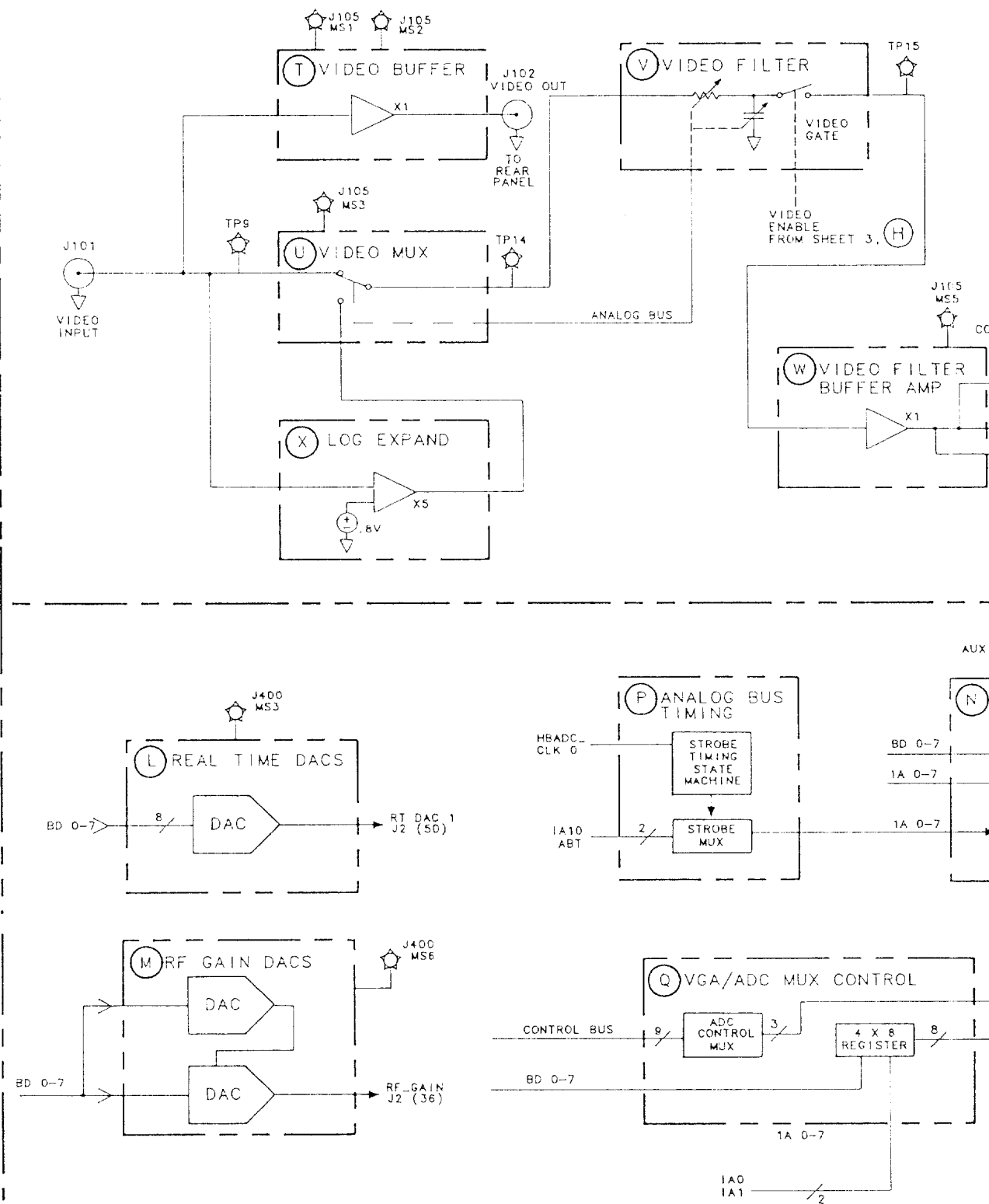
After the address counter is loaded by the CPU during “read” mode, the static RAM is read by the CPU. The RAM is read by first setting LREADMEM (bit 10 of the fast ADC control word) and LREADCLK (bit 9 of the fast ADC control word) to their low state. Since the LREADCLK control bit is low, a negative-going pulse on the ACLK line will occur on every static RAM “read” by the CPU. This causes the address counter to increment at the end of each static RAM “read” so that the address counter automatically post-increments to the next address of RAM U32. In order for this address post-increment to occur, the LSTOP count enable signal from the post-trigger counter must be high. LSTOP goes low when the post-trigger counter reaches its terminal count in the “write” mode to stop the address counter from counting. When the fast ADC assembly is changed from “write” mode to “read” mode, LSTOP will be low. So the CPU on the A2 controller board must always first program the post-trigger counter to a value other than the terminal count (65535) to force LSTOP high.

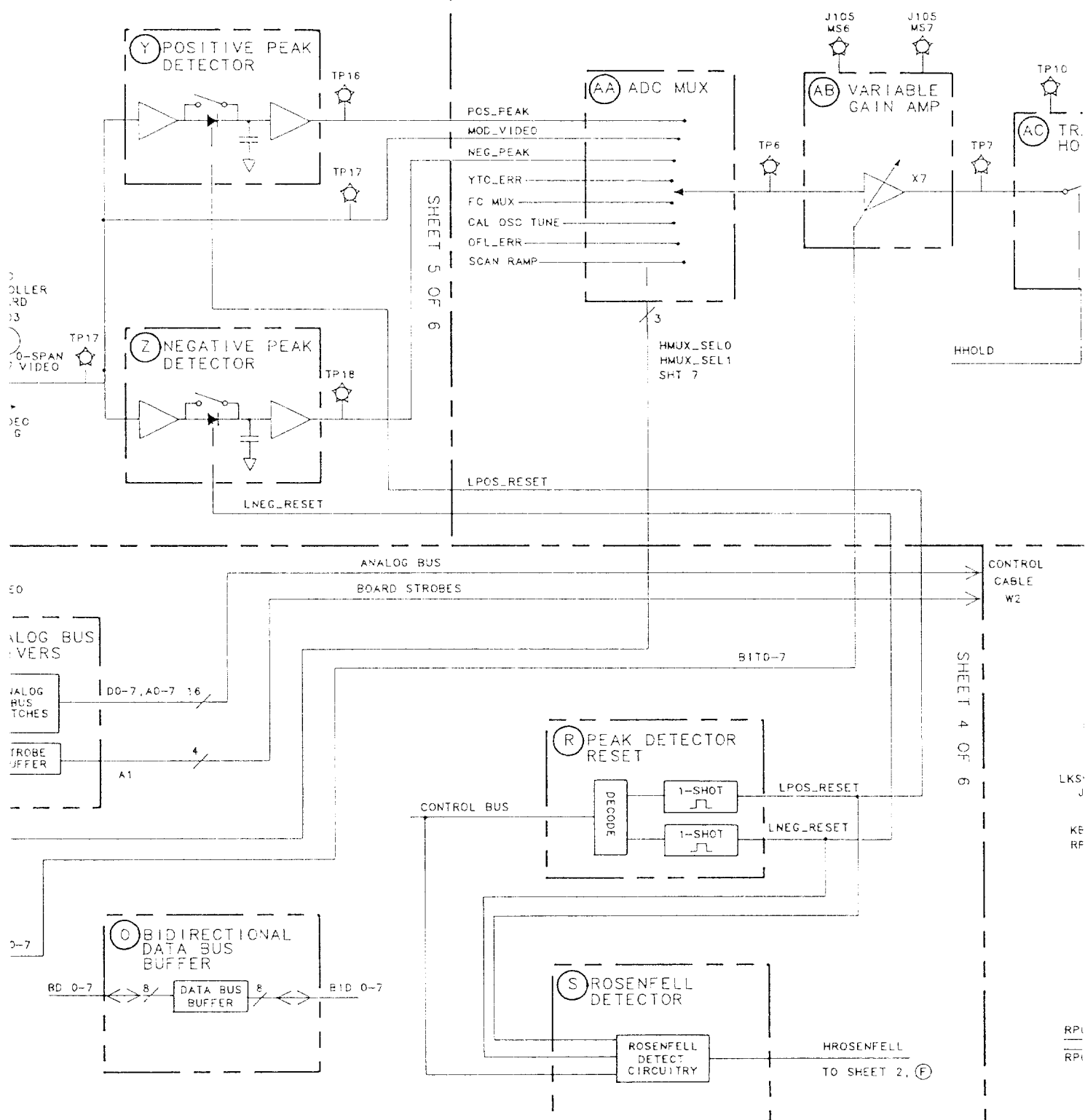
Video Trigger Comparator

Refer to function block M of the A16 fast ADC assembly schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

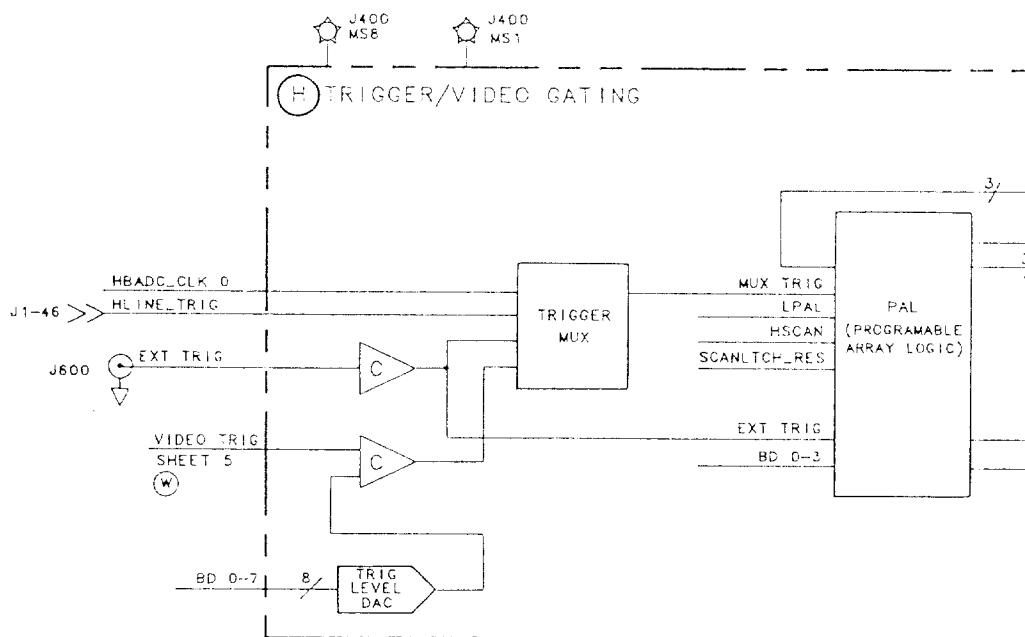
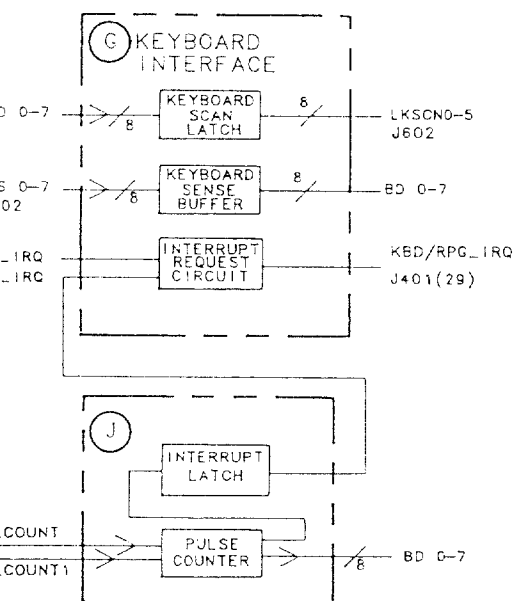
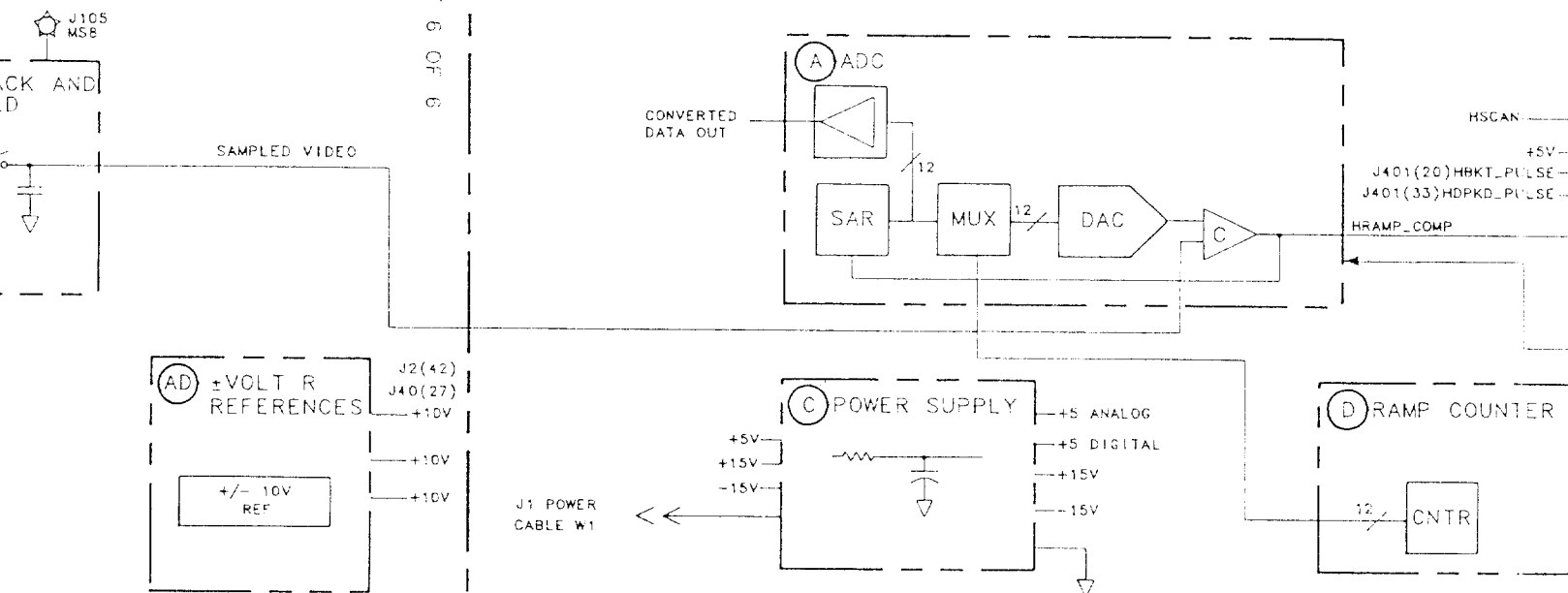
This 8-bit digital magnitude comparator, U34, compares the digitized samples from the flash ADC (latch U29 output) to the programmed video trigger level. The video trigger level value on IOB2 through IOB7 is latched into the P input (top portion of U34) by the firmware on the A2 controller assembly when the fast ADC is in "read" mode. When the sample on the Q input is higher than the video trigger level on the P input, V_HI output is high, and V_LO output is low. When the Q input is lower than the P input, V_HI output is low and V_LO output is high. And when P is equal to Q, both V_HI and V_LO are low. These two signals (V_HI and V_LO) go to PAL U1 (block A) and are used to clock the video trigger generator (block D).

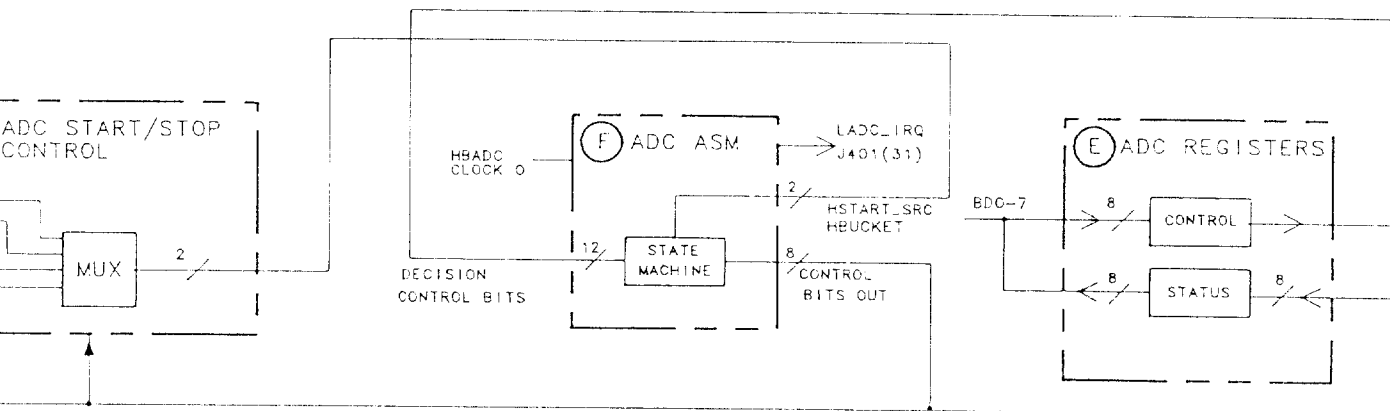
A3 INTERFACE ASSEMBLY



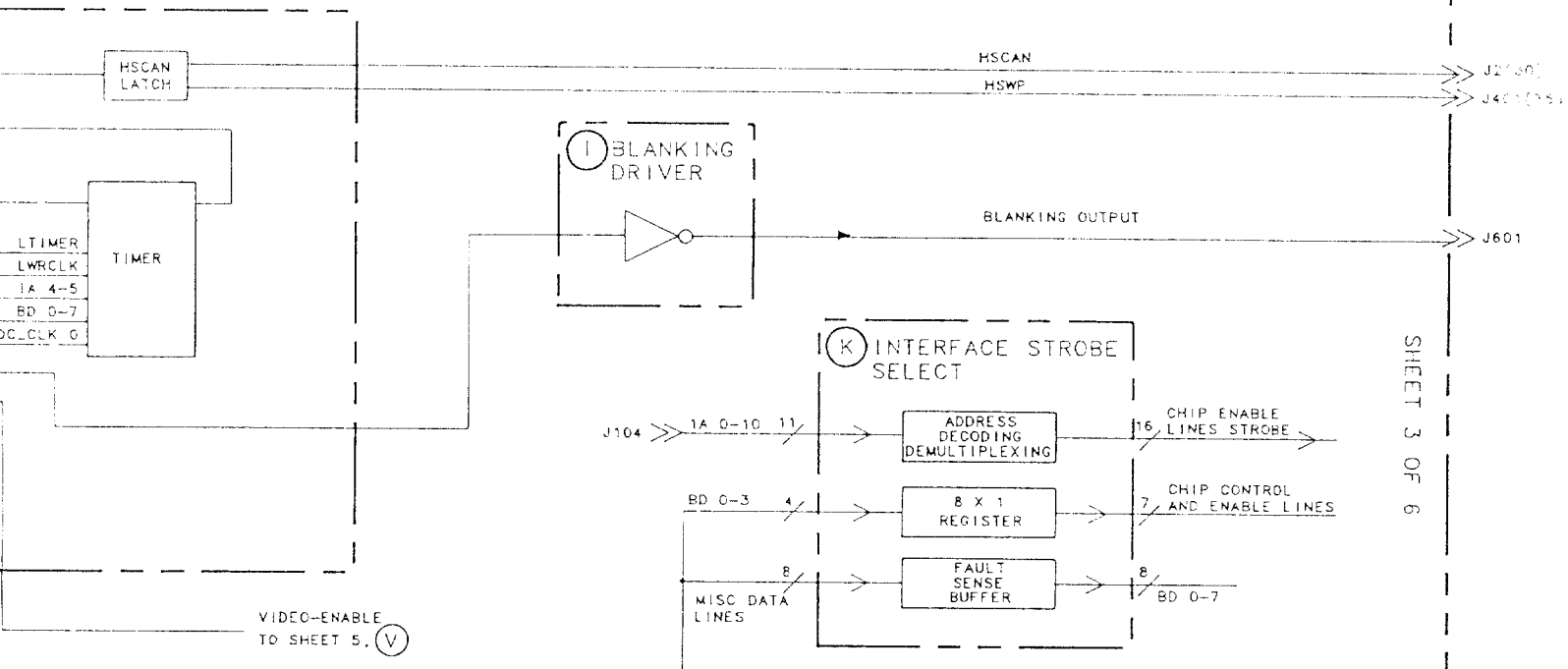


SHEET 6 OF 6



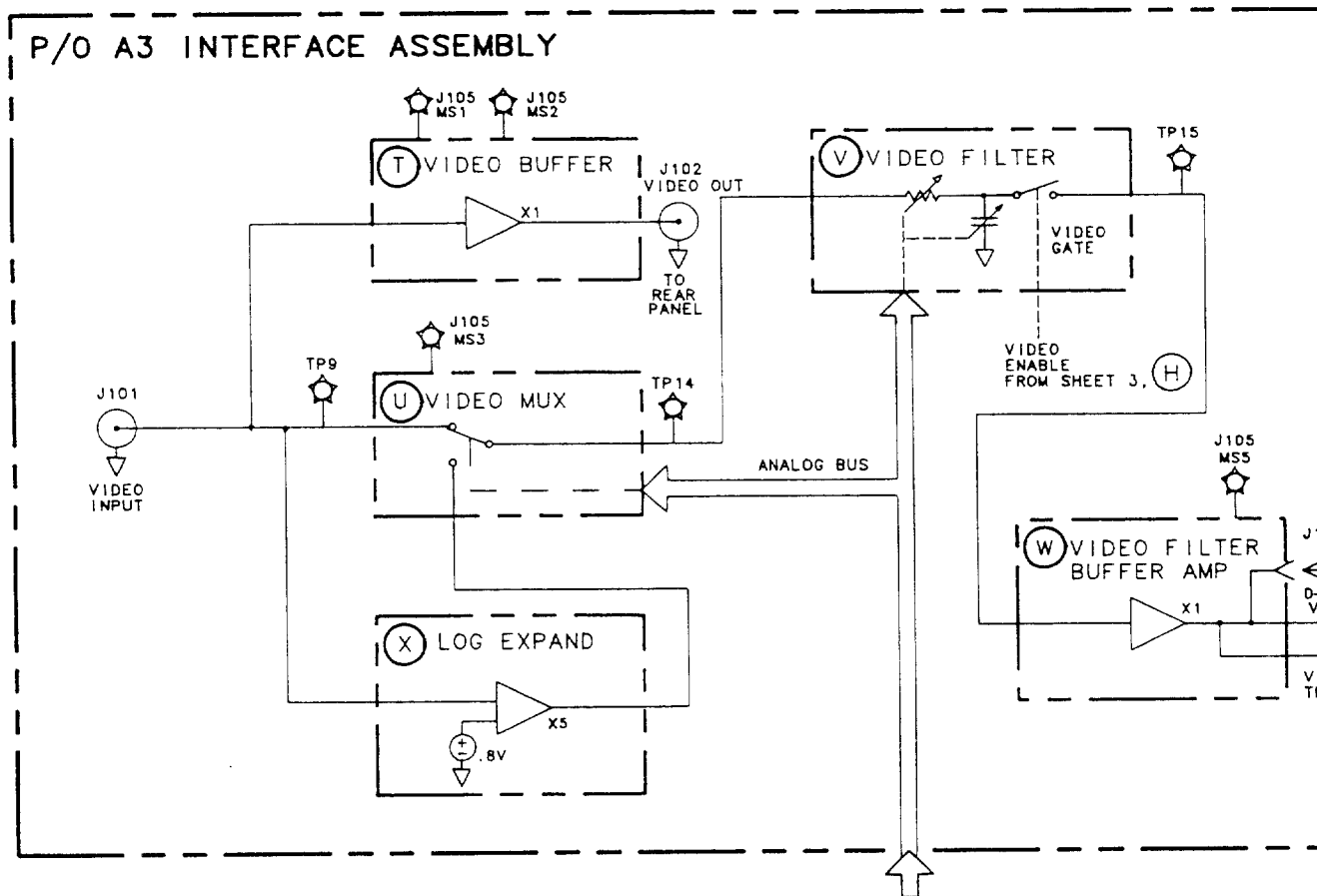


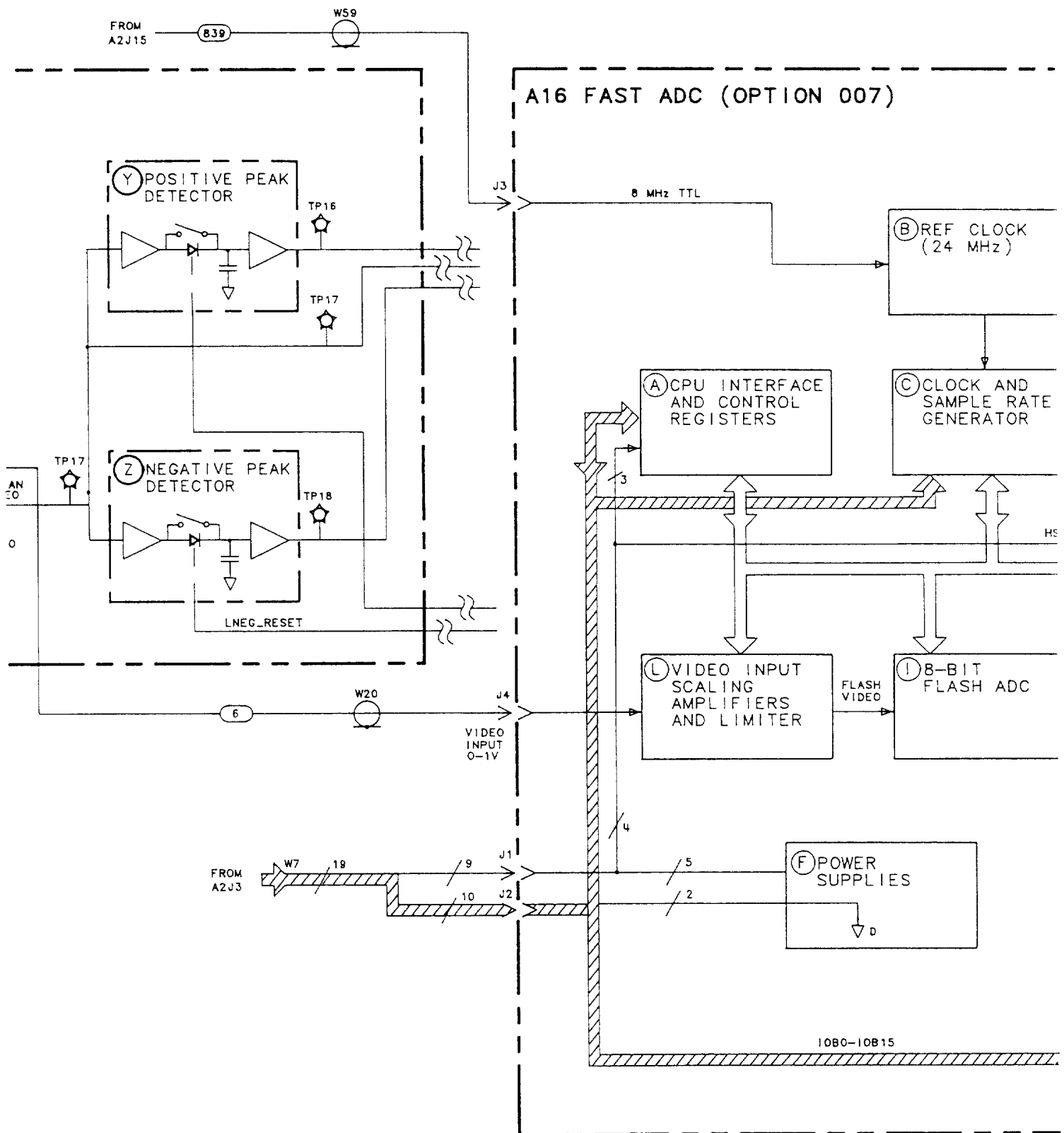
SHEET 2 OF 6



SHEET 3 OF 6

FIGURE 7-2. A3 INTERFACE ASSEMBLY BLOCK DIAGRAM

FAST ADC (OPTION 007)
BLOCK DIAGRAM



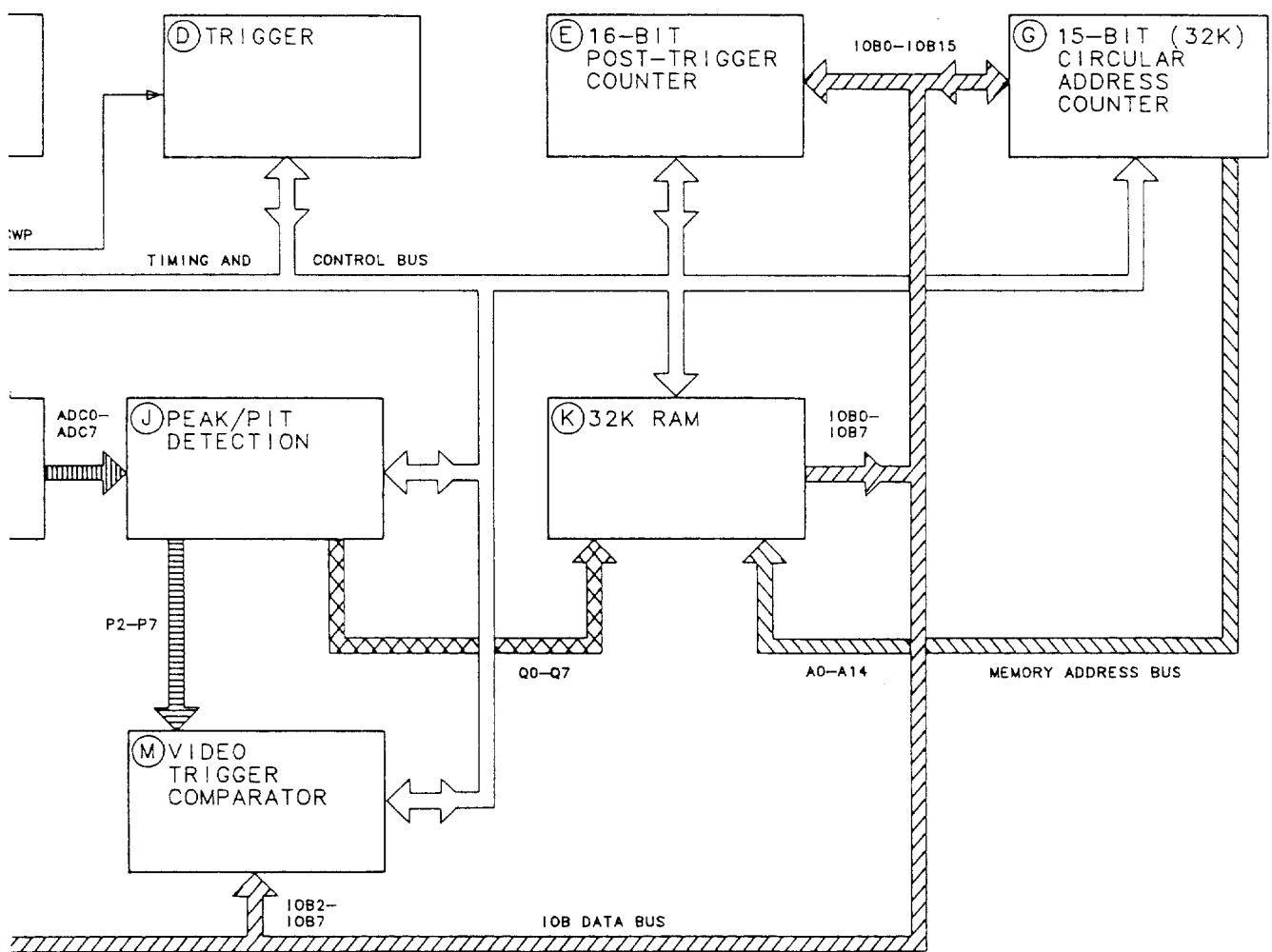


FIGURE 7-3. FAST ADC (OPTION 007) BLOCK DIAGRAM

IF Section

The IF Section contains the A4 Log Amplifier/Cal Oscillator and A5 IF assemblies.

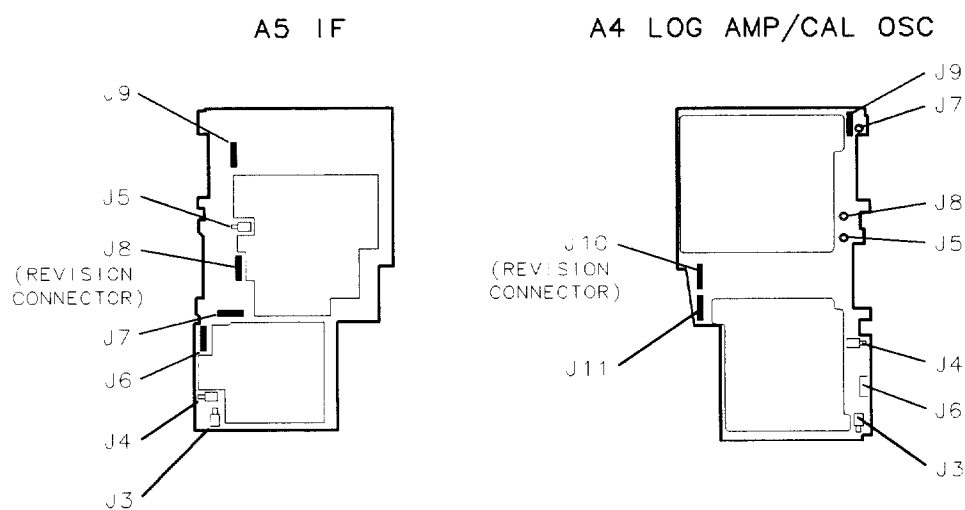
- Troubleshooting Using the TAM
 - Troubleshooting the Log Amplifier with the TAM
 - Troubleshooting A5 with the TAM
 - Troubleshooting the Cal Oscillator with the TAM
- Automatic IF Adjustment
 - Parameters Adjusted
 - Requirements
- Performance Test Failures
 - IF Gain Uncertainty Performance Test
 - Scale Fidelity Performance Test
 - Resolution Bandwidths Performance Tests
- Log Amplifier Assembly (P/O A4)
 - Log Amplifier
 - Linear Amplifiers
 - Video Offset
 - Video Output
 - Frequency Counter Prescaler/Conditioner
 - AM/FM Demodulator
 - 4.8 kHz IF Filters
 - 10.7 MHz IF Filters
 - 4.8 kHz and 10.7 MHz IF Filters
 - 10.6952 MHz VCXO
 - Input Switch
 - LO Switch
 - Synchronous Detector
 - Limiter
 - Isolation Amplifier
 - Detector/Mixer
 - Log Offset/Gain Compensation
 - Log Offset Compensation
 - Log Gain Compensation
 - Video MUX
- A5 IF Assembly
 - IF Signature
 - Common IF Signature Problems
 - 1 MHz Resolution Bandwidth Problems
 - 30 kHz Resolution Bandwidth Problems
 - 3 kHz and 10 kHz Resolution Bandwidth Problems
 - Step Gains
- Cal Oscillator Assembly (P/O A4)
 - Cal Oscillator Unlock at Beginning of IF Adjust

Inadequate CAL OSC AMPTD Range
300 Hz to 3 kHz Resolution Bandwidth Out of Specification
Low-Pass Filter
Sweep Generator
AM/FM Demodulation, Audio Amplifier, and Speaker

Note Because the cal oscillator circuitry on the A4 assembly is such an integral part of the IF adjustment, always check this assembly first, before checking the rest of the IF Section. A faulty cal oscillator can cause many apparent “faults” in the rest of the IF Section.

Troubleshooting Using the TAM

When using Automatic Fault Isolation, the TAM indicates suspected circuits that need to be manually checked. Use Table 8-1 to locate the manual procedure. Table 8-2 lists assembly test connectors associated with each Manual Probe Troubleshooting test. Figure 8-1 illustrates the location of A4 and A5 test connectors. Figure 8-2 illustrates the levels and paths through the IF Section.



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Figure 8-1. A4 and A5 Test Connectors

Table 8-1. Automatic Fault Isolation References

Suspected Circuit Indicated by Automatic Fault Isolation	Manual Procedure to Perform
Check Cal Oscillator on A4 Assembly	Troubleshooting the Cal Osc with the TAM
Check Input Switch on A5 IF Assembly	Troubleshooting A5 with the TAM
Check Linear Amplifiers on A4 Assembly	Linear Amplifiers
Check Log Expand on A3 Interface Assembly	Refer to “Log Expand” in this chapter
Check Step Gains on A5 IF Assembly	Step Gains
Check Video Offsets on A4 Assembly	Video Offset (<i>steps 1 through 4</i>)
Check VIDEO OUT on A4 Assembly	Video Output

Troubleshooting the Log Amplifier with the TAM

Manual probe troubleshooting tests several dc bias points and signal path voltages. A dc bias is measured in the limiter and a fault here indicates a broken limiter stage. Signal path voltages are measured at the input, after the video amplifier in the linear path, after the offset and gain compensation circuits in the log path, and after the video offset.

The cal oscillator on A4 is used as an input to the log amp for the purpose of measuring gains. Faults in the signal path voltages indicate broken circuitry in prior stages. This technique locates dead stages, but might not report slightly degraded ones. Both +15 V and -15 V are measured. The revision code is on J11.

Troubleshooting A5 with the TAM

Manual Probe Troubleshooting calculates stage bias-currents which test the operation of the IF chain. (This technique locates dead stages, but might not report slightly degraded ones.) DACs that are monitored are listed below:

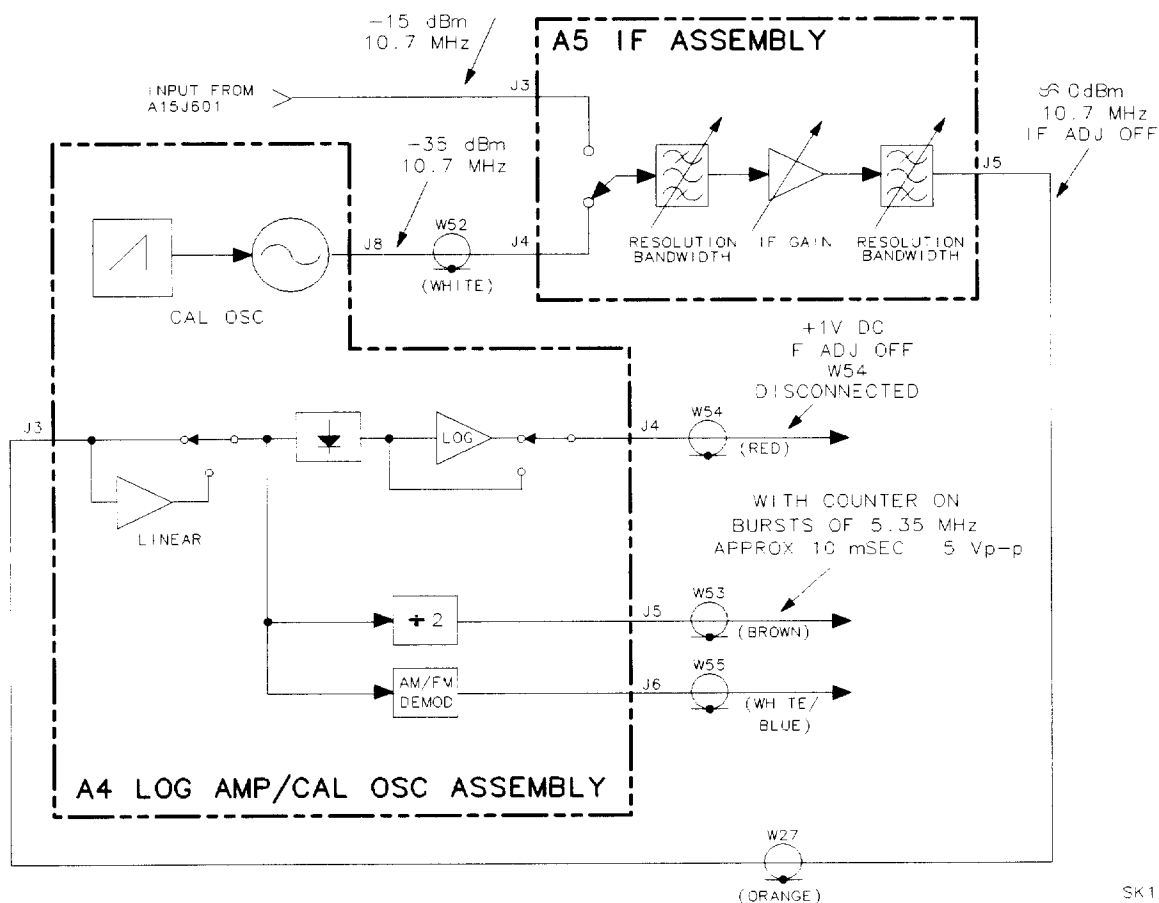
IFDAC1	A5U812
IFDAC2	A5U813
IFDAC3	A5U809
IFDAC4	A5U807
IFDAC5	A5U810
IFDAC6	A5U806

Table 8-2. TAM Tests versus Test Connectors

Connector	Manual Probe Troubleshooting Test	Measured Signal Lines
A3J105	Video Input to Interface	MS1
	Video to Rear Panel	MS2
	Video MUX	MS3
	Log Offset/Log Expand	MS1,MS3
	Video Filter Buffer Amplifier	MS3, MS5, OS1
	Video Peak Detectors	MS5, MS6
	ADC MUX	MS6
	Variable Gain Amplifier	MS6, MS7
	Track and Hold	MS7, MS8
A3J400	Video Trigger DAC	MS1
	Revision	MS2
	Real Time DAC #1	MS3
	RF Gain DACs	MS6
	ADC Start/Stop Control	MS7
	Trigger	MS8
A4J9	Cal Osc Sweep Gen Hardware	MS1, MS2
	Cal Osc Tune Line Test	MS3
	Cal Osc ALC Test	MS4
	Cal Osc Sweep Gen Output	MS6
A4J10	Log Amp Input Switch	MS1
	Log Amp Limiter Bias	MS2
	Positive 15 V Supply	MS5
A4J11	Logamp Linear Output	MS2
	Logamp Linear MUX Path	MS2,MS3,MS8
	Logamp Log Output	MS3
	Logamp Compensation	MS3,MS4
	Logamp Log MUX Path	MS4,MS8
	Logamp Video Offset	MS8
	-15 Volt Supply	MS7
	Revision	MS5
A5J6	1st Step Gain Stage 1	MS1, MS2, MS8
	1st Step Gain Stage 2	MS1, MS2, MS3
	1st XTAL Pole Stage	MS2, MS3, MS4
	2nd XTAL Pole Stage	MS3, MS4, MS5
	1st LC Pole Stage 1	MS4, MS5, MS6
	1st LC Pole Stage 2	MS5, MS6, MS7

Table 8-2. TAM Tests versus Test Connectors (continued)

Connector	Manual Probe Troubleshooting Test	Measured Signal Lines
A5J7	Ref 15 dB Attenuator Stage	MS1, MS2, MS3
	2nd Step Gain Stage	MS2, MS3, MS4
	2nd/3rd Step Gain Stage	MS3, MS4, MS5
	3rd Step Gain Stage	MS4, MS5, MS6
	Fine Atten/3rd XTL Pole	MS5, MS6, MS7
	3rd XTAL Pole Stage	MS6, MS7, MS8
A5J8	Revision	MS8
	4th XTAL Pole Stage	MS1, MS2, MS3
	Post Amplifier Stage 1	MS2, MS3, MS4
	Post Amplifier Stage 3	MS3, MS4, MS5
	3rd LC Pole Stage	MS5, MS6, MS7
	4th LC Pole Stage	MS6, MS7
A5J9	IFDAC Channels 'A'	MS1
	IFDAC Channels 'B'	MS3
	IFDAC Channels 'C'	MS4
	IFDAC Channels 'D'	MS2
	Latched IF Control Lines	MS5
	Negative 15 V Supply	MS6
	5 Volt Supply	MS7
	10 Volt Reference	MS8



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Figure 8-2. IF Section Troubleshooting with the TAM

Both the digital control and DACs are multiplexed onto test point "channels" through resistive networks. One DAC from each of the quad-DAC packages feeds into a network. The TAM varies each DAC individually to isolate which ones failed. Similarly, 10 digitally-controlled lines feed into a network and are monitored by the TAM. The channels used to monitor the DACs are listed below:

Channel A		A5J9 pin 1 (MS1)
Channel B		A5J9 pin 3 (MS3)
Channel C		A5J9 pin 4 (MS4)
Channel D		A5J9 pin 2 (MS2)

1. On the HP 8560E, press **PRESET**, **MODULE**, and **Diagnose**. Select **Cal Osc Troubleshooting Mode**.
2. On the HP 8560E, disconnect W27 (coax 3) from A5J5 and monitor the output of A5J5 with a second spectrum analyzer.

3. Set the other spectrum analyzer controls as follows:

Span 5 MHz
Reference level -20 dBm
Center frequency 10.7 MHz

4. On the HP 8560E, set the cal oscillator to 10.7 MHz by selecting **Fixed Tuned to 10.7 MHz**.
5. A -25 dBm signal from A5J5 should be displayed. If the signal is missing, disconnect W52 (coax 9) from A5J4. This is the cal oscillator signal input from the cal oscillator on the A4 assembly.
6. Connect the end of cable W52 to the input of the second spectrum analyzer. The signal coming from cable W52 should be -35 dBm at 10.7 MHz. If the cal oscillator signal from cable W52 is correct, the A5 IF assembly is probably at fault.

Troubleshooting the Cal Oscillator with the TAM

1. Enter the TAM Cal Osc Troubleshooting Mode.
2. On the spectrum analyzer, disconnect cable W52 (coax 9) from A5J4 and connect this end of cable W52 to the input of a second spectrum analyzer.
3. Set the controls of the second spectrum analyzer connected to cable W52 to the following:

Span 5 MHz
Reference level -30 dBm
Center frequency 10.7 MHz

4. Select each of the fixed-tuned frequencies. Verify at each frequency that the signal amplitude measures -35 dBm. If the frequency is incorrect, do the following:
 - a. Verify that the reference divider output (A4U811 pin 9) is 100 kHz. If it is not, verify that the 10 MHz reference is present at A4U811 pin 1.
 - b. Verify that the frequency found on the output of the divider (A4U808 pin 15) matches the output of the reference divider. Matching frequencies indicate the oscillator loop is locked. If the loop is not locked, troubleshoot the divider, oscillator, or phase detector.
 - c. Verify that the frequency found at the divider input (A4U808 pin 3) matches the CW frequency chosen in step a. Matching frequencies indicate a properly working oscillator. If the frequency is different, troubleshoot the divider.
 - d. Repeat step c for all the CW frequencies provided by the test.
5. Select each of the sweep widths (these sweeps are centered about 10.7 MHz).
6. Reduce the span of the other spectrum analyzer to check that the cal oscillator is actually sweeping. If the oscillator is not sweeping, perform the following steps:
 - a. The output of the sweep generator circuit (A4U804 pin 8 of function block Z) should be a series of negative-going parabolas (frequency and amplitude vary depending on the sweep width chosen). Table 8-3 lists the RANGE, MA0, and MA1 values for the sweep widths. If a failure is indicated in the IF/LOG CHECK, press **More Info** to provide more detailed information about the detected failure. If an HP-IB printer is available, connect it to the spectrum analyzer HP-IB connector, then press **Print Page** for a hard copy output.

Table 8-3. Sweep Width Settings

Sweep Width	Sweep Time	Res BW Adjusted	RANGE A4U105 Pin 6	MA1 A4U105 Pin 2	MA0 A4U105 Pin 5
20 kHz	5 ms	10 kHz	+5 V	0 V	0 V
10 kHz	10 ms	3 kHz	+5 V	0 V	+5 V
4 kHz	30 ms	1 kHz	+5 V	+5 V	0 V
2 kHz	15 ms	300 Hz	+5 V	+5 V	+5 V

Automatic IF Adjustment

The spectrum analyzer performs an automatic adjustment of the IF Section whenever needed.

The cal oscillator on the A4 assembly provides a stimulus signal which is routed through the IF during the retrace period.

The A3 Interface assembly measures the response using its analog-to-digital converter (ADC). The spectrum analyzer turns the cal oscillator off during a sweep.

When IF ADJ is ON, the spectrum analyzer readjusts part of the IF circuitry during each retrace period to readjust the IF completely every 5 minutes.

Automatic IF adjustment is performed upon the following conditions:

- **Power on:** (unless **STOP ALIGN** is pressed). The IF parameter variables are initialized to values loaded in program ROM and all possible IF adjustments are made. If **STOP ALIGN** is pressed, the adjustment is halted.
- If **REALIGN LO & IF** is selected: All possible IF adjustments (and LO adjustments) are made with the most recent IF parameter variables used as the starting point.
- If **FULL IF ADJ** is selected: All possible IF adjustments are made with the most recent IF parameter variables used as the starting point. (**FULL IF ADJ** is located in the **CAL** menu.)
- If **ADJ CURR IF STATE** is selected: All amplitude data and some resolution bandwidths are adjusted. The bandwidths adjusted are a function of the currently selected resolution bandwidth setting.
- **Between sweeps:** IF ADJ must be set to ON. When IF ADJ is OFF, an A is displayed along the left side of the graticule.

If a FULL IF ADJ sequence cannot proceed beyond the amplitude portion, check the output of the cal oscillator on the A4 assembly as follows:

1. Disconnect cable W52 (coax 9) from A5J4. Connect cable W52 to the input of a second spectrum analyzer.
2. Set the second spectrum analyzer center frequency to 10.7 MHz and the reference level to -30 dBm.
3. On the HP 8560E under test, press **FULL IF ADJ** and observe the display of the second spectrum analyzer
4. If a -35 dBm signal does not appear, the cal oscillator is probably at fault.

Parameters Adjusted

The following IF parameters are adjusted in the sequence listed:

1. Amplitude
 - A. Video Offsets: analog (using log amplifier video offset DAC) and digital (applying stored constant to all readings)
 1. Linear Scale Offset
 2. Log Scale Offset
 - a. Wideband and Narrowband modes.
 - b. 0 to 60 dB range in 10 dB steps.
 - c. 10 dB/DIV and 2 dB/DIV (log expand) modes.
 - B. Step Gains (A5 IF Assembly)
 1. First Step Gain for 16 different DAC settings.
 2. Second Step Gain for 16 different DAC settings.
 3. Third Step Gain for 0, 15, and 30 dB attenuation relative to maximum gain.
 4. Fine Attenuator for 32 evenly-spaced DAC settings.
 - C. Log Amplifier Slopes and Fidelity
 1. Wideband (RES BW 300 kHz through 2 MHz) and Narrowband modes (RES BW 300 Hz through 100 kHz)
 2. 10 dB/DIV and 2 dB/DIV (log expand) modes
 - D. Linear Scale Gains - On the log amplifier assembly (P/O A4)
 - E. Peak Detector Offsets (both Positive and Negative Peak Detectors with respect to normal sample path used by Auto IF Adjust)
2. LC Bandwidths
 - A. 300 kHz resolution bandwidth center frequency, bandwidth, and gain
 - B. 1 MHz resolution bandwidth center frequency, bandwidth, and gain
 - C. 2 MHz resolution bandwidth gain
 - D. 100 kHz resolution bandwidth center frequency, bandwidth, and gain
 - E. 30 kHz resolution bandwidth center frequency, bandwidth, and gain
 - F. Gain of all resolution bandwidth relative to the 300 kHz RES BW

3. Crystal Bandwidths

- A. The cal oscillator sweep rate is measured against the 100 kHz resolution bandwidth filter skirt. This result is used in compensating the sweeps used for adjusting the crystal bandwidths.
 - B. 10 kHz resolution bandwidth
 - 1. Center frequency of LC tank that loads the crystal
 - 2. Symmetry adjustment to cancel crystal case capacitance
 - 3. Bandwidth
 - C. 3 kHz resolution bandwidth: center frequency of LC tank and bandwidth of resolution bandwidth
 - D. 1 kHz resolution bandwidth: bandwidth
 - E. 300 Hz resolution bandwidth: bandwidth
 - F. Gain of all resolution bandwidth relative to the 300 kHz RES BW
4. Digital Bandwidths (1 Hz through 100 Hz; 10 Hz through 100 Hz if Option 103)
- A. VCXO (final LO) tuned to align digital bandwidths with crystal bandwidth center frequency
 - B. Overall gain
 - C. Gain variation with input frequency

Requirements

For the Automatic IF Adjustment routine to work, the spectrum analyzer must provide the following basic functions:

- Power supplies
- Control signals
- ADC
- 10 MHz Frequency Reference to the A4 log amp/cal oscillator
- A15 RF Assembly isolation from the RF signal during IF adjustment

A15 RF assembly isolation is a function of the REDIR signal in the A15 Flatness Compensation Control block.

The references against which the Automatic IF Adjustment routine aligns are:

- 10 MHz reference (A15)
- Linear Scale Fidelity, especially the 10 dB gain stage in A4 Linear Amplifier block.
- 15 dB Reference Attenuator (A5)
- Cal Oscillator output power (A4)

Performance Test Failures

Failures in IF-Section-related performance tests may be investigated using the following information.

IF Gain Uncertainty Performance Test

Failure of this performance test indicates a possible problem with the spectrum analyzer IF gain circuits. Assuming no major IF problems causing IF adjustment errors, IF gain problems in the first 50 dB of IF gain (REF LVLs of 0 dBm to -50 dBm with 10 dB ATTEN) are a result of faults on the A5 IF Assembly. IF gain problems in the next 60 dB of IF gain (REF LVLs of -60 dBm to -110 dBm, 10 dB ATTEN) result from log amplifier faults on the A4 assembly.

A signal level of -5 dBm is required at input (A5J3) for displaying a signal at top screen with 10 dB input attenuation and a 0 dBm reference level. Isolate IF gain problems on the log amplifier assembly (A4) with the following steps:

1. On the spectrum analyzer press **PRESET**, **SPAN**, **ZERO SPAN**, **FREQUENCY**, 1 **GHz**, **AMPLITUDE**, -50 dBm.
2. Press **CAL** and **IF ADJ OFF**.
3. Disconnect cable W27 (coax 3) from A5J5 and connect cable W27 to the output of a signal generator.
4. Set the signal generator controls as follows:
Amplitude +10 dBm
Frequency 10.7 MHz
5. Simultaneously decrease the signal generator output and the spectrum analyzer REF LVL in 10 dB steps. The signal displayed by the spectrum analyzer should remain at the reference level for each step. If the signal deviates from the reference level, troubleshoot the video offset circuitry on the A4 assembly.
6. Repeat steps 1 through 5 with the spectrum analyzer set to linear.

Scale Fidelity Performance Test

Failure of this performance test indicates a possible problem with the A4 assembly.

- If the Linear, 5 dB/DIV, or 10 dB/DIV scales are out of specification, the fault is most likely on the log amplifier assembly (P/O A4).
- If only the 1 dB/DIV or 2 dB/DIV scales are out of specification, the fault is most likely on the A3 interface assembly.

Resolution Bandwidths Performance Tests

Most resolution bandwidth problems are a result of A5 IF assembly failures. The resolution bandwidths are adjusted in the following sequence using 300 kHz as the reference: 1 MHz, 2 MHz, 100 kHz, 30 kHz, 10 kHz, 3 kHz, 1 kHz, 300 Hz, 100 Hz, 30 Hz, 10 Hz, 3 Hz, and 1 Hz. The 3 Hz and 1 Hz bandwidths are not available with Option 103.

If the IF adjustment routine encountered an error, the previously adjusted resolution bandwidths should be working properly and default DAC values are used for the remaining resolution bandwidth settings.

If the IF bandpass adjustments and the automatic IF adjustments fail to bring the resolution bandwidths within specification, troubleshoot the A5 IF assembly.

Log Amplifier Assembly (P/O A4)

The log amplifier assembly on A4 performs several functions. It provides log and linear paths converting the 10.7 MHz IF signal to video. In addition it also provides offset circuitry, AM/FM demodulator circuitry, a frequency counter output, and down conversion of the 10.7 MHz IF to 4.8 kHz for use by the digital IF.

The log amp results are realized by using a wide dynamic range linear detector followed by a video log amp. The detector is used for both linear and log paths and contains a mixer that acts as the down converter mixer for the digital IF.

Caution

For troubleshooting, it is recommended that you use an active probe, such as an HP 85024A, and another spectrum analyzer. If an HP 1120A active probe is being used with a spectrum analyzer having dc coupled inputs, such as the HP 8566A/B, HP 8569A/B and the HP 8562A/B, either set the active probe for an ac-coupled output or use a dc-blocking capacitor between the active probe and the spectrum analyzer input. Failure to do this can result in damage to the spectrum analyzer or the probe.

Log Amplifier

Refer to function blocks K, L, and AE of A4 Log Amplifier Schematic Diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*. The log amplifier receives the detected video signal from the Detector/Mixer and outputs a voltage proportional to the log of the input voltage. The linear output is tapped off at the emitter of U501D. U507 provides input offset adjustment capability and adjusts the offset of the op amp formed by U501A, B, C, and D. Q502 is a buffer. Q501 switches in additional offset for digital RBWs. The logarithmic characteristic of the base-emitter junction of U502B is used in the feedback path to produce the logging affect. U502D is used to adjust for non-linearities in the linear mode. R531 is used to adjust log fidelity at the top of the screen.

Use the following steps to verify proper operation of the log amplifier chain:

1. Press **CAL** and **IF ADJ OFF**. Set the digital multimeter to read dc volts and connect the negative lead to the chassis of the spectrum analyzer.
2. Remove W27 from A4J3 and inject a 10.7 MHz signal of +10 dBm into A4J3.
3. Set the spectrum analyzer to log mode, with a resolution bandwidth of 300 kHz and single sweep.
4. Using the DMM, check the voltage at U503 pin 6.
5. Verify that this level is about -700 mV.
6. Adjust the source amplitude to place the signal at the reference level.
7. Reduce the input signal level in 10 dB steps, down to -60 dBm, while noting the voltage displayed on the DMM. The voltage should increase (become less negative) at a rate of 30 mV for each 10 dB decrease in input power. Troubleshoot the A4 assembly if the signal does not decrease properly.
8. Set the spectrum analyzer resolution bandwidth to 100 kHz to place the wide/narrow filter in narrow mode.
9. Repeat steps 2 through 7.
10. If log fidelity is poor near the bottom of the screen or the 1 MHz resolution bandwidth is narrow, a fault might exist in the wide/narrow filter switch. (Refer to function block G of A4 log amplifier schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.) Check this switch as follows:
 - a. Monitor voltages on A4U302 pins 1 and 7 while changing the spectrum analyzer resolution bandwidth from 100 kHz to 300 kHz.
 - b. If the voltages do not come within a few volts of the +15 V and -15 V supplies, U103 and U302 are suspect.
 - c. Disconnect the digital multimeter and reconnect W27 to A4J3.

Linear Amplifiers

Refer to function block C of A4 log amplifier schematic diagram (sheet 2 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*. The Linear Amps consist of two variable gain stages, U201C and U201E as well as the buffer amplifier A4U201B, A4U201D, and A4Q201. The linear amplifiers provide 0 to 40 dB of IF gain in 10 dB steps. The gain of A4U201C can be increased by 20 dB by turning on A4CR201 and A4CR210 with the control line LIN_20B. The gain of A4U201E can be increased by either 10 dB or 20 dB with the control lines LIN_10 or LIN_20A respectively. The gain can be selected by setting the spectrum analyzers reference level.

IF Gain Application Guidelines (ATTEN=10 dB)

Power into A4J3	Reference Level	Gain of A4U201C (Pin 8 in; Pin 3 out)	Gain of A4U201E (Pin 3 in; Pin 10 out)	Total Gain
+6 dBm	-50 dBm	0 dB	0 dB	0 dB
-4 dBm	-60 dBm	0 dB	10 dB	10 dB
-14dBm	-70 dBm	0 dB	20 dB	20 dB
-24 dBm	-80 dBm	20 dB	10 dB	30 dB
-34 dBm	-90 dBm	20 dB	20 dB	40 dB

Total gain can be measured by injecting the specified power into A4J3 and measuring the total gain provided by A4U201C and A4U201E. The following procedure provides a means of troubleshooting the linear amplifiers.

- On the spectrum analyzer, press **PRESET**, **SPAN**, **ZERO SPAN**, **CAL**, **IF ADJ OFF**, **FREQUENCY**, 1 **GHz**, **AMPLITUDE**, -50 dBm, **LINEAR**, **MORE**, **AMPTD UNITS**, **dBm**, and **AMPLITUDE**.
- Disconnect W27 (coax 3) from A4J3 and connect the output of a signal generator to A4J3.
- Set the signal generator controls as follows:

Amplitude		+6 dBm
Frequency		10.7 MHz
- Simultaneously decrease the signal generator output and spectrum analyzer REF LVL in 10 dB steps to -90 dBm. At each step, the signal displayed on the spectrum analyzer should be within one division of the previous position.
- If a problem exists, isolate it by comparing the actual gain of A4U201C and A4U201E with those listed in the above gain guidelines.
- Reconnect W27 (coax 3) to A4J3.

Video Offset

Refer to function block P of A4 log amplifier schematic diagram (sheet 3 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The circuit provides a programmable video offset, with a step size of 5 mV, from -300 mV to +900 mV.

1. On the spectrum analyzer, press **PRESET**, **SPAN**, **ZERO SPAN**, **FREQUENCY**, 1 **GHz**, **AMPLITUDE**, -50 dBm, **CAL**, **IF ADJ OFF**.
2. Disconnect W27 (coax 3) from A4J3 and connect a signal generator to A4J3.
3. Set the signal generator controls as follows:
Amplitude +10 dBm
Frequency 10.7 MHz
4. Simultaneously decrease the signal generator output and spectrum analyzer reference level in 10 dB steps down to -110 dBm. At each step, the signal displayed on the spectrum analyzer should be close to the reference level.
5. Reconnect W27 (coax 3) to A4J3 and cycle the spectrum analyzer power. Press **STOP REALIGN** when it appears.
6. On the spectrum analyzer, press **SWEEP**, **SINGLE**, **CAL**, and **IF ADJ OFF**.
7. The offset DAC, A4U102 pin 2, should now be at its default value of approximately +2.45 V. The voltage at U601 pin 3 should be approximately 0 V for a DAC output of 2.45 V.
8. If this default offset voltage is incorrect, DAC U102 is the most probable cause.

Video Output

1. On the spectrum analyzer, press **PRESET**, **FREQUENCY**, 300 **MHz**, **SPAN**, 100 **Hz**, **AMPLITUDE**, -10 dBm, **SGL SWP**, **CAL** and **IF ADJ OFF**.
2. Connect the CAL OUTPUT to the INPUT 50 Ω connector.
3. Disconnect W54 (coax 2) from A4J4. Connect a short SMB to SMB cable from A4J4 to an SMB tee and connect W54 to the tee. Connect a test cable from the tee to the input of an oscilloscope.
4. Set the oscilloscope controls as follows:
Amplitude scale 200 mV/div
Offset +400 mV
Coupling dc
Sweep time 50 μ s/div
5. The oscilloscope should display a 4.8 kHz sine wave.
6. Disconnect the cable from the CAL OUTPUT and the INPUT 50 Ω connectors.
7. Set the resolution bandwidth to 2 MHz.
8. Broadband noise should be displayed on the oscilloscope from approximately +200 mV to +400 mV.

9. As the **REF LVL** is decreased in 10 dB steps from -10 dBm to -70 dBm, the noise displayed on the oscilloscope should increase in 100 mV increments. If this response is not observed, refer to "Step Gains" and "Video Offset" in this chapter.
10. Reconnect cable W54 to A4J4.

Frequency Counter Prescaler/Conditioner

Refer to function block Q of A4 log amplifier schematic diagram (sheet 4 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The frequency counter prescaler/conditioner divides the frequency by two, and then attenuates it. The circuit consists of frequency divider (U703A) and an output attenuator. The frequency divider turns on only when the instrument is counting.

AM/FM Demodulator

Refer to function block R of A4 Log Amplifier Schematic Diagram (sheet 4 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The demodulator circuitry on the log amplifier on A4 produces a low-level audio signal. This audio signal is then amplified by the audio amplifier on A4. The FM demodulator demodulates narrowband FM (5 kHz deviation) signals. The detector demodulates AM signals.

1. If demodulation problems occur when the spectrum analyzer is in the frequency domain, perform the Frequency Span Accuracy performance test and, if necessary, the YTO Adjustments procedure.
2. If an FM signal cannot be demodulated, perform the Demodulator Adjustment procedure. If the output of A4C707 cannot be adjusted as described in the Demodulator Adjustment procedure, troubleshoot the FM Demodulator or Audio MUX circuits on A4.

4.8 kHz IF Filters

Refer to function block N of A4 Log Amplifier Schematic Diagram (sheet 3 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

Problems with the 4.8 kHz filters can result in spurious signals appearing 2.88 kHz to 3.52 kHz above the frequency of the desired response. Also, **ERR 536 RBW <300** may occur when problems exist with the 4.8 kHz IF filters.

Measure the passband of the 4.8 kHz IF Filters as described in the following procedure.

1. On the spectrum analyzer, press **CAL**, **IF ADJ OFF**, **SPAN**, and 600 **Hz**.
2. Disconnect W27 from A4J3 and inject a 10.7 MHz signal of -20 dBm into A4J3.
3. Fine-tune the frequency of the signal generator to center the signal on the screen. Set the signal generator to sweep one 2 kHz span about this center frequency. Press **SGL SWP** on the HP 8563E.
4. Set another spectrum analyzer, such as the HP 8566A/B, to 4.8 kHz center frequency and 2 kHz span.

Caution If a dc block is not used, damage to the HP 8566A/B results. The HP 8566A/B and many other spectrum analyzers have dc-coupled inputs and cannot tolerate dc voltages on their inputs.

5. Connect the VIDEO OUTPUT (rear panel) of the spectrum analyzer through a 20 dB attenuator and dc block to the input of the HP 8566A/B. Set the sweep time of the HP 8566A/B to 10 seconds.
6. Set the HP 8566A/B to single trigger and press TRACE A **CLEAR-WRITE**. Trigger a sweep of the HP 8566A/B and the signal generator simultaneously. The HP 8566A/B shows the passband of the 4.8 kHz IF filters. The 3 dB bandwidth of the filters should be 1.2 kHz. The passband of the filters should be flat within 2 dB over 800 Hz.
7. Reconnect W27 (coax 3) to A4J3.

10.7 MHz IF Filters

1. Press **PRESET**, **FREQUENCY**, 300 **MHz**, **SPAN**, 600 **Hz**, **CAL**, and **IF ADJ OFF**.
2. Disconnect W29 (coax 7) from A5J3. Set the signal generator for a 10.7 MHz signal at -50 dBm and connect it to A5J3.
3. Fine tune the frequency of the signal generator to center the signal on the HP 8560E display. Set the signal generator to sweep one 2 kHz span about this center frequency.
4. On the HP 8560E, press **SGL SWP**.
5. Disconnect W27 (coax 3) from A5J5. Connect a test cable from A5J5 to the input of an HP 8566A/B.
6. Set the HP 8566A/B as follows:

Center frequency	10.7 MHz
Span	2 kHz
Reference level	+10 dBm
Sweep	Single
7. Press TRACE A **CLEAR-WRITE** on the HP 8566A/B.
8. Trigger a sweep on the signal generator and on the HP 8566A/B simultaneously. The HP 8566A/B should display a 3 dB bandwidth of approximately 500 Hz.
9. Reconnect W27 (coax 3) to A5J5 and W29 (coax 7) to A5J3.

4.8 kHz and 10.7 MHz IF Filters

1. On the HP 8560E, press **PRESET**, **FREQUENCY**, 300 **MHz**, **SPAN**, 600 **Hz**, **CAL**, and **IF ADJ OFF**.
2. Disconnect W29 (coax 7) from A5J3. Set the signal generator for a 10.7 MHz signal at -60 dBm and connect it to A5J3.
3. Fine tune the frequency of the signal generator to center the signal on the HP 8560E display. Set the signal generator to sweep one 2 kHz span about this center frequency.
4. On the HP 8560E, press **SGL SWP**.
5. Set the HP 8566A/B to 4.8 kHz center frequency and 2 kHz span.

Caution Damage to the HP 8566A/B results if a dc block is not used. The HP 8566A/B and many other spectrum analyzers have dc-coupled inputs and cannot tolerate dc voltages on their inputs.

6. Connect the VIDEO OUTPUT (rear panel) of the spectrum analyzer through a 20 dB attenuator and dc block to the input of the HP 8566A/B. Set the sweep time of the HP 8566A/B to 10 seconds.
7. Set the HP 8566A/B to single trigger and press TRACE A **CLEAR-WRITE**. Trigger a sweep on the HP 8566A/B and on the signal generator simultaneously. The HP 8566A/B should show a 3 dB bandwidth of 600 Hz $\pm$ 100 Hz.
8. Reconnect W29 (coax 7) to A5J3.

10.6952 MHz VCXO

Refer to function block E of A4 log amplifier schematic diagram (sheet 2 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The purpose of the 10.6952 MHz voltage-controlled crystal oscillator (VCXO) is to provide an LO for down-converting the peak of the 10.7 MHz IF filter's passband to 4.8 kHz. Since the peak of the passband of the 10.7 MHz IF filters is 10.7 MHz $\pm$ 300 Hz, the frequency of the VCXO is between 10.6949 MHz and 10.6955 MHz. This frequency can best be measured at the collector of A4Q202.

The center frequency of the 300 Hz resolution-bandwidth filters and the 1 Hz to 100 Hz filters should differ no more than 10 Hz. If the center frequency is different by more than this, or if no signal is present in the 1 Hz to 100 Hz resolution-bandwidth settings, troubleshoot the 10.6952 MHz VCXO.

Error message **ERR 539** may occur if the VCXO is not oscillating. If problems exist with the VCXO control voltage, error messages **ERR 536** or **ERR 530** may occur.

Between sweeps the VCXO, at times, is turned off. To prevent the oscillator from turning off, press **PRESET**, **FREQUENCY**, 0.3 **GHz**, **SPAN**, 1 **kHz**, **SGL SWP**, **CAL**, and **IF ADJ OFF**.

Input Switch

Refer to function block D of A4 Log Amplifier Schematic Diagram (sheet 2 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The input switch switches between log and linear modes. In addition it contains a 20 dB attenuator which is used only in digital resolution bandwidth settings. CR207, CR208, and CR209 form the input switch. CR205 and CR206 switch in R234 when in linear mode to maintain a constant impedance at J3. CR210, CR211, CR212, and CR221 switch the 20 dB attenuator in and out.

LO Switch

Refer to function block F of A4 Log Amplifier Schematic Diagram (sheet 2 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The LO switch switches the limiter input between the 10.7 MHz path or the 10.6952 MHz VCXO path.

Synchronous Detector

A wide dynamic range linear detector is realized by the limiter (block G), the isolation amplifier (block H), the LO amplifier (block I), and the detector/mixer (block J). The combination of these circuits form what is commonly known as a synchronous detector.

The input signal is split between two paths. One path flows through the isolation amplifier and the other path flows through the limiter and LO amplifier. The path flowing through the limiter generates the LO for the detector/mixer block. The path through the isolation amplifier drives the RF port.

To troubleshoot this group of circuits set the RBW to 300 kHz. Inject 10.7 MHz at +6 dBm into J3. Probe the gate of A4Q404 or A4Q405 with a scope. Look for a 0 to -3 V square wave. Decrease the input power from +6 dBm to -84 dBm in 10 dB steps. The square wave signal should remain unchanged. It is normal for the phase of the signal to jitter at the lowest signal levels.

The signals at the gates of A4Q404 and A4Q405 should be 180 degrees out of phase from each other. If they are not 180 degrees out of phase or one of the signals are not present, troubleshoot the LO Amplifier or the FET's in the mixer. If the signal is not a symmetrical square wave, troubleshoot the LO amplifier. If the signal drops out prematurely or is not present at all, troubleshoot the limiter or LO amplifier.

Repeat the procedure for an $\text{RBW} \leq 100 \text{ kHz}$. If the log amplifier works in the 300 kHz RBW but not in the narrower RBWs, troubleshoot the log narrow filter in the limiter or isolation amplifier. A4CR302 and A4CR303 are varactor diodes in the limiter filter and are used to tune the filter.

Limiter

Refer to function block G of A4 Log Amplifier Schematic Diagram (sheet 2 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The limiter consists of 7 identical 20 dB gain stages. A “log narrow filter” is switched in for RBWs ≤ 100 kHz. This filter is switched in using the control lines NARROW between the 4th and 5th stages. During normal operation, the limiter serves to amplify even the smallest 10.7 MHz signals up to a level sufficient to drive the LO Amplifier and subsequent detector/mixer. This signal serves as the LO for the mixer circuitry.

Isolation Amplifier

Refer to function block H of A4 Log Amplifier Schematic Diagram (sheet 3 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The isolation amplifier prevents LO port to RF port feedthrough in the mixer from feeding back to the input of the limiter and causing loop oscillations. In addition, the isolation amplifier matches the phase of the non-limited signal path to the phase of the limited signal path. The isolation amplifier should have a gain of about 4 dB and also has a “log narrow filter” that is switched with the control line NARROWB.

Detector/Mixer

Refer to function block J of A4 Log Amplifier Schematic Diagram (sheet 3 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

Sum and difference frequencies are produced in the Detector/Mixer. The difference frequency produces video (dc to approximately 3 MHz), since the two signals are at the same frequency. During digital resolution bandwidths the two signals are separated by about 4.8 kHz.

Log Offset/Gain Compensation

Refer to function blocks L and M of A4 Log Amplifier Schematic Diagram (sheet 3 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

Log Offset Compensation

The gain of A4U503 is set to unity, with A4R539 and A4R540 combining for a gain of 0.5. Therefore, the gain from A4U503 pin 3 to A4U508 pin 3 should be 0.5.

Log Gain Compensation

The gain of A4U508 is nominally 6.8, measuring from pin 3 to pin 8. To check the log offset/gain compensation circuits inject a +10 dBm signal into J3 with the spectrum analyzer set to log mode. Measure A4U503 pin 3, $V_{in}(1)$ and A4U508 pin 3, $V_{out}(1)$ and record the results. Decrease the input level to -40 dBm and make the same measurements recording $V_{in}(2)$ and $V_{out}(2)$.

The gain is then:

$$\frac{(V_{out}(1) - V_{out}(2))}{(V_{in}(1) - V_{in}(2))}$$

This gives an offset-independent gain measurement.

Video MUX

The video MUX switches the video output between linear, log and 4.8 kHz IF (for digital RBWs). The demod video is an unused feature. The easiest way to troubleshoot this circuit is to look for blown FETs. Bad FETs are characterized by having significant gate current. Only one of the signal lines LIN_VIDEO, IF_VIDEO or LOG_VIDEO should be high (+15 V) at any given time. The others should be low (-15 V). Also look for a voltage drop of several volts across the gate resistors R601, R605, R609, or R613 when in either the off or on state. This indicates gate current and thus a bad FET.

A5 IF Assembly

The input switch connects the IF to either the cal oscillator on the A4 assembly or the 10.7 MHz IF output from the A15 RF assembly. The automatic IF adjustment uses the cal oscillator on A4 at instrument turn-on and between sweeps to align the IF filters and step-gain amplifiers. During sweeps the input switch selects the 10.7 MHz IF output from A15. The LC filters are variable-bandwidth filters that provide resolution bandwidths from 30 kHz to 2 MHz. The automatic IF adjustment sets the bandwidths and center frequencies of each filter stage.

The crystal filters are variable-bandwidth filters that provide resolution bandwidths from 300 Hz to 10 kHz. The automatic IF adjustment sets the filter bandwidths and symmetry.

The step-gain amplifiers consist of the first step-gain stage, second step-gain stage, and third step-gain stage. These amplifiers provide gain when the spectrum analyzer reference level is changed. The amplifiers also provide gain range to compensate for variations in the IF filter gains, which change with bandwidth and environmental conditions, and band conversion loss in the front end. Fixed-gain amplifiers shift the signal levels to lower the noise of the IF chain.

The assembly has two variable attenuators. The fine attenuator provides the 0.1 dB reference level steps. The reference 15 dB attenuator provides a reference for automatic adjustment of the step-gain amplifiers and the log amplifier. The reference 15 dB attenuator also provides gain for changes in spectrum analyzer reference level.

Various buffer amplifiers provide a high-input impedance to prevent loading of the previous filter pole and a low-output impedance to drive the next filter pole.

Digital control signals from the W2 control cable, the “analog bus,” drive the control circuitry. At the beginning of each sweep the analog bus sets each control line for instrument operation. At the end of each sweep the analog bus sets each control line for the next portion of the automatic IF adjustment routine. IF adjustments continuously remove the effects of component drift as the spectrum analyzer temperature changes.

The assembly contains a reference limiting amplifier. This amplifier provides a known amount of limiting for the automatic IF adjustment routines. (Limiting occurs only during the automatic IF adjustment routines.) The LC34_Short switches are open during sweeps. The current in the reference limiter is increased during sweeps to prevent limiting.

Caution	For troubleshooting, it is recommended that you use an active probe, such as an HP 85024A, and another spectrum analyzer. If an HP 1120A active probe is being used with a spectrum analyzer having dc-coupled inputs, such as the HP 8566A/B, HP 8569A/B and the HP 8562A/B, either set the active probe for an ac-coupled output or use a dc-blocking capacitor between the active probe and the spectrum analyzer input.
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Caution	■ Do not short control voltages to ground. These voltages are not short-circuit protected. DACs damaged by shorting these voltages might not fail until several weeks after the shorting takes place. ■ Do not short power-supply voltages to ground. The spectrum analyzer power-supply current limiting cannot protect the resistors in series with the power supply.
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Note Some transistors have collectors connected to the case. Electrical connection of the case to the collector might not be reliable, making collector voltage measurements on the transistor case unreliable.

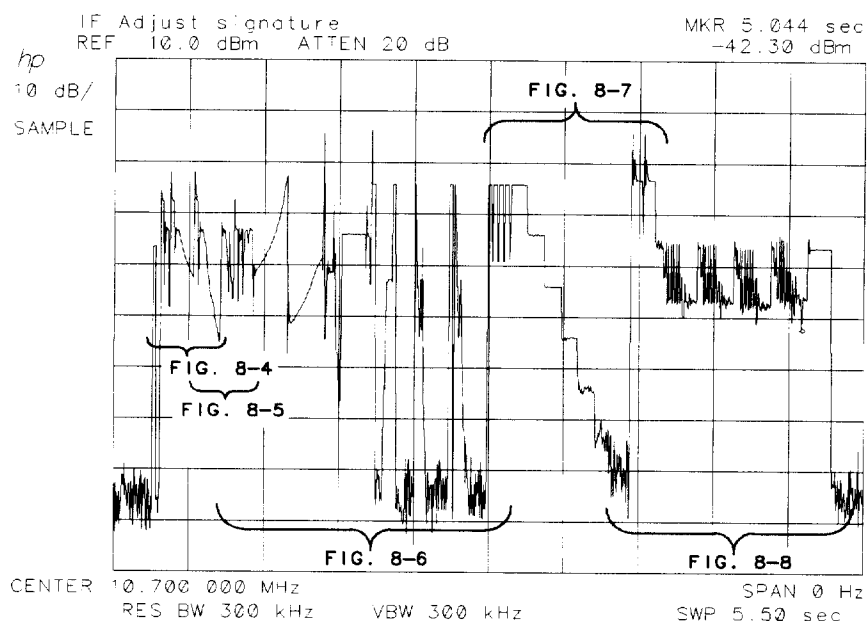
IF Signature

1. Disconnect W27 (coax 3) from A5J5.
2. Connect an SMB tee to A5J5, using a short coaxial cable with SMB connectors.
3. Connect one output of the tee to cable W27 (coax 3).
4. Connect an HP 85024A active probe, with a 10:1 divider installed, to the other output of the tee.
5. Connect the output (type N connector) of the active probe to the input of the HP 8566A/B spectrum analyzer.
6. Connect the probe power cable to the HP 8560E front-panel PROBE POWER connector (you may need to use a probe power extension cable, HP 10131B).
7. Set the HP 8566A/B controls as follows:

Reference level	+10 dBm
Center frequency	10.7 MHz
Span	0 Hz
Resolution bandwidth	300 kHz
Video bandwidth	300 kHz
Sweep time	5.5 s
Trigger	Single
8. On the HP 8566A/B, press **SHIFT**, (trace A blank) to set detector to SAMPLE mode.
9. On the HP 8560E, press **PRESET** and set the controls as follows:

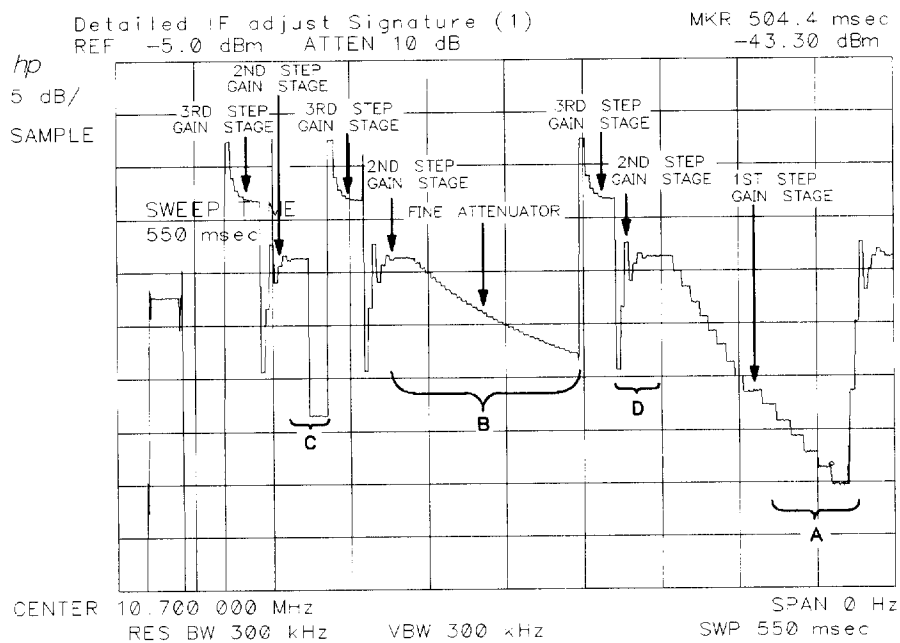
Center frequency	300 MHz
Span	5 MHz
10. On the HP 8560E, press **SGL SWP** and **CAL**.
11. Simultaneously press **SINGLE** on the HP 8566A/B and **ADJ CURR IF STATE** on the HP 8560E. The IF signature is displayed on the HP 8566A/B display. It may be necessary to experiment with different time intervals between initiating the sweep on the HP 8566A/B and initiating the current IF state adjustment on the HP 8560E.

12. Compare the IF signature to the signature of a properly operating spectrum analyzer illustrated in Figure 8-3. If the signatures do not closely resemble each other, a more detailed view of the signature may show the failed hardware.
 - a. Set the HP 8566A/B controls as follows:
 - Sweep time 550 ms
 - dB/DIV 5 dB
 - Reference level -5 dBm
 - b. Press **SINGLE** on the HP 8566A/B and, a very short time later, press **ADJ CURR IF STATE** on HP 8560E. Figure 8-4 through Figure 8-8 illustrate detailed IF signatures of a properly operating HP 8560E. It may be necessary to experiment with different time intervals between initiating the sweep on the HP 8566A/B and initiating the current IF state adjustment on the HP 8560E to obtain the waveforms shown. Note the changes in the HP 8566A/B video bandwidth and sweep time.
13. Reconnect W27 (coax 3) to A5J5.



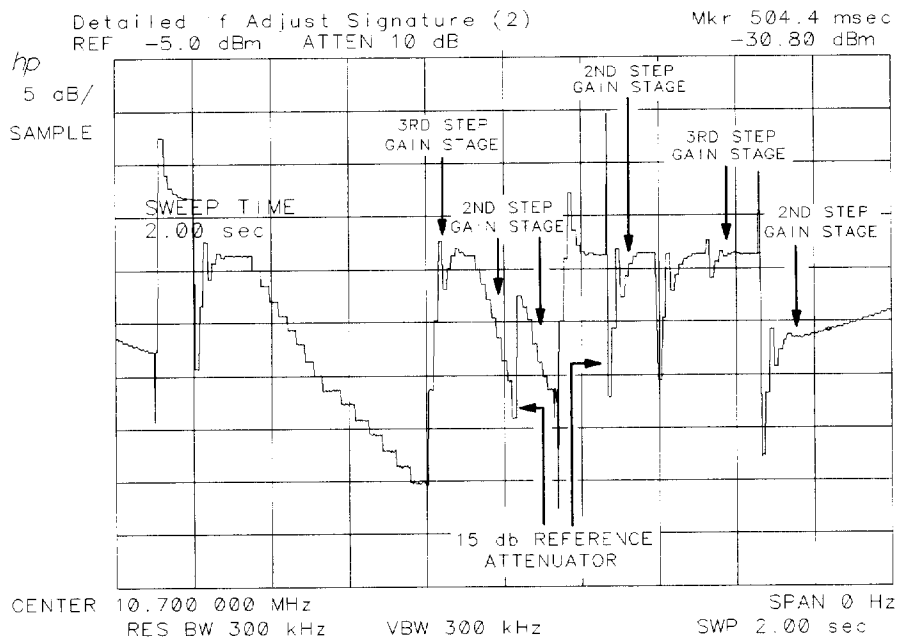
sp143e

Figure 8-3. IF Adjust Signature



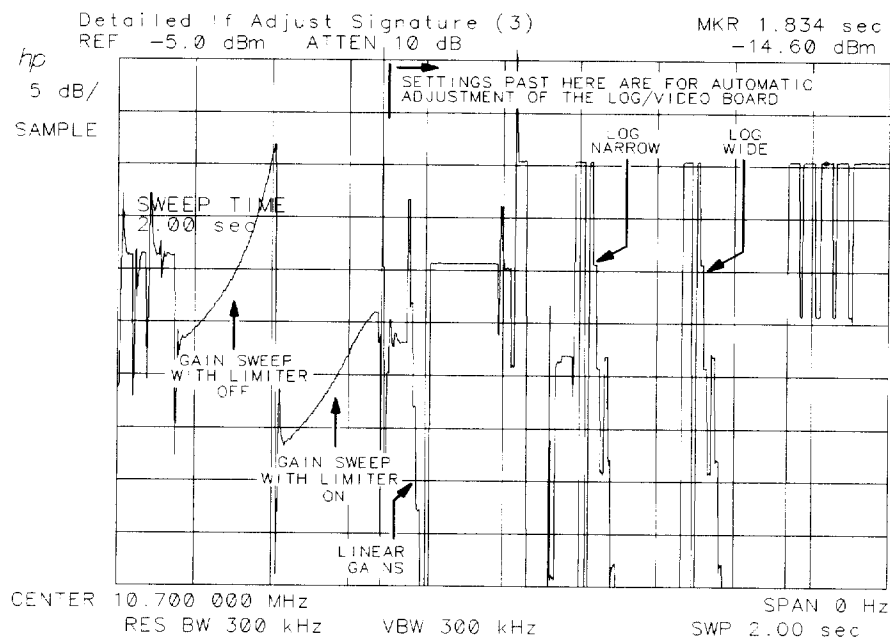
sp144e

Figure 8-4. Detailed IF Adjust Signature (1)



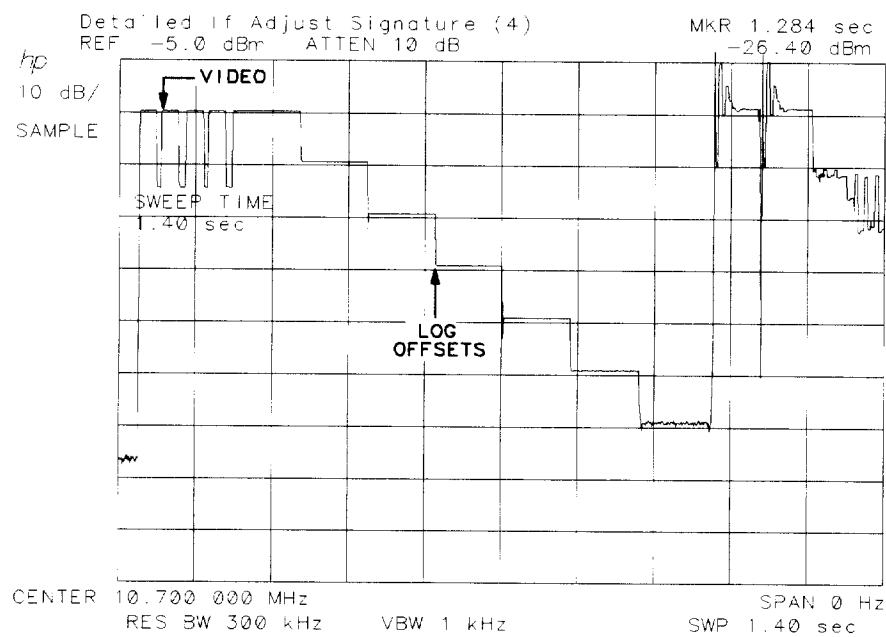
sp145e

Figure 8-5. Detailed IF Adjust Signature (2)



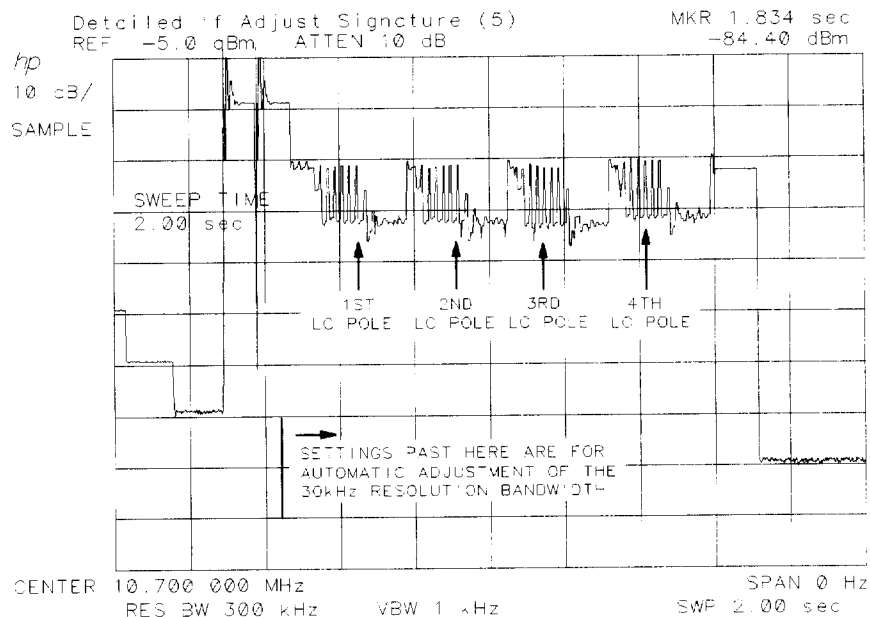
sp146e

Figure 8-6. Detailed IF Adjust Signature (3)



sp147e

Figure 8-7. Detailed IF Adjust Signature (4)



sp1489

Figure 8-8. Detailed IF Adjust Signature (5)

Common IF Signature Problems

Region A of Figure 8-4 is noisy:

Suspect the first LC pole.

Region B of Figure 8-4 is flat:

Suspect the third step-gain stage, the fine attenuator, or the fourth LC-pole output amplifier.

Region C of Figure 8-4 has no 15 dB step:

Suspect the reference 15 dB attenuator.

Region D of Figure 8-4 is flat:

Suspect the second step-gain stage.

Entire signature noisy:

If the signature resembles Figure 8-9, suspect a broken first step-gain stage or a break in the signal path in the input switch, first crystal pole, or second crystal pole.

Correct shape but noisy:

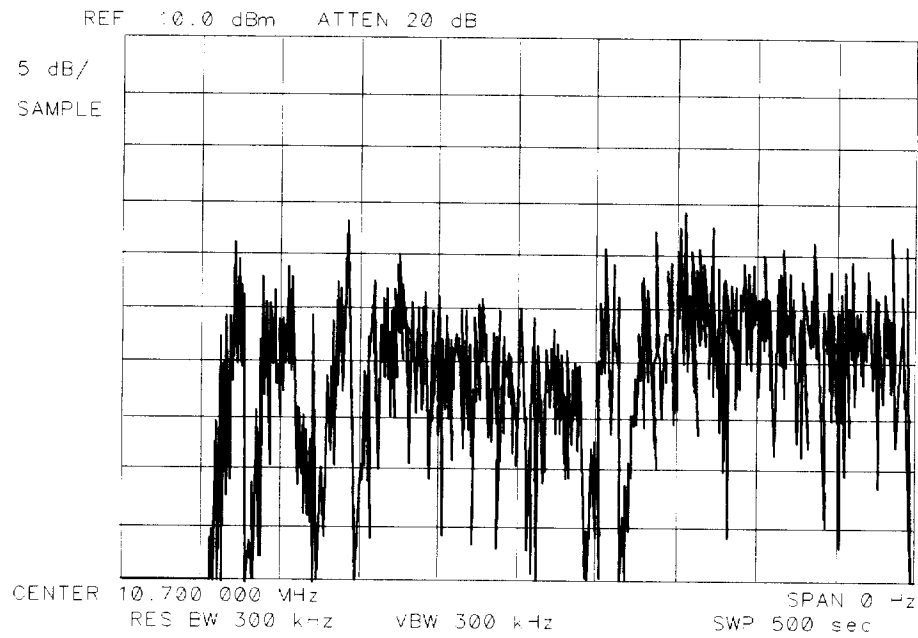
If the signature resembles Figure 8-10, suspect the second crystal-pole output amplifier.

Amplitude of Region B of Figure 8-11 varies more than 12 dB:

Suspect the third step-gain stage output amplifier.

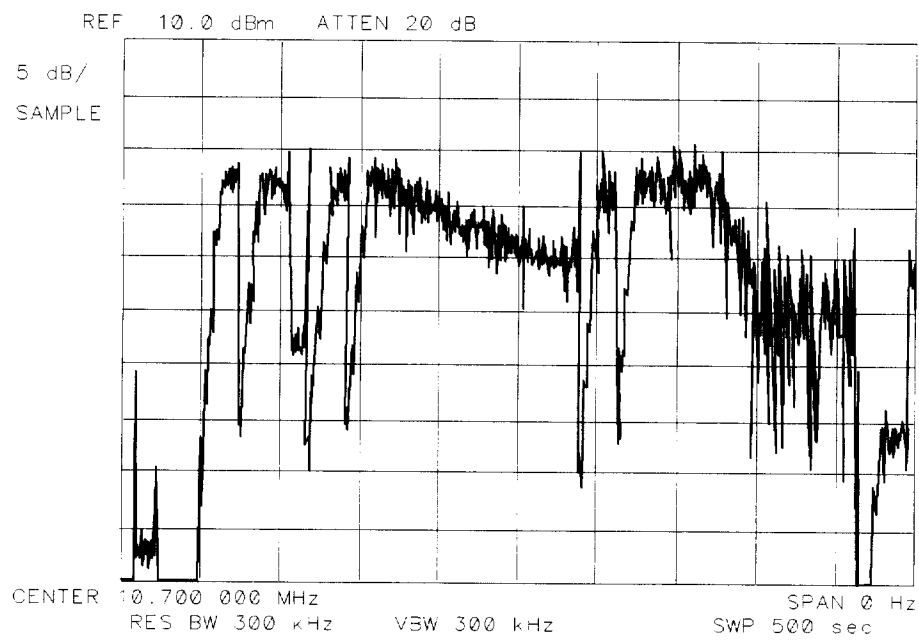
Region B of Figure 8-12 is kinked:

Suspect the fourth LC-pole output amplifier.



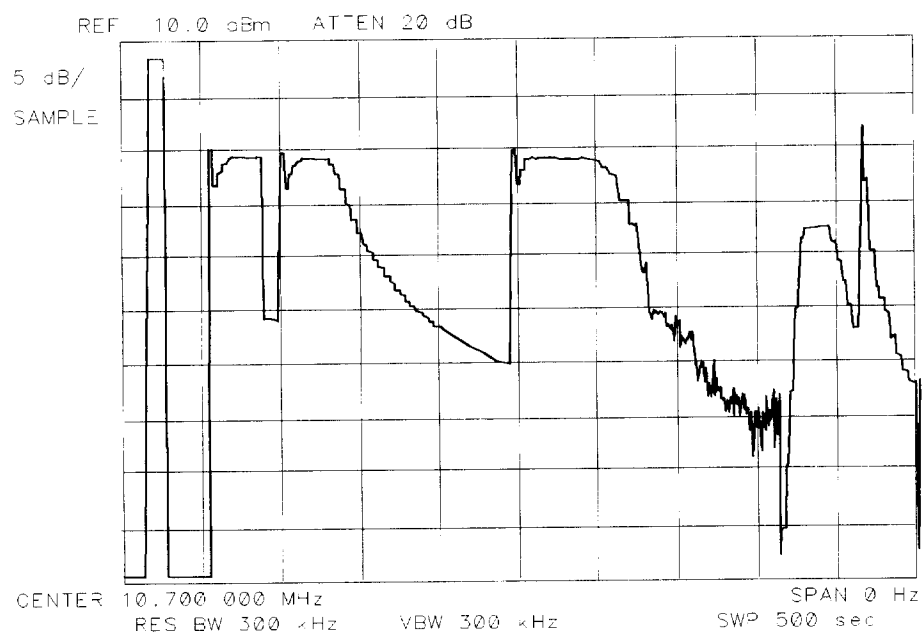
SK178

Figure 8-9. Noisy Signature



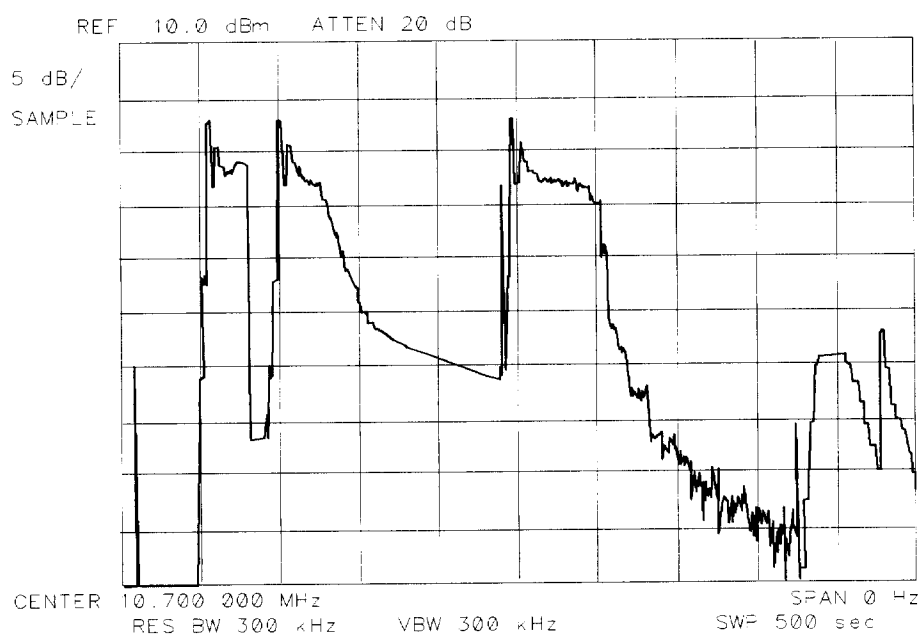
SK179

Figure 8-10. Noise with Correct Shape



SK180

Figure 8-11. Region B Amplitude Variation



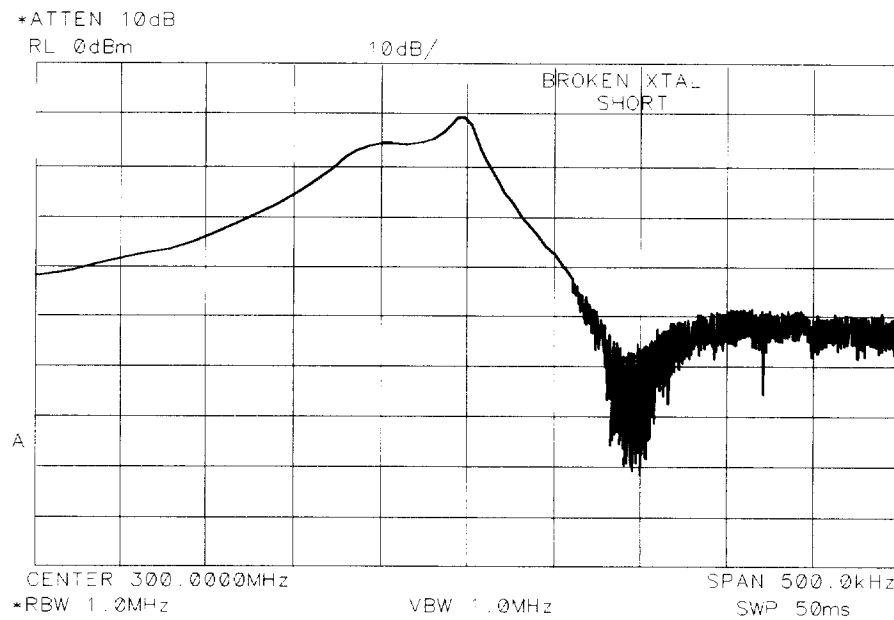
SK181

Figure 8-12. Region B Amplitude Offset

1 MHz Resolution Bandwidth Problems

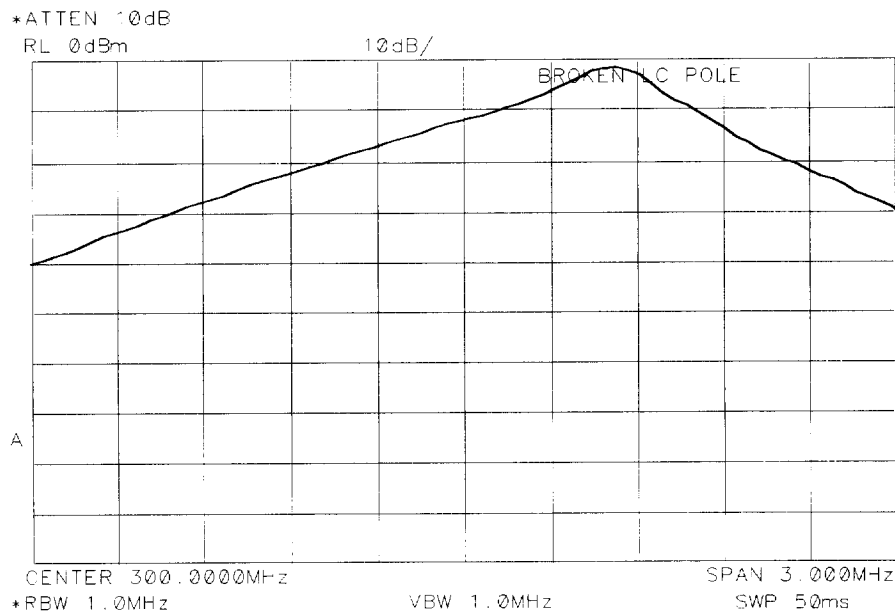
Check the crystal shorting switches as follows:

1. On the spectrum analyzer, press **PRESET** and set the controls as follows:
Resolution bandwidth 1 MHz
Span 500 kHz
Center frequency 300 MHz
2. On the spectrum analyzer, connect the 300 MHz CAL OUTPUT to the INPUT 50Ω.
3. If the trace flatness is not within 2.5 dB, a failure probably exists.
4. A trace similar to Figure 8-13 indicates a crystal short failure.
5. Press **SPAN** to set the spectrum analyzer to 3 MHz. A trace that slopes across the screen (see Figure 8-14) indicates a failed LC pole. To isolate the broken pole refer to the shape factor information in "30 kHz Resolution Bandwidth Problems."



SK 182

Figure 8-13. Faulty Crystal Short



SK183

Figure 8-14. Faulty LC Pole

30 kHz Resolution Bandwidth Problems

Shape factor too high: Shape factor is the ratio of the 60 dB bandwidth to the 3 dB bandwidth. Shape factor should be less than 15:1. If one of the LC poles malfunctions, the shape factor may be the only indication of the failure. Isolate the non-functioning pole with the IF signature. Region E of Figure 8-8 illustrates the four LC-pole adjustments. Take several signatures to examine the LC-pole adjustments. If one of the four sections of Region E is consistently longer than the others, the corresponding LC pole is faulty.

IF gain compression: FET transistors Q301, Q303, Q700, and Q701 can deteriorate with age. Measuring less than 0 volts on the FET source indicates a bad FET.

Bandwidth too wide: Check for contamination on the printed-circuit board. Clean the board as required.

3 kHz and 10 kHz Resolution Bandwidth Problems

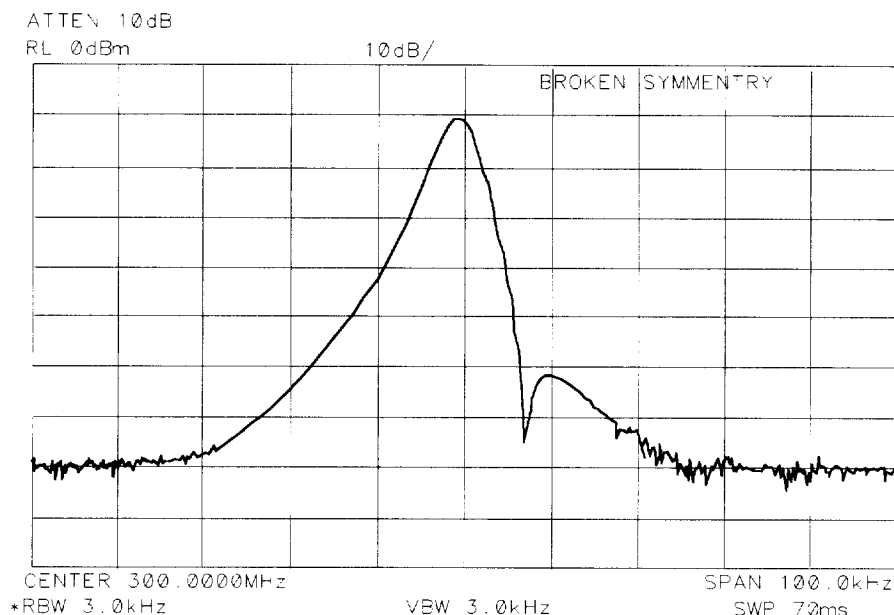
Asymmetric Filter Response: Check the crystal symmetry control with the following steps.

1. Press **PRESET**.
2. Set the spectrum analyzer controls as follows:

Resolution bandwidth		3 kHz
Span		100 kHz
Center frequency		300 MHz
3. On the spectrum analyzer, connect the 300 MHz CAL OUTPUT to the INPUT 50Ω.
4. A trace similar to Figure 8-15 indicates a failed crystal-symmetry circuit.

Narrow 10 kHz resolution bandwidth: Check for printed-circuit board contamination. Clean the board as required.

IF Gain Compression in 10 kHz resolution bandwidth: FET transistors Q202, Q203, Q501, and Q503 can deteriorate with age. Measuring less than 0 volts on the FET source indicates a bad FET.



SK184

Figure 8-15. Faulty Crystal Symmetry

Step Gains

Refer to function blocks B, H, and I of A5 IF filter schematic diagram (sheets 1 of 3 and 2 of 3) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

1. On the spectrum analyzer, press **PRESET**, **SPAN**, **ZERO SPAN**, **FREQUENCY**, and 1 **GHz**.
2. Press **CAL** and **IF ADJ OFF**.
3. Disconnect W29 (coax 7) from A5J3 and W27 (coax 3) from A5J5.
4. Inject a -5 dBm, 10.7 MHz signal into A5J3.
5. Monitor the output of A5J5 with another spectrum analyzer.
6. Simultaneously decrease the signal generator output and spectrum analyzer reference level in 10 dB steps down to a -50 dBm reference level.
7. At each step, the signal displayed on the other spectrum analyzer should be close to +10 dBm. (More subtle IF gain problems might require smaller signal generator and reference level steps.)
8. Reconnect W29 to A5J3 and W27 (coax 3) to A5J5.

Cal Oscillator Assembly (P/O A4)

The cal oscillator on the A4 assembly supplies the stimulus signal for automatic IF adjustments. Normally, the oscillator operates only during retrace (for a few milliseconds) to adjust part of the IF. (All IF parameters are to be readjusted about every 5 minutes.) With continuous IF adjust ON, a group of IF parameters are adjusted during each retrace period (non-disruptive). If continuous IF adjust is OFF, the most recent IF calibration data is used.

The IF parameters adjusted include step gains, log amplifier gain and offset, bandwidth centering, 3 dB bandwidth, bandwidth amplitude, and crystal-filter symmetry.

The cal oscillator provides three types of output signals (all -35 dBm):

- 10.7 MHz
- 9.9 to 11.5 MHz in 100 kHz steps
- Frequency sweeps from 20 kHz to 2 kHz centered at 10.7 MHz (lasting 5 to 60 ms respectively)

The signals perform the following functions:

- Adjust gains, log amps, and video slopes and offsets.
- Adjust 3 dB bandwidth and center frequencies of LC resolution bandwidth filters (30 kHz through 1 MHz).
- Adjust 3 dB bandwidth, symmetry, and gain of the crystal resolution bandwidth filters (300 Hz through 10 kHz).

The cal oscillator uses a phase-locked loop (PLL). The oscillator (function block X) is locked to the instrument 10 MHz reference. The reference divider (function block U) divides the reference and delivers a 100 kHz TTL signal to the phase detector (function block V). The divide-by-N circuitry (function block Y) divides the oscillator output of 9.9 MHz to 11.5 MHz (by 99 to 115) resulting in a 100 kHz output to the phase detector. When the cal-oscillator PLL is locked, narrow positive and negative of equal width pulses occur at the phase detector output. Since the phase detector drives a low-input impedance at the loop integrator, observe the positive pulses at A4CR808 anode and negative pulses at A4CR809 cathode.

The loop integrator acts as a low-pass filter that filters the pulses and inverts the result. If the anode of A4CR808 is more positive (with respect to ground) than the cathode of A4CR809 is negative, the loop integrator output should saturate to approximately -13 V. Conversely, if the anode of A4CR808 is less positive than the cathode of A4CR809 is negative, the integrator should saturate to a positive voltage.

Note	If error messages ERR 581 AMPL or ERR 582 AMPL appears, refer to error message ERR 582 AMPL in Chapter 6 and perform the procedure provided.
-------------	---

1. The oscillator output frequency should exceed 11.5 MHz if the CAL OSC TUNE line, A4U804 pin 14, exceeds $+9$ V. The oscillator frequency should be less than 9.9 MHz if CAL OSC TUNE is below -9 V. The oscillator only operates when CALOSC_OFF is low (0 V).
2. If the cal oscillator remains locked (no error code **ERR 499** displayed) but does not have the correct output level, troubleshoot the output leveling circuitry (function blocks AA, AB, and AC) or output attenuator (function block AD).

Cal Oscillator Unlock at Beginning of IF Adjust

1. Press **LINE** to turn the spectrum analyzer off and then on. The words **IF ADJUST STATUS** appear on the display 10 seconds after the instrument is turned on (assuming the rest of the instrument is working correctly). Immediately observe the lower right corner of the display for error messages. If the message **ERR 499 CAL UNLK** appears (before errors **ERR 561**, **ERR 562** and **ERR 565**), the cal oscillator is unable to phase-lock. Expect to see the **ERR 499** message for only about 1 second.
2. If the spectrum analyzer registers an unlocked cal oscillator, continue with step 3 to verify the presence of externally supplied signals.
3. Check A4U811 pin 9 for a 100 kHz TTL-level square wave verifying operation of A4U811, A4Q802, and the 10 MHz input signal from A4J7.
4. Check the +15 VF, +5 VF and -15 V power supplies, and +10 V reference on the A4 assembly.
5. Check that A4U807 pin 5 (CALOSC_OFF) becomes TTL low (0 V) at the start of a **FULL IF ADJ** (press **CAL** and **FULL IF ADJ**). The phase modulation output at A4U804 pin 8 should also remain at 0 volts. If these checks are correct, troubleshoot blocks V, W, X, and Y. See Figure 8-21, A4 Log Amplifier/Cal Oscillator Block Diagram (2 of 2).

Inadequate CAL OSC AMPTD Range

Refer to function block AC of A4 Log Amplifier Schematic Diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

1. If A4R826, CAL OSC AMPTD, has inadequate range to perform the IF Amplitude Adjustment, press **CAL**.
2. Rotate A4R826 fully clockwise and disconnect W52 (coax 9) from A5J4.
3. Connect A5J4 to the input of a second spectrum analyzer.
4. Set the other spectrum analyzer controls as follows:

Center frequency		10.7 MHz
Reference level		-30 dBm
5. Observe the spectrum analyzer display while pressing **FULL IF ADJ**. The signal level should be above -34.55 dBm. If the signal level is incorrect, continue with step 7.
6. Rotate A4R826 fully counterclockwise. The signal should be below -36.25 dBm. If the signal level is correct at both settings, troubleshoot the A5 IF assembly. If the signal level is incorrect, continue with step 7.
7. Troubleshoot the ALC loop on this assembly using the following steps:
 - a. Connect a positive DVM probe to A4J9 pin 4.
 - b. On the spectrum analyzer, press **CAL**.
 - c. Press **FULL IF ADJ**. Observe the DVM reading between the displayed messages **IF ADJUST STATUS: 300 kHz RBW** and **IF ADJUST STATUS: 3 kHz RBW**. During this time period, the voltage should be within a 2 to 10 Vdc range.
 - d. Observe the DVM reading while **IF ADJUST STATUS: AMPLITUDE** is displayed. The reading should be within the 2 to 10 Vdc range.

- e. If the DVM reading is outside the range in step c but inside the range in step d, suspect one of the filter's reactive components.
8. If the ALC loop is working correctly (A4J9 pin 4 within the test tolerances given), then either the output attenuator is defective, or A4U810 pin 6 (in ALC loop integrator) is outside of its +3 to +6 Vdc range.
9. Reconnect W52 (coax 9) to A5J4.

300 Hz to 3 kHz Resolution Bandwidth Out of Specification

1. If the 3 dB bandwidth of one of these filters is incorrect, suspect a failure of one of the five available sweeps from the cal oscillator's sweep generator (function block Z). These sweeps are generated by changing the switch settings of A4U803 which routes signals through A4U802 and A4U804.
2. Disconnect W52 (coax 9) from A4J8.
3. Connect the source connection of a 3 dB power splitter (Minicircuits Model: ZSC J-2-1) to A4J8. Connect one output of the power splitter to the input of an HP 8566A/B spectrum analyzer. Connect the other output of the power splitter to cable W52 (coax 9).

Note If a 3 dB power splitter is not available, an SMB tee and an active probe may be substituted. Connect the active probe between the tee and the other spectrum analyzer. The absolute power levels are approximately 3 dB higher than those stated below, due to the elimination of the 3 dB power splitter.

4. Press **INSTR PRESET** on the HP 8566A/B and set the controls as follows:

Center frequency	10.8 MHz
Span	0 Hz
Reference level	-43 dBm
Resolution bandwidth	100 kHz
Video bandwidth	10 kHz
Sweep time	50 ms
Scale	1 dB/DIV
Sweep	Single
5. On the spectrum analyzer, press **PRESET** and **CAL**.
6. Press **FULL IF ADJ**. When the display reads **ADJUSTING IF: 10 kHz RBW**, press **SINGLE** on the HP 8566A/B.
7. The HP 8566A/B screen illustrates frequency versus time of the cal oscillator's output sweeps. See Figure 8-16. The slope of the HP 8566A/B 100 kHz resolution bandwidth is used to detect frequency changes. Sweeps that vary (greater than 30%) from the normal levels, trigger error code **ERR 581** or **ERR 582**.
8. Press **FULL IF ADJ**. When the display reads **ADJUSTING IF: 3 kHz**, press **SINGLE** on the HP 8566A/B.
9. Figure 8-17 illustrates normal operation. Severe failures (slope error greater than 30 percent) and subtle 3 kHz resolution bandwidth errors (less than 30 percent) indicate a problem with A4U802, A4U803, A4U804, or A4U106.

10. Severe failure of the bandwidth accompanied by subtle errors in the output signal indicate an A5 failure.
11. Set the HP 8566A/B controls as follows:

Center frequency	10.710 MHz
Resolution bandwidth	10 kHz
Video bandwidth	1 kHz
Sweep time	200 ms
12. On the spectrum analyzer, press **FULL IF ADJ.** When the message **IF ADJUST STATUS: 1 kHz RBW** appears, press **(SINGLE)** on the HP 8566A/B.
13. Figure 8-18 illustrates normal operation. Severe failures (slope error greater than 30%) and subtle 3 kHz resolution bandwidth errors (less than 30%) indicate a problem with A4U802, U803, U804, or U106.
14. On the spectrum analyzer, press **FULL IF ADJ.** When the message **IF ADJUST STATUS: 300 Hz RBW** appears, press **(SINGLE)** on the HP 8566A/B.
15. Figure 8-19 illustrates normal operation. Severe failures (slope error >30%) and 3 kHz resolution bandwidth errors (less than 30%) indicate a problem with A4U802, U803, U804, or U106.
16. Reconnect W52 (white) to A4J8.

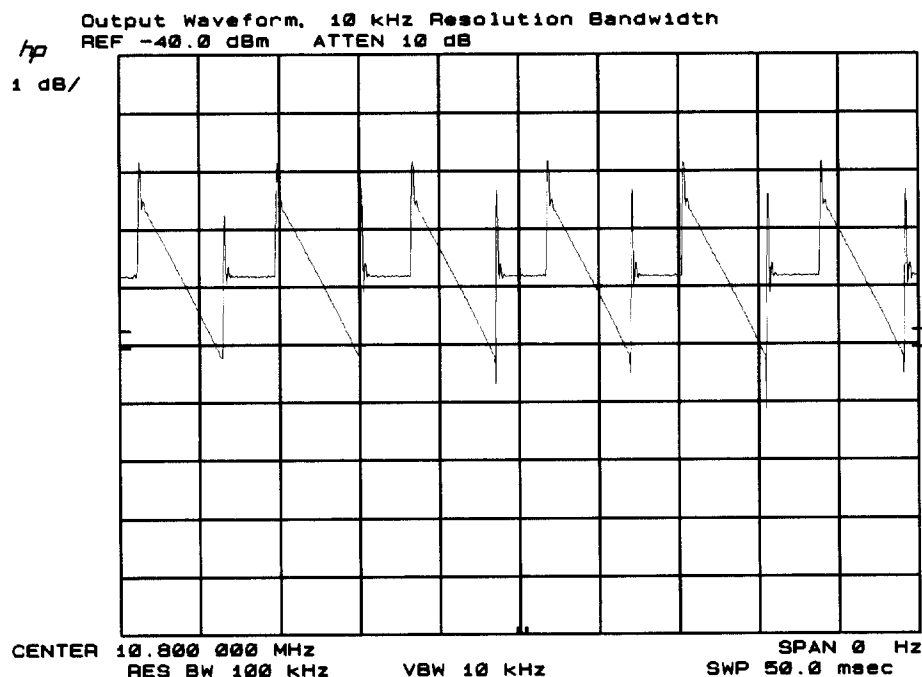


Figure 8-16. Output Waveform, 10 kHz Resolution Bandwidth

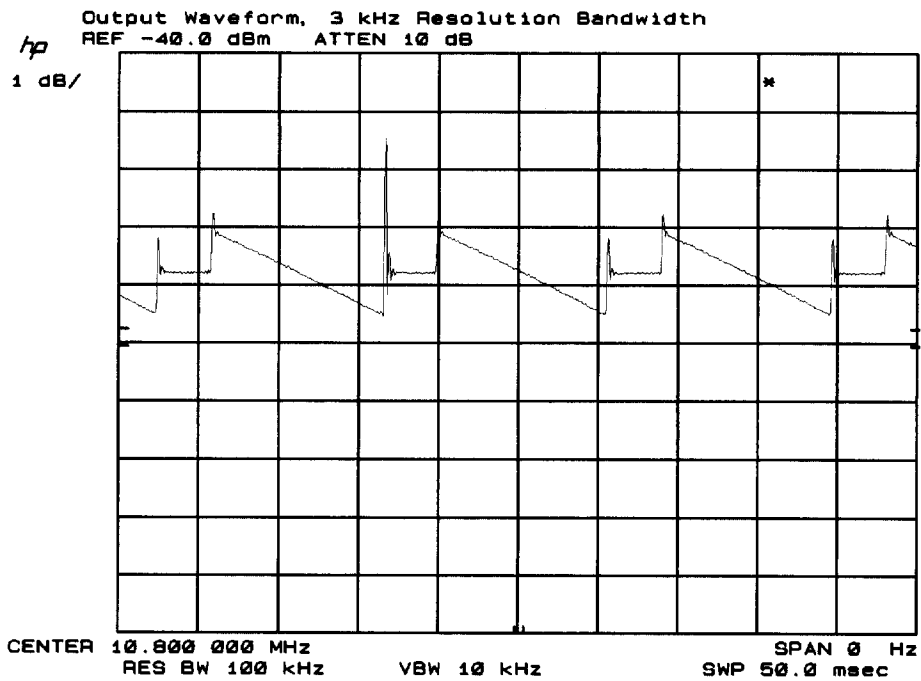


Figure 8-17. Output Waveform, 3 kHz Resolution Bandwidth

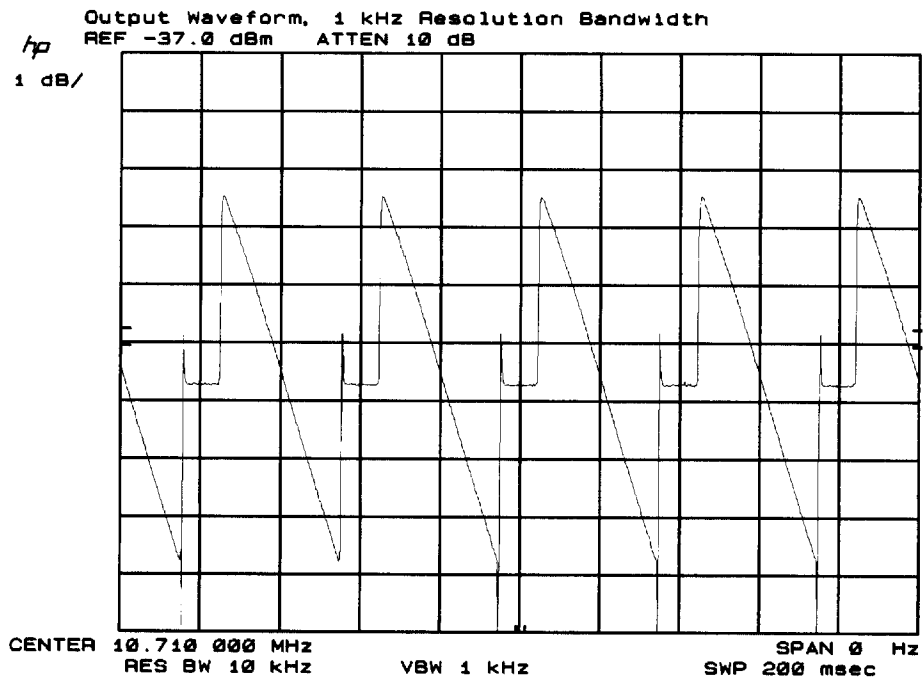


Figure 8-18. Output Waveform, 1 kHz Resolution Bandwidth

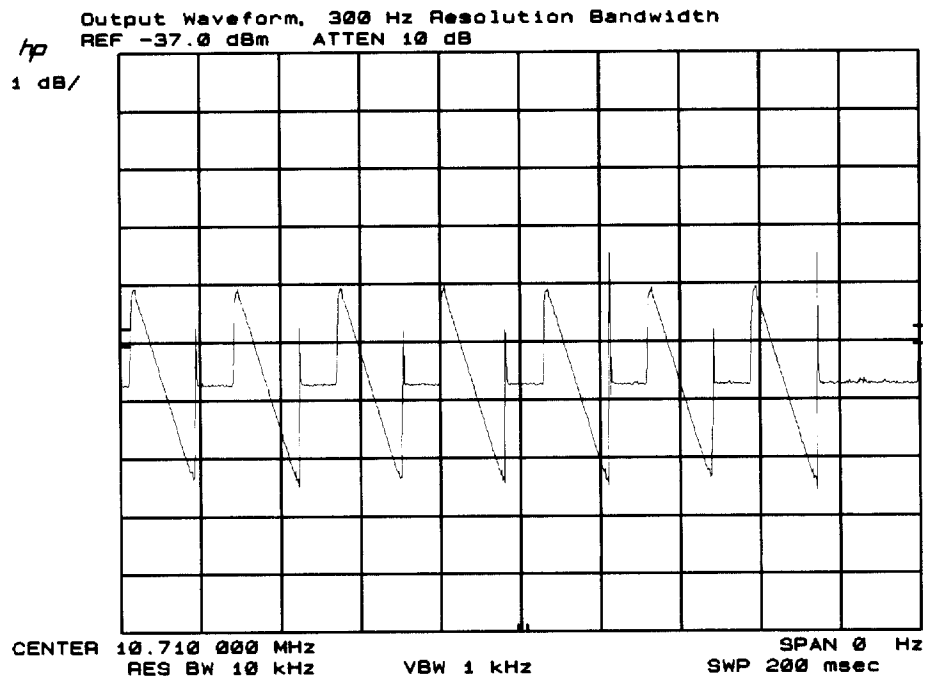
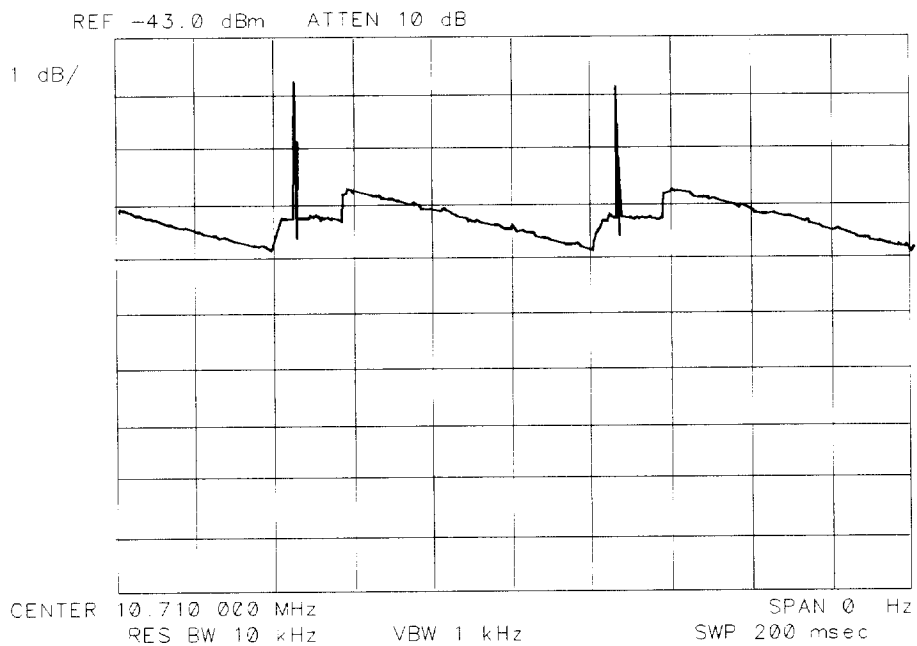


Figure 8-19. Output Waveform, 300 Hz Resolution Bandwidth



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Figure 8-20. Failed Crystal Set Symptoms

Low-Pass Filter

Refer to function block AB of A4 Log Amplifier Schematic Diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

1. Connect a DVM positive probe to A4J9 pin 4.
2. On the spectrum analyzer, press **CAL**.
3. Press **FULL IF ADJUST**. Observe the DVM reading between the displayed messages **IF ADJUST STATUS: 300 kHz RBW** and **IF ADJUST STATUS: 3 kHz RBW**. During this time period, the voltage should be within a 2 to 10 Vdc range.
4. Observe the DVM reading while **IF ADJUST STATUS: AMPLITUDE** is displayed. The reading should be within the 2 to 10 Vdc range.
5. If the DVM reading is outside the range in step 3 but inside the range in step 4, suspect one of the filter's reactive components.

Sweep Generator

Refer to function block Z of A4 log amplifier schematic diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

A properly operating sweep generator generates a series of negative-going parabolas. Before the sweep, switches A4U802C and A4U802D turn on, shorting A4C802 and A4C801 (the output is at 0 volts). These switches open to start the sweep. The output of A4U804A, pin 1, is 0.35 V to 10 V, depending on the sweep width selected by A4U802A and A4U803A. This voltage appears across A4R801. Capacitor A4C801 integrates the current through A4R801. The output of A4U804B is a straight, negative-going ramp. Capacitor A4C802 and resistor A4R802 integrate the output of A4U804A which starts a negative ramp (A4U804C) at the beginning of the sweep. The ramp from A4U804B is added to the current in A4R802 via A4U803B. Integrating this ramp results in the parabolic output waveform.

AM/FM Demodulation, Audio Amplifier, and Speaker

Refer to function blocks R, S, and T of A4 Log Amplifier Schematic (sheet 4 of 4) Diagram in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

If the audio circuits are not functioning use the following procedure to isolate the problem.

1. Set an AM signal generator controls as follows:

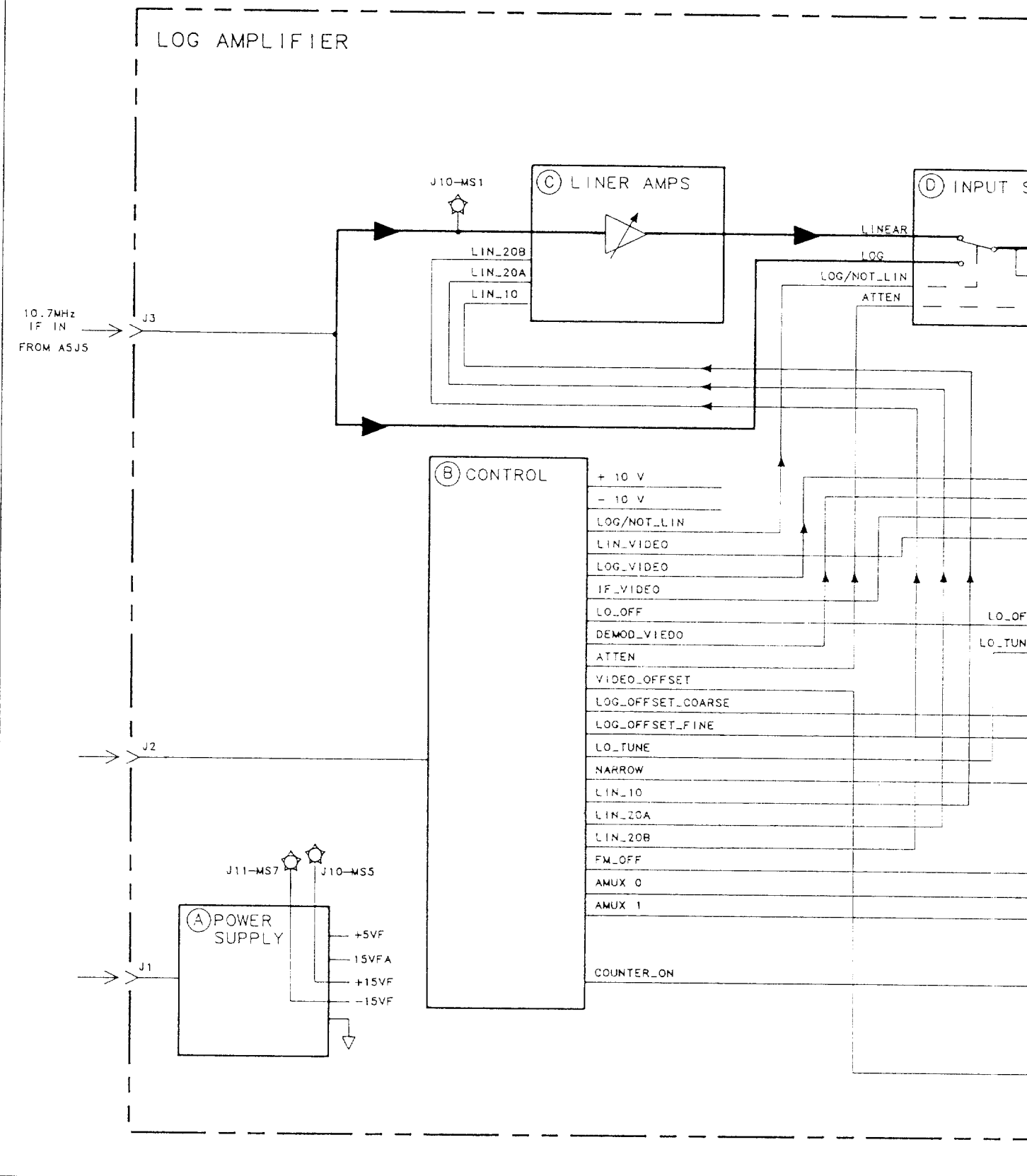
Frequency	100 MHz
Amplitude	-6 dBm
Modulation type	80% AM
Modulation frequency	400 Hz

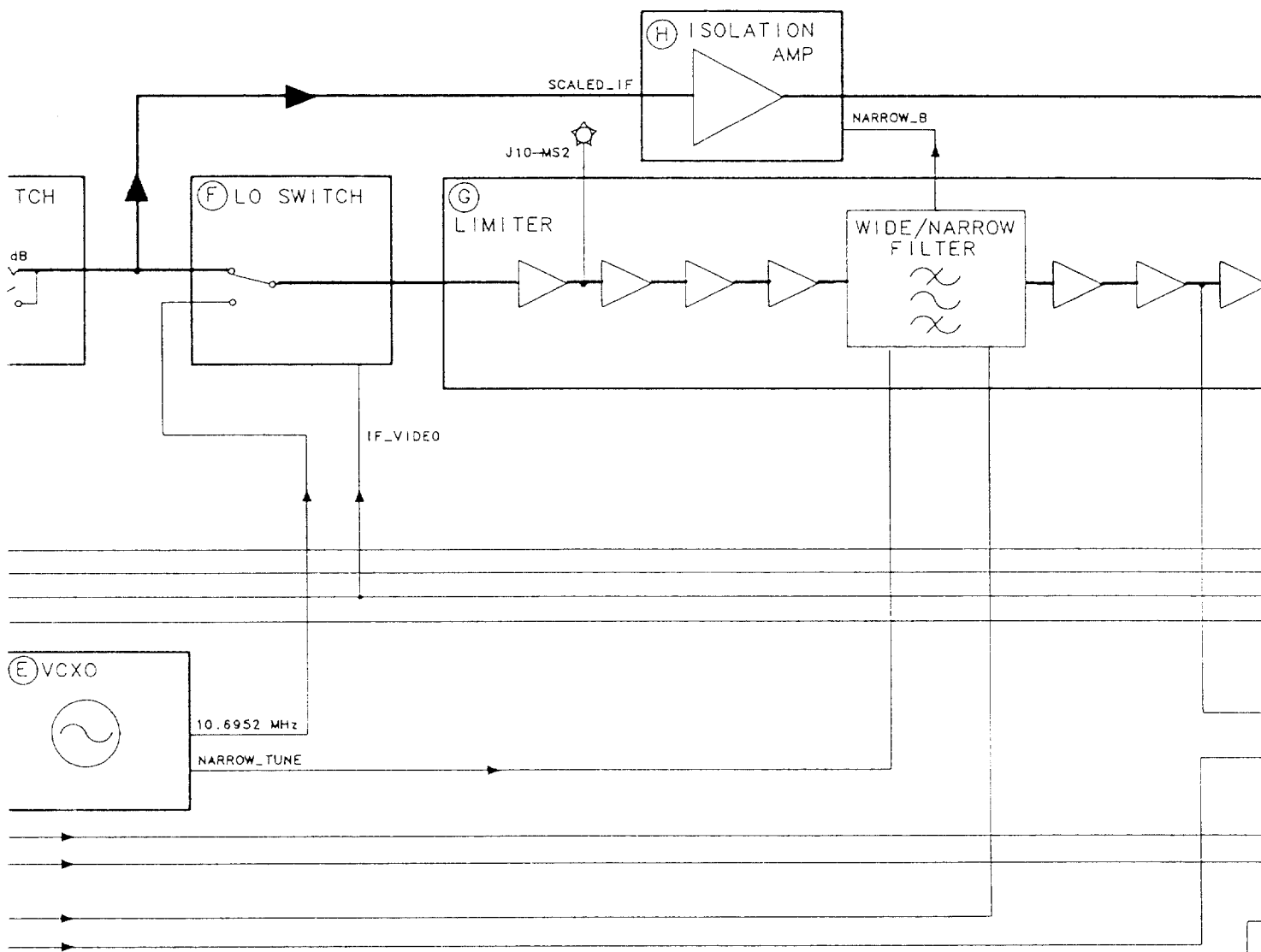
2. Set the spectrum analyzer controls as follows:

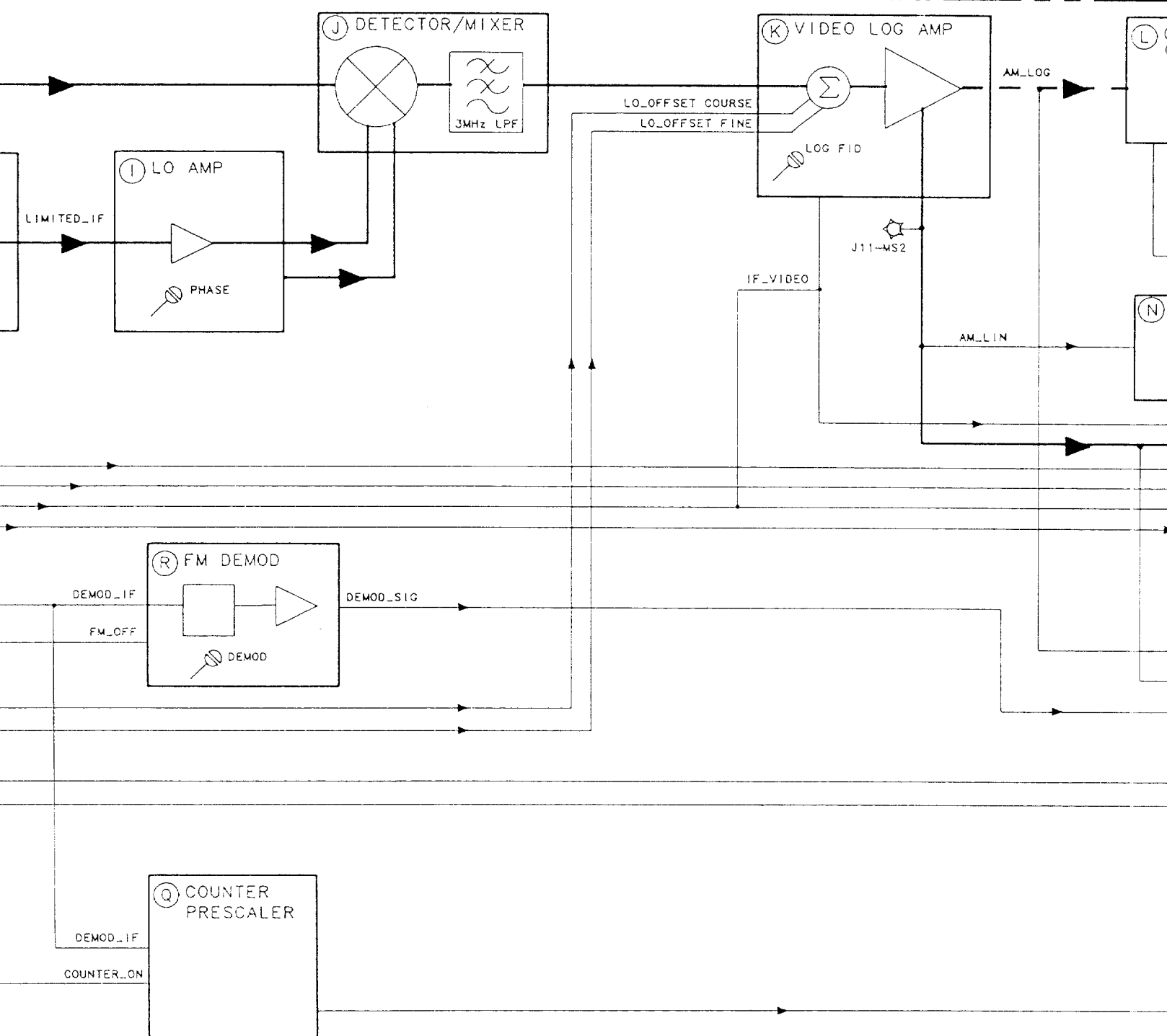
Center frequency	100 MHz
Span	0 Hz
Sweep time	50 ms
Reference level	0 dBm
Resolution bandwidth	10 kHz
Amplitude scale	LINEAR

3. Adjust the spectrum analyzer reference level and center frequency to display the 400 Hz modulation frequency eight divisions peak-to-peak.
4. On the spectrum analyzer, press **AUX CTRL**, **AM/FM DEMOD**, **AM DEMOD ON**, and set the sweep time to 5 seconds.
5. Vary the volume and listen for the variation in speaker output level. Clipping is normal at the highest volume levels.
6. If the audio is not working correctly monitor the signal at A4U704 pin 3 with an oscilloscope. The signal should be 20 mV peak-to-peak $\pm 25\%$ (with +2.5 V of dc bias). If the signal measures outside these limits, the fault is prior to the audio amplifier (block T).
7. If the signal is correct, troubleshoot the audio amplifier and speaker.

A4 LOG AMPLIFIER/CAL OSCILLATOR BLOCK DIAGRAM







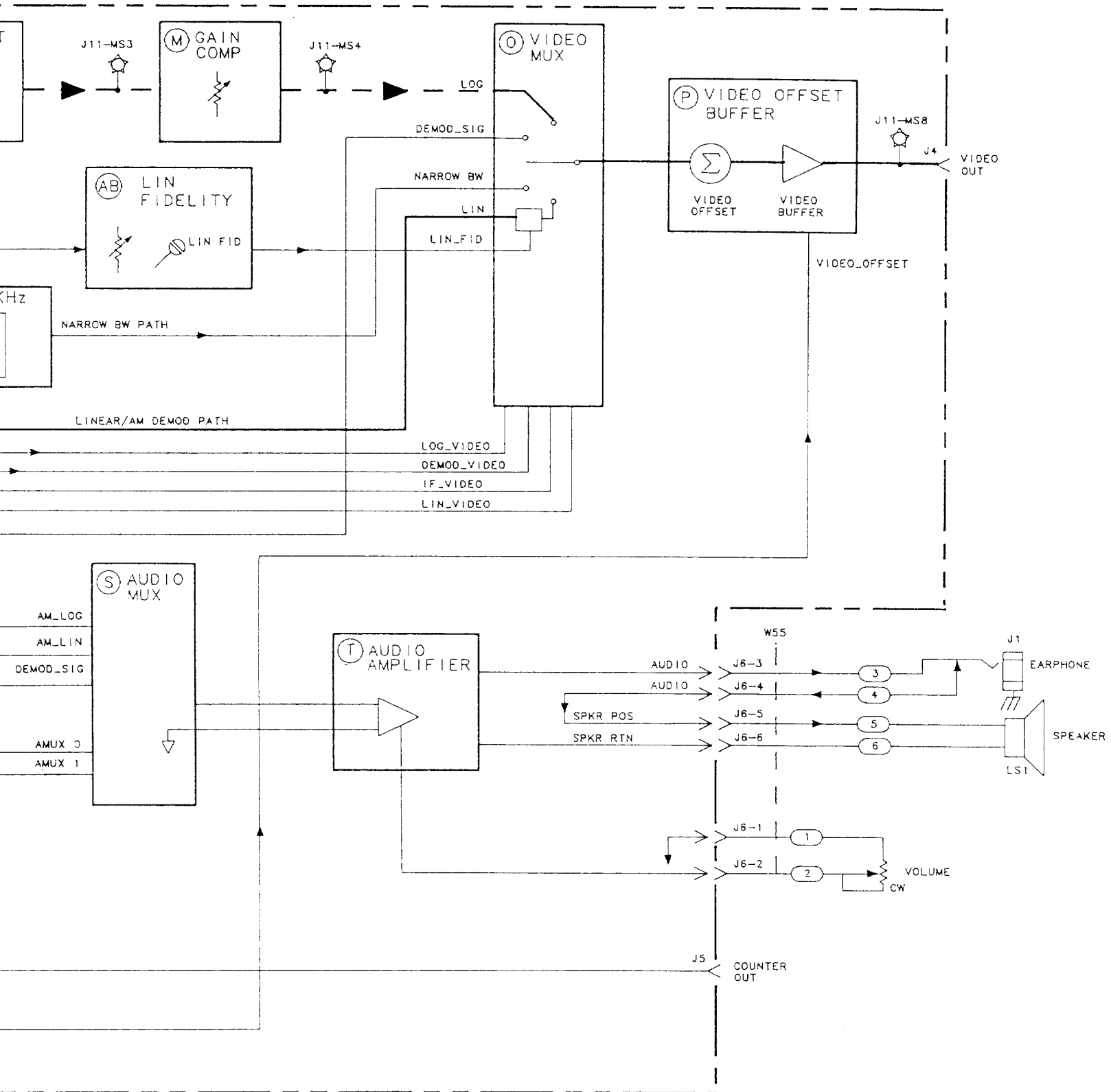
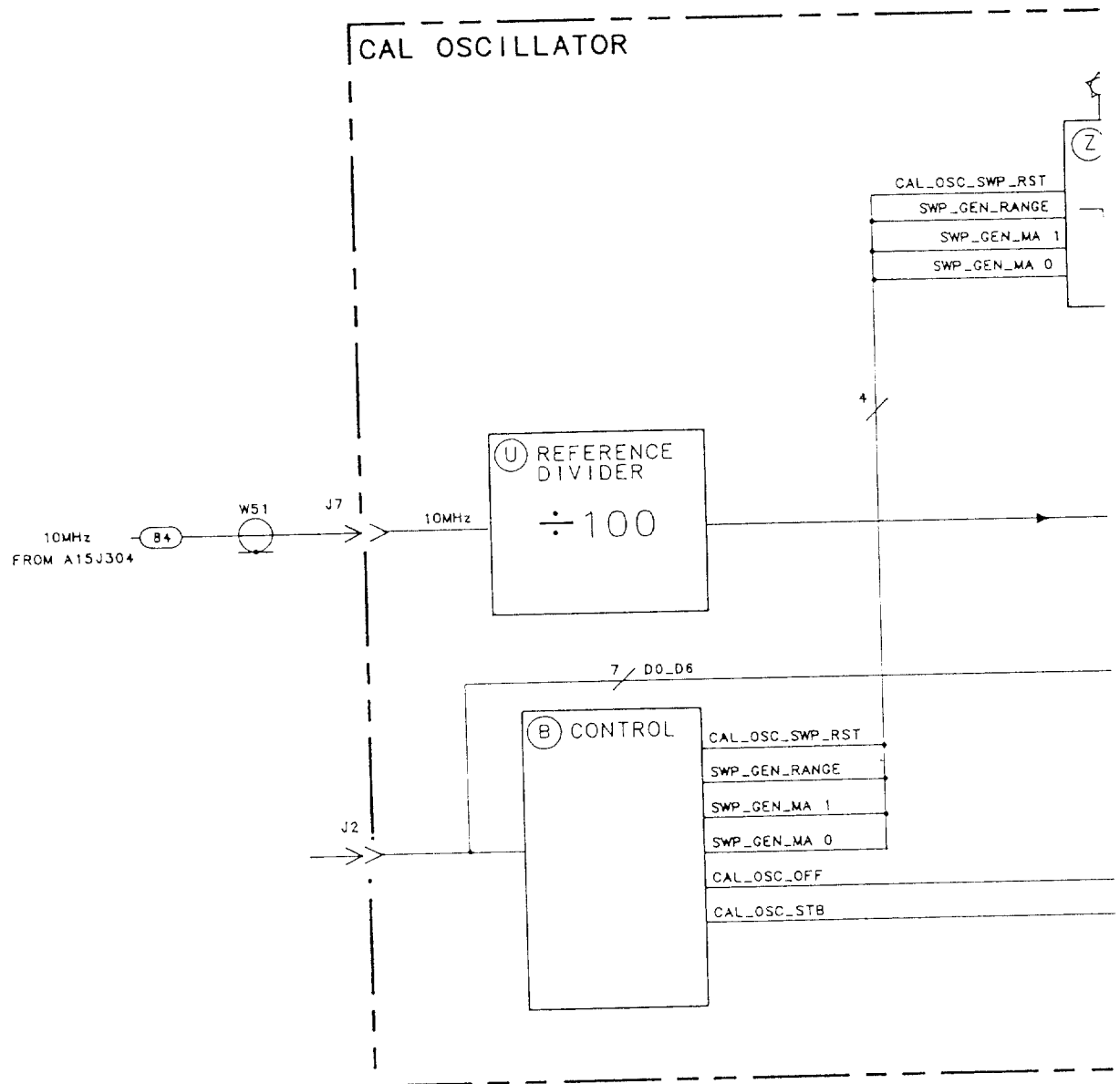
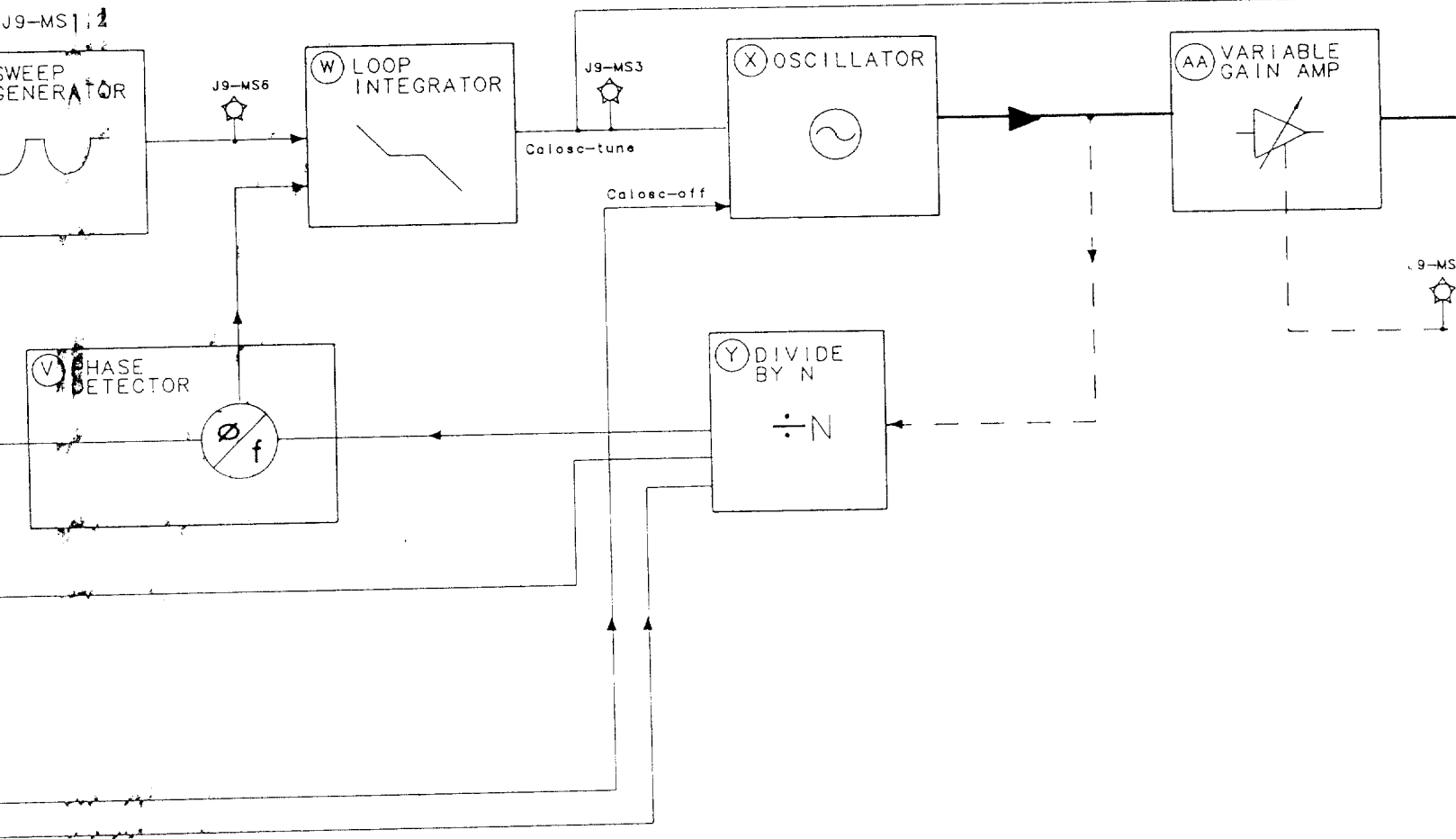


FIGURE 8-21. A4 LOG AMPLIFIER/CAL OSCILLATOR BLOCK DIAGRAM (1 of 2)

A4 LOG AMPLIFIER/CAL OSCILLATOR BLOCK DIAGRAM





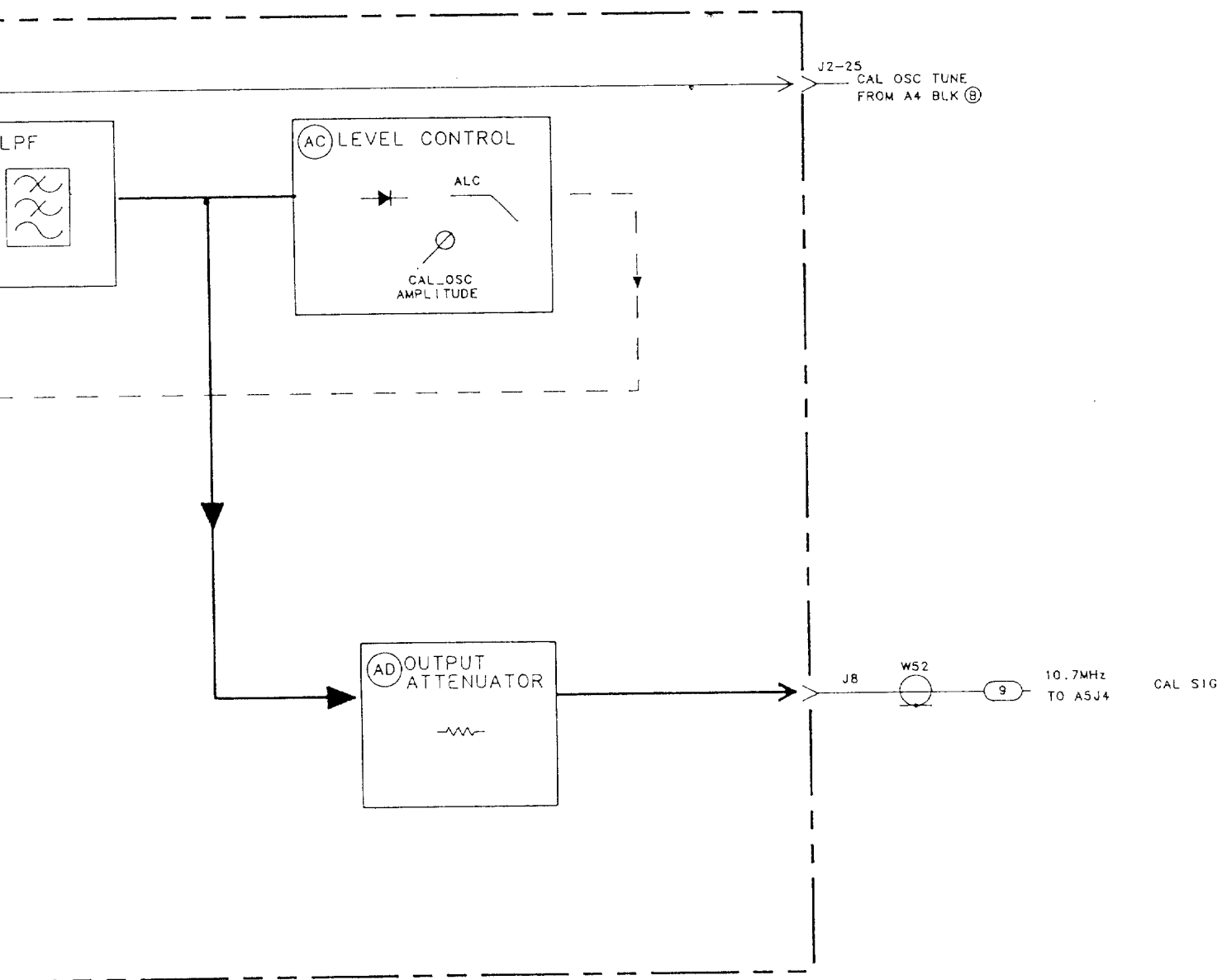
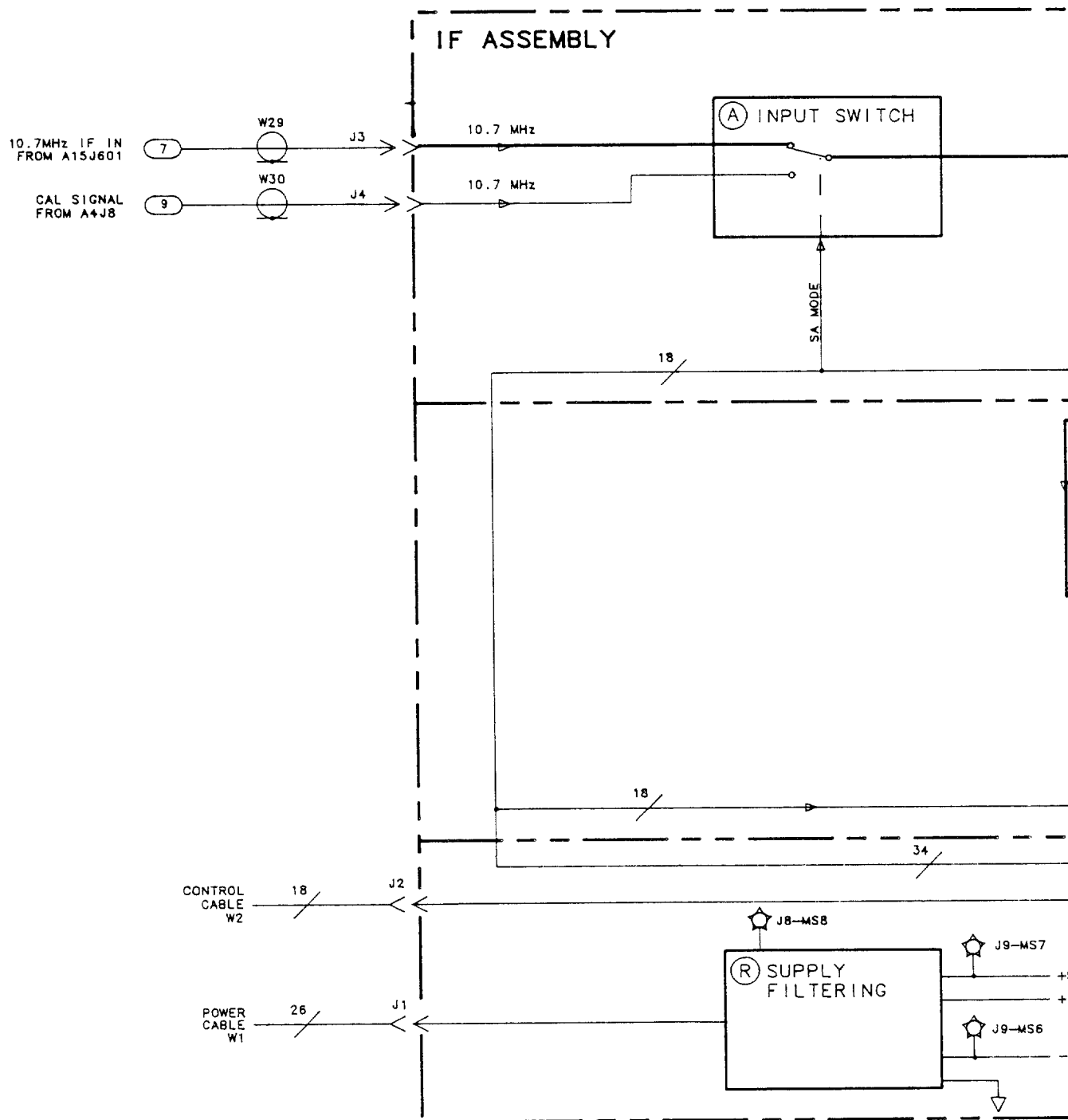
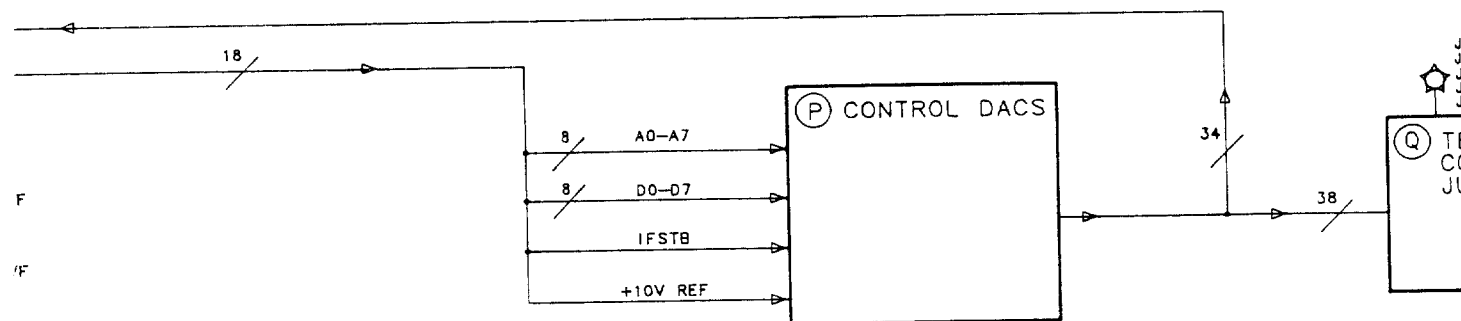
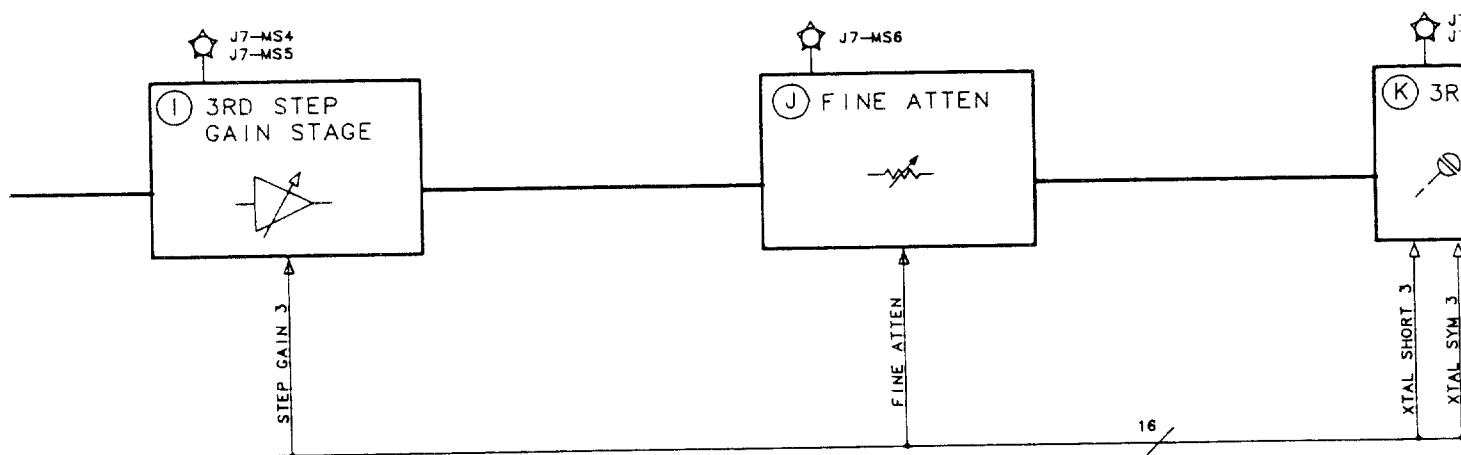
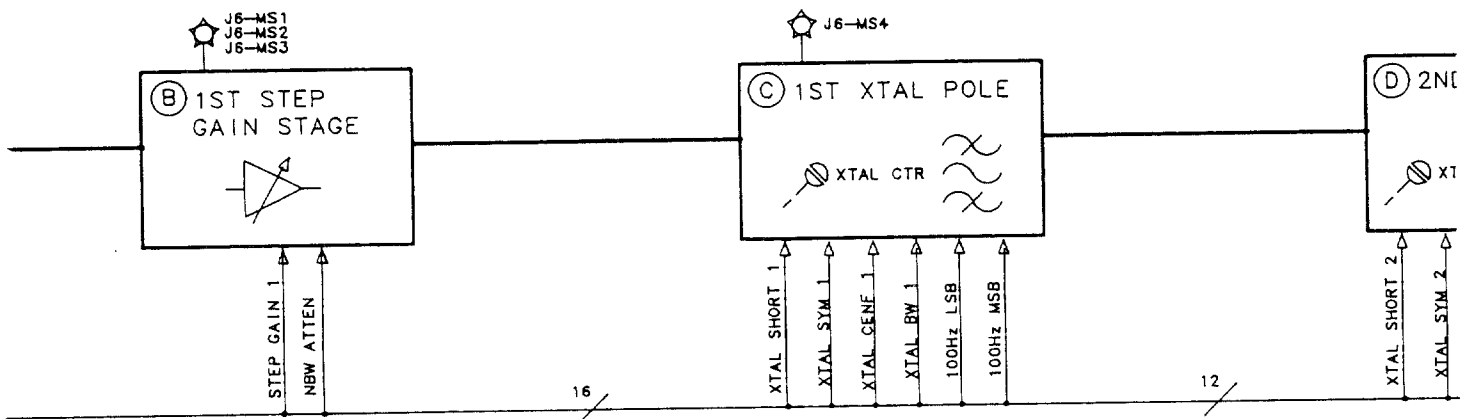
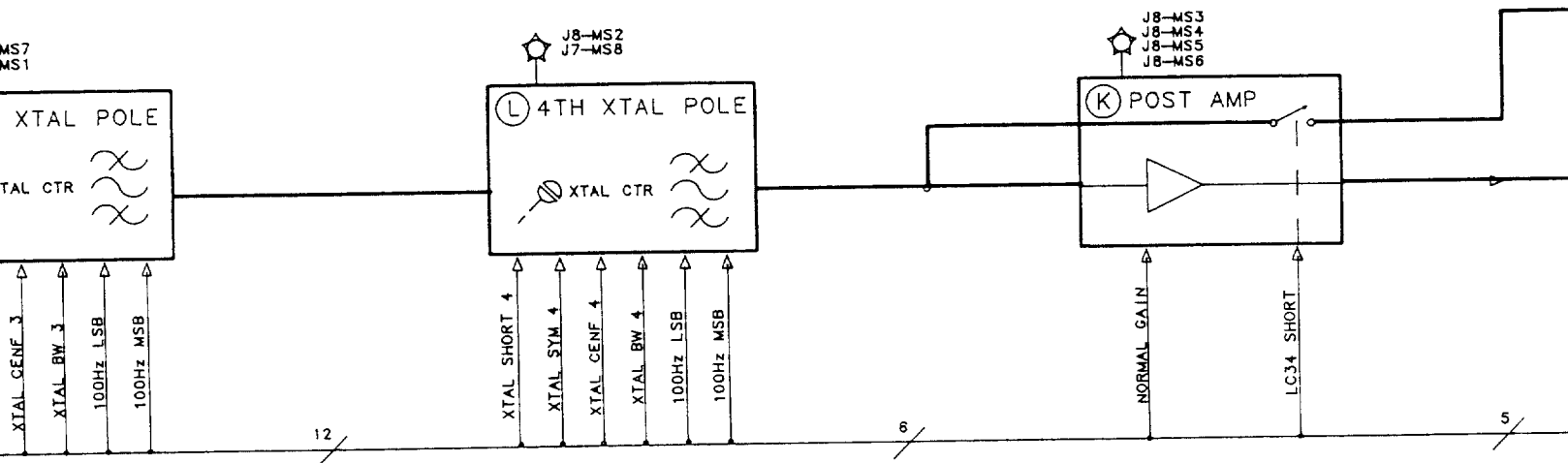
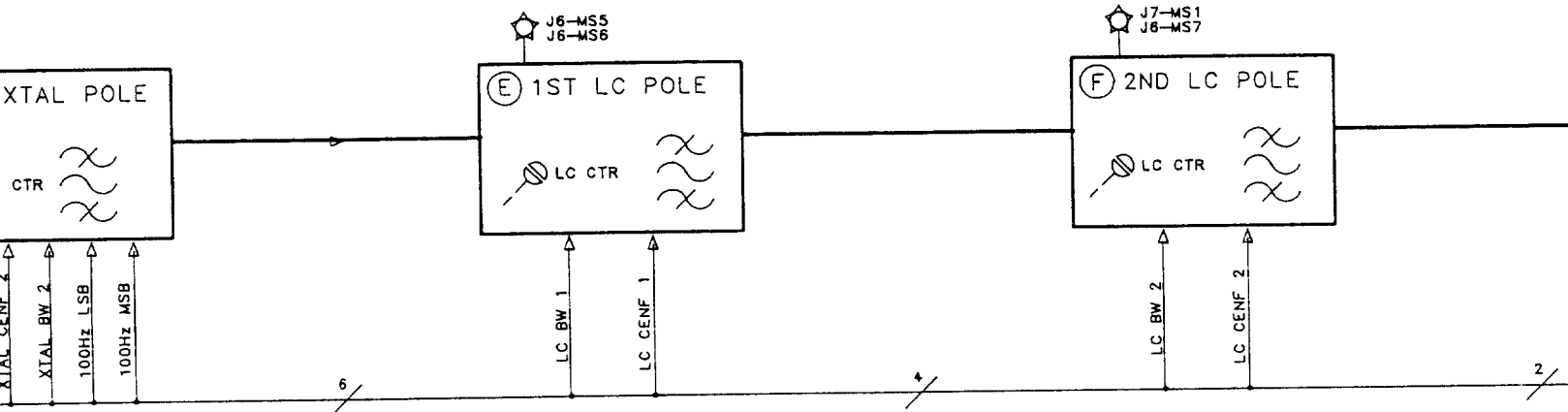


FIGURE 8-21. A4 LOG AMPLIFIER/CAL OSCILLATOR BLOCK DIAGRAM (2 of

A5 IF ASSEMBLY BLOCK DIAGRAM







MS1
MS2
MS3
MS4
MS5

ST
CONNECTOR
FUNCTION

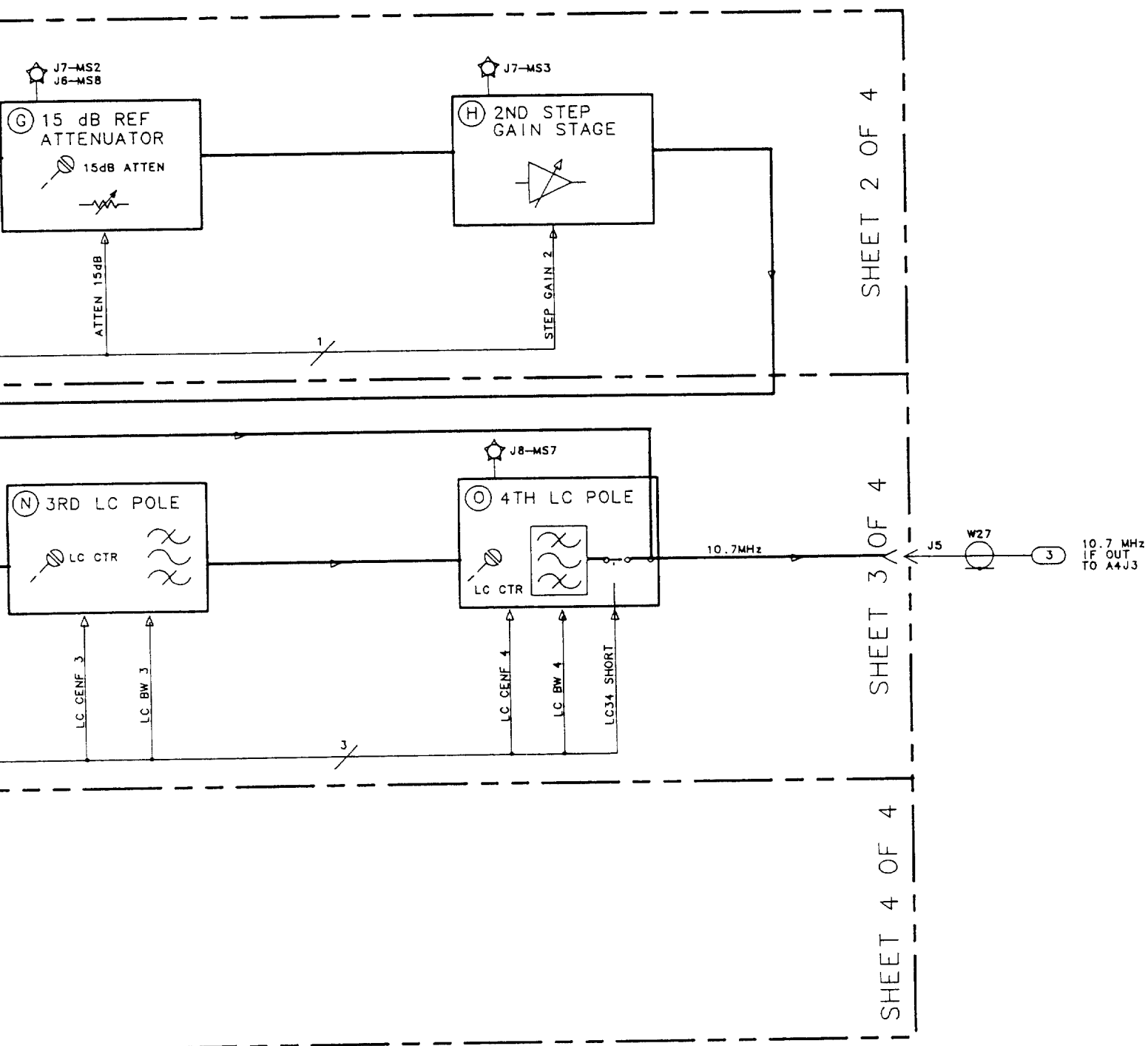


FIGURE 8-22. A5 IF ASSEMBLY BLOCK DIAGRAM

Controller Section

The controller section includes the A2 controller assembly, A19 HP-IB assembly, and BT1 battery. The presence of a display (graticule and annotation) verifies that most of A2 controller assembly is operating properly.

- Troubleshooting Using the TAM
 - Blank Display
 - Digital Signature Analysis (DSA)
 - Display Problems
 - Line Generators
 - Blanking
 - Display Jumbled or Trace Off Screen
 - Intensity
 - Bad Characters or Graticule
 - Long Lines Dimmer than Short Lines
 - Analog Zero-Span Problems
 - Frequency-Count Marker Problems
 - Frequency Counter
 - State- and Trace-Storage Problems
 - Keyboard Problems

Note

When measuring voltages or waveforms, make ground connections to A2TP3. The metal board-standoffs are not grounded and should not be used when taking measurements.

Troubleshooting Using the TAM

Table 9-1 lists assembly test connectors associated with each Manual Probe Troubleshooting test. Figure 9-1 illustrates the location of A2's test connectors.

Table 9-1. TAM Tests versus Test Connectors

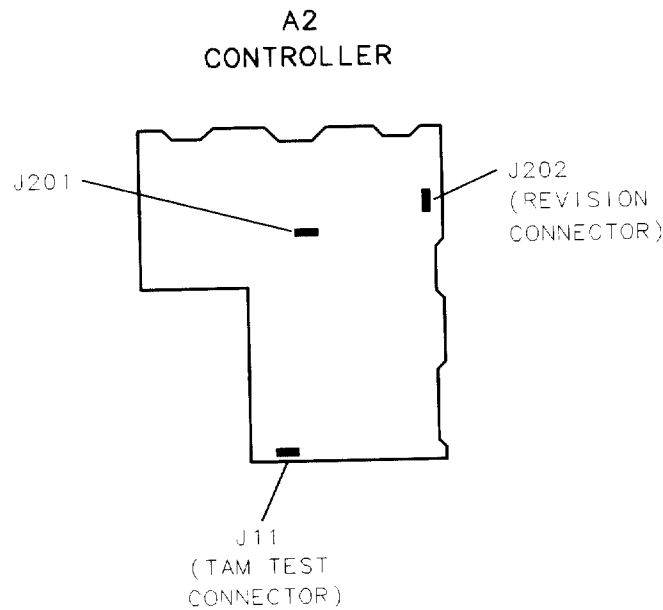
Connector	Manual Probe Troubleshooting Test	Measured Signal Lines
A2J11	ADC/MUX Test DAC test	MS1, MS3 through MS6, MS8 MS2, MS7, OS1
A2J201	10 volt reference test Switch drive test Buffered X & Y DAC outputs X line gen test Y line gen test Intensity offset output	MS4 MS8 MS2, MS7 MS6 MS1 MS3
A2J202	Revision X, Y, & Z Output Offset X output amplifier Y output amplifier Blanking test Focus DAC test	MS1 MS3, MS4, MS7 MS7 MS3 MS8 MS2

Blank Display

Use the following procedure if the instrument's display is blank. This procedure substitutes an HP-IB printer for the display.

1. Connect the printer to the HP 8560E and set the printer's address to the value required by the TAM. This is usually 1.
2. All of the power-supply indicator LEDs along the edge of the A2 controller assembly should be lit.
3. The rear-panel CRT +110 VDC ON indicator might not be lit, even if the +110 V is present.
4. Connect the TAM's probe cable to A2J11.
5. Press **MODULE**, **SOFT KEY #3**, **⇓**, and **SOFT KEY #1**. (The top soft key is #1.)
6. The yellow LED next to A2J11 should blink approximately ten times. If the LED fails to blink correctly, troubleshoot the digital section of the A2 controller assembly.
7. Move the probe cable to A2J202. Press **SOFT KEY #1** and wait five seconds.

8. Press **SOFT KEY #4**. The results should be sent to the printer.
9. If a failure is indicated in any of these tests, the fault lies on the A2 controller assembly.
To obtain more information:
 - a. Press the step down key,  one less time than the test number. (For example, press it twice for the third test on the list.)
 - b. Press **SOFT KEY #3**, then **SOFT KEY #4**, and when the printout is complete, **SOFT KEY #6**.



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Figure 9-1. A2 Test Connectors

10. Move the probe cable to A2J201, press **SOFT KEY #1** and wait five seconds.
11. Press **SOFT KEY #4**. The results will be sent to the printer. Follow the procedure in step 9 to obtain more information on any of the tests.
12. If no failures were indicated in testing the A2 controller, move the probe cable to A17J4.
13. Press **SOFT KEY #1** and wait five seconds.
14. Press **SOFT KEY #4**. The results will be sent to the printer.
15. If no failure is indicated in the printout, refer to "High Voltage Supplies" in Chapter 12.

Digital Signature Analysis (DSA)

Digital signature analysis (DSA) places microprocessor, A2U1, in a simplified known state. This simplified state consists of placing a one-word instruction, MOVE QUICK, (0111 XX10 XXXX XXX0) on the data bus. The microprocessor cycles through its address range continually reading the instruction. Perform the following DSA procedure to test the operation of microprocessor, A2U1:

1. Set the HP 8560E's **LINE** switch off.
2. Move the DSA jumper on J3 (located in the middle of the A2 assembly) from the DISable position to the ENable position.
3. Remove jumper A2E1. A2E1 is a 16 pin dual-in-line package located in the middle of the A2 Assembly. Set the HP 8560E's **LINE** switch on.
4. Use an oscilloscope to confirm that address lines, address strobe, and chip selects are toggling at proper levels.
5. Use an oscilloscope to check the address line sequencing. The signal on each line (starting with A1 and ending with A23) should be one-half the frequency of the previous line.
6. If step 4 reveals problems, microprocessor A2U1 is probably faulty.
7. Set the HP 8560E's **LINE** switch off. Replace jumper A2E1. Move the DSA jumper from connecting E5 and E6 back to connecting E6 and E7.

Display Problems

Line Generators

Refer to function blocks D and I of A2 controller schematic diagram (sheet 1 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The line generators convert the digital display information to an analog output suitable to drive the A17 CRT driver assembly. These circuits change the digital words into vectors, or lines, which move the beam of the CRT. The vectors are each 6 μ s long (width of the INTEGRATE pulse) followed by a 1 μ s SAMPLE pulse. When characters of text are being drawn, the vectors are 3 μ s long.

1. On the HP 8560E press **PRESET**.
2. On the HP 8560E, press **CAL**, **MORE**, and **CRT ADJ PATTERN**. If the display is blank, press the bottom softkey and then the top softkey.
3. Set an oscilloscope to the following settings:

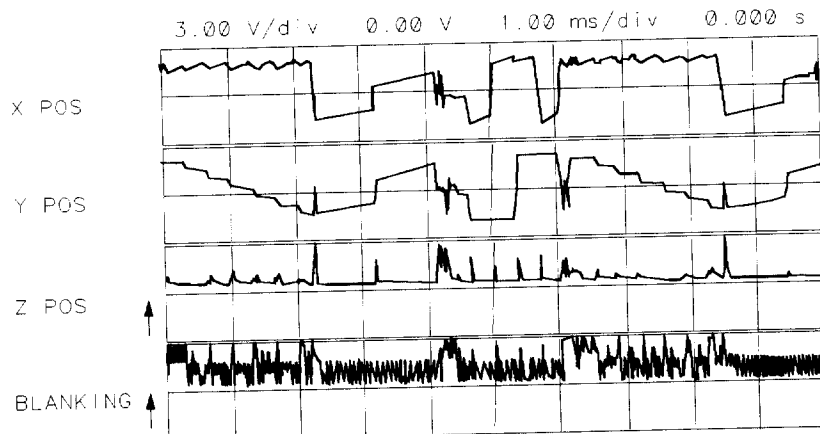
Amplitude scale	 3 V/div
Sweep time	 1 ms/div
Triggering	 External
4. Externally trigger the oscilloscope off the signal at A2U207 pin 8 (LBRIGHT).

5. Compare the signals at the following test points with those illustrated in Figure 9-2.

X POS: A2J202 pin 14
 Y POS: A2J202 pin 3
 Z OUT: A2J201 pin 3
 BLANKING: A2J202 pin 15

Note Waveforms displayed on an analog scope may show considerably more spikes. This is normal and is due to the wider displayed bandwidth.

6. Troubleshoot the circuits associated with any bad waveforms.



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Figure 9-2. Line Generator Output Waveforms

Blanking

Refer to function block J of A2 Controller Schematic Diagram (sheet 1 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

- Using an oscilloscope, check for blanking pulses at A2J202 pin 15. A2U206 pin 6 should be at a TTL high. Blanking pulses turn the CRT beam off during the sample time of the line generators and when moving the CRT beam to a new position for drawing the next vector.
- Set an oscilloscope to the following settings:

Amplitude scale		4 V/div
Amplitude offset		+2.5 V
Sweep time		20 μ s/div
Triggering		External
- Externally trigger the oscilloscope off the signal at A2U207 pin 8 (LBRIGHT).

4. Compare the blanking-circuit input signals at the following test points with those illustrated in Figure 9-3.

BLANKING: J202 pin 15

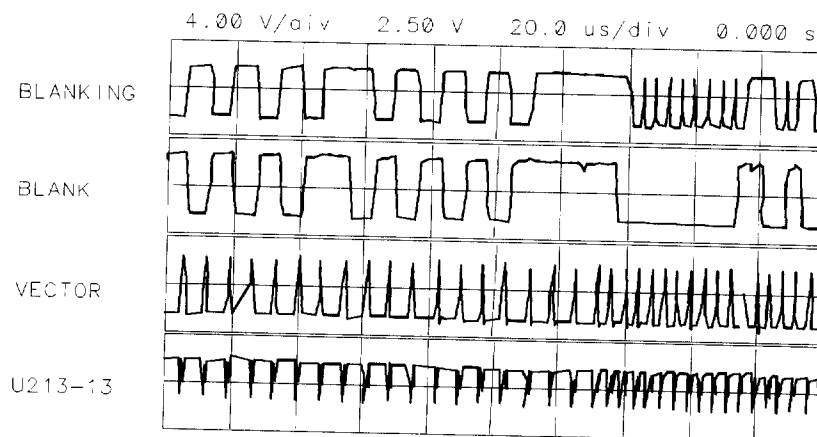
BLANK: U214 pin 12

VECTOR: U214 pin 11

U213 pin 13

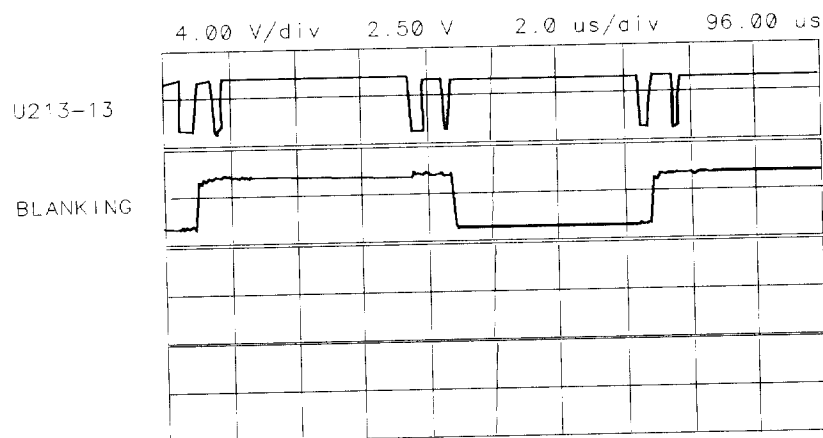
5. The waveforms in Figure 9-3 must match the timing of the vectors being drawn. To do this, U215B is used to adjust the leading edge, and U215A is used to adjust the trailing edge. The first six horizontal divisions show the line drawing mode where the VECTOR pulses are 6 μ s apart. The remaining divisions shows character mode (VECTOR pulses 3 μ s apart). The BLANK pulses are synchronized to the VECTOR pulses by U214B. The fourth trace shows the double pulses which delay the leading and trailing edges of the blanking pulses.
6. Set the oscilloscope to the following settings to expand the first and fourth traces. This displays how the rising edges of U213-13 determine the transitions of the blanking pulses. See Figure 9-4.

Amplitude scale 4 V/div
 Amplitude offset +2.5 V
 Sweep time 2 μ s/div
 Delay from trigger 96 μ s
 Triggering External



SK192

Figure 9-3. Blanking Waveforms



SK193

Figure 9-4. Expanded Blanking Waveforms

Display Jumbled or Trace Off Screen

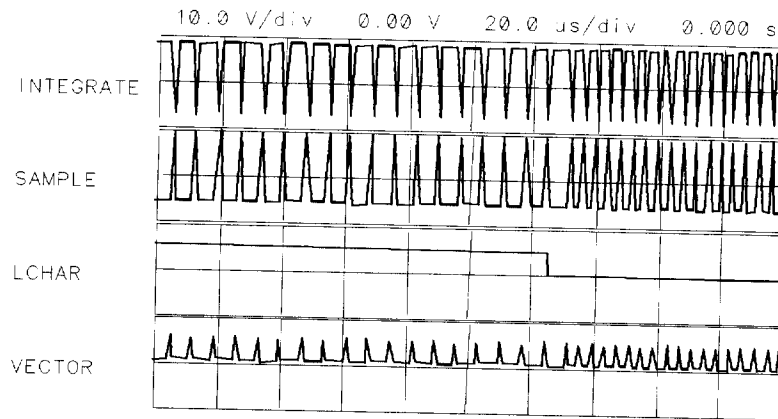
Refer to function blocks D and I of A2 controller schematic diagram (sheet 1 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The two line generators are identical circuits, so the following steps apply to both. The X generator is referenced below, with Y generator references in parentheses.

1. The voltage at A2U202B pin 7 should measure 10.0 V.
2. Perform steps 1 through 5 of "Line Generators" in this chapter. If the X POS and Y POS waveforms look different from those illustrated in Figure 9-2, check the waveforms at the low-pass filter's input (function block E in the component-level information binder).
3. The waveform at the low-pass filter should look like X POS in Figure 9-2 but have an amplitude from 0 V to +5 V.
4. If the waveform in step 3 is incorrect, set an oscilloscope to the following settings:

Amplitude scale	 10 V/div
Sweep time	 20 μs/div
Triggering	 External
5. Trigger the oscilloscope on the signal at U207 pin 8 (LBRIGHT).
6. Compare the line-generator input signals at the following test points with those illustrated in Figure 9-5. INTEGRATE and SAMPLE waveforms are replicas of VECTOR except for polarity and amplitude. LCHAR is low when characters are drawn.

INTEGRATE:	Q202's collector
SAMPLE:	Q201's collector
LCHAR:	U207 pin 9
VECTOR:	U213 Pin 9



SK194

Figure 9-5. Switch Driver Waveform LCHAR

7. All of the DAC inputs should change state two or more times within a 5 ms window. If one or more DAC bits are not working correctly, this will effect the entire display, especially the diagonal lines that go from lower left to upper right. When these lines are drawn, both the X and Y DACs are stepped one count at a time. A “stuck” bit will distort the diagonal in a repetitive manner. The quicker the repetition, the less significant the “stuck” bit. Horizontal distortions apply to the X LINE GENERATOR DAC, while vertical distortions apply to the Y LINE GENERATOR DAC. The DACs have current outputs so they are not readily observable with an oscilloscope. Continue with step 8 to observe the DAC outputs.
8. To break the effect of feedback in the line generators and to observe the output of the DACs, short J201 pin 13 (J201 pin 1) to TP3 (GND) to observe U201 pin 1 and TP2 (U203 pin 1 and TP1.) Continue with step 9.
9. Set an oscilloscope to the following settings:

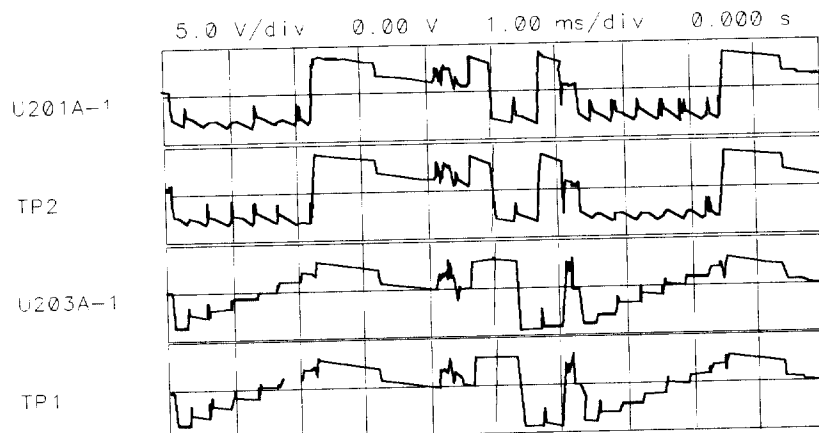
Amplitude scale		5 V/div
Sweep time		1 ms/div
Coupling		ac
Triggering		External
10. Trigger the oscilloscope on the signal at U207 pin 8 (LBRIGHT).
11. The following waveforms should look like Figure 9-6 on the oscilloscope. The top two traces are for the X line generator and the bottom two traces for the Y line generator.

X line generator	
U201 pin 1	
TP2	
Y line generator	
U203 pin 1	
TP1	

12. Figure 9-7 illustrates the waveforms in step 11 expanded to show relative timing. the second and fourth traces are delayed by 5 ms from the first and third. The oscilloscope settings are changed as follows:

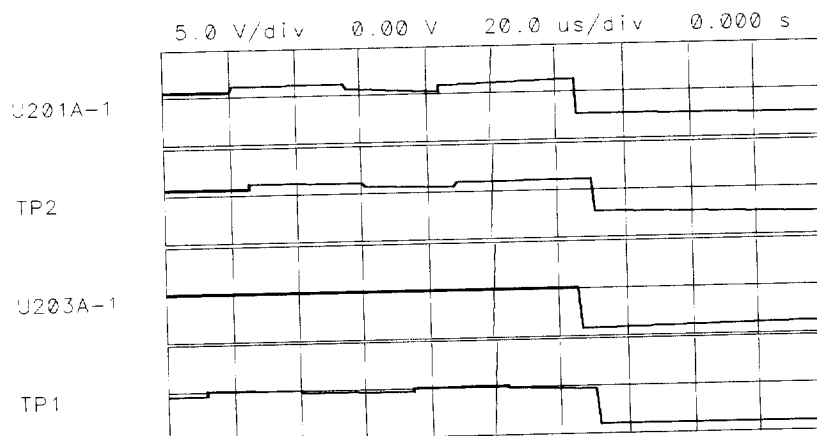
Sweep time 20 μ s/div

13. Figure 9-8 illustrates the waveforms of properly working line generators. Whenever there is a pulse on TP2 (or TP1), the appropriate integrator U201B (or U203B) generates a ramp (the output vector) which feeds back to U201A (U203A) and shows on its output.



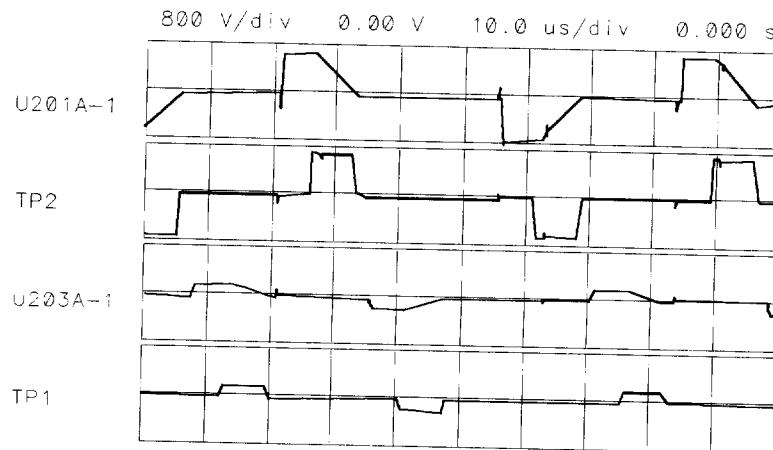
SK195

Figure 9-6. Distorted X/Y Line Generator Waveforms



SK196

Figure 9-7. Expanded X/Y Line Generator Waveforms



SK197

Figure 9-8. Normal X/Y Line Generator Waveforms

Intensity

1. The length of the vector being drawn can effect intensity. U210A, U210C, and U210D sum the lengths of the X and Y vectors. Refer to “Long Lines Dimmer than Short Lines” in this chapter.
2. Short A2U207 pin 6 to pin 7. If the display does not brighten, troubleshoot LBRIGHT switch, U207B. This switch intensifies trace A and active softkeys.
3. Short A2U207 pin 2 to pin 3. If the display does not brighten, troubleshoot DEF1 switch, U207A. This switch is used in analog zero-span.
4. Change the intensity (under **DISPLAY**). If the intensity does not change, troubleshoot the intensity DAC, A2U212A. (A2U212A is controlled from the front panel.) The amplitude of the waveform at U211A pin 1 should increase or decrease with intensity changes.
5. Clamp U211B limits the voltage to about 4.2 V. Short A2J201-1 to ground and set the intensity DAC to a number greater than 80. A major portion of the waveform should be limited to 4.2 V.
6. If a major portion of the waveform is not limited to 4.2 V, troubleshoot the maximum brightness clamp, A2U211C.

Bad Characters or Graticule

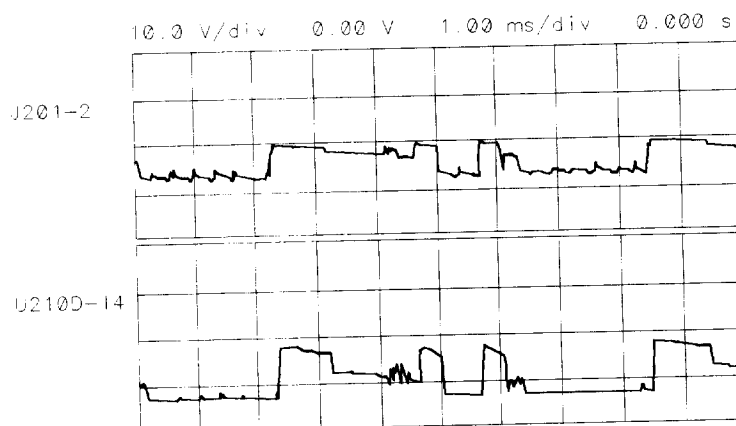
If the displayed characters are bad but the graticule is correct (or if the symptoms are reversed), troubleshoot the X- and Y- generator switches A2U207D and A2U207C. Check that the switch driver signal LCHAR is working properly. Refer to “Display Jumbled or Trace Off Screen” in this chapter.

Long Lines Dimmer than Short Lines

Refer to function block M of A2 controller schematic diagram (sheet 1 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The Z output function block contains the absolute value circuits which determine the intensity of vectors drawn on the display. The vector length is approximated by the sum of the X length and Y length. The voltage corresponding to the X length, ΔX , is converted to current by R274. If the voltage is negative, it is amplified by 2 in A2U210C, converted to current by A2R246, and added to the current from A2R274. This effectively turns both negative and positive voltages into positive currents, hence absolute value.

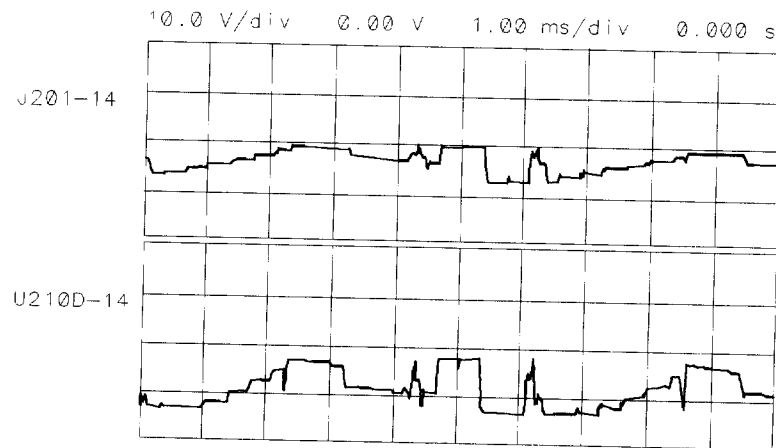
1. Short A2J201 pin 13 to ground (A2TP3).
2. Connect channel A of an oscilloscope to A2J201 pin 2. Connect channel B to A2U210D-14.
3. Set an oscilloscope to the following settings:
Amplitude scale 10 V/div
Sweep time 1 ms/div
Triggering External
4. Externally trigger the oscilloscope off the signal at A2U207 pin 8 (LBRIGHT).
5. The waveforms should look like those illustrated in Figure 9-9. If the waveform at J201 pin 2 is bad, troubleshoot the X line generator (function block D of the A2 controller schematic, sheet 1 of 4).
6. If the waveform at U210D pin 14 is bad, troubleshoot the Z output circuit (function block M of A2 controller schematic, sheet 1 of 4).
7. Remove the short from J201 pin 13 to ground. Short A2J201 pin 1 to ground.



SK 198

Figure 9-9. Delta X Waveform

8. Move the oscilloscope's channel A probe to J201 pin 14.
9. The waveforms should look like those illustrated in Figure 9-10. If the waveform at J201 pin 14 is bad, troubleshoot the Y line generator (function block I of A2 controller schematic, sheet 1 of 4).
10. If the waveform at U210D pin 14 is bad, troubleshoot the Z output circuit (function block M of A2 controller schematic, sheet 1 of 4).
11. Remove the jumpers.

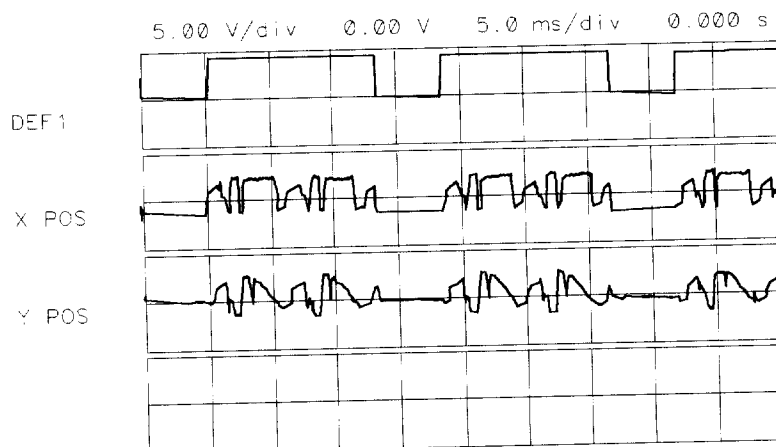


SK199

Figure 9-10. Delta Y Waveform

Analog Zero-Span Problems

1. On the HP 8560E press **PRESET**, **SPAN**, **ZERO SPAN**, **SWEEP**, 1, **ms**, **CAL**, **MORE**, and **CRT ADJ PATTERN**.
2. Set an oscilloscope to the following settings:
Amplitude scale 10 V/div
Sweep time 1 ms/div
Triggering External
3. Externally trigger the oscilloscope off the signal at A2U207 pin 8 (LBRIGHT).
4. The display should be similar to Figure 9-11 except that the untriggered trace should show at the left edge of the screen. In these settings, DEF1 causes switching between the line generators and the analog inputs (sweep and video). DEF1 remains high when the CRT adjust pattern is on. Refer to function block M of the A2 controller schematic, 1 of 4.
5. The sweep input from J1-41 should go from 0 V to +10 V; the video In signal should go from about 0 V to 1 V from the bottom to the top of the screen. Apply a dc voltage to A2J4, Video In, to test the circuit.
6. In Figure 9-11, there is no synchronization between DEF1 and the video patterns X POS and Y POS when DEF1 is TTL high. The Y POS level when DEF1 is low is the Video In level.



SK1100

Figure 9-11. DEF1 Synchronization

Frequency-Count Marker Problems

The FREQ COUNT function works by dividing the 10.7 MHz IF signal by two (prescaling) and counting the divided-down signal using the frequency counter on the A2 controller assembly (block Z of the A2 schematic diagram). The prescaler is on the A4 Log amplifier/cal oscillator assembly (block Q of the A4 schematic diagram). Perform the following steps to determine whether the problem is on the A4 log amplifier/cal oscillator or A2 controller assembly:

1. Disconnect W53 from A2J7.
2. Connect the output of a synthesized source, such as an HP 3335A, to A2J7.
3. Set the synthesized source to the following settings:
Amplitude +10 dBm
Frequency 5.35 MHz
4. Set the HP 8560E to the following settings:
Center frequency 300 MHz
Span 1 MHz
5. On the HP 8560E press **FREQ COUNT**. The frequency counter actually reads one half the frequency of the 10.7 MHz IF. If the CNT frequency display reads all asterisks, the frequency counter is probably at fault.
6. If a valid frequency is displayed, troubleshoot the prescaler on the A4 log amplifier/cal oscillator assembly.
7. Reconnect W53 to A2J7.

Frequency Counter

See function block Z of A2 schematic diagram (sheet 4 of 4) in the *HP 8560 E-Series Spectrum Analyzer Component Level Information*.

The frequency counter counts the frequency of the last IF and provides accurate timing signals for digital zero-spans. The circuit also provides timing signals to the A3 interface assembly's ADC (analog to digital converter). The nominal input frequency is 5.35 MHz (10.7 MHz divided by 2). The circuit's frequency reference in the frequency count mode is the 10 MHz reference from the A15 RF assembly. The frequency reference in digitized zero spans (sweep times ≥ 30 ms) is the 4 MHz HPIB_CLK, selected by MUX U704.

In the frequency count mode, U702 prescales the 10 MHz reference by 5 to generate a 2 MHz timebase. This timebase feeds through MUX U704 to programmable-timer U700's CLK2 input. Programmable-timer U700's output (OUT2) is the gating signal (HBKT_PULSE) for performing the frequency count. The gating time interval is a function of the counter resolution which may be set between 10 Hz and 1 MHz. Table 9-2 lists the gate time for each setting of COUNTER RES. The gate time is the period during which U511 pin 3 is high.

The FREQ COUNT input, A2J7, is gated in U511B by HBKT_PULSE. The gated signal clocks divide-by-16 counters U703A and U703B. These counters are cascaded to form a divide-by-256 counter. The MSB of this counter, CD7, clocks the CLK0 input of U700. The frequency of CD7 is a function of COUNTER RES as shown in Table 9-2. If timer U700 overflows, OUT0 will be set and U701B clocked, generating CNTOVFLIRQ, which will interrupt the CPU.

If IRQAK2 is high, HBKT_PULSE will clock U701A, generating FREQCNTLIRQ. Upon receiving the FREQCNTLIRQ interrupt, the CPU latches the CD0 to CD7 onto the BID bus by setting LCDRD (low counter data read) low and reading the counter data from the BID bus. The CPU will also read the data from the timer, U700, by setting L8254CS and LCNTLRD low, placing the timer data on the BID bus. The CPU resets U701A by setting IRQAK2 low via the BID bus and latch U506.

Table 9-2. Gate Times

Counter Res	Gate Time* (U511 pin 3 high state)	A2TP16	A2TP15
10 Hz	200 ms	2 MHz	4.18 kHz
100 Hz	20 ms	2 MHz	418 Hz
1 kHz	2 ms	2 MHz	41.8 Hz
10 kHz	2 ms	2 MHz	41.8 Hz
100 kHz	2 ms	2 MHz	41.8 Hz
1 MHz	2 ms	2 MHz	41.8 Hz
* TP15 = (FREQ COUNT input $\times$ Gate Time)/256			

1. Disconnect W22 from A2J8.
2. If a 10 MHz, TTL-level signal is not present at the end of W22 continue with step 3. If a 10 MHz signal is present at W22, proceed as follows:
 - a. Reconnect W22 to A2J8.
 - b. Set the HP 8560E to the following settings:

Span	Zero span
Sweep time	20 ms
 - c. Monitor the signal at A2J2 pin 21. This is an output of the frequency counter, HBUCKET PULSE.
 - d. If HBUCKET PULSE is stuck high, troubleshoot the frequency counter.
3. Check for a 10 MHz signal at A15J302. If the signal is not present at A15J302, the A15 RF assembly is probably defective.

State- and Trace-Storage Problems

State storage is in the two of the four Program RAMs and trace storage is in the two display RAMs. With low battery voltage, it is normal for states and traces to be retained if the power is off for less than one minute. If the power is left off for more than thirty minutes with low battery voltage, the stored states and traces will be lost. The following steps test battery backup:

1. Measure the voltage on W6 at A2J10. If the voltage is less than 2.6 V, check the BT1 battery.
2. If the battery voltage is correct, reconnect W6 to A2J10, set the spectrum analyzer's power off and wait five minutes.
3. Measure the voltage at A2U101 pin 28 and A2U102 pin 28.
4. If the voltage is less than 2.0 Vdc, the RAM power battery-backup circuitry on the A2 controller assembly is probably at fault.

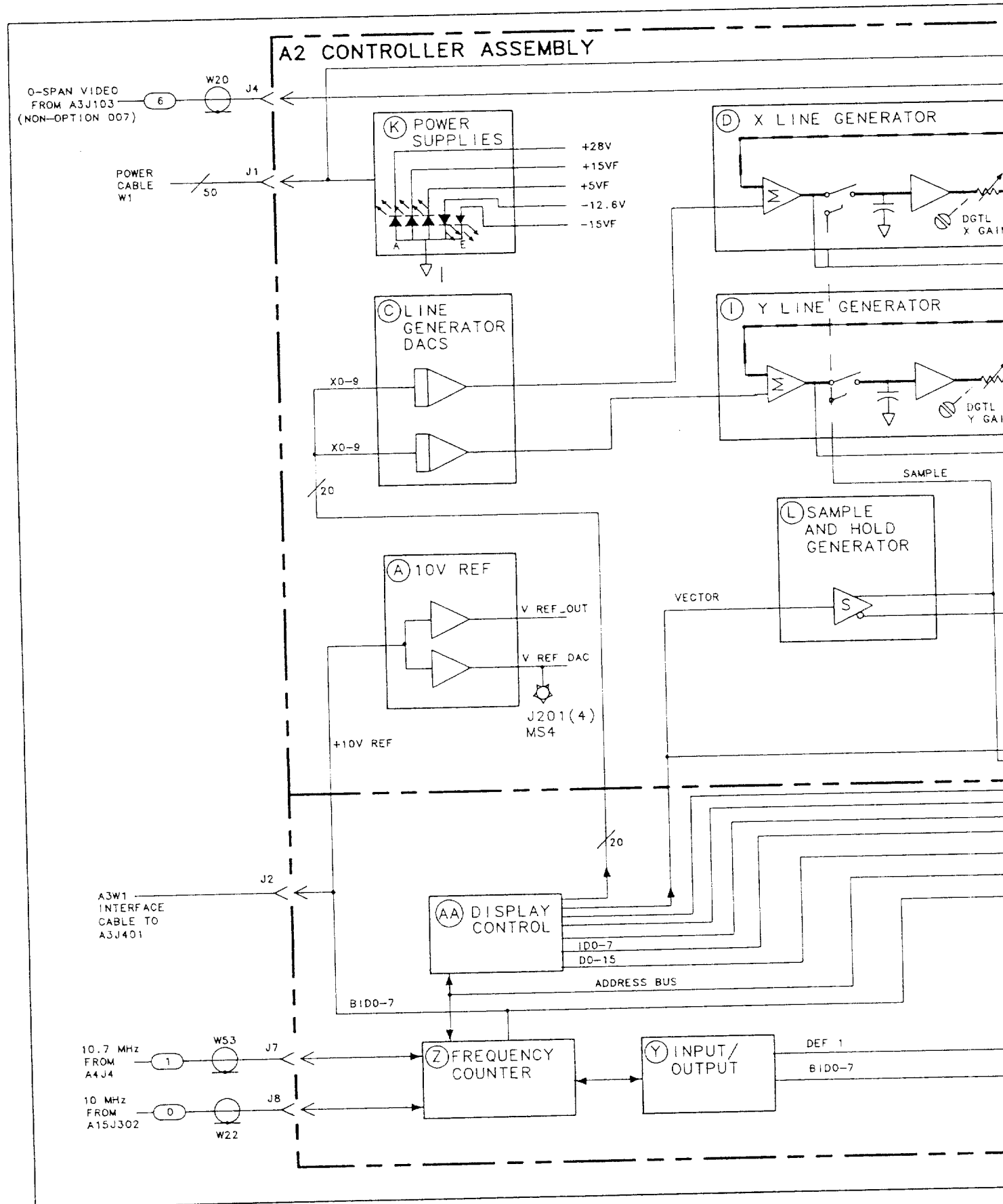
Keyboard Problems

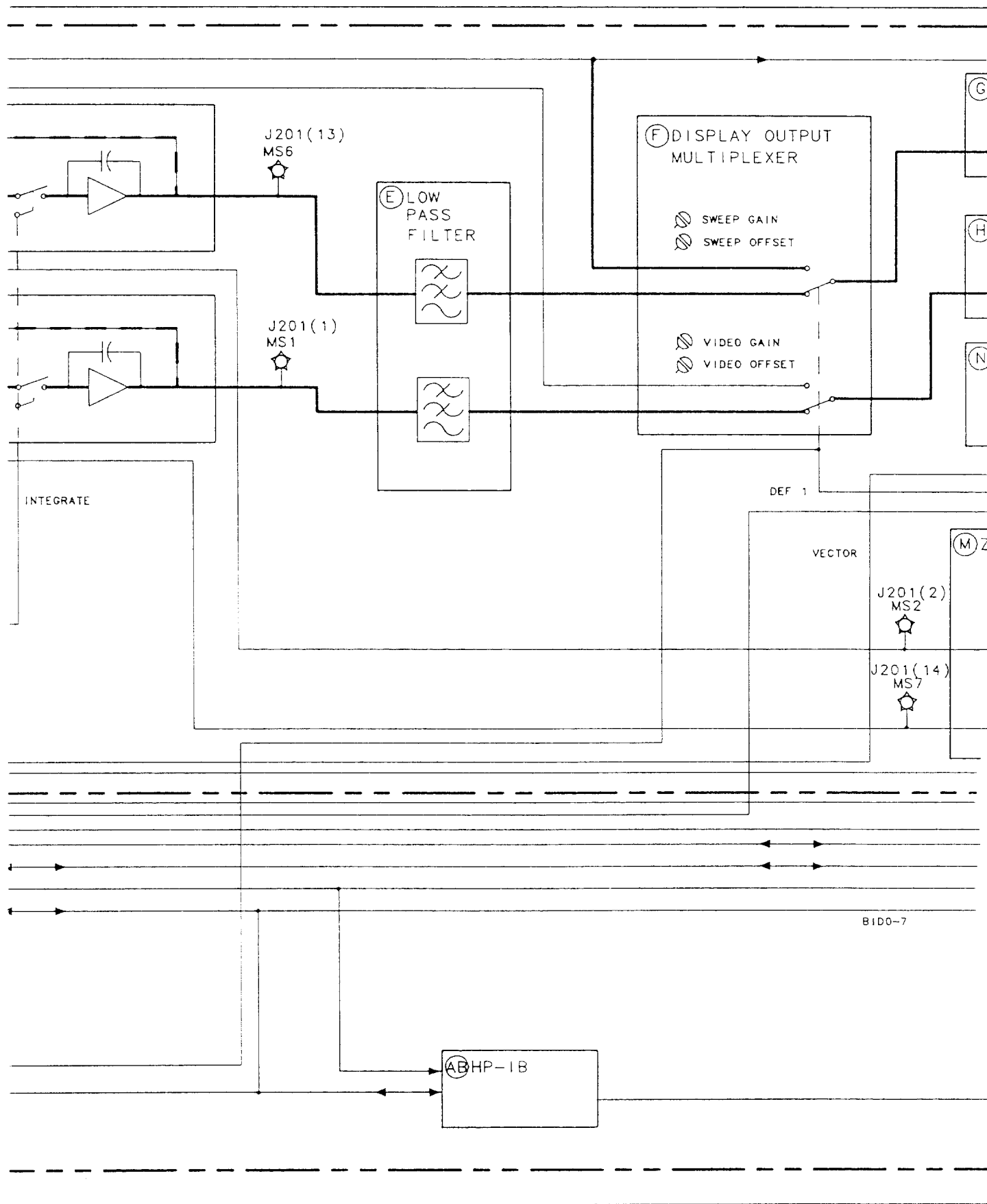
If the spectrum analyzer does not respond to keys being pressed or the knob being rotated, the fault could be either on the A3 interface assembly or the A2 controller assembly. To isolate the A2 controller assembly, use the following procedure. This procedure tests the spectrum analyzer response over HP-IB and the keyboard/RPG interrupt request signal.

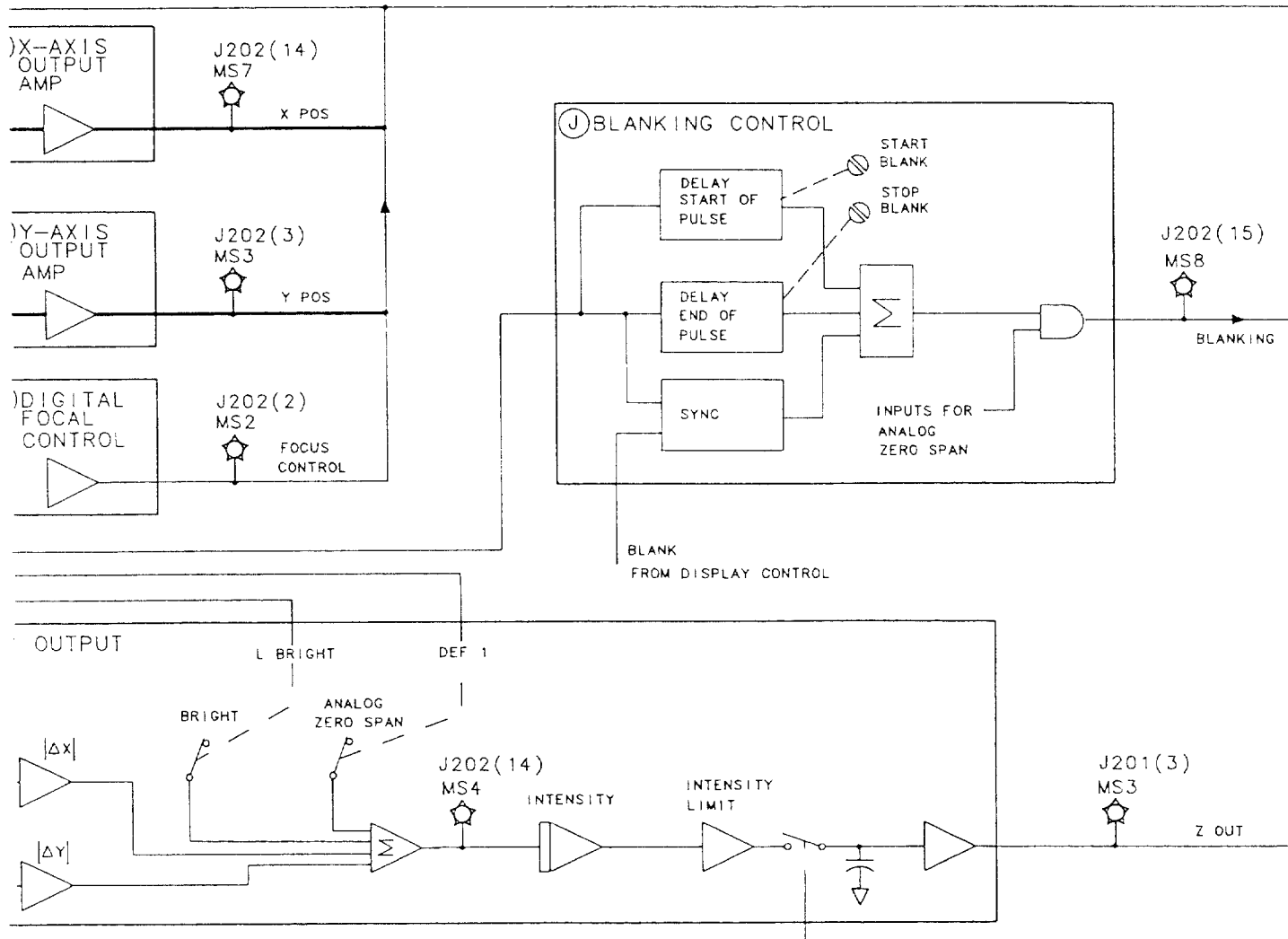
1. Enter and run the following BASIC program.

```
10 OUTPUT 718; "IP; SP 1 MHz;"
20 WAIT 2 ! Wait 2 seconds
30 OUTPUT 718; "AT 70 DB;"
40 WAIT 2 ! Wait 2 seconds
50 OUTPUT 718; "AT 30 DB;"
60 WAIT 2 ! Wait 2 seconds
70 OUTPUT 718; "AT 10 DB;"
80 END
```

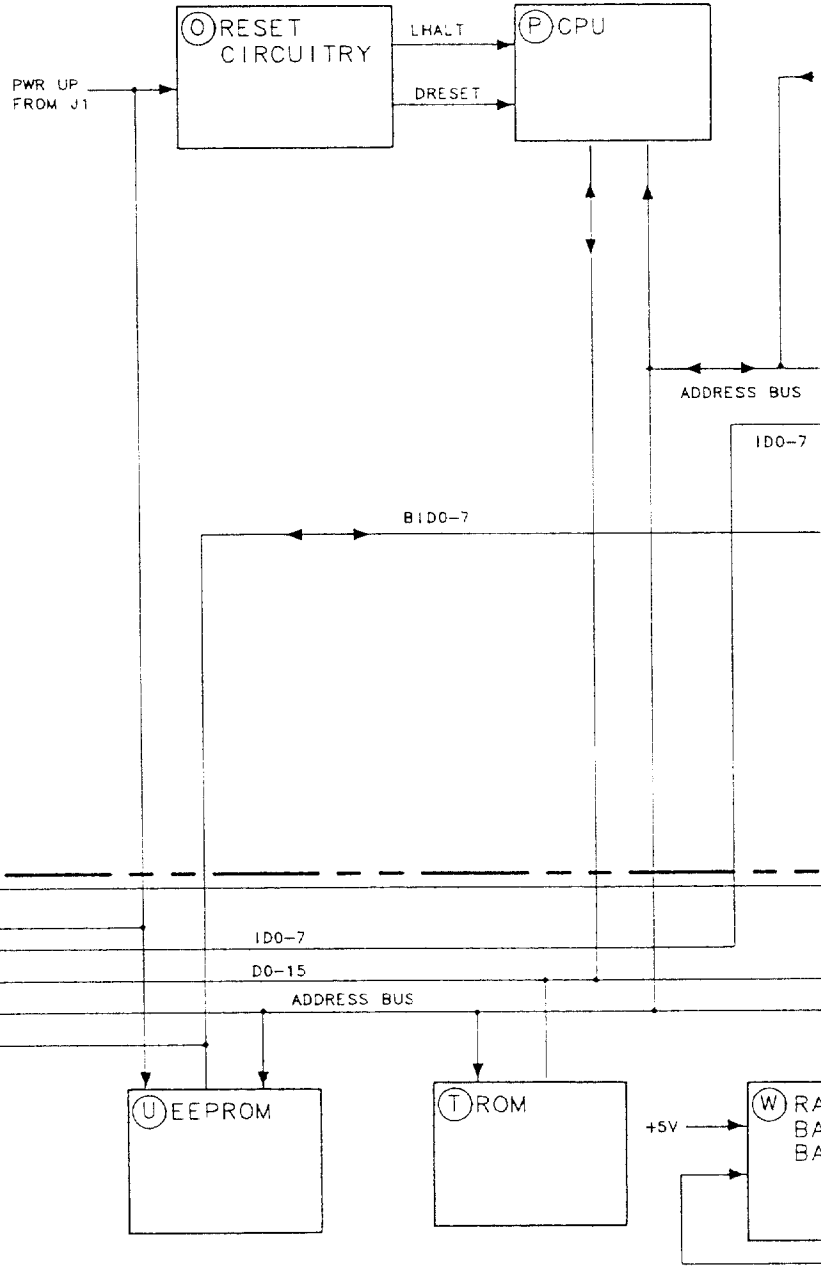
2. When the program runs, three or four clicks should be heard. This is the A9 input attenuator changing attenuation value.
3. If the display shows the spectrum analyzer to be in RMT and the ATTEN value displayed on the CRT changed according to the program, the A2 controller assembly is working properly. Refer to Chapter 7, "ADC/interface."
4. If there was no response over HP-IB, the A2 controller is probably defective. Be sure to also check the A19 HP-IB assembly and A19W1.
5. If there was an improper response (for example, the displayed ATTEN value changed but no clicks were heard), the A2 controller is probably working properly.
6. Attach a logic probe to A2U2 pin 2. Look for pulses while pressing a key and rotating the knob (RPG). This is the interrupt request signal for the keyboard and RPG.
7. If the interrupt request signal is always low, troubleshoot the A2 controller assembly.
8. If the interrupt request signal is always high, the fault is on either the A3 interface or A1A1 keyboard assembly.







SHEET 1 OF 4



SHEET 4 OF 4

HP-1B

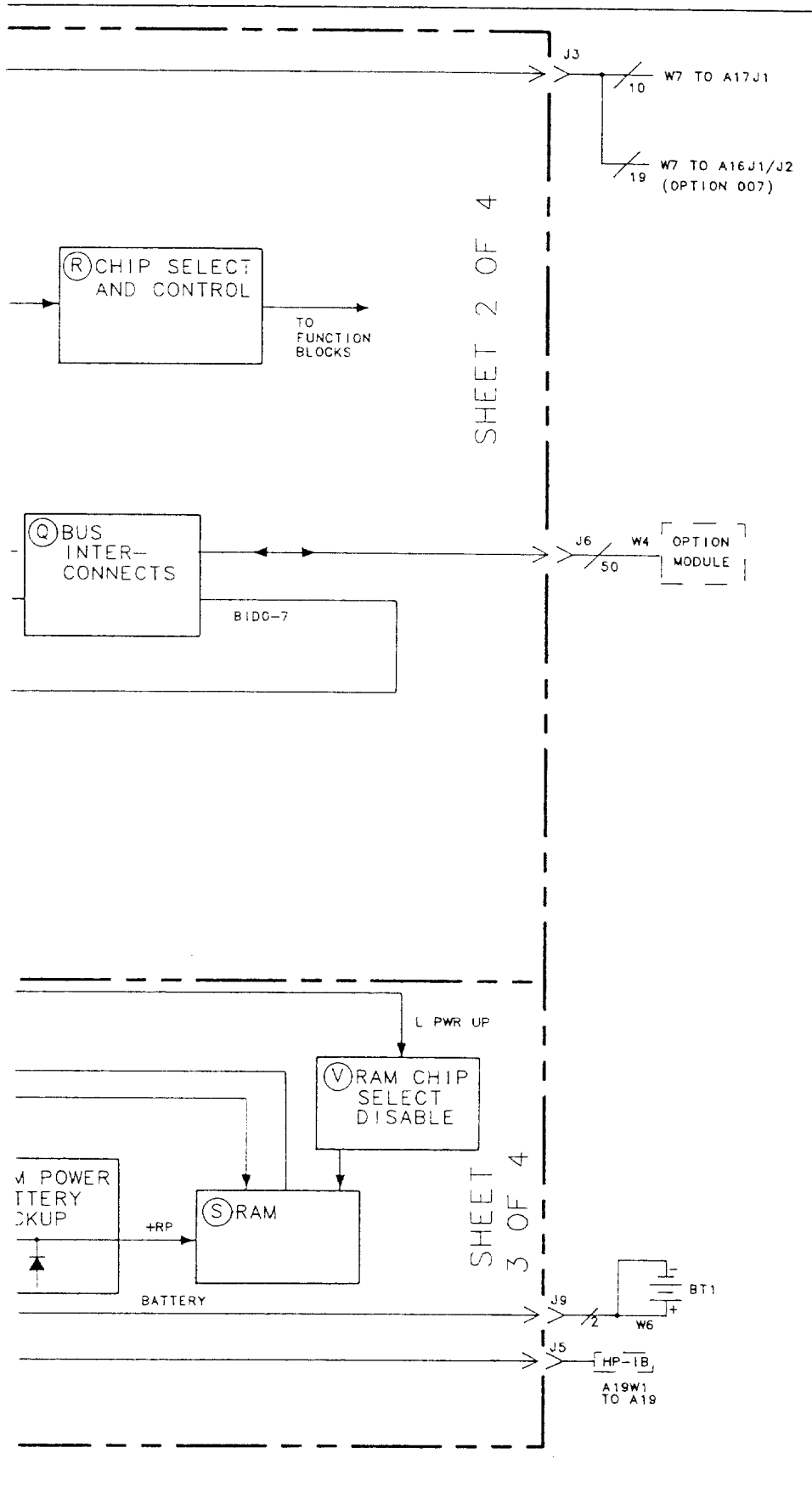


FIGURE 9-12. A2 CONTROLLER BLOCK DIAGRAM

Synthesizer Section

The synthesizer section includes the A7 first LO distribution amplifier, A11 YTO, and parts of the A14 frequency control and A15 RF assemblies. Simplified and detailed block diagrams for each assembly are located at the end of this chapter.

- Synthesizer Troubleshooting Section
 - Test Setup Troubleshooting
 - Troubleshooting Using the TAM
 - General PLL Troubleshooting
 - PLL Locked at Wrong Frequency
 - Unlocked PLL
 - Unlocked Reference PLL (100 MHz VCXO)
 - Operation (100 MHz VCXO)
 - Troubleshooting (100 MHz VCXO)
 - Third LO Driver Amplifier (100 MHz VCXO)
 - Unlocked Reference PLL (600 MHz SAWR)
 - Operation (600 MHz SAWR)
 - Troubleshooting (600 MHz SAWR)
 - Third LO Driver Amplifier (600 MHz SAWR)
 - Unlocked Offset Lock Loop (Sampling Oscillator)
 - Operation
 - Troubleshooting
 - Unlocked YTO PLL
 - Operation
 - Troubleshooting an Unlocked YTO PLL
 - Unlocked Fractional N PLL
 - Operation
 - Confirming an Unlocked Condition
 - Fractional N PLL
 - Frequency Span Accuracy Problems
 - Determining the First LO Span
 - Confirming Span Problems
 - YTO Main Coil Span Problems (LO Spans >20 MHz)
 - YTO FM Coil Span Problems (LO Spans 2.01 MHz to 20 MHz)
 - Fractional N Span Problems (LO Spans ≤ 2 MHz)
 - First LO Span Problems (All Spans)
 - Phase Noise Problems
 - Phase Noise in Locked versus Unlocked Spans
 - Reference versus Reference PLL Phase Noise
 - Fractional N versus Offset PLL or YTO PLL Phase Noise
 - Fractional N PLL Phase Noise
 - Sampler and Sampler IF
 - Sweep Generator Circuit
 - A21 OCXO

Caution	All of the assemblies are extremely sensitive to electrostatic discharge (ESD). For further information regarding electrostatic cautions, refer to “Electrostatic Discharge Information” in Chapter 1.
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Caution	Using an active probe, such as an HP 85024A, with a spectrum analyzer is recommended for troubleshooting the RF circuitry. If an HP 1120A active probe is being used with a spectrum analyzer, such as the HP 8566A/B, or HP 8569A/B having dc coupled inputs, either set the active probe for an ac coupled output or use a dc blocking capacitor (HP 11240B) between the active probe and the spectrum-analyzer input. Some spectrum analyzers can be set to ac coupled. Failure to do this can result in damage to the spectrum analyzer or the probe.
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Synthesizer Troubleshooting Section

The A11 YTO (the HP 8560E's first LO) is a YIG-tuned oscillator which tunes from 2.95 to 6.8107 GHz. The A7 LO distribution amplifier (LODA) levels A11's output and distributes the signal to the A8 low band mixer, A10 YIG-tuned mixer/filter, A15U100 sampler, and the front panel's 1ST LO OUTPUT. The synthesizer section includes the following PLLs (Phase Locked Loops):

YTO PLL	A7, A11, A14 and A15 assemblies
Offset PLL (sampling oscillator PLL)	A15 RF assembly
Fractional N PLL	A14 frequency control assembly
Reference PLL	A15 RF assembly

The fractional N PLL is sometimes swept backwards (higher frequency to lower frequency). This is necessary because of the way in which the sampler IF signal is produced.

-
- | | |
|-------------|---|
| Note | <ul style="list-style-type: none">■ The frequency control board is digitally controlled. If multiple failures appear in unrelated areas of the circuitry, the control may be at fault. Refer to the troubleshooting procedures in this chapter for further help on isolating those failures.■ The TAM tests the signal path circuitry by digitally controlling the hardware and monitoring the control lines to make sure they are responding properly. Use the TAM's automatic fault isolation routine or verify the RF levels manually to ensure proper operation. |
|-------------|---|
-

Check A3 ADC MUX function block (steps 1-4)

1. Connect a DVM's positive lead to A15J200 pin 13 and the negative lead to A15J200 pin 6. This measures the sampling oscillator tune voltage which is an input to the A3 interface assembly's ADC MUX.

2. Set the HP 8560E to the following settings:

Span 0 Hz
Center frequency 389.5 MHz
Trigger Single

3. Use the data entry keys to tune the **CENTER FREQ** to the values listed in Table 10-1.
4. As the sampling oscillator frequency is increased, the DVM reading should also increase. If the tune voltage is correct, but the ADC measures the voltage and determines it to be out of specification, troubleshoot the A3 assembly's ADC MUX.

Table 10-1. Center Frequency Tuning Values

HP 8560E Center Frequency (MHz)	Sampling Oscillator's Frequency (MHz)
2156.3	285.000
2176.3	286.364
2199.5	287.500
2230.3	288.462
799.3	288.889
2263.3	290.000
2282.3	290.909
2302.3	291.667
2155.3	292.500
2158.3	293.478
2336.3	294.444
2196.3	295.000
1.3	296.000
2378.3	296.471
2410.3	297.000
2422.3	297.222

Check A14J301 10 MHz reference input (steps 5-8)

5. Disconnect W37 from A14J301.
6. Connect a test cable from W37 to the input of another spectrum analyzer. Tune the other spectrum analyzer to the following settings:
Center frequency 10 MHz
Span 2 MHz
7. The amplitude of the 10 MHz reference signal should measure >-1 dBm. If the signal does not measure >-1 dBm, troubleshoot A15's 10 MHz distribution and A21 OCXO (if not Option 103).
8. Reconnect W37 to A14J301.

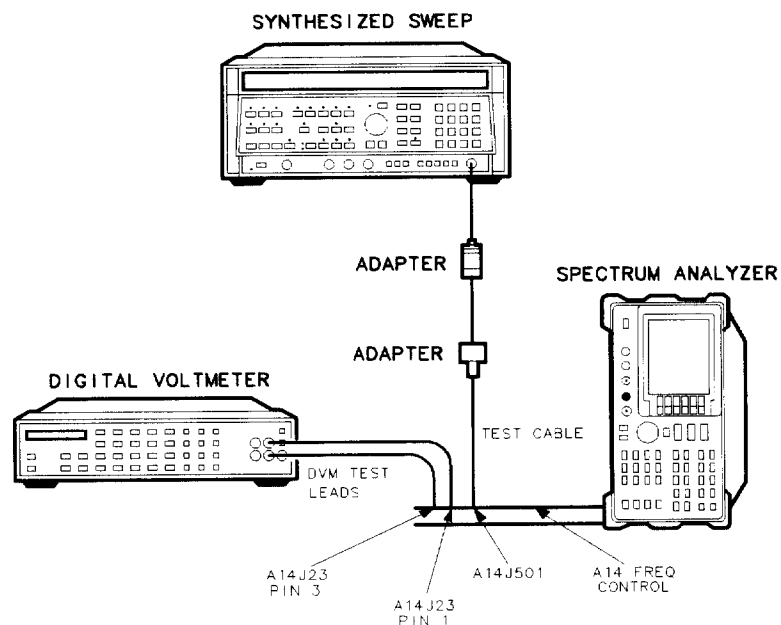
Check first LO (steps 9-11)

9. Connect the CAL OUTPUT to INPUT 50Ω.
10. Set the HP 8560E to the following settings:
Center frequency 300 MHz
Span 100 MHz
Trigger CONT
11. If the first LO is present, a signal should be displayed at about -10 dBm (approximately ±20 MHz from the center frequency). If no signal is displayed and ERR 334 LO AMPL is not present, suspect the A7 LODA. If no signal is displayed and ERR 334 LO AMPL is present, check the A11 YTO as follows:
 - a. Set jumper A14J23 to the TEST position.
 - b. Set the HP 8560E to the following settings:
Center frequency 50 Hz
CF step 300 MHz
Span 0 Hz
 - c. Connect a power meter directly to the output of the A11 YTO.
 - d. Press the HP 8560E's step-up key and measure the YTO output power at each step.
 - e. Check that A11 YTO's output power is between +9 and +13 dBm.
 - f. Set jumper A14J23 to the NORM position and reconnect the A11 YTO.

Check A14 frequency control assembly (steps 12-17)

12. On the HP 8560E press **PRESET**, **SPAN**, **ZERO SPAN**, **CAL**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, and **FRAC N FREQ**. Note the fractional N oscillator frequency. (Ignore the minus sign, if present.)

Fractional N Oscillator Frequency = _____ MHz
13. Check A14J304 (FRAC N TEST) port with a spectrum analyzer for this exact frequency. The amplitude should be approximately -10 dBm.
14. Disconnect W32 from A14J501 and connect the output of a signal source to A14J501. Remove the jumper from A14J23. Connect a DVM's positive lead to A14J23 pin 1 and negative lead to A14J23 pin 3. See Figure 10-1.
15. Set the signal source to the following settings:
Power 0 dBm
Frequency Frequency recorded in step 12
16. Tune the source 1 kHz below the fractional N frequency. The voltage measured on the DVM should be approximately 12 Vdc.
17. Tune the source 1 kHz above the fractional N frequency. The voltage measured on the DVM should be approximately -12 Vdc.
18. If the DVM reading does not change, the A14 frequency control assembly is defective. Reconnect W32 to A14J501.



sp127e

Figure 10-1. YTO Loop Test Setup

Check A15 RF assembly (steps 18-25)

19. Disconnect W34 from A15U100J1 and disconnect W32 from A15J101.
20. Connect a frequency counter to A15J101. Connect a high-frequency test cable from an HP 8340A/B synthesized sweeper to A15U100J1. See Figure 10-2.
21. Connect a BNC cable from the HP 8560E's 10 MHz REF IN/OUT to the HP 8340A/B's FREQUENCY STANDARD EXT input.
22. Set the HP 8340A/B to the following settings:

Frequency standard	EXT
Power level	-5 dBm
23. Set the HP 8560E to the following settings:

Span	0 Hz
Trigger	Single
24. Set the HP 8560E and HP 8340A/B frequencies to the combinations listed in Table 10-2 and press **SGL SWP** on the spectrum analyzer.

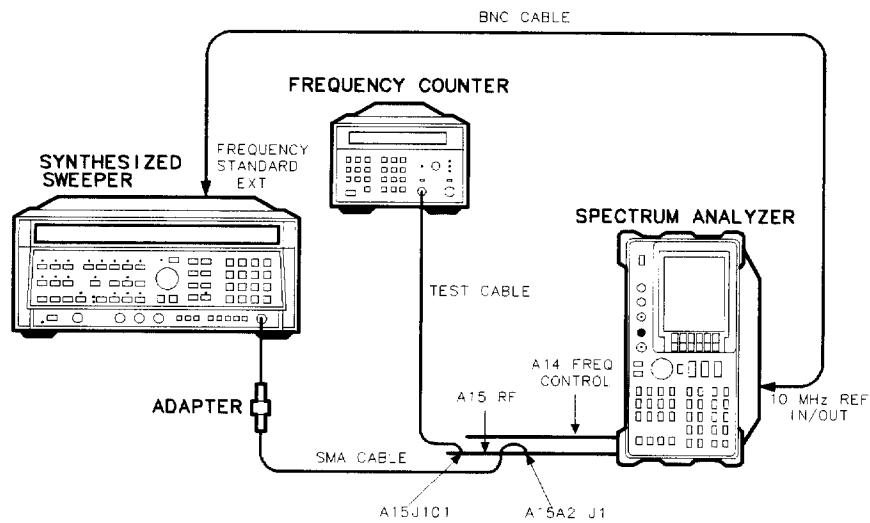


Figure 10-2. Sampler and Sampling Oscillator Test Setup

25. At each combination, the frequency counter should measure a sampler IF as shown in Table 10-2. (The offset PLL's sampling oscillator tunes to the frequencies listed in the table.) If the frequency counter does not read the indicated sampler IF ± 10 kHz, suspect the A15 RF assembly.
26. Reconnect W34 to A15U100J1 and W32 to A15J101.
27. The 1ST LO OUTPUT, located on the front panel, must be terminated in 50 Ω . If the YTO unlocks only with certain center frequency and span combinations, check that the termination is in place.
28. Set the HP 8560E's **CENTER FREQ** and **SPAN** to generate the unlock conditions.
29. On the HP 8560E press **SGL SWP**.
30. Move jumper A14J23 to the TEST position.
31. Disconnect W34 from A15U100J1 and measure the power of the signal at the end of W34.
32. If the power is less than -6.5 dBm, suspect W34, A7 LODA, or A11 YTO.
33. Move jumper A14J23 to the NORM position.

Table 10-2. Sampling Oscillator Test Frequencies

HP 8340A CW Frequency (GHz)	HP 8560E Center Frequency (MHz)	Offset PLL Sampling Oscillator Freq (MHz)	Counter Reading Sampler IF (MHz)
6.067000	2156.3	285.000	82.000
6.087000	2176.3	286.364	73.364
6.110200	2199.5	287.500	72.700
6.141000	2230.3	288.462	83.308
4.710000	799.3	288.889	87.778
6.174000	2263.3	290.000	84.000
6.193000	2282.3	290.909	83.909
6.213000	2302.3	291.667	88.000
6.066000	2155.3	292.500	76.500
6.069000	2158.3	293.478	94.044
6.247000	2336.3	294.444	63.667
6.107000	2196.3	295.000	88.000
3.912000	1.3	296.000	64.000
6.289000	2378.3	296.471	63.118
6.321000	2410.3	297.000	84.000
6.333000	2422.3	297.222	91.333

Test Setup Troubleshooting

Some synthesizer section problems require placing the YTO PLL in an unlocked condition. This is done by moving jumper A14J23 to the TEST position. This grounds the YTO ERROR signal, disabling the CPU's ability to detect an unlocked YTO. The FM coil driver output is set to its mid-range level causing the YTO to be controlled only by the main coil tune DAC.

Synthesizer section troubleshooting is best done with the HP 8560E's SPAN set to 0 Hz (even though it is still possible to sweep the Main and FM coils of the YTO).

With the YTO in its unlocked conditions and the SPAN set to 0 Hz, the nominal YTO frequency is not necessarily the value listed as LO FREQ in the Frequency Diagnose menu. The YTO has an initial pretune accuracy of ± 20 MHz. To display the nominal YTO's frequency, press **[CAL]**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, **LO FREQ**.

The fractional N oscillator frequency is the same as the desired sampler IF. To display the fractional N oscillator frequency press **[CAL]**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, **FRAC N FREQ**. If the sampler IF is negative (YTO frequency is lower than the desired sampling oscillator harmonic), the fractional N frequency will be displayed as a negative number.

Troubleshooting Using the TAM

When using automatic fault isolation, the TAM indicates suspected circuits that need to be manually checked. Use Table 10-4 to locate the manual procedure.

Table 10-5 lists assembly test connectors associated with each manual probe troubleshooting test. Figure 10-3 illustrates the location of A14 and A15 test connectors.

The pin locations of a 16-pin TAM connector are indicated in Figure 10-4. Table 10-3 indicates the correspondence between a measured signal line and the TAM connector pin.

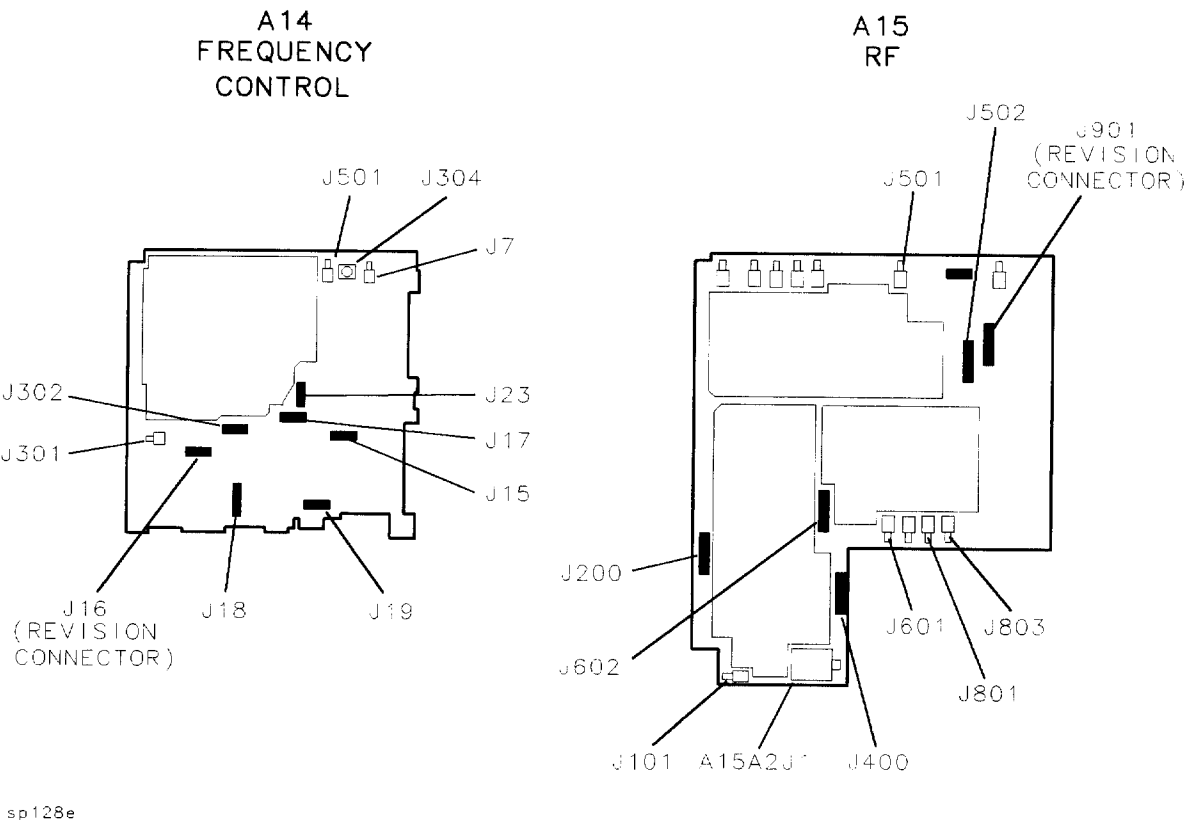


Figure 10-3. A14 and A15 Test Connectors

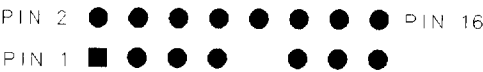


Figure 10-4. TAM Connector Pin Locations

Table 10-3. Measured Signal Line Location

Measured Signal Line	Connector Pin
MSL1	pin 1
MSL2	pin 2
MSL3	pin 3
MSL4	pin 4
MSL5	pin 5
GND	pin 6
MSL6	pin 13
MSL7	pin 14
MSL8	pin 15

Table 10-4. Automatic Fault Isolation References

Suspected Circuit Indicated by Automatic Fault Isolation	Manual Procedure to Perform
Check the YTO loop	Confirming a Faulty Synthesizer Section (<i>steps 9-11</i>)
Check first LO	Unlocked YTO PLL (<i>steps 10-13</i>)
Check first LO pretune frequency and amplitude	Third LO Driver Amplifier (<i>steps 1-6</i>)
Check 3rd LO drive	Unlocked Reference PLL (<i>steps 8-13</i>)
Check 10 MHz reference to phase/frequency detector	Unlocked Reference PLL (<i>steps 12 and 13</i>)
Check for 10 MHz signal at other input to phase/frequency detector	Confirming a Faulty Synthesizer Section (<i>steps 1-4</i>)
Check A3 ADC MUX function block	Confirming a Faulty Synthesizer Section (<i>steps 12-17</i>)
Check A14 frequency control assembly	Confirming a Faulty Synthesizer Section (<i>steps 5-8</i>)
Check A14J301 10 MHz REF input	Confirming a Faulty Synthesizer Section (<i>steps 18-25</i>)
Check A15 RF assembly	First LO Span Problems (All Spans) (<i>steps 14-21</i>)
Check current source	Unlocked YTO PLL (<i>steps 28-34</i>)
Check FM loop sense	Third LO Driver Amplifier (<i>steps 1-6</i>)
Check level at amplifier Input	Unlocked Offset PLL (<i>steps 3-13</i>)
Check levels into mixer U400	Unlocked Offset PLL (<i>steps 1 and 2</i>)
Check loop references	Unlocked YTO PLL (<i>steps 45-49</i>)
Check main coil tune DAC	Unlocked YTO PLL (<i>steps 41-44</i>)
Check main coil coarse and fine DACs	First LO Span Problems ≤ 2 MHz (<i>step 8</i>)
Check offset span accuracy	Unlocked Reference PLL (<i>steps 17-22</i>)
Check phase/frequency detector	Unlocked Offset PLL (<i>steps 3-7, 14-19</i>)
Check path to phase/frequency detector	Unlocked YTO PLL (<i>steps 14-18</i>)
Check fractional N oscillator	Unlocked YTO PLL (<i>steps 19-22</i>)
Check sampler drive output of A7 LODA	Unlocked YTO PLL (<i>steps 23-27</i>)
Check sampler IF	Sampler and Sampler IF (<i>steps 1-15</i>)
Check sampler/sampler IF operation	First LO Span Problems (All Spans) (<i>steps 6-13</i>)
Check span attenuator	Sweep Generator Circuit
Check sweep generator	Unlocked Reference PLL (<i>steps 23-26</i>)
Check the 600 MHz reference loop amplifier	Unlocked YTO PLL
Check the YTO loop	First LO Span Problems (2.01 MHz to 20 MHz) (<i>step 6</i>)
Check YTO FM coil driver	Unlocked YTO PLL (<i>steps 35-40</i>)
Check YTO FM coil driver and main loop error voltage driver	

Table 10-5. TAM Tests versus Test Connectors

Connector	Manual Probe Troubleshooting Test	Measured Signal Lines
A14J15	Sweep generator	MS8
	Span attenuator DAC	MS7
	Span attenuator switches	MS7
	Sweep + tune mult input amp	MS1, OS1
	Sweep + tune mult input switches	MS1, MS3
A14J16	FAV generator	MS4
	FAV gen 0.5 V/GHz output	MS5
A14J17	Main coil coarse DAC	MS3
	Main coil fine DAC	MS2
	Main coil DACs output	MS5
	Main loop error volt DVR	MS4
	Option drive	MS8
	Option drive switch	MS7
	Option drive DAC	MS6
A14J18	± 10 V reference	MS1, MS2
	LODA drive	MS5, MS6, MS7, MS8
	Main coil tune DAC	MS3
	Sweep gen DAC	MS4*
	Sweep gen DAC	MS4*
A14J19	Second conv PIN switch	MS8
	Second conv mixer bias	MS1
	Second conv drain bias	MS3
	Second conv doubler bias	MS4
	Second conv driver bias	MS5
	First mixer drive switch	MS7
	First mixer drive DAC	MS6
A14J302	Revision	MS7
	Fractional N out	MS1
	Divided reference	MS4
	Feedback buffer bias	MS5
	Outamp bias	MS6
* Only on A14 assemblies with part numbers 08560-60059, 08560-69059, 08560-60062, 08560-69062.		

Table 10-5. TAM Tests versus Test Connectors (continued)

Connector	Manual Probe Troubleshooting Test	Measured Signal Lines
A15J200	Positive 15 volt supply	MS1
	Sampler drive buffer bias	MS2
	Sampling oscillator bias	MS3
	Offset lock drive buffer	MS4
	OFL error voltage	MS6
	Negative 10 volt supply	MS8
	Offset lock loop BW DAC	MS5,MS7,MS8
A15J400	Positive 15 volt supply	MS2
	Offset lock RF buffer	MS4
	IF AMP/limiter bias	MS6
	Offset lock loop buffer D	MS7
	Offset lock loop buffer C	MS8
	Sampler bias test	MS3
A15J502	Positive 15 volt supply	MS2
	Third LO tune voltage	MS3
	Offset lock loop buffer	MS4
	600 MHz oscillator bias	MS5
	Calibrator AGC amp bias	MS6
	Calibrator ampl adj	MS7
	3rd LO driver amp	MS1, MS8
A15J602	Positive 15 volt supply	MS8
	Flatness compensation 3	MS2
	Flatness compensation 2	MS5
	Flatness compensation 1	MS6
	SIG ID collector bias (Option 008)	MS7
	RF gain control test	MS1, MS3
A15J901	Revision	MS3
	External mixer switch	MS1, MS8
	Signal ID switch (Option 008)	MS5, MS6
	Ten volt reference	MS4
	External mixer bias	MS7

The synthesizer section relies heavily on phase-locked loops (PLL). Typically, faulty PLL's are either locked at the wrong frequency or unlocked. The information below applies to troubleshooting these two classes of problems on a generalized PLL.

Numbers in the following text identify items in Figure 10-5.

- Any frequency errors at reference (1) will be multiplied by N/M on the PLL's output.
- A sampler reference-frequency error (2) will be multiplied by its harmonic on the PLL's output.
- A mixer reference-frequency error (3) produces the identical error on the PLL's output.
- If divider input or output frequencies (4) are wrong, check for incorrect divide numbers and data controlling the dividers.

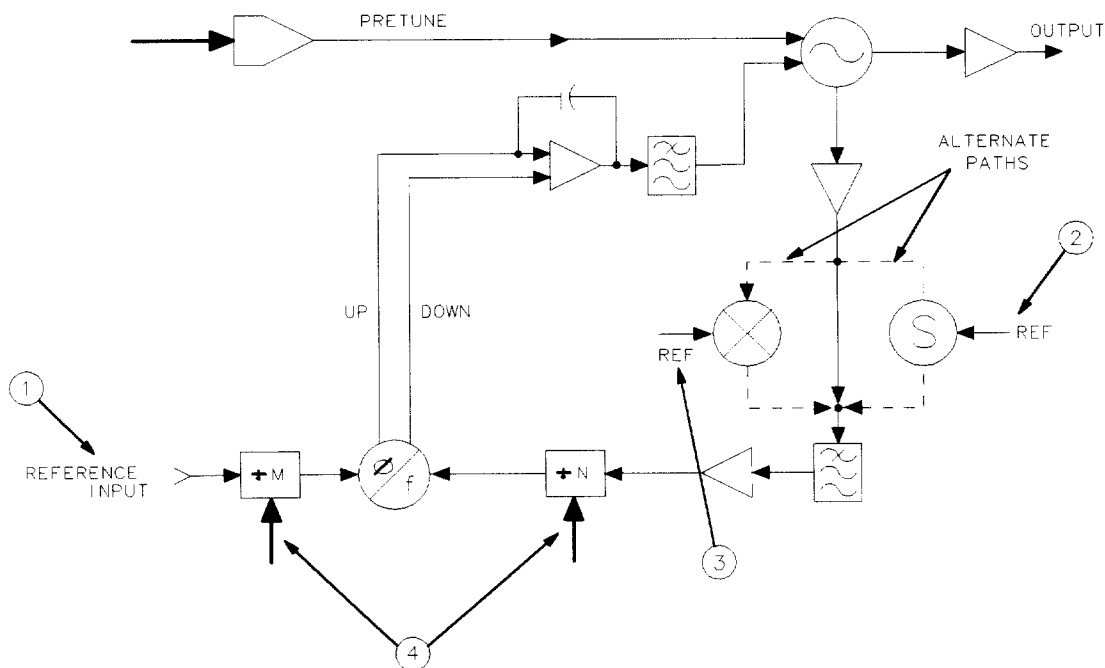


Figure 10-5. PLL Locked at Wrong Frequency

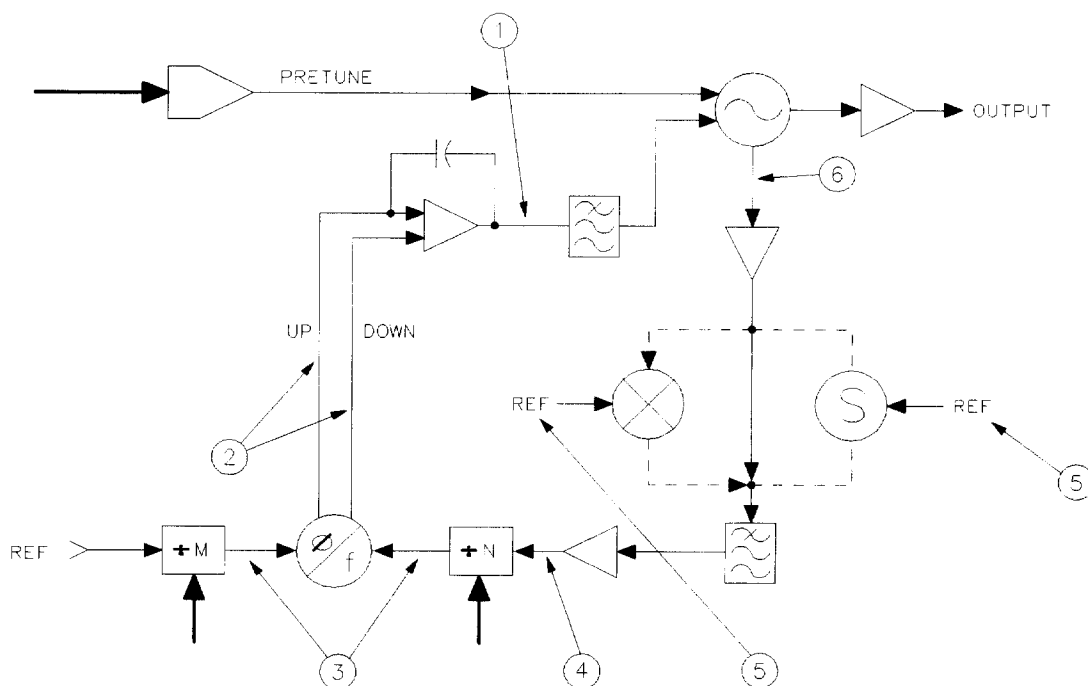
Unlocked PLL

An unlocked PLL can be caused by problems inside or outside the PLL. Troubleshoot this problem by working backward from the oscillator as described in the steps below. Numbers in the following text identify items in Figure 10-6.

1. The loop integrator's output voltage (1) should be attempting to tune the oscillator to the correct frequency.

The voltage at (1) should increase as the frequency increases on all of the PLLs:

PLL	Measurement Point
YTO PLL	A14J23 pin 1 (YTO ERROR)
Reference PLL	A15J502 pin 3 (LO3 ERR)
Sampler PLL	A15J200 pin 13 (OFL ERR)
Fractional N PLL	A14TP13 (INTEGRATOR)



sp130e

Figure 10-6. Unlocked PLL

2. If the integrator's output voltage changes in the manner described in step 1, the problem is external to the PLL. For example, the reference frequency could be faulty. If the integrator's output voltage appears incorrect, confirm that the pulses out of the phase detector (2) are attempting to tune the oscillator in the correct direction.

3. If the phase detector's output is bad, check the inputs to the detector (3). One input should be higher in frequency than the other; this should match the phase detector outputs.
4. Confirm proper power levels for the signals at the input to the "N" dividers (4), the reference inputs (5 and 7), and the loop's feedback path (6).

Unlocked Reference PLL (100 MHz VCXO)

Note The following information is for A15 RF assemblies 08563-60054, 08563-60055, and 08563-60056. For earlier A15 RF assemblies, proceed to *Unlocked Reference PLL (600 MHz SAWR)* in this chapter.

Operation (100 MHz VCXO)

The 600 MHz reference is generated by tripling, then doubling the output of the 100 MHz phase-locked loop. If the 600 MHz reference is off frequency, the 100 MHz phase-lock circuitry is probably at fault. If there is no signal present at A15J701, or if the level is less than -3 dBm, the 100 MHz VCXO, the tripler, or the doubler circuitry has probably failed. Refer to function blocks Q, R, and S of the A15 RF schematic (08563-90071, 08563-90072, or 08563-90073) sheet 2 of 4 in the *HP 8560 E-Series Spectrum Analyzer Component Level Information* binder.

Troubleshooting (100 MHz VCXO)

Check 100 MHz VCXO, tripler, and doubler (steps 1-7)

1. Using an active probe/spectrum analyzer combination, such as the HP 85024A/HP 8566B, measure the tripler output at A15TP700. The tripler output should be $+3$ dBm ± 2 dB.
2. If the tripler output is within tolerance, suspect the doubler circuitry. Refer to function block S of the A15 RF schematic.
3. If the tripler output is too low, probe the output of A15U700 RF amplifier. The level should be $+16.5$ dBm ± 2 dB. The level at the input of A15U700 should be $+8.5$ dBm ± 2 dB.
4. If the level at the input of A15U700 is too low, suspect a faulty 100 MHz VCXO. Refer to function block Q of the A15 RF schematic.
5. On the spectrum analyzer, press **AUX CTRL**, **REAR PANEL**, and **10 MHz INT**.
6. Measuring the tune voltage indicates if the 100 MHz PLL is locked. Connect the ground lead the voltmeter to A15J1 pin 3 and measure the voltage at A15J700 pin 3.
7. The tune voltage should be between $+1$ and $+24$ Volts. If the tune voltage is incorrect, place the P700 jumper (on A15J700) in the TEST position (pin 1 to pin 2). This sets the tune voltage for varactor A15CR700 to the nominal $+13$ Volts, making it easier to troubleshoot the 100 MHz VCXO, tripler, and doubler. Remember to return P700 jumper to the NORMAL position when you have finished troubleshooting the oscillator circuitry.

8. If the 100 MHz oscillator is working, the reason for the unlocked condition is either a problem in the 10 MHz reference or a fault in the signal path around the loop.

Check 10 MHz reference to phase/frequency detector (steps 9-14)

9. On the spectrum analyzer, press **AUX CTRL**, **REAR PANEL**, and **10 MHz INT**.
10. Check the 10 MHz reference frequency-accuracy by connecting a frequency counter to A15J301 and verify that the reference frequency is 10 MHz $\pm$ 40 Hz after a 5 minute warm-up period.
11. If a 10 MHz signal >1 V peak-to-peak is not present at A15J301, refer to the "10 MHz Reference" in Chapter 11.
12. Measure the signal at TP301 with an oscilloscope. Refer to function block M of A15 RF schematic.
13. Measure the signal at U502 pin 11 with an oscilloscope. Refer to function block X of A15 RF schematic. This signal should be TTL levels at 10 MHz with a 60 percent duty cycle.
14. If TTL-level signals (approximately 10 MHz) are not present, check signals backwards through the loop to find a fault in the signal path.
15. Measure the signals at the following test points with an active probe/spectrum analyzer combination:

Junction of C570 and C571	100 MHz, +2.5 dBm $\pm$ 2 dB
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Junction of R715, R716, R567, and R568	100 MHz, -3 dBm $\pm$ 2 dB
---	----------------------------

U700 pin 3	100 MHz, +16.5 dBm $\pm$ 2 dB
------------	-------------------------------

U700 pin 1	100 MHz, +8.5 dBm $\pm$ 2 dB
------------	------------------------------

16. If an approximately 10 MHz TTL signal is present at U502 pin 11 with 60 percent duty cycle, and the RF portion of the phase-lock loop is functioning, the fault probably lies in the phase/frequency detector or the 100 MHz lock loop integrator.

Check phase/frequency detector (steps 17-22)

17. Monitor U504 pin 5 and U503 pin 9 with an oscilloscope. These are the two outputs of the phase/frequency detector. Refer to function block O of A15 RF schematic.
18. A locked loop will exhibit stable, narrow (approximately 20 ns wide), and positive-going TTL pulses occurring at a 10 MHz rate at U504 pin 5 and U503 pin 9.
19. If the loop is unlocked, but signals are present on both inputs of the phase/frequency detector, the output pulses will be superimposed on each other.
20. If the loop is unlocked, and there is no signal at one of the phase/frequency detector inputs, one phase detector output will be at TTL low and the other will be at TTL high. For example, if there is no input signal at U504 pin 3, U504 pin 5 will be TTL low and U503 pin 9 will be TTL high. If there is no input signal at U503 pin 11, U503 pin 9 will be TTL low and U504 pin 5 will be TTL high.
21. To remove the 10 MHz reference input to the phase/frequency detector, press **AUX CTRL**, **REAR PANEL**, and **10 MHz EXT** with no signal applied to the rear-panel 10 MHz REF IN/OUT connector.
22. To remove the divided-down 100 MHz signal from the phase/frequency detector, short R595. Refer to function block X of A15 RF schematic.

Check the 100 MHz lock loop integrator (steps 23-27)

23. Remove 10 MHz reference input to the phase/frequency detector by pressing **AUX CTRL**, **REAR PANEL**, and **10 MHz EXT**. No signal should be connected to the rear-panel 10 MHz REF IN/OUT connector.

Note	The outputs of phase/frequency detector are low-pass filtered to reduce the 10 MHz component of the signal. The filtered signals are then integrated by U506 and the result is fed to the tune line of the 100 MHz VCXO.
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24. Check that the voltage on A15J502 pin 3 is less than 0 Vdc. Refer to function block P of A15 RF schematic.
25. Press **AUX CTRL**, **REAR PANEL**, and **10 MHz INT** and remove the divided-down 100 MHz input to the phase/frequency detector by shorting R572.
26. Check that the voltage on A15J502 pin 3 is greater than 13 Vdc.
27. If the loop is locked, the voltage on A15J502 pin 3 should be between 0 and +6 Vdc.

28. If the front-panel CAL OUTPUT amplitude is out of specification and cannot be brought within specification by adjusting A15R561, CAL AMPTD, check the calibrator AGC amplifier with the following steps. Refer to function block W of A15 RF schematic.

Note	The 300 MHz CAL OUTPUT signal comes from the tripled 100 MHz which is passed through a leveling loop. The 300 MHz signal passes through a low-pass filter for reducing higher harmonics. These harmonics can fool the detector. The 300 MHz signal passes through a variable attenuator controlled by PIN diode CR503 which is controlled by the feedback loop. Diode CR504 is the detector diode (the same type as CR505). Diode CR504 provides temperature compensation between the reference voltage and the detected RF voltage.
-------------	--

- a. Measure the level of 300 MHz at A15 TP505 with an active probe/spectrum analyzer combination. If the signal is less than +2 dBm, repeat the first 27 steps of this procedure.
 - b. If the signal at this point is correct, place a short across the PIN diode CR503.
 - c. If the signal level at the CAL OUTPUT is still less than -10 dBm with CR503 shorted out, troubleshoot the RF forward path through amplifier Q505. (The signal amplitude decreases.)
 - d. If the CAL OUTPUT signal level is greater than -10 dBm, troubleshoot the PIN diode attenuator, the detector, or the feedback path.
29. Measure the detector voltage at A15J502 pin 14. The voltage should measure approximately +0.3 Vdc when the CAL OUTPUT signal is at -10 dBm. This voltage should change with adjustment of A15R561, CAL AMPTD.
30. Check that the voltage at U507A Pin 3 is +1.7 Vdc. If this voltage is not correct, there may be a problem with the +10 V reference.
31. Measure voltage at U507B pin 5 while adjusting R561. This is the temperature-compensated adjustable voltage reference to which the detected voltage is compared. It should vary between +0.15 V and +0.6 V.
32. Adjust R561 to its limits and verify that the output U507B pin 7 measures approximately +1 Vdc at one limit and -12 Vdc at the other limit.

Third LO Driver Amplifier (100 MHz VCXO)

The third LO driver amplifier (Q503) amplifies the 300 MHz from the 300 MHz distribution amplifier to a sufficient level to drive the LO port of the double balanced mixer. During the SIG ID operation, diodes CR501 and CR502 turn off the 3rd LO driver amplifier in order to minimize the amount of 300 MHz going to the double-balanced mixer.

Check level at amplifier input (steps 1-6)

1. Press **AUX CTRL**, **INTERNAL MIXER**. Press **SIG ID OFF**, if option 008 is installed.
2. Use an active-probe/spectrum-analyzer combination to confirm the power level of the 300 MHz signal at the following test points:

A15X602 pin 5	$\geq +7$ dBm
A15TP504	$\geq +15$ dBm

3. If the signal at A15X602 pin 5 is low, but the signal at A15TP504 is correct, press **AUX CTRL**, **INTERNAL MIXER**. Press **SIG ID OFF**, if present.
4. Check that PIN diode switches CR603 and CR605 are reverse biased by approximately +10 Vdc. Refer to function block F of A15 RF schematic.
5. Measure 300 MHz signal at A15TP503 using an active probe/spectrum analyzer combination. If the signal is not approximately +10 dBm, refer to “Unlocked Reference PLL (100 MHz VCXO)” in this chapter.
6. If the level at the TP503 is correct, but signal at TP504 is too low, the fault is probably in the amplifier.

Unlocked Reference PLL (600 MHz SAWR)

Note The following information is for A15 RF assemblies earlier than 08563-60054, 08563-60055, or 08563-60056. For A15 RF assemblies with the aforementioned HP part numbers, refer to *Unlocked Reference PLL (100 MHz VCXO)* earlier in this chapter.

Operation (600 MHz SAWR)

The reference PLL's 600 MHz output is generated by a 600 MHz SAWR (surface acoustical wave resonator) VCO. The SAWR provides a high Q feedback path in the oscillator ensuring good phase noise. If the oscillator is off-frequency, the phase-lock circuitry is probably at fault. If there is no signal present at A15J701, or if the level is less than -3 dBm, the oscillator has failed. Transistor Q703 provides active bias for oscillator transistor Q701. Transistor Q704 provides active bias for 600 MHz buffer amplifier Q702. Refer to function blocks Q and R of A15 RF schematic in the *HP 8560E/HP 8561E/HP 8563E Component Level Information* binder.

Troubleshooting (600 MHz SAWR)

1. If Q701 and Q703 are functioning, check the bias on varactors CR701 and CR702. The varactors should be reverse-biased between 0 V and 18 V, depending on tune voltage.
2. If the active devices are functioning properly, check the SAWR by placing a 100-ohm resistor across U701 pins 1 and 2. This bypasses the SAWR, but provides the equivalent loss of a correctly functioning SAWR.
3. If the oscillator begins to oscillate, the SAWR is probably defective.
4. On the HP 8560E, press **AUX CTRL**, **REAR PANEL**, and **10 MHz INT**.
5. Measuring tune line voltage (LO3 ERR) indicates if the Reference PLL is locked. Measure the voltage at A15J502 pin 3. Connect the ground lead to A15J200 pin 6.
6. If voltage is not between 0 V and 5.75 V the loop is unlocked and **ERR 333 600 UNLK** should be displayed on the CRT.
7. If the 600 MHz oscillator is working, the reason for the unlocked condition is either a problem in the 10 MHz reference or a fault in the signal path around the loop.

Check 10 MHz reference to phase/frequency detector (steps 8-13)

8. On the HP 8560E, press **AUX CTRL**, **REAR PANEL**, and **10 MHz INT**.
9. Check the 10 MHz reference frequency-accuracy by connecting a frequency counter to A15J301 and verify that the reference frequency is $10\text{ MHz} \pm 40\text{ Hz}$ after a 5 minute warm-up period.
10. If a 10 MHz signal >1 V peak-to-peak is not present at A15J301, refer to the "10 MHz Reference" in Chapter 11.
11. Measure the signal on U504 pin 3 with an oscilloscope. Refer to function block O of A15 RF schematic.

12. Measure the signal at U504 pin 11 with an oscilloscope. Refer to function block O of A15 RF schematic. This signal should be TTL levels at 10 MHz with a 90 percent duty cycle.
13. If TTL-level signals (approximately 10 MHz) are not present, check signals backwards through the loop to find a fault in the signal path.
14. Use an oscilloscope to check for 50 MHz TTL level signal at U503 pin 2. Refer to function block X of A15 RF schematic.
15. Measure the signals at the following test points with an active probe/spectrum analyzer combination such as an HP 85024A/HP 8566A/B. The signal level at TP701 should be sufficient to drive an ECL input.

U502 pin 2	50 MHz, $\geq +3$ dBm
U502 pin 15	300 MHz, $\geq +3$ dBm
TP503	300 MHz, approximately +8 dBm
TP502	300 MHz (ECL level), approximately +3 dBm
TP701	600 MHz (ECL level), approximately +3 dBm

16. If an approximately 10 MHz TTL signal is present at U504 pin 11 with 90 percent duty cycle, and the RF portion of the phase-lock loop is functioning, the fault probably lies in the phase/frequency detector or the 600 MHz reference loop amplifier.

Check phase/frequency detector (steps 17-22)

17. Monitor U504 pins 5 and 9 with an oscilloscope. These are the two outputs of the phase/frequency detector. Refer to function block O of A15 RF schematic.
18. A locked loop will exhibit stable, narrow (approximately 20 ns wide), and positive-going TTL pulses occurring at a 10 MHz rate at U504 pins 5 and 9.
19. If the loop is unlocked, but signals are present on both inputs of the phase/frequency detector, the output pulses will be superimposed on each other.
20. If the loop is unlocked, and there is no signal at one of the phase/frequency detector inputs, one phase detector output will be at TTL low and the other will be at TTL high. For example, if there is no input signal at U504 pin 3, U504 pin 5 will be TTL low and U504 pin 9 will be TTL high. If there is no input signal at U504 pin 11, U504 pin 9 will be TTL low and U504 pin 5 will be TTL high.
21. To remove the 10 MHz reference input to the phase/frequency detector, press **AUX CTRL**, **REAR PANEL**, and **10 MHz EXT** with no signal applied to the rear-panel 10 MHz REF IN/OUT connector.
22. To remove the divided-down 600 MHz signal from the phase/frequency detector, short R572. Refer to function block W of A15 RF schematic.

Check the 600 MHz reference loop amplifier (steps 23-26)

23. Remove 10 MHz reference input to the phase/frequency detector by pressing **AUX CTRL**, **REAR PANEL**, and **10 MHz EXT**. No signal should be connected to the rear-panel 10 MHz REF IN/OUT connector.

Note The outputs of phase/frequency detector are low-pass filtered to reduce the 10 MHz component of the signal. The filtered signals are then integrated by U506 and the result is fed to the tune line of the 600 MHz oscillator.

24. Check that the voltage on A15J502 pin 3 is less than 0 Vdc. Refer to function block P of A15 RF schematic.
25. Press **AUX CTRL**, **REAR PANEL**, and **10 MHz INT** and remove the divided-down 600 MHz input to the phase/frequency detector by shorting R572.
26. Check that the voltage on A15J502 pin 3 is greater than 5.75 Vdc.
27. Replace C519 in X501.
28. If the loop is locked, the voltage on A15J502 pin 3 should be between 0 V and +5.75 Vdc.
29. If the front-panel CAL OUTPUT amplitude is out of specification and cannot be brought within specification by adjusting A15R561, CAL AMPTD, check the calibrator AGC amplifier with the following steps. Refer to function block W of A15 RF schematic.

Note The 300 MHz CAL OUTPUT signal comes from the divided down 600 MHz which is passed through a leveling loop. The 300 MHz signal passes through a low-pass filter for reducing higher harmonics. These harmonics can fool the detector. The 300 MHz signal passes through a variable attenuator controlled by PIN diode CR503 which is controlled by the feedback loop. Diode CR504 is the detector diode (the same type as CR505). Diode CR504 provides temperature compensation between the reference voltage and the detected RF voltage.

- a. Measure the level of 300 MHz at A15 TP505 with an active probe/spectrum analyzer combination. If the signal is less than +2 dBm, repeat the first 29 steps of this procedure.
 - b. If the signal at this point is correct, place a short across the PIN diode CR503.
 - c. If the signal level at the CAL OUTPUT is still less than -10 dBm with CR503 shorted out, troubleshoot the RF forward path through amplifier Q505. (The signal amplitude decreases.)
 - d. If the CAL OUTPUT signal level is greater than -10 dBm, troubleshoot the PIN diode attenuator, the detector, or the feedback path.
30. Measure the detector voltage at A15J502 pin 14. The voltage should measure approximately +0.3 Vdc when the CAL OUTPUT signal is at -10 dBm. This voltage should change with adjustment of A15R561, CAL AMPTD.
 31. Check that the voltage at U507A Pin 3 is +1.7 Vdc. If this voltage is not correct, there may be a problem with the +10 V reference.
 32. Measure voltage at U507B pin 5 while adjusting R561. This is the temperature-compensated adjustable voltage reference to which the detected voltage is compared. It should vary between +0.15 V and +0.6 V.
 33. Adjust R561 to its limits and verify that the output U507B pin 7 measures approximately +1 Vdc at one limit and -12 Vdc at the other limit.

Third LO driver amplifier (600 MHz SAWR)

The third LO driver amplifier (Q503) amplifies the 300 MHz from the 600 MHz phase-lock loop to a sufficient level to drive the LO port of the double balanced mixer. During the SIG ID operation, (Option 008 only), diodes CR501 and CR502 turn off the 3rd LO driver amplifier in order to minimize the amount of 300 MHz going to the double-balanced mixer.

Check level at amplifier input (steps 1-6)

1. Press **AUX CTRL**, **INTERNAL MIXER**. For Option 008, press **SIG ID OFF**.
2. Use an active-probe/spectrum-analyzer combination to confirm the power level of the 300 MHz signal at the following test points:

A15TP602	$\geq +7$ dBm
A15TP504	$\geq +15$ dBm
3. If the signal at A15TP602 is low, but the signal at A15TP504 is correct, press **AUX CTRL**, **INTERNAL MIXER**. For Option 008, press **SIG ID OFF**.
4. Check that PIN diode switches CR603 and CR605 are reverse biased by approximately +10 Vdc. Refer to function block F of A15 RF schematic.
5. Measure 300 MHz signal at A15TP503 using an active probe/spectrum analyzer combination. If the signal is not approximately +10 dBm, refer to "Unlocked Reference PLL (600 MHz SAWR)" in this chapter.
6. If the level at the TP503 is correct, but signal at TP504 is too low, the fault is probably in the amplifier.

Unlocked Offset Lock Loop (Sampling Oscillator)

Operation

The offset lock loop drives the A15U100 sampler. The offset lock loop's sampling oscillator tunes to one of sixteen discrete frequencies between 285 MHz and 297.222 MHz. Refer to A15 schematic. Mixer A15U400 mixes the oscillator's output with 300 MHz from the reference PLL, producing a 3 MHz to 15 MHz IF signal. The 3 MHz to 15 MHz signal is compared in the phase/frequency detector with the divided-down 300 MHz from the reference PLL. The phase/frequency detector drives a voltage-to-current diode switch which drives the loop integrator. Loop bandwidth switches vary the loop bandwidth to minimize noise sidebands. The sampling oscillator must produce low noise because the A15U100 sampler multiplies noise by a factor of approximately 24.

Table 10-6 lists the prescaler and postscaler divide numbers in the offset loop reference divide chain, for each of the 16 discrete frequencies to which the offset lock loop may be set. It also indicates what the reference frequency into the phase/frequency divide chain is. Refer to function block AN on the RF schematic.

Troubleshooting

Check loop references (steps 1 and 2)

1. Use an active probe and spectrum analyzer to confirm the presence of the following reference to the offset lock loop's input.

A15TP404

300 MHz at +5 dBm

2. This signal is not correct, refer to "Unlocked Reference PLL" in this chapter.

Check levels into mixer (steps 3-13)

3. Set the HP 8560E to the following settings:

Center frequency	300 MHz
Span	 0 Hz
Trigger	 SINGLE

4. Force the PLL to unlock by shorting A15X201 pin 1 to A15X201 pin 5 with a short length of wire. Then connect a dc power supply to A15J200 pin 16.
5. Monitor A15TP201 with an active probe/spectrum analyzer combination. Vary the dc supply until the frequency of the sampling oscillator is 296 MHz.
6. The voltage required to tune the oscillator should measure between +15 Vdc and +19 Vdc. If the voltage is out of this range, perform the sampling oscillator adjustment in Chapter 2.
7. Vary the voltage to tune the sampling oscillator to 296 MHz.
8. Use an active probe/spectrum analyzer combination to measure the 300 MHz LO signal at the following test point:

A15TP402

+7 dBm

9. If the signal is not measured near the indicated power, troubleshoot the offset lock loop buffer (function block AM of A15 RF schematic sheet 3 of 4).

Table 10-6. Sampling Oscillator PLL Divide Numbers

Sampling Oscillator Frequency (MHz)	Center Frequency* (MHz)	Reference Divide Chain		Reference Frequency (MHz)
		Prescaler	Postscaler	
285.000	2156.3	10	2	15.000
286.364	2176.3	11	2	13.636
287.500	2199.5	8	3	12.500
288.462	2230.3	13	2	11.538
288.888	799.3	9	3	11.111
290.000	2263.3	10	3	10.000
290.909	2282.3	11	3	9.091
291.666	2302.3	9	4	8.333
292.500	2155.3	8	5	7.500
293.478	2158.3	23	2	6.522
294.444	2336.3	9	6	5.556
295.000	2196.3	10	6	5.000
296.000	1.3	15	5	4.000
296.471	2378.3	17	5	3.529
297.000	2410.3	20	5	3.000
297.222	2422.3	18	6	2.778

* To set the sampling oscillator to a desired frequency, set span to 0 Hz and **CENTER FREQ** to the value listed in the table.

10. Measure the 296 MHz loop feedback signal at the following test point:

A15TP400

+2 dBm

11. If the feedback signal is not near the indicated power, measure the signals at the following test points on the feedback path. Refer to function blocks AD, AG, and AH of A15 RF schematic.

A15TP200

+4 dBm

A15TP201

+9 dBm

A15TP202

+5.5 dBm

12. Measure the 4 MHz loop-IF signal at the mixer output. The frequency of the IF is the same as the reference frequency and can be found in Table 10-6.

A15R447 (end nearest L414)

−6 dBm

13. If the IF signal is not near the indicated power, troubleshoot the loop mixer (function block AI).

Check path to phase/frequency detector (steps 14-19)

14. Measure the loop IF signal at the input to the IF amplifier/limiter (function block AK):

A15L428 (end nearest U411) 4 MHz (approximately -6 dBm)

15. Confirm the presence of a 4 MHz square-wave reference frequency signal at U406 pin 3. The square wave is TTL and should go below +0.6 V and above +2.2 V.
16. Disconnect the jumper from X201 pins 1 and 5. Disconnect the dc power supply which is connected to A15J200 pin 16.
17. Set HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz

18. Use an oscilloscope to confirm the presence of a 4 MHz TTL-level reference frequency signal at U406 pin 11.
19. Connect a short across A15R425. Connect A15U406 pins 3 and 11 together. This puts the same signal on both the phase/frequency detector inputs.
20. Observe the phase/frequency detector outputs, U406 pins 6 and 9, with an oscilloscope. Narrow TTL pulses should be present. Pin 9 is normally low, pulsing high, and pin 6 is normally high, pulsing low.
21. Check the end of L417 (nearest C445) with an oscilloscope. With the oscilloscope's input ac-coupled, a triangle waveform approximately 20 mVp-p should be present.
22. Short C441 with a wire jumper. (Connect the jumper from the end of R462 nearest C441 to the end of R460 nearest C443.) This changes the loop integrator into a voltage follower. Refer to function block AB of A15 RF schematic.
23. Check the voltages at the following points:

A15U408 pin 6	+2.5 Vdc (approximately)
A15X201 pin 1	+2.5 Vdc (approximately)

24. If the voltages are not correct suspect A15U408.
25. Remove the jumpers.

Unlocked YTO PLL

Operation

The A11 YTO is locked to two other oscillators, the fractional N oscillator and the offset PLL's sampling oscillator. For LO spans of 2.01 MHz and above, either the FM or main coil of the YTO is swept directly. For LO spans of 2 MHz and below, the fractional N oscillator is swept. The sampling oscillator remains fixed-tuned during all sweeps.

The output of A11 YTO feeds through the A7 LO distribution amplifier (LODA) to the A15U100 sampler. The offset PLL's sampling oscillator, which drives the sampler, oscillates between 285 and 297.222 MHz. The sampler generates harmonics of the sampling oscillator and one of these harmonics mixes with the YTO frequency to generate the sampler IF frequency. As a result, the frequency of the sampler IF is determined by the following equation:

$$F_{IF} = F_{YTO} - (N \times F_{SAMP})$$

Where:

F_{IF} is the sampler IF

F_{YTO} is the YTO's frequency

N is the desired sampling oscillator harmonic

F_{SAMP} is the sampling oscillator frequency

Notice that F_{IF} can be positive or negative depending upon whether the sampling oscillator harmonic used is below or above the YTO frequency. The actual sampler IF is always positive, but the sign is carried along as a "bookkeeping" function which determines which way to sweep the fractional N oscillator (up or down) and what polarity the YTO error voltage should have (positive or negative) to maintain lock.

To check if a negative sampler IF is selected, press **CAL**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, **FRAC N FREQ**. If the fractional N oscillator frequency is positive, the sampler IF is also positive. A negative fractional N frequency indicates that the sampler IF is negative.

Notice that the polarity of the YTO loop error voltage (YTO ERROR) out of the YTO loop phase/frequency detector changes as a function of the polarity of the sampler IF. That is, for positive sampler IFs, an increasing YTO frequency results in an increasing YTO ERROR signal. For negative sampler IFs, an increasing YTO frequency results in a decreasing YTO ERROR signal. This implies that to maintain lock in both cases, the sense of YTO ERROR must be reversed such that, with a negative sampler IF, an increasing YTO ERROR results in an increasing YTO frequency. This is accomplished with error-sign amplifier, A14U328B. This amplifier can be firmware-controlled to operate as either an inverting or non-inverting amplifier. Digital control line ERRSGN (from A14U313 pin 19) controls the polarity of this amplifier. When ERRSGN is high (positive sampler IF), the amplifier has a positive polarity.

In fractional N spans (LO Spans ≤ 2 MHz) the YTO remains locked to the sweeping fractional N PLL. Thus, the sampler IF must always equal the fractional N oscillator frequency (conditions for lock). Since the YTO must always sweep up in frequency, for negative sampler IFs, the fractional N oscillator must sweep from a higher frequency to a lower frequency. This is necessary since an increasing YTO frequency decreases the sampler IF for negative sampler IFs. The opposite is true for positive sampler IFs, so in these cases, the fractional N oscillator sweeps more conventionally from a lower frequency to a higher frequency.

Table 10-7 summarizes the amplifier polarities for the various combinations of sampler IF polarities and LO spans.

The YTO main coil filter is used to improve residual FM in FM and fractional N spans. See function block I of A14 frequency control schematic in the Component-Level Information binder. Transistors Q304 and Q305 switch the filter (capacitor C36 and resistor R48) into the circuit. Transistor Q303 and U333 keep C36 charged during main spans so the frequency does not jump when C36 is switch in.

Table 10-7. Amplifier Polarities

		YTO Error Sign Amplifier	ERRSGN (A14U313 pin 19)
Fractional N Oscillator Swept	Positive Sampler IF	Positive	TTL High
	Negative Sampler IF	Negative	TTL Low
FM/Main YTO Coils Swept	Positive Sampler IF	Positive	TTL High
	Negative Sampler IF	Negative	TTL Low

Troubleshooting an unlocked YTO PLL

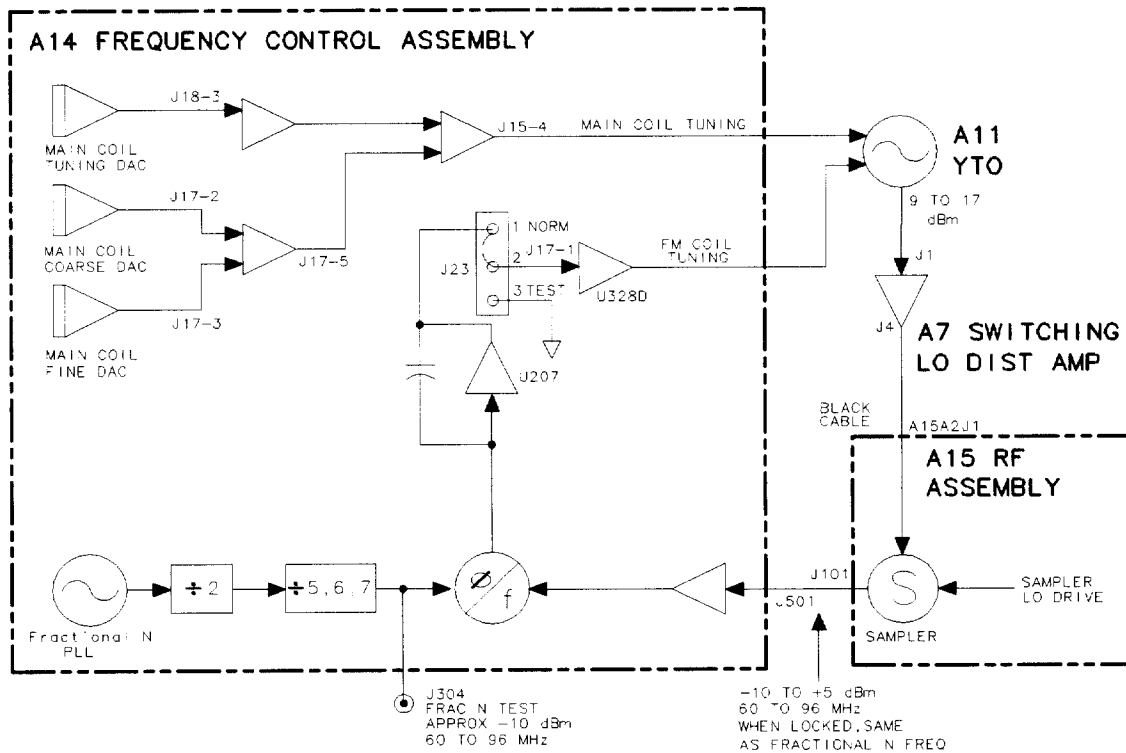
1. If the YTO PLL is unlocked, error code 301 should be displayed. Place the HP 8560E in ZERO SPAN. Figure 10-7 illustrates the simplified YTO PLL.
2. Move the jumper on A14J23 to connect pins 2 and 3 (TEST position). Refer to Figure 10-3 for the location of A14J23. Error code 301 should no longer be displayed. (The YTO PLL's feedback path is now open and the YTO error voltage is forced to zero.)

3. On the HP 8560E, press **CAL**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, and **LO FREQ**. The displayed LO FREQ is the desired YTO frequency calculated. Record the YTO's calculated frequency below:

YTO Frequency (calculated) = _____GHz

4. Measure the YTO frequency at the front-panel's 1ST LO OUTPUT jack and record below:

YTO Frequency (measured) = _____GHz



sp131e

Figure 10-7. Troubleshooting an Unlocked YTO PLL

5. Calculate the YTO's frequency error by subtracting the frequency recorded in step 3 from the frequency recorded in step 4. Record the result below:

YTO Frequency Error = _____MHz

$$\text{YTO Frequency Error} = \text{YTO Frequency (MEASURED)} - \text{YTO Frequency (CALCULATED)}$$

6. On the HP 8560E, press **MORE 1 OF 2**, **FREQ DIAGNOSE**, and **FRAC N FREQ**. Record the fractional N frequency below:

Fractional N frequency = _____MHz

Caution Replacement of the phase/frequency detector chip A14U204 is not recommended. The part is very delicate and requires special tooling to install successfully.

7. If the YTO frequency error recorded in step 5 is greater than 20 MHz, do the following:
 - a. Check the YTO Adjustments using the TAM or the procedure in Chapter 2.
 - b. Check the YTO DACs using the procedure in steps 41 through 49 below, or using manual probe troubleshooting with the TAM on A14J17 and A14J18.
 - c. Refer to steps 9 through 33 below.
8. If the YTO Frequency error recorded in step 5 is less than 20 MHz, do the following:
 - a. Measure the frequency at A14J304. The frequency should be equal to the frequency recorded in step 6. If not, refer to “Unlocked Fractional N PLL” in this chapter.
 - b. Measure the input and output levels of the A15U100 sampler. If the sampler appears defective, check the LO drive to the sampler as described in “Sampler and Sampler IF.”
 - c. Refer to steps 34 through 51 below.

Check first LO pretune frequency and amplitude (steps 10-13)

9. The first LO's pretuned frequency must be sufficiently accurate for the YTO loop to acquire lock. The first LO's amplitude must be sufficient to drive the A15U100 sampler. Perform the YTO Adjustment procedure, particularly the YTO main coil adjustments. (If available, use a synthesized microwave spectrum analyzer instead of the microwave frequency counter specified in the adjustment procedure.)
10. If the YTO's main coil cannot be adjusted, proceed to step 33 to troubleshoot the main coil coarse and fine DACs and main coil tune DAC.
11. The front-panel's 1ST LO OUTPUT should measure between +14.5 and +18.5 dBm in amplitude.
12. If the 1ST LO OUTPUT amplitude is out of the specified range, perform the first LO distribution amplifier adjustment procedure. Refer to Chapter 2.

Check the fractional N oscillator (steps 14-18)

13. Set the HP 8560E to the following settings:
Center frequency 300 MHz
Span 0 Hz
14. Monitor the fractional N PLL's output at A14J304 (FRAC N TEST) with a synthesized spectrum analyzer such as an HP 8568A/B or HP 8566A/B. Refer to function block AI of A14 frequency control schematic.
15. The signal at A14J304 (FRAC N TEST) should measure approximately -10 dBm at 66.7 MHz. If the loop is unlocked, the sampler IF frequency can also be seen on A14J304, about 30 dB below the fractional N signal, when unlocked.
16. If a problem exists only at particular CENTER FREQ and SPAN settings, determine the desired fractional N oscillator frequency by pressing **CAL**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, **FRAC N FREQ** and setting the HP 8560E to SINGLE trigger mode.

17. If the fractional N oscillator frequency is not correct, refer to “Unlocked Fractional N PLL” in this chapter.

Check sampler drive output of A7 LODA (steps 19-22)

18. Set jumper A14J23 to the TEST position and set the HP 8560E to the following settings:

Center frequency 2.9 GHz
Span 0 Hz

19. Disconnect cable W34 from A15U100J1.
20. Use a power meter to measure the A7 LODA sampler-drive output at the end of W34. The power should measure greater than -9 dBm.
21. Place jumper A14J23 in the NORMAL position and reconnect W34 to A15U100J1.

Check sampler IF (steps 23-27)

22. Set the HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz

23. Place jumper A14J23 in the TEST position.
24. Disconnect W32 from A15J101. Monitor the sampler IF output (A15J101, SAMPLER IF) with a synthesized spectrum analyzer such as an HP 8568A/B or HP 8566A/B.
25. The sampler IF should measure between 46 MHz and 86 MHz at -15 dBm to +2 dBm. If the signal frequency or amplitude is incorrect, refer to “Unlocked Offset PLL” in this chapter.
26. Set jumper A14J23 in the NORMAL position. Reconnect W32 to A15J101.

Check FM loop sense (steps 28-34)

27. Set jumper A14J23 in the TEST position.
28. Set the HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz

29. Connect an RF signal-generator output to A14J501. Set the signal generator to the following settings:

Frequency 56 MHz
Amplitude 0 dBm

30. Monitor A14J17 pin 1 with a DVM or oscilloscope. Connect ground to A14J17 pin 6.
31. As the signal generator frequency is increased to 76 MHz, the voltage at A14J17 pin 1 should change from approximately +12 V to -12 V.
32. Set the signal generator to the following settings and repeat step 30.
Frequency 56 MHz
Amplitude -15 dBm
33. If the voltage monitored in step 30 is correct with a 0 dBm output but not with -15 dBm output, suspect the limiting amplifier function block AE.
34. Place jumper A14J23 in the NORMAL position and reconnect W32 to A14J501.

Check YTO FM coil driver and main loop error voltage driver (steps & 35-40)

35. To troubleshoot the YTO FM coil driver, refer to step 6 of "First-LO Span Problems (2.01 MHz to 20 MHz)."
36. Steps 36 through 40 verify that the YTO-loop error voltage is reaching the FM coil. The main loop error voltage driver has a gain of either 1.5 or 15; the spectrum analyzer's firmware controls the gain during the locking process. The error voltage is read by the ADC on the A3 interface assembly. A14U326D calibrates out any offsets from true ground. A14U326A inverts the sense of the YTO loop to lock the YTO on lower sampler-sidebands (YTO frequency < (sampler frequency × sampler harmonic)). The fractional N frequency indicated in the **FREQ DIAGNOSE** menu will be negative when locking to lower sidebands. Refer to function blocks E, M, and N of A14 frequency control schematic in the *HP 8560E/HP 8561E/HP 8563E Component Level Information* binder.

Set the HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz

37. Remove jumper A14J23 and connect a dc power supply to A14J23 pin 2. Connect ground to A14J23 pin 3. Set the dc power supply to +7.5 Vdc.
38. Verify the nominal test-point voltages listed in Table 10-8.
39. Change the input voltage to -7.5 volts and re-verify that the voltages listed in Table 10-8 are the same except for a change in polarity.
40. Change the **CENTER FREQ** to 678.8 MHz with the **SPAN** remaining 0 Hz. This will change the switch setting of U326A and invert the voltages listed in Table 10-8.

Table 10-8. Voltages in FM Coil and Main Loop Drivers

Measurement Points	Voltages
A14U405 pin 6	+2.8 Vdc
A14U322 pin 2	0 Vdc
A14J17 pin 4	>+10 Vdc

Check main coil coarse and fine DAC's (steps 41-44)

41. The main coil coarse and fine DACs correct any initial pretune errors in the YTO main coil. The DACs adjust the FM-coil current to zero before any sweep begins. Refer to function block J of A14 frequency control schematic.
42. Set the HP 8560E to the settings listed below. This sets both DACs to 128 (the DAC setting range is 0 to 255).

Center frequency 300 MHz
Span 0 Hz
Trigger SINGLE, EXT
(with no external trigger connected)

43. Press **SAVE**, **PWR ON STATE** and turn off the spectrum analyzer.
44. Place jumper A14J23 in the TEST position and turn on the spectrum analyzer.

Check main coil tune DAC (steps 45-49)

45. Verify the voltages listed in Table 10-9.

Table 10-9. Main Coil Coarse and Fine DACs Voltages

Measurement Points	Voltages
A14J17 pin 2	–5 Vdc
A14J17 pin 3	–5 Vdc
A14J17 pin 5	+5Vdc

46. Place jumper A14J23 in the NORMAL position.
47. Set the HP 8560E to the following settings:

Center frequency	300 MHz
Span	 0 Hz
48. Place jumper A14J23 in the TEST position.
49. Measure the output of the main coil tune DAC (A14J18 pin 3) with a DVM. Refer to function block E of A14 frequency control schematic.
50. If the HP 8560E's center frequency is 300 MHz, the voltage at A14J18 pin 3 should measure $-3.35\text{ V} \pm 0.25\text{ V}$. The voltage may also be determined from the following equation:

$$V = -(\text{First LO Frequency} - 2.95\text{ GHz}) \times 2.654\text{ V/GHz}$$
51. The voltage at A14U330 pin 2 should measure $-3.4\text{ V} \pm 0.2\text{ Vdc}$. This represents a current setting the YTO to approximately 2.95 GHz.
52. Return jumper A14J23 to the NORMAL position.

Unlocked Fractional N PLL

Operation

The fractional N oscillator is used in the HP 8560E as a reference for the first LO phase locked loop. It provides the 1 Hz start- frequency resolution for the first LO, and is the means by which the first LO is swept in LO spans of 2 MHz or less (fractional N spans). The prescaler, fractional N divider, and the postscaler are preset at power-on.

The PLL operates to produce an output frequency in the range of 60 MHz to 96 MHz selectable in 1 Hz increments. The output frequency can be swept (increasing or decreasing) over a selectable 100 Hz to 2 MHz range.

To determine the fractional N frequency for any given center frequency, press **CAL**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, and **FRAC N FREQ**. The FRAC N FREQ frequency displayed is the frequency that will be measured at A14J304 with the HP 8560E in zero span.

Confirming an unlocked condition

1. Set the HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz

2. Connect A14J304 FRAC N TEST to the input of a synthesized spectrum analyzer and view the fractional N PLL output at 66.7 MHz.

Note	If a synthesized spectrum analyzer is not available, connect A14J304 to the input of a 20 dB gain amplifier, such as an HP 8447E. Connect the output of the amplifier to the input of a frequency counter.
-------------	--

3. If the fractional N oscillator measures a stable 66.7 MHz, the fractional N PLL is probably locked.
4. Check the two LED's visible through the shield on A14. If either LED is lit, the fractional N PLL is not locked.
5. If either LED on A14 is lit, and no error message is displayed, check FC MUX A14U305. Refer to function block AH of A14 frequency control schematic.
6. If neither LED is lit, but the output frequency is wrong by more than 1 MHz, check the postscaler, function block AV.
7. Check that the postscaler is dividing properly. The frequency at A14J304 should be equal to the frequency at A14TP4 divided by either 5, 6, or 7. Refer to Table 10-10. To keep the divide number at a constant value set the spectrum analyzer to:

Span 0 Hz
Trigger SINGLE, EXT
(with no external trigger connected)

Table 10-10. Postscaler Divide Numbers

Divide Number	D11	D10	D9	Input Range (MHz) (A14J304)	Output Range (MHz) (A14TP4)
7	0	0	1	840 to 973	60.0 to 69.5
6	0	1	0	834 to 987.96	69.5 to 82.33
5	0	1	1	823.2 to 960	82.33 to 96.0

If the output frequency is wrong by less than 1 MHz, the phase locked loop is not unlocked but still requires repair. Continue with the “Fractional N Oscillator PLL” section.

Fractional N PLL

The fractional N PLL provides a synthesized frequency in the range of 60 MHz to 96 MHz. The 800 MHz to 1020 MHz voltage controlled oscillator (VCO) in the loop is divided down to lock with the 2.5 MHz reference. Simultaneously, the VCO is divided by two and then by either 5, 6, or 7 to generate the 60 MHz to 96 MHz output.

The prescaler (function block AR) supplies the clock signal for the fractional divider and is required for the fractional divider to operate. At the start of a fractional N sweep the fractional divider is set to a value for the start frequency and a sweep rate. It then sweeps for as long as HSCAN is high. Use the following procedure to troubleshoot unlocked loop problems or problems of locking to the wrong frequency (by less than 1 MHz):

1. Check the two LEDs on A14 frequency control assembly. If either LED is lit, the fractional N phase locked loop is not locked.
2. The 10 MHz reference is required for fractional N operation. It is divided by four to 2.5 MHz in the reference divider circuitry, block AN. It is used to lock the divided voltage controlled oscillator (VCO) frequency. Check that the 10 MHz reference is present at A14J301. The 10 MHz reference is derived from the 600 MHz reference on the A15 RF assembly.
3. Change the spectrum analyzer from the fractional N span to 0 Hz.
4. Check the frequency at A14TP1. It should equal the value found by pressing **CAL**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, and **RAW OSC FREQ**.
5. Check the tune voltage at the ungrounded end of C135.
6. Look up the expected problem area in Table 10-11 with the information from steps 4 and 5. Go to the appropriate troubleshooting steps.

Table 10-11. Unlocked Fractional N Troubleshooting Areas

Measured VCO Frequency Relative to Expected Value	Tune Voltage				
	Below -12.5 V	About -11 V	Between ± 10 V	About +11 V	Above +12.5 V
Measured > expected	VCO clamp	VCO	Divider or integrator	Divider or integrator	VCO clamp
Measured < expected	VCO clamp	Divider or integrator	Divider or integrator	VCO	VCO clamp
Measured, not oscillating	VCO clamp	VCO	VCO	VCO	VCO clamp

7. VCO clamp troubleshooting:

Q131, Q132 and the associated components should limit the tune voltage at R240 to about ± 11 V. If the integrator (its output voltage is on TP13) tries to produce a voltage outside this range, excess current is shunted through CR131 and Q131 for positive excursions or CR132 and Q132 for negative excursions. The bases of these transistors should be at about ± 9.6 V for proper operation.

8. VCO troubleshooting:

Check the dc biases in the VCO function block. The bias voltages, for some points in the VCO, are indicated in Figure 10-8.

sp140e

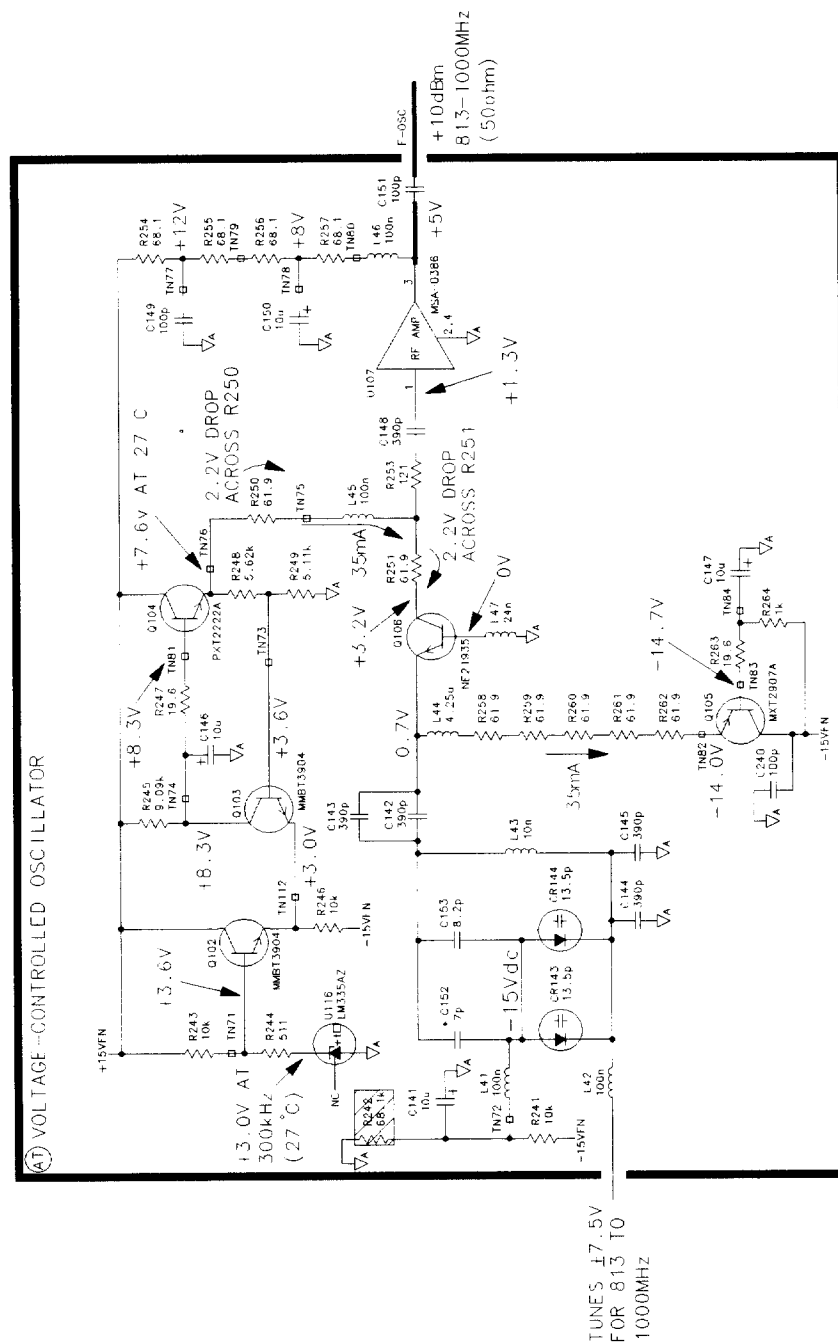


Figure 10-8. VCO Bias Voltages

9. Divider and integrator troubleshooting:

Measure the frequency of the pulses at TP6 in block AO. Look up the expected problem area in Table 10-12 and go to the appropriate troubleshooting steps.

Table 10-12. Divider and Integrator Troubleshooting

Measured VCO Frequency Relative to Expected Value	TP6 Frequency			
	zero	<2.5 MHz	2.5 MHz	>2.5 MHz
Measured > expected	Dividers	Dividers	Dividers	Det or integrator
Measured < expected	Both	Det or integrator	Dividers	Dividers

10. Divider troubleshooting:

- Check the frequency at A14TP2. It should be equal to the frequency at A14TP1 divided by two.
- The signal at A14TP3 should be above -14 dBm.
- Use an analog oscilloscope to view the signal at A14TP5. Adjust the scope's triggering to view the divide-by-16 signal. The frequency at this point will be varying as the prescaler changes its divide number to either 16, 17, 20, or 21. The prescaler uses 16 as the divide number most frequently. The frequency displayed on the oscilloscope should equal the frequency from TP2 divided by 16.
- Use an oscilloscope to view the signal at pin 8 of U112. Its average frequency should be given by:

$f = f(\text{A14TP5}) \times 80 \text{ MHz/RAW OSC FREQ}$ where: $f(\text{A14TP5})$ is the frequency measured at TP5, and RAW OSC FREQ comes from step 4.

If the frequency is in error, the fractional divider, block AS, is not functioning. Check that FRAC N RUN on U113 pin 39 is high.

- Use an oscilloscope to verify that the signals at N_in (U112 pin 8) and N_out (TP6) are identical except for a sub-microsecond delay.

Detector and integrator troubleshooting:

Check the phase detector output on TP11 in block AO. If F_{ref} is higher in frequency than TP6 (reclocked VCO/N), then the average voltage at TP11 should be positive by 0.05 V to 10 V. If F_{ref} is lower, TP11 should be -0.05 V to -10 V.

The polarity of the output of the loop gain (block AP, TP12) should be the same as the polarity of the input (TP11).

The integrator op amp (U106) output (TP13) should try to go very positive (about +12 V) if its average input (TP12) is positive. If its average input is negative, it should try to go very negative (about -12 V). If its average input is zero and it is functioning correctly, it may take on any output voltage between -12 V and +12 V.

Frequency Span Accuracy Problems

The HP 8560E employs lock-and-roll tuning to sweep the first LO for spans greater than 2.0 MHz. The first LO is locked to the start frequency immediately after the previous sweep has been completed. The first LO is then unlocked, and, when a trigger signal is detected, the first LO sweeps (rolls).

When there is a considerable delay between the end of one sweep and the beginning of the next, the actual first LO start frequency may differ from the locked start frequency. This start frequency drift will be most noticeable in a 2.01 MHz LO span (the narrowest FM coil span). This drift is not noticeable in either free run or line trigger modes. The sweep is generated by different oscillators in the synthesizer section depending on the desired first-LO's span (due to harmonic mixing, this is not necessarily the same as the span setting of the spectrum analyzer). Refer to Table 10-13 for a listing of sweep-signal destinations versus First LO spans. Sweeping the fractional N oscillator results in sweeping the YTO's FM coil. There is a one-to-one relationship between the fractional N oscillator's frequency span and the first-LO's span. The fractional N oscillator sweep is generated digitally. The oscillator is always synthesized, rather than employing lock and roll tuning.

Table 10-13. Sweep Signal Destination versus Span

First LO Span	Sweep Signal Destination
>20 MHz	A11 YTO's main coil
2.01 MHz to 20 MHz	A11 YTO's FM coil
≤2 MHz	None
	Fractional N oscillator sweeps without a sweep ramp signal.

Determining the first LO span

The first-LO's span depends on the spectrum analyzer's harmonic-mixing number. Use the following steps to determine the first LO's span:

1. Read the span setting displayed on the HP 8560E.
2. Determine the harmonic-mixing number from the information in Table 10-14.

Table 10-14. Harmonic Mixing Number versus Center Frequency

Center Frequency	Harmonic Mixing Number
1 kHz to 2.9 GHz	1
18 GHz to 325 GHz	6 through 52 depending upon lock harmonic selected

3. Use the following equation to determine the first LO span used.

$$\text{First LO Span} = \frac{\text{Display's Span Setting}}{\text{Current Band's Harmonic Mixing Number}}$$

4. Refer to Table 10-13 to determine the circuit associated with the span.

Confirming span problems

1. If all first LO spans or only first-LO spans of 2.01 MHz or above are affected, perform the YTO Adjustment procedure in Chapter 2.
 - a. On the HP 8560E press **CAL**, **REALIGN LO & IF**, and retest all spans.
 - b. If the YTO adjustment has sufficient range and only LO spans of 2.01 MHz or above are faulty, test YTO linearity by performing step c.
 - c. Test the span in question at different center frequencies in the same band. If the span accuracy changes significantly (2% or more), suspect the A11 YTO.
2. If only first-LO spans of 2 MHz or less are faulty, suspect A14's fractional N PLL.
3. If there are several spans in the main coil and FM coil ranges affected, suspect A14's span attenuator.

YTO main coil span problems (LO spans >20 MHz)

For YTO main coil spans, the YTO is locked at the beginning of the sweep and the sweep ramp is summed into the main coil tune driver.

1. Perform the YTO adjustment procedure in Chapter 2. If the YTO adjustments cannot be performed, continue with step 2.
2. Set the HP 8560E to the following settings:

Start frequency 10 MHz
Stop frequency 2.9 GHz

3. Verify that a -1.2 V to -4.8 V ramp (approximately) is present at A14U331 pin 2.
4. If this ramp is not present, troubleshoot the main/FM sweep switch. See function block H of A14 frequency control schematic.
5. Measure the output of the main coil tune DAC at A14J18 pin 3. At the frequency settings of step 2, this should be -2.48 V.

If the voltage is not -2.48 V, troubleshoot the main coil tune DAC. See function block E of A14 frequency control schematic.

YTO FM coil span problems (LO spans 2.01 MHz to 20 MHz)

In YTO FM coil spans, the YTO loop is locked and then opened while the sweep ramp is summed into the FM coil. The FM coil sensitivity is corrected by changing the sensitivity of the FM coil driver.

1. Perform the YTO Adjustment procedure in Chapter 2. If the YTO adjustments cannot be performed, continue with this procedure.
2. Set the HP 8560E to the following settings:

Center frequency 300 MHz
Span 20 MHz
Sweep time 50 ms

3. Check for the presence of a 0 V to -10 V sweep ramp at A14J15 pin 14 (input to the main/FM sweep switch). Refer to function block H of A14 frequency control schematic.
4. Check for the presence of a 0 V to $+5$ V sweep ramp at A14U405 pin 6 (YTO FM coil driver). Refer to function block M of A14 frequency control schematic.
5. Check the state of the Main/FM sweep switches as indicated in Table 10-15.
6. The rest of the procedure troubleshoots the YTO FM coil driver.

Refer to function block M of A14 frequency control schematic.

Table 10-15. Settings of Sweep Switches

Switch	Switch State	Switch Control Line (Pin #)	Control Line State (TTL)
U318A	Closed	1	High
U318B	Open	16	High
U318C	Closed	9	Low
U318D	Open	8	Low

7. Set the HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz
Trigger SINGLE, EXT

- On the HP 8560E press **SAVE**, **SAVE STATE**, **STATE 0**.
- Remove jumper A14J23 and connect a dc voltage source to A14J23 pin 2. Connect the voltage source ground to A14J23 pin 3.
- Connect a microwave frequency-counter or spectrum analyzer to the HP 8560E's 1ST LO OUTPUT. (front panel output)
- Set the dc-voltage source's output for 0 Vdc and note the 1st LO frequency.
- Set the dc-voltage source's output for +10 Vdc. The first LO frequency should momentarily increase approximately +15.6 MHz.
- The voltage at A14U332 pin 2 should be approximately 19% of the voltage at A14J23 pin 2.
- If the first LO frequency did not change in step e, set the HP 8560E's **LINE** switch off and disconnect W10 from A14J3.
- Place a jumper between A14J3 pins 9 and 10. Place a 50 Ω , 3 watt resistor across A14J3 pins 5 and 6 (resistor, HP part number 0811-1086). Set the **LINE** switch on.
- On the HP 8560E, press **RECALL**, **STATE**, **STATE 0**.
- The voltage at A14U332 pin 2 should be approximately 19% of the voltage at A14J23 pin 2.
- If the voltage at U332 pin 2 is correct with A14J3 pins 9 and 10 shorted, but was incorrect with W10 connected, the YTO FM coil is probably open; replace the A11 YTO.
- Replace jumper A14J23. Remove the jumper and resistor from A14J3. Reconnect W10 to A14J3.

Fractional N span problems (LO spans ≤ 2 MHz)

If the fractional N spans are inaccurate or nonexistent, but the fractional N PLL is locked to the correct frequency and other spans are correct, there may be a problem with the HSCAN signal. Check that HSCAN is present at the fractional divider, U113 pin 41 in function block AS. HSCAN comes from the A3 interface assembly and goes to the sweep generator circuitry in function block A and to Fractional N.

First LO span problems (all spans)

1. Set the HP 8560E to the following settings:

Center frequency	300 MHz
Span	2 MHz
Resolution BW	1 MHz
Video BW	1 MHz
Sweep time	50 ms

2. Check that there is 0 V to +10 V ramp of 50 ms duration at A14J15 pin 15.
3. If a scan ramp is not present, refer to "Sweep Generator" in this chapter.
4. If there is a 0 to -10 V ramp at A14J15 pin 14, the fault is probably in the Main/FM sweep switch. See function block H of A14 frequency control schematic.
5. Check that there is a 0 V to +10 V ramp at U325 pin 1. The spectrum analyzer's ADC obtains information about the sweep from this node.

Check span attenuator (steps 6-13)

6. Continue with step 7 to check the span attenuator. See function block L of A14 frequency control schematic.
7. With the spectrum analyzer set to the settings in step 1, monitor A14U323 pin 6 with an oscilloscope. A 0 V to -10 V ramp should be present.
8. Change the HP 8560E's span to 1 MHz and check for a 0 V to -5 V ramp at U323 pin 6.
9. Change the HP 8560E's span to 400 kHz and check for a 0 V to -2 V ramp at U323 pin 6.
10. Set the HP 8560E to the following settings:

Start frequency	10 MHz
Stop frequency	2.9 GHz
Sweep time	80 ms

11. Monitor A14J15 pin 14 for a 0 V to -7.5 V ramp. Switches U317A, U317B, and U317D should be open and U317C should be closed.
12. Change the HP 8560E's SPAN to 365 MHz and check for a 0 mv to -1.0 V ramp at A14J15 pin 14. Switch U317C should be open and U317B closed.
13. Change the HP 8560E's SPAN to 36.5 MHz and check for a 0 mV to -100 mV ramp at A14J15 pin 14. Switch U317B should be open and U317A closed.

Check current source (steps 14-21)

14. Check the sweep generator's current source with the following steps (function block A of A14 frequency control schematic).
15. Set the HP 8560E to the following settings:

Center frequency	300 MHz
Span	1 MHz
Sweep time	50 ms

16. Use a DVM to monitor the voltage at A14J18 pin 4. The voltage should measure approximately -8.45 Vdc.

17. Set the HP 8560E's sweep time to 100 ms. The voltage at J18 pin 4 should measure approximately -4.21 Vdc.
18. Set the HP 8560E's sweep time to 200 ms. The voltage at J18 pin 4 should measure approximately -2.1 Vdc.
19. The analog switches and comparators should be set as listed in Table 10-16.
20. Check that U312D opens when the sweep time is set to 2 seconds.
21. Check that U312B and U312C close when the sweep time is set to 20 seconds.

Table 10-16. Settings for Switches and Comparators

Sweep Time	Switch U312B	Switch U312C	Switch U312D	Comparator U319A Pin 1	Comparator U319B Pin 7
200 ms	Open	Open	Closed	High	High
2 s	Open	Open	Open	High	High
20 s	Closed	Closed	Open	High	High

Phase Noise Problems

System phase noise can be a result of noise generated in many different areas of the spectrum analyzer. When the spectrum analyzer is functioning correctly, the noise can be observed as a function of the distance away (the offset) from the carrier frequency. The major contributor to system noise can be characterized as coming from specific circuit areas depending upon the offset frequency.

Some very general recommendations can be made for identifying which circuitry is the cause of the noise at certain offsets. The recommendations below apply with a center frequency of 1 GHz.

Carrier Frequency Offset	Major Contributor (when working correctly)
100 Hz	Reference (OCXO or TCXO)
1 kHz	600 MHz reference PLL
3 kHz	Fractional N PLL
10 kHz to 150 kHz	Offset lock loop or YTO loop
>150 kHz	YTO

Phase noise in locked versus lock and roll spans

Input a signal to the spectrum analyzer. Set the center frequency to the input signal frequency, set the span to 2 MHz, and plot the display. This plots the system noise for a locked sweep. Plot the display again with a span of 2.01 MHz (lock and roll sweep). The crossover point of the noise floor of the two plots is typically at an offset of about 50 kHz, for a functioning instrument.

If the crossover point is shifted out to a higher offset frequency, suspect the YTO loop circuitry.

If the crossover point is shifted in to a lower offset frequency, suspect the offset or fractional N loop circuitry.

Reference versus reference PLL phase noise

If the problem seems to be in the frequency reference or reference PLL circuitry, measure the noise with internal and external references. If there is no difference, suspect the circuitry associated with the SAWR A15U701. If there is a difference, look at 10 MHz distribution, OCXO, or TCXO.

Fractional N versus offset PLL or YTO PLL phase noise

If the spectrum analyzer has excessive noise at >1 kHz offset, measure the noise with center frequencies of 100 MHz and 2.5 GHz.

If the measurements are equal, suspect the fractional N circuitry and the YTO loop circuitry on the A14 frequency control assembly.

If the measurements differ by 2 dB to 5 dB, with the 2.5 GHz measurement at a higher noise level, suspect the offset lock loop circuitry.

Fractional N PLL phase noise

Check the noise on the 5 V regulators on A14, particularly the regulator in the reference divider circuitry A14U121. Refer to function block AN on the A14 frequency control assembly schematic.

The noise level of the voltage regulator should be <1 mV. The typical noise level is $40\text{ }\mu\text{V}$ RMS between 10 Hz and 100 kHz.

A coaxial probe with very little unshielded tip area should be used to avoid picking up radiated 60 Hz. Check that your measurement is valid by probing ground on the circuit and verifying that the measured value is well under the 1 mV threshold that indicates a defective regulator.

There can also be phase noise problems if the loop gain is incorrect. See function block AP for loop gain troubleshooting information.

Sampler and Sampler IF

The A15U100 sampler creates and mixes harmonics of the sampling oscillator with the first LO. The resulting sampler IF (60 MHz to 96 MHz) is used to phase-lock the YTO. The sampler IF filters unwanted products from A15U100's output and amplifies the IF to a level sufficient to drive the YTO loop. When the IF is less than 87.14 MHz, PIN diodes switch a 120 MHz low pass filter in the sampler IF section.

1. Set HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz

2. Disconnect W32 from A15J101.

3. Connect the input of a power splitter to A15J101. Connect W32 to one of the splitter outputs. Connect the other splitter output to the input of another spectrum analyzer.

4. If a 66.7 MHz signal, greater than -15 dBm, is not displayed on the other spectrum analyzer, set a microwave source to the following settings:

Frequency 4.2107 GHz
Amplitude -5 dBm

5. Connect the microwave source to A15U100J1. A 66.7 MHz signal at approximately 0 dBm should be displayed on the other spectrum analyzer.

6. Use an active probe/spectrum analyzer combination to measure the signal at the following test points:

A15TP101	66.7 MHz, -8 dBm
A15TP201	296 MHz, $+9$ dBm

7. If a correct signal is seen at A15TP201 but the signal at A15TP101 is wrong, proceed as follows:

Use an oscilloscope to measure the signals at the following test points:

A15J400 pin 1	$+0.8$ Vdc to $+1.6$ Vdc (≤ 0.5 Vp-p variation)
A15J400 pin 3	-0.8 Vdc to -1.6 Vdc (≤ 0.5 Vp-p variation)

If these levels are wrong, perform the "Power and Sampler Match Adjustments" in the sampler oscillator adjustment procedure. Refer to Chapter 2.

If adjusting the sampler match does not bring the signal at A15TP101 within specification when the signal at A15TP201 is correct, the A15U100 sampler is defective.

8. The sampler IF signal at A15J101 is 60 MHz to 96 MHz at -10 dBm to $+5$ dBm. If the signal at A15TP101 is correct, but the signal at A15J101 is wrong, the fault lies in the sampler IF circuitry. Continue with the following steps.

9. Set the HP 8560E to the following settings:

Center frequency 300 MHz
Span 0 Hz

10. Set a microwave source to the following settings:

Frequency	4.2107 GHz
Amplitude	−5 dBm
11. Connect the microwave source to A15U100J1.
12. Measure the signal at U103 pin 1 using an active probe/spectrum analyzer combination.
13. If a 94.7 MHz signal, approximately −14 dBm, is present, but the signal at A15J101 is low, suspect U103.
14. When U104 pin 3 is at TTL low, U104 pin 6 should near −15 Vdc and PIN diodes CR101, CR102, and CR103 should be reverse-biased.
15. Set HP 8560E to the following settings:

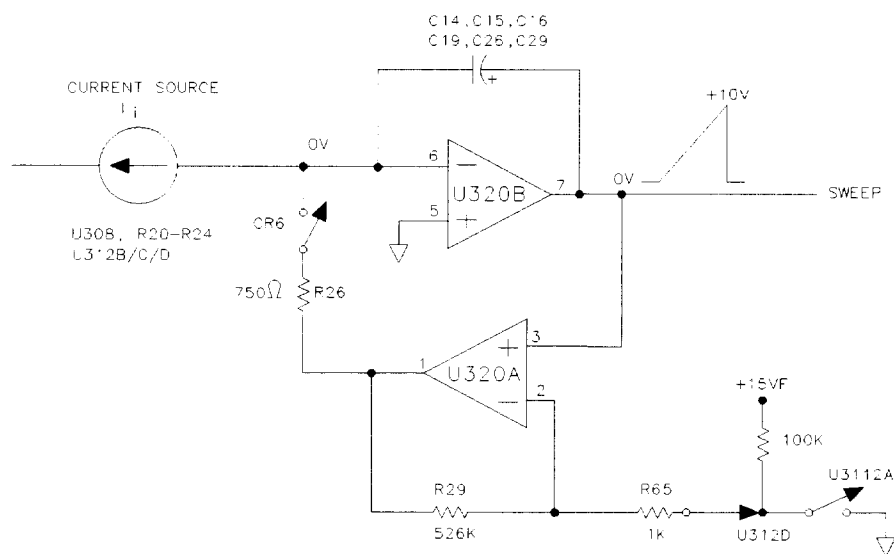
Center frequency	89.3 MHz
Span	0 Hz
16. Check that U104 pin 3 is at a TTL high and U104 pin 6 is greater than +7 V. PIN diodes CR101, CR102, and CR103 should all be turned on with about 7 mA of forward current.
17. Disconnect the power splitter and reconnect W32 to A15J101.

Sweep Generator Circuit (for Spectrum Analyzers with 100 s max. Sweep Time)

The sweep generator operates by feeding a constant current from DAC U307 into an integrator, U320B. See function block A of A14 frequency control schematic. This current is scaled by resistors R20 through R24 and U312B/C/D. See Figure 10-9. The capacitors used in the integrator depend on the sweeptime range; smaller-value capacitors provide faster sweep times.

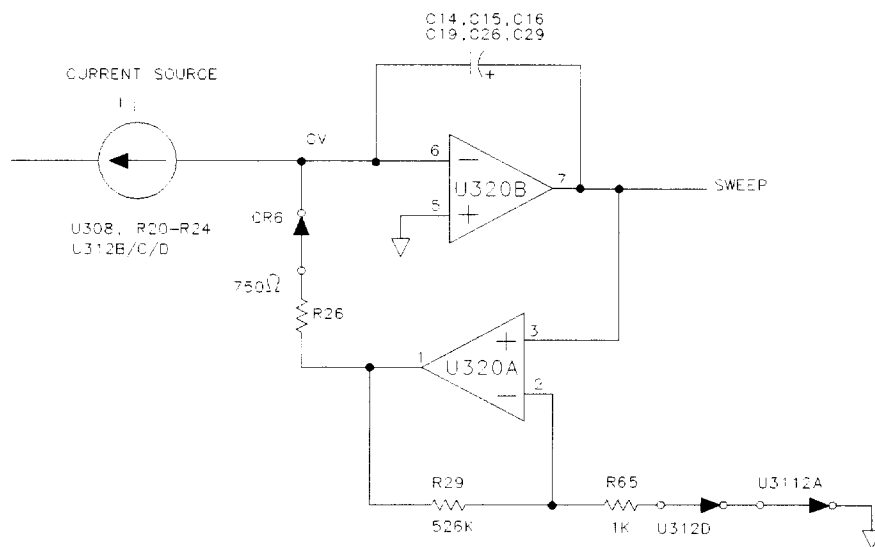
The integration is initiated by HSCAN going high. This opens U312A which places the output of U320A near −15 Vdc, turning CR6 off and allowing the output of integrator U320B to ramp from 0 V to +10 Vdc. The analyzer's ADC (via the scan ramp attenuator U320B pin 7) monitors the scan ramp at U325A pin 1. When the ramp reaches +10 V (for single-band sweeps), HSCAN is brought low and the integration ends. During normal non-fast-zero spans (sweep times >30 ms), comparators U319A and B are high. This turns off diodes CR1, CR2 and turns on transistors Q1 and Q2. The integrating current has a maximum value of 236 μ A.

During retrace, HSCAN is low, closing U306B and U312A. See Figure 10-10. The output of U320A tries to go high, turning CR6 on and sourcing current through R26. This current discharges the capacitors in the integrator, forcing U320B pin 7 toward 0 Vdc. Ultimately, the output of U320B will be brought and held to 0 V by U320A supplying a current equal to that which is sunk by the current source. For more information, refer to “First-LO Span Problems (Multiband Sweeps)” in this chapter.



sp132e

Figure 10-9. Simplified Sweep Generator



sp133e

Figure 10-10. Simplified Sweep Generator during Retrace

Sweep Generator Circuit

(for Spectrum Analyzers with 2000 s max. Sweep Time)

The sweep generator circuitry generates a ramp from 0 to 10 volts during the sweep time. The available sweep times range from 50 μ s to 2,000 seconds. The sweep times are generated in two different ranges, a 50 μ s to 30 ms range and a 50 ms to 2,000 second range. The 50 μ s to 30 ms range is only needed for analog zero span sweeps.

The sweep generator is controlled with an 8-bit latch and the control signal HSCAN. The latch, U308, controls the sweep rate. HSCAN determines when to reset the scan ramp and when to let it sweep.

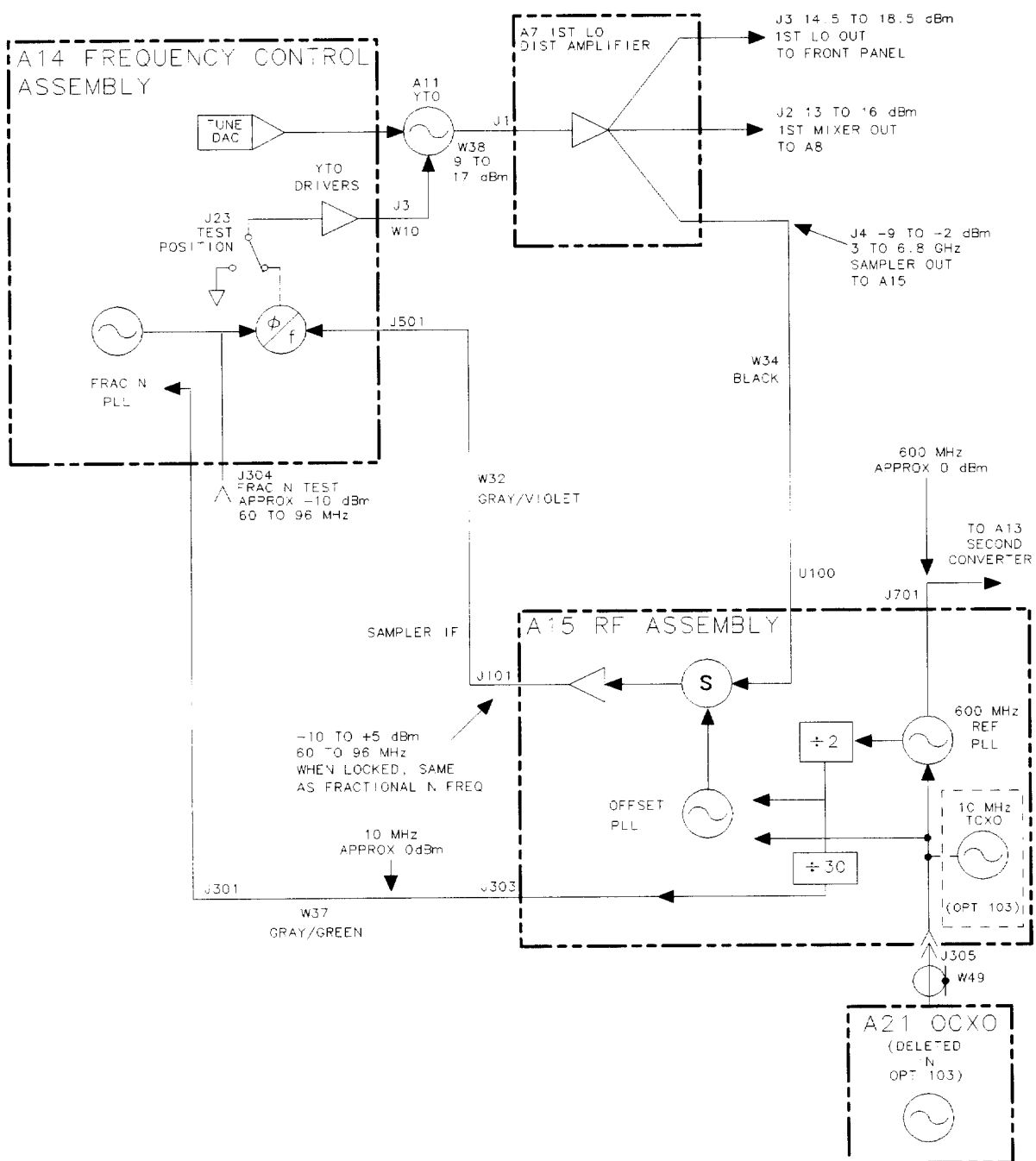
Operation of the 50 ms to 2,000 second range will be described using a 50 ms sweep time as the example. For a 50 ms sweep time, Q1 shorts out C16. The D to A converter U307, has zero output current. U334A is a buffer with zero offset, because there is no current coming out of U307. The buffering of U334 makes the base-emitter voltages on Q3A and Q3B the same. These two transistors are matched, so their collector currents should be identical when their base-emitter voltages are identical. The emitter current of Q3B is 200 μ A, therefore the emitter current of Q3A is 200 μ A and the sweep ramp is generated by C14. The sweep time is given by the formula:

$$sweeptime = capacitance(C14) \frac{\Delta V}{current}$$

The DAC setting is increased for longer sweep times. This increases the current sunk by the DAC output U307 pin 4, which increases the emitter voltage on Q3A, decreasing the base-emitter voltage drop. Q3A acts as an exponentiator and reduces its collector current, creating a slower sweep ramp.

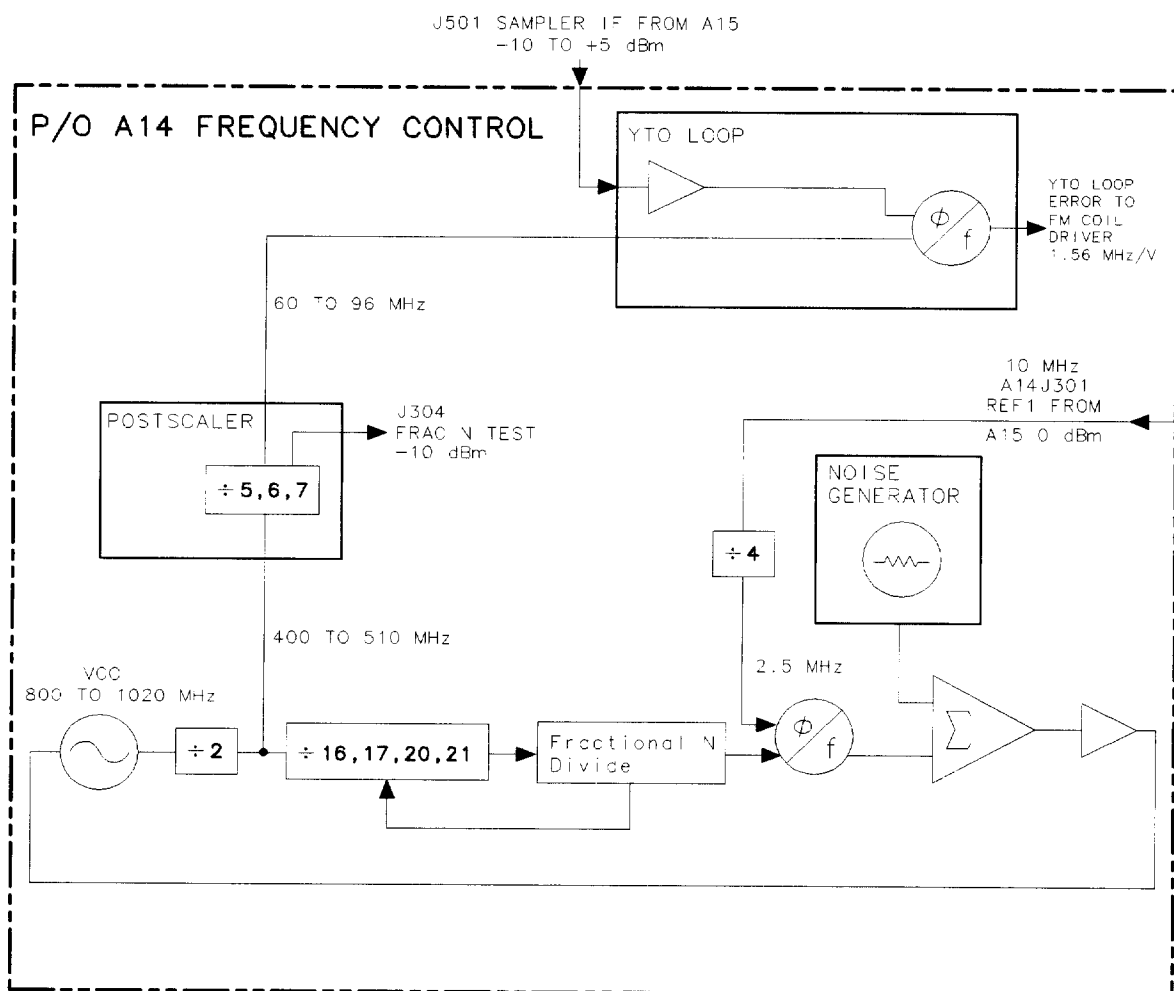
For the shorter sweep times, 50 μ s to 30 ms, Q1 is opened putting C16 in series with C14. This changes the effective capacitance from 1 μ F to 1,000 pF, or a reduction of 1,000 to 1.

The HSCAN signal uses Q2 to reset the ramp. Q2 shorts the integrator and sets its output nominally to ground.



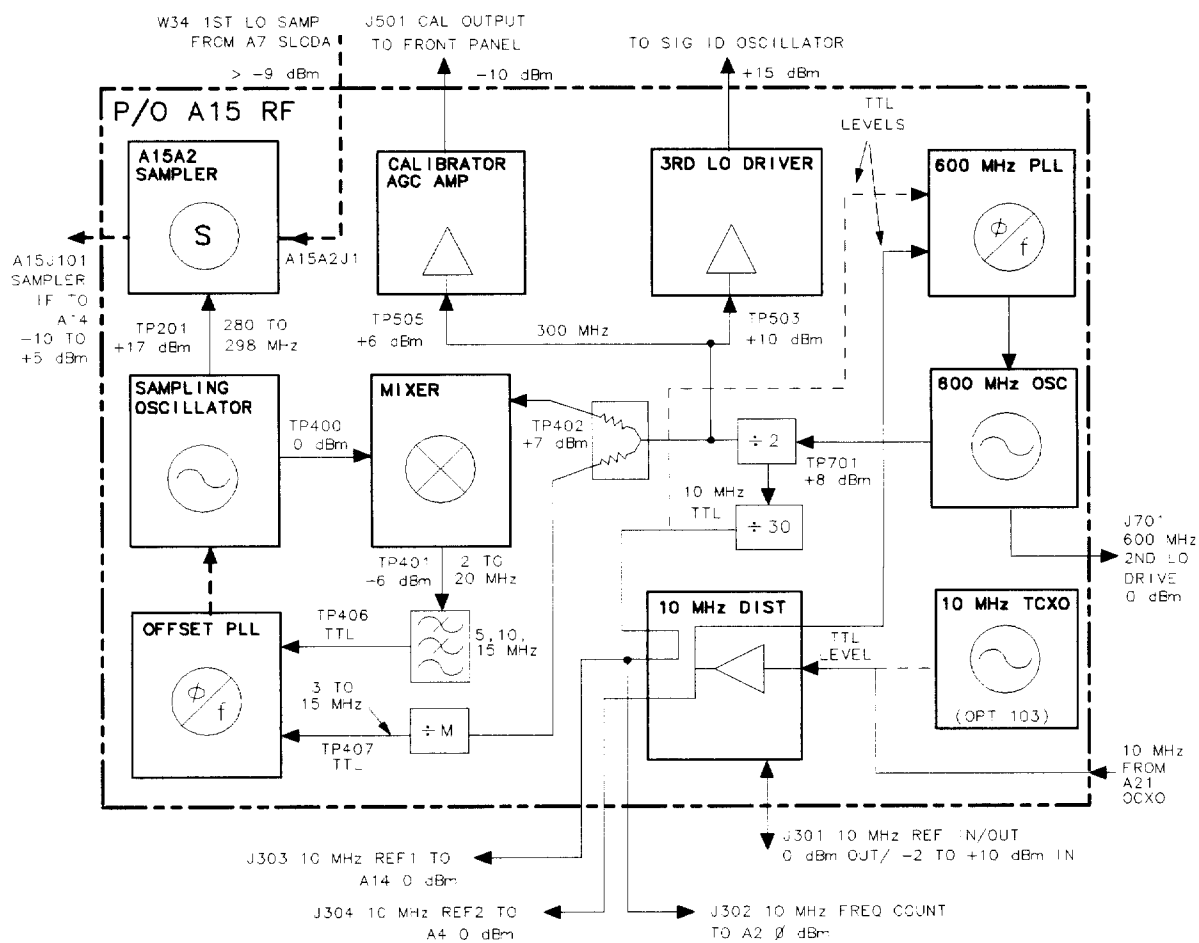
sj147e

Figure 10-11. Simplified Synthesizer Section



sj146e

Figure 10-12. Simplified A14 Assembly Block Diagram



sp134e

Figure 10-13. Simplified A15 Assembly Block Diagram

A21 OCXO

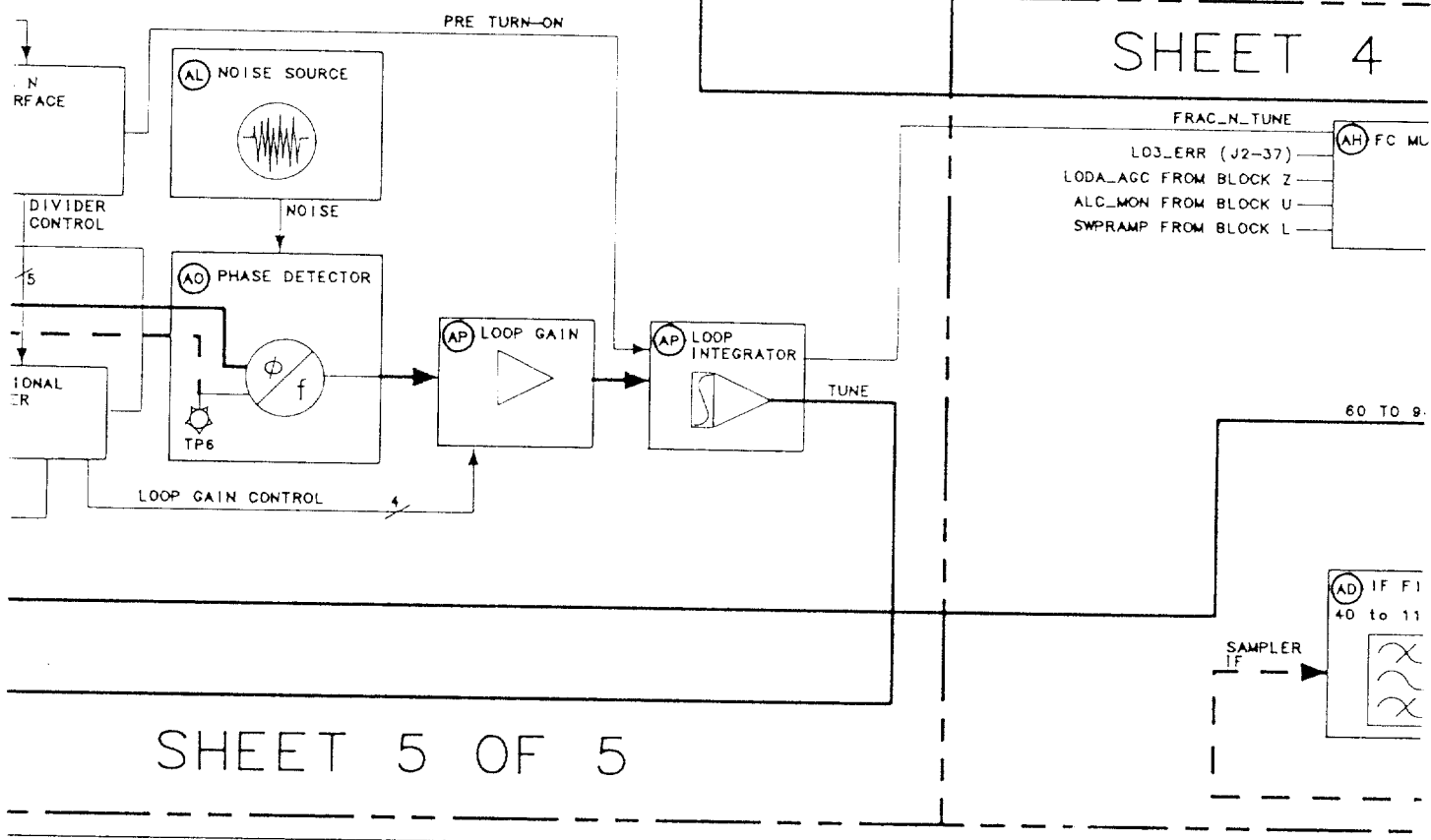
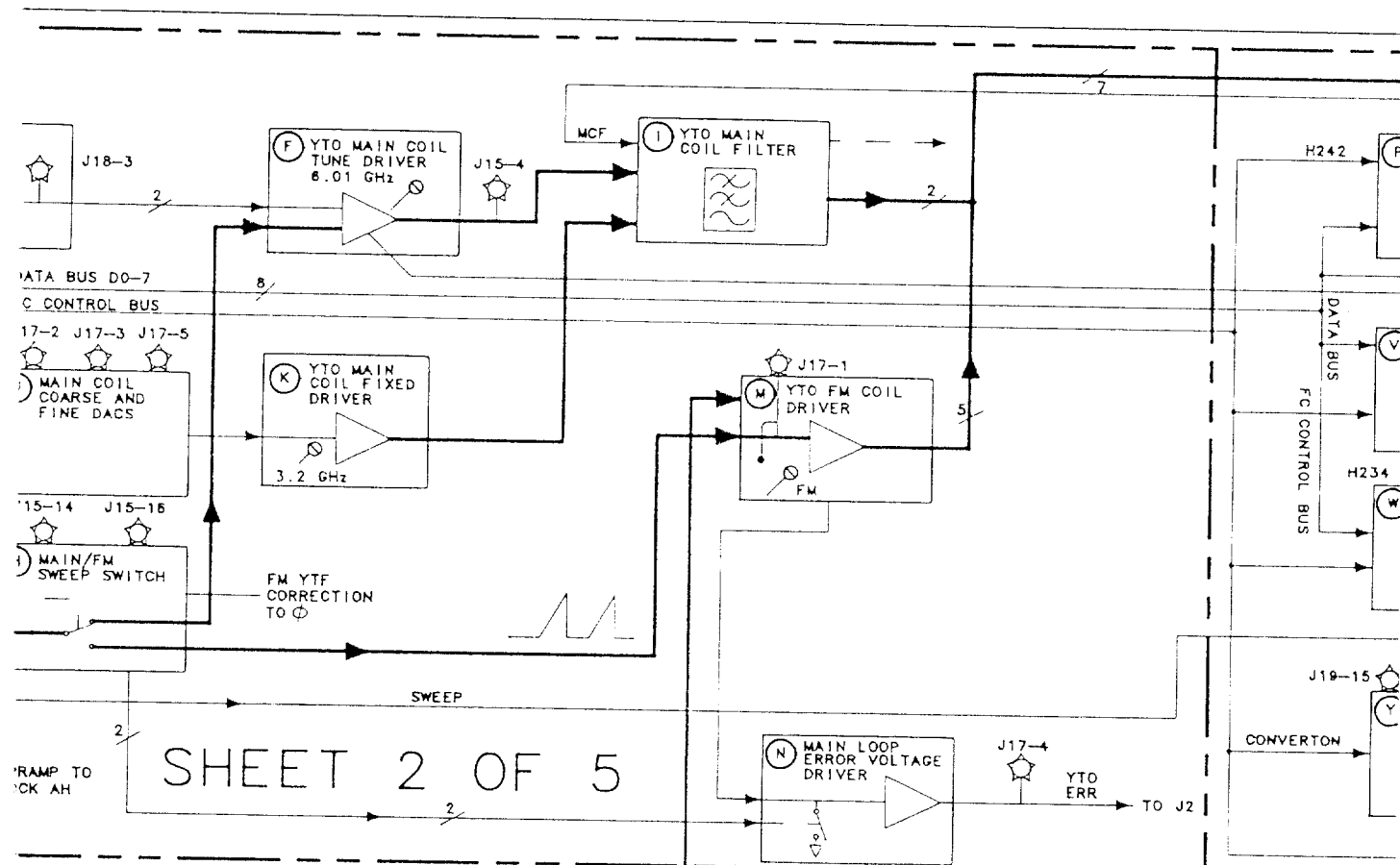
The spectrum analyzer uses an oven-controlled crystal oscillator (OCXO). It is deleted in Option 103 and replaced by a temperature-compensated crystal oscillator (TCXO), located on the A15 RF assembly. Connectors J305 and J306 on the A15 RF assembly are located where the TCXO would be installed in an Option 103. The oven in the OCXO is powered only when the spectrum analyzer is powered on; there is no standby mode of operation. The OCXO's oscillator operates only when the internal frequency reference is selected. Control line HEXT (High = EXternal frequency reference) is inverted by A15U303B (Refer to the A15 RF assembly schematic diagram, block M, sheet 2 of 4) to generate LEXT. LEXT is sent to the OCXO via A15J306 pin 4. When LEXT is low, the oscillator in the OCXO will be turned off.

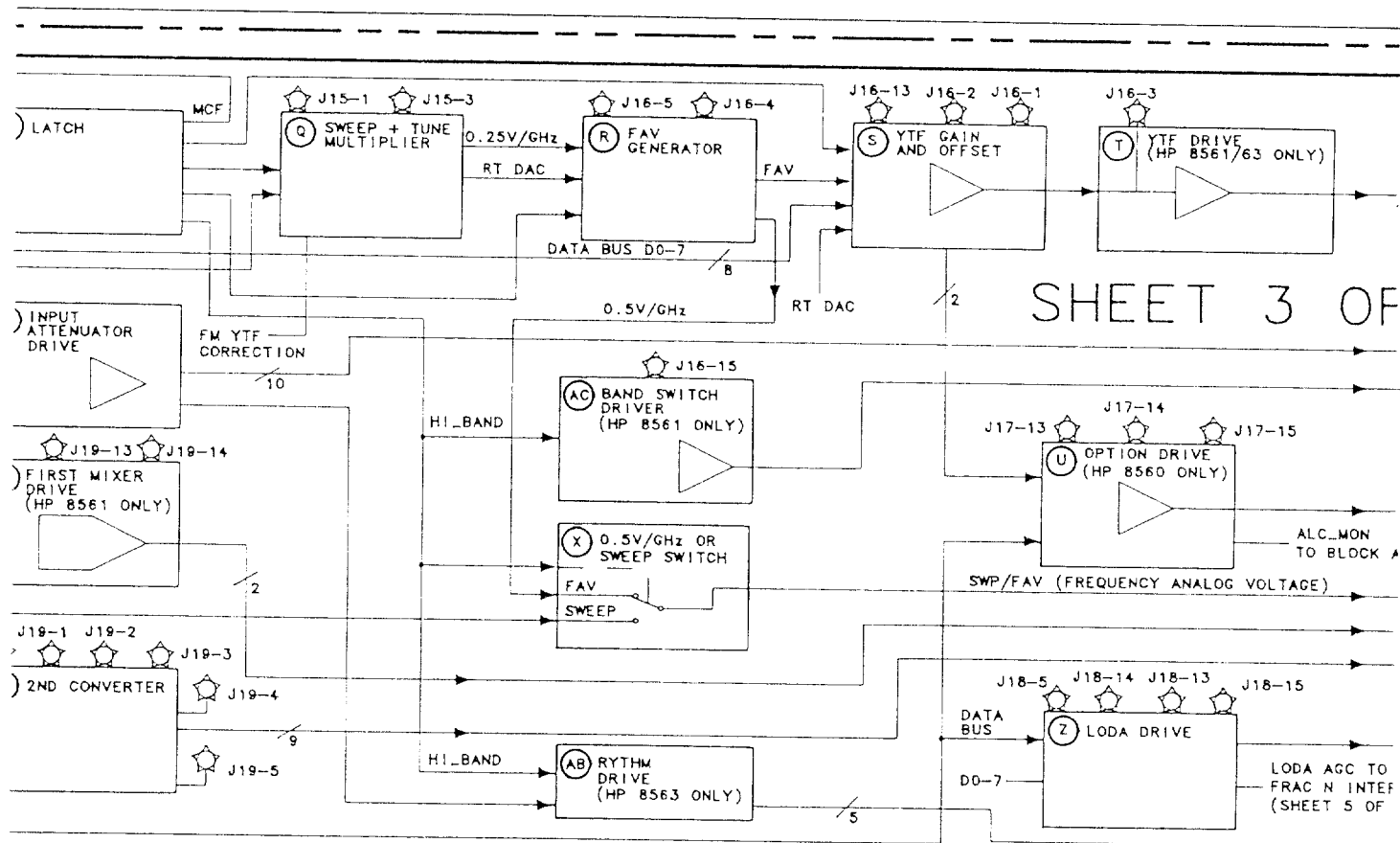
Replacement OCXOs are factory adjusted after a complete warmup and after the specified aging rate has been achieved. Thus, readjustment should typically not be necessary after OCXO replacement, and is generally not recommended.

If adjustment is necessary, the spectrum analyzer must be on continuously for a minimum of 24 hours immediately prior to oscillator adjustment to allow both the temperature and frequency of the oscillator to stabilize. Failure to allow sufficient stabilization time could result in oscillator misadjustment.

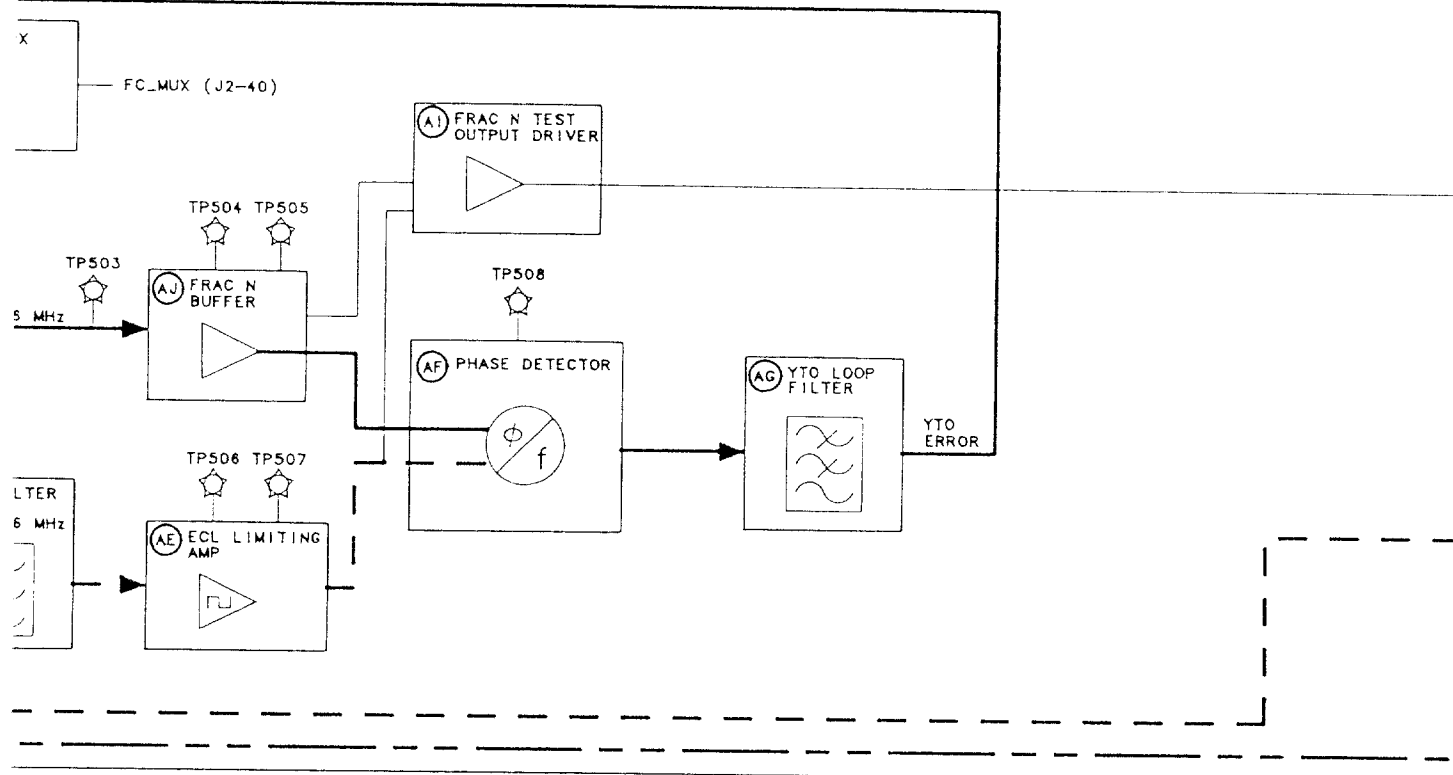
Check operation of the A21 OCXO as follows:

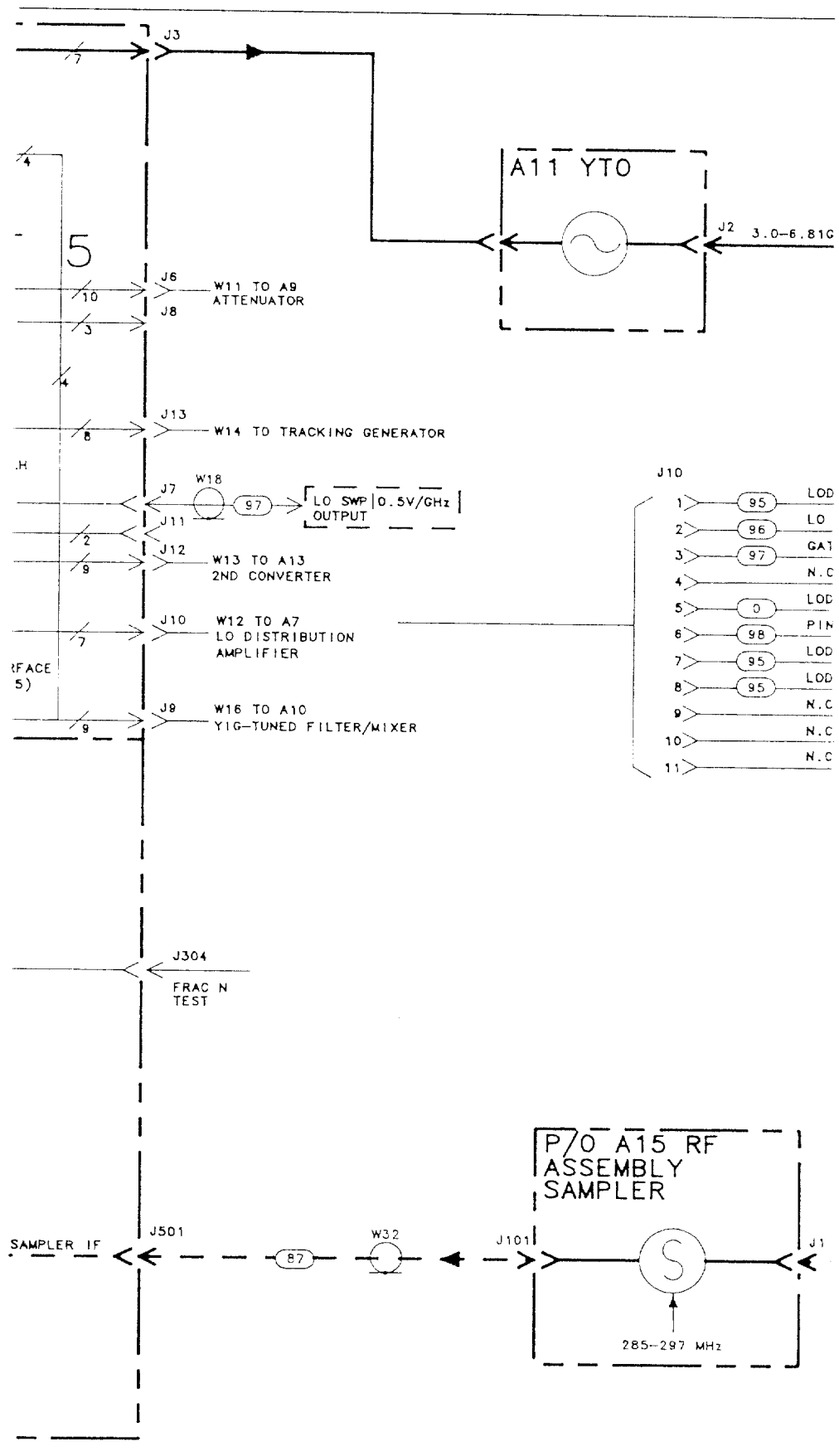
1. Disconnect W49 (Coax 82) from A15J305. Connect the output of W49 to the input of another spectrum analyzer.
2. Check that the fundamental frequency is 10 MHz and that the power level is 0 dBm $\pm$ 3 dB. Also check that the harmonics are at least -25 dBc. Excessive harmonics can generate spurious responses on the fractional N oscillator on the A14 frequency control assembly.
3. If the OCXO has no output, check A15J306 pin 1 for +15 Vdc. Check A15J306 pin 4 for a TTL-high level.
4. If A15J306 pin 4 is at a TTL-low level, press **AUX CTRL** and **REAR PANEL**. Press **10 MHz EXT INT** until INT is underlined. A15J306 pin 4 should read a TTL-high level. Press **10 MHz EXT INT** until EXT is underlined. A15J306 pin 4 should read a TTL-low level.





OF 5





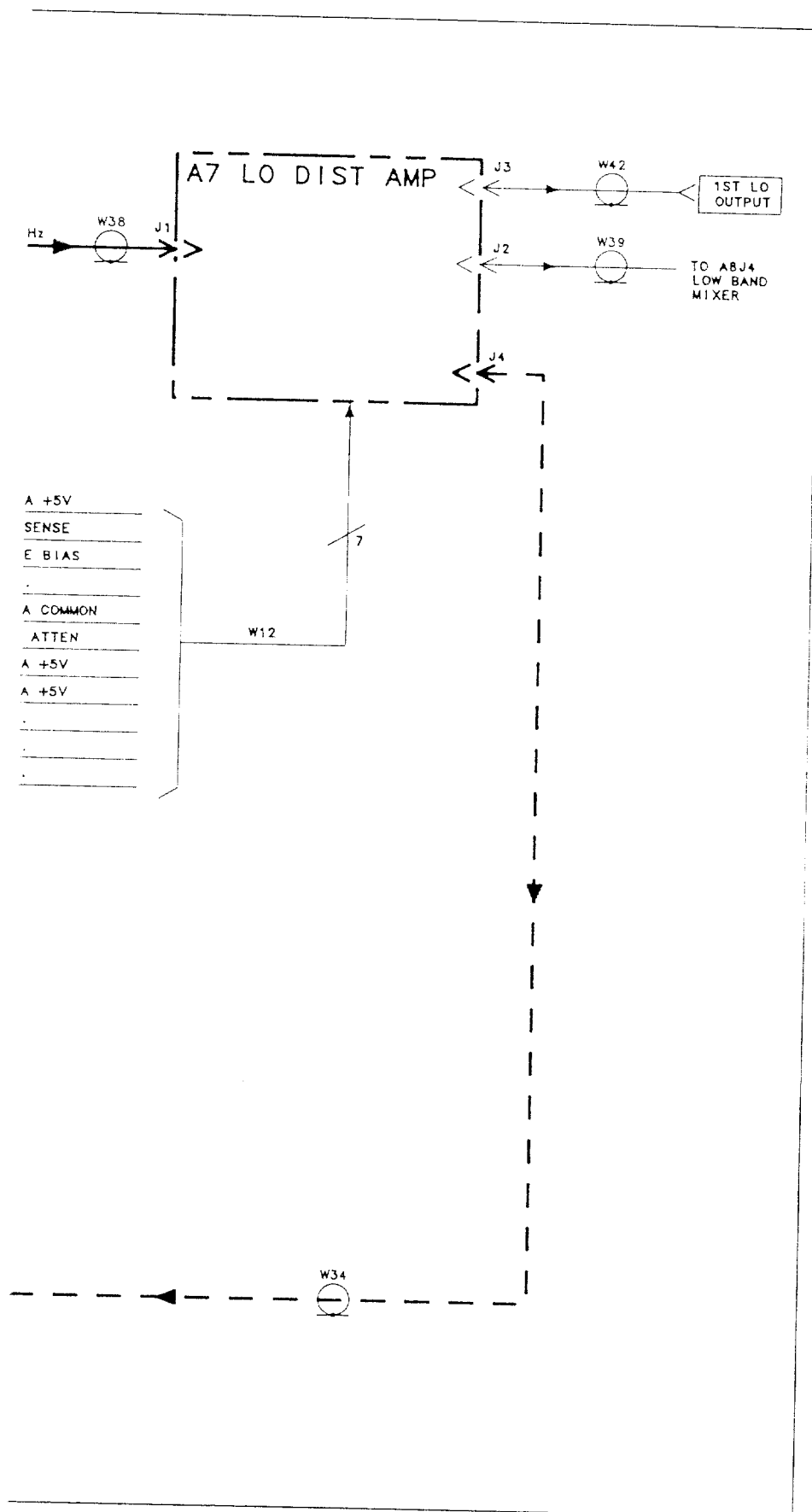
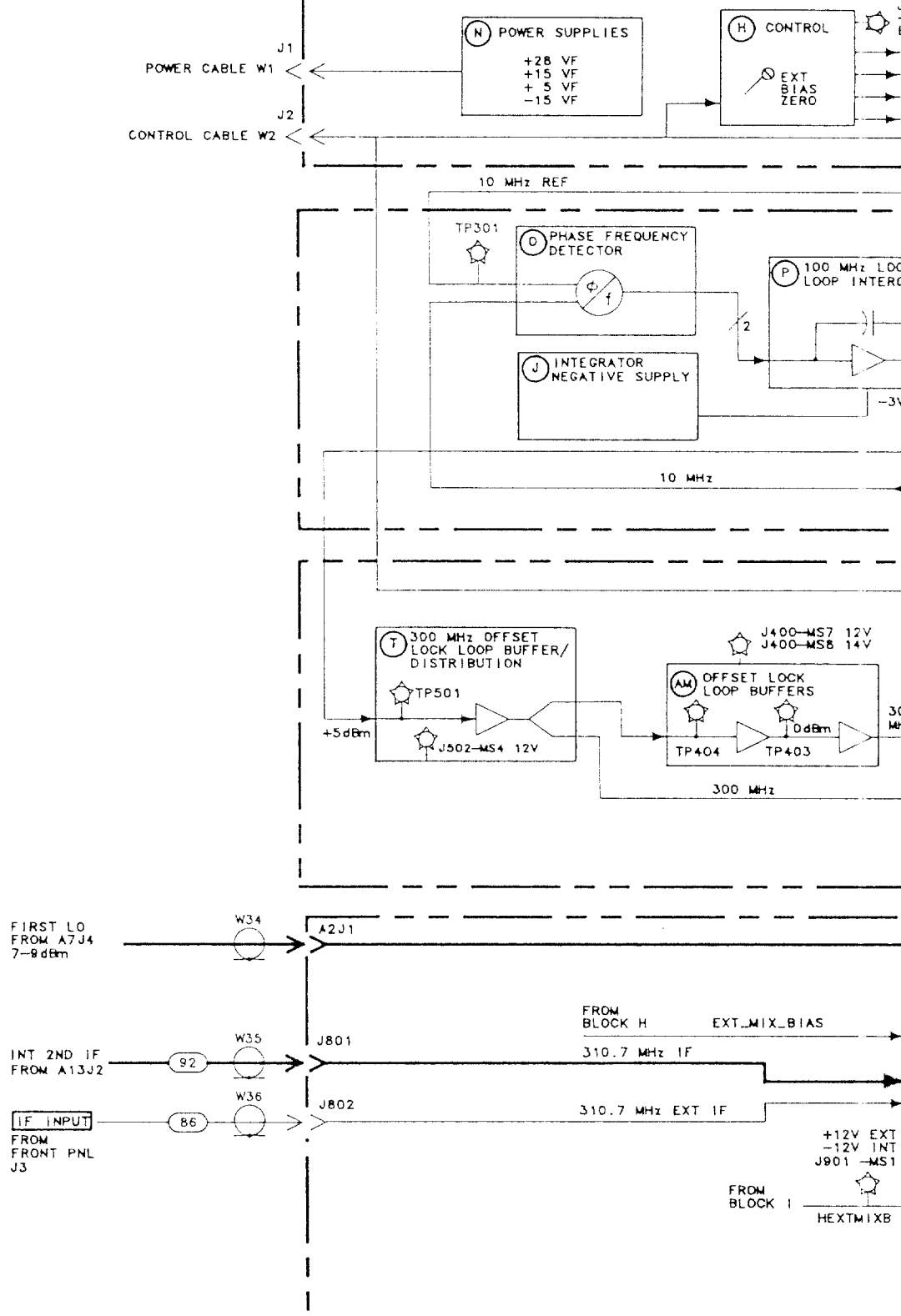
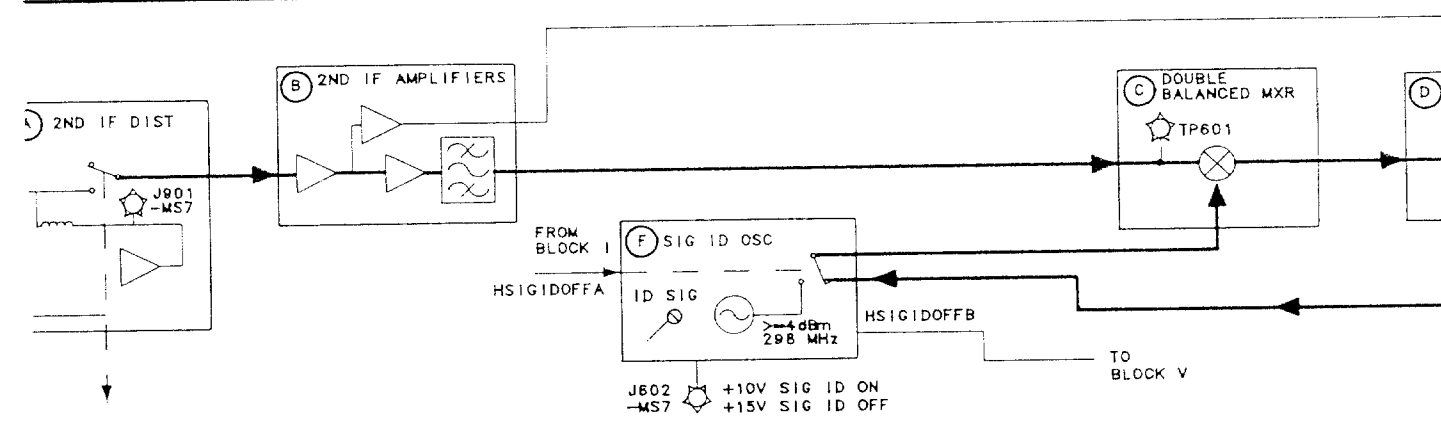
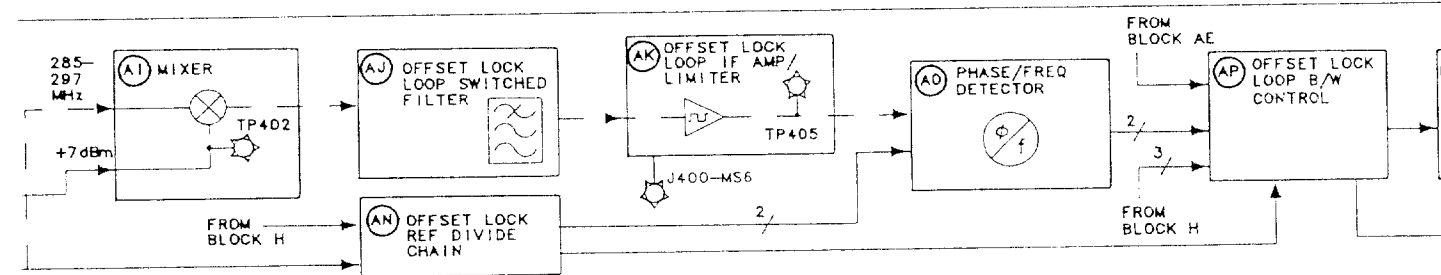
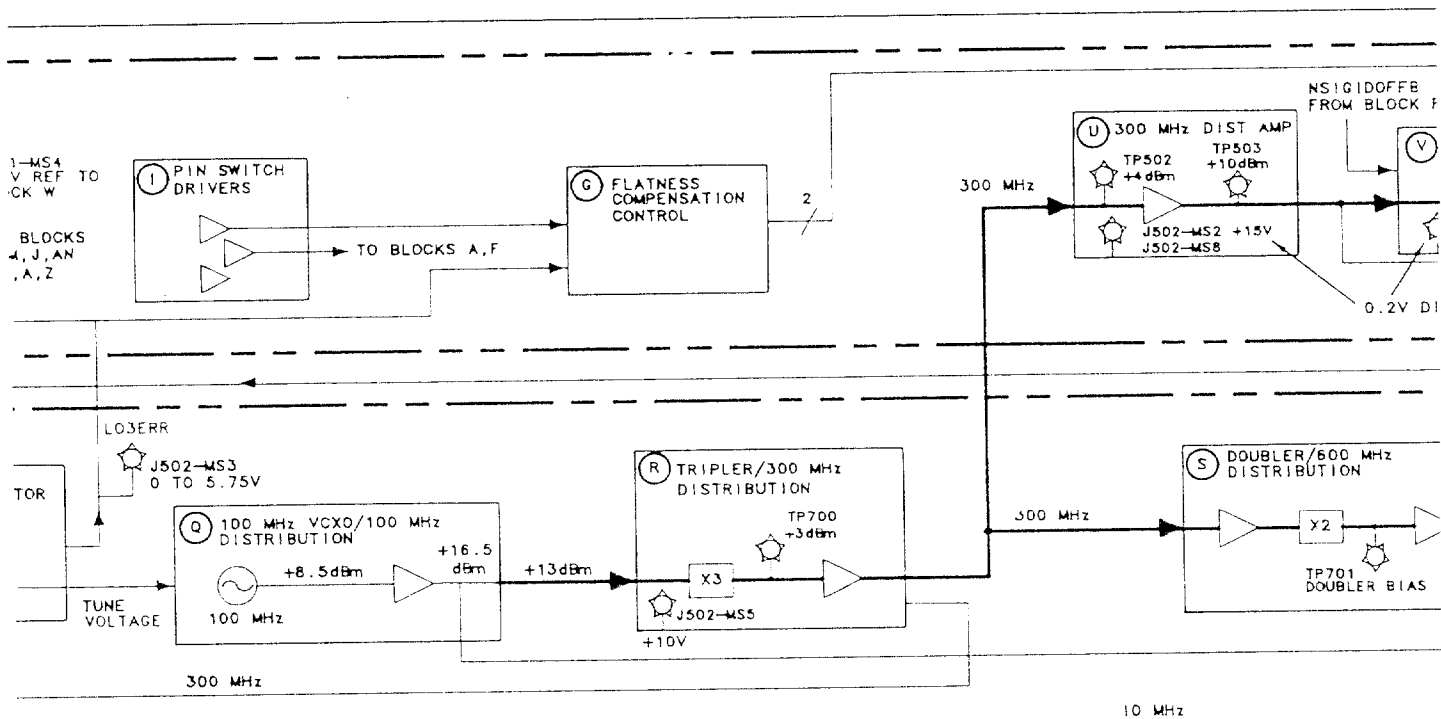
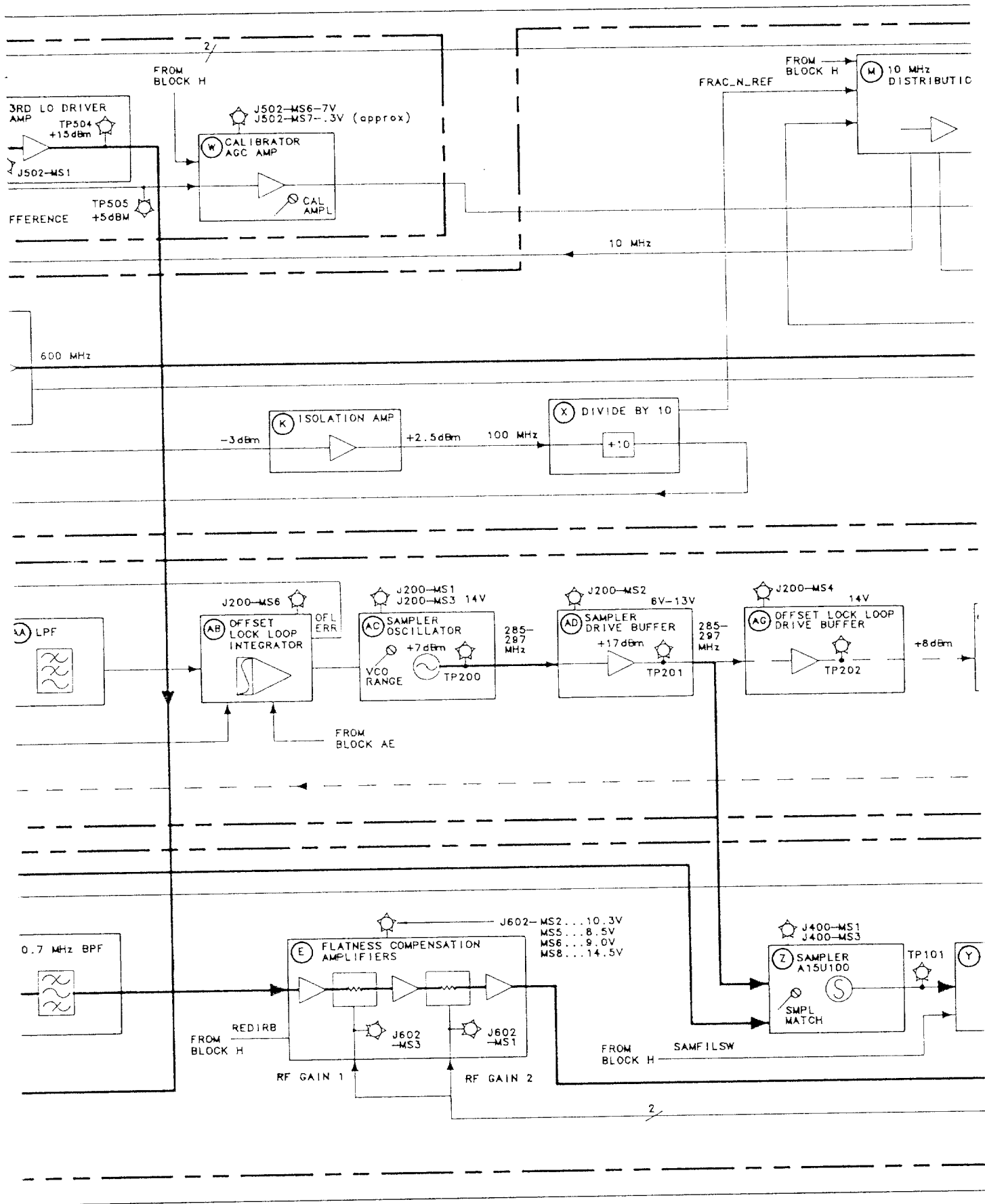


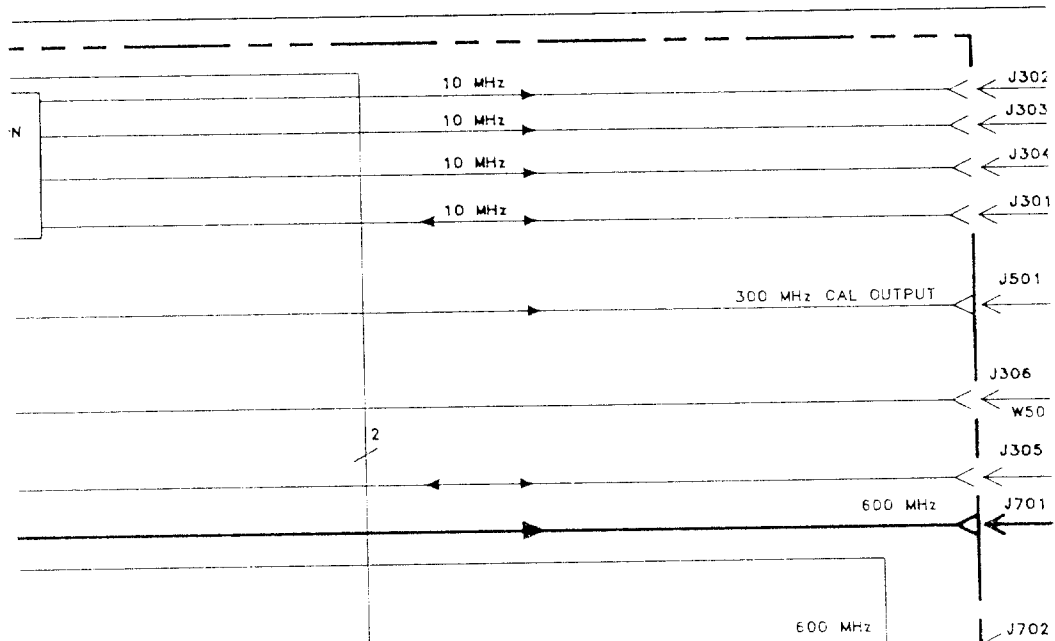
FIGURE 10-14 FREQUENCY CONTROL BLOCK DIAGRAM

A15 RF
SHEET 1 OF 4

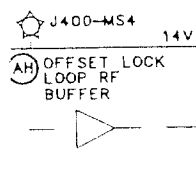




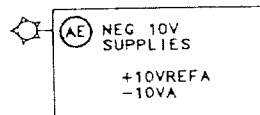




SHEET 2 OF 4

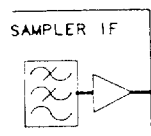


J200-MSB



TO BLOCKS
AB AND AP

SHEET 3 OF 4



TO BLOCK H
U903, PIN 12

310.7 MHz

J803

J101

10.7 MHz

J601

SHEET 4 OF 4

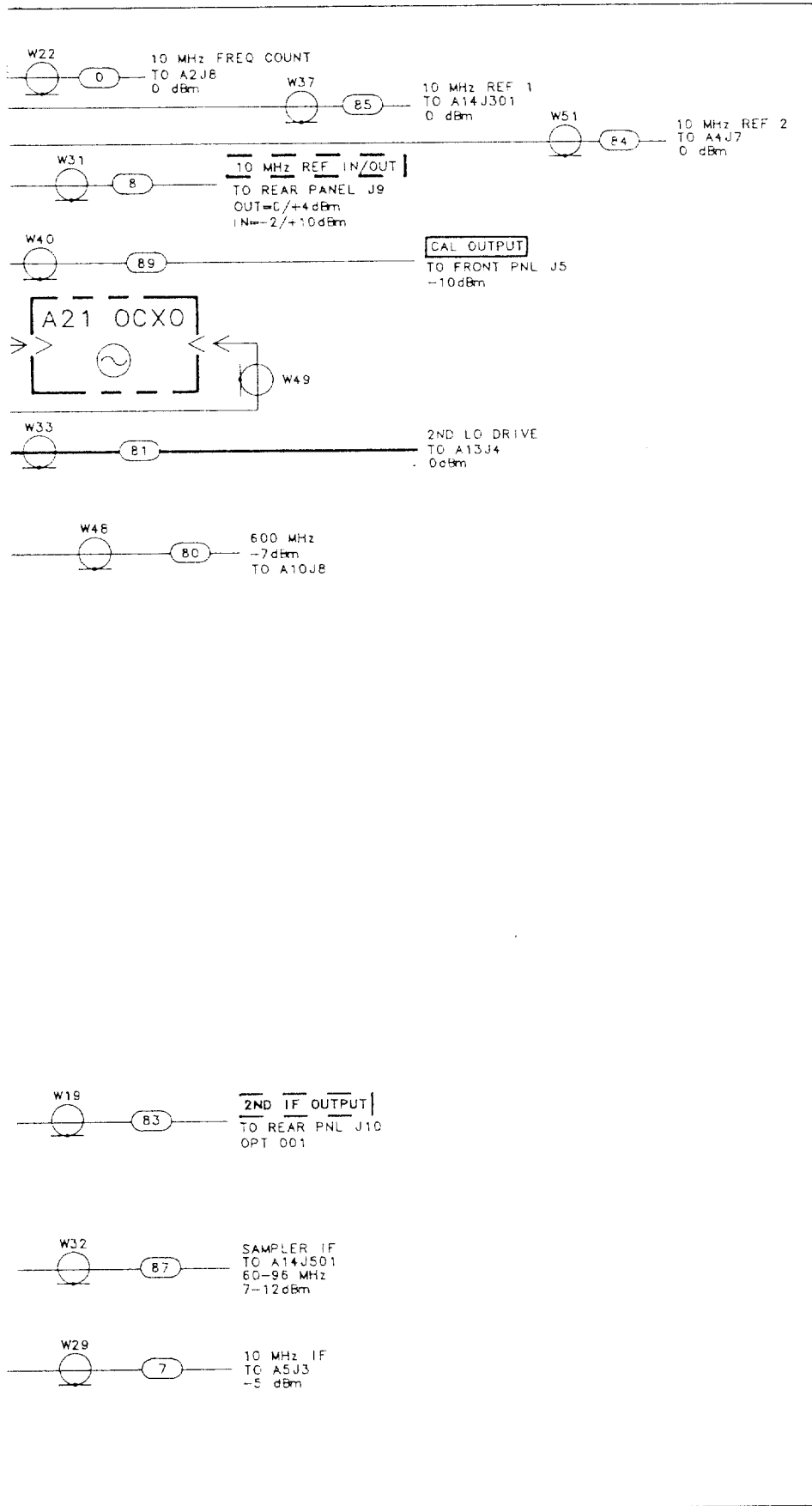
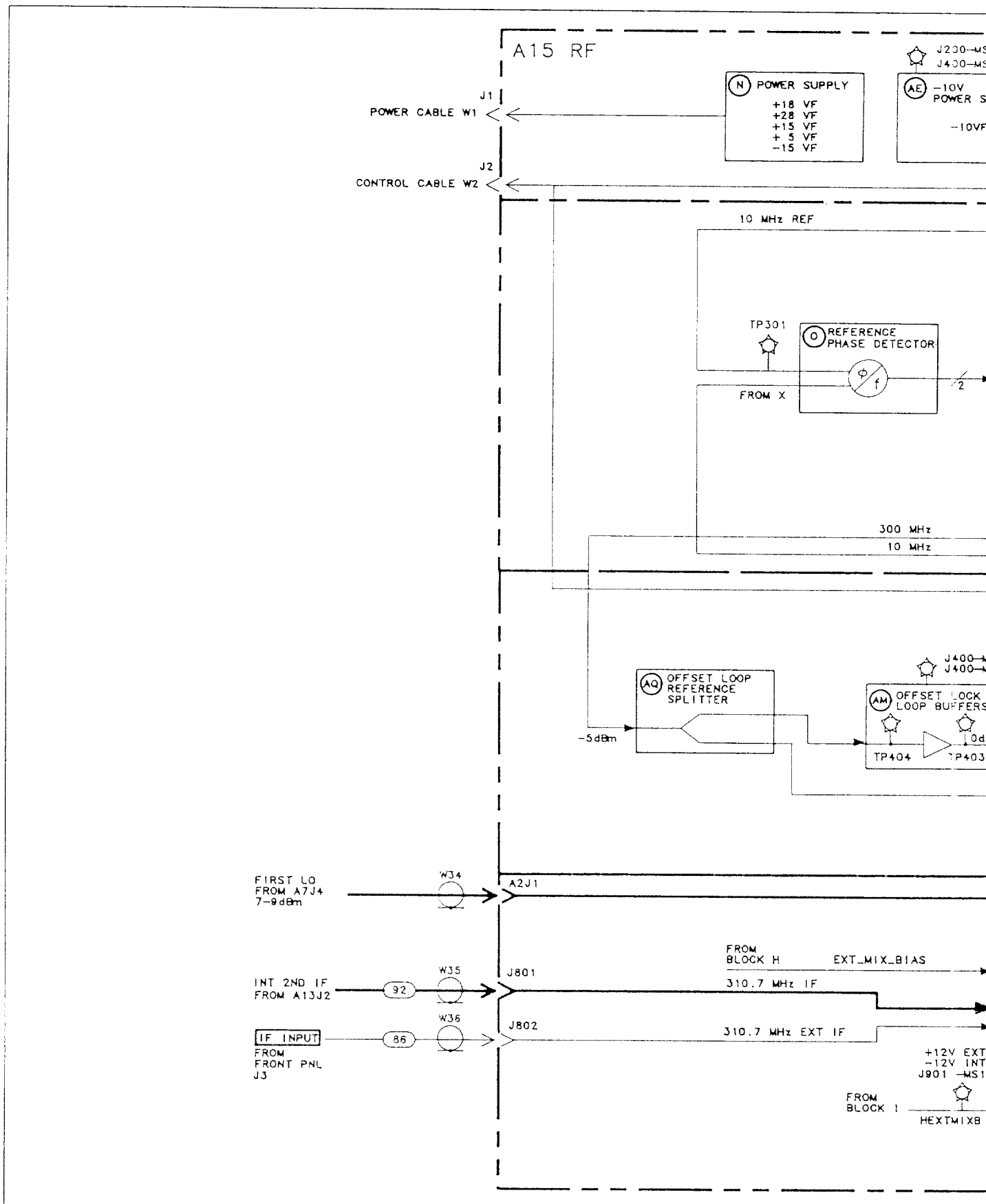
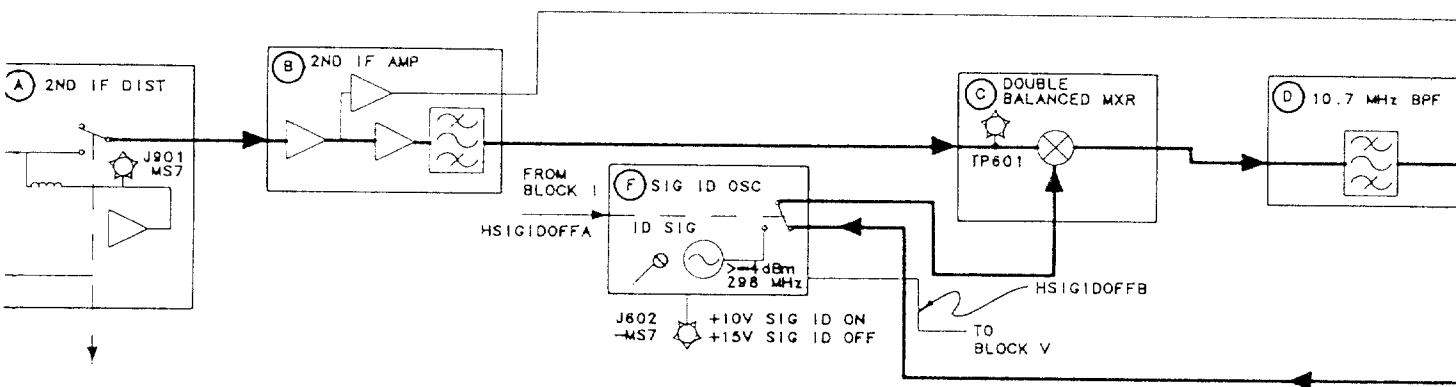
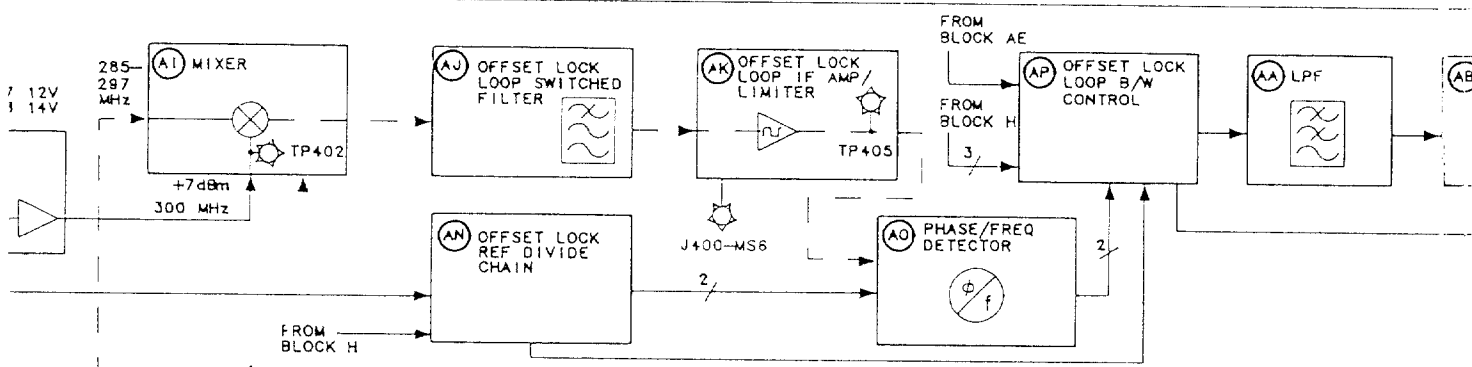
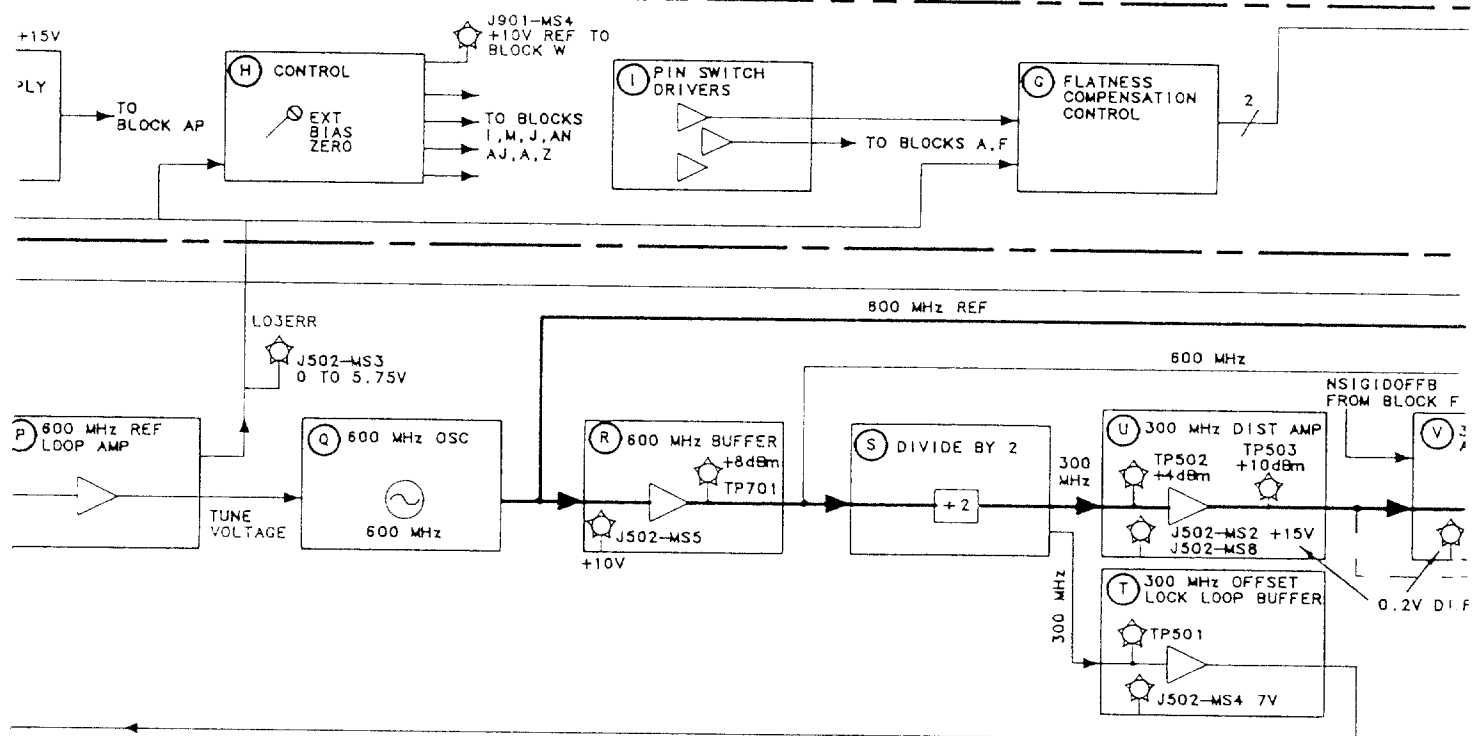
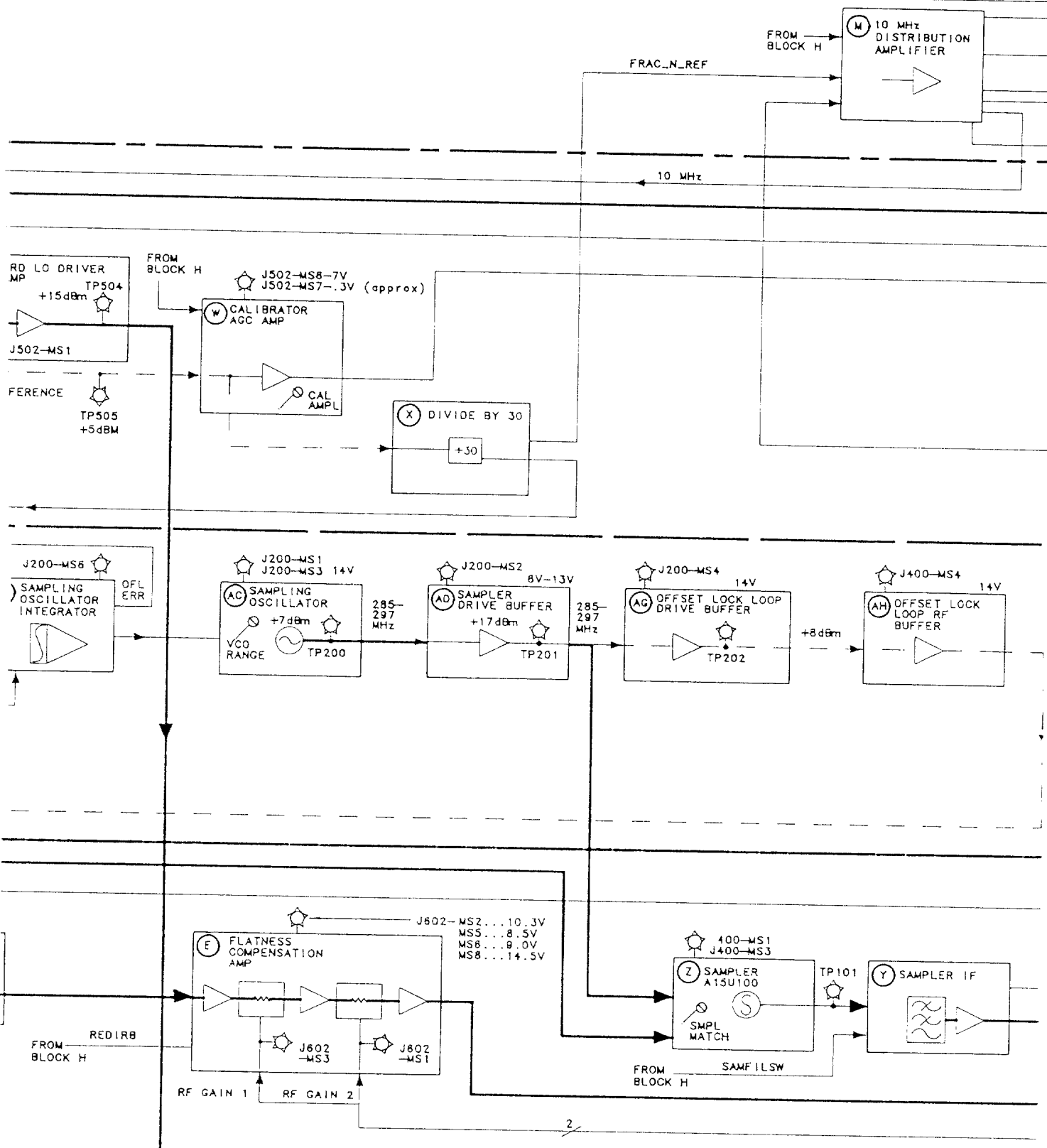


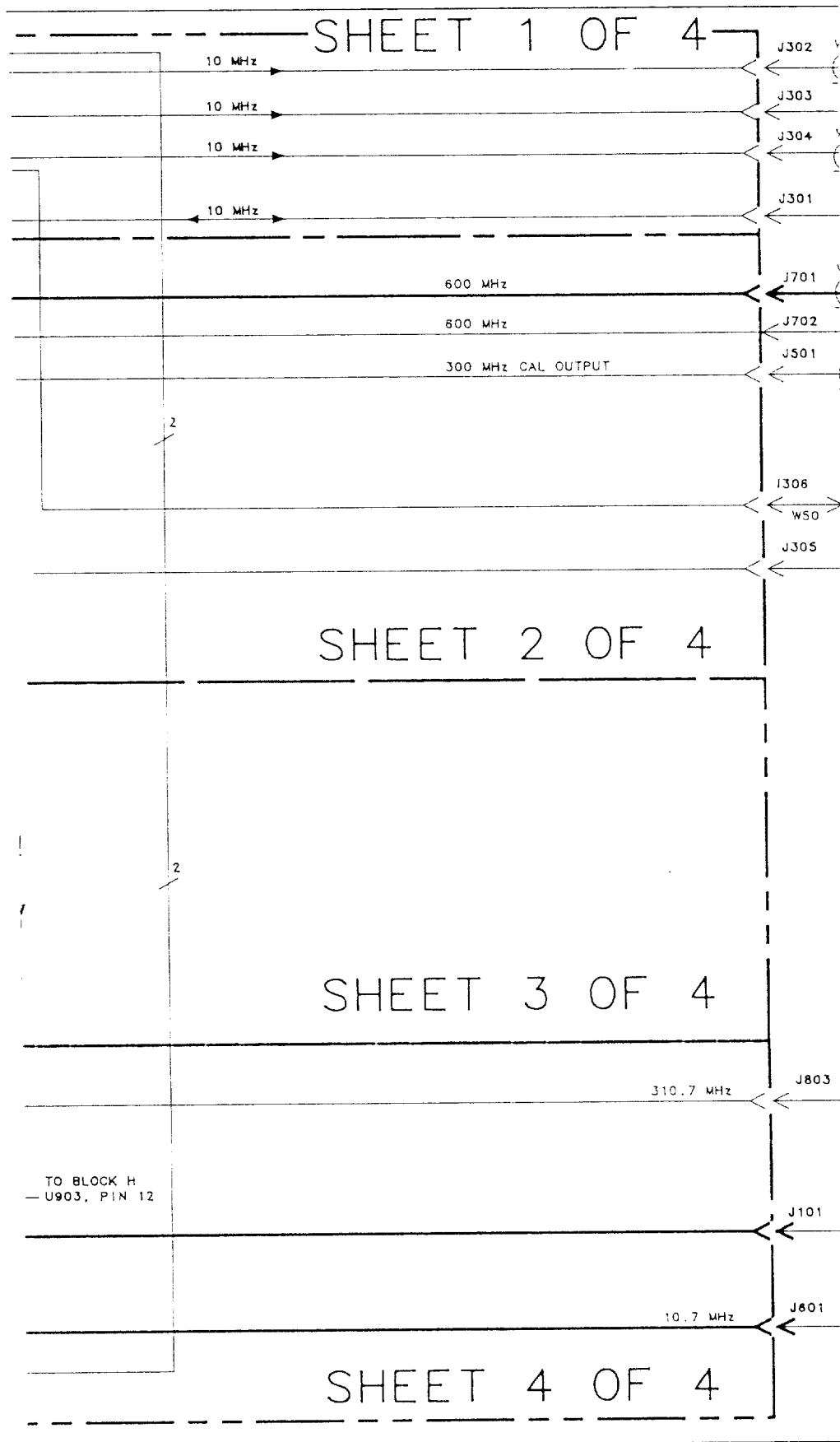
FIGURE 10-15. RF ASSEMBLY BLOCK DIAGRAM
(FOR A15 08563-60054, 08563-60055, OR 08563-60056).





2/





SYNTHESIZER SECTION

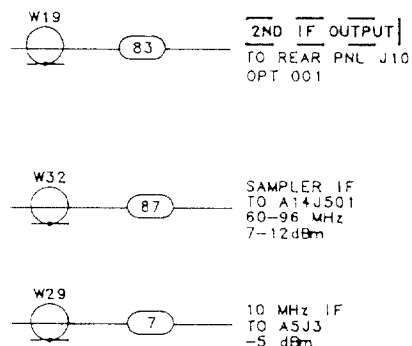
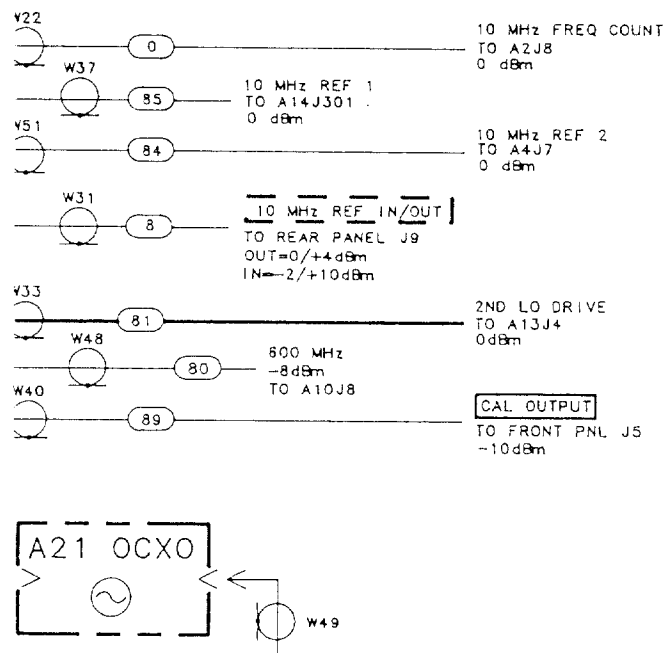


FIGURE 10-16. RF ASSEMBLY BLOCK DIAGRAM
EARLIER THAN 08563-60054, 08563-60055, OR 08563-60056.

RF Section

The RF section converts the input signal to a 10.7 MHz IF (Intermediate Frequency). See Figure 11-5 for a detailed block diagram.

Note The block diagrams for the A14 and A15 assemblies are located in Chapter 10, “Synthesizer Section.”

Troubleshooting Using the TAM
 Low Band Problems (50 Hz to 2.9 GHz)
 Low Band Problems
 A7 LODA (LO Distribution Amplifier)
 A8 Low Band Mixer
 A9 Input Attenuator
 A13 Second Converter
 A14 Frequency Control Assembly
 A7 LODA Drive
 A15 RF Assembly
 Confirming a Faulty Third Converter
 Confirming a Third Converter Output
 Third Converter
 Flatness Compensation Control
 Control Latches
 SIG ID Oscillator (Option 008)
 10 MHz Reference
 A10 Tracking Generator (Option 002)
 Block Diagram Description
 Output Goes Unleveled (ERR 900 or ERR 901)
 Excessive Residual FM
 Flatness Out-of-Tolerance
 Vernier Accuracy Out-of-Tolerance
 Harmonic/Spurious Outputs Too High
 Power Sweep Not Functioning Properly
 No Power Output

Caution All of the RF assemblies are extremely sensitive to Electrostatic Discharge (ESD). For further information regarding electrostatic cautions, refer to “Electrostatic Discharge” in Chapter 1.

Table 11-1. Automatic Fault Isolation References

Suspected Circuit Indicated by Automatic Fault Isolation	Manual Procedure to Perform
Check 2nd IF Amplifier	Third Converter
Check 2nd IF Distribution	Third Converter
Check 10.7 MHz IF Out of Double Balanced Mixer	Third Converter
Check 300 MHz CAL OUTPUT	Calibrator Amplitude Adjustment in Chapter 2
Check A7 1st LO Distribution Amplifier	A7 LODA (LO Distribution Amplifier)
Check A8 Low Band Mixer	A8 Low Band Mixer
Check A9 Input Attenuator	A9 Input Attenuator
Check A13 Second Converter	A13 Second Converter
Check A13J2 INT 2nd IF	A13 Second Converter (<i>steps 1 to 6</i>)
Check A15 Control Latches	Control Latches
Check A15J601 10.7 MHz	Third Converter Output
Check External 10 MHz Reference Operation	10 MHz Reference (<i>steps 5 to 11</i>)
Check Gain of Flatness Compensation Amplifier	Third Converter
Check INT 10 MHz Reference Operation	10 MHz Reference (<i>steps 1 to 4</i>)
Check LO Feedthrough	Low Band Problems (1 kHz to 2.9 GHz) (<i>steps 1 to 3</i>)
Check LO Power	Low Band Problems (<i>steps 4 to 9</i>)
Check PIN Switch	PIN Switch
Check PIN Switches in SIG ID Oscillator	SIG ID Oscillator
Check Second Converter Control	A13 Second Converter
Check SIG ID Oscillator	Signal ID Oscillator Adjustment in Chapter 2
Check SIG ID Oscillator Operation	SIG ID Oscillator
Check Third Converter	Low Band Problems (<i>step 10</i>)

Low Band Problems (50 Hz to 2.9 GHz)

1. Disconnect all inputs from the front-panel INPUT 50 Ω connector.
2. Set the HP 8560E to the following settings:
Center frequency 0 Hz
Span 1 MHz
Input attenuation 0 dB
3. The LO feedthrough's amplitude observed on the display should be between -6 and -30 dBm.

Note	The marker will not peak search on the LO feedthrough when in a non-zero span. To measure the LO feedthrough amplitude with the markers, set the span to 0 Hz and center frequency to 0 Hz. Press MKR ON.
-------------	--

4. If the LO feedthrough's amplitude is within limits, but signals are low, the RF path following the A8 Low Band Mixer is operating properly.
5. If the LO feedthrough's amplitude is higher than -5 dBm (signal will be "clipped" at top of screen) and signals are low in amplitude, suspect a defective A8 Low Band Mixer.
6. Check A13 Second Converter mixer diode bias at A14J19 pin 1. The bias voltage should be between -150 and -900 mVdc.
7. Troubleshoot the signal path. Refer to the power levels listed on Figure 11-3, RF Section Troubleshooting Block Diagram.

Low Band Problems

1. On the HP 8560E press **PRESET** and **REALIGN LO & IF**. If any error messages are displayed, refer to "Error Messages" in Chapter 6.
2. Perform "External Mixer Amplitude Adjustment" in Chapter 2. If this adjustment cannot be completed, perform the steps located in "Third Converter" in this chapter.
3. Perform the "First LO Output Amplitude" performance test (Refer to the *HP 8560 E-Series Spectrum Analyzer Calibration Guide* or use the TAM functional test).
4. If the performance test fails, perform the "First LO Distribution Amplifier Adjustment" in Chapter 2. If the adjustment fails, set the HP 8560E to the following settings:
Center frequency 300 MHz
Span 0 Hz
5. Place the jumper on A14J23 in the TEST position. Remove W38 from the input of the A7 LODA.
6. Use a power meter or another spectrum analyzer to measure the output of A11 YTO. The power should be between $+2$ dBm and $+13$ dBm.
7. Reconnect W38 to the LODA. Place the jumper on A14J23 in the NORM position.

11. If this voltage is not within the correct range, refer to “LO Distribution Amplifier Adjustment” in Chapter 2, “Adjustment Procedures.”
12. If the voltage varies between 0 Vdc and –2 Vdc, adjust the GATE BIAS for a DVM reading within ± 10 mV of the GATE BIAS voltage listed on A7 LODA’s label. If the voltage does not vary between 0 Vdc and –2 Vdc, troubleshoot the A14 frequency control assembly.
13. Disconnect the jumper from A14J19 to A14J10. Press **LINE** to turn spectrum analyzer off. Reconnect W12 to A14J10. Press **LINE** to turn spectrum analyzer on.
14. If the DVM reading changes significantly, the A7 LODA is probably defective.

A8 Low Band Mixer

1. Connect the HP 8560E CAL OUTPUT to INPUT 50 Ω .
2. Set the HP 8560E as follows:

Center frequency		300 MHz
Span		0 Hz
Input attenuation		10 dB
3. Using another spectrum analyzer, check for approximately –21 dBm (300 MHz) at the input of A8. (This level can easily be measured at the output of FL1 by disconnecting W45 from FL1.)
4. If the level at the input of A8 is less than –25 dBm, suspect FL1 low-pass filter, or A9 input attenuator. Refer to power levels shown on Figure 11-5, RF Section Troubleshooting Block Diagram.
5. Check for approximately –30 dBm (3.9107 GHz) at the output of A8. (This level can easily be measured at the output of FL2 by disconnecting W57 from FL2.)
6. If the level at the output of A8 is less than –35 dBm, suspect A8 low band mixer or FL2 low-pass filter.

A13 Second Converter

Caution The A13 assembly is extremely sensitive to Electrostatic Discharge (ESD). For further information regarding electrostatic cautions, refer to “Electrostatic Discharge Information” in Chapter 1.

1. Connect the HP 8560E CAL OUTPUT to the INPUT 50 Ω connector.
2. Set the HP 8560E to the following settings:

Center frequency	300 MHz
Span	 0 Hz
Input attenuation	 10 dB
3. Disconnect W35 (coax 92) from A13J2.
4. Connect a test cable from A13J2 to the input of another spectrum analyzer.
5. Tune the other spectrum analyzer to 310.7 MHz. The signal displayed on the other spectrum analyzer should be approximately -38 dBm.
6. Remove the test cable from A13J2 and reconnect W35 to A13J2.
7. Disconnect W33 (coax81) from A13J4 and connect W33 through a test cable to the input of another spectrum analyzer.
8. Tune the other spectrum analyzer to a center frequency of 600 MHz.
9. If a 600 MHz signal is not present, or its amplitude is less than -5 dBm, the fault is probably on the A15 RF assembly.
10. Reconnect W33 to A13J4.
11. Connect a DVM's positive lead to A14J19 pin 15 and the negative lead to A14J19 pin 6.
12. If the DVM does not measure between $+14.0$ Vdc and $+15.0$ Vdc perform the following:
 - a. Press **LINE** to turn spectrum analyzer off and disconnect W13 from A14J12.
 - b. Press **LINE** to turn spectrum analyzer on and set the spectrum analyzer to the following settings:

Center frequency	300 MHz
Span	10 MHz
 - c. The voltage should measure $+15$ Vdc ± 0.2 V. If the voltage measures outside this limit, the A14 frequency control assembly is probably defective.
 - d. Press **LINE** to turn spectrum analyzer off, reconnect W13 to A14J12, and press **LINE** to turn spectrum analyzer on. Set the HP 8560E to the following settings:

Center frequency	300 MHz
Span	 0 Hz
13. Move the DVM's positive lead to A14J19 pin 1. The voltage should measure between -150 mVdc and -800 mVdc. If the voltage measures outside this limit, the A13 Second Converter is probably defective.

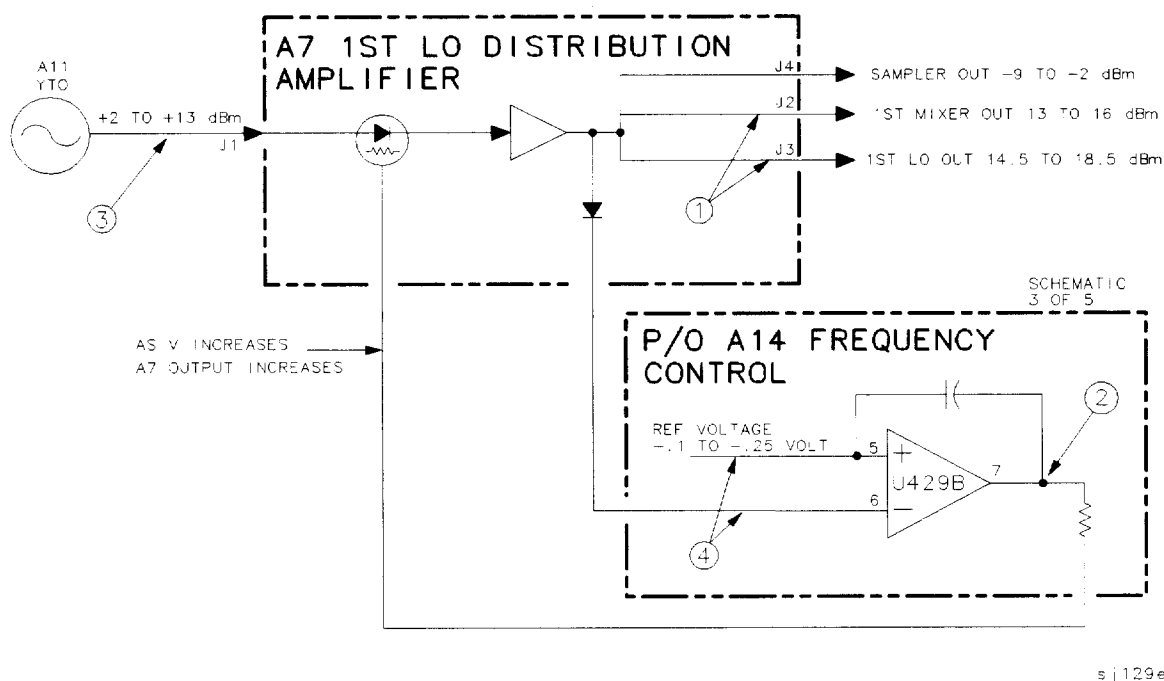


Figure 11-2. A7 LODA Drive

A15 RF Assembly

Note The block diagrams for the A14 and A15 assemblies are located in Chapter 10, "Synthesizer Section."

Confirming a Faulty Third Converter

1. Perform the "IF Input Amplitude Accuracy" performance test in the *HP 8560 E-Series Spectrum Analyzer Calibration Guide* if Opt on 002 is not present. This exercises most of the third converter.
2. If the performance test fails or Option 002 is present, perform the "External Mixer Amplitude Adjustment" in Chapter 2.
3. If adjustment cannot be made, disconnect W35 (coax 92) from A15J801.
4. On the HP 8560E, press **PRESET** and set the controls to the following settings:

Center frequency	300 MHz
Span	0 Hz
5. Connect a signal generator to A15J801.

3. Disconnect W35 (coax 92) and connect a signal source to A15J801. Set the source to the following settings:

Frequency 310.7 MHz
Amplitude -30 dBm

4. Use an active probe with another spectrum analyzer to measure the signal at A15TP601 (function block C). The signal should measure $-17 \text{ dBm} \pm 4 \text{ dB}$ confirming the operation of the 2nd IF Amplifier.
5. Use an active probe with another spectrum analyzer to measure the 300 MHz into the third mixer's LO port. The signal should measure at least +20dBm.
6. Measure the power of the mixer's 10.7 MHz IF output. The signal level should be approximately -22 dBm.
7. Move the A2 controller assembly's WR PROT/WR ENA jumper to the WR ENA position.
8. While measuring the signal at the mixer's 10.7 MHz IF output, adjust the signal source until the level of the 10.7 MHz IF is -40 dBm.
9. On the HP 8560E, press **[SGL SWP]**, **[CAL]**, **IF ADJ OFF**, **MORE 1 OF 2**, and **FLATNESS**. Increase the gain of the flatness compensation amplifiers to maximum by entering 0 using the data keys. This sets the gains in the flatness compensation amplifiers to their maximum values.
10. Connect the other spectrum analyzer to A15J601 and measure the 10.7 MHz IF signal level. The signal should measure greater than -10 dBm. If the signal level is incorrect, continue with step 13.
11. Enter 4095 into the HP 8560E Flatness Data. The signal level at A15J601 should measure less than -36 dBm. This sets the gain of flatness compensation amplifiers to a minimum. If the signal level is incorrect, continue with step 13.
12. Check that the gain stages are properly biased and functioning.
13. Check the attenuator stages and flatness compensation control circuitry.
 - a. For minimum gain (flatness data equals 4095), RF GAIN (A15U909 pin 10) should be at -1.6 Vdc and the current through each section as measured across R667 or R668 should be about 7 mA.
 - b. For maximum gain (flatness data equals 0), RF GAIN (A15U909 pin 10) should be at approximately 0 Vdc and the current through each attenuator section should be close to 0 mA.

Caution	As long as the flatness data just entered is not stored, the previously-stored flatness data will be present after the power is cycled.
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14. Move the A2 controller assembly's WR PROT/WR ENA jumper to the WR PROT position.
15. Reconnect the cable to A15J801.

1. Set the HP 8560E to the following settings:

Trigger single sweep
SIG ID on

2. Use an active probe with another spectrum analyzer to measure the signal level at A15TP602.
3. On the HP 8560E press **SGL SWP**. With each press of **SGL SWP** the spectrum analyzer alternates between the following two states:

State 1:

A15J901 pin 13 (LSID)	TTL low
SIG ID oscillator	ON
Signal at A15TP602	298 MHz $\pm$ 50 kHz (at least +1 dBm)

State 2:

A15J901 pin 13 (LSID)	TTL high
SIG ID oscillator	OFF
3rd LO driver amplifier	Provides LO for double balanced mixer

4. With the SIG ID oscillator on, measure the frequency at A15TP602 with a frequency counter and an active probe. If the frequency is not 298 MHz $\pm$ 50 kHz, refer to the "SIG ID Oscillator Adjustment" procedure in Chapter 2.
5. On the HP 8560E, press **SGL SWP** until A15J901 pin 13 is at TTL low. Diodes CR603 and CR605 should be forward biased and CR604 should be reverse biased (approximately 6 Vdc reverse bias). Diodes CR501 and CR502 should be forward-biased, disabling the 3rd LO driver amplifier.
6. The voltage at the R622/R623 node should measure approximately -5 Vdc, biasing Q604 on.
7. If oscillator bias voltages are correct, place a 100 Ω resistor across SAWR U602 input and output. If the SAWR has failed, this will provide the equivalent loss of a correctly functioning SAWR, and the circuit will begin to oscillate.

10 MHz Reference

The spectrum analyzer 10 MHz reference consists of 10 MHz OCXO (Option 103: TCXO) with associated TTL level generator and distribution circuitry. The OCXO (or TCXO) and TTL level generator are turned off when an external 10 MHz reference is used. Also, with the spectrum analyzer set to EXTERNAL frequency reference, U304A output (low) forces the output of U304D to stay high. This allows U304B to control the outputs of U303B, U304C, and U303D. In INTERNAL frequency reference, U304D controls the outputs of these three NAND gates, and the output of U304B is held high.

Check the 10 MHz reference by performing the following steps:

1. Set the HP 8560E's 10 MHz reference to internal by pressing **AUX CTRL**, **REAR PANEL**, and **10 MHz INT**.

hp running

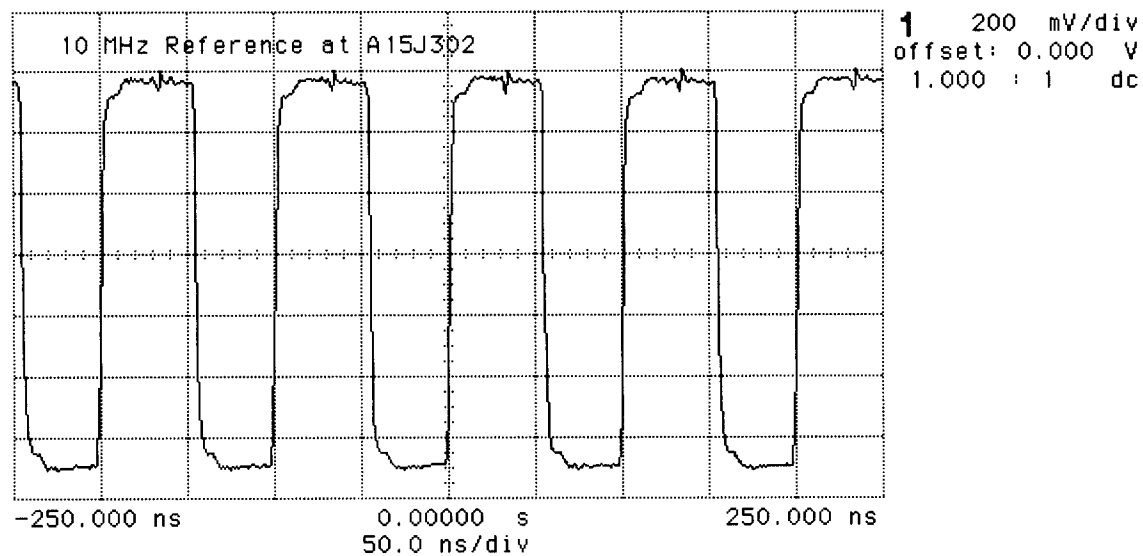


Figure 11-3. 10 MHz Reference at A15J302

hp stopped

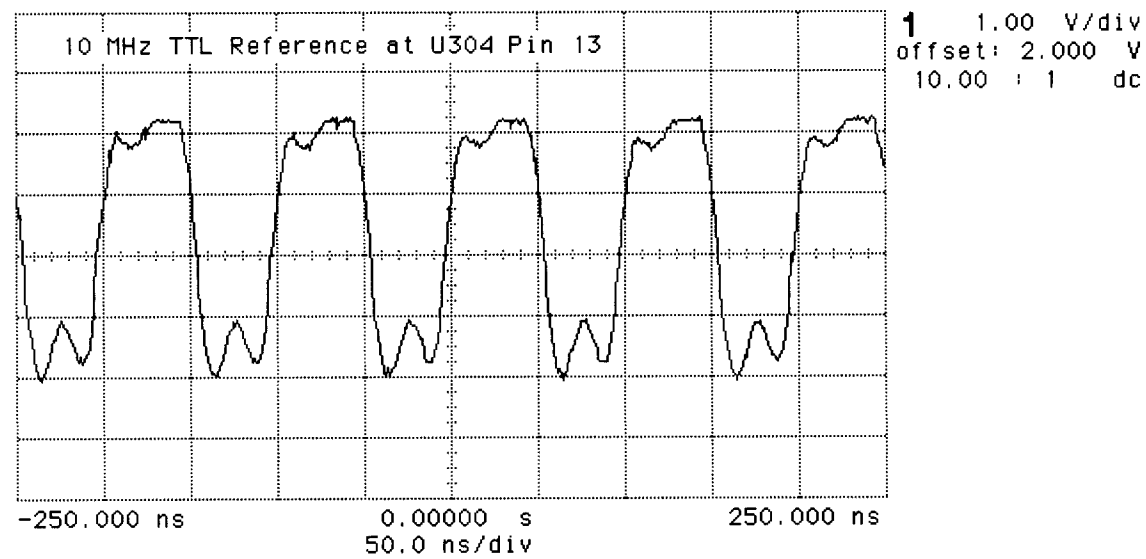


Figure 11-4. 10 MHz TTL Reference at U304 Pin 13

A10 Tracking Generator (Option 002)

Block Diagram Description

The A10 tracking generator consists of several smaller circuits. The A10 is not component-level repairable; a rebuilt exchange assembly is available.

The block diagram of the tracking generator is unique in that it only recreates one of the spectrum analyzer's intermediate frequencies. This minimizes isolation problems associated with a built-in tracking generator. Each of the blocks comprising the A10 tracking generator is described below.

Tracking Oscillator

The tracking oscillator enables the fine adjustment of the tracking generator output frequency to compensate for the frequency inaccuracies of the spectrum analyzer's 10.7 MHz IF. The tracking oscillator determines the residual FM and frequency drift of the tracking generator. The 182.14 MHz output frequency is obtained by doubling the output of a crystal oscillator operating at 91.07 MHz.

Upconverter

The upconverter mixes the tracking oscillator output with the buffered 600 MHz reference from the A15 RF assembly. The upconverter also contains a filter to pass only the 782.14 MHz upper sideband.

Pentupler

The pentupler multiplies the 782.14 MHz signal by five to generate 3.9107 GHz, the spectrum analyzer's 1st IF. A dual cavity band-pass filter centered at 3.9107 GHz eliminates all unwanted multiples of 782.14 MHz.

Modulator

The output of the pentupler is passed through a modulator to adjust the power level into the output mixer. The modulator is controlled by an ALC circuit on the bias board which is fed by a detector in the output amplifier. If the detected output power is too high, the ALC will drive the Modulator to decrease the input level into the output mixer, resulting in a decrease in output power.

Coupler

The 1st LO signal from the A7 LODA is coupled off and buffered to drive the output mixer. The main line of the coupler is fed to the 1ST LO OUTPUT on the front panel. The loss through the coupler main line is less than 2.5 dB.

Output Mixer

The 3.9107 GHz signal from the modulator is fed into the RF port of the output mixer. The LO port of the output mixer is driven by the buffered 1st LO signal from the coupler. The output of the mixer is then amplified.

3. Check maximum power available from the TG. Connect the RF OUT 50 Ω to the INPUT 50 Ω connector. Press **PRESET**, **AMPLITUDE**, **2**, **0**, **+ dBm**, **LOG dB/DIV**, **5**, **dB**, **AUX CTRL**, **TRACKING GENERATOR**, **SRC PWR ON**, **MORE 1 OF 3**, **ALC EXT**. No connection should be made to the ALC EXT INPUT connector on the rear panel. The available power should always be greater than +1 dBm. If the output is unleveled only at specific frequencies, a power hole will usually be visible at those frequencies.
4. Perform the "1ST LO OUTPUT Amplitude" performance test. If the test fails, note the center frequency setting at which the power level was out-of-tolerance. Repeat the test with the power sensor connected to A7J3 (a right-angle SMA adapter will be necessary) and note the center frequency of any out-of-tolerance power levels. The power level should be +16.5 dBm $\pm$ 2 dB.

If the power level is correct at W43 but out-of-tolerance at the 1ST LO OUTPUT (front panel) and the center frequency setting of the out-of-tolerance power levels is close to the frequencies at which the output is unleveled, suspect either A10 or W46.

If the power level at W43 is also out-of-tolerance, suspect either the A7 LODA or the A11 YTO. Refer to Chapter 10, "Synthesizer Section."
5. If the output is unleveled only at certain power level settings or certain frequencies, monitor A17J16 pin 1 with a DVM. Connect the negative DVM lead to A17J16 pin 6. Vary the TRK GEN RF POWER or center frequency settings, as appropriate, and plot the voltage variation versus power level or frequency. A discontinuity in the plot near the frequency or power level at which the output is unleveled indicates a problem on the A14 frequency control assembly.

Excessive Residual FM

Either the tracking oscillator or the ALC circuitry could be responsible for excessive residual FM. The residual FM should be measured on another spectrum analyzer, such as an HP 8566A/B or HP 8568A/B, using slope detection with the HP 8560E set to zero span.

Proceed as follows to troubleshoot residual FM problems:

1. Perform the "Residual FM" performance test for the spectrum analyzer in the *HP 8560 E-Series Spectrum Analyzer Calibration Guide*. If this test passes, the 1st LO input and 600 MHz drive signals should be correct. If the test fails, troubleshoot the synthesizer section.
2. Monitor A14J17 pin 15 (TUNE +) with an oscilloscope. Connect the oscilloscope probe ground lead to A14J17 pin 6. The voltage at this point should be greater than 500 mV. If the voltage is less than 500 mV, perform the "Tracking Oscillator Range" performance test in the *HP 8560 E-Series Spectrum Analyzer Calibration Guide*. If this test fails, perform the "Tracking Oscillator Range Adjustment". If the noise on this tune line is greater than 10 mV, troubleshoot the BITG drive circuitry on A14.
3. Monitor the output of the tracking generator with another spectrum analyzer. Check for high-amplitude spurious responses from 100 kHz to at least 3 GHz. If the spurious responses are too high in amplitude, the (broadband) ALC detector may cause the ALC loop to oscillate, generating FM sidebands. If any spurious responses are excessively high, refer to "Harmonic/Spurious Outputs Too High" in this chapter.
4. If no spurious responses are present or are sufficiently low enough in amplitude to not cause a problem, suspect the tracking oscillator in A10.

3. Check for excessive LO feedthrough. Use the “LO Feedthrough” performance test in the *HP 8560 E-Series Spectrum Analyzer Calibration Guide*, but check over a center frequency range of 300 kHz to 100 MHz. The LO feedthrough will be 3.9107 GHz greater than the center frequency setting.

Harmonic/Spurious Outputs Too High

Harmonic and spurious outputs may be generated by A10 itself or may be present on the either the 600 MHz drive or 1st LO drive signal. There is a direct relationship between spurious signals on the 1st LO and spurious signals on the TG output. There is a five-to-one relationship between spurious signals on the 600 MHz drive and the spurious signals on the TG output. For example, if the 600 MHz signal moves 1 MHz, the TG output signal will move 5 MHz. This is due to the multiplication in the pentupler.

1. If the “Harmonic Spurious Responses” performance test failed, connect another spectrum analyzer, such as an HP 8566A/B, to the HP 8560E 1ST LO OUTPUT connector. Set the HP 8560E to each frequency as indicated in the performance test, with the span set to 0 Hz. At each frequency setting, press **SGL SWP**, **CAL**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, **LO FREQ**. The frequency displayed will be the fundamental frequency of the 1ST LO OUTPUT. Use the HP 8566A/B to measure the level of the second and third harmonics of the 1st LO signal.

Note	The 1st LO typically has a higher harmonic content than the tracking generator output. For the purposes of this check, it is the variation in harmonic content versus frequency which is important.
-------------	---

If the variation of the harmonic level of the 1st LO versus frequency tracks the harmonic level variation of the tracking generator output, repeat this step while measuring the 1st LO signal at the end of W43 nearest A10. If there is little variation in the 1st LO harmonic level between the 1ST LO OUTPUT connector and W43, and the relative variation in harmonic level tracks with the TG output harmonic level, suspect either the A7 LODA or A11 YTO.

If the harmonic level variation of the 1st LO versus frequency does not track the harmonic level variation of the TG output, suspect A10.

2. If sidebands are present at the same frequency offset at every output frequency, check the spectral purity of the 1st LO and the 600 MHz drive signals using another spectrum analyzer. When checking the 1st LO, the HP 8560E must be set to zero span. Press **CAL**, **MORE 1 OF 2**, **FREQ DIAGNOSE**, **LO FREQ** to determine the 1st LO frequency. A 1 MHz sideband on the 1st LO will appear as a 1 MHz sideband on the output signal.

To verify that the 600 MHz drive or 1st LO signal is responsible for the sidebands, substitute a clean signal for the 600 MHz drive or 1st LO signal. If the sidebands on the output disappear when using the clean signal, the substituted signal was responsible for the sidebands.

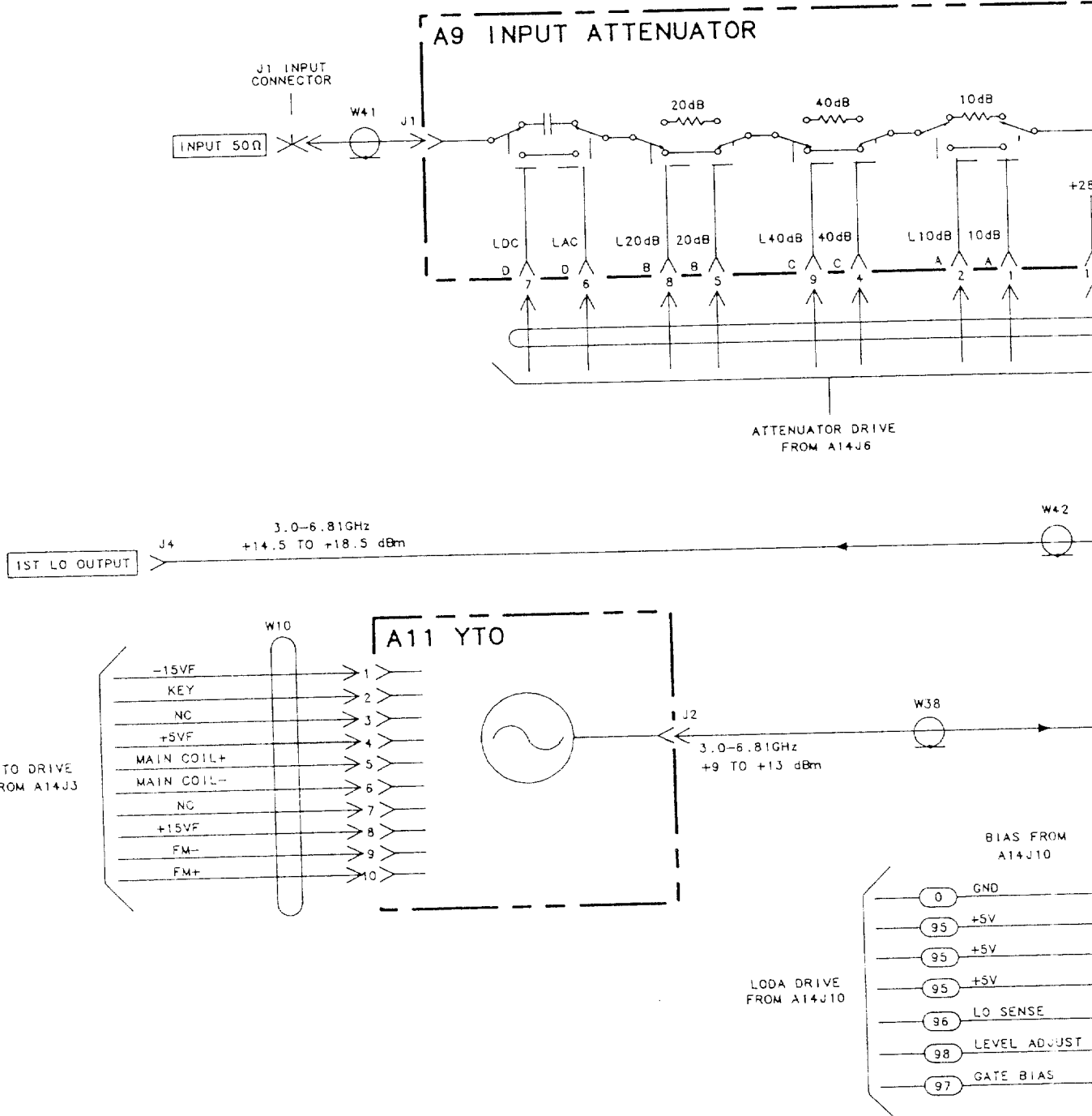
Note	The 600 MHz drive signal should be -8 dBm $\pm$ 3.5 dB. The 1st LO signal should be +16 dBm $\pm$ 2 dB.
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7. If all of the checks above are correct, the tracking oscillator might not be functioning. Setup the HP 8560E as indicated in the "Tracking Oscillator Range Adjustment" procedure, using a spectrum analyzer, such as an HP 8566A/B, in place of the frequency counter. Try to adjust A10C3 until a signal is displayed on the HP 8566A/B. If adjusting A10C3 does not start the tracking oscillator functioning, suspect the A10 tracking generator.

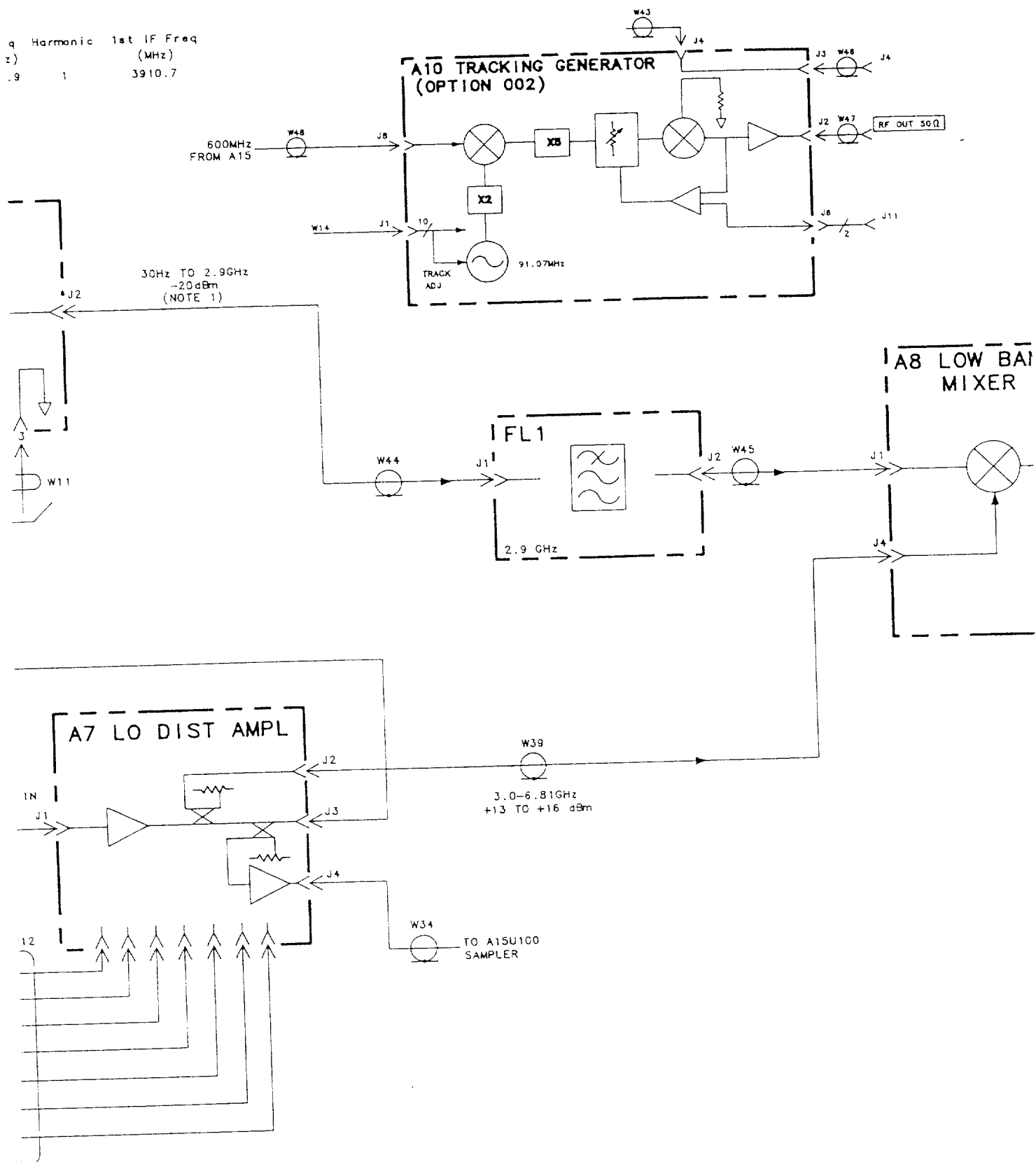
RF SECTION BLOCK DIAGRAM

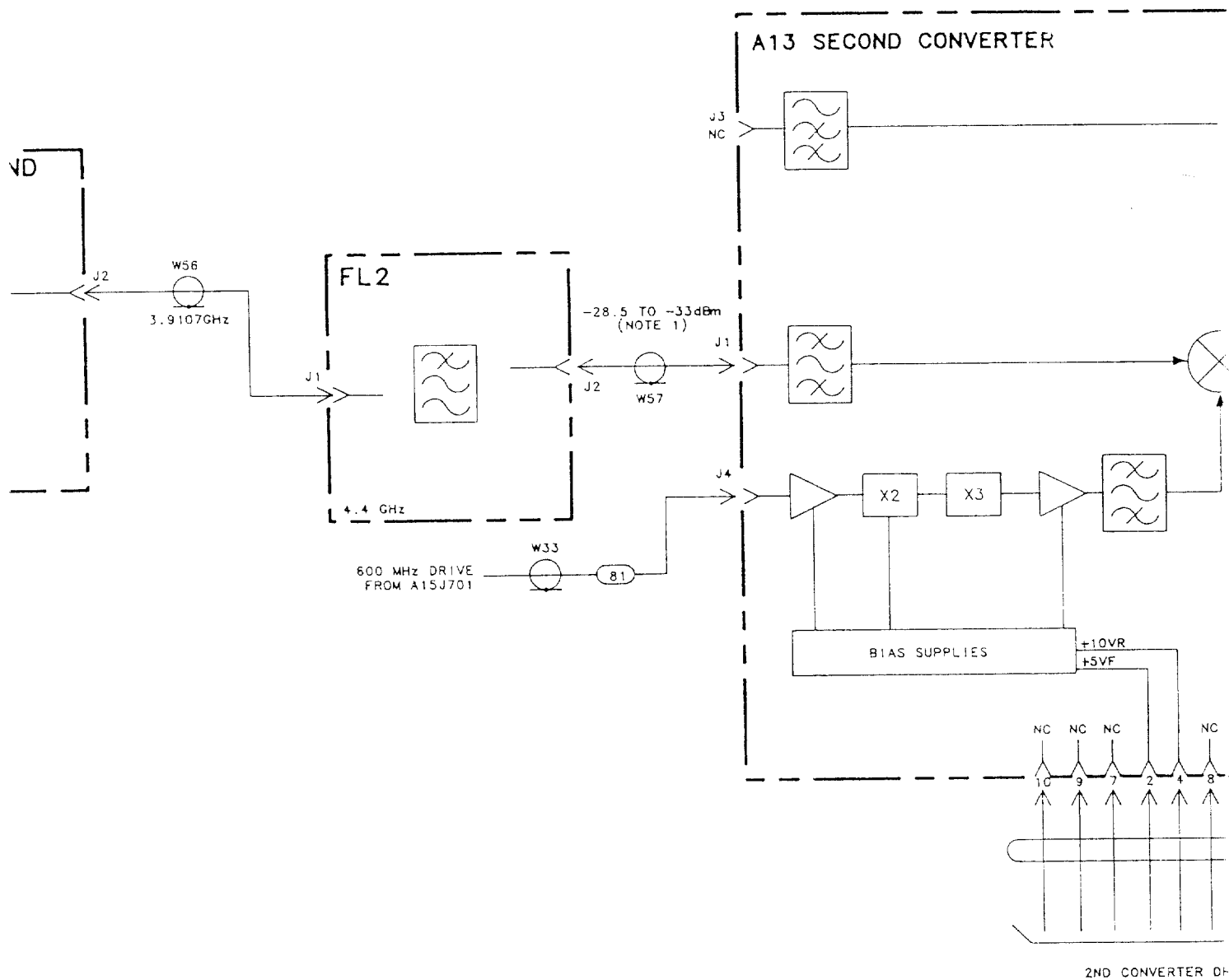
Band

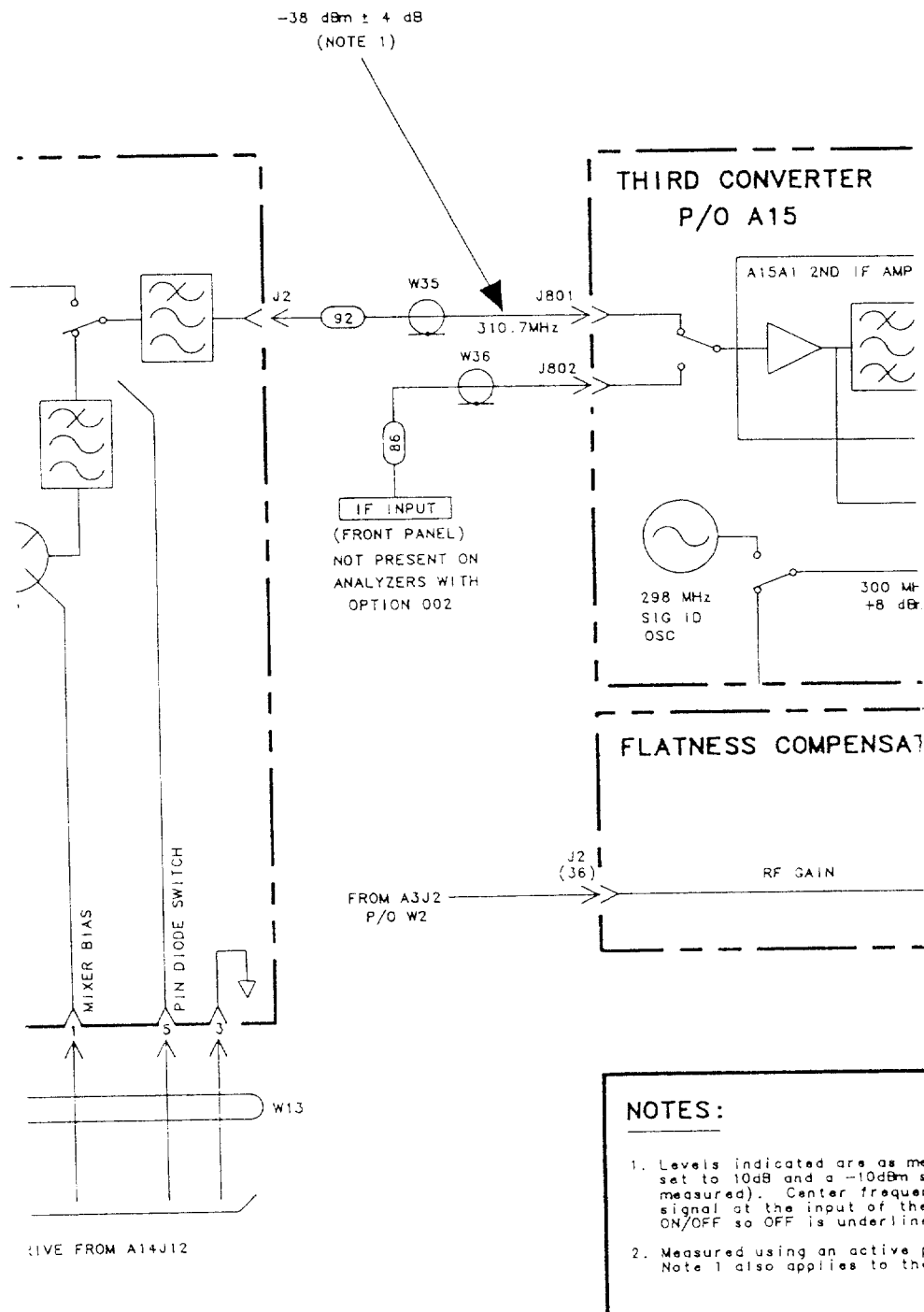
0



q Harmonic 1st IF Freq
 z) (MHz)
 .9 1 3910.7







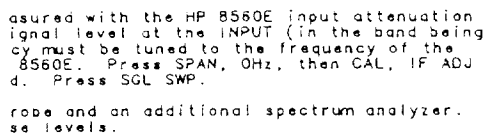


FIGURE 11-5. RF SECTION, TROUBLESHOOTING BLOCK DIAGRAM

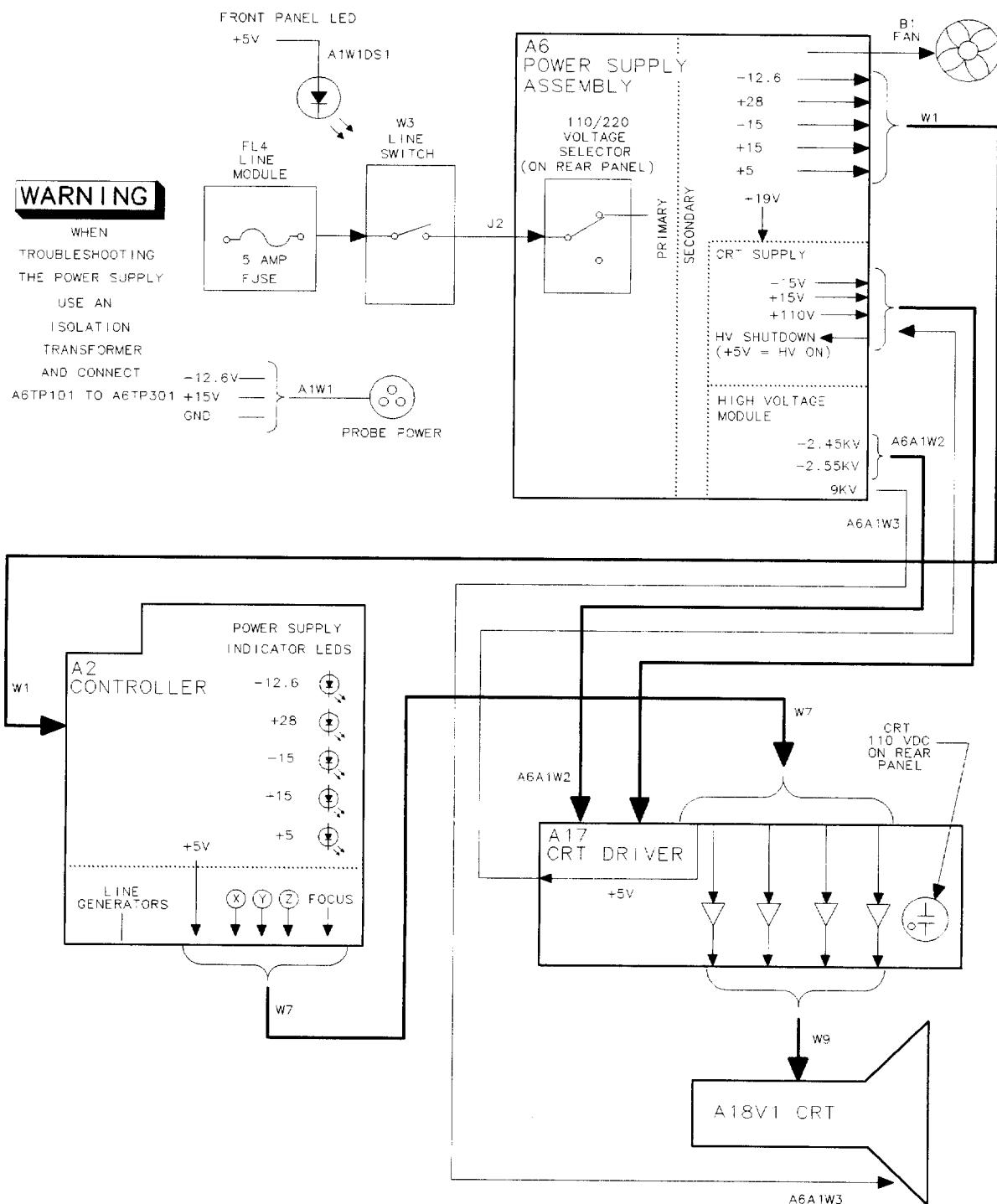
Display/Power Supply Section

The display/power supply section contains the A6 power supply, A6A1 HV module, A17 CRT driver, and A18 CRT. Figure 12-1 illustrates the section block diagram. Table 12-1 lists signal versus pin numbers for power cable W1.

- Troubleshooting Using the TAM
 - Blank Display (Using the TAM)
- Blank Display
- Blanking Signal
- Display Distortion
- Focus Problems
- Intensity Problems
- A6 Power Supply Assembly
 - Dead Power Supply
 - Line Fuse Blowing
 - Supply Restarting Every 1.5 Seconds (Kick Start)
 - Low Voltage Supplies
 - High Voltage Supplies
 - CRT Supply Dropping Out
 - Blanking Signal
 - Buck Regulator Control
 - DC-DC Converter Control
 - Power Up

Warning

- The A6 power supply and A6A1 high voltage assemblies contain lethal voltages with lethal currents in all areas. Use extreme care when servicing these assemblies. Always disconnect the power cord from the instrument before servicing these assemblies. Failure to follow this precaution can represent a shock hazard which may result in personal injury.
- The voltage potential at A6A1W3 is +9 kV. If the cable must be disconnected, always disconnect it at the CRT with caution! Failure to properly discharge A6A1W3 may result in severe electrical shock to personnel and damage to the instrument. See procedure 2 in Chapter 3.
- Do not discharge the CRT second anode directly to ground, with the A6A1 high voltage cable connected. This can damage the A17 CRT driver assembly. Always discharge through a high resistance, such as a high voltage probe.
- Always use an isolation transformer when troubleshooting either the A6 power supply or the A6A1 HV module. When using an isolation transformer, connect a jumper between A6TP101 and A6TP301. This connects the circuit common to earth ground. Remove this jumper when the isolation transformer is not used.



sp141e

Figure 12-1. Simplified Power Supply Block Diagram

12-2 Display/Power Supply Section

Table 12-1. W1 Power-Cable Connections

Signal	A2J1 (pins)	A3J1 (pins)	A4J1 (pins)	A5J1 (pins)	A6J1- (pins)	A14J1 (pins)	A15J1 (pins)
NC	-	-	-	-	-	-	-
NC	-	-	-	-	-	-	-
A GND	-	3	3	48	3*	3	3
NC	-	-	-	-	-	-	-
NC	-	-	-	-	-	-	-
A GND	-	6	6	45	6*	6	6
NC	-	-	-	-	-	-	-
NC	-	-	-	-	-	-	-
A GND	-	9	9	42	9*	9	9
SCAN RAMP	41	10	-	-	-	10*	-
NC	-	-	-	-	-	-	-
A GND	-	12	12	39	12*	12	12
-12.6 V	38	13	-	-	13*	-	-
-15 V	-	14	14	37	14*	14	14
A GND	-	15	15	36	15*	15	15
-15 V	-	16	16	35	16*	16	16
+15 V	-	17	17	34	17*	17	17
A GND	-	18	18	33	18*	18	18
+15 V	-	19	19	32	19*	19	19
+28 V	-	20	-	-	20*	20	20
+28 V	-	21	-	-	21*	21	21
PWR UP	29	-	-	-	22*	-	-
-15 V	-	23	23	28	23*	23	23
-15 V	-	24	24	27	24*	24	24
+15 V	-	25	25	26	25*	25	25
+15 V	-	26	26	25	26*	26	26
+5 V	-	27	27	24	27*	27	27
+5 V	-	28	28	23	28*	28	28
+5 V	-	29	29	22	29*	29	29
+5 V	-	30	30	21	30*	30	30
D GND	20	31	31	20	31*	-	31
D GND	19	32	32	19	32*	-	32
A GND	18	33	33	18	33*	33	33
A GND	17	34	34	17	34*	34	34
D GND	16	35	35	16	35*	35	35
D GND	15	36	36	15	36*	36	36
D GND	14	37	37	14	37*	37	37
D GND	13	38	38	13	38*	38	38

Table 12-1. W1 Power-Cable Connections (continued)

Signal	A2J1 (pins)	A3J1 (pins)	A4J1 (pins)	A5J1 (pins)	A6J1- (pins)	A14J1 (pins)	A15J1 (pins)
+5 V	12	39	-	-	39*	-	-
+5 V	11	40	-	-	40*	-	-
+5 V	10	41	-	-	41*	-	-
+5 V	9	42	-	-	42*	-	-
+5 V	8	43	-	-	43*	-	-
+5 V	7	44	-	-	44*	-	-
+28 V	6	45	-	-	45*	-	-
LINE TRIGGER	-	46	-	-	46*	-	-
+15 V	4	47	-	-	47*	-	-
+15 V	3	48	-	-	48*	-	-
-15 V	2	49	49	-	49*	-	-
-15 V	1	50	50	-	50*	-	-
* Indicates signal source connectors.							

Troubleshooting Using the TAM

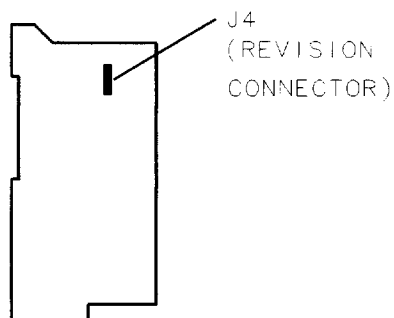
When using automatic fault isolation, the TAM indicates suspected circuits that need to be manually checked. Use Table 12-2 to locate the manual procedure.

Table 12-3 lists assembly test connectors associated with each manual probe troubleshooting test. Figure 12-2 illustrates the location of A17's test connectors.

Table 12-2. Automatic Fault Isolation References

Suspected Circuit Indicated by Automatic Fault Isolation	Manual Procedure to Perform
Check A2 Controller	Blanking Signal
Check All Power Supply Outputs	Dead Power Supply (<i>steps 1-5</i>)
Check Buck Regulator	Dead Power Supply (<i>steps 13-23</i>)
Check Buck Regulator Control Circuitry	Dead Power Supply (<i>steps 11-21</i>)
Check High-Voltage Supplies	High Voltage Supplies
Check Input Rectifier	Dead Power Supply (<i>steps 6-7</i>)
Check Intensity Adjustments	Intensity Problems (<i>steps 1-4</i>)
Check Kick Start/Bias Circuitry	Dead Power Supply (<i>steps 8-10</i>)
Check Low-Voltage Supplies	Low Voltage Supplies

A17 CRT DRIVER



SK 1121

Figure 12-2. A17 Test Connector

Table 12-3. TAM Tests versus Test Connectors

Connector	Manual Probe Troubleshooting Test	Measured Signal Lines
A17J4	Revision	MS5
	Constant current Source	MS1
	Intensity input	MS7
	Intensity offset	MS7
	Blanking control	MS8
A2J201	10 V reference test	MS4
	Switch drive test	MS3
	Buffered X & Y DAC outputs	MS2, MS7
	X line generator test	MS6
	Y line generator test	MS1
	Intensity offset output	MS8
A2J202	Revision	MS1
	X, Y, & Z output offset	MS3, MS4, MS7
	X output amplifier	MS7
	Y output amplifier	MS3
	Blanking test	MS4
	Focus DAC test	MS2

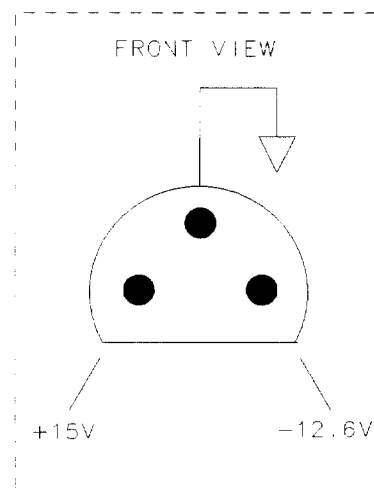
Blank Display (Using the TAM)

Use the following procedure if the instrument's display is blank. This procedure substitutes an HP-IB printer for the display.

1. Connect the printer to the HP 8560E spectrum analyzer and set the printer's address to the value required by the TAM. This is usually 1.
2. All of the power-supply indicator LEDs along the edge of the A2 controller assembly should be lit.
3. The rear-panel CRT +110 VDC ON indicator should also be lit.
4. Connect the TAM's probe cable to A2J11.
5. Press **MODULE**, **SOFT KEY #3**, **▼**, and **SOFT KEY #1**. (The top soft key is #1.)
6. The yellow LED next to A2J11 should blink approximately ten times. If the LED fails to blink correctly, troubleshoot the digital section of the A2 controller assembly.
7. Move the probe cable to A2J202. Press **SOFT KEY #1** and wait 5 seconds.
8. Press **SOFT KEY #4**. The results should be sent to the printer.
9. Move the probe cable to A2J201, press **SOFT KEY #1** and wait 5 seconds.
10. Press **SOFT KEY #4**. The results will be sent to the printer.
11. If a failure is indicated in any of these tests, the fault lies on the A2 controller assembly. to obtain more information:
 - a. Press the down arrow key one less time than the test number. (For example, press it twice for the third test on the list.)
 - b. Press **SOFT KEY #3**, then **SOFT KEY #4**, and when the printout is complete, **SOFT KEY #6**.
12. If no failures were indicated in testing the A2 controller, move the probe cable to A17J4.
13. Press **SOFT KEY #1** and wait 5 seconds.
14. Press **SOFT KEY #4**. The results will be sent to the printer.
15. If no failure is indicated in the printout, check the high-voltage supplies as described "High Voltage Supplies" in this chapter.

Blank Display

1. If the LED above the front-panel LINE switch is lit, most of the A6 power supply is functioning properly.
2. Carefully check the voltages on the front-panel PROBE POWER jack. Be careful to avoid shorting the pins together. See Figure 12-3.
3. Check that the fan is operating. If the PROBE POWER voltages are correct, and the fan is turning, the A6 power supply is probably working properly.
4. If the rear-panel's CRT +110 VDC ON LED is lit, the high-voltage supplies should also be operating. (The high-voltage supplies will be turned off if the HV SHUT_DOWN line is low.) The A6 power supply feeds +5 V to the A2 controller through W1. The A2 assembly distributes this +5 V to the A17 CRT driver through W7. A17 sends +5 V back to A6 as the HV SHUT_DOWN signal on W8. As a result, A2, A17, W1, W7, and W8 must all be in place for the high-voltage supplies to operate.
5. If all of the power supply indicators along the outside edge of the A2 controller assembly are lit, the A6 power supply is probably working properly.



SK 1122

Figure 12-3. Probe Power Socket

6. Press **FREQUENCY**, 1, **GHz**.
7. Allow the analyzer to warm-up for at least 1 minute.
8. While observing the display, press **LINE** to turn the spectrum analyzer off. If a green flash appears on the display, the CRT is probably working properly; troubleshoot either the A2 controller or the A17 CRT driver.
9. If a flash does not appear on the display, the A2 controller, A6A1 HV module, A17 CRT driver, or A18V1 CRT might be at fault.

Blanking Signal

1. Connect an oscilloscope probe to A2J202 pin 3. Connect the oscilloscope ground lead to TP3. Set the oscilloscope to the following settings:

Sweep time 2 ms/div
Vertical scale 1 V/div

2. If a 4 Vp-p signal is not observed, the A2 controller assembly is faulty.

3. Repeat steps 1 and 2 with the oscilloscope probe on A2J202 pin 14.

4. Set the oscilloscope to the following settings:

Sweep time 1 μ s/div
Vertical scale 2 V/div

5. Connect the positive probe lead to A2J202 pin 15. This is the blanking output.

6. TTL-level pulses should be observed. If the signal is either always high or always low, the display will be blanked; suspect the A2 controller assembly.

7. If the signals on A2J202 pins 3, 14, and 15 are correct, troubleshoot the A17 CRT driver.

Display Distortion

The HP 8560E uses a vector display. The graticule lines, traces, and characters are composed of a series of straight lines (“vectors”) placed end-to-end. If the vectors do not begin and end at the proper points, the display appears distorted, but in focus. Symptoms range from characters appearing elongated and graticule lines not meeting squarely, to an entirely unreadable display.

1. If the spectrum analyzer is in external frequency reference mode (an “X” is displayed along the left side of the display), ensure that an external 10 MHz reference is supplied. Otherwise the 16 MHz CPU clock will be off-frequency, causing distortion.
2. Use the CRT ADJ PATTERN to check for distortion. Press **CAL**, **MORE 1 OF 2**, and **CRT ADJ PATTERN**. If vector distortion (described above) occurs, perform the “Display Adjustment” in Chapter 2 to test the function of the A2 controller assembly.
3. If there is distortion along with slight focus degradation, but the graticule lines meet (not necessarily squarely), the A17 CRT driver, CRT, DDD/TRACE ALIGN adjustments, or cable connections might be at fault.
4. If the A2 controller assembly is not part number 08563-60017, perform the “16 MHz PLL adjustment” in Chapter 2. If the 16 MHz CPU clock is off-frequency, the display will be distorted.
5. Perform the “Display Adjustment” in Chapter 2. Isolate the problem to either the X or Y axis by noting the behavior of the adjustments. If the line generator or fast zero-span portion of the adjustment fails, troubleshoot the A2 controller assembly.
6. If the adjustments do not remedy the problem, press **LINE** to turn the spectrum analyzer off and place the A17 CRT driver in the service position.

7. Distortion confined to one axis (vertical or horizontal only), indicates a faulty A17 assembly's X or Y deflection amplifier. Use the alternate good deflection amplifier for obtaining typical voltages. (There is enough symmetry in a typical display that the voltages should be similar between these circuits.)
8. Monitor the waveforms at A17TP11 and A17TP14 (or TP12 and TP13). The 50 to 100 Vp-p ac component of the waveforms at the X and $\bar{X}$ (or Y and $\bar{Y}$) outputs should be mirror images of each other. The dc average should be 55 V.
9. The appropriate POSN adjustment (A17R57 or A17R77) should change the dc component of both X and $\bar{X}$ (or Y and $\bar{Y}$) outputs in opposite directions.
10. The appropriate GAIN adjustment (A17R55 or A17R75) should change the ac component in both outputs by the same amount.
11. If the display is a single dot, check the base of A17Q18 for $-10.3 \text{ V} \pm 0.3 \text{ V}$. Verify the signals at TP11, TP14, TP12, and TP13.
12. If signals are correct and cables to the CRT are good, suspect the CRT.

Focus Problems

Focus problems may be due to a defective A18V1 CRT, the A17 CRT driver (especially the grid level shifter section), or the A2 controller's focus-control circuitry. Focus problems may also be due to improper adjustments, improper connections, or absence of high voltage.

Although A17's grid level shifter (function block D) is the leading cause of A17 focus problems, function blocks C, E, F, and H generally have less effect on focus, but may cause poor focus that is a function of screen position, length of line, or intensity.

1. Connect a DVM's positive lead to A2J202, pin 2. Connect the negative lead to A2J202 pin 6.
2. Use the knob to change the focus DAC value from 0 to 255.
3. If the DVM reads near 0 Vdc with the focus set to 0, and near -10 Vdc with the focus set to 255, A2's focus control circuitry is working properly.
4. Perform the "Display Adjustment" in Chapter 2. Note that A17R34 COARSE FOCUS has the greatest effect on focus. Adjustment A17R93 ASTIG and A17R92 DDD have a lesser effect, and A17R21 Z FOCUS, A17R26 X FOCUS and front-panel adjustment (press **DISPLAY**, **MORE 1 OF 2**, **FOCUS**, and turn knob) have less effect on focus.
5. If the focus of some areas of the screen are worse than normal, continue with step 11. If no part of the screen can be brought to sharp focus, continue with step 6. (CRTs have some normal focus variation across their face.)
6. Turn off the analyzer and place A17 in the service position. Connect the ground lead of a high-voltage probe (HP 34111A) to the chassis, and use it with a DVM to measure A17J7(10).

7. The nominal A17J7(10) voltage is -1600 Vdc , but the CRT will function if this voltage is within 200 V of -1600 Vdc .
8. Adjusting A17R34 COARSE FOCUS should vary the A17J7(10) voltage by 150 V . If these voltages are correct, suspect the CRT.
9. Check the A6A1 high voltage module cathode supply output at A17TP16 using a high voltage probe. If the cathode voltage is $-2450\text{ V} \pm 250\text{ V}$, check the focus grid level shifter.
10. If the cathode voltage is not correct, check the A6A1 high voltage module and its connections.
11. Connect an oscilloscope probe to A17TP9. This signal corrects the focus for the X position of the CRT beam, and for intensity level. It also provides the front-panel focus adjusting voltage.
12. Press **DISPLAY**, **MORE 1 OF 2**, and **FOCUS**. While turning the front-panel knob, verify the dc level of the signal at TP9 adjusts about 30 Vp-p .
13. Verify that the front panel intensity adjustment, when used with the A17R21 Z FOCUS, changes the peak-to-peak voltage at TP9 by 25 V . Access the intensity adjustment by pressing **DISPLAY**, **INTENSITY**, and turning the front panel knob.
14. Set front panel intensity to minimum. Set A17R21 Z FOCUS and A17R26 X FOCUS fully counterclockwise. Verify that the peak-to-peak voltage at TP9 is about 40 Vp-p (due to X-dynamic focus circuit).
15. If circuit operation seems correct, the A18V1 CRT is probably at fault.

Intensity Problems

Intensity problems, or absence of display, can be due to the A17 assembly's intensity amplifier (function block A), intensity grid level shifter (function block B), CRT (A18V1), interconnections, or lack of proper supplies or inputs to A17.

1. On the HP 8560E spectrum analyzer press **DISPLAY** and **INTENSITY**.
2. Rotate the front-panel knob (RPG), and check that the intensity changes from dim, but readable, to bright.
3. If the intensity function does not function properly, troubleshoot the A2 controller assembly.
4. Perform the preliminary and Z-axis portions of the "Display Adjustment" in Chapter 2. Verify that A17R11 CUTOFF functions properly. If A17R11 CUTOFF does not function properly, place the A17 CRT driver in the service position.
5. Verify that blanking pulses are present at A17TP2 using an oscilloscope. The pulses should be normal TTL levels, approximately $1\text{ }\mu\text{s}$ wide and $4\text{ or }7\text{ }\mu\text{s}$ apart. If the blanking pulses are not correct, check the BLANKING output of the A2 controller assembly and cable W7.

6. If blanking pulses are present, check A17TP10 with the oscilloscope. The TP10 signal should vary with the front-panel intensity adjustment, and be approximately 55 Vp-p maximum. The signal will be composed of both blanking pulses and varying intensity levels for the lines being drawn.
 - a. If a proper signal is not present at A17TP10, check A17Q1, Q2, CR1, and CR2.
 - b. If the TP10 signal does not vary with the front-panel intensity adjustment, check the signals at A17TP4 and A17TP1. Both signals should vary with the front panel intensity adjustment. The TP4 signal should be up to 4 Vp-p, and the TP1 signal should be up to approximately 12 Vp-p.

Warning	The A17 CRT Driver contains lethal voltages with lethal currents. Use extreme care when servicing this assembly. Always disconnect the power cord from the instrument before servicing this assembly. Failure to follow this precaution can present a shock hazard which may result in personal injury.
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Note	The following measurements should be made with a high-voltage probe, such as the HP 34111A. When using the high-voltage probe, connect the ground lead securely to the HP 8560E chassis.
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7. Carefully measure the grid voltage at A17J7 pin 6, and the cathode voltage at A17J7 pin 4. The display will work with a cathode voltage of $-2450\text{ V} \pm 250\text{ V}$, provided the grid voltage (A17J7 pin 6) is 30 to 100 V more negative than the cathode. A17R11, CUTOFF, should be able to adjust the voltage difference over a 60 V range to account for tube variations, and achieve proper intensity.
8. If the grid and cathode voltages are correct, turn off the HP 8560E spectrum analyzer and check A17CR10 with an ohmmeter. If A17CR10 is good, suspect the A18V1 CRT.
9. If the grid and cathode voltages are too low, turn off the power and disconnect W8 from the base of A18V1 CRT, and recheck the grid and cathode voltages.
10. If the grid and cathode voltages are still too low, refer to "CRT Supply" in this chapter and the "High-Voltage Power Supply Adjustment" procedure in Chapter 2.
11. If voltages are correct when the tube is disconnected, the CRT is probably defective.

Caution	The pins on the A18V1 CRT bend easily. Be careful not to bend pins when connecting W8 to A18V1.
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A6 Power Supply Assembly

The HP 8560E spectrum analyzer uses a switching power supply operating at 40 kHz to supply the low voltages for most of the analyzer hardware and a 30 kHz switching supply (CRT supply) to provide the high voltages for the CRT display. The CRT supply will be treated as a separate supply since the remainder of A6 must be operating for the CRT supply to operate.

Kick starting occurs when there is a fault either on the power supply or on one of the other assemblies. The power supply will try to start by generating a 200 ms pulse (“kick”) every 1.5 seconds. A kick-starting power supply often appears to be dead, but the fan will make one or two revolutions and stop every 1.5 seconds.

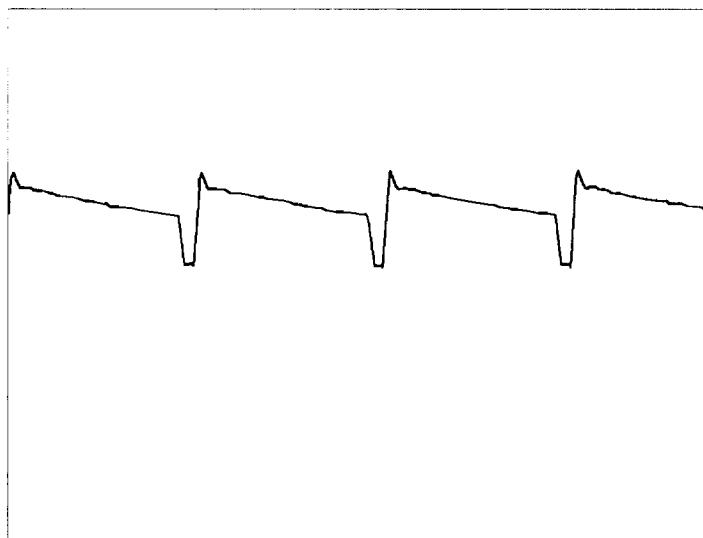
Warning

- **The A6 power supply and A6A1 high voltage assemblies contain lethal voltages with lethal currents in all areas. Use extreme care when servicing these assemblies. Always disconnect the power cord from the instrument before servicing these assemblies. Failure to follow this precaution can present a shock hazard which may result in personal injury.**
- **The voltage potential at A6A1W3 is +9 kV. If the cable must be disconnected, always disconnect it at the CRT with caution! Failure to properly discharge A6A1W3 may result in severe electrical shock to personnel and damage to the instrument. See Chapter 3, Procedure 2.**
- **Always use an isolation transformer when troubleshooting either the A6 power supply or the A6A1 HV module. When using an isolation transformer, connect a jumper between A6TP101 and A6TP301. This connects the circuit common to earth ground. Remove this jumper when the isolation transformer is not used.**

Dead Power Supply

1. Use an isolation transformer and connect a jumper between A6TP101 and A6TP301.
2. Connect the negative lead of a DVM to A6TP301.
3. Check TP308 for +5 V.
4. Check TP302 for +15 V.
5. Check TP303 for –15 V.
6. Check TP304 for +28 V.
7. Check TP305 for –12.6 V.
8. Measure the voltage at TP108 to verify the output of the input rectifier. The voltage should be between +215 Vdc and +350 Vdc.
9. If it is not within this range, check the rear panel fuse, input rectifier, input filter, and the rear-panel line voltage selector switch.
10. Measure the voltage at TP206 to verify the output of the kick- start/bias-circuitry. The voltage should be approximately +14 Vdc. Test point 206 is on pin 1 of U203.

11. If there is no voltage at TP206, check TP210 for pulses 200 ms wide with an amplitude of 14.7 V. If there are no pulses present, the kick-start circuitry is probably defective. If the pulses are low in amplitude (about 1 V), Q201 is probably shorted.
12. If there are pulses at TP206, or there are pulses at TP210, but not at TP206, the buck regulator control circuitry is probably faulty.
13. Disconnect the power cord from the HP 8560E spectrum analyzer.
14. Connect the positive output of a current-limited dc power supply to the cathode of A6CR201 (TP206) and the ground to A6TP201.
15. Set the current limit of the power supply to about 500 mA and the voltage to 12 Vdc.
16. Make sure a jumper is connected from A6TP101 to A6TP301. This independently powers the buck regulator control circuitry.
17. Connect a jumper from the dc power supply's +12 Vdc output to the end of A6R202 physically nearest A6C211.
18. Connect a jumper from +12 Vdc to the end of C207 nearest C209.
19. If the current draw exceeds approximately 50 mA, suspect a short in the buck regulator control circuitry or a shorted CR201.
20. Check TP204 for an 80 kHz sawtooth (4 Vp-p).
21. Check TP203 and TP207 for 40 kHz square (12 Vp-p). If the waveforms at either TP203 or TP207 are bad, one of the FETs in the DC-DC Converter is probably defective.
22. Check TP105 and TP106 for a 12 Vp-p sawtooth waveform that is flattened at the bottom. If the waveform is a squarewave, the FET to which the test point is connected has failed or shorted.
23. Check TP202 for 80 kHz pulses (12 Vp-p).
24. Short TP401 to TP102. Check TP103 for a waveform similar to that in Figure 12-4.
25. If the waveform at TP202 is correct but the waveform at TP103 is bad, suspect either Q102 or CR106.



5x1123

Figure 12-4. Buck Regulator Waveform

Line Fuse Blowing

1. If the line fuse blows with the **LINE** switch in the off position, suspect either the input filter or the power switch cable assembly.
2. If the line fuse blows when the HP 8560E spectrum analyzer is turned on, disconnect the power cord and lift the drain of A6Q102 from TP108. If the line fuse still blows, suspect CR102 through CR105.
3. If the fuse is not burned out, check A6TP108 for a voltage of between +215 V and +350 V.
4. If the voltage at TP108 is correct, disconnect the power cord. Wait 60 seconds for the high voltage to discharge. Remove and check A6Q102.
5. If Q102 is shorted, Q103, Q104, CR106, and CR108 are also probably shorted. If Q102 is working properly, measure the resistance between TP102 and TP101 (positive ohmmeter lead to TP102).
6. If the resistance is less than 1 k Ω , suspect either Q103 or Q104 in the DC-DC Converter.

Supply Restarting Every 1.5 Seconds (Kick Start)

See function blocks G, H and L of A6 power supply schematic diagram in the component-level information binder.

If there is a short on the power supply or on one of the other assemblies, the power supply will attempt to “kick start.” (Every 1.5 seconds the supply will attempt to start, but will be shut down by a fault condition.) The kick start and bias circuits provide power for the control circuitry during power-up. The kick start circuitry is an RC oscillator which emits a 200 ms pulse every 1.5 seconds. These pulses switch current from the Input Rectifier through Q201 to charge C201. When the power supply is up, a winding on T103 provides power to the control circuitry. This voltage is high enough to keep Q201 turned off.

1. Monitor the waveforms at TP206 and TP208 simultaneously on an oscilloscope.
2. If the signal at TP208 goes high before the signal at TP206 goes low, an overcurrent condition has been detected. Suspect a short in the secondary (output rectifier, voltage regulators, or another assembly).

Low Voltage Supplies

1. Connect the DVM's negative lead to A6TP301.
2. Check A6TP302 for +15 Vdc.
3. Check A6TP303 for -15 Vdc.
4. Check A6TP304 for +28 Vdc.
5. Check A6TP305 for -12.6 Vdc.
6. Check A6TP308 for +5 Vdc.
7. If the voltages measured above are correct but the power supply LEDs on the A2 controller assembly are not lit, check W1.
8. If the voltages are low, disconnect W1 from A6J1 and measure the test point voltages again. Unless a dummy load is connected to the A6 power supply, the voltages should return to their nominal voltages but be unregulated.
9. If the voltages do not return to near their nominal range, the A6 power supply is probably at fault.
10. If the +5 V supply is low, suspect the +5 V regulator or the feedback circuit. To check the feedback circuit, measure the voltage of the +5 V reference (U305 pin 6) and the ± 5 V references to the voltage regulators (U306B pin 7 and U306D pin 14).
11. Check output of U306A pin 1. If the feedback circuit is working properly, the output of U306A should be near +13 Vdc.
12. Check output of U302; its output should be high if the feedback circuit is working properly.

High Voltage Supplies

1. Press **LINE** to turn spectrum analyzer off, disconnect the power cord, and remove the power supply shield.
2. Connect a DVM's negative lead to A6TP401 and positive lead to A6TP405.
3. Press **LINE** to turn spectrum analyzer on.
4. If the voltage displayed on the DVM is approximately +110 Vdc and the rear-panel CRT +110 VDC ON indicator is lit, the A6A1 HV module is probably at fault.

Note

Ideally, the DVM should read the voltage written on the label of the A6A1 HV module. If necessary, perform the "High Voltage Power Supply" adjustment in Chapter 2.

5. If the DVM does not read approximately +110 Vdc, measure the voltage on A6U401 pin 10. This is the HV_SHUT_DOWN signal and should be near +5 Vdc.
6. If HV_SHUT_DOWN is low, suspect a bad connection along W8 between the A6 power supply and the 17 CRT driver.
7. If HV_SHUT_DOWN is correct, connect an oscilloscope to A6TP402. Connect the scope probe's negative lead to TP401. Set the oscilloscope to the following settings:

Sweep time	10 μ s/div
Vertical scale	10 V/div
8. A nearly-sinusoidal waveform, greater than 30 Vp-p, with an approximately +18 Vdc offset, should be observed.
9. If the waveform is a dc voltage near 0 Vdc with narrow, positive- and negative-going pulses, the A6A1 HV module is faulty. If the waveform is a dc voltage near +18 Vdc with narrow, positive- and negative-going pulses, connect the probe to TP403.
10. If the waveform at TP403 is a sawtooth waveform with a 1.8 V amplitude, the A6A1 HV module is faulty.
11. If the TP403 waveform has pulses similar to those on TP402, the A6 power supply is probably faulty.

CRT Supply Dropping Out

See function block K of A6 power supply schematic diagram in the component-level information binder.

The CRT supply is a separate switching supply which provides the +110 Vdc for the A17 CRT driver from a winding on the A6A1 HV module. The CRT supply operates at approximately 30 kHz. The exact frequency is determined by the inductance of the primary winding of A6A1T1 and A6C407. The supply will only operate if the HV_SHUT_DOWN line is high.

If the power supply keeps dropping out, there is probably a short on the A17 CRT driver assembly.

1. Disconnect W8 from A6J4.
2. Connect an IC clip to U401 and connect a jumper between U401 pin 10 and TP308 (+5 Vdc).
3. Connect a voltmeter to TP405 and press **LINE** to turn the spectrum analyzer on.
4. Check TP405 for a voltage of approximately +110 Vdc. It will probably measure higher since there is no load on the supply.
5. If the voltage at TP405 is correct, suspect a short on A17. If the voltage at TP405 is not correct, check U401 pin 8 for a sawtooth signal. The sawtooth should be flat-topped and about 5 Vp-p at a frequency of about 30 kHz.
6. If the sawtooth is not flat-topped, suspect U402A and its associated circuitry.
7. If the sawtooth is correct, check the base of Q401 for 30 kHz pulses.
8. If the duty cycle is high, but there is no +110 Vdc, suspect the bridge rectifier, CR401 through CR404.

Blanking Signal

1. Connect an oscilloscope probe to A2J202 pin 3. Connect the oscilloscope ground lead to TP3. Set the oscilloscope to the following settings:
Sweep time 2 ms/div
Vertical scale 1 V/div
2. If a 4 Vp-p signal is not observed, the A2 controller assembly is faulty.
3. Repeat steps 1 and 2 with the oscilloscope probe on A2J202 pin 14.
4. Set the oscilloscope to the following settings:
Sweep time 1 μ s/div
Vertical scale 2 V/div
5. Connect the positive probe lead to A2J202 pin 15. This is the blanking output.
6. TTL-level pulses should be observed. If the signal is either always high or always low, the display will be blanked; suspect the A2 controller assembly.
7. If the signals on A2J202 pins 3, 14, and 15 are correct, troubleshoot the A17 CRT driver.

Buck Regulator Control

See function block H of the A6 power supply schematic diagram in the component-level information binder.

The buck regulator control pulse-width modulates the buck regulator and provides a synchronized signal to the DC-DC converter control circuitry. The buck regulator control has two feedback paths. The first is the output of the buck regulator, which provides coarse regulation. The second is the feedback circuit which samples and compares the +5 Vdc output of the output rectifier.

U202B and associated circuitry sense the output of the input rectifier and will turn off U203 if the voltage at TP108 goes below approximately +170 Vdc. Also, it will not allow U203 to start up until this voltage exceeds +215 Vdc. A low on the output of U202B will also clear the overcurrent latch in the DC-DC converter control circuitry.

Thermal shutdown occurs when RT201, mounted on the main heatsink, reaches a temperature of 100 C. When this occurs, the voltage at U203 pin 13 exceeds 0.6 V and inhibits pulses to the buck regulator.

R203, R204, U211, and associated circuitry provide feedforward for U203. This makes the loop gain independent of input line voltage and cancels 120 Hz ripple by more than 10 dB.

U202C and its associated circuitry permit the power supply to start up at low line voltages at low temperatures. At low line voltages U202C will draw charge away from C206 through R205. This allows the buck regulator to turn on and draw current through the thermistors in the input rectifier. This warms up the thermistors, thereby decreasing their resistance and increasing the voltage at TP108. When the voltage is sufficiently high at TP108, the output of U202C will open and C206 will be allowed to charge normally.

U202A converts the sawtooth at TP204 to a squarewave to drive the DC-DC Converter Control circuitry. The frequency of the sawtooth is determined by the resistance at pin 7 of U203 and the capacitance at pin 8 of U203.

DC-DC Converter Control

See function block I of A6 power supply schematic diagram in the component-level information binder.

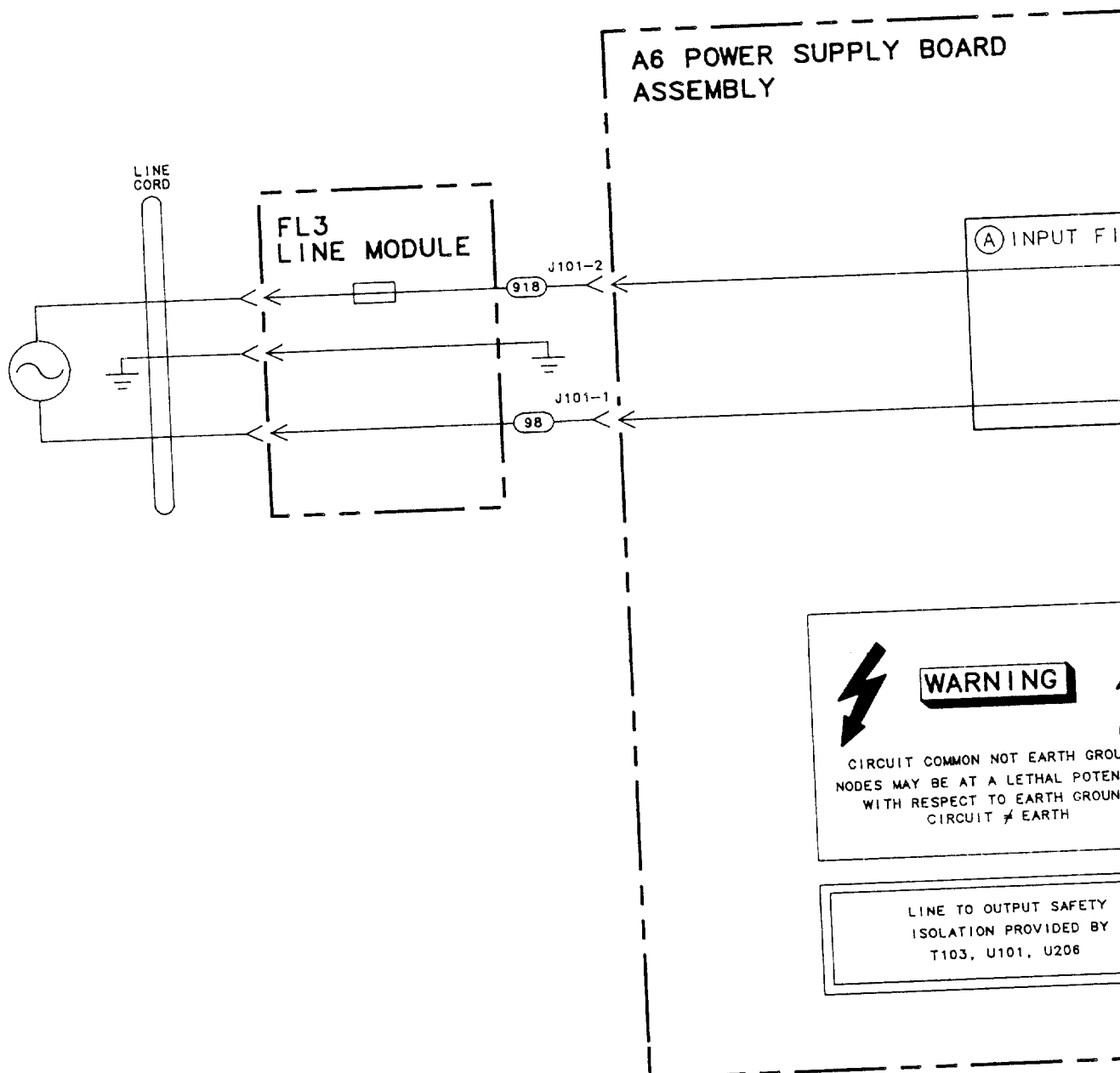
The DC-DC converter control circuitry divides the 80 kHz squarewave from U202A and generates two complementary 40 kHz squarewaves to drive the FETs in the DC-DC converter. Also, U202D and its associated circuitry monitor the voltage across sense resistor R116 in the DC-DC converter. When the current through the FETs in the DC-DC converter exceeds 1.8 A, the voltage across R116 will cause the output of U202D to go high. This sets a latch in U204 which turns off U203.

Power Up

See function block M of the A6 power supply schematic diagram in the component-level information binder.

The power up circuitry generates the PWR UP signal, which tells the microprocessor that the supplies are up and stable. PWR UP will go high when the +5 Vdc supply exceeds +4.99 Vdc. PWR UP will go low when this voltage drops below +4.895 Vdc. Once PWR UP is set low, it will stay low for at least 50 ms before going high, even if the +5 Vdc supply exceeds +4.99 Vdc before 50 ms have elapsed.

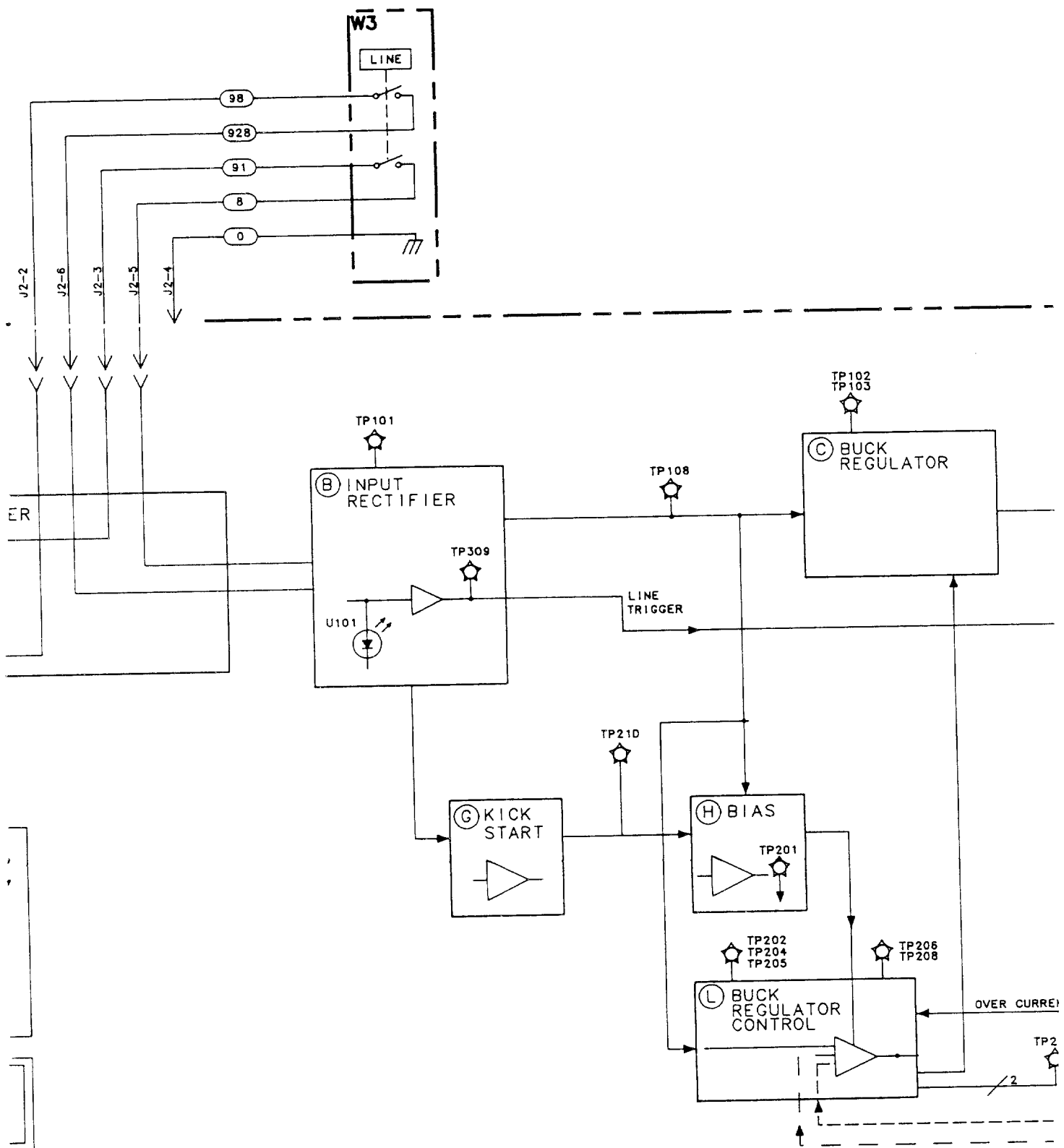
POWER SUPPLY ASSEMBLY BLOCK DIAGRAM

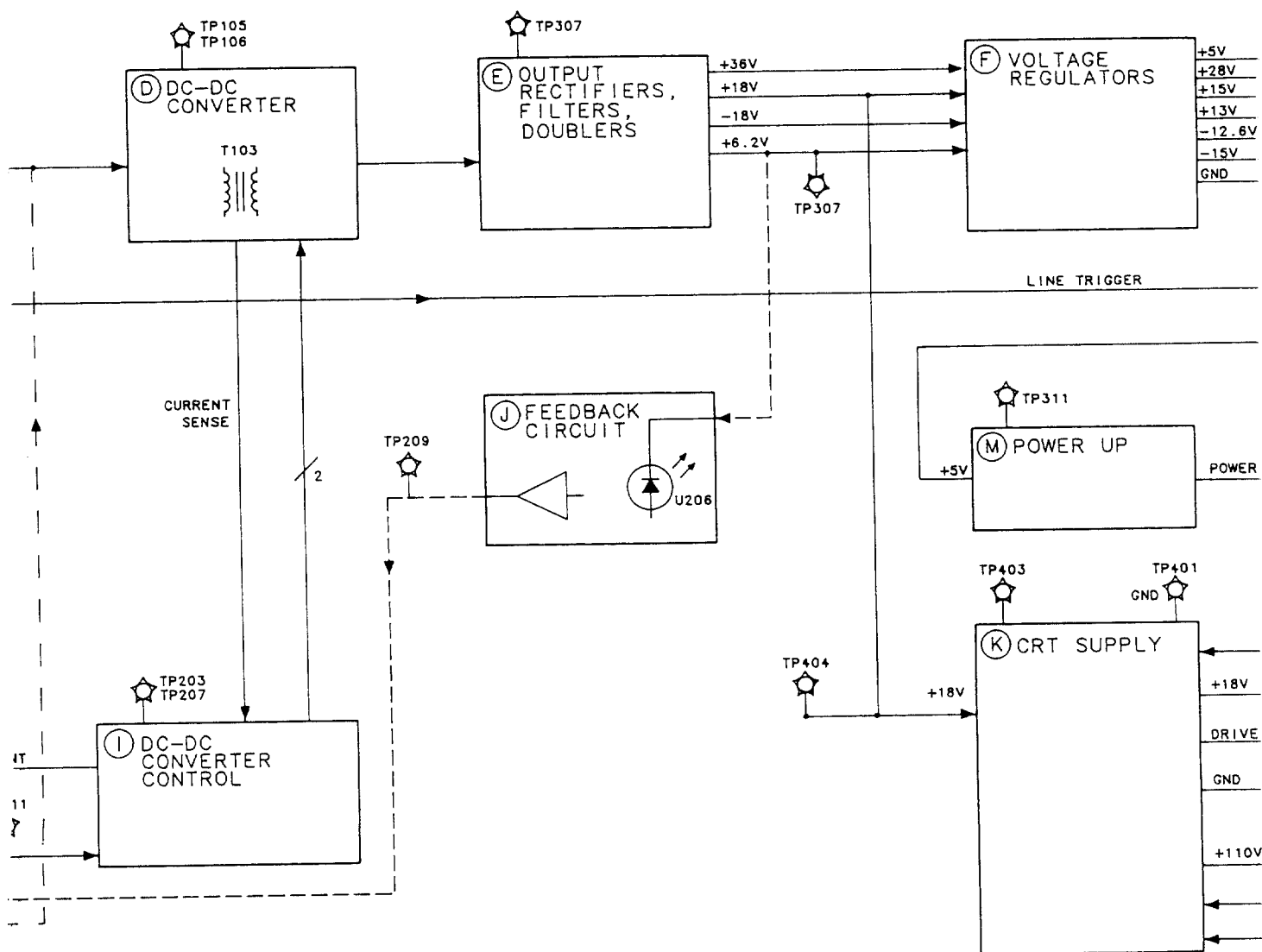


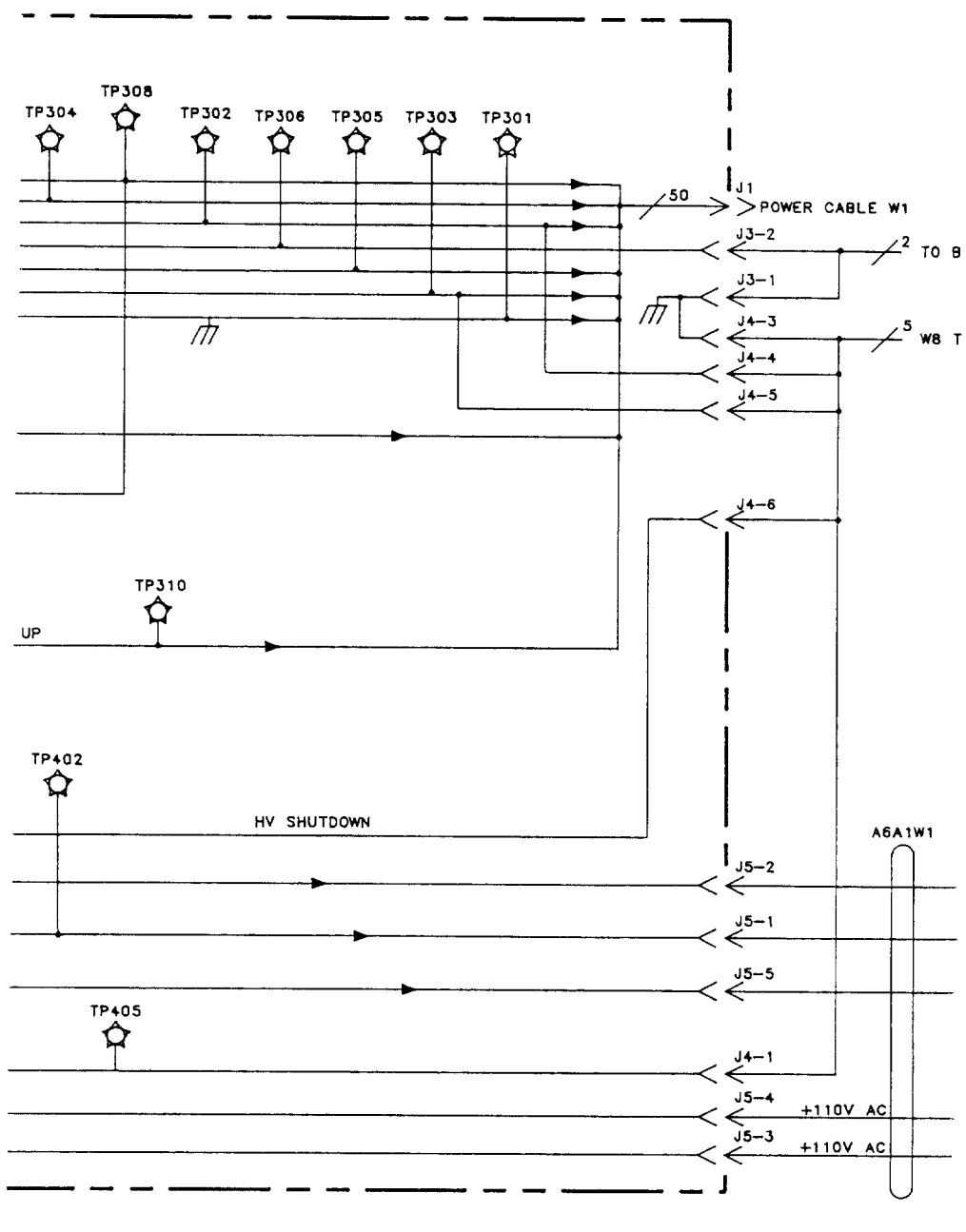
WARNING

CIRCUIT COMMON NOT EARTH GROUND
NODES MAY BE AT A LETHAL POTENTIAL
WITH RESPECT TO EARTH GROUND
CIRCUIT ≠ EARTH

LINE TO OUTPUT SAFETY
ISOLATION PROVIDED BY
T103, U101, U208







1 (FAN)

O A17 CRT DRIVER

WARNING

HAZARDOUS
VOLTAGE

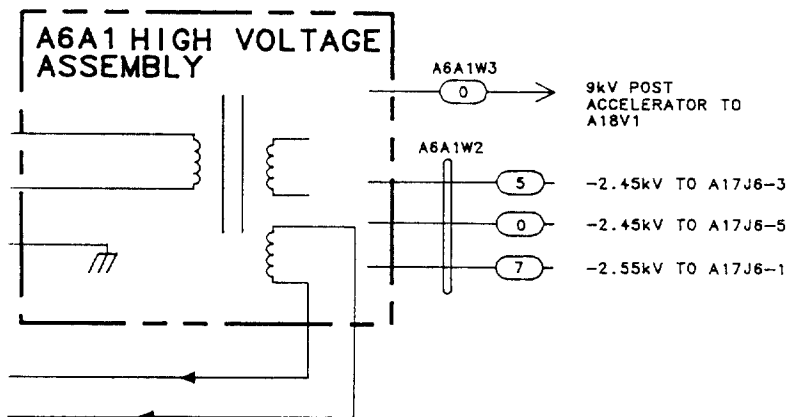
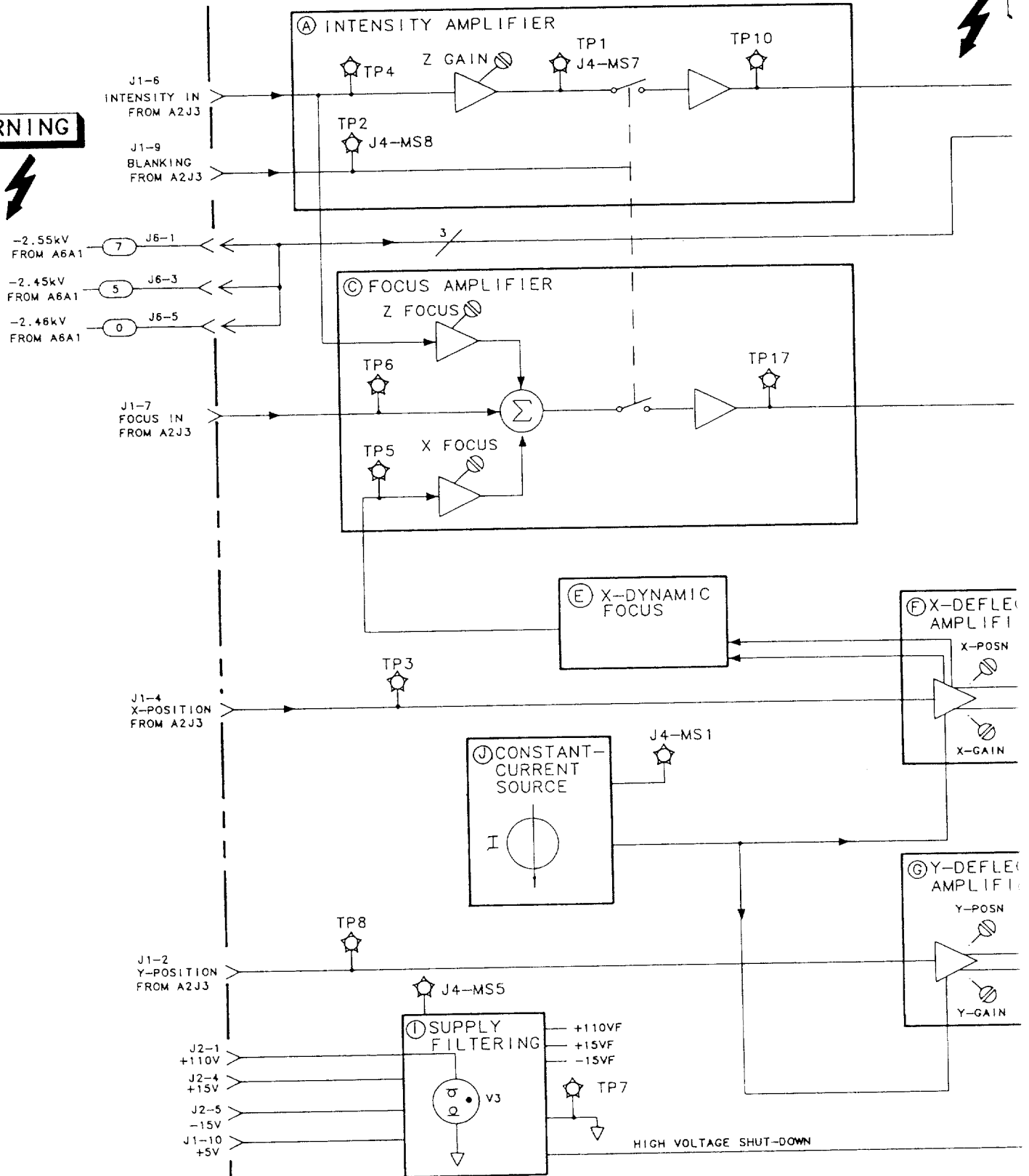


FIGURE 12-5. A6 POWER SUPPLY BLOCK DIAGRAM

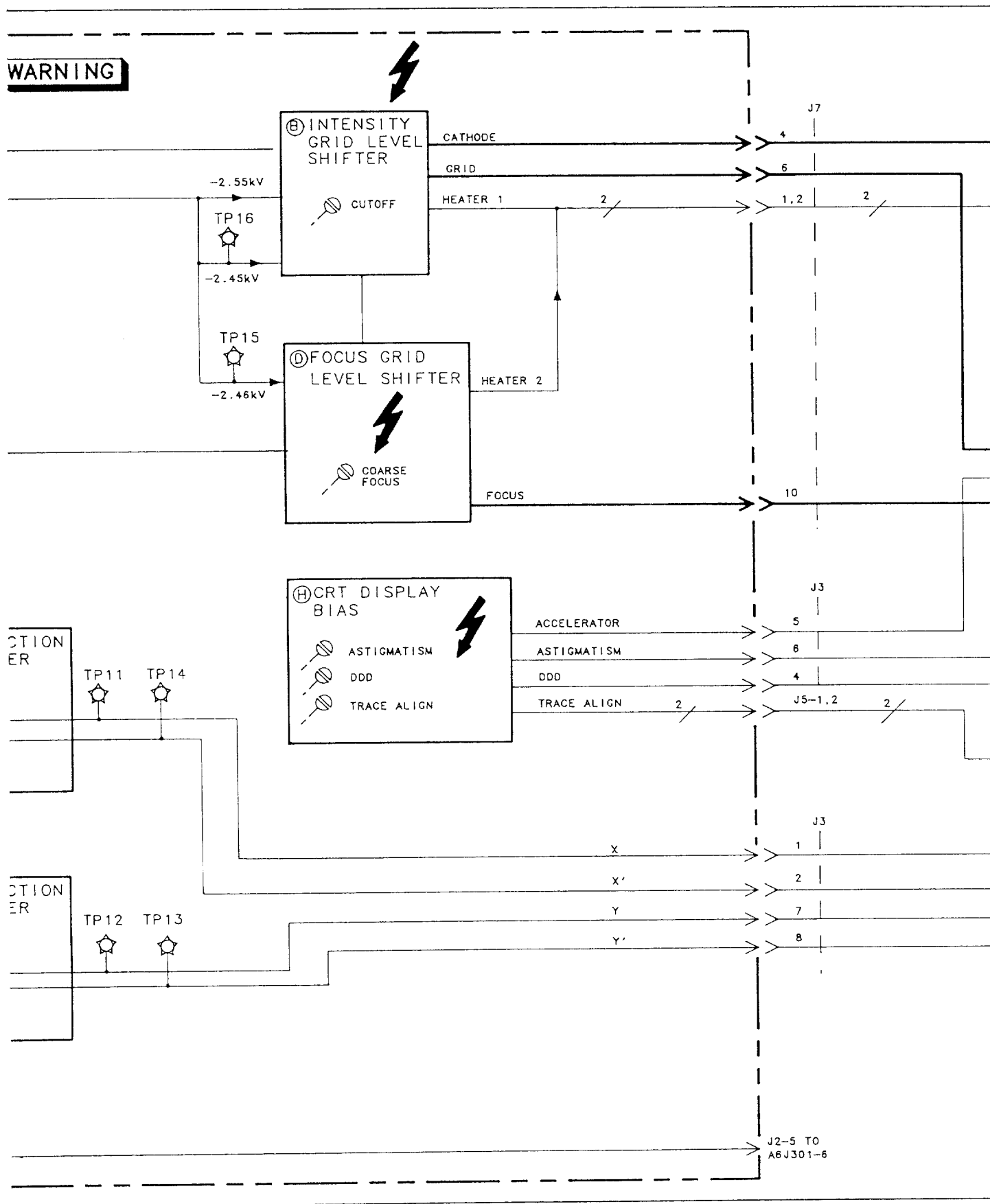
A17 CRT DISPLAY DRIVER BLOCK DIAGRAM

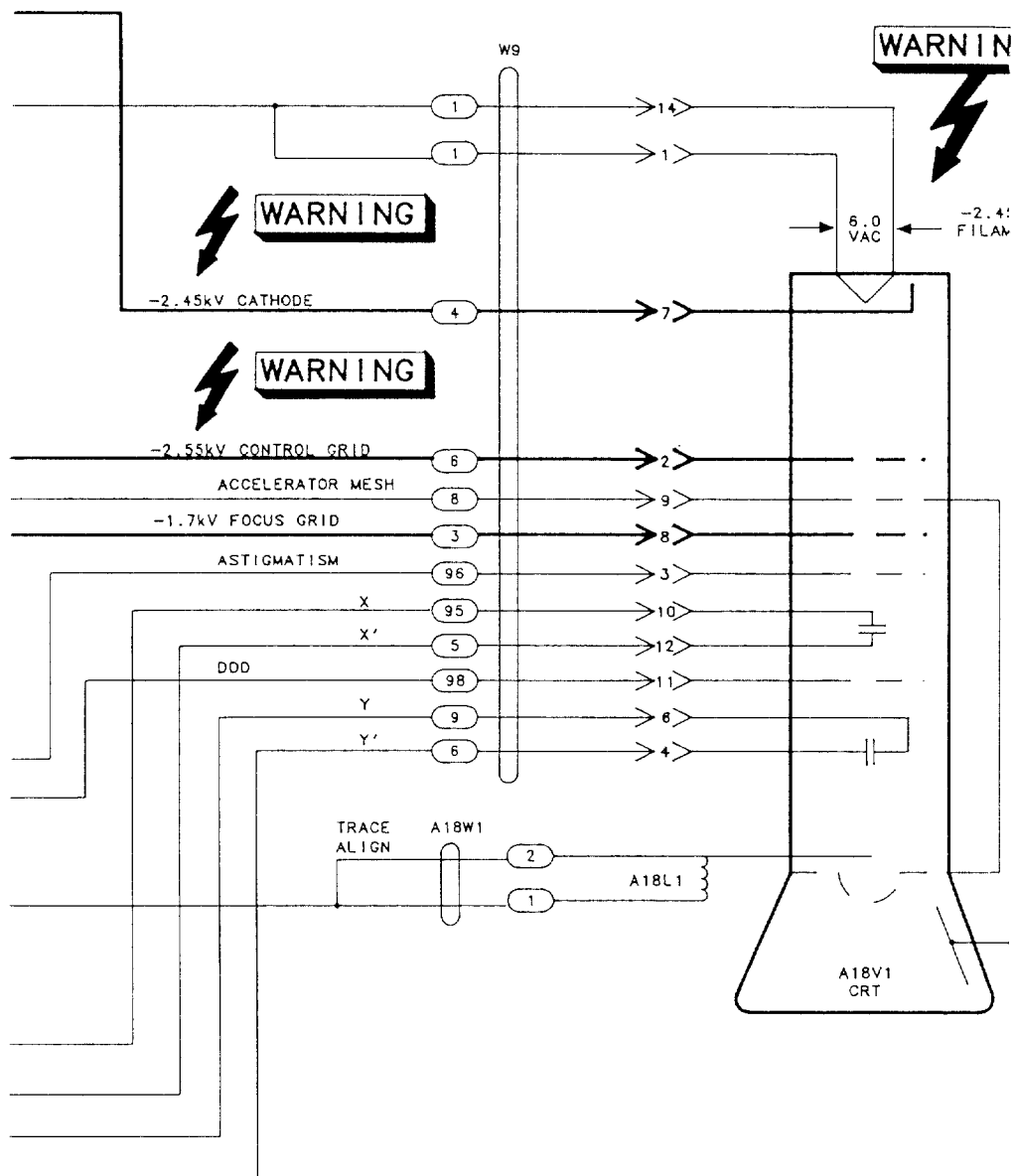
A17 CRT DISPLAY DRIVER

WARNING



WARNING

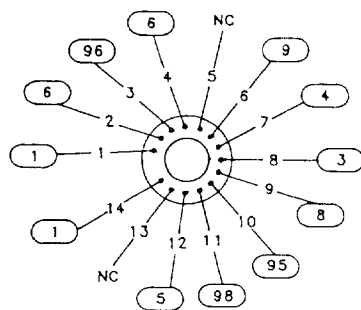




WARNING HIGH VOLTAGE
 DISCONNECT AT CRT WITH CAUTION!
 DISCHARGE FIRST BY GROUNDING AT
 CRT CONNECTION!

G

3kV
IDENT



**CRT CONNECTOR
(REAR VIEW)**

WARNING



←5 0 A6A1W3
POST +9kV
ACCELERATOR FROM A6A1



FIGURE 12-6. A17 CRT DRIVER BLOCK DIAGRAM

Component-Level Information Packets

Component-Level information is available for selected instrument assemblies. The information for each repairable assembly is provided in the form of Component-Level Information Packets (CLIPs). Each CLIP contains a parts list, component-location diagram, and schematic diagram. Each CLIP has an HP part number which is changed whenever the HP part number for its related instrument assembly is changed.

Updated or replacement CLIPs may be ordered through your local Hewlett-Packard Sales or Service office using the CLIP part number provided in Table A-1.

A complete set of the latest version of CLIPs can be ordered using HP part number 5960-6550.

Note

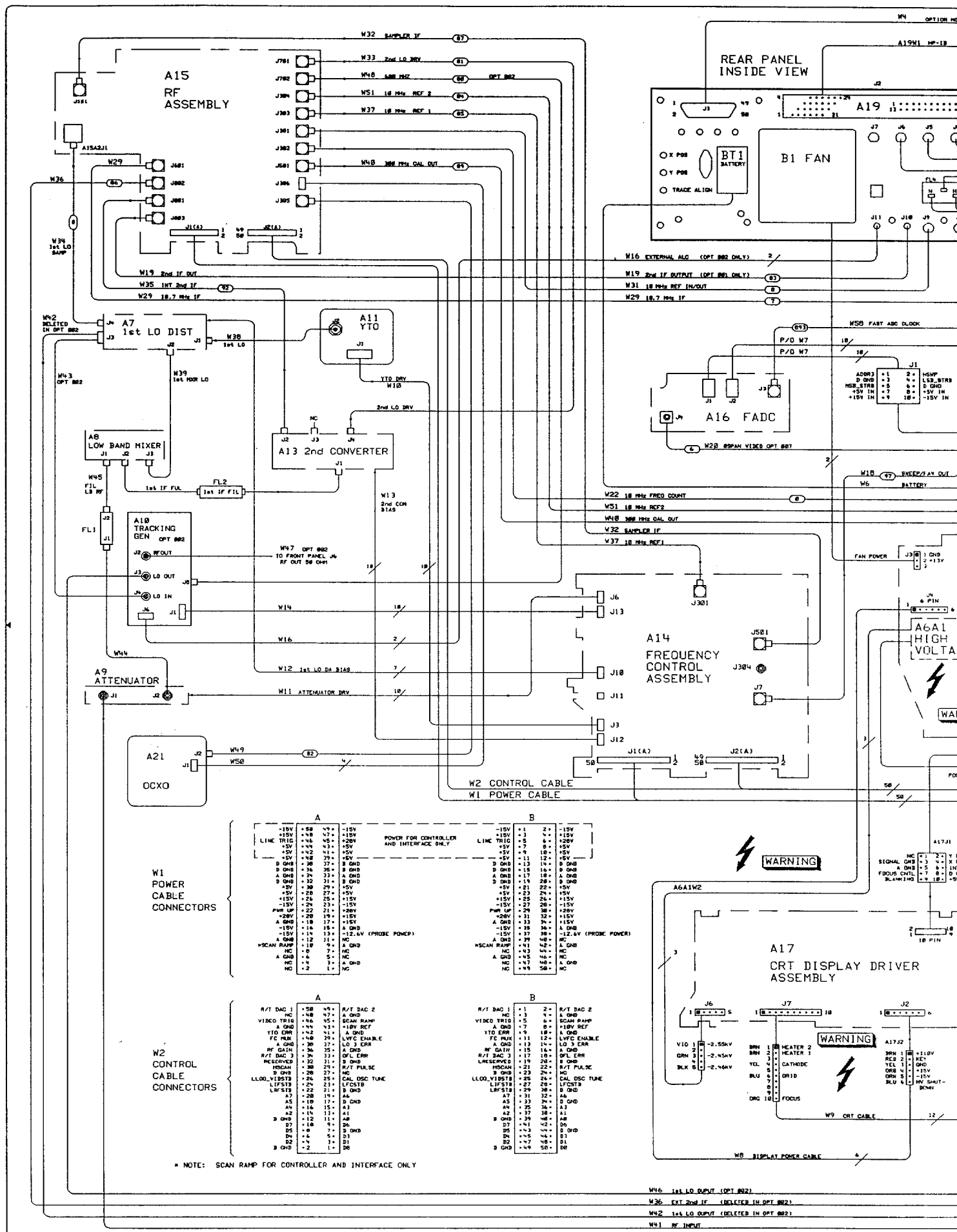
CLIPs may not be available for recently introduced assemblies.

Table A-1. HP 8560E Spectrum Analyzer Documented Assemblies

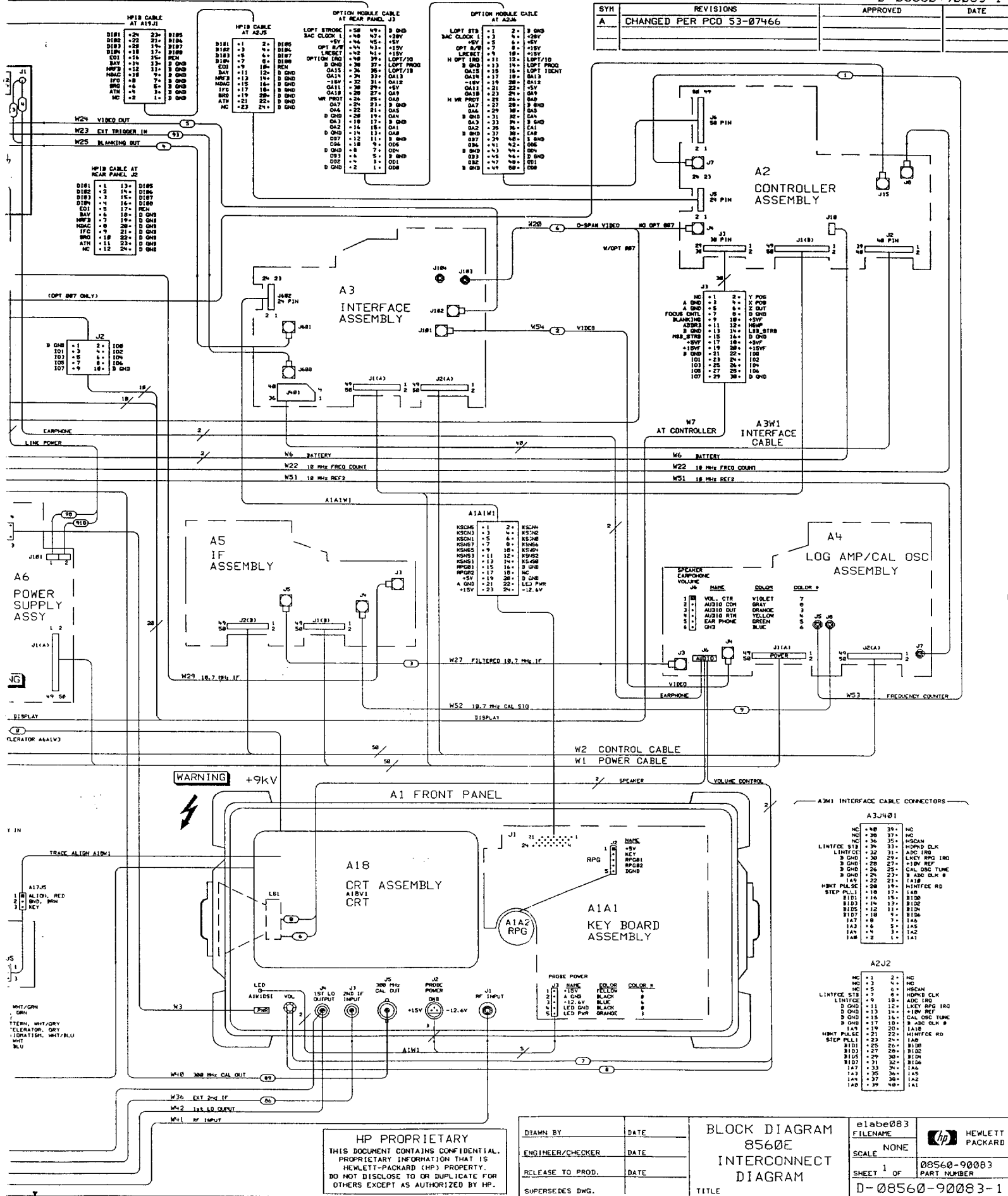
Board Assembly	Instrument Serial Prefix	Assembly Part Number	CLIP Part Number
A1A1 Keyboard	3213A and above	08562-60140	08562-90188*
A2 Controller Assembly	3213A through 3305A 3310A and above	08563-60017 08563-60032 [†]	08563-90055 08563-90074*
A3 Interface Assembly (non-Option 007)	3213A and above	08563-60021	08563-90056*
A3 Interface Assembly (Option 007)	3310A and above	08563-60033	08563-90075*
A4 Log Amplifier/Cal Osc	3213A through 3246A 3301A and above	08563-60025 08563-60050 [†]	08563-90057 08563-90082*
A5 IF Filter	3213A and above	08563-60023	08563-90058*
A6 Power Supply	3213A and above	08563-60020 [†]	08562-90059*
A14 Frequency Control	3213A through 3305A 3310A and above	08560-60059 08560-60062 [†]	08560-90082 08560-90084*
A15 RF Board (Option 103) (With SIG ID);	3213A through 3221A 3240A through 3304A 3305A and above	08563-60010 08563-60035 08563-60045 [†]	08563-90062 08563-90068 08563-90072*
*Denotes the current version of board assembly. [†]Denotes refurbished board assemblies available. Refurbished board assembly part numbers have 9 as the second digit of the suffix. For example, 08563-69032 is the refurbished part number for board assembly 08563-60032.			

Table A-1.
HP 8560E Spectrum Analyzer Documented Assemblies (continued)

Board Assembly	Instrument Serial Prefix	Assembly Part Number	CLIP Part Number
A15 RF Board (Option 103) (Without SIG ID)	3305A and above	08563-60043 [†]	08563-90070*
A15 RF Board (Standard) (With SIG ID)	3213A through 3221A 3240A through 3304A 3305A and above	08563-60016 08563-60036 08563-60046 [†]	08563-90061 08563-90069 08563-90073*
A15 RF Board (Standard) (Without SIG ID)	3305A and above	08563-60044 [†]	08563-90071*
A16 Fast ADC	3310A and above	08563-60030	08563-90076*
A17 CRT Driver	3213A 3221A and above	08562-60165 08562-60166	08562-90187 08562-90193*
A19 HP-IB	3213A and above	08562-60042	08562-90115*
* Denotes the current version of board assembly. [†] Denotes refurbished board assemblies available. Refurbished board assembly part numbers have 9 as the second digit of the suffix. For example, 08563-69032 is the refurbished part number for board assembly 08563-60032.			



SYN	REVISIONS	APPROVED	DATE
A	CHANGED PER PCO 53-07466		



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DESIGNED BY	DATE
ENGINEER/CHECKER	DATE
RELEASE TO PROD.	DATE
SUPERSEDES DWG.	

BLOCK DIAGRAM
8560E
INTERCONNECT
DIAGRAM

elabe083	FILENAME	HP	HEWLETT PACKARD
SCALE	NONE		
SHEET 1 OF	08560-90083		
PART NUMBER	D-08560-90083-1		

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